Calibration Guide

Agilent Technologies ESA Spectrum Analyzers

This manual provides documentation for the following instruments:

Agilent ESA-E Series E4402B (9 kHz - 3.0 GHz) E4404B (9 kHz - 6.7 GHz) E4405B (9 kHz - 13.2 GHz) E4407B (9 kHz - 26.5 GHz)

and

Agilent ESA-L Series E4411B (9 kHz - 1.5 GHz) E4403B (9 kHz - 3.0 GHz) E4408B (9 kHz - 26.5 GHz)

NOTICE: This document contains references to Agilent Technologies. Agilent's former Test and Measurement business has become Keysight Technologies. For more information, go to www.keysight.com.



Manufacturing Part Number: E4401-90493 Supersedes March 2005

Printed in USA

January 2015

© Copyright 2000-2015 Keysight Technologies, Inc.

Notice

The information contained in this document is subject to change without notice.

Agilent Technologies makes no warranty of any kind with regard to this material, including but not limited to, the implied warranties of merchantability and fitness for a particular purpose. Agilent Technologies shall not be liable for errors contained herein or for incidental or consequential damages in connection with the furnishing, performance, or use of this material.

The following safety symbols are used throughout this manual. Familiarize yourself with the symbols and their meaning before operating this instrument.

WARNING

Warning denotes a hazard. It calls attention to a procedure which, if not correctly performed or adhered to, could result in injury or loss of life. Do not proceed beyond a warning note until the indicated conditions are fully understood and met.

CAUTION

Caution denotes a hazard. It calls attention to a procedure that, if not correctly performed or adhered to, could result in damage to or destruction of the instrument. Do not proceed beyond a caution sign until the indicated conditions are fully understood and met.

WARNING

This is a Safety Class 1 Product (provided with a protective earthing ground incorporated in the power cord. The mains plug shall only be inserted in a socket outlet provided with a protective earth contact. Any interruption of the protective conductor inside or outside of the product is likely to make the product dangerous. Intentional interruption is prohibited.

WARNING

If this product is not used as specified, the protection provided by the equipment could be impaired. This product must be used in a normal condition (in which all means for protection are intact) only.

CAUTION

Always use the three-prong ac power cord supplied with this product. Failure to ensure adequate earth grounding by not using this cord may cause product damage.

CAUTION

This instrument has autoranging line voltage input, be sure the supply voltage is within the specified range.

Where to Find the Latest Information

Documentation is updated periodically. For the latest information about Agilent ESA Spectrum Analyzers, including firmware upgrades and application information, please visit the following Internet URL:

http://www.agilent.com/find/esa.

1	. Calibrating Calibration Cycle
	Before You Start
2	2. Performance Verification Tests Tests included in this section:
	1. 10 MHz Reference Output Accuracy
	2. 10 MHz High-Stability Frequency Reference Output Accuracy: Agilent E4401B, E4402B,
	E4404B, E4405B, and E4407B (Option 1D5)
	3. Frequency Readout and Marker Frequency Count Accuracy: Agilent E4401B, E4402B,
	E4403B, and E4411B
	4. Frequency Readout and Marker Frequency Count Accuracy: Agilent E4404B, E4405B,
	E4407B, and E4408B
	5. Frequency Span Accuracy: Agilent E4401B and E4411B
	6. Frequency Span Accuracy:
	Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B
	7. Noise Sidebands
	8. Noise Sidebands - Wide Offsets: Agilent E4402B, E4404B, E4405B and E4407B 70
	9. System-Related Sidebands
	10. Residual FM
	11. Sweep Time Accuracy
	12. Display Scale Fidelity
	13. Input Attenuation Switching Uncertainty
	14. Reference Level Accuracy: Agilent E4401B and E4411B
	15. Reference Level Accuracy: Agilent E4402B,
	E4403B, E4404B, E4405B, E4407B, and E4408B
	16. Resolution Bandwidth Switching Uncertainty
	17. Absolute Amplitude Accuracy (Reference Settings): Agilent E4401B and E4411B 129
	17. Absolute Amplitude Accuracy (Reference Settings): Agilent E4401B and E4411B 123

E4405B, E4407B, and E4408B	136
19. Overall Absolute Amplitude Accuracy: Agilent E4401B and E4411B	143
20. Overall Absolute Amplitude Accuracy: Agilent E4402B, E4403B, E4404B, E4405	В,
E4407B, and E4408B	150
21. Resolution Bandwidth Accuracy	157
22. Frequency Response: Agilent E4401B and E4411B	162
23. Frequency Response, Agilent E4402B and E4403B	172
24. Frequency Response, Agilent E4404B, E4405B, E4407B, and E4408B	187
25. Frequency Response (Preamp On): Agilent E4401B	213
26. Frequency Response (Preamp On): Agilent E4402B	221
27. Frequency Response (Preamp On): Agilent E4404B, E4405B, and E4407B	231
28. Other Input-Related Spurious Responses: Agilent E4401B and E4411B	244
29. Other Input-Related Spurious Responses: Agilent E4402B, E4403B, E4404B, E440)5B,
E4407B, and E4408B	249
30. Spurious Responses: Agilent E4401B and E4411B	255
31. Spurious Responses: Agilent E4402B and E4403B	263
32. Spurious Responses: Agilent E4404B, E4405B, E4407B, and E4408B	273
33. Gain Compression: Agilent E4401B, E4402B, E4403B, and E4411B	290
34. Gain Compression: Agilent E4404B, E4405B, E4407B, and E4408B	294
35. Displayed Average Noise Level: Agilent E4401B and E4411B	299
36. Displayed Average Noise Level: Agilent E4402B and E4403B	309
37. Displayed Average Noise Level: Agilent E4404B and E4405B	316
38. Displayed Average Noise Level: Agilent E4407B and E4408B	323
39. Residual Responses	330
40. Fast Time Domain Amplitude Accuracy: Agilent E4401B, E4402B, E4404B, E440	5B,
and E4407B (Option AYX)	333
41. Tracking Generator Absolute Amplitude and Vernier Accuracy: Agilent E4401B ar	ıd
F4411B (Option 1DN or 1DO)	335

	42. Tracking Generator Absolute Amplitude and Vernier Accuracy: Agilent E4402B,
	E4403B, E4404B, E4405B, E4407B, and E4408B (Option 1DN)
	43. Tracking Generator Level Flatness: Agilent E4401B and E4411B (Option 1DN or 1DQ)
	343
	44. Tracking Generator Level Flatness:
	Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B (Option 1DN) 350
	45. Tracking Generator Harmonic Spurious Outputs: Agilent E4401B and E4411B
	(Option 1DN or 1DQ)
	46. Tracking Generator Harmonic Spurious Outputs: Agilent E4402B, E4403B, E4404B,
	E4405B, E4407B, and E4408B (Option 1DN)
	47. Tracking Generator Non-Harmonic Spurious Outputs: Agilent E4401B and E4411B (Op-
	tion 1DN or 1DQ)
	48. Tracking Generator Non-Harmonic Spurious Outputs: Agilent E4402B, E4403B,
	E4404B, E4405B, E4407B, and E4408B (Option 1DN)
	49. Tracking Generator LO Feedthrough: Agilent E4402B, E4403B, E4404B,
	E4405B, E4407B, and E4408B(Option 1DN)
	50. Gate Delay Accuracy and Gate Length Accuracy: Agilent E4401B, E4402B, E4404B,
	E4405B, and E4407B (Option 1D6)
	51. Gate Mode Additional Amplitude Error: Agilent E4401B, E4402B, E4404B, E4405B,
	and E4407B (Option 1D6)
	52. First LO OUTPUT Power Accuracy (Option AYZ only)
	53. IF INPUT Accuracy (Option AYZ only)
	54. Comms Frequency Response (Option BAC or BAH)
	58. GSM Phase and Frequency Error (Options BAH and B7E)
	59. Comms Absolute Power Accuracy (Options BAC or BAH)
3	. Performance Verification Test Records A gilant E4401B Performance Verification Test Record
	Agilent E4401B Performance Verification Test Record
	Agnetic E4402D Petrofinance Verification rest Record

	Agilent E4403B Performance Verification Test Record	.479
	Agilent E4404B Performance Verification Test Record	.495
	Agilent E4405B Performance Verification Test Record	.525
	Agilent E4407B Performance Verification Test Record	.557
	Agilent E4408B Performance Verification Test Record	.596
	Agilent E4411B Performance Verification Test Record	.617
4.	If You Have a Problem What You'll Find in This Chapter	.636
	Before You Call Agilent Technologies	.637
	How to Return Your Analyzer for Service	.640

1 Calibrating

Calibrating

Calibration verifies that the analyzer performance is within all specifications. It is time consuming and requires extensive test equipment. Calibration consists of *all* the performance tests. For a complete listing of the performance tests, see the performance verification tests table for your specific analyzer.

Allow the analyzer to warm up in accordance with the temperature stability specifications before performing the tests in this chapter.

None of these test procedures involve removing the cover of the analyzer.

Calibration Cycle

The performance tests in chapter 2 should be used to check the analyzer against its specifications once every year. Specifications are listed in the *Specifications Guide*.

Performance Verification Test Tables

The tables on the following pages list the performance tests in Chapter 2, "Performance Verification Tests," required for each model number. Perform all the tests marked with a dot in the "Std" (standard) column. If any options are installed in the analyzer, also perform all tests marked with a dot in the appropriate option column.

Table 1-1 **Agilent E4401B Performance Verification Tests**

			Calibi	ation fo	r Instr	ument	Option	:
	Performance Test Name	Std^a	1DN	1DQ	1DS	1D5	1D6	AYX
1.	10 MHz Reference Output Accuracy ^b	•						
2.	10 MHz High-Stability Frequency Reference Output Accuracy					•		
3.	Frequency Readout and Marker Frequency Count Accuracy	•						
5.	Frequency Span Accuracy	•						
7.	Noise Sidebands	•						
9.	System-Related Sidebands	•						
10.	Residual FM	•						
11.	Sweep Time Accuracy	•						
12.	Display Scale Fidelity	•						
13.	Input Attenuation Switching Uncertainty	•						
14.	Reference Level Accuracy	•						
16.	Resolution Bandwidth Switching Uncertainty	•						
17.	Absolute Amplitude Accuracy (Reference Settings)	•						
19.	Overall Absolute Amplitude Accuracy	•						
21.	Resolution Bandwidth Accuracy	•						
22.	Frequency Response	•						
25.	Frequency Response (Preamp On)				•			
28.	Other Input-Related Spurious Responses	•						
30.	Spurious Responses	•						
33.	Gain Compression	•						
35.	Displayed Average Noise Level	•						
39.	Residual Responses	•						
40.	Fast Time Domain Amplitude Accuracy							•
41.	Tracking Generator Absolute Amplitude and Vernier Accuracy		•	•				
43.	Tracking Generator Level Flatness		•	•				
45.	Tracking Generator Harmonic Spurious Outputs		•	•				
47.	Tracking Generator Non-Harmonic Spurious Outputs		•	•				
50.	Gate Delay Accuracy and Gate Length Accuracy						•	
51.	Gate Mode Additional Amplitude Error						•	

a. Perform these tests for all E4401B analyzers. b. Perform this test only on analyzers not equipped with Option 1D5.

Table 1-2 Agilent E4402B Performance Verification Tests

Performance Test Name Table Table	ВАН	B7E
2. 10 MHz High-Stability Frequency Reference Output Accuracy		
Accuracy		
2 Frequency Poodout and Markor Frequency Count		
3. Frequency Readout and Marker Frequency Count Accuracy		
6. Frequency Span Accuracy		
7. Noise Sidebands •		
8. Noise Sidebands - Wide Offsets		
9. System-Related Sidebands •		
10. Residual FM •		
11. Sweep Time Accuracy		
12. Display Scale Fidelity		
13. Input Attenuation Switching Uncertainty		
15. Reference Level Accuracy		
16. Resolution Bandwidth Switching Uncertainty		
18. Absolute Amplitude Accuracy (Reference Settings)		
20. Overall Absolute Amplitude Accuracy		
21. Resolution Bandwidth Accuracy		
23. Frequency Response		
26. Frequency Response (Preamp On)		
29. Other Input-Related Spurious Responses		
31. Spurious Responses		
33. Gain Compression		
36. Displayed Average Noise Level		
39. Residual Responses		
40. Fast Time Domain Amplitude Accuracy		
42. Tracking Generator Absolute Amplitude and Vernier Accuracy		
44. Tracking Generator Level Flatness		
46. Tracking Generator Harmonic Spurious Outputs		
48. Tracking Generator Non-Harmonic Spurious Outputs		
49. Tracking Generator L.O. Feedthrough		
50. Gate Delay Accuracy and Gate Length Accuracy		
51. Gate Mode Additional Amplitude Error		
54. Comms Frequency Response	•	
55. (This test has been deleted.)		

Table 1-2 Agilent E4402B Performance Verification Tests

	Performance Test Name		Calil	oratio	n for	Inst	rume	nt Op	tion:	
			1DN	1DS	1D5	1D6	AYX	BAC	ВАН	B7E
56.	(This test has been deleted.)									
57.	(This test has been deleted.)									
58.	GSM Phase and Frequency Error ^c									•
59.	Comms Absolute Power Accuracy (Options BAC or BAH)							•	•	

- a. Perform these tests for all E4402B analyzers.
- b. Perform this test only on analyzers not equipped with Option 1D5. $\,$
- c. Perform this test only on instruments having Option BAH, GSM Measurement Personality.

Table 1-3 Agilent E4403B Performance Verification Tests

	Performance Test Name		tion for nt Option:
		Stda	1DN
1.	10 MHz Reference Output Accuracy	•	
3.	Frequency Readout and Marker Frequency Count Accuracy	•	
6.	Frequency Span Accuracy	•	
7.	Noise Sidebands	•	
9.	System-Related Sidebands	•	
10.	Residual FM	•	
11.	Sweep Time Accuracy	•	
12.	Display Scale Fidelity	•	
13.	Input Attenuation Switching Uncertainty	•	
15.	Reference Level Accuracy	•	
16.	Resolution Bandwidth Switching Uncertainty	•	
18.	Absolute Amplitude Accuracy (Reference Settings)	•	
20.	Overall Absolute Amplitude Accuracy	•	
21.	Resolution Bandwidth Accuracy	•	
23.	Frequency Response	•	
29.	Other Input-Related Spurious Responses	•	
31.	Spurious Responses	•	
33.	Gain Compression	•	
36.	Displayed Average Noise Level	•	
39.	Residual Responses	•	
42.	Tracking Generator Absolute Amplitude and Vernier Accuracy		•
44.	Tracking Generator Level Flatness		•
46.	Tracking Generator Harmonic Spurious Outputs		•
48.	Tracking Generator Non-Harmonic Spurious Outputs		•
49.	Tracking Generator L.O. Feedthrough		•

a. Perform these tests on all E4403B analyzers.

Table 1-4 Agilent E4404B Performance Verification Tests

	Deuferman - Total Norma		Ca	librat	ion fo	r Inst	rumen	nt Opt	ion:	
	Performance Test Name	Stda	1DN	1DS	1D5	1D6	AYX	BAC	ВАН	В7Е
1.	10 MHz Reference Output Accuracy ^b	•								
2.	10 MHz High-Stability Frequency Reference Output Accuracy				•					
4.	Frequency Readout and Marker Frequency Count Accuracy	•								
6.	Frequency Span Accuracy	•								
7.	Noise Sidebands	•								
8.	Noise Sidebands - Wide Offsets	•								
9.	System-Related Sidebands	•								
10.	Residual FM	•								
11.	Sweep Time Accuracy	•								
12.	Display Scale Fidelity	•								
13.	Input Attenuation Switching Uncertainty	•								
15.	Reference Level Accuracy	•								
16.	Resolution Bandwidth Switching Uncertainty	•								
18.	Absolute Amplitude Accuracy (Reference Settings)	•								
20.	Overall Absolute Amplitude Accuracy	•								
21.	Resolution Bandwidth Accuracy	•								
24.	Frequency Response	•								
27.	Frequency Response (Preamp On)			•						
29.	Other Input-Related Spurious Responses	•								
32.	Spurious Responses	•								
34.	Gain Compression	•								
37.	Displayed Average Noise Level	•								
39.	Residual Responses	•								
40.	Fast Time Domain Amplitude Accuracy						•			
42.	Tracking Generator Absolute Amplitude and Vernier Accuracy		•							
44.	Tracking Generator Level Flatness		•							
46.	Tracking Generator Harmonic Spurious Outputs		•							
48.	Tracking Generator Non-Harmonic Spurious Outputs		•							
49.	Tracking Generator L.O. Feedthrough		•							
50.	Gate Delay Accuracy and Gate Length Accuracy					•				
51.	Gate Mode Additional Amplitude Error					•				
54.	Comms Frequency Response							•	•	
55.	(This test has been deleted.)									

Table 1-4 Agilent E4404B Performance Verification Tests

	Performance Test Name		Cal	librati	ion fo	r Instr	umen	t Opti	on:	
	Terror mance Test Name		1DN	108	1D5	1D6	AYX	BAC	ВАН	B7E
56.	(This test has been deleted.)									
57.	(This test has been deleted.)									
58.	GSM Phase and Frequency Error ^c									•
59.	Comms Absolute Power Accuracy (Options BAC or BAH)							•	•	

- a. Perform these tests on all Agilent E4404B analyzers.
- b. Perform this test only on analyzers not equipped with Option 1D5.
- c. Perform this test only on instruments having Option BAH, GSM Measurement Personality.

Table 1-5 Agilent E4405B Performance Verification Tests

	Doubles on as The st News	(Calib	ratio	n for	Inst	rum	ent O	ptio	n:
	Performance Test Name	Stda	1DN	1DS	1D5	1D6	AYX	BAC	ВАН	B7E
1.	10 MHz Reference Output Accuracy ^b	•								
2.	10 MHz High-Stability Frequency Reference Output Accuracy				•					
4.	Frequency Readout and Marker Frequency Count Accuracy	•								
6.	Frequency Span Accuracy	•								
7.	Noise Sidebands	•								
8.	Noise Sidebands - Wide Offsets	•								
9.	System-Related Sidebands	•								
10.	Residual FM	•								
11.	Sweep Time Accuracy	•								
12.	Display Scale Fidelity	•								
13.	Input Attenuation Switching Uncertainty	•								
15.	Reference Level Accuracy	•								
16.	Resolution Bandwidth Switching Uncertainty	•								
18.	Absolute Amplitude Accuracy (Reference Settings)	•								
20.	Overall Absolute Amplitude Accuracy	•								
21.	Resolution Bandwidth Accuracy	•								
24.	Frequency Response	•								
27.	Frequency Response (Preamp On)			•						
29.	Other Input-Related Spurious Responses	•								
32.	Spurious Responses	•								
34.	Gain Compression	•								
37.	Displayed Average Noise Level	•								
39.	Residual Responses	•								
40.	Fast Time Domain Amplitude Accuracy						•			
42.	Tracking Generator Absolute Amplitude and Vernier Accuracy		•							
44.	Tracking Generator Level Flatness		•							
46.	Tracking Generator Harmonic Spurious Outputs		•							
48.	Tracking Generator Non-Harmonic Spurious Outputs		•							
49.	Tracking Generator L.O. Feedthrough		•							
50.	Gate Delay Accuracy and Gate Length Accuracy					•				
51.	Gate Mode Additional Amplitude Error					•				
54.	Comms Frequency Response							•	•	
55.	(This test has been deleted.)									

Agilent E4405B Performance Verification Tests Table 1-5

	Performance Test Name		alib	ratio	n for	Inst	rume	ent O	ption	a:
			1DN	1DS	1D5	1D6	AYX	BAC	ВАН	B7E
56.	(This test has been deleted.)									
57.	(This test has been deleted.)									
58.	GSM Phase and Frequency Error ^c									•
59.	Comms Absolute Power Accuracy (Options BAC or BAH)							•	•	

- a. Perform these tests on all E4405B analyzers.
- b. Perform this test only if the analyzer is not equipped with Option 1D5.c. Perform this test only on instruments having Option BAH, GSM Measurement Personality.

Table 1-6 Agilent E4407B Performance Verification Tests

	D 4		Calibration for Instrument Option:								
	Performance Test Name			1DS	1D5	1D6	AYX	AYZ	BAC	ВАН	B7E
1.	10 MHz Reference Output Accuracy ^b	•									
2.	10 MHz High-Stability Frequency Reference Output Accuracy				•						
4.	Frequency Readout and Marker Frequency Count Accuracy	•									
6.	Frequency Span Accuracy	•									
7.	Noise Sidebands	•									
8.	Noise Sidebands - Wide Offsets	•									
9.	System-Related Sidebands	•									
10.	Residual FM	•									
11.	Sweep Time Accuracy	•									
12.	Display Scale Fidelity	•									
13.	Input Attenuation Switching Uncertainty	•									
15.	Reference Level Accuracy	•									
16.	Resolution Bandwidth Switching Uncertainty	•									
18.	Absolute Amplitude Accuracy (Reference Settings)	•									
20.	Overall Absolute Amplitude Accuracy	•									
21.	Resolution Bandwidth Accuracy	•									
24.	Frequency Response	•									
27.	Frequency Response (Preamp On)			•							
29.	Other Input-Related Spurious Responses	•									
32.	Spurious Responses	•									
34.	Gain Compression	•									
38.	Displayed Average Noise Level	•									
39.	Residual Responses	•									
40.	Fast Time Domain Amplitude Accuracy						•				
42.	Tracking Generator Absolute Amplitude and Vernier Accuracy		•								
44.	Tracking Generator Level Flatness		•								
46.	Tracking Generator Harmonic Spurious Outputs		•								
48.	Tracking Generator Non-Harmonic Spurious Outputs		•								
49.	Tracking Generator L.O. Feedthrough		•								
50.	Gate Delay Accuracy and Gate Length Accuracy					•					
51.	Gate Mode Additional Amplitude Error					•					

Table 1-6 Agilent E4407B Performance Verification Tests

	Performance Test Name		Calibration for Instrument Option:								
	Performance Test Name	$\mathbf{Std}^{\mathbf{a}}$	1DN	1DS	1D5	1D6	AYX	AYZ	BAC	ВАН	B7E
52.	First LO OUTPUT Power Accuracy							•			
53.	IF Input Accuracy							•			
54.	Comms Frequency Response								•	•	
55.	(This test has been deleted.)										
56.	(This test has been deleted.)										
57.	(This test has been deleted.)										
58.	GSM - Phase and Frequency Error ^c										•
59.	Comms Absolute Power Accuracy (Options BAC or BAH)								•	•	

- a. Perform these tests on all E4407B analyzers.
- b. Perform this test only on analyzers not equipped with Option 1D5.
- c. Perform this test only on instruments having Option BAH, GSM Measurement Personality.

Table 1-7 Agilent E4408B Performance Verification Tests

	Performance Test Name		tion for nt Option:
		Std^a	1DN
1.	10 MHz Reference Output Accuracy	•	
4.	Frequency Readout and Marker Frequency Count Accuracy	•	
6.	Frequency Span Accuracy	•	
7.	Noise Sidebands	•	
9.	System-Related Sidebands	•	
10.	Residual FM	•	
11.	Sweep Time Accuracy	•	
12.	Display Scale Fidelity	•	
13.	Input Attenuation Switching Uncertainty	•	
15.	Reference Level Accuracy	•	
16.	Resolution Bandwidth Switching Uncertainty	•	
18.	Absolute Amplitude Accuracy (Reference Settings)	•	
20.	Overall Absolute Amplitude Accuracy	•	
21.	Resolution Bandwidth Accuracy	•	
24.	Frequency Response	•	
29.	Other Input-Related Spurious Responses	•	
32.	Spurious Responses	•	
34.	Gain Compression	•	
38.	Displayed Average Noise Level	•	
39.	Residual Responses	•	
42.	Tracking Generator Absolute Amplitude and Vernier Accuracy		•
44.	Tracking Generator Level Flatness		•
46.	Tracking Generator Harmonic Spurious Outputs		•
48.	Tracking Generator Non-Harmonic Spurious Outputs		•
49.	Tracking Generator L.O. Feedthrough		•

a. Perform these tests on all E4408B analyzers.

Table 1-8 Agilent E4411B Performance Verification Tests

	Performance Test Name		Calibration for Instrument Opt		
		Std^a	1DN	1DQ	
1.	10 MHz Reference Output Accuracy	•			
3.	Frequency Readout and Marker Frequency Count Accuracy	•			
5.	Frequency Span Accuracy	•			
7.	Noise Sidebands	•			
9.	System-Related Sidebands	•			
10.	Residual FM	•			
11.	Sweep Time Accuracy	•			
12.	Display Scale Fidelity	•			
13.	Input Attenuation Switching Uncertainty	•			
14.	Reference Level Accuracy	•			
16.	Resolution Bandwidth Switching Uncertainty	•			
17.	Absolute Amplitude Accuracy (Reference Settings)	•			
19.	Overall Absolute Amplitude Accuracy	•			
21.	Resolution Bandwidth Accuracy	•			
22.	Frequency Response	•			
28.	Other Input-Related Spurious Responses	•			
30.	Spurious Responses	•			
33.	Gain Compression	•			
35.	Displayed Average Noise Level	•			
39.	Residual Responses	•			
41.	Tracking Generator Absolute Amplitude and Vernier Accuracy		•	•	
43.	Tracking Generator Level Flatness		•	•	
45.	Tracking Generator Harmonic Spurious Outputs		•	•	
47.	Tracking Generator Non-Harmonic Spurious Outputs		•	•	

a. Perform these tests on all E4411B analyzers.

Before You Start

This brief procedure should be performed before starting the performance verification tests:

- 1. Switch the analyzer on and let it warm up for five minutes.
- 2. If the analyzer is an Agilent E4402B, E4403B, E4404B, E4405B, E4407B, or E4408B, connect a cable from AMPTD REF OUT to the 50 Ω Input.
- 3. Press **System**, **Alignments**, **Align Now**, **All**, and wait for the auto alignments to finish.
- 4. Read the remainder of this section before you start any of the tests, and make a copy of the Performance Verification Test Record described below in "Recording the test results."

Recording the test results

Performance verification test records, for each analyzer, are provided in the chapter following the tests.

Each test result is identified as a *TR Entry* in the performance tests and on the performance verification test record. We recommend that you make a copy of the performance verification test record, record the test results on the copy, and keep the copy for your calibration test record. This record could prove valuable in tracking gradual changes in test results over long periods of time.

Performing Self-Alignment

Perform a complete self-alignment at least once per day, or if the analyzer fails a verification test. To perform a self-alignment, press **System**, **Alignment**, **Align Now**, **All**. The instrument must be up to operating temperature in order for this test to be valid. If the analyzer continuously fails one or more specifications, complete any remaining tests and record all test results on a copy of the test record. Then refer to Chapter 4 , "If You Have a Problem," for instructions on how to solve the problem.

Periodic verification of operation

The analyzer requires periodic verification of operation. Under most conditions of use, you should test the analyzer at least once a year with the complete set of performance verification tests.

Test equipment you will need

The following tables list the recommended test equipment for the performance tests. The tables also list recommended equipment for the analyzer adjustment procedures which are located in the *Agilent ESA Spectrum Analyzers Service Guide*. Any equipment that meets the critical specifications given in the table can be substituted for the recommended model.

Table 1-9 Recommended Test Equipment

Equipment	Critical Specifications for Equipment Substitution	Recommended HP/Agilent Model	Use ^a
Digital Multimeter	Input Resistance ≥10 megohms Accuracy: ±10 mV on 100 V range	3458A	P,A,T
DVM Test Leads	For use with HP/Agilent 3458A Digital Multimeter	34118B	Т
Universal Counter	Frequency Range: 10 MHz ±100 Hz Time Interval Range: 25 ms to 100 ms Single Trigger Operation Range: 2.5 Vdc to −2.5 Vdc External Reference Input Gate Time: ≥10 seconds Frequency Resolution: 0.01 Hz	53132A	P,A,T
Frequency Standard	Frequency: 10 MHz Timebase Accuracy (Aging): <1×10 ⁻⁹ /day	5071A	P,A

Table 1-9 Recommended Test Equipment

Equipment	Critical Specifications for Equipment Substitution	Recommended HP/Agilent Model	Use ^a
Oscilloscope	Bandwidth: dc to 100 MHz Vertical Scale Factor of 0.5 V to 5 V/Div Two channels Minimum Timebase Setting: <100 ns Digitizing display with pulse width and time interval measurement functions Delta –T measurement accuracy in 200 ns / div: <450 ps	54820A	Т
Power Meter	Compatible with HP/Agilent 8480 series power sensors. dB relative mode. Resolution: 0.01 dB Reference Accuracy: ±1.2%	E4419B	P,A,T
RF Power Sensor (2 required)	Frequency Range: 100 kHz to 3 GHz Maximum SWR: 1.60 (100 kHz to 300 kHz) 1.20 (300 kHz to 1 MHz) 1.1 (1 MHz to 2.0 GHz) 1.18 (2.0 GHz to 3.0 GHz) Amplitude range: -25 dBm to 10 dBm	8482A	P,A,T
Microwave Power Sensor	Frequency Range: 50 MHz to 26.5 GHz Maximum SWR: 1.15 (50 MHz to 100 MHz) 1.10 (100 MHz to 2 GHz) 1.15 (2 GHz to 12.4 GHz) 1.20 (12.4 GHz to 18 GHz) 1.25 (18 GHz to 26.5 GHz) Amplitude range: -25 dBm to 0 dBm	8485A	P,A,T
Power Sensor, Low Power	Frequency Range: 50 MHz to 3.0 GHz Amplitude Range: -20 dBm to -70 dBm Maximum SWR: 1.4 (10 MHz to 30 MHz) 1.15 (30 MHz to 3.0 GHz)	8481D	P,A,T
Synthesized Signal Generator	Frequency Range: 100 kHz to 1500 MHz Amplitude Range: –35 to 16 dBm SSB Noise: <–120 dBc/Hz at 20 kHz offset	8663A	P,A

Table 1-9 Recommended Test Equipment

Equipment	Critical Specifications for Equipment Substitution	Recommended HP/Agilent Model	Use ^a
Wide Offset Phase Noise Signal Generator	Frequency Range: 1 GHz ±1 MHz Amplitude Range: 0 dBM ±5 dB Phase Noise: <-131 dBc/Hz typical @ 100 kHz offset <-145 dBc/Hz typical @ 1 MHz offset <-147 dBc/Hz typical @ 5 MHz offset <-149 dBc/Hz typical @ 10 MHz offset	8665B	P
Signal Generator (Option BAH)	Frequency Range: 900 MHz to 1800 MHz Amplitude Range: -30 to 0 dBm Phase Error: <0.5° Frequency Error: <2.5 Hz	E4433B Option UN8, 1E5	P
Spectrum Analyzer, Microwave	Frequency Range: 100 kHz to 7 GHz Relative Amplitude Accuracy: 100 kHz to 3.0 GHz: <±1.8 dB Frequency Accuracy: <±10 kHz at 7 GHz	8563E	Р,Т
Synthesized Sweeper (2 required)	Frequency Range: E4407B or E4408B: 10 MHz to 26.5 GHz All others: 10 MHz to 13.2 GHz Frequency Accuracy (CW): ±0.02% Leveling Modes: Internal and External Modulation Modes: AM Power Level Range: -40 to 16 dBm	83630/40/50B 83620/30/B 40/50B	P,A,T
Function Generator	Frequency Range: 0.1 Hz to 15 MHz Frequency Accuracy: ±0.02% Waveform: Triangle, Square, Sine	33120A or 3325B	P,A,T
Attenuator/Switch Driver	Compatible with HP/Agilent 8494G and 8496G Programmable step attenuators	11713A	P

Table 1-9 Recommended Test Equipment

Equipment	Critical Specifications for Equipment Substitution	Recommended HP/Agilent Model	Use ^a
Attenuator, 1 dB Step	Attenuation Range: 0 to 11 dB Frequency Range: 50 MHz ±1 MHz Connectors: Type-N female Calibrated at 50 MHz with accuracy of 1 to 11 dB attenuation: ±0.010 dB.	8494A/G	P
Attenuator, 10 dB Step	Attenuation Range: 0 to 110 dB Frequency Range: 50 MHz ±1 MHz Connectors: Type-N female Calibrated at 50 MHz with accuracy of: 0 to 40 dB attenuation: ±0.020 dB 50 to 100 dB attenuation: ±0.065 dB 110 dB attenuation: ±0.075 dB	8496A/G	P
Attenuator, 10 dB Fixed	Nominal attenuation: 10 dB Frequency Range: dc to 3 GHz Connectors: Type-N(m) and Type-N(f)	8491A Option 010	P
Attenuator, 6 dB Fixed (2 required)	Nominal attenuation: 6 dB Frequency Range: 50 MHz ±1 MHz VSWR: <1.1: 1 at 50 MHz	8491A Option 006	Р
Attenuator, 20 dB Fixed	Nominal attenuation: 20 dB Frequency Range: 100 kHz to 3 GHz VSWR: <1.2: 1 at ≤3 GHz	8491A Option 020	Р
Attenuator Interconnect Kit	Mechanically and electrically connects HP/Agilent 8494A/G and HP/Agilent 8496A/G	11716 Series	

a. P = Performance Test, A = Adjustment, T = Troubleshooting

Table 1-10 Recommended Accessories

Equipment	Critical Specifications for Accessory Substitution	Recommended HP/Agilent Model	Use ^a
Directional Bridge	Frequency Range: 5 MHz to 3 GHz Directivity: >40 dB Coupling factor: 16 dB nominal Insertion Loss: 2 dB maximum	86205A	P

Table 1-10 Recommended Accessories

Equipment	Critical Specifications for Accessory Substitution	Recommended HP/Agilent Model	Use ^a
Power Splitter (for E4401B/ 02B/03B/11B)	Frequency Range: 9 kHz to 13.2 GHz Insertion Loss: 6 dB nominal Output Tracking: <0.25 dB Equivalent Output SWR: <1.22:1	11667A	P,A
Power Splitter (for E4404B/ 05B/07B/08B)	Frequency Range: 9 kHz to 26.5 GHz Insertion Loss: 6 dB nominal Output Tracking: <0.25 dB Equivalent Output SWR: <1.22:1	11667B	
Directional Coupler (for E4404B/05B/ 07B/08B)	Frequency Range: 2 GHz to 15 GHz Directivity: >16 dB Max.VSWR: 1.35:1 Transmission Arm Loss: <1.5 dB (nominal) Coupled Arm Loss: ~ 10 dB (nominal)	87300B	
Termination, 50Ω (2 required for Option 1DN)	Impedance: 50 Ω nominal Connector: Type-N (m)	909A	P,T
Termination, 50 Ω	Impedance: 50 Ω (nominal) Connector: BNC (m)	11593A	P,A
Termination, 75 Ω (Option 1DQ, 1DP)	Impedance: 75Ω (nominal) (2 required for Option 1DQ) (1 required for Option 1DP)	909E Option 201	P,T
50 MHz Low Pass Filter	Cutoff Frequency: 50 MHz Rejection at 65 MHz: >40 MHz Rejection at 75 MHz: >60 dB	0955-0306	Р
300 MHz Low Pass Filter	Cutoff Frequency: 300 MHz Rejection at >435 MHz: >45 dB	0955-0455	Р
1 GHz Low Pass Filter	Cutoff Frequency: 1 GHz Rejection at >2 GHz: >60 dB	0955-0487	Р

Table 1-10 Recommended Accessories

Equipment	Critical Specifications for Accessory Substitution	Recommended HP/Agilent Model	Use ^a
1.8 GHz Low Pass Filter (for E4404/5/7/8B)	Cutoff Frequency: 1.8 GHz Rejection at >3 GHz: >45 dB	0955-0491 (2 required)	P
4.4 GHz Low Pass Filter (for E4404/5/7/8B)	Cutoff Frequency: 4.4 GHz Rejection at >5.5 GHz: >42 dB	9135-0005 or 360D (2 required)	P

a. P = Performance Test, A = Adjustment, T = Troubleshooting

Table 1-11 Recommended Adapters

Critical Specifications for Adapter Substitution	Recommended HP/Agilent Model	Use ^a
BNC (m) to BNC (m)	1250-0216	P,T
BNC tee (f,m,f)	1250-0781	A,T
Type-N (f) to APC 3.5 (f)	1250-1745	P,A,T
Type-N (f) to BNC (m)	1250-1477	P,T
Type-N (f) to BNC (m), 75 Ω (2 required for Option 1DQ) (1 required for Option 1DP)	1250-1534	P,A,T
Type-N (m) to BNC (f) (4 required)	1250-1476	P,A,T
Type-N (m) to BNC (m) (2 required)	1250-1473	P,T
Type-N (m) to BNC (m), 75 Ω (Option 1DP)	1250-1533	P,A,T
Type-N (m) to Type-N (m)	1250-1472	P,T
Type-N (m) to Type-N (m)	1250-1475	P,A,T
Type-N (f) to Type-N (f), 75 Ω (Option 1DP)	1250-1529	P,A,T
Type-N (f), 75 Ω , to Type-N (m), 50 Ω (Option 1DP)	1250-0597	P,A,T
Type-N (m) to SMA (m)	1250-1636	P
50 to 75 Ω Minimum Loss Frequency Range: dc to 1.5 GHz Insertion Loss: 5.7 dB, nominal (Option 1DP)	11852B	P,A,T
Type N(f) to Type N(f)	1250-0777	
Type N(f) to BNC(f), 75 ohm (Option 1DP only)	1250-1535	
Type N (m) to APC 3.5 (f) (3 required)	1250-1744	
APC 3.5 (f) to APC 3.5 (f)	1250-1749	
Dual Banana to BNC (f)	1251-2277	P,A,T
Type N (m) to BNC (f) (2 required)	1250-0780	

a. P = Performance Test, A = Adjustment, T = Troubleshooting

Table 1-12 Recommended Cables

Critical Specifications for Cable Substitution	Recommended HP/Agilent Model	Use ^a
Frequency Range: dc to 1 GHz Length: ≥122 cm (48 in) Connectors: BNC (m) both ends (4 required)	10503A	P,A,T
Type-N, 62 cm (24 in)	11500C	P,T
Type-N, 152 cm (60 in) (2 required)	11500D	P,A,T
Frequency Range: dc to 310 MHz Length: 23 cm (9 in) Connectors: BNC (m) both ends	10502A	P,T
BNC, 75 Ω, 30 cm (12 in) (Option 1DP)	5062-6452	P,A,T
Cable, Test Length: ≥91 cm (36 in) Connectors: SMB (f) to BNC (m) (2 required)	85680-60093	Т
APC 3.5 Cable Frequency: 9 kHz to 26.5 GHz Connectors: APC 3.5 (m) Length: >92 cm (36 in) (2 required)	8120-4921	P,A,T

a. P = Performance Test, A = Adjustment, T = Troubleshooting

Performance Verification Tests

These tests verify the electrical performance of the analyzer. Allow the analyzer to warm up in accordance with the temperature stability specifications before performing the tests.

Tests included in this section:

- 1. 10 MHz Reference Output Accuracy
- 2. 10 MHz High-Stability Frequency Reference Output Accuracy: Agilent E4401B, E4402B, E4404B, E4405B, and E4407B (Option 1D5)
- 3. Frequency Readout and Marker Frequency Count Accuracy: Agilent E4401B, E4402B, E4403B, and E4411B
- 4. Frequency Readout and Marker Frequency Count Accuracy: Agilent E4404B, E4405B, E4407B, and E4408B
- 5. Frequency Span Accuracy: Agilent E4401B and E4411B
- 6. Frequency Span Accuracy: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B
- 7. Noise Sidebands
- $8.\ Noise\ Sidebands$ Wide Offsets: Agilent E4402B, E4404B, E4405B and E4407B
- 9. System-Related Sidebands
- 10. Residual FM
- 11. Sweep Time Accuracy
- 12. Display Scale Fidelity
- 13. Input Attenuation Switching Uncertainty
- 14. Reference Level Accuracy: Agilent E4401B and E4411B
- 15. Reference Level Accuracy: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B.
- 16. Resolution Bandwidth Switching Uncertainty
- 17. Absolute Amplitude Accuracy (Reference Settings): Agilent E4401B and E4411B
- 18. Absolute Amplitude Accuracy (Reference Settings): Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B
- 19. Overall Absolute Amplitude Accuracy: Agilent E4401B and E4411B
- 20. Overall Absolute Amplitude Accuracy: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B
- 21. Resolution Bandwidth Accuracy
- 22. Frequency Response: Agilent E4401B and E4411B

- 23. Frequency Response, Agilent E4402B and E4403B
- 24. Frequency Response, Agilent E4404B, E4405B, E4407B, and E4408B
- 25. Frequency Response (Preamp On): Agilent E4401B
- 26. Frequency Response (Preamp On): Agilent E4402B
- 27. Frequency Response (Preamp On): Agilent E4404B, E4405B, and E4407B
- 28. Other Input-Related Spurious Responses: Agilent E4401B and E4411B
- 29. Other Input-Related Spurious Responses: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B
- 30. Spurious Responses: Agilent E4401B and E4411B
- 31. Spurious Responses: Agilent E4402B and E4403B
- 32. Spurious Responses: Agilent E4404B, E4405B, E4407B, and E4408B
- 33. Gain Compression: Agilent E4401B, E4402B, E4403B, and E4411B
- $34.\ Gain\ Compression:$ Agilent E4404B, E4405B, E4407B, and E4408B
- 35. Displayed Average Noise Level: Agilent E4401B and E4411B
- 36. Displayed Average Noise Level: Agilent E4402B and E4403B
- 37. Displayed Average Noise Level: Agilent E4404B and E4405B
- 38. Displayed Average Noise Level: Agilent E4407B and E4408B
- 39. Residual Responses
- 40. Fast Time Domain Amplitude Accuracy: Agilent E4401B, E4402B, E4404B, E4405B, and E4407B (Option AYX)
- 41. Tracking Generator Absolute Amplitude and Vernier Accuracy: Agilent E4401B and E4411B (Option 1DN or 1DQ)
- 42. Tracking Generator Absolute Amplitude and Vernier Accuracy: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B (Option 1DN)
- 43. Tracking Generator Level Flatness: Agilent E4401B and E4411B (Option 1DN or 1DQ)
- 44. Tracking Generator Level Flatness: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B (Option 1DN)
- 45. Tracking Generator Harmonic Spurious Outputs: Agilent E4401B and E4411B (Option 1DN or 1DQ)

Chapter 2 35

Tests included in this section:

- 46. Tracking Generator Harmonic Spurious Outputs: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B (Option 1DN)
- 47. Tracking Generator Non-Harmonic Spurious Outputs: Agilent E4401B and E4411B (Option 1DN or 1DQ)
- 48. Tracking Generator Non-Harmonic Spurious Outputs: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B (Option 1DN)
- 49. Tracking Generator LO Feedthrough: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B(Option 1DN)
- 50. Gate Delay Accuracy and Gate Length Accuracy: Agilent E4401B, E4402B, E4404B, E4405B, and E4407B (Option 1D6)
- 51. Gate Mode Additional Amplitude Error: Agilent E4401B, E4402B, E4404B, E4405B, and E4407B (Option 1D6)
- 52. First LO OUTPUT Power Accuracy (Option AYZ only)
- 53. IF INPUT Accuracy (Option AYZ only)
- 54. Comms Frequency Response (Option BAC or BAH)
- 55. This Test Has Been Deleted (Modulation Accuracy Rho)
- 56. This Test Has Been Deleted (CDMA Modulation Accuracy EVM)
- 57. This Test Has Been Deleted (CDMA Code Domain Power)
- 58. GSM Phase and Frequency Error (Options BAH and B7E)
- 59. Comms Absolute Power Accuracy (Options BAC or BAH)

Calibration

To perform calibration:

- 1. Run all performance verification tests listed in Column 1 of Table 2-1 that are applicable to the analyzer being calibrated and the installed options. Refer to the Performance Verification test tables in Chapter 1 for a list of the tests that are applicable to the analyzer being calibrated.
- 2. If any of the performance verification tests fail, perform the appropriate calibration adjustments listed in Column 2 of Table 2-1 which corresponds to the failure.
- 3. Repeat all of the performance verification tests listed in Column 1 of Table 2-1 if any calibration adjustments were made in step 2. This will confirm that there is no interaction between adjustments which could negatively impact analyzer performance.

Table 2-1 lists the performance verification tests and adjustments needed for calibration. The performance tests are located in the following pages of this chapter. Adjustment information is located in the service guide.

Table 2-1 Calibration Requirements

Test #	Performance Verification Tests	Calibration Adjustments
1.	10 MHz Reference Output Accuracy	10 MHz Frequency Reference Adjustment
2.	10 MHz High-Stability Frequency Reference Output Accuracy	10 MHz Frequency Reference Adjustment
3.	Frequency Readout and Marker Frequency Count Accuracy	None
4.	Frequency Readout and Marker Frequency Count Accuracy	None
5.	Frequency Span Accuracy	None
6.	Frequency Span Accuracy	None
7.	Noise Sidebands	None
8.	Noise Sidebands - Wide Offsets	None
9.	System-Related Sidebands	IF Amplitude
10.	Residual FM	None
11.	Sweep Time Accuracy	None
12.	Display Scale Fidelity	IF Amplitude
13.	Input Attenuation Switching Uncertainty	50 MHz Amplitude Reference
14.	Reference Level Accuracy	IF Amplitude
15.	Reference Level Accuracy	IF Amplitude
16.	Resolution Bandwidth Switching Uncertainty	IF Amplitude
17.	Absolute Amplitude Accuracy (Reference Settings)	None
18.	Absolute Amplitude Accuracy (Reference Settings)	None
19.	Overall Absolute Amplitude Accuracy	Frequency Response Adjustment
20.	Overall Absolute Amplitude Accuracy	None
21.	Resolution Bandwidth Accuracy	IF Amplitude
22.	Frequency Response	Frequency Response
23.	Frequency Response	Frequency Response

Table 2-1 Calibration Requirements

Test #	Performance Verification Tests	Calibration Adjustments
24.	Frequency Response	Frequency Response
25.	Frequency Response (Preamp On)	Frequency Response
26.	Frequency Response (Preamp On)	Frequency Response
27.	Frequency Response (Preamp On)	Frequency Response
28.	Other Input-Related Spurious Responses	None
29.	Other Input-Related Spurious Responses	None
30.	Spurious Responses	None
31.	Spurious Responses	None
32.	Spurious Responses	None
33.	Gain Compression	None
34.	Gain Compression	None
35.	Displayed Average Noise Level	Frequency Response
36.	Displayed Average Noise Level	Frequency Response
37.	Displayed Average Noise Level	Frequency Response
38.	Displayed Average Noise Level	Frequency Response
39.	Residual Responses	None
40.	Fast Time Domain Amplitude Accuracy	None
41.	Tracking Generator Absolute Amplitude and Vernier Accuracy	Tracking Generator ALC and Tracking Generator Frequency Slope
42.	Tracking Generator Absolute Amplitude and Vernier Accuracy	Tracking Generator ALC and Tracking Generator Frequency Slope
43.	Tracking Generator Level Flatness	Tracking Generator ALC and Tracking Generator Frequency Slope
44.	Tracking Generator Level Flatness	Tracking Generator ALC and Tracking Generator Frequency Slope
45.	Tracking Generator Harmonic Spurious Outputs	None
46.	Tracking Generator Harmonic Spurious Outputs	None

Table 2-1 Calibration Requirements

Test #	Performance Verification Tests	Calibration Adjustments
47.	Tracking Generator Non-Harmonic Spurious Outputs	None
48.	Tracking Generator Non-Harmonic Spurious Outputs	None
49.	Tracking Generator L.O. Feedthrough	LO Power
50.	Gate Delay Accuracy and Gate Length Accuracy	None
51.	Gate Mode Additional Amplitude Error	None
52.	First LO OUTPUT Power Accuracy	LO Power
53.	IF INPUT Accuracy	IF INPUT Correction
54.	Comms Frequency Response	Frequency Response Error Correction
55.	Deleted	None
56.	Deleted	None
57.	Deleted	None
58.	GSM Phase and Frequency Error	None
59.	Comms Absolute Power Accuracy	IF Amplitude Adjustment

Manual use of Agilent 8494G and Agilent 8496G Attenuators with the Agilent 11713A

When using the programmable versions of the 1 dB and 10 dB step attenuator (Agilent 8494G and Agilent 8496G), the Agilent 11713A Attenuator/ Switch Driver must be used to control the attenuators. The Agilent 8494G 1 dB step attenuator should be connected as Attenuator X and the Agilent 8496G 10 dB step attenuator should be connected as Attenuator Y.

Use Table 2-2 to determine which of the Attenuator X and Attenuator Y settings are use to set the step attenuators to the desired value. In the columns labeled Attenuator X and Attenuator Y, a "1" indicates that section is on (the LED in the button will be lit), while a "0" indicates that section is off. For example, if the 1 dB step attenuator should be set to 2 dB and the 10 dB step attenuator should be set to 60 dB, sections 2, 6, and 7 should be on (lit) and all other sections should be off.

Table 2-2 Agilent 11713A Settings for Agilent 8494G and Agilent 8496G

1 dB Step	Attenuator X 10 dB Attenuator Y Step		uator Y						
Atten (dB)	1	2	3	4	Atten (dB)	5	6	7	8
0	0	0	0	0	0	0	0	0	0
1	1	0	0	0	10	1	0	0	0
2	0	1	0	0	20	0	1	0	0
3	1	1	0	0	30	1	1	0	0
4	0	0	1	0	40	0	0	1	0
5	1	0	1	0	50	1	0	1	0
6	0	1	1	0	60	0	1	1	0
7	1	1	1	0	70	1	1	1	0
8	0	0	1	1	80	0	0	1	1
9	1	0	1	1	90	1	0	1	1
10	0	1	1	1	100	0	1	1	1
11	1	1	1	1	110	1	1	1	1

1. 10 MHz Reference Output Accuracy

The setability is measured by changing the settings of the digital-to-analog converter (DAC), which controls the frequency of the timebase. The difference in frequency for each DAC step is calculated and compared to the specification.

The related adjustment for this performance verification test is the "10 MHz Reference Frequency Adjustment."

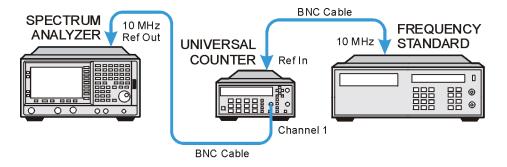
Equipment Required

Universal counter (Instructions are for Agilent 53132A. For Agilent 5316B, refer to its user documentation.)

Frequency standard

Cable, BNC, 122-cm (48-in) (2 required)

Figure 2-1 10 MHz Reference Test Setup



wl73a

Procedure

- 1. Connect the equipment as shown in Figure 2-1. The frequency standard provides the reference for the universal counter.
- 2. Check that the analyzer is not in external reference mode. If Ext Ref appears on the screen, the analyzer is in external reference mode. If the analyzer is in external reference mode, disconnect the external reference.
- 3. Ensure that the analyzer has been on and in internal frequency mode for at least five minutes before proceeding.
- 4. Set the universal counter controls as follows:
 - a. Press Gate & ExtArm.
 - b. Press any one of the arrow keys until TIME is displayed.
 - c. Press Gate & ExtArm again. Using the arrow keys, set the time to

10 s.

- d. Press Enter.
- e. On Channel 1, press 50 $\Omega/1$ M Ω until the LED is lit.
- f. On Channel 1, press x10 Attenuator until the LEd is extinguished.
- g. On Channel 1, press **AC/DC** until the LED next to DC is extinguished.
- h. On Channel 1, press 100 kHz Filter until the LED is extinguished.
- i. On Channel 1, press Trigger/Sensitivity until Auto Trig is displayed.
- j. Use the arrow keys to toggle to off.
- k. Press Freq & Ratio.
- 5. Wait for the universal counter reading to stabilize. Record the universal counter reading in Table 2-3 as Counter Reading 1 with 0.1 Hz resolution.
- 6. Set the analyzer by pressing the following keys:

System, Alignments, Timebase, Fine

- 7. Record the number in the active function block of the analyzer in Table 2-3 as Timebase Fine.
- 8. Press the \uparrow (up arrow) key on the analyzer.
- 9. Wait for the frequency counter reading to stabilize. Record the frequency counter reading in Table 2-3 as Counter Reading 2 with 0.1 Hz resolution.
- 10.Press the \downarrow (down arrow) key on the analyzer 2 times.
- 11. Wait for the frequency counter reading to stabilize. Record the frequency counter reading in Table 2-3 as Counter Reading 3 with 0.1 Hz resolution.
- 12.Press **Preset** on the analyzer to return the DAC settings to their initial values. Press the **Factory Preset** softkey, if it is displayed.
- 13.Subtract Counter Reading 1 from Counter Reading 2 and record the difference in Table 2-3 as the Positive Frequency Change.
 - Positive Frequency Change = Counter Reading 2 Counter Reading 1
- 14.Subtract Counter Reading 3 from Counter Reading 1 and record the difference in Table 2-3 as the Positive Frequency Change.
 - Negative Frequency Change = Counter Reading 1 Counter Reading 3
- 15.Of the Positive Frequency Change and negative frequency change values recorded in Table 2-3, record the largest value in Table 2-3 as

1. 10 MHz Reference Output Accuracy

the maximum frequency change.

16.Divide the maximum frequency change by two and record the result as the settability.

Table 2-3 10 MHz Reference Accuracy Worksheet

Description	Measurement
Counter Reading 1	Hz
Timebase Fine DAC	Hz
Counter Reading 2	Hz
Counter Reading 3	Hz
Positive Frequency Change	Hz
Negative Frequency Change	Hz
Maximum Frequency Change	Hz
Settability	Hz

2. 10 MHz High-Stability Frequency Reference Output Accuracy: Agilent E4401B, E4402B, E4404B, E4405B, and E4407B (Option 1D5)

This test applies only to analyzers equipped with the high-stability frequency reference, Option 1D5. If your analyzer does not have Option 1D5, perform the "10 MHz Reference Output Accuracy" test instead.

This test measures the warmup characteristics of the 10 MHz reference oscillator. The ability of the 10 MHz oscillator to meet its warmup characteristics gives a high level of confidence that it will also meet its yearly aging specification.

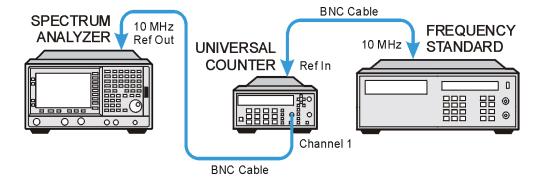
The universal counter is connected to the 10 MHz REF OUT. After the analyzer has been allowed to cool for at least 60 minutes, the analyzer is powered on. A frequency measurement is made five minutes after power is applied and the frequency is recorded. Another frequency measurement is made 10 minutes later (15 minutes after power is applied) and the frequency is recorded. A final frequency measurement is made 60 minutes after power is applied. The difference between each of the first two frequency measurements and the last frequency measurement is calculated and recorded.

The related adjustment for this performance verification test is the "10 MHz Reference Frequency Adjustment."

Equipment Required

- ☐ Universal counter (Instructions are for Agilent 53132A. For Agilent 5316B, refer to its user documentation.)
- ☐ Frequency standard
- ☐ Cable, BNC, 122-cm (48-in) (2 required)

Figure 2-2 Frequency Reference Test Setup



wl73a

2. 10 MHz High-Stability Frequency Reference Output Accuracy: Agilent E4401B, E4402B, E4404B, E4405B, and E4407B (Option 1D5)

Procedure

The analyzer must have been allowed to sit with the power off for at least 60 minutes before performing this procedure. This adequately simulates a cold start.

- 1. Allow the analyzer to sit with the power off for at least 60 minutes before proceeding.
- 2. Switch the power to the analyzer on. Record the Power On Time below.

Power On Time	
---------------	--

- 3. Connect the equipment as shown in Figure 2-2. The frequency standard provides the reference for the universal counter.

 Disconnect any cable to the 10 MHz REF INPUT of the analyzer.
- 4. Check that the analyzer is not in external reference mode. Ext Ref will appear on the display if the analyzer is in external reference mode. If the analyzer is in external reference mode, disconnect the external reference.
- 5. Set the universal counter controls as follows:
 - a. Press Gate & ExtArm.
 - b. Press any one of the arrow keys until TIME is displayed.
 - c. Press **Gate & ExtArm** again. Using the arrow keys, set the TIME to 10s.
 - d. Press Enter
 - e. On Channel 1, press 50 Ω /1 M Ω to light the LED next to 50 Ω
 - f. On Channel 1, press **AC/DC** to extinguish the LED next to DC.
 - g. On Channel 1, press **x10** Attenuator to extinguish the LED next to x10 Attenuator.
 - h. On Channel 1, press 100 kHz Filter to extinguish the LED next to 100 kHz Filter.
 - i. On Channel 1, press Trigger/Sensitivity until Auto Trig is displayed.
 - j. Use the arrows keys to toggle to off.
 - k. Press Freq & Ratio
- 6. Continue with the next step 5 minutes after the Power On Time noted in step 2.
- 7. Wait for the universal counter reading to make at least two readings. Record the universal counter reading in Table 2-3 as Counter Reading 1 with 0.001 Hz resolution.

- 2. 10 MHz High-Stability Frequency Reference Output Accuracy: Agilent E4401B, E4402B, E4404B, E4405B, and E4407B (Option 1D5)
- 8. Continue with next step 15 minutes after the Power On Time noted in step 2.
- 9. Wait for the universal counter reading to make at least two readings. Record the universal counter reading in Table 2-3 as Counter Reading 2 with 0.001 Hz resolution.
- 10.Continue with next step 60 minutes after the Power On Time noted in step 2.
- 11. Wait for the universal counter reading to make at least two readings. Record the universal counter reading in Table 2-3 as Counter Reading 3 with 0.001 Hz resolution.
- 12.Calculate the 5 Minute Warm-up Error (in ppm) by subtracting Counter Reading 3 from Counter Reading 1 and dividing the result by 10.
 - 5 Minute Warm-up Error = (Counter Reading 1 Counter Reading 3)/10

NOTE

Dividing the frequency by 10 is equivalent to dividing the difference first by 10 MHz (to normalize the difference to the reference frequency) and then multiplying by 1 x 106 to convert the result to parts-per-million (ppm).

- 13.Record the 5 Minute Warm-up Error (in ppm) in the performance verification test record as Test Record entry 1.
- 14.Calculate the 15 Minute Warm-up Error (in ppm) by subtracting Counter Reading 3 from Counter Reading 2 and dividing the result by 10.
 - 15 Minute Warm-up Error = (Counter Reading 2 Counter Reading 3)/10
- 15.Record the 15 Minute Warm-up Error in the performance verification test record as Test Record entry 2.

Table 2-4 10 MHz Reference Accuracy Worksheet

Description	Measurement
Counter Reading 1	Hz
Counter Reading 2	Hz
Counter Reading 3	Hz

3. Frequency Readout and Marker Frequency Count Accuracy: Agilent E4401B, E4402B, E4403B, and E4411B

The frequency readout accuracy of the analyzer is tested with an input signal of known frequency. By using the same frequency standard for the analyzer and the synthesized sweeper, the frequency reference error is eliminated.

There are no related adjustment procedures for this performance test.

Equipment Required

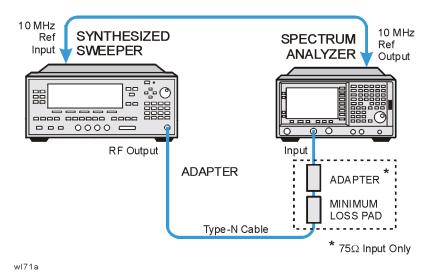
Synthesized sweeper Adapter, Type N (f) to APC 3.5 (m) Cable, Type N, 183 cm (72 in) Cable, BNC, 122 cm (48 in)

Additional Equipment for 75 Ω Input

Pad, minimum loss Adapter, Type N (f) to BNC (m), 75 Ω

Procedure

Figure 2-3 Frequency Readout and Marker Frequency Accuracy Test Setup



This performance test consists of two parts:

"Part 1: Frequency Readout Accuracy"

"Part 2: Marker Count Accuracy"

Perform "Part 1: Frequency Readout Accuracy" before "Part 2: Marker Count Accuracy".

Part 1: Frequency Readout Accuracy

1. Connect the equipment as shown in Figure 2-3. Remember to connect the 10 MHz REF OUT of the analyzer to the 10 MHz REF INPUT of the synthesized sweeper.

CAUTION

Use only 75 Ω cables, connectors, or adapters on instruments with 75 Ω inputs, or the input connector will be damaged.

- 2. Perform the following steps to set up the equipment:
 - a. Press **INSTRUMENT PRESET** on the synthesized sweeper, then set the controls as follows:

CW, 1.490 GHz ($Agilent\ E4401B\ and\ E4411B$) CW, 1.5 GHz ($Agilent\ E4402B\ and\ E4403B$) POWER LEVEL, –10 dBm

b. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the analyzer by pressing the following keys:

FREQUENCY, 1.5 GHz SPAN, 20 MHz

- 3. Press **Peak Search** (or **Search**) on the analyzer to measure the frequency readout accuracy.
- 4. Record the marker frequency reading in the performance verification test record.
- 5. Repeat step 3 and step 4 above for the remaining spans listed in Table 2-5.

Table 2-5 Frequency Readout Accuracy

Analyzer Span (MHz)	Test Record Entry, Actual Marker Frequency
20	1)
10	2)
1	3)

Part 2: Marker Count Accuracy

Perform "Part 1: Frequency Readout Accuracy" before performing this procedure.

1. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is

3. Frequency Readout and Marker Frequency Count Accuracy: Agilent E4401B, E4402B, E4403B, and E4411B

displayed. Set the analyzer to measure the marker count accuracy by pressing the following keys:

FREQUENCY, 1.490 GHz ($Agilent\ E4401B\ and\ E4411B$) FREQUENCY, 1.5 GHz ($Agilent\ E4402B\ and\ E4403B$) SPAN, 10 MHz BW/Avg, Res BW, 100 kHz (Man) Freq Count, Marker Count (On) Resolution (Man), 1 Hz

- 2. Press **Peak Search** (or **Search**), then wait for a count be taken (it may take several seconds).
- 3. Record the counter (Cntr1) frequency reading as Test Record entry 4 of the performance verification test record.
- 4. On the analyzer, press **SPAN**, **1 MHz**.
- 5. Press **Peak Search** (or **Search**), then wait for a count be taken (it may take several seconds).
- 6. Record the counter (Cntr1) frequency reading as Test Record entry 5 of the performance verification test record.

4. Frequency Readout and Marker Frequency Count Accuracy: Agilent E4404B, E4405B, E4407B, and E4408B

The frequency readout accuracy of the analyzer is tested with an input signal of known frequency. By using the same frequency standard for the analyzer and the synthesized sweeper, the frequency reference error is eliminated.

There are no related adjustment procedures for this performance test.

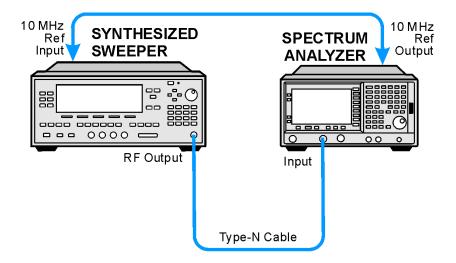
Equipment Required

Synthesized sweeper Adapter, Type N (m) to APC 3.5 (f) Adapter, APC 3.5 (f) to APC 3.5 (f) Cable, APC 3.5, 91 cm (36 in) Cable, BNC, 122 cm (48 in)

Additional Equipment for Option BAB

Adapter, APC 3.5 (f) to APC 3.5 (f)

Figure 2-4 Frequency Readout and Marker Count Accuracy Test Setup



wl772a

4. Frequency Readout and Marker Frequency Count Accuracy: Agilent E4404B, E4405B, E4407B, and E4408B

Procedure

This performance verification test consists of two parts:

"Part 1: Frequency Readout Accuracy"
"Part 2: Marker Count Accuracy"

Perform "Part 1: Frequency Readout Accuracy" before "Part 2: Marker Count Accuracy."

Part 1: Frequency Readout Accuracy

1. Connect the equipment as shown in Figure 2-4. Remember to connect the 10 MHz REF OUT of the analyzer to the 10 MHz REF INPUT of the synthesized sweeper.

Option BAB only: Use the APC 3.5 adapter to connect the cable to the analyzer input.

- 2. Perform the following steps to set up the equipment:
 - a. Press **INSTRUMENT PRESET** on the synthesized sweeper, then set the controls as follows:

CW, 1.5 GHz POWER LEVEL, -10 dBm

b. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the analyzer by pressing the following keys:

FREQUENCY, 1.5 GHz SPAN, 20 MHz

- 3. Press **Peak Search** (or **Search**) on the analyzer to measure the frequency readout accuracy.
- 4. Record the marker (Mkr1) frequency reading in the performance verification test record as indicated in Table 2-6.
- 5. Change to the next analyzer span setting listed in Table 2-6.
- 6. Repeat step 3 through step 5 for each analyzer frequency and span setting and synthesized sweeper CW frequency setting listed in Table 2-6 for the analyzer being tested.

Table 2-6 Frequency Readout Accuracy

Synthesized Sweeper CW Frequency (MHz)	Analyzer Span (MHz)	Analyzer Center Frequency (GHz)	Test Record Entry Frequency (GHz)
1500	20	1.5	1)

Table 2-6 Frequency Readout Accuracy

Synthesized Sweeper CW Frequency (MHz)	Analyzer Span (MHz)	Analyzer Center Frequency (GHz)	Test Record Entry Frequency (GHz)
1500	10	1.5	2)
1500	1	1.5	3)
4000	20	4.0	4)
4000	10	4.0	5)
4000	1	4.0	6)
	Stop here for Agil	ent E4404B.	
9000	9000 20		7)
9000	10	9.0	8)
9000	1	9.0	9)
	Stop here for Agil	ent E4405B.	
16000	20	16.0	10)
16000	10	16.0	11)
16000	1	16.0	12)
21000	20	21.0	13)
21000	10	21.0	14)
21000	1	21.0	15)

Part 2: Marker Count Accuracy

Perform "Part 1: Frequency Readout Accuracy" before performing this procedure.

1. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the analyzer to measure the marker count accuracy by pressing the following keys:

FREQUENCY, 1.5 GHz SPAN, 20 MHz BW/Avg, Res BW, 100 kHz (Man) Freq Count, Marker Count (On) Resolution (Man)

- 2. Press **Peak Search** (or **Search**), then wait for a count be taken (it may take several seconds).
- 3. Record the counter (Cntr1) frequency reading in the performance

4. Frequency Readout and Marker Frequency Count Accuracy: Agilent E4404B, E4405B, E4407B, and E4408B

verification test record as indicated in Table 2-7.

4. Repeat step 2 and step 3 for each analyzer center frequency and span setting and synthesized sweeper CW frequency setting listed in Table 2-7 for the analyzer being tested.

Performance verification test "Frequency Readout Accuracy and Marker Count Accuracy" is now complete.

Table 2-7 Marker Count Accuracy

Synthesized Sweeper CW Frequency	Analyzer Center Frequency	Analyzer Span	Counter Frequency (Cntr1)
MHz	GHz	MHz	Test Record Entry
1500	1.5	20	16)
1500	1.5	1	17)
4000	4.0	20	18)
4000	4.0	1	19)
Sto	op here for Agilent	t E4404B.	
9000	9.0	20	20)
9000	9.0	1	21)
Sto	op here for Agilen	t E4405B.	
16000	16.0	20	22)
16000	16.0	1	23)
21000	21.0	20	24)
21000	21.0	1	25)

5. Frequency Span Accuracy: Agilent E4401B and E4411B

For testing each frequency span, two synthesized sources are used to provide two precisely-spaced signals. The analyzer marker functions are used to measure this frequency difference.

There are no related adjustment procedures for this performance test.

Equipment Required

Synthesized sweeper Synthesized signal generator Power splitter Adapter, Type-N (m) to Type-N (m) Adapter, Type-N (f) to APC 3.5 (f) Cable, Type-N, 152-cm (60-in) (2 required) Cable, BNC, 122-cm (48-in)

Additional Equipment for 75 Ω Input

Pad, minimum loss Adapter, Type-N (f), to BNC (m), 75 Ω

Procedure

Full Span Frequency Span Readout Accuracy

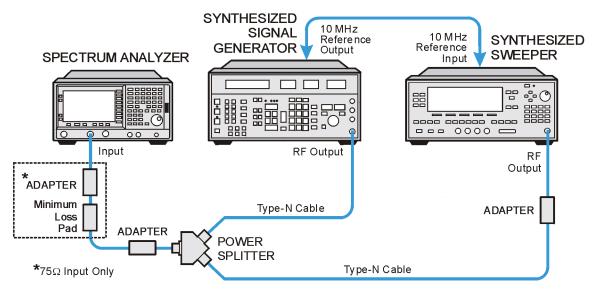
- 1. Connect the equipment as shown in Figure 2-5. Note that the power splitter is used as a combiner. The synthesized signal generator provides the frequency reference for the synthesized sweeper.
- 2. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed.
- 3. Press **PRESET** on the synthesized sweeper and set the controls as follows:

CW, 1350 MHz POWER LEVEL, -5 dBm

4. On the synthesized signal generator, set the controls as follows:

FREQUENCY, 150 MHz AMPLITUDE, 0 dBm

Figure 2-5 Frequency Span Readout Accuracy Test Setup



wl75a

- 5. Adjust the analyzer center frequency, if necessary, to place the lower frequency on the second vertical graticule line (one division from the left-most graticule line).
- 6. On the analyzer, press **Single**. Wait for the completion of a new sweep, then press the following keys:

Peak Search (or Search)
Marker, Delta
Peak Search (or Search)
Next Peak

The two markers should be on the signals near the second and tenth vertical graticule lines (the first graticule line is the left-most).

- 7. If necessary, continue pressing **Next Peak** until the active marker is on the right-most signal (1350 MHz).
- 8. Record the marker delta (Δ Mkr1) frequency reading as Test Record entry 1 of the performance verification test record.

100 kHz and 100 MHz Frequency Span Readout Accuracy

1. Set the analyzer by pressing the following keys:

FREQUENCY, Start Freq, 10 MHz Stop Freq, 110 MHz Sweep, Sweep (Cont)

2. On the synthesized sweeper set the controls as follows:

CW, 100 MHz POWER LEVEL, -5 dBm

3. Set the synthesized signal generator controls as follows:

FREQUENCY, 20 MHz AMPLITUDE, 0 dBm

- 4. Adjust the analyzer center frequency to center the two signals on the display.
- 5. On the analyzer, press **Single**. Wait for the completion of a new sweep, then press the following keys:

Peak Search (or Search)
Marker, Delta
Peak Search (or Search)
Next Peak

The two markers should be on the signals near the second and tenth vertical graticule lines (the first graticule line is the left-most).

- 6. If necessary, continue pressing **Next Peak** until the active marker is on the right-most signal (100 MHz). Record the marker delta (Δ Mkr1) frequency reading in the performance test record as Test Record entry 2.
- 7. Press Marker, More, Marker All Off on the analyzer.
- 8. Change to the next equipment settings listed in Table 2-8.
- 9. On the analyzer, press **Single**. Wait for the completion of a newsweep, then press the following keys:

Peak Search (or Search) Marker, Delta Peak Search (or Search) Next Peak

- 10.If necessary, continue pressing **Next Peak** until the marker delta is on the right-most signal. Record the marker delta (Δ Mkr1) frequency reading in the performance test record.
- 11.Repeat step 7 through step 10 for the remaining analyzer span settings listed in Table 2-8.

Table 2-8 Frequency Span Readout Accuracy

Analyzer Start Frequency (MHz)	Analyzer Stop Frequency (MHz)	Synthesized Signal Generator Frequency (MHz)	Synthesized Sweeper Frequency (MHz)	Test Record Entry	Analyzer Span (MHz)
0	1500	150	1350	1)	1500

 Table 2-8
 Frequency Span Readout Accuracy

Analyzer Start Frequency (MHz)	Analyzer Stop Frequency (MHz)	Synthesized Signal Generator Frequency (MHz)	Synthesized Sweeper Frequency (MHz)	Test Record Entry	Analyzer Span (MHz)
10	110	20	100	2)	100
10	10.1	10.01	10.09	3)	0.1
800	900	810	890	4)	100
800	800.1	800.01	800.09	5)	0.1
1400	1500	1410	1490	6)	100
1499	1499.1	1499.01	1499.09	7)	0.1

6. Frequency Span Accuracy: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B

For testing each frequency span, two synthesized sources are used to provide two precisely-spaced signals. The analyzer marker functions are used to measure this frequency difference.

There are no related adjustment procedures for this performance test.

Equipment Required

Synthesized sweeper Synthesized signal generator Power splitter Adapter, Type-N (m) to Type-N (m) Adapter, Type-N (f) to APC 3.5 (f) Cable, Type-N, 152-cm (60-in) (2 required) Cable, BNC, 122-cm (48-in)

Additional Equipment for Option BAB

Adapter, Type-N (m), to APC 3.5 (f)

Procedure

Full Span Frequency Span Readout Accuracy

- 1. Connect the equipment as shown in Figure 2-6. Note that the power splitter is used as a combiner. The synthesized signal generator provides the frequency reference for the synthesized sweeper.
- 2. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the analyzer by pressing the following keys:

FREQUENCY, Stop Freq, 3 GHz

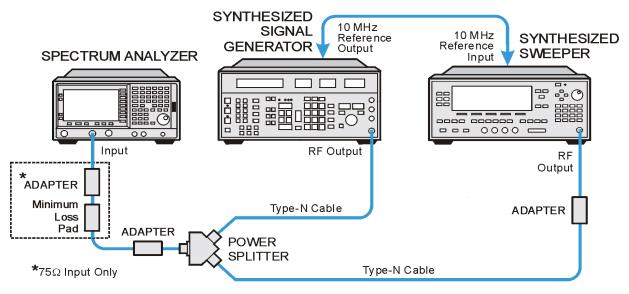
3. Press **PRESET** on the synthesized sweeper and set the controls as follows:

CW, 2700 MHz POWER LEVEL, -5 dBm

4. On the synthesized signal generator, set the controls as follows:

FREQUENCY, 300 MHz AMPLITUDE, 0 dBm

Figure 2-6 Frequency Span Readout Accuracy Test Setup



wI75a

- 5. Adjust the analyzer center frequency, if necessary, to place the lower frequency on the second vertical graticule line (one division from the left-most graticule line).
- 6. On the analyzer, press **Single**. Wait for the completion of a new sweep, then press the following keys:

Peak Search (or Search)
Marker, Delta
Peak Search (or Search)
Next Peak

NOTE

The two markers should be on the signals near the second and tenth vertical graticule lines (the first graticule line is the left-most).

- 7. If necessary, continue pressing **Next Peak** until the active marker is on the right-most signal (2700 MHz).
- 8. Record the marker delta (Δ Mkr1) frequency reading as Test Record entry 1 of the performance verification test record.

100 kHz and 100 MHz Frequency Span Readout Accuracy

1. Set the analyzer by pressing the following keys:

FREQUENCY, Start Freq, 10 MHz Stop Freq, 110 MHz Sweep, Sweep (Cont)

2. On the synthesized sweeper set the controls as follows:

CW, 100 MHz

POWER LEVEL, -5 dBm

3. Set the synthesized signal generator controls as follows:

FREQUENCY, 20 MHz AMPLITUDE, 0 dBm

- 4. Adjust the analyzer center frequency to center the two signals on the display.
- 5. On the analyzer, press **Single**. Wait for the completion of a new sweep, then press the following keys:

Peak Search (or Search)
Marker, Delta
Peak Search (or Search)
Next Peak

The two markers should be on the signals near the second and tenth vertical graticule lines (the first graticule line is the left-most).

- 6. If necessary, continue pressing **Next Peak** until the active marker is on the right-most signal (100 MHz). Record the marker delta (Δ Mkr1) frequency reading in the performance test record as Test Record entry 2.
- 7. Press Marker, More, Marker Off on the analyzer.
- 8. Change to the next equipment settings listed in Table 2-9.
- 9. On the analyzer, press **Single**. Wait for the completion of a new sweep, then press the following keys:

Peak Search (or Search)
Marker, Delta
Peak Search (or Search)
Next Peak

- 10.If necessary, continue pressing **Next Peak** until the marker delta is on the right-most signal. Record the marker delta (Δ Mkr1) frequency reading in the performance test record.
- 11.Repeat step 7 through step 10 for the remaining analyzer span settings listed in Table 2-9.

 Table 2-9
 Frequency Span Readout Accuracy

Analyzer Start Frequency (MHz)	Analyzer Stop Frequency (MHz)	Synthesized Signal Generator Frequency (MHz)	Synthesized Sweeper Frequency (MHz)	Test Record Entry	Analyzer Span (MHz)
0	3000	300	2700	1)	3000
10	110	20	100	2)	100
10	10.1	10.01	10.09	3)	0.1
800	900	810	890	4)	100
800	800.1	800.01	800.09	5)	0.1
1400	1500	1410	1490	6)	100
1499	1499.1	1499.01	1499.09	7)	0.1

7. Noise Sidebands

A 1 GHz CW signal is applied to the input of the analyzer. The marker functions are used to measure the amplitude of the carrier and the noise level at 10 kHz, 20 kHz, and 30 kHz above and below the carrier. The 100 kHz offset from the carrier is also tested on Agilent E4401B and E4411B analyzers. For all other analyzers, the 100 kHz offset from the carrier is tested in performance test 8. Noise Sidebands - Wide Offsets: Agilent E4402B, E4404B, E4405B and E4407B.

There are no related adjustment procedures for this performance test.

Equipment Required

Synthesized signal generator Cable, Type-N, 152-cm (60-in)

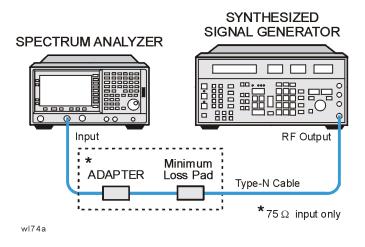
Additional Equipment for 75 Ω Input

Pad, minimum loss Adapter, Type-N (f), to BNC (m), 75 Ω

Additional Equipment for Option BAB

Adapter, Type-N (f), to APC 3.5 (f)

Figure 2-7 Noise Sidebands Test Setup



CAUTION

Use only 75 Ω cables, connectors, or adapters on instruments with 75 Ω connectors, or the connectors will be damaged.

Procedure

E4411B only)

This performance test consists of five parts:

```
Part 1: Noise Sideband Suppression at 10 kHz (measured in 1 kHz RBW)
Part 2: Noise Sideband Suppression at 10 kHz (measured in 100 Hz RBW)
Part 3: Noise Sideband Suppression at 20 kHz
Part 4: Noise Sideband Suppression at 30 kHz
Part 5: Noise Sideband Suppression at 100 kHz (Agilent E4401B and
```

- For E4401B or E4411B, do Parts 1, 3, 4 and 5.
- For E4402B, E4404B, E4405B or E4407B with Option 1DR and serial prefixes greater than or equal to US4510, SG4510, or MY4510, do Parts 2, 3 and 4.
- For all other ESA series analyzers do Parts 1, 3 and 4.

A worksheet is provided at the end of this procedure for calculating the noise sideband suppression.

Part 1: Noise Sideband Suppression at 10 kHz (measured in 1 kHz RBW)

1. Perform the following steps to set up the equipment:

Set the synthesized signal generator controls as follows:

```
FREQUENCY, 1000 MHz AMPLITUDE, 0 dBm (50~\Omega~\mathrm{Input~only}) AMPLITUDE, 6 dBm (75~\Omega~\mathrm{Input~only}) AM OFF FM OFF
```

- 2. Connect the equipment as shown in Figure 2-7.
- 3. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the analyzer by pressing the following keys:

```
FREQUENCY, 1 GHz
SPAN, 10 MHz
AMPLITUDE, Attenuation 10 dB (Man)
```

4. Press the following analyzer keys to measure the carrier amplitude:

```
Peak Search (or Search)
FREQUENCY, Signal Track (On)
SPAN, 50 kHz
BW/Avg, 1 kHz
Video BW, 30 Hz (Man)
FREQUENCY, Signal Track (Off)
```

Det/Demod, Detector, Sample Sweep, Sweep Time, 5 sec Single

Wait for the completion of a sweep, then press **Peak Search** (or **Search**).

5. Press the following analyzer keys to measure the noise sideband level at 10 kHz:

Marker, Delta
More, Function, Marker Noise (or Noise)
AMPLITUDE, −10 dBm
FREQUENCY, CF Step, 10 kHz
Center Freq, ↑
SPAN, Zero Span
Single

Record the marker amplitude noise reading in Table 2-10 as the Upper Sideband Noise Level at 10 kHz.

6. Press the following analyzer keys to measure the noise sideband level at -10 kHz:

```
FREQUENCY, Center Freq, \downarrow, \downarrow Single
```

Record the marker amplitude noise reading in Table 2-10 as the Lower Sideband Noise Level at $-10~\mathrm{kHz}$.

- 7. Press FREQUENCY, Center Freq, ↑
- 8. Continue with Part 3: Noise Sideband Suppression at 20 kHz.

Part 2: Noise Sideband Suppression at 10 kHz (measured in 100 Hz RBW)

1. Perform the following steps to set up the equipment:

Set the synthesized signal generator controls as follows:

```
FREQUENCY, 1000 MHz
AMPLITUDE, 0 dBm
AM, OFF
FM, OFF
```

- 2. Connect the equipment as shown in Figure 2-7.
- 3. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the analyzer by pressing the following keys:

```
FREQUENCY, 1 GHz SPAN, 10 MHz AMPLITUDE, Attenuation 10 dB (Man)
```

7. Noise Sidebands

4. Press the following analyzer keys to measure the carrier amplitude:

Peak Search (or Search)
FREQUENCY, Signal Track (On)
SPAN, 50 kHz
BW/Avg, 100 Hz
Video BW, 30 Hz (Man)
FREQUENCY, Signal Track (Off)
Det/Demod, Detector, Sample
Sweep, Sweep Time, 5 sec
Single

Wait for the completion of a sweep, then press **Peak Search** (or **Search**).

5. Press the following analyzer keys to measure the noise sideband level at 10 kHz:

Marker, Delta
More, Function, Marker Noise (or Noise)
AMPLITUDE, −10 dBm
FREQUENCY, CF Step, 10 kHz
Center Freq, ↑
SPAN, Zero Span
Single

Record the marker amplitude noise reading in Table 2-10 as the Upper Sideband Noise Level at 10 kHz.

6. Press the following analyzer keys to measure the noise sideband level at -10 kHz:

```
FREQUENCY, Center Freq, \downarrow, \downarrow Single
```

Record the marker amplitude noise reading in Table 2-10 as the Lower Sideband Noise Level at -10 kHz.

7. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the analyzer by pressing the following keys:

```
FREQUENCY, 1 GHz
SPAN, 10 MHz
AMPLITUDE, Attenuation 10 dB (Man)
```

8. Press the following analyzer keys to measure the carrier amplitude:

Peak Search (or Search)
FREQUENCY, Signal Track (On)
SPAN, 50 kHz
BW/Avg, 1 kHz
Video BW, 30 Hz (Man)
FREQUENCY, Signal Track (Off)
Det/Demod, Detector, Sample

```
Sweep, Sweep Time, 5 sec Single
```

Wait for the completion of a sweep, then press **Peak Search** (or **Search**).

9. Press the following analyzer keys to measure the noise sideband level at 10 kHz:

```
Marker, Delta
More, Function, Marker Noise (or Noise)
AMPLITUDE, –10 dBm
```

10. Continue with Part 3: Noise Sideband Suppression at 20 kHz

Part 3: Noise Sideband Suppression at 20 kHz

1. Press the following analyzer keys to measure the noise sideband level at 20 kHz:

```
FREQUENCY, CF Step, 20 kHz
Center Freq, ↑
Single
```

Record the marker amplitude noise reading in Table 2-10 as the Upper Sideband Noise Level at 20 kHz.

2. Press the following analyzer keys to measure the noise sideband level at -20 kHz:

```
FREQUENCY, Center Freq, \downarrow, \downarrow Single
```

Record the marker amplitude noise reading in Table 2-10 as the Lower Sideband Noise Level at -20 kHz.

3. Press ↑.

Part 4: Noise Sideband Suppression at 30 kHz

1. Press the following analyzer keys to measure the noise sideband level at 30 kHz:

```
FREQUENCY, CF Step, 30 kHz
Center Freq, ↑
Single
```

Record the marker amplitude noise reading in Table 2-10 as the Upper Sideband Noise Level at 30 kHz.

2. Press the following analyzer keys to measure the noise sideband level at -30 kHz:

```
FREQUENCY, \downarrow, \downarrow Single
```

Record the marker amplitude noise reading in Table 2-10 as the Lower Sideband Noise Level at -30 kHz.

- 3. Press \uparrow .
- 4. If the analyzer is an Agilent E4401B or E4411B, continue with Part 5: Noise Sideband Suppression at 100 kHz (Agilent E4401B and E4411B only). Otherwise, continue with the next step.
- 5. In Table 2-10, record the more positive values (either Upper Noise Sideband Level, or Lower Noise Sideband Level) at the three offset frequencies and record them in the table as the Worst-Case offsets. Record these Worst-Case offset values in the performance verification test record in locations 1, 2 and 3 respectively.
- 6. This completes the Noise Sidebands test for the Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B analyzers.

Part 5: Noise Sideband Suppression at 100 kHz (Agilent E4401B and E4411B only)

1. Press the following analyzer keys to measure the noise sideband level at 100 kHz:

```
CF Step, 98 kHz
Center Freq, ↑
Single
```

2. Press **Peak Search** (or **Search**) and record the marker amplitude noise reading in Table 2-10 as the Upper Sideband Noise Level at 100 kHz.

NOTE

A spur may exist at 100 kHz offset from the carrier. Measuring at ± 98 kHz offset from the carrier will yield a noise sideband level worse than the reading at ± 100 kHz offset.

3. Press the following analyzer keys to measure the noise sideband level at $-100~\mathrm{kHz}$:

```
FREQUENCY, \downarrow, \downarrow Single
```

- 4. Press **Peak Search** (or **Search**) and record the marker amplitude noise reading in Table 2-10 as the Lower Sideband Noise Level at −100 kHz.
- 5. In Table 2-10, record the more positive values (either Upper Noise Sideband Level, or Lower Noise Sideband Level) at the four offset frequencies and record them in the table as the Worst-Case offsets. Record these Worst-Case offset values in the performance

- verification test record in locations 1, 2, 3 and 4 respectively.
- 6. This completes the Noise Sidebands test for the Agilent E4401B or E4411B analyzer.

Table 2-10 Noise Sidebands Worksheet

	Noise Sideband Amplitude						
Offset (kHz)	Upper (dBc/Hz)	Lower (dBc/Hz)	Worst (dBc/Hz)	Test Record Entry			
10 kHz				1)			
20 kHz				2)			
30 kHz				3)			
100 kHz ^a				4)			

a. This offset frequency is tested on Agilent E4402B, E4404B, E4405B, and E4407B analyzers as part of performance test 8. Noise Sidebands - Wide Offsets: Agilent E4402B, E4404B, E4405B and E4407B.

8. Noise Sidebands - Wide Offsets: Agilent E4402B, E4404B, E4405B and E4407B

A 1 GHz CW signal is applied to the input of the analyzer. The marker functions are used to measure the amplitude of the carrier and the noise level at 100 kHz, 1 MHz, 5 MHz, and 10 MHz above and below the carrier.

There are no related adjustment procedures for this performance test.

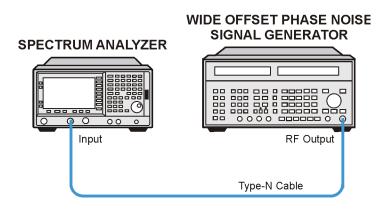
Equipment Required

Wide offset phase noise signal generator Cable, Type-N, 152-cm (60-in)

Additional Equipment for Option BAB

Adapter, Type-N (f), to APC 3.5 (f)

Figure 2-8 Noise Sidebands Test Setup



wl771a

Procedure

This performance test consists of four parts:

Part 1: Noise Sideband Suppression at 100 kHz

Part 2: Noise Sideband Suppression at 1 MHz

Part 3: Noise Sideband Suppression at 5 MHz

Part 4: Noise Sideband Suppression at 10 MHz

Perform part 1 before performing parts 2-4 of this procedure.

A worksheet is provided at the end of this procedure for calculating the

noise sideband suppression.

Part 1: Noise Sideband Suppression at 100 kHz

1. Perform the following steps to set up the equipment:

Set the synthesized signal generator controls as follows:

FREQUENCY, 1 GHz AMPLITUDE, 0 dBm AM OFF FM OFF

- 2. Connect the equipment as shown in Figure 2-8.
- 3. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Press the following keys on the analyzer:

```
FREQUENCY, 1 GHz
SPAN, 1 MHz
```

4. Press the following analyzer keys to measure the carrier amplitude:

```
Peak Search (or Search)
FREQUENCY, Signal Track (On)
SPAN, 10 kHz
FREQUENCY, Signal Track (Off)
Det/Demod, Detector, Sample
BW/Avg, 1 kHz
```

- 5. Adjust the signal generator **AMPLITUDE** to place the signal peak within 0.5 dB of the reference level on the analyzer. Press Single and then press **Peak Search** (or **Search**).
- 6. Press the following analyzer keys:

```
Marker, Delta
More, Function, Marker Noise (or Noise)
AMPLITUDE, -40 dBm
SPAN, Zero Span
```

- 7. Press **BW/Avg**, **Average On 10**, **Enter** to set the analyzer to video average 10 sweeps.
- 8. Press the following analyzer keys to measure the noise sideband level at 100 kHz:

```
FREQUENCY, CF Step, 99.8 kHz
Center Freq, ↑
Single
```

Wait for the analyzer to average ten sweeps.

9. Press **Peak Search** (or **Search**) and record the marker amplitude noise reading in Table 2-11 as the Upper Sideband Noise Level at 100 kHz.

NOTE

A spur may exist at 100 kHz offset from the carrier. Measuring at ± 98 kHz offset from the carrier will yield a noise sideband level worse than the reading at ± 100 kHz offset.

Press the following analyzer keys to measure the noise sideband level at -100 kHz:

```
FREQUENCY, \downarrow, \downarrow Single
```

Wait for the analyzer to average ten sweeps.

- 10.Press **Peak Search** (or **Search**) and record the marker amplitude noise reading in Table 2-11 as the Lower Sideband Noise Level at -100 kHz.
- 11.Press \uparrow .

Part 2: Noise Sideband Suppression at 1 MHz

1. Press the following analyzer keys to measure the noise sideband level at 1 MHz:

```
FREQUENCY, CF Step, 980 kHz
Center Freq, ↑
Single
```

Wait for the analyzer to average ten sweeps.

2. Press **Peak Search** (or **Search**) and record the marker amplitude noise reading in Table 2-11 as the Upper Sideband Noise Level at 1 MHz.

NOTE

A spur may exist at 1 MHz offset from the carrier. Measuring at ± 980 kHz offset from the carrier will yield a noise sideband level worse than the reading at ± 1 MHz offset.

Press the following analyzer keys to measure the noise sideband level at -1 MHz:

```
FREQUENCY, \downarrow, \downarrow Single
```

Wait for the analyzer to average ten sweeps.

- 3. Press **Peak Search** (or **Search**) and record the marker amplitude noise reading in Table 2-11 as the Lower Sideband Noise Level at -1 MHz.
- 4. Press ↑.

Part 3: Noise Sideband Suppression at 5 MHz

1. Press the following analyzer keys to measure the noise sideband level at 5 MHz:

```
FREQUENCY, CF Step, 5 MHz
Center Freq, ↑
Single
```

Wait for the analyzer to average ten sweeps.

- 2. Press **Peak Search** (or **Search**) and record the marker amplitude noise reading in Table 2-11 as the Upper Sideband Noise Level at 5 MHz.
- 3. Press the following analyzer keys to measure the noise sideband level at -5 MHz:

```
FREQUENCY, \downarrow, \downarrow Single
```

Wait for the analyzer to average ten sweeps.

- 4. Press **Peak Search** (or **Search**) and record the marker amplitude noise reading in Table 2-11 as the Lower Sideband Noise Level at -5 MHz.
- 5. Press \uparrow .

Part 4: Noise Sideband Suppression at 10 MHz

1. Press the following analyzer keys to measure the noise sideband level at 10 MHz:

```
FREQUENCY, CF Step, 9.99 MHz
Center Freq, ↑
Single
```

Wait for the analyzer to average ten sweeps.

2. Press **Peak Search** (or **Search**) and record the marker amplitude noise reading in Table 2-11 as the Upper Sideband Noise Level at 10 MHz.

NOTE

A spur may exist at 10 MHz offset from the carrier. Measuring at ± 9.99 MHz offset from the carrier will yield a noise sideband level worse than the reading at ± 10 MHz offset.

Press the following analyzer keys to measure the noise sideband level at $-10~\mathrm{MHz}$:

```
FREQUENCY, \downarrow, \downarrow Single
```

Wait for the analyzer to average ten sweeps.

3. Press Peak Search (or Search) and record the marker amplitude noise

reading in Table 2-11 as the Lower Sideband Noise Level at -10 MHz.

4. In Table 2-11, record the more positive values (either Upper Noise Sideband Level, or Lower Noise Sideband Level) at the four offset frequencies and record them in the table as the Worst-Case offsets. Record these Worst-Case offset values in the performance verification test record in locations 1, 2, 3 and 4 respectively.

Table 2-11 Noise Sidebands Worksheet

	Noise Sideband Amplitude							
Offset (kHz)	Upper (dBc/Hz)	Lower (dBc/Hz)	Worst (dBc/Hz)	Test Record Entry				
100 kHz				1)				
1 MHz				2)				
5 MHz				3)				
10 MHz				4)				

9. System-Related Sidebands

A 500 MHz CW signal is applied to the input of the analyzer. The marker functions are used to measure the amplitude of the carrier and the amplitude of any system-related sidebands more than 30 kHz away from the carrier. System-related sidebands are any internally generated sidebands related to the line, power supply or local oscillator.

There are no related adjustment procedures for this performance test.

Equipment Required

Synthesized signal generator Cable, Type-N, 152-cm (60-in)

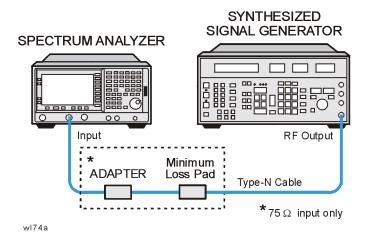
Additional Equipment for 75 Ω Input

Pad, minimum loss Adapter, Type-N (f), to BNC (m), 75 Ω

Additional Equipment for Option BAB

Adapter, Type-N (f), to APC 3.5 (f)

Figure 2-9 System-related Sidebands Test Setup



CAUTION

Use only 75 Ω cables, connectors, or adapters on instruments with 75 Ω connectors, or the connectors will be damaged.

Procedure

1. Perform the following steps to set up the equipment:

9. System-Related Sidebands

a. Set the synthesized signal generator controls as follows:

```
FREQUENCY, 500 MHz AMPLITUDE, 0 dBm (50 \Omega Input only) AMPLITUDE, 6 dBm (75 \Omega Input only) AM Off FM Off
```

- b. Connect the equipment as shown in Figure 2-9.
- c. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the analyzer by pressing the following keys:

```
FREQUENCY, 500 MHz
SPAN, 10 MHz
```

- 2. Set the analyzer to measure the system-related sideband above the signal by performing the following steps:
 - a. Press the following keys:

```
Peak Search (or Search)  \label{eq:FREQUENCY}  \mbox{FREQUENCY, Signal Track } (On) \\ \mbox{SPAN, 200 kHz} \\ \mbox{BW/Avg, 1 kHz} \\ \mbox{Video BW, 30 Hz } (Man)
```

Allow the analyzer to take two complete sweeps. Then press the following keys:

```
FREQUENCY, Signal Track (Off) CF Step, 130 kHz (Man)
```

- b. Press Single and wait for the completion of the sweep. Press Peak Search (or Search), then Marker, Delta.
- c. Press the following keys:

```
FREQUENCY
```

↑(step-up key)

- 3. Measure the system-related sideband above the signal by pressing **Single** on the analyzer. Wait for the completion of a new sweep, then press **Peak Search** (or **Search**).
- 4. Record the marker delta amplitude as Test Record entry 1 of the performance verification test record.
- 5. Set the analyzer to measure the system-related sideband below the signal by pressing the following keys:

FREQUENCY

- ↓ (step-down key)
- ↓ (step-down key)
- 6. Measure the system-related sideband below the signal by pressing

Single. Wait for the completion of a new sweep, then press **Peak Search** (or **Search**).

Record the marker delta amplitude as Test Record entry 2 of the performance verification test record.

10. Residual FM

This test measures the inherent short-term instability of the analyzer LO system. With the analyzer in zero span, a stable signal is applied to the input and slope detected on the linear portion of the IF bandwidth filter skirt. Any instability in the LO transfers to the IF signal in the mixing process. The test determines the slope of the IF filter in Hz/dB and then measures the signal amplitude variation caused by the residual FM. Multiplying these two values yields the residual FM in Hz.

For instruments having Option 1DR (Narrow Bandwidths), since the 10 Hz resolution bandwidth filter is digitally implemented, its slope is well known. The measured amplitude variation is simply multiplied by the known slope to yield the residual FM in a 10 Hz resolution bandwidth.

There are no related adjustment procedures for this performance test.

Equipment Required

Synthesized signal generator Cable, Type-N, 152-cm (60-in)

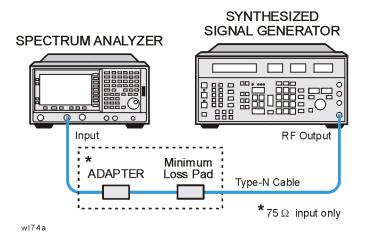
Additional Equipment for 75 Ω Input

Pad, minimum loss Adapter, Type-N (f), to BNC (m), 75 Ω

Additional Equipment for Option BAB

Adapter, Type-N (f), to APC 3.5 (f)

Figure 2-10 Residual FM Test Setup



CAUTION

Use only 75 Ω cables, connectors, or adapters on instruments with 75 Ω connectors, or the connectors will be damaged.

Procedure

This performance test consists of two parts:

```
"Part 1: Residual FM"
"Part 2: Residual FM for Option 1DR and 1D5"
```

Perform "Part 2: Residual FM for Option 1DR and 1D5" in addition to Part 1, only if your analyzer is equipped with Option 1DR and 1D5.

Part 1: Residual FM

Determining the IF Filter Slope

- 1. Connect the equipment as shown in Figure 2-10.
- 2. Set the synthesized signal generator controls as follows:

```
FREQUENCY, 1000 MHz AMPLITUDE, –10 dBm (50~\Omega~Input~only) AMPLITUDE, –4 dBm (75~\Omega~Input~only) AM OFF FM OFF
```

3. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the analyzer by pressing the following keys:

```
FREQUENCY, Center Freq, 1 GHz SPAN, 1 MHz AMPLITUDE, Ref Level, –9 dBm (50~\Omega~Input~only) AMPLITUDE, 39.8 dBmV (75~\Omega~Input~only) Scale/Div, 2 dB BW/Avq, Res BW, 1 kHz
```

4. On the analyzer, press the following keys:

```
Peak Search (or Search) SPAN, Span Zoom, 5 kHz
```

Wait for the Span 5kHz message to appear, then press:

```
Peak Search (or Search), Marker \rightarrow, Marker \rightarrow Ref LvI, Marker, Off
```

5. On the analyzer, press the following keys:

```
Single (Wait for the sweep to finish)
Peak Search (or Search)
Meas Tools, Delta
```

6. On the analyzer, rotate knob counterclockwise until the marker

delta (Δ Mkr1) amplitude reads -8 dB \pm 0.3 dB.

7. Press **Delta**, then rotate the knob counterclockwise until the marker delta (Δ Mkr1) reads -4 dB ± 0.3 dB.

If you have difficulty achieving the ± 0.3 dB setting, then make the following analyzer settings:

```
Sweep, Sweep (Cont)
SPAN, 2 kHz
BW/Avg, Video BW, 30 Hz (Man)
Repeat step 5 through step 7.
```

8. Divide the marker delta (Δ Mkr1) frequency in Hertz by the marker delta (Δ Mkr1) amplitude in dB to obtain the slope of the resolution bandwidth filter. For example, if the marker delta (Δ Mkr1) frequency is 275 Hz and the marker delta (Δ Mkr1) amplitude is 3.92 dB, the slope would be equal to 70.15 Hz/dB. Record the result below:

```
Slope _____ Hz/dB
```

Measuring the Residual FM

9. On the analyzer, press:

Marker, Off
Peak Search (or Search)
Meas Tools
Delta

- 10.Rotate the knob counterclockwise until the marker delta (Δ Mkr1) amplitude reads -10 dB ± 0.3 dB.
- 11.On the analyzer, press the following keys:

Marker, Normal
Marker →, Mkr → CF
Single
BW/Avg, Video BW (Man), 1 kHz
SPAN, Zero Span
Sweep, Sweep Time
100 ms, Single

The displayed trace should be about five divisions below the reference level. If it is not, press **Sweep**, **Sweep** (Cont), **FREQUENCY**, and use the knob to place the displayed trace about five divisions below the reference level. Press **Single**.

12.On the analyzer, press Peak Search (or Search), Pk-Pk Search. Read the marker delta (Δ Mkr1) amplitude, take its absolute value, and record the result as the Deviation. Deviation _____ dB

13. Calculate the Residual FM by multiplying the Slope recorded in

step 8 by the Deviation recorded in step 12.

Record this value as Test Record entry 1 (Residual FM, 1 kHz Res BW) in the performance verification test record.

Part 2: Residual FM for Option 1DR and 1D5

Perform this additional procedure only if Option 1DR and Option 1D5 are present. Perform "Part 1: Residual FM" before performing this procedure.

1. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the analyzer by pressing the following keys:

```
FREQUENCY, Center Freq, 1 GHz SPAN, 1 MHz AMPLITUDE, Ref Level, –9 dBm (50~\Omega~Input~only) AMPLITUDE, Ref Level, 39.8 dBmV (75~\Omega~Input~only) Scale/Div, 2 dB
```

2. On the analyzer press the following keys:

```
Peak Search (or Search)
SPAN, Span Zoom, 5 kHz
```

Wait for the "Span 5 kHz" message to appear. Press the following keys:

```
BW/Avg, Res BW, 10 Hz (Man) SPAN, 100 Hz
```

3. On the analyzer, press the following keys:

```
Peak Search (or Search) Marker \rightarrow, Mkr \rightarrow Ref Lvl Marker, Off Peak Search (or Search) Meas Tools Delta
```

- 4. On the analyzer, rotate the knob counterclockwise until the marker delta (Δ Mkr1) amplitude reads -10 dB ± 0.3 dB.
- 5. On the analyzer, press the following keys:

```
Marker, Normal Marker \rightarrow, Mkr \rightarrow CF Single BW/Avg, Video BW, 10 Hz (Man) SPAN, Zero Span Sweep, Sweep Time, 20 ms Single
```

The displayed trace should be about five divisions below the

10. Residual FM

reference level. If it is not, press **Sweep**, **Sweep** (Cont), **FREQUENCY**, and use the knob to place the displayed trace about five divisions below the reference level. Press **Single**.

6.	On the analyzer, press Peak Search (or Search),
	Pk-Pk Search . Read the marker delta (Δ Mkr1) amplitude, take its
	absolute value, and record the result as the Deviation.
	Deviation dB

7. Calculate the Residual FM by multiplying the deviation recorded in step 6 by 0.426 Hz/dB. This is the slope of the 10 Hz Res BW filter at 10 dB below the peak of the filter.

Record this value as Test Record entry 2 (Residual FM (10 Hz RBW)) in the performance verification test record.

11. Sweep Time Accuracy

This test uses a function generator to amplitude-modulate a 500 MHz CW signal from another signal generator. The analyzer demodulates this signal in zero span to display the response in the time domain. The marker Δ function on the analyzer is used to read out the sweep time accuracy.

If the analyzer is equipped with Option AYX, also perform "Fast Time Domain Amplitude Accuracy" in addition to this procedure.

There are no related adjustment procedures for this performance test.

Equipment Required

Function generator Synthesized signal generator Cable, Type-N, 152-cm (60-in) Cable, BNC, 120-cm (48-in)

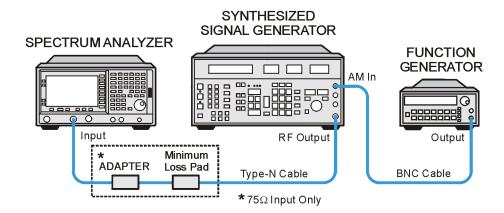
Additional Equipment for 75 Ω Input

Pad, minimum loss Adapter, Type-N (f), to BNC (m), 75 Ω

Additional Equipment for Option BAB

Adapter, Type-N (f), to APC 3.5 (f)

Figure 2-11 Sweep Time Accuracy Test Setup



wl76a

CAUTION

Use only 75 Ω cables, connectors, or adapters on instruments with 75 Ω

connectors, or the connectors will be damaged.

Procedure

1. Set the synthesized signal generator to output a 500 MHz, −10 dBm, CW signal. Set the AM and FM controls to off.

75 Ω Input only: Set output level to -4 dBm.

- 2. Set the function generator to output a 2 kHz, 1.14 Vp-p triangle waveform signal.
- 3. Connect the equipment as shown in Figure 2-11.
- 4. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the analyzer by pressing the following keys:

FREQUENCY, 500 MHz SPAN, 10 MHz SPAN, Span Zoom, 50 kHz

- 5. Wait for the Span 50 kHz message to appear. Set Signal Track (Off).
- 6. Set the span to 0 Hz and set the analyzer as follows:

BW/Avg, Res BW, 3 MHz
Sweep, Sweep Time, 5 ms
AMPLITUDE, Scale Type (Lin)
Peak Search (or Search)
More, Search Parameters (or Search Criteria)
Peak Excursion, 3 dB

Adjust the synthesized signal generator amplitude as necessary for a mid-screen display (marker amplitude should read approximately 110 mV).

- 7. Set the synthesized signal generator modulation source to EXT DC. Set AM ON at 90% modulation.
- 8. On the analyzer, press **Trig** then **Video**. Set the video trigger level to 110 mV (mid-screen).
- 9. On the analyzer, press Single. After the completion of the sweep, press Peak Search (or Search), 0, s, Meas Tools, Next Pk Right. This is the marked signal.
- 10.Press Marker, Delta, then Peak Search (or Search) and press Next Pk Right eight times so the delta marker is on the eighth signal peak from the marked signal.
- 11.Read the marker delta (Δ Mkr1) time. Calculate the sweeptime

accuracy as follows:

Sweep Time Accuracy =
$$100 \times \frac{\Delta Mkr1 - (0.8 \times Sweep Time)}{Sweep Time}$$

NOTE

The sweep time accuracy is defined as a percentage of the indicated sweep time, not of the indicated signal separation. Therefore, it is appropriate to divide the difference between the marker delta (Δ Mkr1) reading and the nominal signal separation by the sweep time, rather than dividing by the nominal signal separation.

- 12.Record the calculated sweeptime accuracy in Table 2-12.
- 13.If the analyzer is not equipped with Option AYX, fast time domain sweeps, or Option B7D, DSP and Fast ADC, repeat step 9 through step 12 only for sweeptime settings between 5 ms and 10 s as indicated in Table 2-12. For each sweeptime setting, set the function generator to the frequency indicated in Table 2-12.
- 14.If the analyzer is equipped with Option AYX, fast time domain sweeps, or Option B7D, DSP and Fast ADC, repeat step 9 through step 12 for all sweeptime settings as indicated in Table 2-12. For each sweeptime setting, set the function generator to the frequency indicated in Table 2-12.

Table 2-12 Sweep Time Accuracy

Analyzer Sweep Time Setting	Synthesizer Function Generator Frequency	Marker Delta (∆ Mkr1) Reading	Sweep Time Accuracy (%)	Test Record Entry
5 ms	2.0 kHz			1)
20 ms	500.0 Hz			2)
100 ms	100.0 Hz			3)
1 s	10.0 Hz			4)
10 s	1.0 Hz			5)
The following entries or	nly apply to analyzers equippe	ed with Option	AYX or B7D.	
1 ms	10.0 kHz			6)
500 μs	20.0 kHz			7)
100 μs	100.0 kHz			8)

12. Display Scale Fidelity

A 50 MHz CW signal is applied to the input of the analyzer through two calibrated step attenuators. The attenuators are the amplitude reference standard. The source is adjusted for a response at the reference level. The attenuators are then set to achieve a nominal amplitude below the reference level. The analyzer amplitude marker is compared to the actual total attenuation to determine the scale fidelity error.

The test is performed in both log and linear amplitude scales.

The related adjustment for this performance test is "IF Amplitude."

Equipment Required

Synthesized signal generator
1 dB step attenuator
10 dB step attenuator
6 dB fixed attenuator (2 required)
Attenuator switch driver (if programmable step attenuators are used)
Cable, Type-N 152-cm (60-in) (2 required)
Cable, BNC 122-cm (48-in)
Attenuator interconnect kit

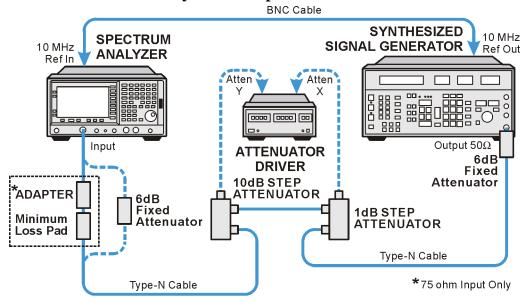
Additional Equipment for 75 Ω Input

50 Ω to 75 Ω minimum loss pad Adapter, Type-N (f), to BNC (m), 75 Ω

Additional Equipment for Option BAB

Adapter, Type-N (f), to APC 3.5 (f)

Figure 2-12 Scale Fidelity Test Setup



wI77b

CAUTION

Use only 75 Ω cables, connectors, and adapters on instruments with 75 Ω connectors, or the connectors will be damaged.

Procedure

Calculate the Actual Attenuation Errors

1. From the calibration data supplied with the 10 dB step attenuator, enter into Column 4 of Table 2-13 through Table 2-17 the actual attenuation for the corresponding nominal attenuation settings. Enter data in Table 2-14, Table 2-16, and Table 2-17 only if the analyzer has Option 1DR.

If the calibration data does not indicate an actual attenuation value for the 0 dB setting, enter 0 dB.

NOTE

The Agilent 8496G programmable attenuator has four attenuator sections consisting of 10 dB, 20 dB, and 40 dB attenuators. If using the Agilent 8496G programmable attenuator, enter the calibration data for the section three, 40 dB step, rather than the section four, 40 dB step.

2. From the calibration data supplied with the 1 dB step attenuator, enter into Column 5 of Table 2-13 through Table 2-17 the actual attenuation for the corresponding nominal attenuation settings. Enter data in Table 2-14, Table 2-16, and Table 2-17 only if the analyzer has Option 1DR.

If the calibration data does not indicate an actual attenuation value for the 0 dB setting, enter 0 dB.

NOTE

The Agilent 8494G programmable attenuator has four attenuator sections consisting of 1 dB, 2 dB, 4 dB, and 4 dB attenuators. If using the Agilent 8494G programmable attenuator, enter the calibration data for the section three, 4 dB step, rather than the section four, 4 dB step.

3. For each row in Table 2-13 and Table 2-14, add the 10 dB and the 1 dB Step Attenuator Actual Attenuation values (Columns 4 and 5) and place the results into the Total Actual Attenuation (Column 6).

Total Actual Attenuation = 1 dB Step Attenuator Actual Attenuation + 10 dB Step Attenuator Actual Attenuation

Example for -36 dB from REF LVL setting:

1 dB Step Attenuator Actual Attenuation (6 dB) = 5.998 dB

10dB Step Attenuator Actual Attenuation (30 dB) = 30.012 dB

Total Actual Attenuation = 5.998dB + 30.012 dB = 36.010 dB

4. Enter the total actual attenuation (0 dB from the reference level) below:

Total actual attenuation (0 dB from Ref Level) = dB

Part 1: Log Display Scale Fidelity, Analog Bandwidths

Setup for Log Scale Measurement

- 1. Connect the equipment as indicated in Figure 2-12.
- 2. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the analyzer by pressing the following keys:

System, Alignments, Auto Align, Off FREQUENCY, 50 MHz SPAN, 45 kHz BW/Avg, 3 kHz BW/Avg, Video BW, 1 kHz

3. **Preset** the synthesized signal generator, then press **Blue Key**, **Special**, **0.0**. Press the following keys:

FREQUENCY, 50 MHz AMPLITUDE. +9 dBm

- 4. Set the 1 dB step attenuator to 0 dB.
- 5. Set the 10 dB step attenuator to 0 dB.

- 6. Press Peak Search (or Search) on the analyzer.
- 7. Adjust the synthesized signal generator amplitude until the analyzer marker amplitude reads 0 dBm±0.1 dB.

75 Ω Input: Adjust the synthesized signal generator amplitude until the analyzer marker reads 48.75 dBmV ±±0.1 dB.

NOTE

Do not adjust the synthesized signal generator amplitude after the reference is established.

8. On the analyzer, press Marker, Delta.

Measure the Cumulative Log Fidelity

- 1. Perform step 2 to step 4 for each measurement value in Table 2-13.
- 2. Set the 1 dB and 10 dB step attenuators as indicated in Column 2 and Column 3 of Table 2-13 for the various dB from REF LVL settings.

For settings of –64 dB and lower, press the following keys:

BW/Avg, Average (On) 5, Enter

- 3. Press **Peak Search** (or **Search**) on the analyzer and record the marker delta (Δ Mkr1) reading in Column 7 of Table 2-13.
- 4. Calculate the Cumulative Log Fidelity Error (CLFE) as follows, and record the result in the performance verification test record as indicated in Column 8 of Table 2-13:

CLFE = Total Actual Attenuation + MkrΔ Reading – Total Actual Atten (0 dB from Ref Level)

Table 2-13 Cumulative and Incremental Log Scale Fidelity Worksheet, Analog Resolution Bandwidths Measured at 3 kHz

Column 1	Column 2	Column 3	Column 4	Column 5	Column 6	Column 7	Column 8	Column 9
dB from REF LVL	10 dB Step Atten Nominal Attenu- ation	1 dB Step Atten Nominal Attenu- ation	10 dB Step Atten Actual Attenu- ation	1 dB Step Atten Actual Attenu- ation	Total Actual Attenu- ation	Marker Delta (∆ Mkr1) Reading	Test Record Entry - CLFE	Test Record Entry – ILFE
(dB)	(dB)	(dB)	(dB)	(dB)	(dB)	(dB)	(dB)	(dB)
0 (Ref)	0	0				0 (Ref)	0 (Ref)	NA

Table 2-13 Cumulative and Incremental Log Scale Fidelity Worksheet, Analog Resolution Bandwidths Measured at 3 kHz

Column 1	Column 2	Column 3	Column 4	Column 5	Column 6	Column 7	Column 8	Column 9
dB from REF LVL	10 dB Step Atten Nominal Attenu- ation	1 dB Step Atten Nominal Attenu- ation	10 dB Step Atten Actual Attenu- ation	1 dB Step Atten Actual Attenu- ation	Total Actual Attenu- ation	Marker Delta (∆ Mkr1) Reading	Test Record Entry - CLFE	Test Record Entry – ILFE
(dB)	(dB)	(dB)	(dB)	(dB)	(dB)	(dB)	(dB)	(dB)
-4	0	4					1)	22)
-8	0	8					2)	23)
-12	10	2					3)	24)
-16	10	6					4)	25)
-20	20	0					5)	26)
-24	20	4					6)	27)
-28	20	8					7)	28)
-32	30	2					8)	29)
-36	30	6					9)	30)
-40	40	0					10)	31)
-44	40	4					11)	32)
-48	40	8					12)	33)
-52	50	2					13)	34)
-56	50	6					14)	35)
-60	60	0					15)	36)
-64	60	4					16)	37)
-68	60	8					17)	38)
-72	70	2					18)	39)
-76	70	6					19)	40)
-80	80	0					20)	41)
-84	80	4					21)	NA

Calculate Incremental Log Fidelity

1. Calculate the Incremental Log Fidelity Error (ILFE) for dB from REF LVL settings of -4 dB to -80 dB using the current and previous Cumulative Log Fidelity Errors (CLFEs):

ILFE = CLFE(current) – CLFE(previous)

Example Calculation for ILFE at -20 dB from REFLVL setting:

Previous CLFE(-16 dB from REF LVL) = -0.07 dB

Current CLFE(-20 dB from REF LVL) = 0.02 dB

ILFE(-20 dB) = 0.02 dB - (-0.07 dB) = 0.09 dB

2. Record the result in the performance verification test record as indicated in Column 9 of Table 2-13.

Part 2: Log Display Scale Fidelity, Digital Bandwidths

This section is for analyzers with Option 1DR (narrow resolution bandwidths) only.

Setup for Log Scale Measurement

1. Set the following parameters on the analyzer:

SPAN, 150 Hz BW/Avg, 10 Hz (ESA-E Series only) BW/Avg, 100 Hz (ESA-L Series only) BW/Avg, Video BW, 3 Hz

- 2. Press Peak Search (or Search) on the analyzer.
- 3. Adjust the amplitude of the synthesized signal generator until the analyzer marker amplitude reads $0 \text{ dBm } \pm 0.1 \text{ dB}$.

75 Ω Input only: Adjust the amplitude of the synthesized signal generator until the analyzer marker amplitude reads $48.75~dBmV\pm0.1~dB$.

4. Set the 1 dB and the 10 dB step attenuators to 0 dB.

NOTE

Do not adjust the synthesized signal generator amplitude after the reference is established.

5. On the analyzer, press Marker, Delta.

Measure the Cumulative Log Fidelity

- 1. Perform step 2 to step 4 for each measurement value in Table 2-14.
- 2. Set the 1 dB and 10 dB step attenuators as indicated in Table 2-14 for the various dB from REF LVL settings.

For settings of -84 dB and lower, press the following keys:

BW/Avg, Average (On) 5, Enter

- 3. Press Peak Search (or Search) on the analyzer and record the marker delta (Δ Mkr1) reading in Column 7 of Table 2-14.
- 4. Calculate the Cumulative Log Fidelity Error (CLFE) as follows and record the result in the performance verification test record as indicated in Column 8 of Table 2-14:

CLFE = Total Actual Attenuation + MkrΔReading – Total Actual Atten(0 dB from F

Table 2-14 Cumulative and Incremental Log Scale Fidelity Worksheet, Option 1DR Narrow Resolution Bandwidths

Column 1	Column 2	Column 3	Column 4	Column 5	Column 6	Column 7	Column 8	Column 9
dB from REF LVL	10 dB Step Atten Nominal Attenu- ation	1 dB Step Atten Nominal Attenu- ation	10 dB Step Atten Actual Attenu- ation	1 dB Step Atten Actual Attenu- ation	Total Actual Attenu- ation	Marker Delta (\(\Delta \) Reading	Test Record Entry - CLFE	Test Record Entry – ILFE
(dB)	(dB)	(dB)	(dB)	(dB)	(dB)	(dB)	(dB)	(dB)
0 (Ref)	0	0				0 (Ref)	0 (Ref)	NA
-4	0	4					43)	68)
-8	0	8					44)	69)
-12	10	2					45)	70)
-16	10	6					46)	71)
-20	20	0					47)	72)
-24	20	4					48)	73)
-28	20	8					49)	74)
-32	30	2					50)	75)
-36	30	6					51)	76)
-40	40	0					52)	77)
-44	40	4					53)	78)
-48	40	8					54)	79)
-52	50	2					55)	80)
-56	50	6					56)	81)
-60	60	0					57)	82)

Table 2-14 Cumulative and Incremental Log Scale Fidelity Worksheet, Option 1DR Narrow Resolution Bandwidths

Column 1	Column 2	Column 3	Column 4	Column 5	Column 6	Column 7	Column 8	Column 9
dB from REF LVL	10 dB Step Atten Nominal Attenu- ation	1 dB Step Atten Nominal Attenu- ation	10 dB Step Atten Actual Attenu- ation	1 dB Step Atten Actual Attenu- ation	Total Actual Attenu- ation	Marker Delta (∆ Mkr1) Reading	Test Record Entry – CLFE	Test Record Entry – ILFE
(dB)	(dB)	(dB)	(dB)	(dB)	(dB)	(dB)	(dB)	(dB)
-64	60	4					58)	83)
-68	60	8					59)	84)
-72	70	2					60)	85)
-76	70	6					61)	86)
-80	80	0					62)	87)
-84	80	4					63)	NA
-88	80	8					64)	NA
-92	90	2					65)	NA
-96	90	6					66)	NA
-98	90	8					67)	NA

Calculate incremental log fidelity:

Calculate the Incremental Log Fidelity Error (ILFE) for dB from REF LVL settings of –4 dB to –80 dB using the current and previous Cumulative Log Fidelity Errors (CLFEs):

ILFE= CLFE(current) - CLFE(previous)

Record the result in the performance verification test record as indicated in Column 9 of Table 2-14.

Part 3: Linear Display Scale Fidelity, Analog Bandwidths

Setup for linear scale measurement:

1. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the analyzer by pressing the following keys:

System, Alignments, Auto Align, Off

FREQUENCY, 50 MHz

SPAN, 10 kHz BW/Avg, 3 kHz AMPLITUDE, Scale Type (Lin) Input/Output (or Input), Input $Z Corr (50) (75 \ \Omega \ Input \ only)$

2. Preset the synthesized signal generator, by pressing **Blue Key**, **Special**, **0**, **0**. Press the following keys:

FREQUENCY, 50 MHz AMPLITUDE, -3 dBm $(50~\Omega~Input~only)$ AMPLITUDE, 4 dBm $(75~\Omega~Input~only)$

- 3. Set the 1 dB step attenuator to 0 dB.
- 4. Set the 10 dB step attenuator to 0 dB.
- 5. Press Peak Search (or Search) on the analyzer.
- 6. Adjust the synthesized signal generator amplitude until the analyzer marker amplitude reads 223.6 mV ± 4 mV.

NOTE

Do not adjust the amplitude of the synthesized signal generator after the reference is established.

Calculate ideal marker amplitude:

7. Considering Total Actual Attenuation at the 0 dB from REF LVL setting to be ATref, and the Total Actual Attenuation at any other dB from REF LVL setting to be ATmeas, calculate the Ideal Mkr Reading, in millivolts, as follows, and enter the result in Column 7 of Table 2-15.

Ideal Mkr Reading(mV) =
$$1000\sqrt{0.05 \times 10^{(-\text{ATmeas} + \text{ATref})/10}}$$

For example, if ATref = 0.012 dB and ATmeas = 7.982, the Ideal Mkr Reading for the -8 dB from Ref Level setting would be:

Ideal Mkr Reading(mV) =
$$1000\sqrt{0.05 \times 10^{(-7.982 + 0.012)/10}}$$
 = 89.3 mV

Measure Linear Fidelity:

- 8. Perform step 9 to step 11 for each measurement value in Table 2-15.
- 9. Set the 1 dB and 10 dB step attenuators as indicated in Column 2 and Column 3 of Table 2-15 for the dB from REF LVL settings.
- 10.Press Peak Search (or Search) on the analyzer and record the marker delta (Δ Mkr1) amplitude reading as the actual Mkr reading in Column 8 of

Table 2-15.

11.Calculate the Linear Fidelity Error (LFE) as a percentage of reference level (RL), and record the result in the performance verification test record as indicated in Column 9 of Table 2-15.

LFE(% of RL) =
$$100 \times \frac{\text{Actual Mkr Reading} - \text{Ideal Mkr Reading}}{223.6 \text{ mV}}$$

Example calculation for LFE(% of RL):

Actual Mkr Reading =
$$85.0 \text{ mV}$$

Ideal Mkr Reading = 89.3 mV
LFE(%of RL) = $100 \times \frac{85.0 - 89.3}{223.6}$
LFE(%of RL) = 1.92% of RL

Table 2-15 Linear Scale Fidelity Worksheet, Analog Resolution Bandwidths Measured at 3 kHz

Column 1	Column 2	Column 3	Column 4	Column 5	Column 6	Column 7	Column 8	Column 9
dB from REF LVL	10 dB Step Atten Nominal Attenu- ation	1 dB Step Atten Nominal Attenu- ation	10 dB Step Atten Actual Attenu- ation	1 dB Step Atten Actual Attenu- ation	Total Actual Attenu- ation	Ideal Mkr Reading	Actual Mkr Reading	Test Record Entry – LFE
(dB)	(dB)	(dB)	(dB)	(dB)	(dB)	(mV)	(mV)	(% of RL)
0 (Ref)	0	0				0 (Ref)	0 (Ref)	0 (Ref)
-4	0	4						93)
-8	0	8						94)
-12	10	2						95)
-16	10	6						96)
-20	20	0						97)

Part 4: Linear Display Scale Fidelity, Digital Bandwidths

This section is for analyzers with Option 1DR (narrow resolution bandwidths) only.

Setup for linear scale measurement:

1. Set the following parameters on the analyzer:

SPAN, 100, Hz (ESA-E Series only)
SPAN, 300, Hz (ESA-L Series only)
BW/Avg, 10 Hz (ESA-E Series only)
BW/Avg, 100 Hz (ESA-L Series only)
Video BW, 1 Hz

- 2. Press Peak Search (or Search) on the analyzer.
- 3. Set the 1 dB and 10 dB step attenuators to 0 dB.
- 4. Adjust the synthesized signal generator amplitude until the analyzer marker amplitude reads 223.6 mV ± 4 mV.

NOTE

Do not adjust the synthesized signal generator amplitude after the reference is established.

Calculate ideal marker amplitude:

5. Considering Total Actual Attenuation at the 0 dB from REF LVL setting to be ATref and the Total Actual Attenuation at any other dB from REF LVL setting to be ATmeas, calculate the Ideal Mkr Reading, in millivolts, as follows and enter the result in Column 7 of Table 2-16.

Ideal Mkr Reading(mV) =
$$1000\sqrt{0.05 \times 10^{(-\text{ATmeas} + \text{ATref})/10}}$$

Measure linear fidelity:

- 6. Perform step 7 to step 9 for each measurement value in Table 2-16.
- 7. Set the 1 dB and 10 dB step attenuators as indicated in Table 2-16 for the dB from REF LVL settings.
- 8. Press **Peak Search** (or **Search**) on the analyzer and record the marker delta (Δ Mkr1) amplitude reading as the actual Mkr reading in Column 8 of Table 2-16.
- 9. Calculate the Linear Fidelity Error (LFE) as a percentage of reference level (RL), and record the result in the performance verification test record as indicated in Column 9 of Table 2-16.

$$LFE(\% of RL) = 100 \times \frac{Actual Mkr Reading - Ideal Mkr Reading}{223.6 mV}$$

Table 2-16 Linear Scale Fidelity Worksheet, Option 1DR Narrow Resolution Bandwidths

Column 1	Column 2	Column 3	Column 4	Column 5	Column 6	Column 7	Column 8	Column 9
dB from REF LVL	10 dB Step Atten Nominal Attenu- ation	1 dB Step Atten Nominal Attenu- ation	10 dB Step Atten Actual Attenu- ation	1 dB Step Atten Actual Attenu- ation	Total Actual Attenu- ation	Ideal Mkr Reading	Actual Mkr Reading	Test Record Entry – LFE
(dB)	(dB)	(dB)	(dB)	(dB)	(dB)	(mV)	(mV)	(% of RL)
0 (Ref)	0	0				0 (Ref)	0 (Ref)	0 (Ref)
-4	0	4						98)
-8	0	8						99)
-12	10	2						100)
-16	10	6						101)
-20	20	0						102)

10.If the analyzer has a 75W Input press:

Input/Output (or Input)
Input Z Corr (75)

Zero Span Log Fidelity, Digital Bandwidths

This section is for analyzers with Option 1DR (narrow resolution bandwidths) only.

Setup for zero span measurements

- 11. Set the 1 dB step attenuator to 11 dB and the 10 dB step attenuator to 110 dB.
- 12. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the analyzer by pressing the following keys:

System, Alignments

Align Now, All (wait for the alignment sequence to complete)

- 13. Set the 1 dB and 10 dB step attenuators to 0 dB.
- 14. Set the following parameters on the analyzer:

FREQUENCY, 50 MHz

SPAN, 100 Hz (ESA-E Series only)

SPAN, 500 Hz (ESA-L Series only)

BW/Avg, 10 Hz (ESA-E Series only)

BW/Avg, 100 Hz (ESA-L Series only)

15. On the analyzer press Peak Search (or Search), Marker ->, and Marker -> CF.

12. Display Scale Fidelity

- 16. Press SPAN, Zero Span on the analyzer.
- 17. Adjust the synthesized signal generator amplitude until the analyzer marker amplitude reads 0 dBm \pm 0.1 dB.

75 Ω Input: Adjust the synthesized signal generator amplitude until the analyzer marker amplitude reads 48.75 dBmV \pm 0.1 dB.

NOTE

Do not adjust the synthesized signal generator amplitude after the reference is established.

18. On the analyzer, press Marker, Delta.

Measure the Cumulative Log Fidelity

- 19.On the analyzer, press Single, BW/Avg, Average, 5, Enter.
- 20.Perform step 22 to step 24 for each measurement value in Table 2-17.
- 21.Set the 1 dB and 10 dB step attenuators as indicated in Column 2 and Column 3 of Table 2-16 for the various dB from REF LVL settings.
- 22.Press **Single** and wait for "VAvg 5" to be displayed to the right of the graticule area.
- 23.Record the marker delta (Δ Mkr1) amplitude reading in Column 7 of Table 2-16.
- 24.Calculate the Cumulative Log Fidelity Error (CLFE) as follows, and record the result in the performance verification test record as indicated in Column 8 of Table 2-16.

CLFE = Total Actual Attenuation + ΔMkr Reading – Total Actual Atten (0 dB from Ref Level)

Table 2-17 Zero Span Cumulative Log Fidelity Worksheet, Opt 1DR Narrow Resolution Bandwidths

Column 1	Column 2	Column 3	Column 4	Column 5	Column 6	Column 7	Column 8
dB from REF LVL	10 dB Step Atten Nominal Attenu- ation	1 dB Step Atten Nominal Attenu- ation	10 dB Step Atten Actual Attenu- ation	1 dB Step Atten Actual Attenu- ation	Total Actual Attenu- ation	DMkr Reading	Test Record Entry- CLFE
(dB)	(dB)	(dB)	(dB)	(dB)	(dB)	(dB)	(dB)
0 (Ref)	0	0				0 (Ref)	0 (Ref)
-4	0	4					103)
-8	0	8					104)
-12	10	2					105)
-16	10	6					106)
-20	20	0					107)
-24	20	4					108)
-28	20	8					109)
-32	30	2					110)
-36	30	6					111)
-40	40	0					112)
-44	40	4					113)
-48	40	8					114)
-52	50	2					115)
-56	50	6					116)
-60	60	0					117)
-64	60	4					118)
-68	60	8					119)
-70	70	0					120)

Post-Test Instrument Restoration

25. Remove the RF cable from the analyzer input connector.

26. On the analyzer, press the following keys:

Preset

System, Alignments, Auto Align, All

13. Input Attenuation Switching Uncertainty

A 50 MHz CW signal is applied to the input of the analyzer through two calibrated step attenuators. The attenuators are the amplitude reference standard. The source is adjusted for a response at the reference level. The internal attenuators are then varied between settings and the external attenuators are changed accordingly to maintain the same input level at the mixer. The analyzer marker functions are used to measure the amplitude differences. The actual attenuation values of the step attenuators are used to correct the marker amplitude readings yielding the input attenuation switching error.

The related adjustment for this performance test is "Frequency Response."

Equipment Required

Synthesized signal generator
1 dB step attenuator
10 dB step attenuator
Attenuator switch driver (if programmable step attenuators are used)
6 dB fixed attenuator (2 required)
Cable, Type-N 152-cm (60-in) (2 required)
Cable, BNC 122-cm (48-in)
Attenuator interconnect kit

Additional Equipment for 75 Ω Input

50 Ω to 75 Ω minimum loss pad Adapter, Type-N (f), to BNC (m), 75 Ω

Additional Equipment for Option BAB

Adapter, Type-N (f), to APC 3.5 (f)

BNC Cable SYNTHESIZED 10 MHz **SPECTRUM** 10 MHz SIGNAL GENERATOR Ref Out **ANALYZER** Ref In Atten 0000 0000 00 Output 50Ω **TTENUATOR** 6dB **DRIVER** Fixed 10dB STEP Attenuator **ADAPTER ATTENUATOR** 6dB Fixed 1dB STEP Minimum Attenuator TTENUATOR Loss Pad Type-N Cable

Figure 2-13 Input Attenuator Switching Uncertainty Test Setup

wI77b

*75 ohm Input Only

CAUTION

Use only 75 Ω cables, connectors, or adapters on instruments with 75 Ω connectors, or the connectors will be damaged.

Procedure

Type-N Cable

Calculate Actual Attenuation Values

1. From the calibration data supplied with the 1 dB step attenuator, enter into Column 2 of Table 2-18 the actual attenuation for the corresponding nominal attenuation settings. If the calibration data does not indicate an actual attenuation value for the 0 dB setting, enter 0 dB.

NOTE

The Agilent 8494G programmable attenuator has four attenuator sections consisting of 1 dB, 2 dB, 4 dB, and 4 dB attenuators. If using the Agilent 8494G programmable attenuator, enter the calibration data for the section three 4 dB step rather than the section four 4 dB step.

2. From the calibration data supplied with the 10 dB step attenuator, enter into Column 4 of Table 2-18 the actual attenuation for the corresponding nominal attenuation settings. If the calibration data does not indicate an actual attenuation value for the 0 dB setting, enter 0 dB.

NOTE

The Agilent 8496G programmable attenuator has four attenuator sections consisting of 10 dB, 20 dB, 40 dB, and 40 dB attenuators. If

using the Agilent 8496G programmable attenuator, enter the calibration data for the section three 40 dB step rather than the section four 40 dB step.

3. For each Total Nominal Attenuation setting indicated in Table 2-18, calculate the Total Actual Attenuation from the actual attenuation Columns for the 1 dB and the 10 dB step attenuators and enter the result into Column 6 of Table 2-18.

Total Actual Attenuation = 1 dB Step Attenuator Actual Attenuation + 10 dB Step Attenuator Actual Attenuation

Example for 35 dB total nominal attenuation setting:

1dB Step Attenuator Actual Attenuation (5 dB) = 5.021 dB

10 dB Step Attenuator Actual Attenuation (30 dB) = 29.981 dB

Total Actual Attenuation = 5.998 dB + 30.012 dB = 35.002 dB

Table 2-18 Actual Attenuation Worksheet

Column 1	Column 2	Column 3	Column 4	Column 5	Column 6
1 dB step Attenuator Nominal Attenuation (dB)	1 dB step Attenuator Actual Attenuation (dB)	10 dB step Attenuator Nominal Attenuation (dB)	10 dB step Attenuator Actual Attenuation (dB)	Total Nominal Atten- uation (dB)	Total Actual Atten- uation (dB)
0		0		0	
5		0		5	
0		10		10	
5		10		15	
0		20		20	
5		20		25	
0		30		30	
5		30		35	
0		40		40	
5		40		45	
0		50		50	
5		50		55	
0		60		60	
5		60		65	

4. For each attenuation error value in Column 4 of Table 2-19, calculate the attenuation errors by subtracting the difference between the Table 2-18 Total Actual Attenuation and Total Nominal Attenuation from the difference between the Total Actual Attenuation and Total Nominal Attenuation at 55 dB. Note that the total nominal attenuations listed in Table 2-19 are in a different order than those listed in Table 2-18.

 $AttenErr = (ActAtten(55 \ dB) - 55 \ dB) - (ActAtten(X \ dB) - NomAtten(X \ dB))$

Where:

AttenErr = Attenuator Error between the X dB and 55 dB settings

ActAtten(55 dB) = Actual Attenuation of the 55 dB setting

ActAtten(X dB) = Actual Attenuation of the X dB setting

NomAtten(X dB) = Nominal Attenuation of the X dB setting

Example of attenuation error calculation for 35 dB nominal attenuation:

ActAtten (55 dB) = 55.15 dB ActAtten (35 dB) = 35.002 dB NomAtten (35 dB) = 35 dB

AttenErr = (55.15 - 55) - (35.002 - 35)AttenErr = 0.15 - 0.002AttenErr = 0.148 dB

Setup for Switching Uncertainty Measurement

- 5. Connect the equipment as indicated in Figure 2-13. The 6 dB fixed attenuator (or minimum loss pad for 75 Ω input analyzers) should be connected directly to the input connector of the analyzer.
- 6. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Press **System**, **Alignments**, **Auto Align**, **Off**. Set the controls as follows:

FREQUENCY, 50 MHz SPAN, 100 kHz

AMPLITUDE, -55 dBm $(50~\Omega~Input~only)$ AMPLITUDE, -6.2 dBmV $(75~\Omega~Input~only)$ AMPLITUDE, Attenuation, 10 dB AMPLITUDE, Scale/Div, 2 dB BW/Avg, 30 kHz BW/Avg, Video BW, 100 Hz

7. Preset the synthesized signal generator (**Blue Key, Special, 0, 0**) and set the controls as follows:

FREQUENCY, 50 MHz AMPLITUDE, 12 dBm

- 8. Set the 1 dB step attenuator to 5 dB attenuation. Set the 10 dB step attenuator to 50 dB. Refer to the Agilent 11713A attenuator switch driver manual for information on manually controlling a programmable step attenuator.
- 9. Press Peak Search (or Search) on the analyzer.
- 10.Adjust the amplitude of the synthesized signal generator until the marker amplitude of the analyzer reads –57 dBm± 0.1 dB.

75 Ω Input only: Adjust the amplitude of the synthesized signal generator until the marker of the analyzer reads $-8.2 \text{ dBmV} \pm 0.1 \text{ dB}$.

NOTE

Do not adjust the amplitude of the synthesized signal generator after the reference is established.

11.On the analyzer, press Peak Search (or Search), Marker, Delta.

Table 2-19 Input Attenuation Switching Uncertainty Worksheet

Column 1	Column 2	Column 3	Column 4	Column 5	Column 6	Column 7
Analyzer Internal Attenu- ation Setting	Analyzer Reference Level Setting 50 W Input/ 75 W Input	Total Nominal Attenu- ation Setting	Attenuation Error	Ideal Marker Delta Reading	Marker Delta Reading (dB)	Test Record Entry – Switching Error (dB)
10 dB	-55 dBm / -6.2 dBmV	55 dB	0	0 dB	0	Ref
0 dB	-65 dBm / -16.2 dBmV	65 dB		-10 dB		1)
5 dB	-60 dBm / -11.2 dBmV	60 dB		-5 dB		2)
15 dB	–50 dBm / –1.2 dBmV	50 dB		5 dB		3)
20 dB	-45 dBm/3.8 dBmV	45 dB		10 dB		4)
25 dB	-40 dBm/8.8 dBmV	40 dB		15 dB		5)
30 dB	–35 dBm / 13.8 dBmV	35 dB		20 dB		6)

Table 2-19 Input Attenuation Switching Uncertainty Worksheet

Column 1	Column 2	Column 3	Column 4	Column 5	Column 6	Column 7
Analyzer Internal Attenu- ation Setting	Analyzer Reference Level Setting 50 W Input/ 75 W Input	Total Nominal Attenu- ation Setting	Attenuation Error	Ideal Marker Delta Reading	Marker Delta Reading (dB)	Test Record Entry - Switching Error (dB)
35 dB	-30 dBm / 18.8 dBmV	30 dB		25 dB		7)
40 dB	-25 dBm / 23.8 dBmV	25 dB		30 dB		8)
45 dB	-20 dBm / 28.8 dBmV	20 dB		35 dB		9)
50 dB	-15 dBm / 33.8 dBmV	15 dB		40 dB		10)
55 dB	-10 dBm / 38.8 dBmV	10 dB		45 dB		11)
60 dB	-5 dBm / 43.8 dBmV	5 dB		50 dB		12)
65 dB ^a	0 dBm / 48.8 dBmV	0 dB		55 dB		13)

a. Does not apply to Agilent E4401B or E4411B.

Measure Switching Uncertainty

Perform step 12 to step 15 for each measurement value in Table 2-19.

- 12.Set the 1 dB and 10 dB step attenuators to the Total Nominal Attenuation setting value as indicated in Column 3 of Table 2-19 for the various analyzer attenuation settings for each measurement. Table 2-18 may be used as a reference for setting the step attenuators to achieve the desired total nominal attenuation.
- 13. Similarly, set the corresponding analyzer attenuation and reference level settings as indicated in Column 1 and Column 2 of Table 2-19.
- 14.Press Single, then Peak Search (or Search) and record the marker amplitude reading as the Marker Delta Reading in Column 6 of Table 2-19.
- 15.Calculate the Switching Error (Table 2-19, Column 7) by subtracting the Ideal Marker Delta Reading and the Attenuation Error from the Marker Delta Reading. Record the result in the performance verification test record.

13. Input Attenuation Switching Uncertainty

Switching Error = Marker Delta Reading – Ideal Marker Delta Reading – Attenuattic Example for 25 dB analyzer internal attenuation setting:

Marker Delta Reading = 14.790 dB

Ideal Marker Delta Reading = 15 dB

Attenuation Error = -0.148 dB

Switching Error = 14.790 - 15 - (-0.148) = -0.062 dB

Post-test Instrument Restoration

16.Remove the RF cable from the analyzer input connector.

17.On the analyzer, press Preset, System, Alignments, Auto Align, All.

14. Reference Level Accuracy: Agilent E4401B and E4411B

A 50 MHz CW signal is applied to the 50 Ω input of the analyzer through two step attenuators. The amplitude of the source is decreased in 10 dB steps and the analyzer marker functions are used to measure the amplitude difference between steps. The external attenuator is used as the reference standard. The test is performed in both log and linear amplitude scales.

It is only necessary to test reference levels as low as $-90~dBm~(-41.25~dBmv~for~75~\Omega~inputs)$ (with 10 dB internal attenuation) since lower reference levels are a function of the analyzer microprocessor manipulating the trace data. There is no error associated with the trace data manipulation.

The related adjustment for this performance test is "IF Amplitude."

Equipment Required

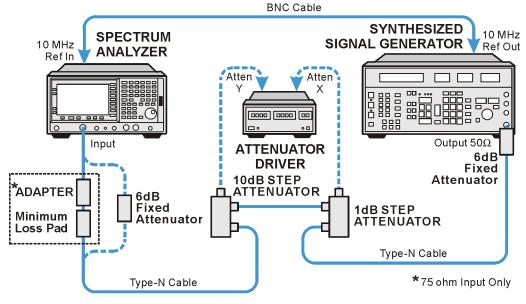
Synthesized signal generator
1 dB step attenuator
10 dB step attenuator
6 dB fixed attenuator (2 required)
Attenuator switch driver (if programmable step attenuators are used)
Cable, Type-N 152-cm (60-in) (2 required)
Cable, BNC 122-cm (48-in)
Attenuator interconnect kit

Additional Equipment for 75 Ω Input

Pad, minimum loss Adapter, Type-N (f), to BNC (m), 75 Ω

Procedure

Figure 2-14 Reference Level Accuracy Test Setup



wl77b

Calculate the Actual Attenuation Errors

1. From the calibration data supplied with the 10 dB step attenuator, enter into Column 2 of Table 2-20 through Table 2-23 the actual attenuation for the corresponding nominal attenuation settings. Enter data into Table 2-21 and Table 2-23 if the analyzer has Option 1DR. If no calibration data is supplied for 0 dB, enter zero.

NOTE

The Agilent 8496G programmable attenuator has four attenuator sections consisting of 10 dB, 20 dB, 40 dB and 40 dB attenuators. If using the Agilent 8496G programmable attenuator, enter the calibration data for the section three 40 dB step rather than the section four 40 dB step.

2. To calculate the Actual Attenuation Step, subtract the 10dB Actual Attenuation Error at all settings from the 10dB Actual Attenuation (20 dB) and enter the result in Column 3 of Table 2-20 through Table 2-23. Enter data into Table 2-21 and Table 2-23 if the analyzer has Option 1DR.

Actual Attenuator Step (X dB) = (Actual Attenuation(20 dB) – Actual Attenuation (X dB))

Example for 50 dB attenuator setting:

Actual Attenuation (50 dB) = 50.08 dB

Actual Attenuation (20 dB) = 19.85 dB

Actual Attenuator Step (50 dB) = (19.85 dB - 50.08 dB)

= -30.23 dB

Log Scale, Analog Bandwidths

1. Set the synthesized signal generator controls as follows:

FREQUENCY, 50 MHz AMPLITUDE, 12 dBm

- 2. Connect the equipment as shown in Figure 2-14. Set the 10 dB step attenuator to 20 dB attenuation and the 1 dB step attenuator to 5 dB attenuation.
- 3. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Press **System**, **Alignments**, **Auto Align**, **Off**. Set the analyzer by pressing the following keys:

FREQUENCY, 50 MHz Attenuation, 10 dB (Man) AMPLITUDE, -25 dBm $(50~\Omega~Input~only)$ AMPLITUDE, 28.75 dBmV $(75~\Omega~Input~only)$ Scale/Div, 1 dB SPAN, 50 kHz BW/Avg, 3 kHz Video BW, 30 Hz

- 4. Set the 1 dB step attenuator to place the signal peak 1 to 3 dB (1 to 3 divisions) below the reference level.
- 5. On the analyzer, press the following keys:

Single Peak Search (or Search) Marker, Delta

- 6. Set the 10 dB step attenuator and analyzer reference level according to Column 1 and Column 4 of Table 2-20. At each setting, do the following:
 - a. Press Single on the analyzer.
 - b. Press Peak Search (or Search).
 - c. Record the marker delta amplitude reading in Column 5 of Table 2-20.
 - d. Add the Actual Attenuation Step to the analyzer marker delta

14. Reference Level Accuracy: Agilent E4401B and E4411B

amplitude and enter the result as the Test Record entry in the performance test record.

The following is an example for -35 dBm reference level:

Analyzer marker Δ amplitude = (-10.17) dB

Actual Attenuator Step (30 dB) = (-10.07) dB

Test Record Entry = (-10.17) dB - (-10.07) dB = (-0.10) dB

Table 2-20	Log Scale, Analog Bandwidths
-------------------	------------------------------

Column 1	Column 2	Column 3	Colı	umn 4	Column 5	Column 6
10 dB Attenuator Nominal Attenuation (dB)	10 dB Attenuator Actual Attenuation (dB)	Actual Attenuator Step (dB)	Refe Le (d	alyzer erence evel ^a Bm) BmV)	Analyzer Marker Delta Amplitude (dB)	Test Record Entry
20		0 (Ref)	-25	28.75	0 (Ref)	(Ref)
10			-15	38.75		1)
0			-5	48.75		2)
30			-35	18.75		3)
40			-45	8.75		4)
50			-55	-1.25		5)
60			-65	-11.25		6)
70			-75	-21.25		7)

a. Use the dBm column values for analyzers with a 50 Ω input and the dBmV column for analyzers with a 75 Ω input.

Log Scale, Digital Bandwidths, Option 1DR

NOTE	If the analyzer is an E4401B that is not equipped with Option 1DR (narrow resolution bandwidths) or an E4411B (with or without Option
	1DR), skip to the next section (Linear Scale, Analog Bandwidths).

1. On the analyzer, press the following keys:

SPAN, 150 Hz BW/Avg, 10 Hz Video BW, 1 Hz

- 2. Set the 1 dB step attenuator to place the signal peak 1 to 3 dB (1 to 3 divisions) below the reference level.
- 3. On the analyzer, press the following keys:

Single Peak Search (or Search) Marker, Delta

4. Set the 10 dB step attenuator and analyzer reference level according to Column 1 and Column 4 of Table 2-21. At each setting, do the following:

14. Reference Level Accuracy: Agilent E4401B and E4411B

- a. Press Single on the analyzer.
- b. Press Peak Search (or Search).
- c. Record the Marker Delta Amplitude reading in Column 5 of Table 2-21.
- d. Add the Actual Attenuator Step to the Analyzer Marker Delta Amplitude and enter the result as the Test Record entry in the performance test record.

Column 1	Column 2	Column 3	Colı	umn 4	Column 5	Column 6
10 dB Attenuator Nominal Attenuation (dB)	10 dB Attenuator Actual Attenuation (dB)	Actual Attenuator Step (dB)	Refe	alyzer erence evel ^a (dBmV)	Analyzer Marker Delta Amplitude (dB)	Test Record Entry
20		0 (Ref)	-25	28.75	0 (Ref)	(Ref)
10			-15	38.75		8)
0			-5	48.75		9)
30			-35	18.75		10)
40			-45	8.75		11)
50			-55	-1.25		12)
60			-65	-11.25		13)
70			-75	-21.25		14)

Table 2-21 Log Mode, Digital Bandwidths Worksheet, Option 1DR

a. Use the dBm column values for analyzers with a 50 Ω input and the dBmV column for analyzers with a 75 Ω input.

Linear Scale, Analog Bandwidths

- 1. Set the 10 dB step attenuator to 20 dB attenuation.
- 2. Set the 1 dB step attenuator to 5 dB attenuation.
- 3. Set the analyzer by pressing the following keys:

AMPLITUDE, $-25 \text{ dBm} (50 \Omega input only)$

AMPLITUDE, 28.75 dBmV (75 Ω input only)

AMPLITUDE, Scale Type (Lin)

AMPLITUDE, More, Y Axis Units (or Amptd Units), dBm

 $(50 \Omega input only)$

AMPLITUDE, More, Y Axis Units (or Amptd Units), dBmV

 $(75 \Omega input only)$

SPAN, 50 kHz

BW/Avg, 3 kHz

Video BW, 30 Hz

Sweep, Sweep Cont

Marker, Off

- 4. Set the 1 dB step attenuator to place the signal peak one to three divisions below the reference level.
- 5. On the analyzer, press the following keys:

Single

14. Reference Level Accuracy: Agilent E4401B and E4411B

Peak Search (or Search) Marker, Delta

- 6. Set the 10 dB step attenuator and analyzer reference level according to Column 1 and Column 4 of Table 2-22. At each setting, do the following:
 - a. Press Single on the analyzer.
 - b. Press Peak Search (or Search).
 - c. Record the marker delta amplitude reading in Column 5 of Table 2-22.
 - d. Add the Actual Attenuator Step to the Analyzer Marker Delta Amplitude and enter the result in the performance test record.

Table 2-22	Linear Mode, Analog Bandwidths Worksheet
-------------------	--

Column 1	Column 2	Column 3	Colı	umn 4	Column 5	Column 6
10 dB Attenuator Nominal Attenuation (dB)	10 dB Attenuator Actual Attenuation (dB)	Actual Attenuator Step (dB)	Refe Le	alyzer erence evel ^a (dBmV)	Analyzer Marker Delta Amplitude (dB)	Test Record Entry
20		0 (Ref)	-25	28.75	0 (Ref)	(Ref)
10			-15	38.75		15)
0			-5	48.75		16)
30			-35	18.75		17)
40			-45	8.75		18)
50			-55	-1.25		19)
60			-65	-11.25		20)
70			-75	-21.25		21)

a. Use the dBm column values for analyzers with a 50 Ω input and the dBmV column for analyzers with a 75 Ω input.

Linear Scale, Digital Bandwidths, Option 1DR

NOTE	If the analyzer is an E4401B that is not equipped with Option 1DR (narrow resolution bandwidths) or an E4411B (with or without Option
	1DR), continue with the next section (Post-test Instrument Restoration).

1. On the analyzer, press the following keys:

SPAN, 150 Hz BW/Avg, 10 Hz Video BW, 1 Hz

- 2. Set the 1 dB step attenuator to place the signal peak 1 to 3 divisions below the reference level.
- 3. On the analyzer, press the following keys:

Single Peak Search (or Search) Marker, Delta

4. Set the 10 dB step attenuator and analyzer reference level according to Column 1 and Column 4 of Table 2-23. At each setting, do the following:

14. Reference Level Accuracy: Agilent E4401B and E4411B

- a. Press Single on the analyzer.
- b. Press Peak Search (or Search).
- c. Record the marker delta amplitude reading in Column 5 of Table 2-23.
- d. Add the Actual Attenuator Step to the Analyzer Marker Delta Amplitude and enter the result as the Test Record entry in the performance test record.

Table 2-23 Linear Mode, Digital Bandwidths, Option 1DR

Column 1	Column 2	Column 3	Colı	umn 4	Column 5	Column 6
10 dB Attenuator Nominal Attenuation (dB)	10 dB Attenuator Actual Attenuation (dB)	Actual Attenuator Step (dB)	Refe Le	alyzer erence evel ^a (dBmV)	Analyzer Marker Delta Amplitude (dB)	Test Record Entry
20		0 (Ref)	-25	28.75	0 (Ref)	(Ref)
10			-15	38.75		22)
0			-5	48.75		23)
30			-35	18.75		24)
40			-45	8.75		25)
50			-55	-1.25		26)
60			-65	-11.25		27)
70			-75	-21.25		28)

a. Use the dBm column values for analyzers with a 50 Ω input and the dBmV column for analyzers with a 75 Ω input.

Post-test Instrument Restoration

- 1. Remove the RF cable from the analyzer input connector.
- 2. To restore the default settings on the analyzer, press Preset, System, Alignments, Auto Align, All.

15. Reference Level Accuracy: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B.

A 50 MHz CW signal is applied to the 50 Ω Input of the analyzer through two step attenuators. The amplitude of the source is decreased in 10 dB steps and the analyzer marker functions are used to measure the amplitude difference between steps. The external attenuator is used as the reference standard. The test is performed in both log and linear amplitude scales.

It is only necessary to test reference levels as low as $-90~\mathrm{dBm}$ (with $10~\mathrm{dB}$ internal attenuation) since lower reference levels are a function of the analyzer microprocessor manipulating the trace data. There is no error associated with the trace data manipulation.

The related adjustment for this performance test is "IF Amplitude."

Equipment Required

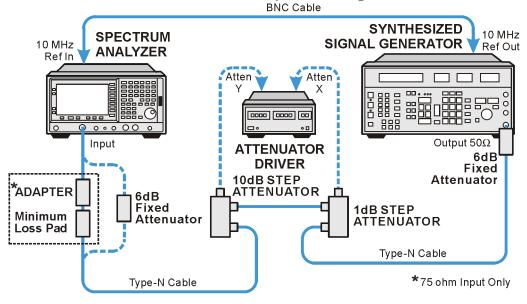
Synthesized signal generator
1 dB step attenuator
10 dB step attenuator
6 dB fixed attenuator (2 required)
Attenuator switch driver (if programmable step attenuators are used)
Cable, Type-N 152-cm (60-in) (2 required)
Cable, BNC 122-cm (48-in)
Attenuator interconnect kit

Additional Equipment for Option BAB

Adapter, Type-N (f) to APC 3.5 (f)

15. Reference Level Accuracy: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B.

Figure 2-15 Reference Level Accuracy Test Setup



wI77b

Procedure

Calculate the Actual Attenuation Errors

1. From the calibration data supplied with the 10 dB step attenuator, enter into Column 2 of Table 2-24 through Table 2-27 the actual attenuation for the corresponding nominal attenuation settings. Enter data into Table 2-25 and Table 2-27 if the analyzer has Option 1DR. If no calibration data is supplied for 0 dB, enter zero.

NOTE

The Agilent 8496G programmable attenuator has four attenuator sections consisting of 10 dB, 20 dB, 40 dB and 40 dB attenuators. If using the Agilent 8496G programmable attenuator, enter the calibration data for the section three 40 dB step rather than the section four 40 dB step.

2. To calculate the attenuation error at other nominal attenuator settings, subtract the attenuation error at the other settings from the reference attenuator error and enter the result in Column 3 of Table 2-24 through Table 2-27. Enter data into Table 2-25 and Table 2-27 if the analyzer has Option 1DR.

Actual Attenuator Step (X dB) = (Actual Attenuation(20 dB) – Actual Attenuation (X dB))

Example for 50 dB attenuator setting:

Actual Attenuation (50 dB) = 50.08 dB

Actual Attenuation (20 dB) = 19.85 dB

Actual Attenuator Step (50 dB) = (19.85 dB - 50.08 dB)

= -30.23 dB

Log Scale, Analog Bandwidths

1. Set the synthesized signal generator controls as follows:

FREQUENCY, 50 MHz AMPLITUDE, 12 dBm

- 2. Connect the equipment as shown in Figure 2-15. Set the 10 dB step attenuator to 20 dB attenuation and the 1 dB step attenuator to 5 dB attenuation.
- 3. Press **Preset** on the analyzer. Press the Factory Preset softkey, if it is displayed. Press **System**, **Alignments**, **Auto Align**, **Off**. Set the analyzer by pressing the following keys:

FREQUENCY, 50 MHz
AMPLITUDE, -20 dBm
Attenuation, 10 dB
Scale/Div, 1 dB
SPAN, 50 kHz
BW/Avg, 3 kHz
Video BW, 30 Hz

- 4. Set the 1 dB step attenuator to place the signal peak 1 to 3 divisions below the reference level.
- 5. On the analyzer, press the following keys:

Single Peak Search (or Search) Marker, Delta

- 6. Set the 10 dB step attenuator and analyzer reference level according to Column 1 and Column 4 of Table 2-24. At each setting, do the following:
 - a. Press **Single** on the analyzer.
 - b. Press Peak Search (or Search).
 - c. Record the marker delta amplitude reading in Column 5 of Table 2-24.
 - d. Add the Actual Attenuator Step to the analyzer marker delta amplitude and enter the result as the Test Record entry in the

15. Reference Level Accuracy: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B.

performance test record.

The following is an example for -30 dBm reference level:

Analyzer marker Δ amplitude = (-10.17) dB

Actual Attenuator Step (30 dB) = (-10.07) dB

Test Record Entry = (-10.17) dB - (-10.07) dB = (-0.10) dB

Table 2-24 Log Mode, Analog Bandwidths Worksheet

Column 1	Column 2	Column 3	Column 4	Column 5	Column 6
10 dB Attenuator Nominal Attenuation (dB)	10 dB Attenuator Actual Attenuation (dB)	Actual Attenuator Step (dB)	Analyzer Reference Level (dBm)	Analyzer Marker Delta Amplitude (dB)	Test Record Entry
20		0 (Ref)	-20	0 (Ref)	(Ref)
10			-10		1)
0			0		2)
30			-30		3)
40			-40		4)
50			-50		5)
60			-60		6)
70			-70		7)
80			-80		8)

Log Scale, Digital Bandwidths, Option 1DR

NOTE

If the analyzer is an E4404B/E4405B/E4407B that is not equipped with Option 1DR (narrow resolution bandwidths) or an E4403B/E4408B (with or without Option 1DR), skip to the next section (Linear Scale, Analog Bandwidths).

7. On the analyzer, press the following keys:

SPAN, 150 Hz BW/Avg, 10 Hz Video BW, 1 Hz

8. Set the 1 dB step attenuator to set the signal peak 1 to 3 divisions below the reference level.

9. On the analyzer, press the following keys:

Single Peak Search (or Search) Marker, Delta

- 10.Set the 10 dB step attenuator and analyzer reference level according to Column 1 and Column 4 of Table 2-25. At each setting, do the following:
 - a. Press **Single** on the analyzer.
 - b. Press Peak Search (or Search).
 - c. Record the marker delta amplitude reading in Column 5 of Table 2-25.
 - d. Add the Actual Attenuator Step to the analyzer marker delta amplitude and enter the result as the Test Record entry in the performance test record.

Table 2-25 Log Mode, Digital Bandwidths Worksheet, Option 1DR

Column 1	Column 2	Column 3	Column 4	Column 5	Column 6
10 dB Attenuator Nominal Attenuation (dB)	10 dB Attenuator Actual Attenuation, (dB)	Actual Attenuator Step (dB)	Analyzer Reference Level (dBm)	Analyzer Marker Delta Amplitude (dB)	Test Record Entry
20		0 (Ref)	-20	0 (Ref)	(Ref)
10			-10		9)
0			0		10)
30			-30		11)
40			-40		12)
50			-50		13)
60			-60		14)
70			-70		15)
80			-80		16)

Linear Scale, Analog Bandwidths

- 1. Set the 10 dB step attenuator to 20 dB attenuation.
- 2. Set the 1 dB step attenuator to 5 dB attenuation.
- 3. Set the analyzer by pressing the following keys:

15. Reference Level Accuracy: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B.

AMPLITUDE, Scale Type (Lin)
AMPLITUDE, More, Y Axis Units (or Amptd Units), dBm
AMPLITUDE, -20 dBm
SPAN, 50 kHz
BW/Avg, 3 kHz
Video BW, 30 Hz
Sweep, Sweep Cont
Marker, Off

- 4. Set the 1 dB step attenuator to place the signal peak 1 to 3 divisions below the reference level.
- 5. On the analyzer, press the following keys:

Single Peak Search (or Search) Marker, Delta

- 6. Set the 10 dB step attenuator and analyzer reference level according to Column 1 and Column 4 of Table 2-26. At each setting, do the following:
 - a. Press **Single** on the analyzer.
 - b. Press Peak Search (or Search).
 - c. Record the marker delta amplitude reading in Column 5 of Table 2-26.
 - d. Add the Actual Attenuator Step to the Analyzer Marker Delta Amplitude and enter the result as the Test Record entry in the performance test record.

Table 2-26 Linear Mode, Analog Bandwidths Worksheet

Column 1	Column 2	Column 3	Column 4	Column 5	Column 6
10 dB Attenuator Nominal Attenuation (dB)	10 dB Attenuator Actual Attenuation (dB)	Actual Attenuator Step (dB)	Analyzer Reference Level (dBm)	Analyzer Marker Delta Amplitude (dB)	Test Record Entry
20		0 (Ref)	-20	0 (Ref)	(Ref)
10			-10		17)
0			0		18)
30			-30		19)
40			-40		20)
50			-50		21)
60			-60		22)
70			-70		23)
80			-80		24)

Linear Scale, Digital Bandwidths, Option 1DR

NOTE

If the analyzer is an E4404B/E4405B/E4407B that is not equipped with Option 1DR (narrow resolution bandwidths) or an E4403B/E4408B (with or without Option 1DR), skip to the next section (Post-Test Instrument Restoration).

1. On the analyzer, press the following keys:

SPAN, 150 Hz BW/Avg, 10 Hz Video BW, 1 Hz

- 2. Set the 1 dB step attenuator to place the signal peak 1 to 3 divisions below the reference level.
- 3. On the analyzer, press the following keys:

Single Peak Search (or Search) Marker, Delta

- 4. Set the 10 dB step attenuator and analyzer reference level according to Column 1 and Column 4 of Table 2-27. At each setting, do the following:
 - a. Press Single on the analyzer.

15. Reference Level Accuracy: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B.

- b. Press Peak Search (or Search).
- c. Record the marker delta amplitude reading in Column 5 of Table 2-27.
- d. Add the Actual Attenuator Step to the analyzer marker delta amplitude and enter the result as the Test Record entry in the performance test record.

Table 2-27 Linear Mode, Digital Bandwidths Worksheet, Option 1DR

Column 1	Column 2	Column 3	Column 4	Column 5	Column 6
10 dB Attenuator Nominal Attenuation (dB)	10 dB Attenuator Actual Attenuation (dB)	Actual Attenuator Step (dB)	Analyzer Reference Level (dBm)	Analyzer Marker Delta Amplitude (dB)	Test Record Entry
20		0 (Ref)	-20	0 (Ref)	(Ref)
10			-10		25)
0			0		26)
30			-30		27)
40			-40		28)
50			-50		29)
60			-60		30)
70			-70		31)
80			-80		32)

Post-test Instrument Restoration

- 1. Remove the RF cable from the analyzer input connector.
- 2. To restore the default settings on the analyzer, press **Preset**, **System**, **Alignments**, **Auto Align**, **All**.

16. Resolution Bandwidth Switching Uncertainty

To measure the resolution bandwidth switching uncertainty an amplitude reference is taken with the resolution bandwidth set to 1 kHz using the marker delta function. The resolution bandwidth is changed to settings between 5 MHz and 1 Hz, as applicable, and the amplitude variation is measured at each setting and compared to the specification. The span is changed as necessary to maintain approximately the same aspect ratio.

The related adjustment for this performance test is "IF Amplitude."

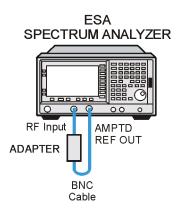
Equipment Required for Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B

BNC Cable: Agilent (E4402B, E4404B, E4405B, E4407B, E4408B) Adapter, Type-N (m) to BNC (f): Agilent (E4402B, E4404B, E4405B, E4407B, E4408B)

Additional Equipment for Option BAB

Adapter, Type-N (f) to APC 3.5 (f)

Figure 2-16 Resolution Bandwidth Switching Test Setup



wl760a

Procedure

- 1. On the Agilent E4402B, E4403B, E4404B, E4405B, E4407B, or E4408B, connect a BNC cable from the AMPTD REF OUT to the 50 Ω Input using adapters as necessary. Refer to Figure 2-16.
- 2. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the analyzer controls by pressing the following keys:

Input/Output (or Input), Amptd Ref (On) (Agilent E4401B, E4411B)
Input/Output (or Input), Amptd Ref Out (On) (Agilent E4402B,
E4403B, E4404B, E4405B, E4407, E4408B)
FREQUENCY, Center Freq, 50 MHz
SPAN, 5 kHz
AMPLITUDE, More, Y Axis Units (or Amptd Units), dBm
AMPLITUDE, -25 dBm (Agilent E4401B, E4411B)
AMPLITUDE, -19 dBm (Agilent E4402B, E4403B, E4404B, E4405B, E4407B, E4408B)
AMPLITUDE, Scale/Div, 1 dB
BW/Avg, 1 kHz
BW/Avg, Video BW, 300 Hz

3. Press **AMPLITUDE** and use the knob to adjust the reference level until the signal appears five divisions below the reference level, then press the following keys:

Peak Search (or Search) Marker \rightarrow , $Mkr \rightarrow CF$ Marker, Delta

- 4. Set the analyzer span and resolution bandwidth according to Table 2-28.
- 5. Press Peak Search (or Search), Marker→, Mkr →CF, Peak Search (or Search) then record the marker delta amplitude reading in the performance verification test record as indicated in Table 2-28.
- 6. Repeat step 4 and step 5 for each of the remaining resolution bandwidth and span settings listed in Table 2-28.

Table 2-28 Resolution Bandwidth Switching Uncertainty

Analyzer Settings		Marker Delta Amplitude Reading
RES BW	SPAN	Test Record Entry
1 kHz	5 kHz	0 (Ref)
3 kHz	10 kHz	1)
9 kHz ^a	50 kHz	2)
10 kHz	50 kHz	3)
30 kHz	100 kHz	4)
100 kHz	500 kHz	5)
120 kHz ^a	500 kHz	6)
300 kHz	1 MHz	7)

Table 2-28 Resolution Bandwidth Switching Uncertainty

Analyzer Settings		Marker Delta Amplitude Reading
RES BW	SPAN	Test Record Entry
1 MHz	5 MHz	8)
3 MHz	10 MHz	9)
5 MHz	25 MHz	10)

- a. These Res BW Settings must be entered from the keypad; they cannot be accessed from the step keys or knob.
- 7. If you are testing an analyzer equipped with Option 1DR, press **FREQUENCY**, **Center Freq**, **50 MHz**, **SPAN 10 kHz** and continue with step 8. If the analyzer is not equipped with Option 1DR, stop here.
- 8. Set the resolution bandwidth and span according to Table 2-29.
- 9. Press Peak Search (or Search), Marker→, Mkr →CF, Peak Search (or Search) then record the Marker Delta Amplitude Reading in the performance verification test record as indicated in Table 2-29.
- 10.If the analyzer is an ESA-L Series analyzer, repeat step 8 and step 9 for Res BW settings of 300 Hz and 100 Hz with the corresponding span settings listed in Table 2-29.
- 11.If the analyzer is an ESA-E Series analyzer, repeat step 8 and step 9 for Res BW settings of 300 Hz through 10 Hz with the corresponding span settings listed in Table 2-29.
- 12.If the analyzer is an ESA-E Series analyzer with firmware revision A.08.00 or later and it is equipped with Option 1D5 (high stability frequency reference), repeat step 8 and step 9 for all the Res BW settings listed in Table 2-29.

Table 2-29 Resolution Bandwidth Switching Uncertainty for Option 1DR

Analyzer Settings		Marker Delta Amplitude Reading
RES BW	SPAN	Test Record Entry
300 Hz	1 kHz	11)
200 Hz ^a	1 kHz	12)
100 Hz	500 Hz	13)
$30~{ m Hz^b}$	100 Hz	14)

Table 2-29 Resolution Bandwidth Switching Uncertainty for Option 1DR

Analyzer Settings		Marker Delta Amplitude Reading
RES BW	SPAN	Test Record Entry
10 Hz ^b	100 Hz	15)
3 Hz ^{c,b}	100 Hz	16)
1 Hz ^{c,b}	100 Hz	17)

- a. These Res BW settings must be entered from the keypad; they cannot be accessed from the step keys or knob.
- b. These Res BW settings are not available on ESA-L Series analyzers with Option 1DR.
- c. These resolution bandwidths are available only on analyzers having options 1DR and 1D5 (High-Stability Frequency Reference) and firmware revision A.08.00 and later.

17. Absolute Amplitude Accuracy (Reference Settings): Agilent E4401B and E4411B

A power sensor (the "buried sensor"), power splitter, and attenuator combination is characterized at 50 MHz using a second power sensor (the "reference sensor"). The attenuator is then connected to the input of the analyzer and the signal generator power level is adjusted for the appropriate level at 50 MHz. A complete auto alignment is performed. The 50 MHz signal is then measured with the spectrum analyzer. The difference between the power meter reading (corrected for the splitter/attenuator tracking error) and spectrum analyzer readings is calculated.

For analyzers with 75Ω inputs, a minimum loss pad is used between the attenuator and the analyzer, and a lower-value attenuator is used.

For analyzers with Option 1DS, Preamplifier, the test is repeated with preamp on

Equipment Required

Synthesized signal generator Power meter RF power sensor (2 required) Power splitter 20 dB attenuator Cable, Type-N, 152-cm (60-in) Adapter, Type-N (m) to Type-N (m)

Additional Equipment for 75 Ω Input

Power sensor, 75 Ω Adapter, mechanical, Type-N (f), 75 Ω to Type-N (m) 50 Ω Pad, minimum loss Adapter, Type-N (f), to BNC (m), 75 Ω 10 dB attenuator

Procedure

This performance test consists of three parts:

Part 1. Splitter/Attenuator Characterization

Part 2. Absolute Amplitude Accuracy, Preamp Off

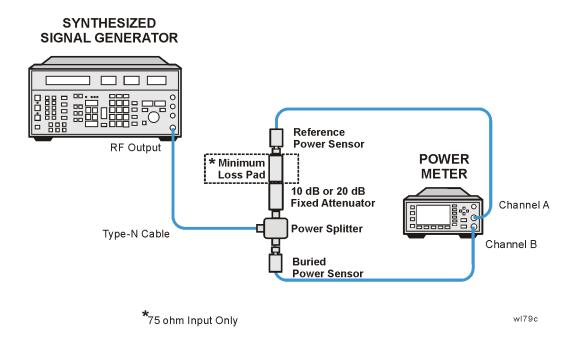
Part 3. Absolute Amplitude Accuracy, Preamp On (Option 1DS)

Parts 1 and 2 should be performed on all Agilent Spectrum Analyzers. Part 3 should be performed only on ESA-E Series Spectrum Analyzers

equipped with Option 1DS, Preamplifier.

Part 1. Splitter/Attenuator Characterization

Figure 2-17 Power Splitter/Attenuator Characterization Setup



1. Refer to Figure 2-17. Connect one RF power sensor to Channel A of the power meter. This will be the "reference" sensor. Connect the other RF power sensor to Channel B of the power meter. This will be the "buried" sensor.

75 Ω Inputs, Opt 1DP: Connect the 75 Ω power sensor to Channel A of the power meter. This will be the "reference" sensor.

- 2. Zero and calibrate both power sensors.
- 3. On the power meter, set the Channel A calibration factor to the reference sensor's reference calibration factor.
- 4. On the power meter, set the Channel B calibration factor to 100%. Do not change this calibration factor during this test.
- 5. Connect the equipment as shown in Figure 2-17, "Power Splitter/Attenuator Characterization Setup,". Use the 20 dB fixed attenuator for 50Ω analyzers. Use the 10 dB fixed attenuator and the minimum loss pad for 75Ω analyzers. Note that the reference sensor connects to either the fixed attenuator (50Ω analyzers) or the minimum loss pad (75Ω analyzers).
- 6. Set the synthesized signal generator frequency to $50~\mathrm{MHz}$ and amplitude to $+12~\mathrm{dBm}$

7. Adjust the synthesized signal generator amplitude to obtain a Channel A power meter reading of -14 dBm ±0.1 dB.

75 Ω Inputs, Opt 1DP: Adjust the source amplitude to obtain a Channel A power meter reading of -10 dBm ± 0.1 dB.

8. Record the Channel A and Channel B power meter readings below:

Channel A (reference sensor):	dBn
Channel B (buried sensor):	dBm

9. Calculate the splitter/attenuator tracking error as follows and record the result below:

Tracking Error = Channel A Power - Channel B Power

For example, if Channel A Power is -14.07 dBm and Channel B power is +6.23 dBm, the splitter tracking error is -20.30 dB.

Tracking Error: _____ dB

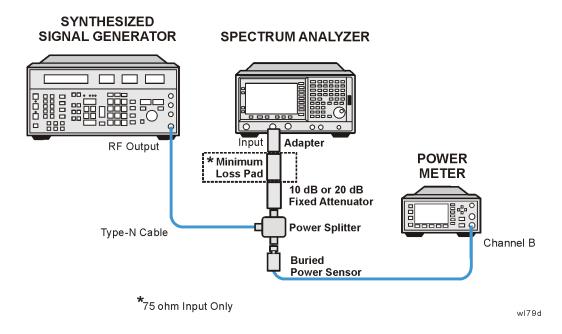
NOTE

NOTE: Tracking errors when using the minimum loss pad will be nominally $-15.7~\mathrm{dB}$

10. Proceed to Part 2: Absolute Amplitude Accuracy, Preamp Off.

Part 2. Absolute Amplitude Accuracy, Preamp Off

Figure 2-18 Absolute Amplitude Accuracy Test Setup



1. On the synthesized signal generator set the controls as follows:

FREQUENCY, 50 MHz AMPLITUDE, -1 dBm $(50~\Omega~Input~only)$ AMPLITUDE, -2.3 dBm $(75~\Omega~Input~only)$ RF ON AM OFF

- 2. Press **Preset** on the analyzer. (Press the **Factory Preset** softkey, if it is displayed.)
- 3. Press System, Alignments, Align Now, All. Wait for the auto alignment to finish. Press System, Alignments, Auto Align, Off.
- 4. Refer to Figure 2-18. Disconnect the reference sensor from the fixed attenuator. Connect the fixed attenuator or minimum loss pad to the input of the analyzer using an adapter. Do not use a cable.

 75Ω Input: Disconnect the reference sensor from the minimum loss pad. Connect the minimum loss pad to the input of the analyzer using an adapter, do not use a cable.

5. Calculate the ideal buried sensor reading by subtracting the Tracking Error recorded in step 9 of Part 1 from the ideal input level to the analyzer, as indicated in the table below:

Input Impedance	Ideal Input Level	Tracking Error from Part 1, step 9	Ideal Buried Sensor Reading
50Ω	–27 dBm		
75Ω	–24 dBm		

Ideal Buried Sensor Reading = Ideal Input Level - Tracking Error

- 6. Adjust the synthesized signal generator to obtain the Ideal Buried Sensor Reading calculated above ±0.1 dB.
- 7. Calculate the Corrected Power Meter Reading by adding the current power meter reading to the Tracking Error recorded in Part 1, step 9 and record the result below:

Corrected Power Meter Reading = Power Meter Reading + Tracking Error

Example: If the Power Meter Reading is 0.24 dBm and the Tracking Error is -20.3 dB, the Corrected Power Meter Reading is -20.06 dBm

Corrected Power Meter Reading dBm

8. Set the analyzer by pressing the following keys:

FREQUENCY, Center Freq, $50~\mathrm{MHz}$ SPAN, $2~\mathrm{kHz}$

BW/ Avg, Resolution BW, 1 kHz (Man)

BW/Avg, Video BW, 1 kHz (Man)

AMPLITUDE, More, Y Axis Units, dBm (50 Ω Input only)

AMPLITUDE, More, Y Axis Units, dBmV (75 Ω Input only)

AMPLITUDE, Ref Level, $-25 dBm (50\Omega Input only)$

AMPLITUDE, Ref Level, $+28.75 \text{ dBmV} (75\Omega \text{ Input only})$

AMPLITUDE, Attenuation, 10 dB

AMPLITUDE, Scale Type (Log)

Det/Demod, Detector, Sample

- 9. Press AMPLITUDE, More, Y Axis Units (or Amptd Units), Volts.
- 10.Press Peak Search (or Search).
- 11.Convert the marker amplitude reading from Volts to dBm using the appropriate equation below:

50Ω Input Marker Amptd (dBm) =
$$10 \times \log_{10} \left(Mkr \left(\frac{V^2}{0.05} \right) \right)$$

75Ω Input Marker Amptd (dBm) =
$$10 \times \log_{10} \left(Mkr \left(\frac{V^2}{0.075} \right) \right)$$

Marker Amptd (dBm) _____ dBm

12.Subtract the Corrected Power Meter Reading noted in step 7 from the Marker Amptd (dBm) recorded in step 11. Record the difference, Absolute Amplitude Accuracy (Log), as TR Entry 1 in the performance verification test record:

 $Absolute\ Amplitude\ Accuracy\ (Log) = Marker\ Amptd\ (dBm) - \\ Corrected\ Power\ Meter\ Reading\ (dBm)$

- 13. Press AMPLITUDE, Scale Type (Lin), More, Y-Axis Units (or Amptd Units), Volts.
- 14.Press Peak Search (or Search).
- 15.Convert the marker amplitude reading from Volts to dBm using the appropriate equation below:

50Ω Input Marker Amptd (dBm) =
$$10 \times \log_{10} \left(Mkr \left(\frac{V^2}{0.05} \right) \right)$$

75Ω Input Marker Amptd (dBm) =
$$10 \times \log_{10} \left(Mkr \left(\frac{V^2}{0.075} \right) \right)$$

Marker Amptd (dBm) _____ dBm

16.Subtract the Corrected Power Meter Reading noted in step 7 from the Marker Amptd (dBm) recorded in step 15. Record the difference, Absolute Amplitude Accuracy (Lin), as TR Entry 2 in the performance verification test record:

```
Absolute Amplitude Accuracy (Lin) = Marker Amptd (dBm) – Corrected Power Meter Reading (dBm)
```

- 17.If the analyzer is not equipped with Option 1DS, Press Preset and wait for the preset routine to finish. Press **System**, **Alignments**, **Auto Align**, **All**.
- 18.If the analyzer is equipped with Option 1DS, Preamplifier, proceed to Part 3. Absolute Amplitude Accuracy, Preamp On (Option 1DS).

Part 3. Absolute Amplitude Accuracy, Preamp On (Option 1DS)

1. On the synthesized signal generator set the controls as follows:

```
FREQUENCY, 50 MHz AMPLITUDE, –4 dBm (50~\Omega~Input~only) AMPLITUDE, –8.3 dBm (75~\Omega~Input~only) RF ON AM OFF FM OFF
```

2. Calculate the ideal buried sensor reading by subtracting the Tracking Error recorded in step 9 of Part 1 from -30 dBm, the ideal input level to the analyzer, as indicated below:

Ideal Buried Sensor Reading = -30 dBm - Tracking Error

- 3. Adjust the synthesized signal generator to obtain the Ideal Buried Sensor Reading calculated above ± 0.1 dB.
- 4. Calculate the Corrected Power Meter Reading by adding the current power meter reading to the Tracking Error recorded in Part 1, step 9 and record the result below:

Corrected Power Meter Reading = Power Meter Reading + Tracking Error

Example: If the Power Meter Reading is -9.74 dBm and the Tracking Error is -20.3 dB, the Corrected Power Meter Reading is -30.04 dBm

Corrected Power Meter Reading _____ dBm

5. Set the analyzer by pressing the following keys:

```
FREQUENCY, Center Freq, 50~\mathrm{MHz} SPAN, 2~\mathrm{kHz} BW/ Avg, Resolution BW, 1~\mathrm{kHz} (Man) BW/Avg, Video BW, 1~\mathrm{kHz} (Man) AMPLITUDE, Scale Type (Log) AMPLITUDE, More, Y Axis Units, dBm~(50\Omega~\mathrm{Input~only}) AMPLITUDE, More, Y Axis Units, dBmV~(75\Omega~\mathrm{Input~only}) AMPLITUDE, Ref Level, -30~\mathrm{dBm}~(50\Omega~\mathrm{Input~only}) AMPLITUDE, Ref Level, +18.75~\mathrm{dBmV}~(75\Omega~\mathrm{Input~only}) AMPLITUDE, Attenuation, 0~\mathrm{dB} AMPLITUDE, More, Int Preamp (On)
```

Det/Demod, Detector, Sample

- 6. Press AMPLITUDE, More, Y Axis Units (or Amptd Units), Volts.
- 7. Press Peak Search (or Search).
- 8. Convert the marker amplitude reading from Volts to dBm using the appropriate equation below:

50Ω Input Marker Amptd (dBm) =
$$10 \times \log_{10} \left(Mkr \left(\frac{V^2}{0.05} \right) \right)$$

75
$$\Omega$$
 Input Marker Amptd (dBm) = $10 \times \log_{10} \left(Mkr \left(\frac{V^2}{0.075} \right) \right)$

Marker Amptd (dBm) _____ dBm

9. Subtract the Corrected Power Meter Reading noted in step 4 from the Marker Amptd (dBm) recorded in step 8. Record the difference, Absolute Amplitude Accuracy (Log), as TR Entry 3 in the performance verification test record:

Absolute Amplitude Accuracy (Log) = Marker Amptd (dBm) - Corrected Power Meter Reading (dBm)

- $10. Press \ \textbf{AMPLITUDE}, \ \textbf{Scale Type} \ (Lin), \ \textbf{More}, \ \textbf{Y-Axis Units} \ (or \ Amptd \ Units), \ \textbf{Volts}.$
- 11.Press Peak Search (or Search).
- 12.Convert the marker amplitude reading from Volts to dBm using the appropriate equation below:

50Ω Input Marker Amptd (dBm) =
$$10 \times \log_{10} \left(Mkr \left(\frac{V^2}{0.05} \right) \right)$$

75Ω Input Marker Amptd (dBm) =
$$10 \times \log_{10} \left(Mkr \left(\frac{V^2}{0.075} \right) \right)$$

Marker Amptd (dBm) dBm

13.Subtract the Corrected Power Meter Reading noted in step 4 from the Marker Amptd (dBm) recorded in step 12. Record the difference, Absolute Amplitude Accuracy (Lin), as TR Entry 4 in the performance verification test record:

 $Absolute\ Amplitude\ Accuracy\ (Lin) = Marker\ Amptd\ (dBm)\ Corrected\ Power\ Meter\ Reading\ (dBm)$

14.Press Preset and wait for the preset routine to finish. Press System, Alignments, Auto Align, All.

A power sensor (the "buried sensor"), power splitter, and attenuator combination is characterized at 50 MHz using a second power sensor (the "reference sensor"). The attenuator is then connected to the input of the analyzer and the signal generator power level is adjusted for the appropriate level at 50 MHz. A complete auto alignment is performed. The 50 MHz signal is then measured with the spectrum analyzer. The difference between the power meter reading (corrected for the splitter/attenuator tracking error) and spectrum analyzer readings is calculated.

For analyzers with Option 1DS, Preamplifier, the test is repeated with preamp on

Equipment Required

Synthesized signal generator Power meter RF power sensor (2 required) Power splitter 20 dB attenuator Cable, Type-N, 152-cm (60 in) Adapter, Type-N (m to Type-N (m)

Additional Equipment for Option BAB

Adapter, Type-N (m) to APC 3.5 (f)

Procedure

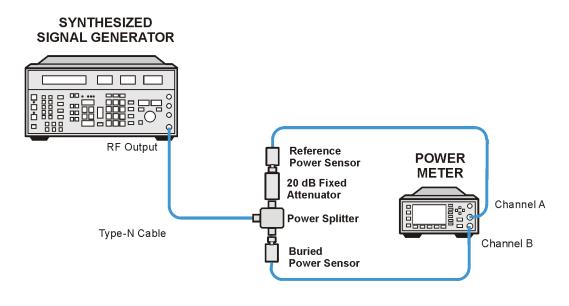
This performance test consists of three parts:

- Part 1. Splitter/Attenuator Characterization
- Part 2. Absolute Amplitude Accuracy, Preamp Off
- Part 3. Absolute Amplitude Accuracy, Preamp On (Option 1DS)

Parts 1 and 2 should be performed on all ESA Series Spectrum Analyzers. Part 3 should be performed only on ESA-E Series Spectrum Analyzers equipped with Option 1DS, Preamplifier.

Part 1. Splitter/Attenuator Characterization

Figure 2-19 Power Splitter/Attenuator Characterization Setup



WI710c

- 1. Refer to Figure 2-19. Connect one RF power sensor to Channel A of the power meter. This will be the "reference" sensor. Connect the other RF power sensor to Channel B of the power meter. This will be the "buried" sensor.
- 2. Zero and calibrate both power sensors.
- 3. On the power meter, set the Channel A calibration factor to the reference sensor's reference calibration factor.
- 4. On the power meter, set the Channel B calibration factor to 100%. Do not change this calibration factor during this test.
- 5. Connect the equipment as shown in Figure 2-19, "Power Splitter/Attenuator Characterization Setup,".
- 6. Set the synthesized signal generator frequency to 50 MHz and amplitude to $+12~\mathrm{dBm}$
- 7. Adjust the synthesized signal generator amplitude to obtain a Channel A power meter reading of -14 dBm ±0.1 dB.
- 8. Record the Channel A and Channel B power meter readings below:

Channel A (reference sensor): _____ dBm Channel B (buried sensor): dBm

9. Calculate the splitter/attenuator tracking error as follows and record the result below:

Tracking Error = Channel A Power - Channel B Power

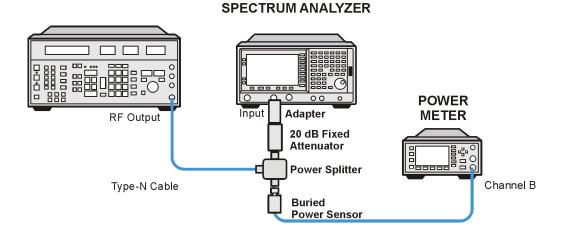
For example, if Channel A Power is –14.07 dBm and Channel B power is +6.23 dBm, the splitter tracking error is –20.30 dB.

Tracking Error: _____ dB

10. Proceed to Part 2: Absolute Amplitude Accuracy, Preamp Off.

Part 2. Absolute Amplitude Accuracy, Preamp Off

Figure 2-20 Absolute Amplitude Accuracy Test Setup



WI710d

1. On the synthesized signal generator set the controls as follows:

FREQUENCY, 50 MHz AMPLITUDE, +6 dBm RF ON AM OFF FM OFF

- 2. Press **Preset** on the analyzer. (Press the Factory Preset softkey, if it is displayed.)
- 3. Use a BNC cable and adapter to connect the AMPTD REF OUT to the INPUT 50Ω .
- 4. Press System, Alignments, Align Now, All. Wait for the auto alignment to finish. Press System, Alignments, Auto Align, Off.
- 5. Refer to Figure 2-20. Disconnect the reference sensor from the fixed attenuator. Connect the fixed attenuator to the input of the analyzer using an adapter. Do not use a cable.

6. Calculate the ideal buried sensor reading by subtracting the Tracking Error recorded in step 9 of Part 1 from -20 dBm, the ideal input level to the analyzer.

Ideal Buried Sensor Reading = -20 dBm - Tracking Error

- 7. Adjust the synthesized signal generator to obtain the Ideal Buried Sensor Reading calculated above ±0.1 dB.
- 8. Calculate the Corrected Power Meter Reading by adding the current power meter reading to the Tracking Error recorded in Part 1, step 9 and record the result below:

Corrected Power Meter Reading = Power Meter Reading + Tracking Error

Example: If the Power Meter Reading is 0.24~dBm and the Tracking Error is -20.3~dB, the Corrected Power Meter Reading is -20.06~dBm

Corrected Power Meter Reading dBm

9. Set the analyzer by pressing the following keys:

FREQUENCY, Center Freq, $50~\mathrm{MHz}$

SPAN, 2 kHz

BW/ Avg, Resolution BW, $1~\mathrm{kHz}~(Man)$

BW/Avg, Video BW, 1 kHz (Man)

AMPLITUDE, More, Y Axis Units, dBm

AMPLITUDE, Ref Level, -20 dBm

AMPLITUDE, Attenuation, 10 dB

AMPLITUDE, Scale Type (Log)

Det/Demod, Detector, Sample

- 10.Press AMPLITUDE, More, Y Axis Units (or Amptd Units), Volts.
- 11.Press Peak Search (or Search).
- 12.Convert the marker amplitude reading from Volts to dBm using the equation below:

50Ω Input Marker Amptd (dBm) =
$$10 \times \log_{10} \left(Mkr \left(\frac{V^2}{0.05} \right) \right)$$

Marker Amptd (dBm) _____ dBm

13.Subtract the Corrected Power Meter Reading noted in step 8 from the Marker Amptd (dBm) recorded in step 12. Record the difference, Absolute Amplitude Accuracy (Log), as TR Entry 1 in the performance verification test record:

Absolute Amplitude Accuracy (Log) = Marker Amptd (dBm) – Corrected Power Meter Reading (dBm)

 $14. Press\ \textbf{AMPLITUDE},\ \textbf{Scale}\ \textbf{Type}\ (Lin),\ \textbf{More},\ \textbf{Y-Axis}\ \textbf{Units}\ (or\ Amptd\ Units),\ \textbf{Volts}.$

- 15.Press Peak Search (or Search).
- 16.Convert the marker amplitude reading from Volts to dBm using the equation below:

50Ω Input Marker Amptd (dBm) =
$$10 \times \log_{10} \left(Mkr \left(\frac{V^2}{0.05} \right) \right)$$

Marker Amptd (dBm) _____ dBm

17.Subtract the Corrected Power Meter Reading noted in step 8 from the Marker Amptd (dBm) recorded in step 16. Record the difference, Absolute Amplitude Accuracy (Lin), as TR Entry 2 in the performance verification test record:

Absolute Amplitude Accuracy (Lin) = Marker Amptd (dBm) – Corrected Power Meter Reading (dBm)

- 18.If the analyzer is not equipped with Option 1DS, Press Preset and wait for the preset routine to finish. Press **System**, **Alignments**, **Auto Align**, **All**.
- 19.If the analyzer is equipped with Option 1DS, Preamplifier, proceed to Part 3. Absolute Amplitude Accuracy, Preamp On (Option 1DS).

Part 3. Absolute Amplitude Accuracy, Preamp On (Option 1DS)

1. On the synthesized signal generator set the controls as follows:

FREQUENCY, 50 MHz AMPLITUDE, -4 dBm RF ON AM OFF FM OFF

2. Calculate the ideal buried sensor reading by subtracting the Tracking Error recorded in step 9 of Part 1 from -30dBm, the ideal input level to the analyzer, as indicated below:

Ideal Buried Sensor Reading = -30 dBm - Tracking Error

- 3. Adjust the synthesized signal generator to obtain the Ideal Buried Sensor Reading calculated above ±0.1 dB.
- 4. Calculate the Corrected Power Meter Reading by adding the current power meter reading to the Tracking Error recorded in Part 1, step 9 and record the result below:

Corrected Power Meter Reading = Power Meter Reading + Tracking Error

Example: If the Power Meter Reading is -9.74 dBm and the Tracking Error is -20.3 dB, the Corrected Power Meter Reading is -30.04 dBm

Corrected Power Meter Reading _____ dBm

5. Set the analyzer by pressing the following keys:

FREQUENCY, Center Freq, $50~\mathrm{MHz}$ SPAN, $2~\mathrm{kHz}$ BW/ Avg, Resolution BW, $1~\mathrm{kHz}$ (Man) BW/Avg, Video BW, $1~\mathrm{kHz}$ (Man) AMPLITUDE, Scale Type (Log) AMPLITUDE, More, Y Axis Units, dBm AMPLITUDE, Ref Level, $-30~\mathrm{dBm}$ AMPLITUDE, Attenuation, $0~\mathrm{dB}$ AMPLITUDE, More, Int Preamp (On) Det/Demod, Detector, Sample

- 6. Press AMPLITUDE, More, Y Axis Units (or Amptd Units), Volts.
- 7. Press Peak Search (or Search).
- 8. Convert the marker amplitude reading from Volts to dBm using the equation below:

50Ω Input Marker Amptd (dBm) =
$$10 \times \log_{10} \left(Mkr \left(\frac{V^2}{0.05} \right) \right)$$

Marker Amptd (dBm) _____ dBm

9. Subtract the Corrected Power Meter Reading noted in step 4 from the Marker Amptd (dBm) recorded in step 8. Record the difference, Absolute Amplitude Accuracy (Log), as TR Entry 3 in the performance verification test record:

 $Absolute\ Amplitude\ Accuracy\ (Log) = Marker\ Amptd\ (dBm)\ Corrected\ Power\ Meter\ Reading\ (dBm)$

- $10. Press \ \textbf{AMPLITUDE}, \ \textbf{Scale Type} \ (Lin), \ \textbf{More}, \ \textbf{Y-Axis Units} \ (or \ Amptd \ Units), \ \textbf{Volts}.$
- 11.Press Peak Search (or Search).
- 12.Convert the marker amplitude reading from Volts to dBm using the equation below:

50Ω Input Marker Amptd (dBm) =
$$10 \times \log_{10} \left(Mkr \left(\frac{V^2}{0.05} \right) \right)$$

Marker Amptd (dBm) _____ dBm

13.Subtract the Corrected Power Meter Reading noted in step 4 from the Marker Amptd (dBm) recorded in step 12. Record the difference, Absolute Amplitude Accuracy (Lin), as TR Entry 4 in the performance verification test record:

Absolute Amplitude Accuracy (Lin) = Marker Amptd (dBm) - Corrected Power Meter Reading (dBm)

14. Press **Preset** and wait for the preset routine to finish. Press **System**,

Alignments, Auto Align, All.

19. Overall Absolute Amplitude Accuracy: Agilent E4401B and E4411B

This test measures the absolute amplitude of the analyzer at 50 MHz. A synthesized signal generator and attenuators are used as the signal source to the analyzer. A power meter is used to measure this signal source with the attenuators set to 0 dB. The value measured is recorded as the source amplitude. The attenuators are used to adjust the signal levels applied to the analyzer between the initial signal amplitude (set with the power meter) and -50 dBm. The amplitude measured by the analyzer is compared to the actual signal level and the amplitude error is calculated.

There are no related adjustment procedures for this performance test.

Equipment Required

Synthesized signal generator
10 dB step attenuator
1 dB step attenuator
Attenuator interconnection kit
Attenuator driver (if programmable step attenuators are used)
6 dB fixed attenuator (2 required)
Power meter
Power sensor
Cable, Type-N, 62-cm (24 in.) (m) (2 required)
Cable, BNC
Adapter, Type-N (f) to Type-N (f)

Additional Equipment for 75 Ω Input

Power sensor, 75 Ω Pad, minimum loss Adapter, mechanical, Type-N (f), 75 Ω to Type-N (m) 50 Ω Adapter, Type-N (f), to BNC (m), 75 Ω Adapter, Type-N (f) to Type-N (f), 75 Ω

Procedure

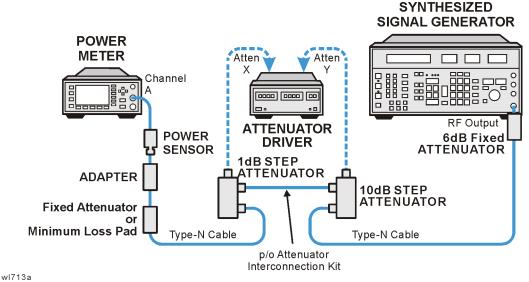
Measuring 0 dBm Reference Level

- 1. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed.
- 2. Perform a complete self-alignment and set Auto Align Off. Press System, Alignments, Align Now, All, and wait for the alignment routine to finish. Then, press Return, Auto Align, Off.

3. Zero and calibrate the power meter and power sensor connected to Channel A of the power meter.

75 Ω Inputs: Zero and calibrate the power meter and 75 Ω power sensor connected to Channel A of the power meter.

Figure 2-21 Measure Source Test Setup



4. Connect the equipment as shown in Figure 2-21. The power sensor should connect directly to the 6 dB fixed attenuator using an adapter.

75 Ω Inputs: Use the minimum loss pad in place of the 6 dB fixed attenuator and a 75 Ω Type-N (f) to Type-N (f) adapter.

5. Preset the synthesized signal generator. Manually press **Blue Key**, **Special**, **0**, **0**. Set the signal generator as follows:

FREQUENCY, 50 MHz AMPLITUDE, 12 dBm

- 6. Set the 10 dB and 1 dB step attenuators to 0 dB.
- 7. Obtain the actual attenuation for the 0 dB setting of each attenuator at 50 MHz from the metrology data for the step attenuators. In some cases this value might be zero, by definition. Add the two actual attenuations to obtain the 0 dB reference attenuation.

$$RefAtten_{0dB} = 10 dB Actual_{0dB} + 1 dB Actual_{0dB}$$

For example, if the actual attenuation for the 10 dB step attenuator is 0.03 dB, 10 dB Actual $_{0dB}$ is 0.03 dB. If the actual attenuation for the 1 dB step attenuator is 0.02 dB, 1 dB Actual $_{0dB}$ is 0.02 dB. In this case RefAtten $_{0dB}$ is 0.05 dB.

8. Obtain the metrology data for the step attenuators at 50 MHz. Enter the actual attenuation values for each attenuator setting as indicated in Table 2-30. If using a programmable attenuator, the section three 40 dB step should be used for the 40 dB setting on the 10 dB step attenuator. Similarly, the section three 4 dB step should be used for the 4 dB setting on the 1 dB step attenuator.

Table 2-30 Amplitude Accuracy Worksheet, 0 dBm Reference Level

1 dB Ster Attenuat	•	10 dB St Attenuat	-	Total Attenuation		Nominal Amptd.	Meas. Amptd.	Amptd. Accuracy Test
Setting	Actual	Setting	Actual	Setting	Actual			Record Entry
0 dB		0 dB		0 dB		0 dBm		1)
0 dB		10 dB		10 dB		-10 dBm		2)
0 dB		20 dB		20 dB		-20 dBm		3)
0 dB		30 dB		30 dB		-30 dBm		4)
0 dB		40 dB		40 dB		-40 dBm		5)
0 dB		50 dB		50 dB		-50 dBm		6)

9. Calculate the actual total attenuation by adding the actual attenuation for the 1 dB step attenuator to the actual attenuation for the 10 dB step attenuator for each total attenuation setting listed in Table 2-30.

N	$\boldsymbol{\cap}$	т	ᆮ
14	v	ı	ㄷ

The external attenuators and cables are now part of the "source."

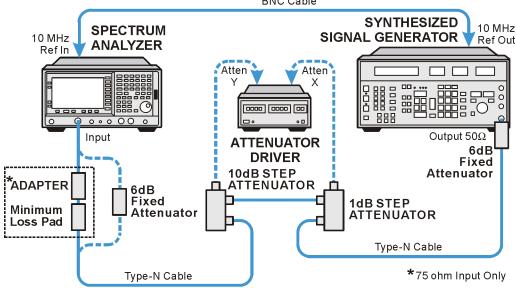
10.Adjust the signal generator amplitude for a power meter reading of $0 \text{ dBm} \pm 0.2 \text{ dB}$. Record the power meter reading here:

$$Amptd_{0dBm} = \underline{\hspace{1cm}} dBm$$

11.Connect the equipment as indicated in Figure 2-22. The fixed attenuator must connect directly to the analyzer input.

75 Ω Inputs: The minimum loss pad should be connected to the analyzer input using a Type N (f) to BNC (m) 75 Ω adapter.

Figure 2-22 Amplitude Accuracy Test Setup



wl77b

12.Set the analyzer as follows:

FREQUENCY, Center Freq, 50 MHz SPAN, 6 kHz BW/Avg, Res BW, 1 kHz AMPLITUDE, More, Y Axis Units (or Amptd Units), dBm AMPLITUDE, Ref Level, 0 dBm Attenuation, 10 dB (Man)

- 13.Perform the following steps for each of the nominal amplitude values listed in Table 2-30:
 - a. Set the 1 dB step attenuator as indicated in Table 2-30.
 - b. Set the 10 dB step attenuator as indicated in Table 2-30.
 - c. Press **Single** and wait for the sweep to finish.
 - d. Press **Peak Search** (or **Search**). Even though the signal may be slightly above the reference level for the first nominal amplitude setting, the marker can still make a valid measurement.
 - e. Record the marker (Mkr1) amplitude value as the measured amplitude in Table 2-30.
 - f. If the nominal amplitude is 0 dBm, calculate the amplitude accuracy as follows:
 - Amplitude Accuracy = Measured Amplitude Amptd_{0dBm}
 - g. If the amplitude is less than 0 dBm, calculate the amplitude accuracy as follows:

 $Amplitude\ Accuracy\ =\ Measured\ Amplitude\ -\ (Amptd_{0dBm}\ -\ Actual Total Atten\ +\ Ref Atten_{0dB})$

h. Record the amplitude accuracy in the performance verification

test record as indicated in Table 2-30.

Measuring -20 dBm Reference Level

- 1. Press AMPLITUDE, Ref Level, –20 dBm.
- 2. Copy the actual total attenuation values from Table 2-30 into the actual total attenuation column in Table 2-31. Not all values in Table 2-30 will be required in Table 2-31.

Table 2-31 Amplitude Accuracy Worksheet, -20 dBm Reference Level

1 dB Step Attenuator	10 dB Step Attenuator	Total Att	enuation	Nominal	Measured	Amplitude Accuracy
Setting	Actual	Setting	Actual	Amplitude	Amplitude	Test Record Entry
0 dB	20 dB	20 dB		-20 dBm		7)
0 dB	30 dB	30 dB		-30 dBm		8)
0 dB	40 dB	40 dB		-40 dBm		9)
0 dB	50 dB	50 dB		-50 dBm		10)

- 3. Perform the following steps for each of the nominal amplitude values listed in Table 2-31:
 - a. Set the 1 dB step attenuator as indicated in Table 2-31.
 - b. Set the 10 dB step attenuator as indicated in Table 2-31.
 - c. Press **Single** and wait for the sweep to finish.
 - d. Press **Peak Search** (or **Search**). Even though the signal may be slightly above the reference level for the first nominal amplitude setting, the marker can still make a valid measurement.
 - e. Record the marker (Mkr1) amplitude value as the measured amplitude in Table 2-31.
 - f. Calculate the amplitude accuracy as follows:

Amplitude Accuracy = Measured Amplitude – (Amptd_{0dBm} – ActualTotalAtten + RefAtten_{0dB})

g. Record the amplitude accuracy in the performance verification test record as indicated in Table 2-31.

Measuring -40 dBm Reference Level

- 1. Press AMPLITUDE, Ref Level, -40 dBm.
- 2. Copy the actual total attenuation values from Table 2-31 into the actual total attenuation column in Table 2-32. Not all values in Table 2-31 will be required in Table 2-32.

Table 2-32 Amplitude Accuracy Worksheet, -40 dBm Reference Level

1 dB Step Attenuator	10 dB Step Attenuator	Total Att	enuation	Nominal Amplitude	Measured Amplitude	Amplitude Accuracy
Setting	Actual	Setting	Actual			Test Record Entry
0 dB	40 dB	40 dB		-40 dBm		11)
0 dB	50 dB	50 dB		–50 dBm		12)

- 3. Perform the following steps for each of the nominal amplitude values listed in Table 2-32:
 - a. Set the 1 dB step attenuator as indicated in Table 2-32.
 - b. Set the 10 dB step attenuator as indicated in Table 2-32.
 - c. Press **Single** and wait for the sweep to finish.
 - d. Press **Peak Search** (or **Search**). Even though the signal may be slightly above the reference level for the first nominal amplitude setting, the marker can still make a valid measurement.
 - e. Record the marker (Mkr1) amplitude value as the measured amplitude in Table 2-32.

 - g. Record the amplitude accuracy in the performance verification test record as indicated in Table 2-32.

Measuring -50 dBm Reference Level

- 1. Press AMPLITUDE, Ref Level, -50 dBm.
- 2. Copy the actual total attenuation values from Table 2-32 into the actual total attenuation column in Table 2-33. Not all values in Table 2-32 will be required in Table 2-33.

Table 2-33 Amplitude Accuracy Worksheet, -50 dBm Reference Level

1 dB Step Attenuator	10 dB Step Attenuator	Total Attenuation		Nominal Amplitude	Measured Amplitude	Amplitude Accuracy
Setting	Actual	Setting	Actual			Test Record Entry
0 dB	50 dB	50 dB		–50 dBm		13)

- 3. Perform the following steps for each of the nominal amplitude values listed in Table 2-33:
 - a. Set the 1 dB step attenuator as indicated in Table 2-33.
 - b. Set the 10 dB step attenuator as indicated in Table 2-33.

- c. Press **Single** and wait for the sweep to finish.
- d. Press **Peak Search** (or **Search**). Even though the signal may be slightly above the reference level for the first nominal amplitude setting, the marker can still make a valid measurement.
- e. Record the marker (Mkr1) amplitude value as the measured amplitude in Table 2-33.
- $\label{eq:control_odbm} \begin{array}{ll} \text{f. Calculate the amplitude accuracy as follows:} \\ \text{Amplitude Accuracy = Measured Amplitude} (\text{Amptd}_{\text{0dBm}} \text{ActualTotalAtten} + \text{RefAtten}_{\text{0dB}}) \end{array}$
- g. Record the amplitude accuracy in the performance verification test record as indicated in Table 2-33.

20. Overall Absolute Amplitude Accuracy: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B

This test measures the absolute amplitude of the analyzer at 50 MHz. A synthesized signal generator and attenuators are used as the signal source to the analyzer. A power meter is used to measure this signal source with the attenuators set to 0 dB. The value measured is recorded as the source amplitude. The attenuators are used to adjust the signal levels applied to the analyzer from the initial signal amplitude (set with the power meter) and $-50~\mathrm{dBm}$. The amplitude measured by the analyzer is compared to the actual signal level and the amplitude error is calculated.

There are no related adjustment procedures for this performance test.

Equipment Required

Synthesized signal generator
10 dB step attenuator
1 dB step attenuator
Attenuator interconnection kit
Attenuator driver (if programmable step attenuators are used)
6 dB fixed attenuator (2 required)
Power meter
RF power sensor
Cable, Type-N, 62 cm (24 in.) (m) (2 required)
Cable, BNC
Adapter, Type-N (f) to Type-N (f)

Additional Equipment for Option BAB

Adapter, Type N (f) to APC 3.5 (f)

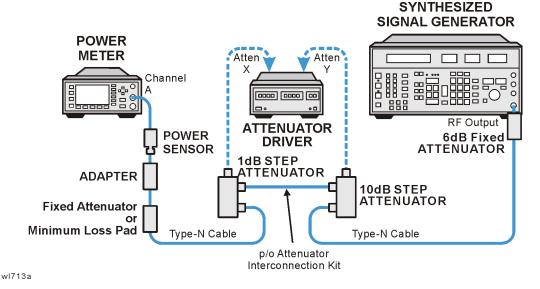
Procedure

Measuring 0 dBm Reference Level

- 1. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed.
- 2. Connect a BNC cable from AMPTD REF OUT to the 50 Ω Input connector using a Type N (m) to BNC (f) adapter.
- 3. Perform a complete self-alignment and set Auto Align Off. Press System, Alignments, Align Now, All, and wait for the alignment routine to finish. Then, press Return, Auto Align, Off.

- 4. Zero and calibrate the power meter and power sensor connected to Channel A of the power meter.
- 5. Connect the equipment as shown in Figure 2-23. The power sensor should connect directly to the 6 dB fixed attenuator using an adapter.

Figure 2-23 Measure Source Test Setup



6. **Preset** the synthesized signal generator. Manually press **Blue Key**, **Special**, **0**, **0**. Set the signal generator as follows:

FREQUENCY, 50 MHz AMPLITUDE, 12 dBm

- 7. Set the 10 dB and 1 dB step attenuators to 0 dB.
- 8. Obtain the actual attenuation for the 0 dB setting of each attenuator at 50 MHz from the metrology data for the step attenuators. In some cases this value might be zero, by definition. Add the two actual attenuations to obtain the 0 dB reference attenuation.

$$RefAtten_{0dB} = 10 dB Actual_{0dB} + 1 dB Actual_{0dB}$$

For example, if the actual attenuation for the 10 dB step attenuator is 0.03 dB, 10 dB Actual $_{0dB}$ is 0.03 dB. If the actual attenuation for the 1 dB step attenuator is 0.02 dB, 1 dB Actual $_{0dB}$ is 0.02 dB. In this case RefAtten $_{0dB}$ is 0.05 dB.

9. Obtain the metrology data for the step attenuators at 50 MHz. Enter the actual attenuation values for each attenuator setting as indicated in Table 2-34. If using a programmable attenuator, the section three 40 dB step should be used for the 40 dB setting on the 10 dB step attenuator. Similarly, the section three 4 dB step should

20. Overall Absolute Amplitude Accuracy: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B

be used for the 4 dB setting on the 1 dB step attenuator.

Table 2-34 Amplitude Accuracy Worksheet, 0 dBm Reference Level

1 dB Atten	-	10 dB Atten	-	Tot Attenu		Nominal Meas.	Amptd. Accuracy Test	
Setting	Actual	Setting	Actual	Setting	Actual	Amptd.	Amptd.	Record Entry
0 dB		0 dB		0 dB		0 dBm		1)
0 dB		10 dB		10 dB		-10 dBm		2)
0 dB		20 dB		20 dB		-20 dBm		3)
0 dB		30 dB		30 dB		-30 dBm		4)
0 dB		40 dB		40 dB		-40 dBm		5)
0 dB		50 dB		50 dB		-50 dBm		6)

10.Calculate the actual total attenuation by adding the actual attenuation for the 1 dB step attenuator to the actual attenuation for the 10 dB step attenuator for each total attenuation setting listed in Table 2-34.

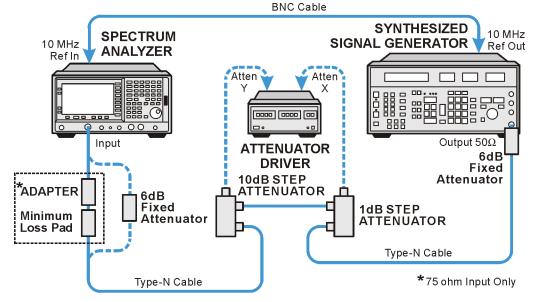
NOTE The external attenuators and cables are now part of the "source	NOTE	The external	attenuators	and cables	are now	part of the	"source.
---	------	--------------	-------------	------------	---------	-------------	----------

11. Adjust the signal generator amplitude for a power meter reading of $0 \text{ dBm } \pm 0.2 \text{ dB}$. Record the power meter reading here:

$$Amptd_{0dBm} = \underline{\hspace{1cm}} dBm$$

12.Connect the equipment as indicated in Figure 2-24. The fixed attenuator must connect directly to the analyzer input.

Figure 2-24 Amplitude Accuracy Test Setup



wI77b

13.Set the analyzer as follows:

FREQUENCY, Center Freq, 50 MHz SPAN, 6 kHz BW/Avg, Res BW, 1 kHz

AMPLITUDE, Ref Level, 0 dBm Attenuation, 10 dB (Man)

- 14.Perform the following steps for each of the nominal amplitude values listed in Table 2-34:
 - a. Set the 1 dB step attenuator as indicated in Table 2-34.
 - b. Set the 10 dB step attenuator as indicated in Table 2-34.
 - c. Press **Single** and wait for the sweep to finish.
 - d. Press **Peak Search** (or **Search**). Even though the signal may be slightly above the reference level for the first nominal amplitude setting, the marker can still make a valid measurement.
 - e. Record the marker (Mkr1) amplitude value as the measured amplitude in Table 2-34.
 - f. If the nominal amplitude is 0 dBm, calculate the amplitude accuracy as follows:
 - Amplitude Accuracy = Measured Amplitude Amptd_{0dBm}
 - g. If the amplitude is less than 0 dBm, calculate the amplitude accuracy as follows:
 - $Amplitude\ Accuracy\ =\ Measured\ Amplitude\ -\ (Amptd_{0dBm}\ -\ Actual Total Atten\ +\ Ref Atten_{0dB})$
 - h. Record the amplitude accuracy in the performance verification test record as indicated in Table 2-34.

20. Overall Absolute Amplitude Accuracy: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B

Measuring -20 dBm Reference Level

- 1. Press AMPLITUDE, Ref Level, -20 dBm.
- 2. Copy the actual total attenuation values from Table 2-34 into the actual total attenuation column in Table 2-35. Not all values in Table 2-34 will be required in Table 2-35.

Table 2-35 Amplitude Accuracy Worksheet, -20 dBm Reference Level

1 dB Step Attenuator	10 dB Step Attenuator	Total Att	enuation	Nominal	Measured	Amplitude Accuracy
Setting	Actual	Setting	Actual	Amplitude	Amplitude	Test Record Entry
0 dB	20 dB	20 dB		-20 dBm		7)
0 dB	30 dB	30 dB		-30 dBm		8)
0 dB	40 dB	40 dB		-40 dBm		9)
0 dB	50 dB	50 dB		-50 dBm		10)

- 3. Perform the following steps for each of the nominal amplitude values listed in Table 2-35:
 - a. Set the 1 dB step attenuator as indicated in Table 2-35.
 - b. Set the 10 dB step attenuator as indicated in Table 2-35.
 - c. Press **Single** and wait for the sweep to finish.
 - d. Press **Peak Search** (or **Search**). Even though the signal may be slightly above the reference level for the first nominal amplitude setting, the marker can still make a valid measurement.
 - e. Record the marker (Mkr1) amplitude value as the measured amplitude in Table 2-35.
 - f. Calculate the amplitude accuracy as follows: $\text{Amplitude Accuracy = Measured Amplitude} (\text{Amptd}_{0dBm} \text{ActualTotalAtten} + \text{RefAtten}_{0dB})$
 - g. Record the amplitude accuracy in the performance verification test record as indicated in Table 2-35.

Measuring -40 dBm Reference Level

- 1. Press AMPLITUDE, Ref Level, -40 dBm.
- 2. Copy the actual total attenuation values from Table 2-34 into the actual total attenuation column in Table 2-36. Not all values in

Table 2-34 will be required in Table 2-36.

Table 2-36 Amplitude Accuracy Worksheet, -40 dBm Reference Level

1 dB Step Attenuator	10 dB Step Attenuator	Total Att	enuation	Nominal	Measured	Amplitude Accuracy
Setting	Actual	Setting	Actual	Amplitude	Amplitude	Test Record Entry
0 dB	40 dB	40 dB		-40 dBm		11)
0 dB	50 dB	50 dB		-50 dBm		12)

- 3. Perform the following steps for each of the nominal amplitude values listed in Table 2-36:
 - a. Set the 1 dB step attenuator as indicated in Table 2-36.
 - b. Set the 10 dB step attenuator as indicated in Table 2-36.
 - c. Press **Single** and wait for the sweep to finish.
 - d. Press **Peak Search** (or **Search**). Even though the signal may be slightly above the reference level for the first nominal amplitude setting, the marker can still make a valid measurement.
 - e. Record the marker (Mkr1) amplitude value as the measured amplitude in Table 2-36.

 - g. Record the amplitude accuracy in the performance verification test record as indicated in Table 2-36.

Measuring -50 dBm Reference Level

- 1. Press AMPLITUDE, Ref Level, -50 dBm.
- 2. Copy the actual total attenuation values from Table 2-34 into the actual total attenuation column in Table 2-37. Not all values in Table 2-34 will be required in Table 2-37.

Table 2-37 Amplitude Accuracy Worksheet, -50 dBm Reference Level

1 dB Step Attenuator	10 dB Step Attenuator	Total Att	enuation	Nominal	Measured	Amplitude Accuracy
Setting	Actual	Setting	Actual	Amplitude	Amplitude	Test Record Entry
0 dB	50 dB	50 dB		-50 dBm		13)

3. Perform the following steps for each of the nominal amplitude values listed in Table 2-37:

Performance Verification Tests

20. Overall Absolute Amplitude Accuracy: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B

- a. Set the 1 dB step attenuator as indicated in Table 2-37.
- b. Set the 10 dB step attenuator as indicated in Table 2-37.
- c. Press **Single** and wait for the sweep to finish.
- d. Press **Peak Search** (or **Search**). Even though the signal may be slightly above the reference level for the first nominal amplitude setting, the marker can still make a valid measurement.
- e. Record the marker (Mkr1) amplitude value as the measured amplitude in Table 2-37.
- g. Record the amplitude accuracy in the performance verification test record as indicated in Table 2-37.

21. Resolution Bandwidth Accuracy

The output of a synthesized signal generator is connected to the Input of the analyzer, characterized through a 1 dB step attenuator set to 3 dB. The amplitude of the synthesized signal generator is set to a reference amplitude 5 dB below the top of the screen. A marker reference is set and the attenuator is set to 0 dB.

The markers of the analyzer are then used to measure the 3 dB bandwidth. The first marker is set on the left filter skirt so that the marker delta amplitude is 1 dB plus the attenuator error for the 3 dB setting. The second marker is similarly set on the right filter skirt. The frequency difference between the two markers is the 3 dB bandwidth.

Resolution bandwidth settings £300 Hz (Option 1DR) are not measured. These bandwidths are digitally derived; therefore, their accuracy is verified by design.

The related adjustment for this performance test is "IF Amplitude."

Equipment Required

Synthesized signal generator
Cable, BNC, 122-cm (48-in)
Cable, Type-N, 152-cm (60-in) (2 required)
1 dB step attenuator
Attenuator/switch driver (if programmable step attenuators are used)

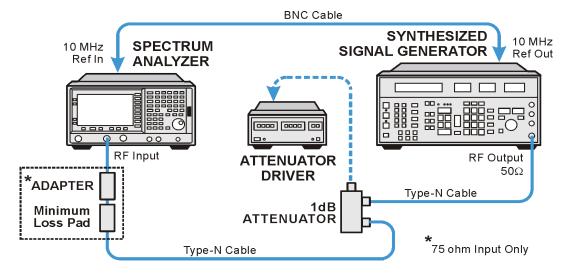
Additional Equipment for 75 Ω Input

Pad, minimum loss Adapter, Type-N (f), to BNC (m), 75 Ω

Additional Equipment for Option BAB

Adapter, Type-N (f), to APC 3.5 (f)

Figure 2-25 Resolution Bandwidth Accuracy Test Setup



w1738a

CAUTION

Use only 75 Ω cables, connectors, or adapters on instruments with 75 Ω connectors, or the connectors will be damaged.

Procedure

- 1. Connect the equipment as shown in Figure 2-25.
- 2. On the synthesized signal generator, press **Blue Key**, **Special**, **0**, **0** and set the controls as follows:

FREQUENCY, 50 MHz AMPLITUDE, 0 dBm $(50~\Omega~Input~only)$ AMPLITUDE, 6 dBm (75 $\Omega~Input~only)$

3. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Press **System**, **Alignments**, **Auto Align**, **Off**. Set the analyzer by pressing the following keys:

FREQUENCY, 50 MHz
SPAN, 7.5 MHz
AMPLITUDE, Scale/Div 1 dB
AMPLITUDE, Y Axis Units (or Amptd Units), dBm
BW/Avg, 5 MHz
BW/Avg, Video BW, 30 Hz

- 4. Set the 1 dB step attenuator to 3 dB.
- 5. Note the error of the external 1 dB step attenuator at 3 dB and 6 dB below using its calibration records.

Attenuator Error (3 dB) _____ dB

Attenuator Error (6 dB) _____ dB

3 dB Resolution Bandwidth Accuracy

- 6. Press Peak Search (or Search), Meas Tools, Mkr→ CF on the analyzer.
- 7. Adjust the amplitude of the synthesized signal generator for a marker amplitude reading of –5 dBm ±0.2 dB.
- 8. Press Peak Search (or Search), Marker, Delta on the analyzer.
- 9. Set the attenuator to 0 dB.
- 10.On the analyzer, press **Marker**. Lower the marker frequency by adjusting the knob until the marker delta amplitude is 0 dB plus the attenuator error (3 dB) noted in step 5 to a tolerance of ±0.05 dB.
- 11.Record the marker frequency readout in Column 3 of Table 2-38.
- 12.Using the analyzer knob, raise the marker frequency so that the marker delta amplitude is maximum. Continue increasing the marker frequency until the marker reads 0.0 dB plus the attenuator error (3 dB) noted in step 5 to a tolerance of ±0.05 dB.
- 13. Record the marker frequency readout in Column 4 of Table 2-38.
- 14.Set the attenuator to 3 dB.
- 15.Press Marker, Normal on the analyzer.
- 16.Repeat step 6 through step 15 for each of the analyzer Res BW and Analyzer Span settings listed in Table 2-38.
- 17.Subtract the Lower Marker Frequency from the Upper Marker Frequency. Record the difference as the 3 dB Bandwidth, in the performance verification test record as indicated in Table 2-38.
 - 3 db Bandwidth = Upper Marker Frequency Lower Marker

Frequency

Table 2-38 3 dB Resolution Bandwidth Accuracy

Column 1	Column 2	Column 3	Column 4	Column 5
Analyzer Res BW	Analyzer Span	Lower Marker Frequency	Upper Marker Frequency	Test Record Entry 3 dB Bandwidth
5 MHz	7.5 MHz			1)
3 MHz	4.5 MHz			2)
1 MHz	1.5 MHz			3)
300 kHz	450 kHz			4)
100 kHz	150 kHz			5)
30 kHz	45 kHz			6)
10 kHz	15 kHz			7)
3 kHz	4.5 kHz			8)
1 kHz	1.5 kHz			9)

6 dB Resolution Bandwidth Accuracy

- 18.Set the analyzer Res BW to 120 kHz and the analyzer span to 180 kHz as shown in Table 2-39.
- 19.On the analyzer, press Peak Search (or Search), Meas Tools, Mkr→ CF.
- 20.Set the external 1 dB step attenuator to 6 dB and adjust the amplitude of the synthesized signal generator for a marker amplitude reading of -7 dBm ± 0.2 dB.
- 21. Press Peak Search (or Search), Marker, Delta on the analyzer.
- 22.Set the attenuator to 0 dB.
- 23.On the analyzer, press **Marker**. Lower the marker frequency by adjusting the knob until the marker delta amplitude is 0 dB plus the attenuator error (6 dB) noted in step 5 to tolerance of ± 0.05 dB.
- 24.Record the marker frequency readout in Column 3 of Table 2-39.
- 25.Using the analyzer knob, raise the marker frequency so that the marker delta amplitude is maximum. Continue increasing the marker frequency until the marker reads 0.0 dB plus the attenuator error (6 dB) noted in step 5 to a tolerance of $\pm 0.05 \text{ dB}$.
- 26. Record the marker frequency readout in Column 4 of Table 2-39.
- 27.Set the attenuator to 6 dB.

- 28. Press Marker, Normal on the analyzer.
- 29.Repeat step 19 through step 28 for each of the analyzer Res BW and analyzer span settings listed in Table 2-39.
- 30.Subtract the Lower Marker Frequency from the Upper Marker Frequency. Record the difference as the 6 dB bandwidth, in the performance verification test record as indicated in Table 2-39.
 - 6 dB Bandwidth = Upper Marker Frequency Lower Marker Frequency

Table 2-39 6 dB Resolution Bandwidth Accuracy

Column 1	Column 2	Column 3	Column 4	Column 5
Analyzer Res BW	Analyzer Span	Lower Marker Frequency	Upper Marker Frequency	Test Record Entry 3 dB Bandwidth
120 kHz	180 kHz			10)
9 kHz	13.5 kHz			11)

Post-test Instrument Restoration

- 31.Remove the RF cable from the analyzer input connector.
- 32.Press Preset on the analyzer. Press the Factory Preset softkey, if it is displayed. Press System, Alignments, Auto Align, All.

22. Frequency Response: Agilent E4401B and E4411B

This test measures the amplitude error of the analyzer as a function of frequency. To measure frequencies of 100 kHz and greater, the output of a signal generator is fed through a power splitter to a power sensor and the analyzer.

To measure frequencies below 100 kHz, a digital voltmeter (DVM) with a 50 Ω load replaces the power sensor and a function generator is used as the source.

For improved amplitude accuracy, the power splitter is characterized using a power sensor (the "reference" sensor) connected to one power splitter output port. The other power splitter output port connects to the "buried" sensor; it is not removed from the power splitter. Once the characterization is done, the reference sensor is removed and replaced by the analyzer.

This procedure does not test frequency response with the optional preamplifier (Option 1DS) turned on. If the analyzer is equipped with Option 1DS, also perform the "Frequency Response, Preamp On" procedure.

The related adjustment for this performance test is "Frequency Response."

Analyzers with 75 Ω inputs are tested down to 1 MHz only.

Equipment Required

Synthesized signal generator
Function generator
Power meter
RF power sensor, (2 required)
RF Power splitter
Digital multimeter
Adapter, Type-N (m) to Type-N (m)
Adapter, Type-N (m) to BNC (f)
Dual banana plug to BNC (f)
BNC Tee (BNC f,m,f)
Cable, BNC, 120-cm (48-in) (2 required)
Cable, Type-N, 183-cm (72-in)
Termination, 50 Ω, BNC (m)

Additional Equipment for 75 Ω Input

Power sensor, 75 Ω Minimum Loss Pad, Type-N (f) 75 Ω to Type-N (m) 50 Ω Adapter, Type-N (m) to BNC (m), 75 Ω

CAUTION

Use only 75 Ω cables, connectors, or adapters on instruments with 75 Ω connectors, or damage to the connectors will occur.

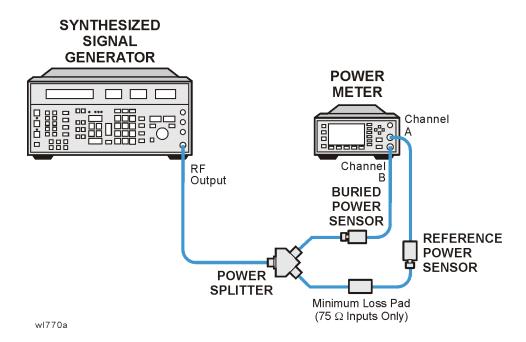
Procedure

Source/Splitter Characterization

1. Connect the equipment as shown in Figure 2-26. Connect one of the Agilent 8482A power sensors to Channel A of the power meter. This will be the "reference" sensor. Connect the other Agilent 8482A power sensor to Channel B of the power meter. This will be the "buried" sensor.

75 Ω Inputs, Option 1DP: Connect the Agilent 8483A power sensor to Channel A of the power meter. This will be the "reference" sensor.

Figure 2-26 Source/Splitter Characterization Setup



- 2. Zero and calibrate both power sensors.
- 3. On the power meter, set the Channel A calibration factor to the

22. Frequency Response: Agilent E4401B and E4411B

calibration factor of the reference sensor for 100 kHz.

75 Ω Inputs, Option 1DP: Use the calibration factor of the reference sensor for 1 MHz.

- 4. On the power meter, set the Channel B calibration factor to 100%. Do not change this calibration factor during this test.
- 5. Set the source frequency to 100 kHz and amplitude to -4 dBm.
 - 75 Ω Inputs, Option 1DP: Set the source frequency to 1 MHz and amplitude to 2 dBm.
- 6. Adjust the source amplitude to obtain a Channel A power meter reading of -10 dBm ± 0.1 dB.
- 7. Record the source amplitude setting, and both the Channel A and Channel B power meter readings in Table 2-40.
- 8. Tune the source to the next frequency in Table 2-40.
- 9. On the power meter, set the Channel A calibration factor to the calibration factor of the reference sensor for the current source frequency.
- 10.Adjust the source amplitude to obtain a Channel A power meter reading of -10 dBm ± 0.1 dB.
- 11.Record the source amplitude setting, and both the Channel A and Channel B power meter readings in Table 2-40.
- 12. Repeat step 8 through step 11 for each frequency in Table 2-40.
- 13. For each entry in Table 2-40, calculate the Splitter Tracking Error as follows:

Splitter Tracking Error = Channel A Power – Channel B Power

For example, if Channel A Power is -10.05 dBm and Channel B Power is -10.23 dBm, the Splitter Tracking Error is 0.18 dB.

NOTE

Tracking errors are nominally –5.7 dB when using the minimum loss pad.

Table 2-40 Source/Splitter Characterization

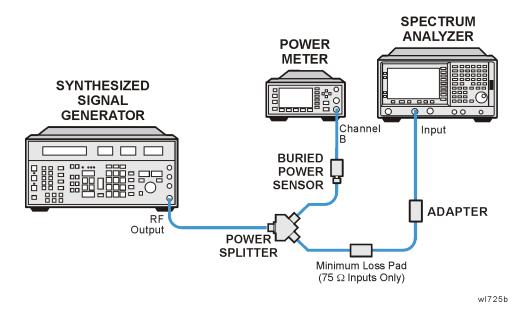
	Power Met	ter Reading	Splitter	Source	
Frequency	Channel A (dBm)	Channel B (dBm)	Tracking Error (dB)	Power Setting (dBm)	
100 kHz ^a					
500 kHz ^a					
1 MHz					
5 MHz					
10 MHz					
20 MHz					
50 MHz					
75 MHz					
175 MHz					
275 MHz					
375 MHz					
475 MHz					
575 MHz					
675 MHz					
775 MHz					
825 MHz					
875 MHz					
925 MHz					
975 MHz					
1025 MHz					
1075 MHz					
1175 MHz					
1275 MHz					
1375 MHz					
1500 MHz					

a. These values do not apply to analyzers with 75 Ω inputs (Option 1DP).

Measuring Frequency Response, 100 kHz to 1.5 GHz

1. Refer to Figure 2-27. Remove the reference sensor (Channel A sensor) from the power splitter. Connect the power splitter to the analyzer 50Ω Input using an adapter. Do not use a cable.

Figure 2-27 Frequency Response Test Setup, 100 kHz to 1.5 GHz



75 Ω inputs, Option 1DP: Connect the power splitter to the analyzer 75 Ω Input using a mechanical adapter and a 75 Ω , Type-N(m) to BNC(m) adapter.

- 2. Set the source frequency to 100 kHz:
 - 75 Ω inputs, Option 1DP: Set the source frequency to 1 MHz.
- 3. Set the source amplitude to the value corresponding to the source power setting in Table 2-41 for the current source frequency (100 kHz or 1 MHz).
- 4. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the controls as follows:

FREQUENCY, Center Freq, 100 kHz ($50~\Omega~\mathrm{Input}$) FREQUENCY, Center Freq, 1 MHz ($75~\Omega~\mathrm{Input}$) CF Step, 100 MHz SPAN, 20 kHz AMPLITUDE, More, Int Preamp (Off) (Option~1DS~only) AMPLITUDE, More, Y Axis Units (or Amptd Units), dBm AMPLITUDE, Ref Level, –5 dBm Attenuation, 10 dB (Man) Scale/Div, 1 dB BW/Avg, Res BW, 3 kHz (Man)

Video BW, 3 kHz (Man)

- 5. Adjust the source AMPLITUDE to obtain the Channel B power meter reading recorded in Table 2-40 \pm 0.1 dB.
- 6. Record the current Channel B power reading in Table 2-41 as the Current Channel B reading.
- 7. On the analyzer, press Single then Peak Search (or Search).
- 8. Record the marker (Mkr1) amplitude reading in Table 2-41.
- 9. Set the source to the next frequency listed in Table 2-41.
- 10.Set the analyzer center frequency to the next frequency listed in Table 2-41.
- 11.Adjust the source AMPLITUDE to obtain the Channel B power meter reading recorded in Table 2-40 ± 0.1 dB for the current frequency.
- 12.Record the current Channel B power meter reading in Table 2-41 as the Current Channel B Reading.
- 13.On the analyzer, press Single then Peak Search (or Search).
- 14.Record the marker (Mkr1) amplitude reading in Table 2-41.
- 15.Repeat step 9 through step 14 for each frequency in Table 2-41.
- 16.Copy the splitter tracking errors from Table 2-40 into Table 2-41.
- 17.Calculate the Flatness Error for each frequency in Table 2-41 as follows:

Flatness Error =	: Mkrl Amptd _{dBm}	 Current Channel 	l B _{dBm} – Splitter	Tracking Error _d
------------------	-----------------------------	-------------------------------------	-------------------------------	-----------------------------

For example, if marker (Mkr1) Amptd is -10.32 dBm, Current Channel B is -10.2 dBm and Splitter Tracking Error is 0.18 dB, Flatness Error would be -0.30 dB.

18.Record	the F	'latness	Error	for 5	50 I	MHz	below	as	$_{ m the}$	50	MHz
Ref Am	iptd:										

Hz Ref Ampt	t.d	Hz Ref	60
-------------	-----	--------	----

19.Calculate the Flatness Relative to 50 MHz for each frequency in Table 2-41 as follows:

Flatness Relative to 50 MHz = Flatness Error – 50 MHz Ref Amptd

For example, if Flatness Error is -0.30 dB and 50 MHz Ref Amptd is

 $0.15~\mathrm{dB},$ Flatness Relative to 50 MHz would be $-0.45~\mathrm{dB}.$

Table 2-41 Frequency Response Worksheet, 100 kHz to 1.5 GHz

Frequency	Current Channel B Reading	Marker (Mkr1) Amplitude	Splitter Tracking Error	Flatness Error	Flatness Relative to 50 MHz
100 kHz ^a					
500 kHz ^a					
1 MHz					
5 MHz					
10 MHz					
20 MHz					
50 MHz					
75 MHz					
175 MHz					
275 MHz					
375 MHz					
475 MHz					
575 MHz					
675 MHz					
775 MHz					
825 MHz					
875 MHz					
925 MHz					
975 MHz					
1025 MHz					
1075 MHz			_		
1175 MHz					
1275 MHz					
1375 MHz	_		_		
1500 MHz					

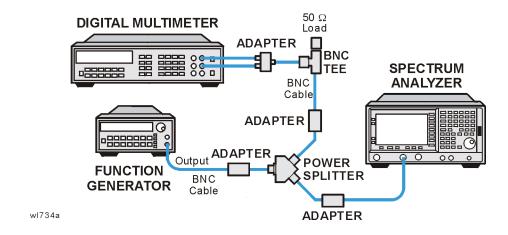
a. These values do not apply to analyzers with 75 Ω inputs (Option 1DP).

Measuring Frequency Response, ≤100 kHz

If the analyzer has Option 1DP, skip to the Test Results section.

1. Connect the equipment as shown in Figure 2-28.

Figure 2-28 Frequency Response Test Setup, ≤100 kHz



2. Set the function generator controls as follows:

FREQUENCY, 100 kHz AMPLITUDE, -4 dBm

3. Set the DVM as follows:

Function	Synchronous ac Volts
Math	dBm
RES Register	50 Ω
Front/Rear Terminals	Front
Range	Auto

- 4. On the analyzer, press **FREQUENCY**, **100** kHz.
- 5. Adjust the function generator amplitude until the DVM reading is $-10~dBm~\pm0.1~dB$.
- 6. Record the actual DVM reading in Table 2-42 as the DVM amplitude reading.
- 7. On the analyzer, press Peak Search (or Search), Marker, Delta.
- 8. Set the analyzer center frequency to the next frequency listed in Table 2-42.
- 9. Set the function generator frequency to the next frequency listed in Table 2-42.

22. Frequency Response: Agilent E4401B and E4411B

- 10.On the analyzer, press Peak Search (or Search).
- 11.Adjust the function generator amplitude until the marker delta (Δ Mkr1) amplitude reads 0 dB ± 0.05 dB.
- 12.Record the DVM reading in Table 2-42 as the DVM amplitude reading.
- 13. Repeat step 8 through step 12 for each frequency in Table 2-42.
- 14.For each of the frequencies in Table 2-42, subtract the DVM amplitude from the DVM Amplitude at 100 kHz recorded in step 6. Record the result as the Response Relative to 100 kHz in Table 2-42.
- 15.From Table 2-41, note the Flatness Relative to 50 MHz for the 100 kHz frequency. Record this below as the 100 kHz error relative to 50 MHz:

100 kHz Error Relative to 50 MHz _____ dE

16.Add the 100 kHz error relative to 50 MHz that was recorded in step 15 above to each of the Response Relative to 100 kHz entries in Table 2-42. Record the results as the Response Relative to 50 MHz in Table 2-42.

Table 2-42 Frequency Response Worksheet, ≤100 kHz

Frequency	DVM Amplitude	Response Relative to 100 kHz	Response Relative to 50 MHz
100 kHz		0 dB (Ref)	
75 kHz			
50 kHz			
20 kHz			
9 kHz			

Test Results

	350 11054115
1.	Enter the most positive number from the Flatness Relative to 50 MHz column of Table 2-41:
	dB
2.	Enter the most positive number from the Response Relative to 50 MHz column of Table 2-42:
	dB
	75 Ω inputs, Option 1DP: The frequency range below 100 kHz was not tested; no entry from Table 2-42 is necessary.

3. Record the more positive of numbers from step 1 and step 2 in Table 2-43 as the Maximum Response for Band 0.

4.	Enter the most negative number from the Flatness Relative to 50 MHz column of Table 2-41:
	dB
5.	Enter the most negative number from the Response Relative to 50 MHz column of Table 2-42:
	dB
	75 O inpute Ontion 1DP: The frequency range helow 100 hHz was n

75 Ω inputs, Option 1DP: The frequency range below 100 kHz was not tested; no entry from Table 2-42 is necessary.

- 6. Record the more negative of numbers from step 4 and step 5 in Table 2-43 as the Minimum Response for Band 0.
- 7. Subtract the Minimum Response for Band 0 from the Maximum Response for Band 0 and record the result as the Peak-to-Peak Response for Band 0 in Table 2-43.

Table 2-43 Frequency Response Results

	Maximum Response		Minimum Response		Peak-to-Peak Response	
Band	dB	Test Record Entry	dB	Test Record Entry	dB	Test Record Entry
0		1)		2)		3)

23. Frequency Response, Agilent E4402B and E4403B

This test measures the amplitude error of the analyzer as a function of frequency. To measure frequencies of 100 kHz and greater, the output of a source is fed through a power splitter to a power sensor and the analyzer. A function generator is used as the source from 100 kHz to 10 MHz, and a synthesized sweeper at 10 MHz and greater. To measure frequencies below 100 kHz, a DVM with a 50 Ω load replaces the power sensor.

For improved amplitude accuracy the power splitter is characterized using a "reference" sensor connected to one power splitter output port. The other power splitter output port connects to the "buried" sensor; it is not removed from the power splitter. Once the characterization is done, the reference sensor is removed and replaced by the analyzer. Measurements are made at the same frequencies used in the characterization. The analyzer marker amplitude measurements are corrected using the characterization data to determine the absolute flatness error and the flatness error relative to 50 MHz.

This procedure does not test frequency response with the optional preamplifier (Option 1DS) turned on. If the analyzer is equipped with Option 1DS, also perform the "Frequency Response, Preamp On" procedure. Analyzers with Option UKB are tested down to 100 Hz in dc coupled mode. In ac coupled mode, Agilent E4402B analyzers are tested down to 100 kHz.

The related adjustment for this performance test is "Frequency Response."

Equipment Required

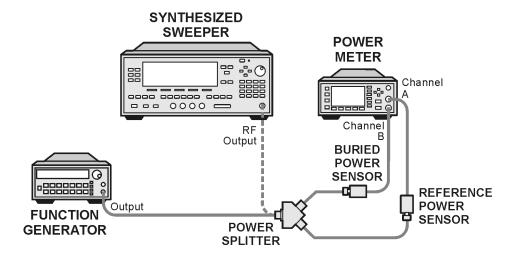
Synthesized sweeper
Function generator
Power meter
RF power sensor (2 required)
RF Power splitter
Digital multimeter
Adapter, Type-N (m) to Type-N (m)
Adapter, Type-N (m) to BNC (f)
Dual banana plug to BNC (f)
BNC Tee (BNC f,m,f)
Cable, BNC, 122-cm (48-in) (2 required)
Cable, Type-N, 183-cm (72-in)
Termination, 50 Ω, BNC (m)

Procedure

Source/Splitter Characterization

1. Connect the equipment as shown in Figure 2-29; use the function generator as the source. Connect one of the Agilent 8482A power sensors to Channel A of the power meter. This will be the "reference" sensor. Connect the other Agilent 8482A power sensor to Channel B of the power meter. This will be the "buried" sensor.

Figure 2-29 Source/Splitter Characterization Setup



wl713b

- 2. Zero and calibrate both power sensors.
- 3. On the power meter, set the Channel A calibration factor to the calibration factor of the reference sensor for 100 kHz.
- 4. On the power meter, set the Channel B calibration factor to 100%. Do not change this calibration factor during this test.
- 5. Set the function generator frequency to 100 kHz and amplitude to -4 dBm.
- 6. Adjust the function generator amplitude to obtain a Channel A power meter reading of -10 dBm ± 0.1 dB.
- 7. Record the function generator amplitude setting, and both the Channel A and Channel B power meter readings in Table 2-44.
- 8. Tune the source to the next frequency in Table 2-44.
- 9. On the power meter, set the Channel A calibration factor to the calibration factor of the reference sensor for the current source frequency.

23. Frequency Response, Agilent E4402B and E4403B

- 10.Adjust the source amplitude to obtain a Channel A power meter reading of -10 dBm ± 0.1 dB.
- 11.Record the source amplitude setting, and both the Channel A and Channel B power meter readings in Table 2-44.
- 12.Repeat step 8 through step 11 for frequencies up through 10 MHz.
- 13. Replace the function generator with the synthesized sweeper.
- 14.Set the synthesized sweeper CW frequency to 10 MHz and the amplitude to –4 dBm.
- 15.Adjust the synthesized sweeper power level to obtain a Channel A power meter reading of $-10 \text{ dBm} \pm 0.1 \text{ dB}$.
- 16.Record the synthesized sweeper power level and both the Channel A and Channel B power meter readings in Table 2-44.
- 17.Repeat step 8 through step 11 for each remaining frequency in Table 2-44.
- 18.For each entry in Table 2-44, calculate the Splitter Tracking Error as follows:

Splitter Tracking Error = Channel A Power – Channel B Power

For example, if Channel A Power is –10.05 dBm and Channel B Power is –10.23 dBm, the Splitter Tracking Error is 0.18 dB.

Table 2-44 Source/Splitter Characterization

Frequency	Power Met	er Reading	Splitter	Source Power
	Channel A	Channel B	Tracking Error	Setting
100 kHz				
500 kHz				
1 MHz				
5 MHz				
10 MHz ^a				
10 MHz ^b				
20 MHz				0 dB (Ref)
50 MHz				
75 MHz				
175 MHz				
275 MHz				
375 MHz				

Table 2-44 Source/Splitter Characterization

T7	Power Met	er Reading	Splitter	Source
Frequency	Channel A	Channel B	Tracking Error	Power Setting
475 MHz				
575 MHz				
675 MHz				
775 MHz				
825 MHz				
875 MHz				
925 MHz				
975 MHz				
1025 MHz				
1075 MHz				
1175 MHz				
1275 MHz				
1375 MHz				
1500 MHz				
1525 MHz				
1625 MHz				
1675 MHz				
1725 MHz				
1775 MHz				
1825 MHz				
1875 MHz				
1925 MHz				
1975 MHz				
2025 MHz				
2125 MHz				
2325 MHz				
2525 MHz				
2725 MHz				

Table 2-44 Source/Splitter Characterization

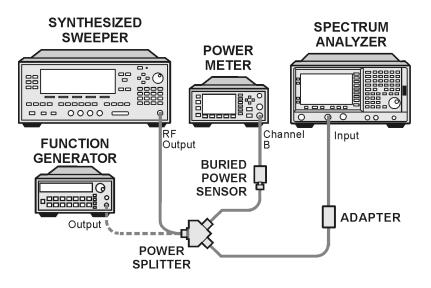
Frequency	Power Met	ter Reading	Splitter Tracking	Source Power Setting		
	Channel A	Channel B	Error			
2925 MHz						
2999 MHz						

- a. This entry is for data taken with the function generator as
- b. This entry is for data taken with the synthesized sweeper as source.

Measuring Frequency Response, 100 kHz to 3.0 GHz

1. Refer to Figure 2-30. Remove the reference sensor (Channel A sensor) from the power splitter. Connect the power splitter to the 50 Ω Input of the analyzer using an adapter. Do not use a cable.

Figure 2-30 Frequency Response Test Setup, 100 kHz to 3.0 GHz



wl716b

- 2. Set the source frequency to 10 MHz.
- 3. Set the source power level to the value corresponding to the source power setting in Table 2-44 for the current source frequency (10 MHz).
- 4. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the controls as follows:

FREQUENCY, Center Freq, 10 MHz

CF Step, 100 MHz
SPAN, 20 kHz
Input/Output (or Input), Coupling (DC) (Agilent E4402B, Option UKB only)
AMPLITUDE, More, Int Preamp, (Off) (Option 1DS only)
AMPLITUDE, More, Y Axis Units (or Amptd Units), dBm
AMPLITUDE, Ref Level, -5 dBm
Attenuation, 10 dB (Man)
Scale/Div, 1 dB
BW/Avg, Res BW, 3 kHz (Man)
Video BW, 3 kHz (Man)

- 5. Adjust the source power level to obtain the Channel B power meter reading recorded in Table $2-44 \pm 0.1$ dB.
- 6. Record the current Channel B power reading in Table 2-45 as the Current Channel B Reading for dc (coupling).
- 7. On the analyzer, press Single then Peak Search (or Search).
- 8. Record the marker (Mkr1) amplitude reading in Table 2-45 for dc (coupling).
- 9. Set the source to the next frequency listed in Table 2-45.
- 10.Set the analyzer center frequency to the next frequency listed in Table 2-45.
- 11.Adjust the source power level to obtain the Channel B power meter reading recorded in Table 2-45 ±0.1 dB for the current frequency.
- 12.Record the current Channel B power reading in Table 2-45 as the current Channel B reading.
- 13.On the analyzer, press Single then Peak Search (or Search).
- 14.Record the marker (Mkr1) amplitude reading in Table 2-45.
- 15.Repeat step 9 through step 14 for each remaining frequency in Table 2-45.
- 16. Replace the synthesized sweeper with the function generator.
- 17.Set the function generator amplitude to –4 dBm.
- 18.Set the function generator frequency to 100 kHz.
- 19.On the analyzer, press FREQUENCY, Center Freq, 100 kHz.
- 20.Adjust the function generator amplitude to obtain the Channel B power meter reading recorded in Table 2-44 ±0.1 dB for 100 kHz.
- 21.Record the current Channel B power reading in Table 2-45 as the current Channel B reading.
- 22.On the analyzer, press Single then Peak Search (or Search).
- 23.Record the analyzer marker (Mkr1) Amplitude Reading in Table 2-45

23. Frequency Response, Agilent E4402B and E4403B

as marker (Mkr1) Amplitude.

- 24.Repeat step 18 through step 23 for frequencies between 100 kHz and 10 MHz.
- 25. Copy the Splitter Tracking Errors from Table 2-44 into Table 2-45.
- 26.Calculate the Flatness Error for each frequency in Table 2-45 as follows:

```
Flatness Error = Mkr1 Amptd_{dBm} - Current Channel B_{dBm} - Splitter Tracking Error<sub>dB</sub>
```

For example, if marker (Mkr1) Amptd is -10.32 dBm, Current Channel B is -10.2 dBm and Splitter Tracking Error is 0.18 dB, Flatness Error would be -0.30 dB.

- 27.Record the Flatness Error for 50 MHz below as the 50 MHz Ref Amptd:
 - 50 MHz Ref Amptd: _____
- 28.Calculate the setup change error (error due to changing the test setup from using a synthesized sweeper to using a function generator) as follows:
 - a. Record the Flatness Error from Table 2-45 at 10 MHz using the function generator as FlatError_{FG}:

b. Record the Flatness Error from Table 2-45 at 10 MHz using the synthesized sweeper as FlatError_{SS}:

c. Subtract FlatError $_{\rm SS}$ from FlatError $_{\rm FG}$ and record the result as the Setup Change Error:

29.For frequencies less than 10 MHz calculate the Flatness Relative to 50 MHz for each frequency in Table 2-45 as follows:

Flatness Relative to 50 MHz = Flatness Error – 50 MHz Ref Amptd – Setup Change Error

For example, if Flatness Error is -0.30 dB, 50 MHz Ref Amptd is 0.15 dB and Setup Change Error is -0.19 dB, Flatness Relative to 50 MHz would be -0.26 dB.

30.For frequencies 10 MHz and greater, calculate the Flatness Relative to 50 MHz for each frequency in Table 2-45 as follows:

Flatness Relative to 50 MHz = Flatness Error – 50 MHz Ref Amptd

For example, if Flatness Error is -0.30 dB and 50 MHz Ref Amptd is 0.15 dB, Flatness Relative to 50 MHz would be -0.45 dB.

- 31.If the analyzer has Option UKB, continue with this procedure. Otherwise, perform the procedure in "Measuring Frequency Response Less Than or Equal to 100 kHz."
- 32. Replace the function generator with the synthesized sweeper.
- 33.Set the source frequency to 10 MHz and the source power level to the value corresponding to the source power setting in Table 2-44 for the current source frequency (10 MHz).
- 34. For an Agilent E4402B only, press Input/Output (or Input), Coupling (AC) on the analyzer.
- 35.For an Agilent E4402B only, repeat step 5 through step 30 for ac coupling.
- 36. Perform the procedure in "Measuring Frequency Response Less Than or Equal to 100 kHz."

Table 2-45 Frequency Response Worksheet, 100 kHz to 3.0 GHz

Freq. (MHz)	Splitter Tracking Error	Current Channel B Reading		Marker (Mkr1) Amptd		Flatness Error		Flatness Relative to 50 MHz	
		dc	ac	dc	ac	dc	ac	dc	ac
0.1									
0.5									
1									
5									
10 ^a									
10 ^b									
20									
50								0 dB (ref)	0 dB (ref)
75									
175									
275									
375									
475									

Table 2-45 Frequency Response Worksheet, 100 kHz to 3.0 GHz

Freq. (MHz)	Splitter Tracking Error	Current Channel B Reading		Marker (Mkr1) Amptd		Flatness Error		Flatness Relative to 50 MHz	
		dc	ac	dc	ac	dc	ac	dc	ac
575									
675									
775									
825									
875									
925									
975									
1025									
1075									
1175									
1275									
1375									
1500									
1525									
1625									
1675									
1725									
1775									
1825									
1875									
1925									
1975									
2025									
2125									
2325									
2525									
2725									

Table 2-45 Frequency Response Worksheet, 100 kHz to 3.0 GHz

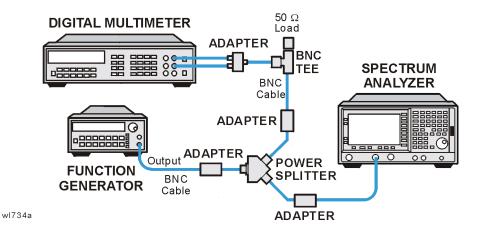
Freq. (MHz)	Splitter Tracking Error	Chan	rent nel B ding	Marker (Mkr1) Amptd		Flatness Error		Flatness Relative to 50 MHz	
		dc	ac	de	ac	de	ac	dc	ac
2925									
2999									

- a. This entry is for data taken with the function generator as source.
- b. This entry is for data taken with the synthesized sweeper as source.

Measuring Frequency Response Less Than or Equal to 100 kHz

1. Connect the equipment as shown in Figure 2-31.

Figure 2-31 Frequency Response Test Setup, ≤100 kHz



2. Set the function generator controls as follows:

FREQUENCY, 100 kHz AMPLITUDE, -4 dBm Amptd Increment, 0.05 dB

3. Set the DVM as follows:

Function	Synchronous AC Volts
Math	dBm
RES Register	$50~\Omega$
Front/Rear Terminals	Front
Range	Auto

- 4. On the analyzer, press **FREQUENCY**, **100** kHz.
- If the analyzer has Option UKB, press Input/Output (or Input),
 Coupling (DC). Then press SPAN, 100 Hz, BW/Avg, Res BW, 10 Hz, Video BW, 10 Hz.
- 6. Adjust the function generator amplitude until the DVM reading is $-10 \text{ dBm} \pm 0.1 \text{ dB}$.
- 7. Record the actual DVM reading in Table 2-46 as the DVM Amplitude reading.
- 8. On the analyzer, press Peak Search (or Search), Marker, Delta.
- 9. Set the analyzer center frequency to the next frequency listed in Table 2-46.
- 10.Set the function generator frequency to the next frequency listed in

Table 2-46. Frequencies less than 9 kHz only apply to analyzers with Option UKB.

- 11.On the analyzer, press Peak Search (or Search).
- 12.Adjust the function generator amplitude until the marker delta (Δ Mkr1) amplitude reads 0 dB \pm 0.05 dB.
- 13.Record the DVM reading in Table 2-46 as the DVM Amplitude reading.
- 14.Repeat step 9 through step 13 for each frequency setting listed in Table 2-46.
- 15.For each of the frequencies in Table 2-46, subtract the DVM Amplitude from the DVM Amplitude at 100 kHz recorded in step 7. Record the result as the Response Relative to 100 kHz in Table 2-46.
- 16.From Table 2-45, note the Flatness Relative to 50 MHz for the 100 kHz frequency. Record this below as the 100 kHz Error Relative to 50 MHz:

100 kHz Error Relative to 50 MHz = dB

17.Add the 100 kHz Error Relative to 50 MHz that was recorded in step 16 above to each of the Response Relative to 100 kHz entries in Table 2-46. Record the results as the Response Relative to 50 MHz in Table 2-46.

Table 2-46 Frequency Response Worksheet, ≤100 kHz

Frequency	DVM Amplitude	Response Relative to 100 kHz	Response Relative to 50 MHz
100 kHz		0 dB (Ref)	
75 kHz			
50 kHz			
20 kHz			
9 kHz			
5 kHz ^a			
2 kHz ^a			
1 kHz ^a			
500 Hz ^a			
200 Hz ^a			
100 Hz ^a			

a. These frequencies apply only to analyzers with Option UKB.

Test Results

Perform the following steps to verify the frequency response of the analyzer.

1.	Enter the most positive number from the Flatness Relative to 50 MHz (dc) column of Table 2-45:
	dB
2.	Enter the most positive number from the Response Relative to 50 MHz column of Table 2-46:
	dB
3.	Record the most positive of numbers from step 1 and step 2 into Table 2-47 as the Maximum Response for Band 0.
4.	Enter the most negative number from the Flatness Relative to 50 MHz (dc) column of Table 2-45:
	dB
5.	Enter the most negative number from the Response Relative to 50 MHz column of Table 2-46:
	dB

- 6. Record the most negative of numbers from step 4 and step 5 into Table 2-47 as the Minimum Response for Band 0.
- 7. For Band 0 in Table 2-47, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 8. If the analyzer is an Agilent E4403B or an E4402B with a serial number less than US39441006 then transfer the values in Table 2-47 into the test record in this guide. The frequency response test is complete for those instruments only.
- 9. If the analyzer has Option UKB then perform step 18 through step 27. Otherwise, perform step 10 through step 16.
- 10.Note the most positive number from the Flatness Relative to 50 MHz (dc) column of Table 2-45 for frequencies between 800 MHz and 1.0 GHz. Record this number in Table 2-47 as the Maximum Response for Band 0A.
- 11.Note the most negative number from the Flatness Relative to 50 MHz (dc) column of Table 2-45 for frequencies between 800 MHz and 1.0 GHz. Record this number in Table 2-47 as the Minimum Response for Band 0A.
- 12.For Band 0A in Table 2-47, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.

- 13.Note the most positive number from the Flatness Relative to 50 MHz (dc) column of Table 2-45 for frequencies between 1.7 GHz and 2.0 GHz. Record this number in Table 2-47 as the Maximum Response for Band 0B.
- 14.Note the most negative number from the Flatness Relative to 50 MHz (dc) column of Table 2-45 for frequencies between 1.7 GHz and 2.0 GHz. Record this number in Table 2-47 as the Minimum Response for Band 0B.
- 15.For Band 0B in Table 2-47, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 16.Transfer the values entered in Table 2-47 to the test record in this guide.
- 17. The frequency response test for analyzers without Option UKB is now complete. The following steps apply only to analyzers having Option UKB.
- 18.Record the most positive number from the Flatness Relative to 50 MHz (ac) column of Table 2-45 as the Maximum Response for Band 0 in Table 2-48.
- 19.Record the most negative number from the Flatness Relative to 50 MHz (ac) column of Table 2-45 as the Minimum Response for Band 0 in Table 2-48.
- 20.For Band 0 in Table 2-48, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 21.Note the most positive number from the Flatness Relative to 50 MHz (ac) column of Table 2-45 for frequencies between 800 MHz and 1.0 GHz. Record this number in Table 2-48 as the Maximum Response for Band 0A.
- 22.Note the most negative number from the Flatness Relative to 50 MHz (ac) column of Table 2-45 for frequencies between 800 MHz and 1.0 GHz. Record this number in Table 2-48 as the Minimum Response for Band 0A.
- 23.For Band 0A in Table 2-48, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 24.Note the most positive number from the Flatness Relative to 50 MHz (ac) column of Table 2-45 for frequencies between 1.7 GHz and 2.0 GHz. Record this number in Table 2-48 as the Maximum Response for Band 0B.
- 25.Note the most negative number from the Flatness Relative to 50 MHz (ac) column of Table 2-45 for frequencies between 1.7 GHz

23. Frequency Response, Agilent E4402B and E4403B

- and 2.0 GHz. Record this number in Table 2-48 as the Minimum Response for Band 0B.
- 26.For Band 0B in Table 2-48, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 27.Transfer the values entered in Table 2-48 to the test record in this guide.
- 28. The frequency response test for analyzers with Option UKB is now complete.

Table 2-47 Frequency Response Results, dc Coupled

Band	Maximum Response		Minimum Response		Peak-to-Peak Response	
	dB	Test Record Entry	dB	Test Record Entry	dB	Test Record Entry
0		1)		2)		3)
0A		4)		5)		6)
0B		7)		8)		9)

Table 2-48 Frequency Response Results, ac Coupled

	Maximum Response		Minimum	Response	Peak-to-Peak Response	
Band	dB	Test Record Entry	dB	Test Record Entry	dB	Test Record Entry
0		10)		11)		12)
0A		13)		14)		15)
0B		16)		17)		18)

24. Frequency Response, Agilent E4404B, E4405B, E4407B, and E4408B

This test measures the amplitude error of the analyzer as a function of frequency. To measure frequencies of 100 kHz and greater, the output of a source is fed through a power splitter to a power sensor and the analyzer. A function generator is used as the source from 100 kHz to 10 MHz, and a synthesized sweeper at 10 MHz and greater. To measure frequencies below 100 kHz, a DVM with a 50 Ω load replaces the power sensor.

For improved amplitude accuracy the power splitter is characterized using a "reference" sensor connected to one power splitter output port. The other power splitter output port connects to the "buried" sensor; it is not removed from the power splitter. Once the characterization is done, the reference sensor is removed and replaced by the analyzer. Measurements are made at the same frequencies used in the characterization. The analyzer marker amplitude measurements are corrected using the characterization data to determine the absolute flatness error and the flatness error relative to 50 MHz.

To measure frequencies greater than 3 GHz, the source power level is adjusted at 50 MHz to place the displayed signal at the analyzer center horizontal graticule line. The power meter is then set to measure dB relative to the power at 50 MHz. At each new source frequency and analyzer center frequency, the source power level is adjusted to place the signal at the center horizontal graticule line. The power meter displays the inverse of the frequency response relative to 50 MHz.

This procedure does not test frequency response with the optional preamplifier (Option 1DS) turned on. If the analyzer is equipped with a preamplifier, also perform the "Frequency Response, Preamp On" procedure. Analyzers with Option UKB are tested down to 100 Hz in dc coupled mode. In ac coupled mode, Agilent E4404B and E4405B analyzers are tested down to 100 kHz. Agilent E4407B analyzers with Option UKB are tested down to 10 MHz in ac coupled mode.

The related adjustment for this performance test is "Frequency Response."

Equipment Required

Synthesized sweeper
Function generator
Power meter
RF Power sensor (2 required)
Microwave power sensor
Microwave power splitter
Digital multimeter

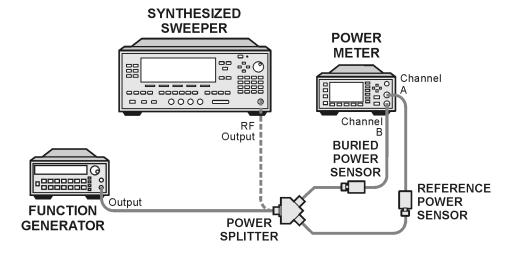
Adapter, APC 3.5 (f) to APC 3.5 (f) Adapter, Type-N (m) to Type-N (m) Adapter, Type-N (m) to BNC (f) Dual banana plug to BNC (f) BNC Tee (BNC f,m,f) Cable, BNC, 122-cm (48-in) (2 required) Cable, APC 3.5 Termination, 50 Ω, BNC (m)

Procedure

Source/Splitter Characterization

1. Connect the equipment as shown in Figure 2-32. Use the function generator as the source. Connect one of the Agilent 8482A power sensors to Channel A of the power meter. This will be the "reference" sensor. Connect the other Agilent 8482A power sensor to Channel B of the power meter. This will be the "buried" sensor.

Figure 2-32 Source/Splitter Characterization Setup



wl713b

- 2. Zero and calibrate both power sensors.
- 3. On the power meter, set the Channel A calibration factor to the calibration factor of the reference sensor for 100 kHz.
- 4. On the power meter, set the Channel B calibration factor to 100%. Do not change this calibration factor during this test.
- 5. Set the function generator frequency to 100 kHz and amplitude to -4 dBm.
- 6. Adjust the function generator amplitude to obtain a Channel A

- power meter reading of -10 dBm ±0.1 dB.
- 7. Record the function generator amplitude setting, and both the Channel A and Channel B power meter readings in Table 2-49.
- 8. Tune the source to the next frequency in Table 2-49.
- 9. On the power meter, set the Channel A calibration factor to the calibration factor of the reference sensor for the current source frequency.
- 10. Adjust the source amplitude to obtain a Channel A power meter reading of -10 dBm ± 0.1 dB.
- 11.Record the source amplitude setting, and both the Channel A and Channel B power meter readings in Table 2-49.
- 12.Repeat step 8 through step 11 for frequencies up through 10 MHz.
- 13.Replace the function generator with the synthesized sweeper.
- 14.Set the synthesized sweeper CW frequency to 10 MHz and the amplitude to –4 dBm.
- 15.Adjust the synthesized sweeper power level to obtain a Channel A power meter reading of $-10 \text{ dBm } \pm 0.1 \text{ dB}$.
- 16.Record the synthesized sweeper power level and both the Channel A and Channel B power meter readings in Table 2-49.
- 17.Repeat step 8 through step 11 for each remaining frequency in Table 2-49.
- 18. For each entry in Table 2-49, calculate the Splitter Tracking Error as follows:

Splitter Tracking Error = Channel A Power – Channel B Power

For example, if Channel A Power is -10.05 dBm and Channel B Power is -10.23 dBm, the Splitter Tracking Error is 0.18 dB.

Table 2-49 Source/Splitter Characterization

Frequency	Power Met	ter Reading	Splitter Tracking	Source Power Setting	
Frequency	Channel A	Channel B	Error		
100 kHz					
500 kHz					
1 MHz					
5 MHz					
10 MHz ^a					
10 MHz ^b					

Table 2-49 Source/Splitter Characterization

Encourage	Power Met	er Reading	Splitter	Source Power
Frequency	Channel A	Channel B	Tracking Error	Setting
20 MHz				0 dB (Ref)
50 MHz				
75 MHz				
175 MHz				
275 MHz				
375 MHz				
475 MHz				
575 MHz				
675 MHz				
775 MHz				
825 MHz				
875 MHz				
925 MHz				
975 MHz				
1025 MHz				
1075 MHz				
1175 MHz				
1275 MHz				
1375 MHz				
1500 MHz				
1525 MHz				
1625 MHz				
1675 MHz				
1725 MHz				
1775 MHz				
1825 MHz				
1875 MHz				
1925 MHz				

Table 2-49 Source/Splitter Characterization

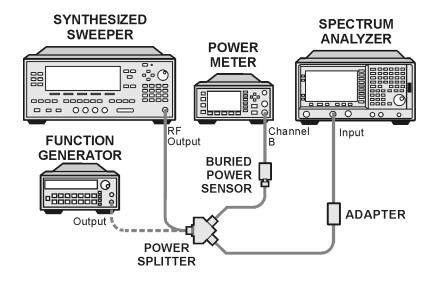
Frequency	Power Met	er Reading	Splitter Tracking	Source Power	
	Channel A	Channel A Channel B		Setting	
1975 MHz					
2025 MHz					
2125 MHz					
2325 MHz					
2525 MHz					
2725 MHz					
2925 MHz					
2999 MHz					

- a. This entry is for data taken with the function generator as source.
- b. This entry is for data taken with the synthesized sweeper as source.

Measuring Frequency Response, 100 kHz to 3.0 GHz

1. Refer to Figure 2-33. Remove the reference sensor (Channel A sensor) from the power splitter. Connect the power splitter to the 50 Ω Input of the analyzer using an adapter. Do not use a cable.

Figure 2-33 Frequency Response Test Setup, 100 kHz to 3.0 GHz



wl716b

- 24. Frequency Response, Agilent E4404B, E4405B, E4407B, and E4408B
- 2. Set the source frequency to 10 MHz.
- 3. Set the source power level to the value corresponding to the source power setting in Table 2-49 for the current source frequency (10 MHz).
- 4. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the controls as follows:

FREQUENCY, Center Freq, 10 MHz
CF Step, 100 MHz
SPAN, 20 kHz
Input/Output (or Input), Coupling (DC) (Agilent E4404B, E4405B, or any model with Option UKB)
AMPLITUDE, More, Int Preamp, (Off) (Option 1DS only)

AMPLITUDE, Ref Level, -5 dBm Attenuation, 10 dB (Man) Scale/Div, 1 dB BW/Avg, Res BW, 3 kHz (Man) Video BW, 3 kHz (Man)

- 5. Adjust the source power level to obtain the Channel B power meter reading recorded in Table 2-49 ± 0.1 dB.
- 6. Record the current Channel B power reading in Table 2-50 as the Current Channel B Reading for dc (coupling).
- 7. On the analyzer, press Single then Peak Search (or Search).
- 8. Record the marker (Mkr1) amplitude reading in Table 2-50 for dc (coupling).
- 9. Set the source to the next frequency listed in Table 2-50.
- 10.Set the analyzer center frequency to the next frequency listed in Table 2-50.
- 11.Adjust the source power level to obtain the Channel B power meter reading recorded in Table 2-49 ± 0.1 dB for the current frequency.
- 12.Record the current Channel B power reading in Table 2-50 as the current Channel B reading.
- 13.On the analyzer, press Single then Peak Search (or Search).
- 14.Record the marker (Mkr1) amplitude reading in Table 2-50.
- 15.Repeat step 9 through step 14 for each remaining frequency in Table 2-50.
- 16.If the analyzer under test is an Agilent E4407B with Option UKB and is being tested in ac coupled mode, continue with step 26. These analyzers are specified only down to 10 MHz in ac coupled mode.
- 17. Replace the synthesized sweeper with the function generator.

- 18.Set the function generator amplitude to -4 dBm.
- 19.Set the function generator frequency to 100 kHz.
- 20.On the analyzer, press FREQUENCY, Center Freq, 100 kHz.
- 21.Adjust the function generator amplitude to obtain the Channel B power meter reading recorded in Table 2-49 \pm 0.1 dB for 100 kHz.
- 22.Record the current Channel B power reading in Table 2-50 as the current Channel B reading.
- 23.On the analyzer, press Single then Peak Search (or Search).
- 24.Record the analyzer marker (Mkr1) Amplitude Reading in Table 2-50 as marker (Mkr1) Amplitude.
- 25.Repeat step 19 through step 24 for frequencies between 100 kHz and 10 MHz.
- 26. Copy the Splitter Tracking Errors from Table 2-49 into Table 2-50.
- 27.Calculate the Flatness Error for each frequency in Table 2-50 as follows:

```
Flatness Error = Mkr1 Amptd<sub>dBm</sub> - Current Channel B<sub>dBm</sub> - Splitter Tracking Error<sub>dB</sub>
```

For example, if marker (Mkr1) Amptd is -10.32 dBm, Current Channel B is -10.2 dBm and Splitter Tracking Error is 0.18 dB, Flatness Error would be -0.30 dB.

28.Record the Flatness Error for 50 MHz below as the 50 MHz Ref Amptd:

50 MHz Ref Amptd:	
-------------------	--

- 29.Continue with step 31 if the analyzer under test is an Agilent E4407B with Option UKB and is being tested in ac coupled mode. Calculate the setup change error (error due to changing the test setup from using a synthesized sweeper to using a function generator) as follows:
 - a. Record the Flatness Error from Table 2-50 at 10 MHz using the function generator as FlatError_{FG}:

$FlatError_{FG} = $	d	ŀ	Ľ
---------------------	---	---	---

b. Record the Flatness Error from Table 2-50 at 10 MHz using the synthesized sweeper as FlatError_{SS}:

c. Subtract FlatError_{SS} from FlatError_{FG} and record the result as the Setup Change Error:

Setup Change Error = $FlatError_{FG} - FlatError_{SS}$

24. Frequency Response, Agilent E4404B, E4405B, E4407B, and E4408B

Setup Change Error = dB

30.For frequencies less than 10 MHz calculate the Flatness Relative to 50 MHz for each frequency in Table 2-50 as follows:

Flatness Relative to 50 MHz = Flatness Error – 50 MHz Ref Amptd – Setup Change Error

For example, if Flatness Error is -0.30 dB, 50 MHz Ref Amptd is 0.15 dB and Setup Change Error is -0.19 dB, Flatness Relative to 50 MHz would be -0.26 dB.

31.For frequencies 10 MHz and greater, calculate the Flatness Relative to 50 MHz for each frequency in Table 2-50 as follows:

Flatness Relative to 50 MHz = Flatness Error – 50 MHz Ref Amptd

For example, if Flatness Error is -0.30 dB and 50 MHz Ref Amptd is 0.15 dB, Flatness Relative to 50 MHz would be -0.45 dB.

- 32.If the analyzer under test is an Agilent E4407B with Option UKB, E4404B or E4405B, continue with this procedure. Otherwise, perform the procedure in "Measuring Frequency Response Less Than or Equal to 100 kHz."
- 33. Replace the function generator with the synthesized sweeper.
- 34.Set the source frequency to 10 MHz and the source power level to the value corresponding to the source power setting in Table 2-49 for the current source frequency (10 MHz).
- 35.On the analyzer, press Input/Output (or Input), Coupling (AC).
- 36. Repeat step 5 through step 31 for ac coupling.
- 37. Perform the procedure in "Measuring Frequency Response Less Than or Equal to 100 kHz."

Table 2-50 Frequency Response Worksheet, 100 kHz to 3.0 GHz

Freq. (MHz)	Splitter Tracking Error	Chan	rent nel B ding	Marker (Mkr1) Amptd		Flatness Error		Flatness Relative to 50 MHz	
		dc	ac	dc	ac	de	ac	dc	ac
0.1 ^a									
0.5 ^a									
1 ^a									
5 ^a									
10 ^{ab}									

Table 2-50 Frequency Response Worksheet, 100 kHz to 3.0 GHz

Freq. (MHz)	Splitter Tracking Error	Curr Chan Read	nel B		r (Mkr1) nptd	Flatness Error		Relat	ness tive to MHz
		dc	ac	dc	ac	dc	ac	dc	ac
10 ^c									
20									
50								0 dB (ref)	0 dB (ref)
75									
175									
275									
375									
475									
575									
675									
775									
825									
875									
925									
975									
1025									
1075									
1175									
1275									
1375									
1500									
1525									
1625									
1675									
1725									
1775									

Table 2-50 Frequency Response Worksheet, 100 kHz to 3.0 GHz

Freq. (MHz)	Splitter Tracking Error	Chan	rent inel B ding		(Mkr1) ptd	Flatnes	Flatness Error		Flatness Relative to 50 MHz	
		dc	ac	dc	ac	dc	ac	dc	ac	
1825										
1875										
1925										
1975										
2025										
2125										
2325										
2525										
2725										
2925										
2999										

a. This frequency is not tested on Agilent E4407B analyzers with Option UKB when in ac coupled mode.

b. This entry is for data taken with the function generator as source.

c. This entry is for data taken with the synthesized sweeper as source.

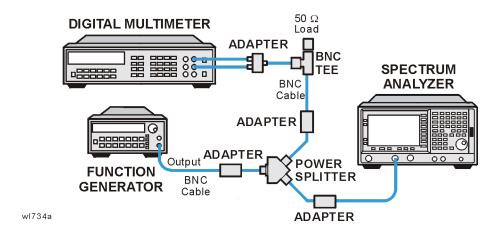
Measuring Frequency Response Less Than or Equal to 100 kHz

NOTE

Do not perform this procedure for Agilent E4407B analyzers having Option UKB in ac coupled mode.

1. Connect the equipment as shown in Figure 2-34.

Figure 2-34 Frequency Response Test Setup, ≤100 kHz



2. Set the function generator controls as follows:

FREQUENCY, 100 kHz AMPLITUDE, -4 dBm Amptd Increment, 0.05 dB

3. Set the DVM as follows:

Function	Synchronous AC Volts
Math	dBm
RES Register	$50~\Omega$
Front/Rear Terminals	Front
Range	Auto

- 4. On the analyzer, press FREQUENCY, 100 kHz.
- 5. If the analyzer under test is an Agilent E4407B with Option UKB, E4404B or E4405B, press Input/Output (or Input), Coupling (DC).
- 6. If the analyzer under test has Option UKB then press SPAN, 100 Hz, BW/Avg, Res BW, 10 Hz, Video BW, 10 Hz.
- 7. Adjust the function generator amplitude until the DVM reading is $-10 \text{ dBm} \pm 0.1 \text{ dB}$.
- 8. Record the actual DVM reading in Table 2-51 as the DVM Amplitude reading.

- 24. Frequency Response, Agilent E4404B, E4405B, E4407B, and E4408B
- 9. On the analyzer, press Peak Search (or Search), Marker, Delta.
- 10.Set the analyzer center frequency to the next frequency listed in Table 2-51.
- 11.Set the function generator frequency to the next frequency listed in Table 2-51. Frequencies less than 9 kHz only apply to analyzers with Option UKB.
- 12.On the analyzer, press Peak Search (or Search).
- 13.Adjust the function generator amplitude until the marker delta (Δ Mkr1) amplitude reads 0 dB ± 0.05 dB.
- 14.Record the DVM reading in Table 2-51 as the DVM Amplitude reading.
- 15.Repeat step 10 through step 14 for each frequency setting listed in Table 2-51.
- 16.For each of the frequencies in Table 2-51, subtract the DVM Amplitude from the DVM Amplitude at 100 kHz recorded in step 8. Record the result as the Response Relative to 100 kHz in Table 2-51.
- 17.From Table 2-50, note the Flatness Relative to 50 MHz for the 100 kHz frequency. Record this below as the 100 kHz Error Relative to 50 MHz:

.00 kHz Error Relative	to 50 MHz =	dE
------------------------	-------------	----

18.Add the 100 kHz Error Relative to 50 MHz that was recorded in step 17 above to each of the Response Relative to 100 kHz entries in Table 2-51. Record the results as the Response Relative to 50 MHz in Table 2-51.

Table 2-51 Frequency Response Worksheet, ≤100 kHz

Frequency	DVM Amplitude	Response Relative to 100 kHz	Response Relative to 50 MHz
100 kHz		0 dB (Ref)	
75 kHz			
50 kHz			
20 kHz			
9 kHz			
5 kHz ^a			
2 kHz ^a			
1 kHz ^a			

Table 2-51Frequency Response Worksheet, $\leq 100 \mathrm{\ kHz}$

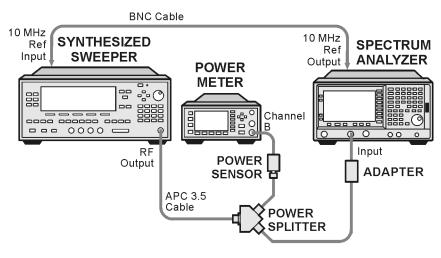
Frequency	DVM Amplitude	Response Relative to 100 kHz	Response Relative to 50 MHz
500 Hz ^a			
200 Hz ^a			
100 Hz ^a			

a. These frequencies apply only to analyzers with Option UKB.

Measuring Frequency Response, >3 GHz

- 1. Replace the Channel B power sensor with the microwave power sensor. Zero and calibrate the power sensor and power meter in log mode. Enter the 50 MHz calibration factor of the power sensor into the power meter.
- 2. Connect the equipment as shown in Figure 2-35.

Figure 2-35 Frequency Response Test Setup, >3 GHz



wl736a

- 3. If the analyzer is an Agilent E4407B with Option UKB, E4404B or E4405B, then press Input/Output (or Input), Coupling (DC). This sets the analyzer to dc coupled mode.
- 4. On the analyzer, press FREQUENCY, 50 MHz, CF Step 250 MHz.
- 5. Set the synthesized sweeper CW frequency to 50 MHz and FREQ STEP to 250 MHz.
- 6. Adjust the synthesized sweeper power level for a power meter reading of $-10 \text{ dBm} \pm 0.05 \text{ dB}$.
- 7. On the analyzer, press Peak Search (or Search).
- 8. On the analyzer, press Marker, Delta.
- 9. Activate the dB relative mode on the power meter. Power meter readings will now be displayed relative to the power meter reading at 50 MHz.
- 10.Set the synthesized sweeper CW frequency to the next frequency listed in Table 2-52.
- 11.Enter the appropriate power sensor calibration factor into the power meter.
- 12.On the analyzer, press Peak Search (or Search), Amplitude,

Presel Center.

- 13.Adjust the synthesized sweeper power level until the analyzer marker delta (Δ Mkr1) amplitude reading is 0 dB \pm 0.05 dB.
- 14.Record the *negative of the* power meter reading in Table 2-52 as the Flatness Relative to 50 MHz for dc coupled mode.

NOTE

Record this power meter reading as the negative, or opposite polarity from the measured value. For example, a measured value of -0.75 dB is recorded as +0.75 dB; a measured value of +0.25 dB is recorded as -0.25 dB.

If the analyzer is an Agilent E4407B without Option UKB, make all entries in the dc coupled column.

- 15.Repeat step 10 through step 14 for frequencies up through 6.699 GHz in Table 2-52. On the analyzer, pressing FREQUENCY, ↑ will allow you to step through most of the frequencies. Similarly, on the synthesized sweeper, pressing CW, ↑ will allow you to step through most of the frequencies.
- 16.If the analyzer is an Agilent E4404B, continue with the next step. Otherwise, continue with step 20.
- 17. On the analyzer, press Input/Output (or Input), Coupling (AC). This sets the analyzer to ac coupled mode.
- 18.Repeat step 4 through step 15, making entries in the ac Coupled column of Table 2-52.
- 19.Continue with "Agilent E4404B/E4405B Test Results" (for an Agilent E4404B only). The following steps apply to the Agilent E4405B, E4407B, and E4408B only.
- 20.Set the synthesized sweeper FREQ STEP to 400 MHz.
 - Set the analyzer center frequency step size to 400 MHz by manually pressing **FREQUENCY**, **CF Step**, 400 MHz.
- 21.Repeat step 10 through step 14 for frequencies up through 13.199 GHz in Table 2-52.
- 22.If the analyzer is an Agilent E4405B, continue with the next step. If the analyzer is an Agilent E4407B or E4408B, continue with step 27.
- 23. On the analyzer, press Input/Output (or Input), Coupling (AC). This sets the analyzer to ac coupled mode.
- 24.Repeat step 4 through step 15, making entries in the ac Coupled column of Table 2-52.
- 25.Set the synthesized sweeper FREQ STEP to 400 MHz.

Set the analyzer center frequency step size to 400 MHz by pressing **FREQUENCY, CF Step, 400 MHz**.

- 24. Frequency Response, Agilent E4404B, E4405B, E4407B, and E4408B
- 26.Repeat step 10 through step 14 for frequencies up through 13.199 GHz making entries in the ac Coupled column of Table 2-52.
- 27.Continue with "Agilent E4404B/E4405B Test Results" (for an Agilent E4405B only). The following steps apply to the Agilent E4407B and E4408B only.
- 28.Set the synthesized sweeper FREQ STEP to 500 MHz.
 - Set the analyzer center frequency step size to 500 MHz by pressing **FREQUENCY**, **CF Step**, **500 MHz**.
- 29.Repeat step 10 through step 14 for the remaining frequencies in Table 2-52. If the analyzer under test is an Agilent E4407B with Option UKB then continue with the next step. Otherwise, continue with "Agilent E4407B/E4408B Test Results" (for an Agilent E4407B or E4408B only).
- 30. On the analyzer, press Input/Output (or Input), Coupling (AC). This sets the analyzer to ac coupled mode.
- 31.Repeat step 4 through step 15, making entries in the ac Coupled column of Table 2-52.
- 32.Set the synthesized sweeper FREQ STEP to 400 MHz.
 - Set the analyzer center frequency step size by pressing **FREQUENCY**, **CF Step**, **400 MHz**.
- 33.Repeat step 10 through step 14 for the remaining frequencies in Table 2-52, making entries in the ac Coupled column.
- 34. Continue with "Agilent E4407B/E4408B Test Results."

Table 2-52 Frequency Response Worksheet, >3 GHz

Frequency	Flatness Relative to 50 MHz, dB		
	dc Coupled	ac Coupled	
3.05 GHz			
3.25 GHz			
3.5 GHz			
3.75 GHz			
4.0 GHz			
4.25 GHz			
4.5 GHz			
4.75 GHz			
5.0 GHz			

Table 2-52 Frequency Response Worksheet, >3 GHz

Frequency	Flatness Relative to 50 MHz, dB		
	dc Coupled	ac Coupled	
5.25 GHz			
5.5 GHz			
5.75 GHz			
6.0 GHz			
6.25 GHz			
6.5 GHz			
6.699 GHz			
End of worksheet red	ording for Agilent E440)4B	
6.8 GHz			
7.0 GHz			
7.4 GHz			
7.8 GHz			
8.2 GHz			
8.6 GHz			
9.0 GHz			
9.4 GHz			
9.8 GHz			
10.2 GHz			
10.6 GHz			
11.0 GHz			
11.4 GHz			
11.8 GHz			
12.2 GHz			
12.6 GHz			
12.8 GHz			
13.199 GHz			
End of worksheet red	ording for Agilent E440	05B	
13.3 GHz		_	

Table 2-52 Frequency Response Worksheet, >3 GHz

Frequency	Flatness Relative to 50 MHz, dB		
	dc Coupled	ac Coupled	
13.5 GHz			
14.0 GHz			
14.5 GHz			
15.0 GHz			
15.5 GHz			
16.0 GHz			
16.5 GHz			
17.0 GHz			
17.5 GHz			
18.0 GHz			
18.5 GHz			
19.0 GHz			
19.5 GHz			
20.0 GHz			
20.5 GHz			
21.0 GHz			
21.5 GHz			
22.0 GHz			
22.5 GHz			
23.0 GHz			
23.5 GHz			
24.0 GHz			
24.5 GHz			
25.0 GHz			
25.5 GHz			
26.0 GHz			
26.5 GHz			

Agilent E4404B/E4405B Test Results

Perform the following steps to verify the frequency response of the analyzer.

1.	Enter the most positive number from the Flatness Relative to 50 MHz (dc) column of Table 2-50:
	dB
2.	Enter the most positive number from the Response Relative to 50 MHz column of Table 2-51:
	dB
3.	Record the most positive of numbers from step 1 and step 2 in Table 2-53 as the Maximum Response for Band 0.
4.	Enter the most negative number from the Flatness Relative to 50 MHz (dc) column of Table 2-50:
	dB
5.	Enter the most negative number from the Response Relative to 50 MHz column of Table 2-51:
	dB
6.	Record the most negative of numbers from step 4 and step 5 in Table

- 6. Record the most negative of numbers from step 4 and step 5 in Table 2-53 as the Minimum Response for Band 0.
- 7. For Band 0 in Table 2-53, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 8. Note the most positive number from the Flatness Relative to 50 MHz (dc) column of Table 2-52 for frequencies between 3.0 GHz and 6.7 GHz. Record this number in Table 2-53 as the Maximum Response for Band 1.
- 9. Note the most negative number from the Flatness Relative to 50 MHz (dc) column of Table 2-52 for frequencies between 3.0 GHz and 6.7 GHz. Record this number in Table 2-53 as the Minimum Response for Band 1.
- 10.For Band 1 in Table 2-53, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 11. If the analyzer is an Agilent E4404B, then continue with step 15.
- 12.Note the most positive number from the Flatness Relative to 50 MHz (dc) column of Table 2-52 for frequencies between 6.7 GHz and 13.2 GHz. Record this number in Table 2-53 as the Maximum Response for Band 2.
- 13. Note the most negative number from the Flatness Relative to

- 50 MHz (dc) column of Table 2-52 for frequencies between 6.7 GHz and 13.2 GHz. Record this number in Table 2-53 as the Minimum Response for Band 2.
- 14.For Band 2 in Table 2-53, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 15.Record the most positive number from the Flatness Relative to 50 MHz (ac) column of Table 2-50 as the Maximum Response for Band 0 in Table 2-54.
- 16.Record the most negative number from the Flatness Relative to 50 MHz (ac) column of Table 2-50 as the Minimum Response for Band 0 in Table 2-54.
- 17.For Band 0 in Table 2-54, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 18.If the analyzer is an Agilent E4404B with a serial number less than US39440498 or an E4405B with a serial number less than US39440327, then continue with step 25.
- 19.Note the most positive number from the Flatness Relative to 50 MHz (ac) column of Table 2-50 for frequencies between 800 MHz and 1.0 GHz. Record this number in Table 2-54 as the Maximum Response for Band 0A.
- 20.Note the most negative number from the Flatness Relative to 50 MHz (ac) column of Table 2-50 for frequencies between 800 MHz and 1.0 GHz. Record this number in Table 2-54 as the Minimum Response for Band 0A.
- 21. For Band 0A in Table 2-54, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 22.Note the most positive number from the Flatness Relative to 50 MHz (ac) column of Table 2-50 for frequencies between 1.7 GHz and 2.0 GHz. Record this number in Table 2-54 as the Maximum Response for Band 0B.
- 23.Note the most negative number from the Flatness Relative to 50 MHz (ac) column of Table 2-50 for frequencies between 1.7 GHz and 2.0 GHz. Record this number in Table 2-54 as the Minimum Response for Band 0B.
- 24.For Band 0B in Table 2-54, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 25.Note the most positive number from the Flatness Relative to 50 MHz (ac) column of Table 2-52 for frequencies between 3.0 GHz and

- 6.7 GHz. Record this number in Table 2-54 as the Maximum Response for Band 1.
- 26.Note the most negative number from the Flatness Relative to 50 MHz (ac) column of Table 2-52 for frequencies between 3.0 GHz and 6.7 GHz. Record this number in Table 2-54 as the Minimum Response for Band 1.
- 27.For Band 1 in Table 2-54, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 28.If the analyzer is an Agilent E4404B then the frequency response test is complete; transfer the values entered in Table 2-54 to the test record in this guide. If the analyzer is an Agilent E4405B, continue this procedure.
- 29.Note the most positive number from the Flatness Relative to 50 MHz (ac) column of Table 2-52 for frequencies between 6.7 GHz and 13.2 GHz. Record this number in Table 2-54 as the Maximum Response for Band 2.
- 30.Note the most negative number from the Flatness Relative to 50 MHz (ac) column of Table 2-52 for frequencies between 6.7 GHz and 13.2 GHz. Record this number in Table 2-54 as the Minimum Response for Band 2.
- 31.For Band 2 in Table 2-54, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 32.Transfer the values entered in Table 2-54 to the test record in this guide.
- 33. The frequency response test for Agilent E4405B analyzers is now complete.

Table 2-53 Frequency Response Results, Agilent E4404B/E4405B, dc Coupled

	Maximum	Response	Minimum	Response	Peak-to-Peak Respons	
Band	dB	Test Record Entry	dB	Test Record Entry	dB	Test Record Entry
0		1)		2)		3)
1		4)		5)		6)
2		7)		8)		9)

Table 2-54 Frequency Response Results, Agilent E4404B/E4405B, ac Coupled

	Maximum	Response	Minimum	Response	Peak-to-Peak Response		
Band	dB	Test Record Entry	dB	Test Record Entry	dB	Test Record Entry	
0		10)		11)		12)	
0A		13)		14)		15)	
0B		16)		17)		18)	
1		19)		20)		21)	
2		22)		23)		24)	

Agilent E4407B/E4408B Test Results

Perform the following steps to verify the frequency response of the analyzer.

1.	Enter the most positive number from the Flatness Relative to 50 MHz (dc) column of Table 2-50:
	dB
2.	Enter the most positive number from the Response Relative to 50 MHz column of Table 2-51:
	dB
3.	Record the most positive of numbers from step 1 and step 2 in Table 2-55 as the Maximum Response for Band 0.
4.	Enter the most negative number from the Flatness Relative to 50 MHz (dc) column of Table 2-50:
	dB
5.	Enter the most negative number from the Response Relative to 50 MHz column of Table 2-51:
	dB
6.	Record the most negative of numbers from step 4 and step 5 in Table

- 6. Record the most negative of numbers from step 4 and step 5 in Table 2-55 as the Minimum Response for Band 0.
- 7. For Band 0 in Table 2-55, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 8. If the analyzer is an Agilent E4408B, an E4407B with Option UKB, or is an E4407B with a serial number less than US39440871, then

- continue with step 15.
- 9. Note the most positive number from the Flatness Relative to 50 MHz (dc) column of Table 2-50 for frequencies between 800 MHz and 1.0 GHz. Record this number in Table 2-55 as the Maximum Response for Band 0A.
- 10.Note the most negative number from the Flatness Relative to 50 MHz (dc) column of Table 2-50 for frequencies between 800 MHz and 1.0 GHz. Record this number in Table 2-55 as the Minimum Response for Band 0A.
- 11.For Band 0A in Table 2-55, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 12.Note the most positive number from the Flatness Relative to 50 MHz (dc) column of Table 2-50 for frequencies between 1.7 GHz and 2.0 GHz. Record this number in Table 2-55 as the Maximum Response for Band 0B.
- 13.Note the most negative number from the Flatness Relative to 50 MHz (dc) column of Table 2-50 for frequencies between 1.7 GHz and 2.0 GHz. Record this number in Table 2-55 as the Minimum Response for Band 0B.
- 14.For Band 0B in Table 2-55, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 15.Note the most positive number from the Flatness Relative to 50 MHz (dc) column of Table 2-52 for frequencies between 3.0 GHz and 6.7 GHz. Record this number in Table 2-55 as the Maximum Response for Band 1.
- 16.Note the most negative number from the Flatness Relative to 50 MHz (dc) column of Table 2-52 for frequencies between 3.0 GHz and 6.7 GHz. Record this number in Table 2-55 as the Minimum Response for Band 1.
- 17.For Band 1 in Table 2-55, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 18.Note the most positive number from the Flatness Relative to 50 MHz (dc) column of Table 2-52 for frequencies between 6.7 GHz and 13.2 GHz. Record this number in Table 2-55 as the Maximum Response for Band 2.
- 19.Note the most negative number from the Flatness Relative to 50 MHz (dc) column of Table 2-52 for frequencies between 6.7 GHz and 13.2 GHz. Record this number in Table 2-55 as the Minimum Response for Band 2.

- 20.For Band 2 in Table 2-55, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 21.Note the most positive number from the Flatness Relative to 50 MHz (dc) column of Table 2-52 for frequencies between 13.2 GHz and 26.5 GHz. Record this number in Table 2-55 as the Maximum Response for Band 3.
- 22.Note the most negative number from the Flatness Relative to 50 MHz (dc) column of Table 2-52 for frequencies between 13.2 GHz and 26.5 GHz. Record this number in Table 2-55 as the Minimum Response for Band 3.
- 23.For Band 3 in Table 2-55, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 24.Transfer the values entered in Table 2-55 to the test record in this guide.
- 25.If the analyzer is an Agilent E4407B with Option UKB, continue with this procedure. Otherwise, the frequency response test for Agilent E4407B or E4408B analyzers is now complete.

Table 2-55 Frequency Response Results, Agilent E4407B/E4408B, dc Coupled

	Maximum Response		Minimum Response		Peak-to-Peak Response	
Band	dB	Test Record Entry	dB	Test Record Entry	dB	Test Record Entry
0		1)		2)		3)
0A		4)		5)		6)
0B		7)		8)		9)
1		10)		11)		12)
2		13)		14)		15)
3		16)		17)		18)

Agilent E4407B, Option UKB Test Results

Perform the following steps to verify the frequency response of the analyzer.

- 1. Note the most positive of numbers from the Flatness Relative to 50 MHz (ac) column of Table 2-50. Record this number in Table 2-56 as the Maximum Response for Band 0.
- 2. Note the most negative of numbers from the Flatness Relative to 50

- MHz (ac) column of Table 2-50. Record this number in Table 2-56 as the Minimum Response for Band 0.
- 3. For Band 0 in Table 2-56, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 4. Note the most positive number from the Flatness Relative to 50 MHz (ac) column of Table 2-50 for frequencies between 800 MHz and 1.0 GHz. Record this number in Table 2-56 as the Maximum Response for Band 0A.
- 5. Note the most negative number from the Flatness Relative to 50 MHz (ac) column of Table 2-50 for frequencies between 800 MHz and 1.0 GHz. Record this number in Table 2-56 as the Minimum Response for Band 0A.
- 6. For Band 0A in Table 2-56, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 7. Note the most positive number from the Flatness Relative to 50 MHz (ac) column of Table 2-50 for frequencies between 1.7 GHz and 2.0 GHz. Record this number in Table 2-56 as the Maximum Response for Band 0B.
- 8. Note the most negative number from the Flatness Relative to 50 MHz (ac) column of Table 2-50 for frequencies between 1.7 GHz and 2.0 GHz. Record this number in Table 2-56 as the Minimum Response for Band 0B.
- 9. For Band 0B in Table 2-56, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 10.Note the most positive number from the Flatness Relative to 50 MHz (ac) column of Table 2-52 for frequencies between 3.0 GHz and 6.7 GHz. Record this number in Table 2-56 as the Maximum Response for Band 1.
- 11.Note the most negative number from the Flatness Relative to 50 MHz (ac) column of Table 2-52 for frequencies between 3.0 GHz and 6.7 GHz. Record this number in Table 2-56 as the Minimum Response for Band 1.
- 12.For Band 1 in Table 2-56, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 13.Note the most positive number from the Flatness Relative to 50 MHz (ac) column of Table 2-52 for frequencies between 6.7 GHz and 13.2 GHz. Record this number in Table 2-56 as the Maximum Response for Band 2.

- 14.Note the most negative number from the Flatness Relative to 50 MHz (ac) column of Table 2-52 for frequencies between 6.7 GHz and 13.2 GHz. Record this number in Table 2-56 as the Minimum Response for Band 2.
- 15.For Band 2 in Table 2-56, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 16.Note the most positive number from the Flatness Relative to 50 MHz (ac) column of Table 2-52 for frequencies between 13.2 GHz and 26.5 GHz. Record this number in Table 2-56 as the Maximum Response for Band 3.
- 17.Note the most negative number from the Flatness Relative to 50 MHz (ac) column of Table 2-52 for frequencies between 13.2 GHz and 26.5 GHz. Record this number in Table 2-56 as the Minimum Response for Band 3.
- 18.For Band 3 in Table 2-56, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 19.Transfer the values entered in Table 2-56 to the test record in this guide.
- 20. The frequency response test for Agilent E4407B analyzers with Option UKB is now complete.

Table 2-56 Frequency Response Results, Agilent E4407B Option UKB, ac Coupled

	Maximum Response		Minimum Response		Peak-to-Peak Response	
Band	dB	Test Record Entry	dB	Test Record Entry	dB	Test Record Entry
0		19)		20)		21)
0A		22)		23)		24)
0B		25)		26)		27)
1		28)		29)		30)
2		31)		32)		33)
3		34)		35)		36)

25. Frequency Response (Preamp On): Agilent E4401B

This test measures the amplitude error of the analyzer as a function of frequency. The output of a source is fed through a power splitter to a power sensor and the analyzer. The power level of the source is adjusted at 50 MHz to place the displayed signal at approximately –32 dBm. At each new source frequency and analyzer center frequency, the power level of the source is adjusted to place the signal at approximately –32 dBm.

For improved amplitude accuracy the power splitter is characterized using a power sensor (the "reference" sensor) connected to one power splitter output port. The other power splitter output port connects to the "buried" sensor; it is not removed from the power splitter. Once the characterization is done, the reference sensor is removed and replaced by the analyzer.

Analyzers with 75 Ω inputs are tested down to 1 MHz only.

This procedure only tests frequency response with the optional preamplifier (Option 1DS) turned on. Perform the "Frequency Response" procedure to test all other frequency response specifications.

The related adjustment for this performance test is "Frequency Response."

Equipment Required

Synthesized signal generator
Power meter
RF power sensor (2 required for 50 Ω inputs)
20 dB fixed attenuator
Power splitter
Cable, Type-N (m), 183 cm
Cable, BNC, 120 cm
Adapter, Type-N (m) to Type-N (m)
Adapter, Type-N (m) to BNC (f)

Additional Equipment for 75 Ω Input

Power sensor, 75 Ω Minimum Loss Pad, Type-N (m) 50 Ω to Type-N (f) 75 Ω Adapter, Type-N (m) to BNC (m), 75 Ω

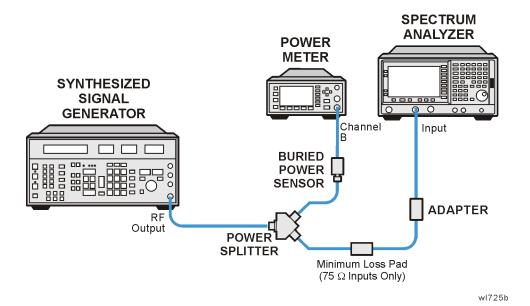
Procedure

Source/Splitter Characterization

1. Refer to Figure 2-36. Connect one RF power sensor to Channel A of the power meter. This will be the "reference" sensor. Connect the other RF power sensor to Channel B of the power meter. This will be the "buried" sensor.

75 Ω inputs: Connect the 75 Ω power sensor to Channel A of the power meter. This will be the "reference" sensor.

Figure 2-36 Source/Splitter Characterization Setup



CAUTION

Use only 75 Ω cables, connectors, or adapters on instruments with 75 Ω connectors, or damage to the connectors will occur.

- 2. Zero and calibrate both power sensors.
- 3. On the power meter, set the Channel A calibration factor to the calibration factor of the reference sensor at 100 kHz.

75 Ω inputs: Set the Channel A calibration factor to the calibration factor of the reference sensor at 1 MHz.

- 4. On the power meter, set the Channel B calibration factor to 100%. Do not change this calibration factor during this test.
- 5. Connect the equipment as shown in Figure 2-36. Note that the reference sensor connects to the 20 dB fixed attenuator.

75 Ω inputs: Connect the reference sensor to the power splitter and attenuator using the minimum loss pad.

- 6. Set the source frequency to 100 kHz and amplitude to 6 dBm. 75 Ω inputs: Set the source frequency to 1 MHz and amplitude to
- 7. Adjust the source amplitude to obtain a Channel A power meter reading of -20 dBm ± 0.1 dB.
- 8. Record the Channel A and Channel B power meter readings in Table 2-57.
- 9. Tune the source to the next frequency in Table 2-57.
- 10.On the power meter, set the Channel A calibration factor to the calibration factor of the reference sensor for the current source frequency.
- 11. Adjust the source amplitude to obtain a Channel A power meter reading of -20 dBm ± 0.1 dB.
- 12.Record the Channel A and Channel B power meter readings in Table 2-57.
- 13. Repeat step 9 through step 12 for each frequency in Table 2-57.
- 14. For each entry in Table 2-57, calculate the Splitter Tracking Error as follows:

Splitter Tracking Error = Channel A Power – Channel B Power

For example, if Channel A Power is –20.3 dBm and Channel B power is –0.23 dBm, the splitter tracking error is –20.07 dB.

NOTE	Tracking errors are nominally -25.7 dB when using the minimum loss
	pad.

Table 2-57 Source/Splitter Characterization

12 dBm.

Frequency	Power Met	Splitter Tracking	
Frequency	Channel A	Channel B	Error
100 kHz ^a			
500 kHz ^a			
1 MHz			
5 MHz			
10 MHz			

Table 2-57 Source/Splitter Characterization

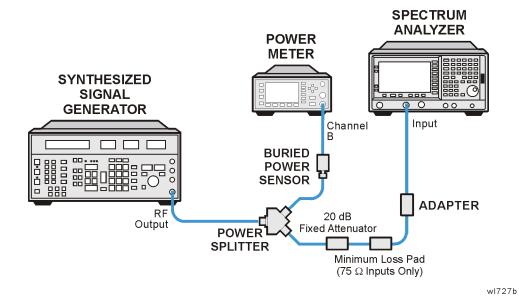
Frequency	Power Met	Splitter Tracking	
Frequency	Channel A	Channel B	Error
20 MHz			
50 MHz			
75 MHz			
175 MHz			
275 MHz			
375 MHz			
475 MHz			
575 MHz			
675 MHz			
775 MHz			
825 MHz			
875 MHz			
925 MHz			
975 MHz			
1025 MHz			
1075 MHz			
1175 MHz			
1275 MHz			
1375 MHz			
1500 MHz			

a. These values do not apply to analyzers with 75 Ω inputs (Option 1DP).

Measuring Frequency Response, Preamp On

1. Refer to Figure 2-37. Remove the reference sensor (Channel A sensor) from the 20 dB fixed attenuator. Connect the 20 dB fixed attenuator to the analyzer 50 Ω Input using an adapter. Do not use a cable.

Figure 2-37 Frequency Response Test Setup, Preamp On



75 Ω inputs: Connect the 20 dB fixed attenuator to the analyzer 75 Ω Input using a mechanical adapter and a 75 Ω , Type-N(m) to BNC(m) adapter.

2. Set the source frequency to 100 kHz:

75 Ω inputs: Set the source frequency to 1 MHz.

- 3. Set the source amplitude to -6 dBm.
- 4. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the controls as follows:

FREQUENCY, Center Freq, 100 kHz ($50~\Omega~\mathrm{Input}$) FREQUENCY, Center Freq, 1 MHz ($75~\Omega~\mathrm{Input}$) CF Step, 100 MHz SPAN, 20 kHz AMPLITUDE, More, Int Preamp (On) AMPLITUDE, More, Y Axis Units (or Amptd Units), dBm AMPLITUDE, Ref Level, –30 dBm Attenuation, 0 dB (Man) Scale/Div, 2 dB BW/Avg, Res BW, 3 kHz (Man) Video BW, 3 kHz (Man)

- 5. On the analyzer, press **Peak Search** (or **Search**).
- 6. Adjust the source amplitude to obtain a marker amplitude reading on the analyzer of -32.00 dBm ± 0.2 dB.
- 7. Record the current Channel B power reading in Table 2-58 as the Current Channel B reading.

25. Frequency Response (Preamp On): Agilent E4401B

- 8. Record the marker (Mkr1) amplitude reading in Table 2-58.
- 9. Set the source to the next frequency listed in Table 2-58.
- 10.Set the analyzer center frequency to the next frequency listed in Table 2-58.
- 11.On the analyzer, press Peak Search (or Search).
- 12. Adjust the source amplitude to obtain a marker amplitude reading on the analyzer of -32.00 dBm ± 0.2 dB.
- 13.Record the current Channel B power reading in Table 2-58 as the Current Channel B reading.
- 14.Record the marker (Mkr1) amplitude reading in Table 2-58 as marker (Mkr1) Amptd.
- 15.Repeat step 9 through step 14 for each frequency in Table 2-58.
- 16.Copy the splitter tracking errors from Table 2-57 into Table 2-58.
- 17.Calculate the Flatness Error for each frequency in Table 2-58 as follows:

Flatness Error = Mkr1 Amptd_{dBm} - Current Channel B_{dBm} - Splitter Tracking Error_{dB}

For example, if marker (Mkr1) Amptd is -33.32 dBm, Current Channel B is -12.4 dBm, and Splitter Tracking Error is -20.07 dB, Flatness Error would be -0.85 dB.

18.Record the Flatness Error for 50 MHz below as the 50 MHz Ref Amptd:

50	MHz	Ref A	$_{ m mptd}$	
----	-----	-------	--------------	--

19.Calculate the Flatness Relative to 50 MHz for each frequency in Table 2-58 as follows:

Flatness Relative to 50 MHz = Flatness Error – 50 MHz Ref Amptd

For example, if Flatness Error is -0.30 dB and 50 MHz Ref Amptd is 0.15 dB, Flatness Relative to 50 MHz would be -0.45 dB.

Table 2-58 Frequency Response Worksheet, Preamp On

Frequency	Current Channel B Reading	Marker (Mkr1) Amptd	Splitter Tracking Error	Flatness Error	Flatness Relative to 50 MHz
100 kHz ^a					
500 kHz ^a					
1 MHz					
5 MHz					

Frequency	Current Channel B Reading	Marker (Mkr1) Amptd	Splitter Tracking Error	Flatness Error	Flatness Relative to 50 MHz
10 MHz					
20 MHz					
50 MHz					0 dB (Ref)
75 MHz					
175 MHz					
275 MHz					
375 MHz					
475 MHz					
575 MHz					
675 MHz					
775 MHz					
825 MHz					
875 MHz					
925 MHz					
975 MHz					
1025 MHz					
1075 MHz					
1175 MHz					
1275 MHz					
1375 MHz					
1500 MHz					

a. These values do not apply to analyzers with 75 Ω inputs (Option 1DP).

Test Results

- 1. Record the most positive number from the Flatness Relative to 50 MHz column of Table 2-58 as the Maximum Response in Table 2-59 and as Entry 1 in the performance verification test record.
- 2. Record the most negative number from the Flatness Relative to 50 MHz column of Table 2-58 as the Minimum Response in Table 2-59 and as Entry 2 in the performance verification test record.

25. Frequency Response (Preamp On): Agilent E4401B

3. In Table 2-59, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column, and as Entry 3 in the performance verification test record.

Table 2-59 Frequency Response Results

Maximum Response		Minimum Response		Peak-to-Peak Response	
dB	Test Record Entry	dB	Test Record Entry	dB	Test Record Entry
	1)		2)		3)

26. Frequency Response (Preamp On): Agilent E4402B

This test measures the amplitude error of the analyzer as a function of frequency. The output of a source is fed through a power splitter to a power sensor and the analyzer. The power level of the source is adjusted at 50 MHz to place the displayed signal at approximately -32 dBm. At each new source frequency and analyzer center frequency, the power level of the source is adjusted to place the signal at approximately -32 dBm.

For improved amplitude accuracy the power splitter is characterized using a power sensor (the "reference" sensor) connected to one power splitter output port. The other power splitter output port connects to the "buried" sensor; it is not removed from the power splitter. Once the characterization is done, the reference sensor is removed and replaced by the analyzer.

This procedure only tests frequency response with the optional preamplifier (Option 1DS) turned on. Perform the "Frequency Response" procedure to test all other frequency response specifications.

The related adjustment for this performance test is "Frequency Response."

Equipment Required

Function generator
Synthesized sweeper
Power meter
RF power sensor (2 required)
20 dB fixed attenuator
Power splitter
Cable, Type-N (m), 183 cm
Cable, BNC, 120 cm
Adapter, Type-N (m) to Type-N (m)
Adapter, Type-N (m) to BNC (f)

Procedure

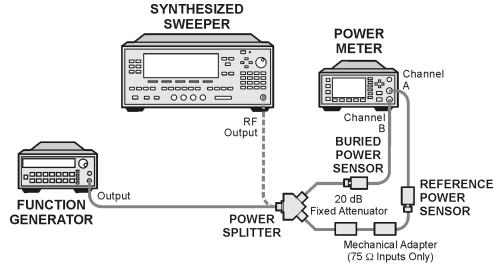
Source/Splitter Characterization

- 1. Connect one RF power sensor to Channel A of the power meter. This will be the "reference" sensor. Connect the other RF power sensor to Channel B of the power meter. This will be the "buried" sensor.
- 2. Zero and calibrate both power sensors.
- 3. On the power meter, set the Channel A calibration factor to the

calibration factor of the reference sensor at 1 MHz.

- 4. On the power meter, set the Channel B calibration factor to 100%. Do not change this calibration factor during this test.
- 5. Connect the equipment as shown in Figure 2-38. Use the function generator as the source. Note that the reference sensor connects to the 20 dB fixed attenuator.

Figure 2-38 Source/Splitter Characterization Setup



- w1714b
- 6. Set the function generator frequency to 1 MHz and amplitude to 450 mV rms (approximately 6 dBm).
- 7. Adjust the source amplitude to obtain a Channel A power meter reading of $-20 \text{ dBm} \pm 0.1 \text{ dB}$.
- 8. Record the Channel A and Channel B power meter readings in Table 2-60.
- 9. Tune the source to the next frequency in Table 2-60.
- 10.On the power meter, set the Channel A calibration factor to the calibration factor of the reference sensor for the current source frequency.
- 11. Adjust the source amplitude to obtain a Channel A power meter reading of -20 dBm ± 0.1 dB.
- 12.Record the Channel A and Channel B power meter readings in Table 2-60.
- 13. Repeat step 9 through step 12 for frequencies up through 10 MHz.
- 14. Replace the function generator with the synthesized sweeper.

- 15.Set the synthesized sweeper CW frequency to 10 MHz and the amplitude to 6 dBm.
- 16.Adjust the synthesized sweeper power level to obtain a Channel A power meter reading of -20 dBm ±0.1 dB.
- 17.Record both Channel A and Channel B power meter readings in Table 2-60.
- 18.Repeat step 9 through step 12 for each remaining frequency in Table 2-60.
- 19.For each entry in Table 2-60, calculate the Splitter Tracking Error as follows:

Splitter Tracking Error = Channel A Power – Channel B Power

For example, if Channel A Power is –20.3 dBm and Channel B power is –0.23 dBm, the splitter tracking error is –20.07 dB.

Table 2-60 Source/Splitter Characterization

Engage	Power Met	Splitter Tracking	
Frequency	Channel A	Channel B	Error
1 MHz			
5 MHz			
10 MHz ^a			
10 MHz ^b			
20 MHz			
50 MHz			
75 MHz			
175 MHz			
275 MHz			
375 MHz			
475 MHz			
575 MHz			
675 MHz			
775 MHz			
825 MHz			
875 MHz			
925 MHz			

Table 2-60 Source/Splitter Characterization

Frequency	Power Met	Splitter Tracking	
Frequency	Channel A	Channel B	Error
975 MHz			
1025 MHz			
1075 MHz			
1175 MHz			
1275 MHz			
1375 MHz			
1500 MHz			
1525 MHz			
1675 MHz			
1725 MHz			
1775 MHz			
1825 MHz			
1875 MHz			
1925 MHz			
1975 MHz			
2025 MHz			
2125 MHz			
2325 MHz			
2525 MHz			
2725 MHz			
2925 MHz			
2999 MHz			

- a. This entry is for data taken with the function generator as source.
- b. This entry is for data taken with the synthesized sweeper as source.

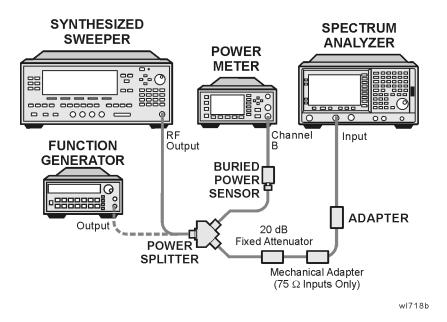
Measuring Frequency Response, Preamp On

1. Refer to Figure 2-39. Remove the reference sensor (Channel A sensor) from the 20 dB fixed attenuator. Connect the 20 dB fixed attenuator to the 50 Ω Input of the analyzer using an adapter. Do not

use a cable.

- 2. Set the source frequency to 10 MHz.
- 3. Set the source power level to -6 dBm.

Figure 2-39 Frequency Response Test Setup, Preamp On



4. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the controls as follows:

FREQUENCY, Center Freq, 10 MHz CF Step, 100 MHz SPAN, 20 kHz Input/Output (or Input), Coupling (DC) $(Option\ UKB\ only)$ AMPLITUDE, More, Int Preamp, On AMPLITUDE, Ref Level, $-30\ dBm$ Attenuation, 0 dB (Man) Scale/Div, 2 dB BW/Avg, Res BW, 3 kHz (Man) Video BW, 3 kHz (Man)

- 5. On the analyzer, press Peak Search (or Search).
- 6. Adjust the source power level to obtain a marker amplitude reading on the analyzer of -32.00 dBm ± 0.2 dB.
- 7. Record the current Channel B power reading in Table 2-61 as the Current Channel B Reading.
- 8. Record the marker (Mkr1) amplitude reading in Table 2-61.
- 9. Set the source to the next frequency listed in Table 2-61.

26. Frequency Response (Preamp On): Agilent E4402B

- 10.Set the analyzer center frequency to the next frequency listed in Table 2-61.
- 11.On the analyzer, press Peak Search (or Search).
- 12.Adjust the source power level to obtain a marker amplitude reading on the analyzer of –32.00 dBm ±0.2 dB.
- 13.Record the current Channel B power reading in Table 2-61 as the current Channel B reading.
- 14.Record the marker (Mkr1) amplitude reading in Table 2-61.
- 15.Repeat step 9 through step 14 for each remaining frequency in Table 2-61.
- 16. Replace the synthesized sweeper with the function generator.
- 17.Set the function generator amplitude to 112 mV rms (-6 dBm, or -12 dBm plus nominal power splitter insertion loss).
- 18.Set the function generator frequency to 1 MHz.
- 19.Set the analyzer center frequency to 1 MHz.
- 20. On the analyzer, press Peak Search (or Search).
- 21.Adjust the function generator amplitude to obtain a marker amplitude reading of -32.00 dBm ± 0.2 dB.
- 22.Record the current Channel B power reading in Table 2-61 as the current Channel B reading.
- 23.Record the analyzer marker (Mkr1) amplitude reading in Table 2-61 as marker (Mkr1) amplitude.
- 24.Repeat step 18 through step 23 for frequencies between 100 kHz and 10 MHz.
- 25.Copy the Splitter Tracking Error values from Table 2-60 into Table 2-61.
- 26.Calculate the Flatness Error for each frequency in Table 2-61 as follows:

Flatness Error = $Mkr1 Amptd_0$	_{8m} – Current Channel B _{dBn}	₁ – Splitter Tracking Error _{dB}
---------------------------------	--	--

For example, if marker (Mkr1) Amptd is -33.32 dBm, Current Channel B is -12.4 dBm, and Splitter Tracking Error is -20.07 dB, Flatness Error would be -0.85 dB.

27.Record the Flatness Error for 50 MHz below as the 50 MHz Ref Amptd:

50	MHz	Ref	Amptd:		dJ	В
----	-----	-----	--------	--	----	---

28.Calculate the Setup Change Error (error due to changing the test setup from using a synthesized sweeper to using a function

ge	nerator) as follows:
a.	Record the Flatness Error from Table 2-61 at 10 MHz using the function generator as FlatError $_{\rm FG}$:
	$FlatError_{FG}$ =dB
b.	Record the Flatness Error from Table 2-61 at 10 MHz using the synthesized sweeper as FlatError $_{\rm SS}$:
	$FlatError_{SS}$ =dB
c.	$\label{eq:Subtract FlatError} Subtract \ FlatError_{SS} \ from \ FlatError_{FG} \ and \ record \ the \ result \ as the Setup Change Error: \\ Setup \ Change \ Error \ = \ FlatError_{FG} - FlatError_{SS}$
	Setup Change Error ≡ dB

29.For frequencies less than 10 MHz calculate the Flatness Relative to 50 MHz for each frequency in Table 2-61 as follows:

Flatness Relative to 50 MHz = Flatness Error – 50 MHz Ref Amptd – Setup Change Error

For example, if Flatness Error is -0.30 dB, 50 MHz Ref Amptd is 0.15 dB, and Setup Change Error is -0.19 dB, Flatness Relative to 50 MHz would be -0.26 dB.

30.For frequencies 10 MHz and greater, calculate the Flatness Relative to 50 MHz for each frequency in Table 2-61 as follows:

Flatness Relative to 50 MHz = Flatness Error – 50 MHz Ref Amptd

For example, if Flatness Error is -0.30 dB and 50 MHz Ref Amptd is 0.15 dB, Flatness Relative to 50 MHz would be -0.45 dB.

Table 2-61 Frequency Response Worksheet, Preamp On

Frequency	Current Channel B Reading	Mkr1 Amptd	Splitter Tracking Error	Flatness Error	Flatness Relative to 50 MHz
1 MHz					
5 MHz					
10 MHz ^a					
10 MHz ^b					
20 MHz					
50 MHz					0 dB (Ref)
75 MHz					

Table 2-61 Frequency Response Worksheet, Preamp On

Frequency	Current Channel B Reading	Mkr1 Amptd	Splitter Tracking Error	Flatness Error	Flatness Relative to 50 MHz
175 MHz					
275 MHz					
375 MHz					
475 MHz					
575 MHz					
675 MHz					
775 MHz					
825 MHz					
875 MHz					
925 MHz					
975 MHz					
1025 MHz					
1075 MHz					
1175 MHz					
1275 MHz					
1375 MHz					
1500 MHz					
1525 MHz					
1675 MHz					
1725 MHz					
1775 MHz					
1825 MHz					
1875 MHz					
1925 MHz					
1975 MHz					
2025 MHz					
2125 MHz					
2325 MHz					

Table 2-61 Frequency Response Worksheet, Preamp On

Frequency	Current Channel B Reading	Mkr1 Amptd	Splitter Tracking Error	Flatness Error	Flatness Relative to 50 MHz
2525 MHz					
2725 MHz					
2925 MHz					
2999 MHz					

- a. This entry is for data taken with the function generator as source.
- b. This entry is for data taken with the synthesized sweeper as source.

Test Results

- 1. Record the most positive number from the Flatness Relative to 50 MHz column of Table 2-61 as the Maximum Response for Band 0 in Table 2-62.
- 2. Record the most negative number from the Flatness Relative to 50 MHz column of Table 2-61 as the Minimum Response for Band 0 in Table 2-62.
- 3. For Band 0 in Table 2-62, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 4. If the analyzer is an Agilent E4402B with a serial number greater than or equal to US39441006 then continue with the next step. Otherwise, transfer the values entered in Table 2-62 to the test record in this guide; the frequency response test is now complete.
- 5. Note the most positive number from the Flatness Relative to 50 MHz column of Table 2-61 for frequencies between 800 MHz and 1.0 GHz. Record this number in Table 2-62 as the Maximum Response for Band 0A.
- 6. Note the most negative number from the Flatness Relative to 50 MHz column of Table 2-61 for frequencies between 800 MHz and 1.0 GHz. Record this number in Table 2-62 as the Minimum Response for Band 0A.
- 7. For Band 0A in Table 2-62, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 8. Note the most positive number from the Flatness Relative to 50 MHz column of Table 2-61 for frequencies between 1.7 GHz and 2.0 GHz. Record this number in Table 2-62 as the Maximum Response for Band 0B.

26. Frequency Response (Preamp On): Agilent E4402B

- 9. Note the most negative number from the Flatness Relative to 50MHz column of Table 2-61 for frequencies between 1.7 GHz and 2.0 GHz. Record this number in Table 2-62 as the Minimum Response for Band 0B.
- 10.For Band 0B in Table 2-62, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 11.Transfer the values entered in Table 2-62 to the test record in this guide.
- 12. The frequency response test is now complete.

Table 2-62 Frequency Response Results

	Maximum Response		Maximum Response Minimum Response		Peak-to-Peak Response		
Band	dB	Test Record Entry	dB	Test Record Entry	dB	Test Record Entry	
0		1)		2)		3)	
0A		4)		5)		6)	
0B		7)		8)		9)	

27. Frequency Response (Preamp On): Agilent E4404B, E4405B, and E4407B

This test measures the amplitude error of the analyzer as a function of frequency. The output of a source is fed through a power splitter to a power sensor and the analyzer. The power level of the source is adjusted at 50 MHz to place the displayed signal at approximately –32 dBm. At each new source frequency and analyzer center frequency, the power level of the source is adjusted to place the signal at approximately –32 dBm.

For improved amplitude accuracy the power splitter is characterized using a power sensor (the "reference" sensor) connected to one power splitter output port. The other power splitter output port connects to the "buried" sensor; it is not removed from the power splitter. Once the characterization is done, the reference sensor is removed and replaced by the analyzer.

This procedure only tests frequency response with the optional preamplifier (Option 1DS) turned on. Perform the "Frequency Response" procedure to test all other frequency response specifications.

The related adjustment for this performance test is "Frequency Response."

Equipment Required

Function generator
Synthesized sweeper
Power meter
RF power sensor (2 required)
20 dB fixed attenuator
Power splitter
Cable, Type-N (m), 183 cm
Cable, BNC, 120 cm
Adapter, Type-N (m) to Type-N (m)
Adapter, Type-N (m) to BNC (f)

Additional Equipment for Option BAB

Adapter, Type-N (m) to APC 3.5 (f)

Procedure

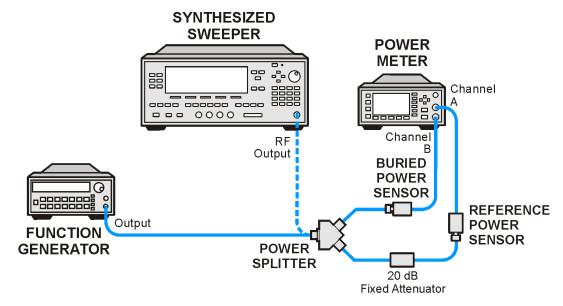
Source/Splitter Characterization

1. Connect one RF power sensor to Channel A of the power meter. This will be the "reference" sensor. Connect the other RF power sensor to

Channel B of the power meter. This will be the "buried" sensor.

- 2. Zero and calibrate both power sensors.
- 3. On the power meter, set the Channel A calibration factor to the calibration factor of the reference sensor at 1 MHz.
- 4. On the power meter, set the Channel B calibration factor to 100%. Do not change this calibration factor during this test.
- 5. Connect the equipment as shown in Figure 2-40. Use the function generator as the source. Note that the reference sensor connects to the 20 dB fixed attenuator.

Figure 2-40 Source/Splitter Characterization Setup



wb922a

- 6. Set the function generator frequency to 1 MHz and amplitude to 446 mV rms (approximately 6 dBm).
- 7. Adjust the source amplitude to obtain a Channel A power meter reading of -20 dBm ± 0.1 dB.
- 8. Record the Channel A and Channel B power meter readings in Table 2-63.
- 9. Tune the source to the next frequency in Table 2-63.
- 10.On the power meter, set the Channel A calibration factor to the calibration factor of the reference sensor for the current source frequency.
- 11. Adjust the source amplitude to obtain a Channel A power meter reading of -20 dBm ± 0.1 dB.
- 12.Record the Channel A and Channel B power meter readings in

Table 2-63.

- 13.Repeat step 9 through step 12 for frequencies up through 10 MHz.
- 14. Replace the function generator with the synthesized sweeper.
- 15.Set the synthesized sweeper CW frequency to 10 MHz and the amplitude to 6 dBm.
- 16.Adjust the synthesized sweeper power level to obtain a Channel A power meter reading of -20 dBm ±0.1 dB.
- 17.Record the synthesized sweeper power level and both Channel A and Channel B power meter readings in Table 2-63.
- 18.Repeat step 9 through step 12 for each remaining frequency in Table 2-63.
- 19.For each entry in Table 2-63, calculate the Splitter Tracking Error as follows:

Splitter Tracking Error = Channel A Power – Channel B Power

For example, if Channel A Power is -20.3 dBm and Channel B power is -0.23 dBm, the splitter tracking error is -20.07 dB.

Table 2-63 Source/Splitter Characterization

E	Power Met	Splitter	
Frequency	Channel A Channel B		Tracking Error
1 MHz			
5 MHz			
10 MHz ^a			
10 MHz ^b			
20 MHz			
50 MHz			
75 MHz			
175 MHz			
275 MHz			
375 MHz			
475 MHz			
575 MHz			
675 MHz			

Table 2-63 Source/Splitter Characterization

E	Power Met	Splitter	
Frequency	Channel A	Channel B	- Tracking Error
775 MHz			
825 MHz			
875 MHz			
925 MHz			
975 MHz			
1025 MHz			
1075 MHz			
1175 MHz			
1275 MHz			
1375 MHz			
1500 MHz			
1525 MHz			
1675 MHz			
1725 MHz			
1775 MHz			
1825 MHz			
1875 MHz			
1925 MHz			
1975 MHz			
2025 MHz			
2125 MHz			
2325 MHz			
2525 MHz			
2725 MHz			
2925 MHz			
2999 MHz			

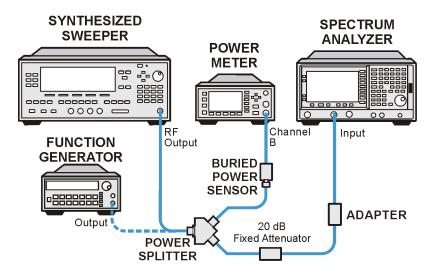
a. This entry is for data taken with the function generator as source.

b. This entry is for data taken with the synthesized sweeper as source.

Measuring Frequency Response, Preamp On

1. Refer to Figure 2-41. Remove the reference sensor (Channel A sensor) from the 20 dB fixed attenuator. Connect the 20 dB fixed attenuator to the 50 Ω Input of the analyzer using an adapter. Do not use a cable.

Figure 2-41 Frequency Response Test Setup, Preamp On



wl728b

- 2. Set the source frequency to 10 MHz.
- 3. Set the source power level to -6 dBm.
- 4. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the controls as follows:

FREQUENCY, Center Freq, 10 MHz
CF Step, 100 MHz
SPAN, 20 kHz
Input/Output (or Input), Coupling, (DC) (Agilent E4404B, E4405B, or any model with Option UKB)
AMPLITUDE, More, Int Preamp, On

 $\label{eq:amplitude} \begin{array}{l} \text{AMPLITUDE, Ref Level, -30 dBm} \\ \text{Attenuation, 0 dB} \ (Man) \\ \text{Scale/Div, 2 dB} \\ \text{BW/Avg, Res BW, 3 kHz} \ (Man) \\ \text{Video BW, 3 kHz} \ (Man) \\ \end{array}$

- 5. On the analyzer, press Peak Search (or Search).
- 6. Adjust the source power level to obtain a marker amplitude reading on the analyzer of $-32.00 \text{ dBm} \pm 0.2 \text{ dB}$.
- 7. Record the current Channel B power reading in Table 2-64 as the Current Channel B Reading for ac or dc coupling, as appropriate. If the analyzer does not have switchable ac/dc coupling, enter all data into the dc columns.
- 8. Record the marker (Mkr1) amplitude reading in Table 2-64.
- 9. Set the source to the next frequency listed in Table 2-64.
- 10.Set the analyzer center frequency to the next frequency listed in Table 2-64.
- 11.On the analyzer, press Peak Search (or Search).
- 12. Adjust the source power level to obtain a marker amplitude reading on the analyzer of $-32.00 \text{ dBm} \pm 0.2 \text{ dB}$.
- 13.Record the current Channel B power reading in Table 2-64 as the current Channel B reading in the ac or dc column, as appropriate.
- 14.Record the marker (Mkr1) amplitude reading in Table 2-64.
- 15.Repeat step 9 through step 14 for each remaining frequency in Table 2-64.
- 16.If the analyzer is an Agilent E4407B with Option UKB and is being tested in ac coupled mode, continue with step 26. These analyzers are specified only down to 10 MHz in ac coupled mode.
- 17. Replace the synthesized sweeper with the function generator.
- 18.Set the function generator amplitude to 112 mV rms (-6 dBm, or -12 dBm plus nominal power splitter insertion loss).
- 19.Set the function generator frequency to 1 MHz.
- 20.Set the analyzer center frequency to 1 MHz.
- 21.On the analyzer, press Peak Search (or Search).
- 22. Adjust the function generator amplitude to obtain a marker amplitude reading of $-00 \text{ dBm} \pm 0.2 \text{ dB}$.
- 23.Record the current Channel B power reading in Table 2-64 as the current Channel B reading.
- 24.Record the analyzer marker (Mkr1) amplitude reading in Table 2-64 as marker (Mkr1) amplitude.
- 25.Repeat step 19 through step 24 for frequencies between 1 MHz and 10 MHz.
- 26.Copy the Splitter Tracking Error values from Table 2-63 into Table 2-64.

27.Calculate the Flatness	Error	for each	frequency	in Ta	ble 2	2-64	as
follows:							

 $Flatness\ Error\ =\ Mkr1\ Amptd_{dBm}-Current\ Channel\ B_{dBm}-Splitter\ Tracking\ Error_{dB}$

For example, if marker (Mkr1) Amptd is -33.32 dBm, Current Channel B is -12.4 dBm, and Splitter Tracking Error is -20.07 dB, Flatness Error would be -0.85 dB.

28.Record the Flatness Error for 50 MHz below as the 50 MHz Ref Amptd:

50 MHz Ref Amptd:

- 29.If the analyzer is an Agilent E4407B with Option UKB and is being tested in ac coupled mode, continue with step 31. Calculate the Setup Change Error (error due to changing the test setup from using a synthesized sweeper to using a function generator) as follows:
 - a. Record the Flatness Error from Table 2-64 at 10 MHz using the function generator as FlatError_{FG}:

 $FlatError_{FG} = ___ dB$

b. Record the Flatness Error from Table 2-64 at 10 MHz using the synthesized sweeper as FlatErrorss:

FlatError_{SS}=____ dB

c. Subtract FlatError $_{\rm SS}$ from FlatError $_{\rm FG}$ and record the result as the Setup Change Error:

Setup Change Error = $FlatError_{FG} - FlatError_{SS}$

Setup Change Error = ____ dB

30.For frequencies less than 10 MHz calculate the Flatness Relative to 50 MHz for each frequency in Table 2-64 as follows:

Flatness Relative to 50 MHz = Flatness Error – 50 MHz Ref Amptd – Setup Change Error

For example, if Flatness Error is -0.30 dB, 50 MHz Ref Amptd is 0.15 dB, and Setup Change Error is -0.19 dB, Flatness Relative to 50 MHz would be -0.26 dB.

31.For frequencies 10 MHz and greater, calculate the Flatness Relative to 50 MHz for each frequency in Table 2-64 as follows:

Flatness Relative to 50 MHz = Flatness Error – 50 MHz Ref Amptd

For example, if Flatness Error is -0.30 dB and 50 MHz Ref Amptd is 0.15 dB, Flatness Relative to 50 MHz would be -0.45 dB.

32. Replace the function generator with the synthesized sweeper.

27. Frequency Response (Preamp On): Agilent E4404B, E4405B, and E4407B

33.If the analyzer is an Agilent E4407B with Option UKB then repeat step 2 through step 31 using ac coupled mode.

Table 2-64 Frequency Response Worksheet, Preamp On

Freq. (MHz)	Splitter Tracking Error	Cur Chan Read		Marker Am	(Mkr1) ptd	Flatness Error		Flatness Relative to 50 MHz	
		dc	ac	dc	ac	dc	ac	dc	ac
1 ^a									
5 ^a									
10 ^{ab}									
10 ^c									
20									
50								0 dB (ref)	0 dB (ref)
75									
175									
275									
375									
475									
575									
675									
775									
825									
875									
925									
975									
1025									
1075									
1175									
1275									
1375									
1500									
1525									
1675									

 Table 2-64
 Frequency Response Worksheet, Preamp On

Freq. (MHz)	Splitter Tracking Error	Chan	rent inel B ding		(Mkr1) ptd	Flatnes	ss Error	Relat	ness ive to MHz
		dc	ac	dc	ac	dc	ac	dc	ac
1725									
1775									
1825									
1875									
1925									
1975									
2025									
2125									
2325									
2525									
2725									
2925									
2999									

- a. This frequency is not tested on Agilent E4407B analyzers with Option UKB when in ac coupled mode.
- b. This entry is for data taken with the function generator as source.
- c. This entry is for data taken with the synthesized sweeper as source.

Test Results

- 1. Record the most positive number from the Flatness Relative to 50 MHz (dc) column of Table 2-64 as the Maximum Response for Band 0 in Table 2-65.
- 2. Record the most negative number from the Flatness Relative to 50 MHz (dc) column of Table 2-64 as the Minimum Response for Band 0 in Table 2-65.
- 3. For Band 0 in Table 2-65, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 4. If the analyzer is an Agilent E4404B with a serial number greater than or equal to US39440498 then continue with step 8. Otherwise, transfer the values entered in Table 2-65 to the test record in this guide; the frequency response test is now complete.

- 5. If the analyzer is an Agilent E4405B with a serial number greater than or equal to US39440327 then continue with step 8. Otherwise, transfer the values entered in Table 2-65 to the test record in this guide; the frequency response test is now complete.
- 6. If the analyzer is an Agilent E4407B with a serial number greater than or equal to US39440871 and does not have Option UKB then continue with step 8. Otherwise, transfer the values entered in Table 2-65 to the test record in this guide; the frequency response test is now complete.
- 7. If the analyzer is an Agilent E4407B with Option UKB, continue with step 16.
- 8. Note the most positive number from the Flatness Relative to 50 MHz (dc) column of Table 2-64 for frequencies between 800 MHz and 1.0 GHz. Record the number in Table 2-65 as the Maximum Response for Band 0A.
- 9. Note the most negative number from the Flatness Relative to 50 MHz (dc) column of Table 2-64 for frequencies between 800 MHz and 1.0 GHz. Record the number in Table 2-65 as the Minimum Response for Band 0A.
- 10.For Band 0A in Table 2-65, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 11.Note the most positive number from the Flatness Relative to 50 MHz (dc) column of Table 2-64 for frequencies between 1.7 GHz and 2.0 GHz. Record the number in Table 2-65 as the Maximum Response for Band 0B.
- 12.Note the most negative number from the Flatness Relative to 50 MHz (dc) column of Table 2-64 for frequencies between 1.7 GHz and 2.0 GHz. Record the number in Table 2-65 as the Minimum Response for Band 0B.
- 13.For Band 0B in Table 2-65, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 14.Transfer the values entered in Table 2-65 to the test record in this guide.

15. The frequency response (preamp on) test is now complete.

Table 2-65 Frequency Response Results, dc Coupled

	Maximum Response		Maximum Response Minimum Response		Peak-to-Peak Response	
Band	dB	Test Record Entry	dB	Test Record Entry	dB	Test Record Entry
0		1)		2)		3)
0A		4)		5)		6)
0B		7)		8)		9)

- 16.Note the most positive number from the Flatness Relative to 50 MHz (ac) column of Table 2-64. Record the number in Table 2-66 as the Maximum Response for Band 0.
- 17.Note the most negative number from the Flatness Relative to 50 MHz (ac) column of Table 2-64. Record the number in Table 2-66 as the Minimum Response for Band 0.
- 18.For Band 0 in Table 2-66, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 19.Note the most positive number from the Flatness Relative to 50 MHz (ac) column of Table 2-64 for frequencies between 800 MHz and 1.0 GHz. Record the number in Table 2-66 as the Maximum Response for Band 0A.
- 20.Note the most negative number from the Flatness Relative to 50 MHz (ac) column of Table 2-64 for frequencies between 800 MHz and 1.0 GHz. Record the number in Table 2-66 as the Minimum Response for Band 0A.
- 21.For Band 0A in Table 2-66, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.
- 22.Note the most positive number from the Flatness Relative to 50 MHz (ac) column of Table 2-64 for frequencies between 1.7 GHz and 2.0 GHz. Record the number in Table 2-66 as the Maximum Response for Band 0B.
- 23.Note the most negative number from the Flatness Relative to 50 MHz (ac) column of Table 2-64 for frequencies between 1.7 GHz and 2.0 GHz. Record the number in Table 2-66 as the Minimum Response for Band 0B.
- 24.For Band 0B in Table 2-66, subtract the Minimum Response value from the Maximum Response value and record the result in the Peak-to-Peak Response column.

25.Transfer the values entered in Table 2-66 to the test record in this guide.

26. The frequency response (preamp on) test is now complete.

Table 2-66 Frequency Response Results, Agilent E4407B Option UKB

	Maximum Response		Minimum Response		Peak-to-Peak Response	
Band	dB	Test Record Entry	dB	Test Record Entry	dB	Test Record Entry
0		10)		11)		12)
0A		13)		14)		15)
0B		16)		17)		18)

28. Other Input-Related Spurious Responses: Agilent E4401B and E4411B

This test measures the ability of the analyzer to reject image and multiple responses. A synthesized source and the analyzer are set to the same frequency and the amplitude of the source is set to $-20~\mathrm{dBm}$. A marker amplitude reference is set on the analyzer. The source is then tuned to several different frequencies which should generate image and multiple responses. At each source frequency, the source amplitude is set to $-20~\mathrm{dBm}$ and the amplitude of the response, if any, is measured using the analyzer marker functions.

There are no related adjustment procedures for this performance test.

Equipment Required

Synthesized signal generator Power meter RF power sensor Adapter, Type-N (f) to APC 3.5 (f) Adapter, Type-N (f) to Type-N (f) Cable, Type-N, 152-cm (60-in)

Additional Equipment for 75 Ω Input

Power sensor, 75 Ω Adapter, Type-N (f), to BNC (m), 75 Ω Adapter, BNC (m), to BNC (m), 75 Ω Pad, minimum loss

Procedure

1. Zero and calibrate the power meter and RF power sensor in log mode (power reads out in dBm), as described in the power meter operation manual. Enter the 500 MHz calibration factor of the power sensor into the power meter.

75 Ω Input only: Use a 75 Ω power sensor.

2. Press **Preset** on the synthesized sweeper and set the controls as follows:

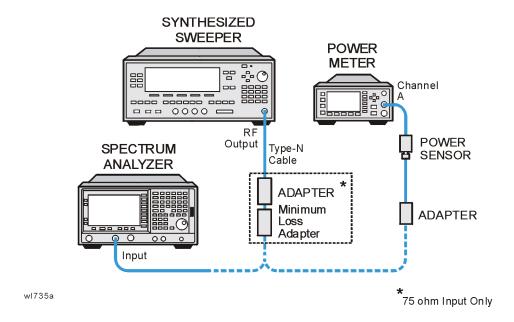
CW, 542.8 MHz POWER LEVEL, -10 dBm

3. Connect the equipment as shown in Figure 2-42 with the output of the synthesized sweeper connected to the power sensor using an adapter between the cable and the power sensor.

75 Ω Input only: Use the minimum loss pad and 75 Ω adapters to connect to the 75 Ω power sensor.

- 4. Adjust the power level of the synthesized sweeper for a -10 dBm ± 0.1 dB reading on the power meter.
- 5. On the synthesized sweeper, press **SAVE**, 1.

Figure 2-42 Other Input Related Spurious Responses Power Setting Setup

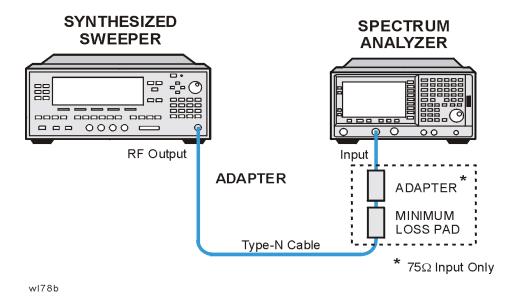


- 6. Set the CW frequency on the synthesized sweeper to 510.7 MHz.
- 7. Adjust the synthesized sweeper power level for a -10 dBm ± 0.1 dB reading on the power meter.
- 8. On the synthesized sweeper, press **SAVE 2**.
- 9. Enter the 1 GHz calibration factor for the power sensor into the power meter.
- 10.Set the CW frequency on the synthesized sweeper to 1310.7 MHz.
- 11. Adjust the synthesized sweeper power level for a $-10 \text{ dBm} \pm 0.1 \text{ dB}$ reading on the power meter.
- 12.On the synthesized sweeper, press **SAVE 3**.
- 13.Enter the 100 MHz calibration factor of the power sensor into the power meter.
- 14.Set the CW frequency of the synthesized sweeper to 100 MHz.
- 15.Adjust the synthesized sweeper power level for a $-10 \text{ dBm} \pm 0.1 \text{ dB}$ reading on the power meter.

- 16.On the synthesized sweeper, press **SAVE 4**.
- 17.Set the CW frequency on the synthesized sweeper to 500 MHz.
- 18.Adjust the power level of the synthesized sweeper for a -10 dBm $\pm 0.1 \text{ dB}$ reading on the power meter.
- 19.Connect the synthesized sweeper to the Input of the analyzer using the appropriate cable and adapters. See Figure 2-43.

75 Ω Input only: Use the minimum loss pad and a 75 Ω adapter as shown in Figure 2-43.

Figure 2-43 Other Input Related Spurious Responses Measurement Setup



20.Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the controls as follows:

FREQUENCY, Center Freq, 500 MHz SPAN, 200 kHz AMPLITUDE, Attenuation, 10 dB (Man) BW/Avg, Res BW, 1 kHz Peak Search $(or\ Search)$, Marker \rightarrow , Mkr \rightarrow Ref Lvl Peak Search $(or\ Search)$, Marker, Delta Single

- 21.On the synthesized sweeper, press **RECALL**, 1.
- 22.On the analyzer, press **Single** and wait for the completion of a new sweep.
- 23.On the analyzer, press **Peak Search** (or **Search**), and record the marker delta (Δ Mkr1) amplitude in the performance verification test record as indicated in Table 2-67.

- 24.On the synthesized sweeper, press RECALL, 2.
- 25.On the analyzer, press **Single** and wait for the completion of a new sweep.
- 26.On the analyzer, press **Peak Search** (or **Search**), record the marker delta (Δ Mkr1) amplitude in the performance verification test record as indicated in Table 2-67.
- 27.On the synthesized sweeper, press **RECALL**, 4.
- 28.On the analyzer press the following keys:

FREQUENCY, Center Freq, 100 MHz AMPLITUDE, -5 dBm($50 \Omega Input$) AMPLITUDE, 48.75 dBmV ($75 \Omega Input$) Marker, Normal Sweep, Sweep (Cont) Peak Search (or Search), Meas Tools, Mkr \rightarrow Ref Lvl Peak Search (or Search), Meas Tools, Delta Single

- 29.On the synthesized sweeper, press **RECALL 3** for a CW frequency of 1310.7 MHz.
- 30.Press **Single** on the analyzer and wait for a completion of a new sweep.
- 31.On the analyzer, press **Peak Search** (or **Search**) and record the marker delta (Δ Mkr1) amplitude in the performance test record as indicated in Table 2-67.

 Table 2-67
 Other Input-Related Spurious Responses Worksheet

Synt	Test Record Entry		
Save Register	CW	Power Level	Marker Delta (∆ Mkr1)
1	542.8 MHz ^a	-10 dBm	1)
2	510.7 MHz ^b	-10 dBm	2)
3	1310.7 MHz ^b	-10 dBm	3)
4	100 MHz	-10 dBm	N/A

- a. Image response
- b. Multiple response

29. Other Input-Related Spurious Responses: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B

This test measures the ability of the analyzer to reject image, multiple, and out-of-band responses. A synthesized source and the analyzer are set to the same frequency and the amplitude of the source is set to -10 dBm and -20 dBm. A marker amplitude reference is set on the analyzer for each source amplitude setting. The source is then tuned to several different frequencies which should generate image, multiple, and out-of-band responses. At each source frequency, the source amplitude is set to the appropriate amplitude and the amplitude of the response, if any, is measured using the analyzer marker functions.

There are no related adjustment procedures for this performance test.

Equipment Required

Synthesized sweeper

Power meter

RF power sensor, (Agilent E4402B, E4403B)

Microwave power sensor (*Agilent E4404B*, *E4405B*, *E4407B*, *E4408B*)

RF power splitter (Agilent E4402B, E4403B)

Microwave power splitter (*Agilent E4404B*, *E4405B*, *E4407B*, *E4408B*)

Adapter, Type-N (m) to Type-N (m)

Adapter, Type-N (m) to APC 3.5 (m)

Adapter, APC 3.5 (f) to APC 3.5 (f)

Cable, APC 3.5, 91 cm (36 in)

Procedure

Band 0

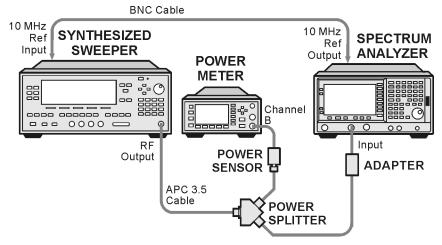
- 1. Zero and calibrate the power meter and power sensor in log mode (power reads out in dBm), as described in the power meter operation manual. Enter the power sensor 2 GHz calibration factor into the power meter.
- 2. Preset the synthesized sweeper and set the controls as follows:

CW, 2000 MHz POWER LEVEL, -4 dBm

3. Connect the equipment as shown in Figure 2-44. The analyzer provides the 10 MHz reference for the synthesized sweeper.

29. Other Input-Related Spurious Responses: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B

Figure 2-44 Other Input-Related Spurious Responses Test Setup



wl736a

4. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the controls as follows:

FREQUENCY, Center Freq, 2 GHz SPAN, 200 kHz

AMPLITUDE, Ref Level –10 dBm AMPLITUDE, Attenuation 0 dBm (Man) BW/Avg, Res BW, 1 kHz

- 5. Adjust the synthesized sweeper power level for a $-10 \text{ dBm} \pm 0.1 \text{ dB}$ reading on the power meter.
- 6. On the analyzer, press **Single**, and wait for the sweep to finish. Then press following keys:

Marker, Select Marker (1)
Peak Search (or Search)
Marker
Delta

The signal peak might be slightly above the reference level, but the marker function can still make an accurate measurement.

- 7. Adjust the synthesized sweeper power level for a $-20 \text{ dBm} \pm 0.1 \text{ dB}$ reading on the power meter.
- 8. On the analyzer, press **Single**, and wait for the sweep to finish. Press following keys:

Marker, Select Marker (2) Peak Search (or Search) Marker Delta

9. On the analyzer, press AMPLITUDE, Ref Level, -30 dBm.

10. Repeat step a through step h using the data in Table 2-68 for Band 0.

- a. Set the synthesized sweeper to the listed CW frequency.
 - Do not set the synthesized sweeper to frequencies outside the frequency range of the analyzer.
- b. Enter the appropriate power sensor calibration factor into the power meter.
- c. Adjust the synthesized sweeper power level until the power meter reading is equal to the Mixer Level in Table 2-68, ±0.1 dB.
- d. On the analyzer, press **Single** and wait for the completion of a new sweep. Then, press **Peak Search** (or **Search**).
- e. If the Mixer Level in Table 2-68 is -20 dBm, press Marker, Select Marker (2).
- f. If the Mixer Level in Table 2-68 is -10 dBm, press Marker, Select Marker (1).
- g. On the analyzer, press Peak Search (or Search).
- h. Record the delta marker (Δ Mkr) amplitude reading in Table 2-68 and in the appropriate entry locations in the performance verification test record.
- 11.On the analyzer, press the following keys:

Marker, More, Marker All Off Auto Couple SPAN, 1 MHz AMPLITUDE, Ref Level, -10 dBm AMPLITUDE, Attenuation, 0 dB Sweep, Sweep (Cont)

NOTE

End of procedure for Agilent E4402B and E4403B.

Band 1

12.On the analyzer, press the following keys:

FREQUENCY, Center Freq, 4 GHz

- 13.On the synthesized sweeper, press CW, 4 GHz.
- 14.Enter the power sensor 4 GHz calibration factor into the power meter.
- 15.On the analyzer, press the following keys:

Marker, More, Marker All Off Amplitude, Presel Center

16.Repeat step 5 through step 11 for the synthesized sweeper CW

29. Other Input-Related Spurious Responses: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B

frequencies listed in Table 2-68 for Band 1.

NOTE

End of procedure for Agilent E4404B.

Band 2

17.On the analyzer, press the following keys:

FREQUENCY, Center Freq, 9 GHz

- 18.On the synthesized sweeper, press CW, 9 GHz.
- 19.Enter the power sensor 9 GHz calibration factor into the power meter.
- 20.On the analyzer press the following keys:

AMPLITUDE, Presel Center Marker, More, Marker All Off

21.Repeat step 5 through step 11 for the synthesized sweeper CW frequencies listed in Table 2-68 for Band 2.

NOTE

End of procedure for Agilent E4405B.

Band 3

22.On the analyzer, press the following keys:

FREQUENCY, Center Freq, 15 GHz

- 23.On the synthesized sweeper, press: CW, 15 GHz.
- 24.Enter the power sensor 15 GHz calibration factor into the power meter.
- 25.On the analyzer press the following keys:

AMPLITUDE, Presel Center Marker, More, Marker All Off

26.Repeat step 5 through step 11 for the synthesized sweeper CW frequencies listed in Table 2-68 for Band 3 for the 15 GHz analyzer center frequency.

Band 4

27.On the analyzer, press:

FREQUENCY, Center Freq, 21 GHz

- 28.On the synthesized sweeper, press: CW, 21 GHz.
- 29.Enter the power sensor 21 GHz calibration factor into the power meter.

- 30.On the analyzer, press AMPLITUDE, Presel Center.
- 31.On the analyzer, press the following:

Marker, More, Marker All Off

32.Repeat step 5 through step 11 for the synthesized sweeper CW frequencies listed in Table 2-68 for Band 4 for the 21 GHz analyzer center frequency.

Table 2-68 Other Input-Related Spurious Responses

Band	Analyzer Center Frequency (GHz)	Synthesized Sweeper CW Frequency (MHz)	Mixer Level (dBm)	Test Record Entry Δ Mkr1 or Δ Mkr2 Amplitude			
0	2.0	2042.8 ^a	-20	1)			
	2.0	2642.8 ^a	-20	2)			
	2.0	1820.8 ^b	-20	3)			
	2.0	278.5 ^b	-20	4)			
	he following data a 3 and E4408B	applies only to the Agile	ent E4404B	, E4405B,			
0	2.0	5600.0 ^c	-10	5)			
	2.0	6242.8 ^c	-10	6)			
1	4.0	4042.8 ^a	-20	7)			
	4.0	4642.8 ^a	-20	8)			
	4.0	3742.9 ^b	-20	9)			
	4.0	2242.8 ^c	-10	10)			
	Note: The following data applies only to the Agilent E4405B, E4407B and E4408B						
2	9.0	9042.8 ^a	-20	11)			
	9.0	9642.8 ^a	-20	12)			
	9.0	4982.1 ^b	-20	13)			
	9.0	9342.8 ^c	-10	14)			
Note: T	he following data a	applies only to the Agile	ent E4407B	and E4408B			
3	15.0	15042.8 ^a	-20	15)			

29. Other Input-Related Spurious Responses: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B

Table 2-68 Other Input-Related Spurious Responses

Band	Analyzer Center Frequency (GHz)	Synthesized Sweeper CW Frequency (MHz)	Mixer Level (dBm)	Test Record Entry △ Mkr1 or △ Mkr2 Amplitude
	15.0	15642.8 ^a	-20	16)
	15.0	18830.35 ^b	-20	17)
	15.0	4151.75 ^c	-10	18)
4	21.0	21042.8 ^a	-20	19)
	21.0	21642.8 ^a	-20	20)
	21.0	21342.8 ^b	-20	21)
	21.0	5008.95 ^c	-10	22)

- a. Image response
- b. Multiple response
- c. Out-of-band response

30. Spurious Responses: Agilent E4401B and E4411B

This test is performed in two parts. Part 1 measures third order intermodulation distortion. Part 2 measures second harmonic distortion.

To test second harmonic distortion, a low pass filter is used to filter the source output, ensuring that harmonics read by the analyzer are internally generated and not coming from the source. To measure the distortion products, the power at the mixer is set 25 dB higher than specified.

For example, if the specification states that with -40 dBm at the input mixer, the distortion products should be suppressed by >75 dBc, the equivalent second harmonic intercept (SHI) is >35 dBm(-40 dBm + 75 dBc). Measuring with -15 dBm at the mixer and verifying the distortion products suppressed by >50 dBc also ensures the SHI is >35 dBm (-15 dBm + 50 dBc).

For third order intermodulation distortion, two signals are combined in a directional bridge to provide isolation. These two signals are applied to the analyzer input. The power level of the two signals is several dB higher than specified, so the distortion products should be suppressed by less than the amount specified. In this manner, the equivalent third order intercept (TOI) is measured.

For example, if the specification states that with two –30 dBm signals at the input mixer, the distortion products should be suppressed by >80 dBc, which yields a third order intercept of >10 dBm (–30 dBm + (80 dBc/2)). Measuring with –20 dBm at the mixer and verifying the distortion products are suppressed by >60 dBc, the equivalent TOI is also >10 dBm (–20 dBm + (60 dBc/2)).

There are no related adjustment procedures for this performance test.

Equipment Required

Synthesized signal generator
Synthesized sweeper
Power meter, dual channel
RF power sensor
Power splitter
Directional bridge
50 MHz low pass filter
Cable, BNC, 120-cm
Cable, APC 3.5, 91-cm (2 required)
Adapter, Type-N (m) to APC 3.5 (f) (3 required)
Adapter, Type-N (m) to SMA (m)

Adapter, Type-N (m) to BNC (f) Adapter, Type-N (m) to Type-N (m) Adapter, SMA (f) to BNC (m) Adapter, APC 3.5 (f) to APC 3.5 (f)

Additional Equipment for 75 Ω Input

Power sensor, 75 Ω Adapter, mechanical, Type-N (m) 50 Ω , to Type-N (m), 75 Ω Adapter, Type-N (m), to BNC (m), 75 Ω

Procedure

This performance test consists of two parts:

Part 1: Third Order Intermodulation Distortion

Part 2: Second Harmonic Distortion

Perform Part 1 before Part 2.

Part 1: Third Order Intermodulation Distortion

1. Zero and calibrate the power meter and RF power sensor in log mode (power reads out in dBm), as described in the power meter operation manual.

75 Ω Input only: Use a 75 Ω power sensor.

CAUTION

Use only 75 Ω cables, connectors, or adapters on instruments with 75 Ω connectors, or damage to the connectors will occur.

2. Connect the equipment as shown in Figure 2-45 with the output of the directional bridge connected to the power sensor.

75 Ω Input only: Use the 75 Ω power sensor with the 50 Ω to 75 Ω mechanical adapter.

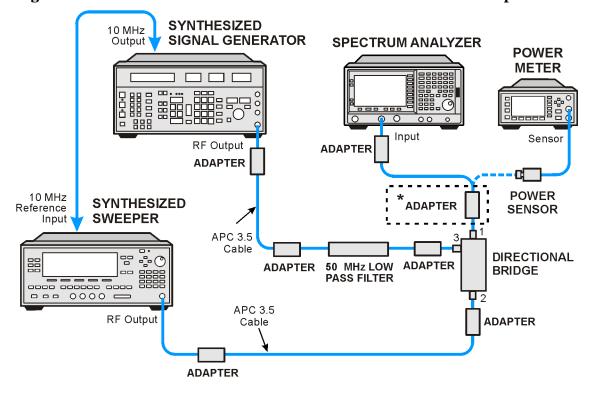


Figure 2-45 Third Order Intermodulation Distortion Test Setup

*50 -75 ohm Mechanical Adapter (75 ohm Input Only)

c1711b

3. Perform step 4 through step 29 using the information and entries from Table 2-69. Then continue with step 30 through step 38.

Table 2-69 Test Equipment Settings for Testing TOI

TOI Test	F1 (MHz)	F2 (MHz)	Low Pass Filter (MHz)
1	50.0	50.05	50
Option 1DR	50.0	50.05	50

- 4. Press Blue Key, Special, 0, 0 on the signal generator. Set the frequency to the F1 value for TOI Test 1 in Table 2-69. Set the amplitude to 4 dBm.
- 5. Press **PRESET** on the synthesized sweeper. Set the CW frequency of the synthesized sweeper to the F2 value for TOI Test 1 in Table 2-69. Then press the following:

POWER LEVEL, -10 dBm RF Off

6. Enter the power sensor calibration factor for the signal generator

frequency into the power meter.

7. Adjust the amplitude of the signal generator until the power meter reads -12 dBm ± 0.1 dB.

75 Ω Input only: The power measured at the output of the 50 Ω directional bridge by the 75 Ω power sensor is the equivalent power "seen" by the 75 Ω analyzer.

8. Disconnect the power sensor from the directional bridge. Connect the directional bridge directly to the analyzer input using an adapter (do not use a cable).

75 Ω Input only: Use a 50 Ω to 75 Ω mechanical adapter and a 75 Ω Type-N(m) to BNC(m) adapter.

CAUTION

Support the directional bridge and low pass filter to minimize stress on the analyzer input connector.

9. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Press **System**, **Alignments**, **Auto Align**, **Off**. Set the analyzer center frequency to the F1 value for TOI Test 1 in Table 2-69. Then, set the analyzer by pressing the following keys:

FREQUENCY, CF Step, 50 kHz (Man) SPAN, 20 kHz AMPLITUDE, More, Y Axis Units $(or\ Amptd\ Units)$, dBm AMPLITUDE, Ref Level, $-5\ dBm\ (50\ \Omega\ Input\ only)$ AMPLITUDE, Ref Level, $-10\ dBm\ (75\ \Omega\ Input\ only)$ AMPLITUDE, Attenuation, 5 dB $(Man)\ (50\ \Omega\ Input\ only)$ AMPLITUDE, Attenuation, 0 dB $(Man)\ (75\ \Omega\ Input\ only)$ BW/Avg, 1 kHz (Man) BW/Avg, Video BW, 300 Hz (Man) Peak Search $(or\ Search)$, More, Search Param, Peak Excursn, 3 dB

10.On the analyzer, press the following keys:

Peak Search (or Search) Meas Tools $Mkr \rightarrow CF$, Delta

- 11.On the analyzer, press **FREQUENCY**, \uparrow .
- 12. If the resolution bandwidth is $\geq 1 \text{kHz}$, press SPAN, 4 kHz.
- 13.On the synthesized sweeper, set the RF On.
- 14.On the analyzer, press Peak Search (or Search).
- 15.On the synthesized sweeper, adjust the power level until the marker delta (Δ Mkr1) amplitude reads 0 dB \pm 0.05 dB.
- 16.On the analyzer, press: **FREQUENCY**, \downarrow , \downarrow . The center frequency should now be lower than the signal generator frequency by the CF Step value.

- 17.Set the analyzer reference level to −15 dBm.
 - 75 Ω Input only: Set the reference level to -20 dBm.
- 18.On the analyzer, press **BW/Avg**, **Average**, **20**, and wait for "Vavg 20" to appear along the left side of the display.
- 19.On the analyzer, press **Peak Search** (or **Search**) and record the marker amplitude reading in Table 2-70 as the Lower Distortion Amplitude.
- 20.On the analyzer, press BW/Avg, Average Off.
- 21.On the analyzer, increment the center frequency by three times the CF Step value. Press **FREQUENCY**, **Center Freq**, ↑, ↑, ↑. The center frequency should now be one CF Step value above the synthesized sweeper frequency.
- 22.Set the synthesized signal generator frequency to F2 as indicated in Table 2-69.
- 23.Set the synthesized sweeper CW frequency to F1 as indicated in Table 2-69.
- 24.On the analyzer, press **BW/Avg**, **Average**, **20**, and wait for Vavg 20 to appear along the left side of the display.
- 25.On the analyzer, press **Peak Search** (or **Search**) and record the marker amplitude reading in Table 2-70 as the Upper Distortion Amplitude.
- 26.On the analyzer, press BW/Avg, Average Off.
- 27.Of the Lower Distortion Amplitude and Upper Distortion Amplitudes recorded in Table 2-70, enter the most positive value as the Worst Distortion Amplitude in Table 2-70. For example, if the Upper Distortion Amplitude is -62 dBc and the Lower Distortion Amplitude is -63 dBc, enter -62 dBc as the Worst Distortion Amplitude.
- 28.If the analyzer has a 50 Ω input, enter -17 dBm as the Mixer Level in Table 2-70 (-12 dBm input power 5 dB input attenuation). If the analyzer has a 75 Ω input, enter 36.75 dBmV as the Mixer Level in Table 2-70 (-12 dBm = 36.75 dBmV).
- 29.Calculate the equivalent TOI by subtracting one half of the Worst Distortion Amplitude (in dB) from the Mixer Level (in dBm or dBmV). Enter the result in Table 2-70 as the Calculated TOI. For example, if the Worst Distortion Amplitude is -62 dBc and the Mixer Level is -17 dBm, the Calculated TOI would be:

$$TOI = -17 \text{ dBm} - \left(-\frac{62 \text{ dB}}{2}\right) = -17 \text{ dBm} + 31 \text{ dB} = +14 \text{ dBm}$$

Table 2-70 Third Order Intermodulation Distortion Worksheet

TOI Test	Lower Distortion Amplitude	Upper Distortion Amplitude	Worst Distortion Amplitude	Mixer Level	Test Record Entry Calculated TOI
1					1)
Option 1DR					2)

- 30.If the analyzer is an E4401B and is equipped with Option 1DR, Narrow Resolution Bandwidth, perform step 31 through step 36. Otherwise, continue with step 37.
- 31.Set synthesized signal generator frequency to the F1 value used in TOI Test 1 of Table 2-69.
- 32.Set synthesized sweeper CW frequency to the F2 value used in TOI Test 1 of Table 2-69.
- 33.Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Press **System**, **Alignments**, **Auto Align**, **Off**. Set the analyzer to the F1 value for TOI Test Option 1DR in Table 2-69. Then set the analyzer by pressing the following keys:

FREQUENCY, CF Step, 50 kHz (Man) SPAN, 20 kHz AMPLITUDE, More, Y Axis Units $(or\ Amptd\ Units)$, dBm AMPLITUDE, Ref Level, -5 dBm $(50\ \Omega\ Input\ only)$ AMPLITUDE, Ref Level, -10 dBm $(75\ \Omega\ Input\ only)$ AMPLITUDE, Attenuation, 5 dB $(Man)\ (50\ \Omega\ Input\ only)$ AMPLITUDE, Attenuation, 0 dB $(Man)\ (75\ \Omega\ Input\ only)$ BW/Avg, 1 kHz (Man) BW/Avg, Video BW, 300 Hz (Man) Peak Search $(or\ Search)$, More Search Param $(or\ Search\ Criteria)$, Peak Excursn, 3 dB

34.On the analyzer, press the following keys:

 $\begin{array}{l} \textbf{Peak Search} \; (or \; \textbf{Search}) \\ \textbf{Marker} \rightarrow \\ \textbf{Mkr} \rightarrow \textbf{CF} \\ \end{array}$

35.Set the analyzer as follows:

SPAN, 500 Hz BW/Avg, Res BW, 30 Hz BW/Avg, Video BW, 10 Hz

- 36.Repeat step 10 through step 29. This is the TOI test for Option 1DR.
- 37.On the analyzer, press System, Alignments, Auto Align, On.
- 38.Part 1: Third Order Intermodulation Distortion is complete. Continue with Part 2: Second Harmonic Distortion.

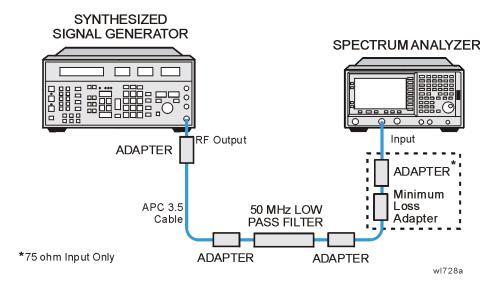
Part 2: Second Harmonic Distortion

1. Set the synthesized signal generator controls as follows:

```
FREQUENCY, 40 MHz AMPLITUDE, –10 dBm (50~\Omega~Input~only) AMPLITUDE, –4.3 dBm (75~\Omega~Input~only)
```

2. Connect the equipment as shown in Figure 2-46.

Figure 2-46 Second Harmonic Distortion Test Setup



75 Ω Input only: Connect the minimum loss adapter between the LPF and INPUT 75 Ω

3. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the controls as follows:

```
FREQUENCY, Center Freq, 40 MHz SPAN, 1 MHz AMPLITUDE, -10 dBm (50~\Omega~Input~only) AMPLITUDE, 44 dBmV (75~\Omega~Input~only) Attenuation Auto Man 10 dB BW/Avg, 30 kHz
```

4. Adjust the synthesized signal generator amplitude to place the peak of the signal at the reference level.

30. Spurious Responses: Agilent E4401B and E4411B

5. Set the analyzer control as follows:

SPAN, 50 kHz BW/Avg, 1 kHz Video BW Auto Man, 100 Hz

6. Wait for two sweeps to finish, then press the following analyzer keys:

Peak Search (or Search) $\begin{tabular}{ll} Mkr \to , Mkr \to CF Step \\ Marker, Delta \\ FREQUENCY, Center Freq, \end{tabular}$

- 7. Press Peak Search (or Search). The marker delta (Δ Mkr1) amplitude reading is the second harmonic suppression.
- 8. If the analyzer has a 50 Ω input, calculate the second harmonic intercept (SHI) using the second harmonic suppression value read in step 7 as follows:

SHI = -20 dBm - Second Harmonic Suppression

For example, if the second harmonic suppression is -62 dB, the SHI would be 42 dBm:

$$42 \text{ dBm} = -20 \text{ dBm} - (-62 \text{ dB})$$

9. If the analyzer has a 75 Ω input, calculate the second harmonic intercept (SHI) using the second harmonic suppression value read in step 7 as follows:

SHI = 34 dBmV – Second Harmonic Suppression

For example, if the second harmonic suppression is -65 dB, the SHI would be 99 dBmV:

$$99 \text{ dBmV} = 34 \text{ dBmV} - (-65 \text{ dB})$$

10.Record the SHI result as Entry 3 in the performance verification test record.

31. Spurious Responses: Agilent E4402B and E4403B

This test is performed in two parts. Part 1 measures third order intermodulation distortion; Part 2 measures second harmonic distortion.

To test second harmonic distortion, a low pass filter is used to filter the source output, ensuring that harmonics read by the analyzer are internally generated and not coming from the source. To measure the distortion products, the power at the mixer is set 25 dB higher than specified.

For example, if the specification states that with -30 dBm at the input mixer, the distortion products should be suppressed by >75 dBc, the equivalent second harmonic intercept (SHI) is >45 dBm (-30 dBm + 75 dBc). Measuring with -15 dBm at the mixer and verifying the distortion products suppressed by >60 dBc also ensures the SHI is >45 dBm (-15 dBm + 60 dBc).

For third order intermodulation distortion, two signals are combined in a directional bridge to provide isolation. These two signals are applied to the analyzer input. The power level of the two signals is several dB higher than specified, so the distortion products should be suppressed by less than the amount specified. In this manner, the equivalent third order intercept (TOI) is measured.

For example, if the specification states that with two –30 dBm signals at the input mixer, the distortion products should be suppressed by >82 dBc, which yields a third order intercept of >11 dBm (–30 dBm + (82 dBc/2)). Measuring with –20 dBm at the mixer and verifying the distortion products are suppressed by >62 dBc, the equivalent TOI is also >11 dBm (–20 dBm + (62 dBc/2)).

There are no related adjustment procedures for this performance test.

Equipment Required

Synthesized signal generator
Synthesized sweeper
Power meter, dual channel
RF power sensor
Power splitter
Directional bridge
300 MHz low pass filter
Cable, APC 3.5, 91-cm (2 required)
Cable, BNC, 120-cm
Adapter, Type-N (m) to APC 3.5 (f) (3 required)
Adapter, Type-N (m) to SMA (m)

31. Spurious Responses: Agilent E4402B and E4403B

Adapter, Type-N (m) to BNC (f) Adapter, Type-N (m) to Type-N (m) Adapter, SMA (f) to BNC (m) Adapter, APC 3.5 (f) to APC 3.5 (f)

Procedure

This performance test consists of two parts:

Part 1: Third Order Intermodulation Distortion

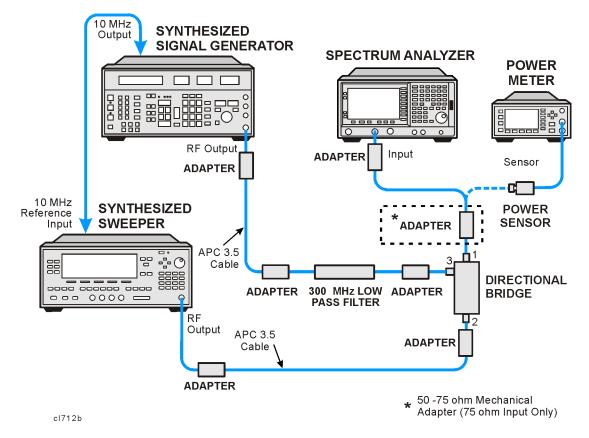
Part 2: Second Harmonic Distortion

Perform Part 1 before Part 2.

Part 1: Third Order Intermodulation Distortion

- 1. Zero and calibrate the power meter and RF power sensor in log mode (power reads out in dBm), as described in the power meter operation manual.
- 2. Connect the equipment as shown in Figure 2-47 with the output of the directional bridge connected to the power sensor.

Figure 2-47 Third Order Intermodulation Distortion Test Setup



3. Perform step 4 through step 29 using the information and entries from Table 2-71. Then continue with step 30 through step 38.

Table 2-71 Test Equipment Settings for TOI

TOI Test	F1 (MHz)	F2 (MHz)	Low Pass Filter (MHz)
1	300.0	300.05	300
Option 1DR	300.0	300.05	300

- 4. Press **Blue Key**, **Special**, **0**, **0** on the signal generator. Set the frequency to F1 in Table 2-71 for TOI Test 1. Set the amplitude to 4 dBm.
- 5. Press **PRESET** on the synthesized sweeper, and set the frequency to F2 in Table 2-71 for TOI Test 1. Set the synthesized sweeper controls as follows:

POWER LEVEL, -10 dBm RF Off

- 6. Enter the power sensor calibration factor for the signal generator frequency into the power meter.
- 7. Adjust the amplitude of the signal generator until the power meter reads -12 dBm ± 0.1 dB.
- 8. Disconnect the power sensor from the directional bridge. Connect the directional bridge directly to the analyzer input using an adapter (do not use a cable).

CAUTION

Support the directional bridge and low pass filter to minimize stress on the analyzer input connector.

9. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Press **System**, **Alignments**, **Auto Align**, **Off**. Set the analyzer center frequency to the F1 value for TOI Test 1 in Table 2-71. Then, set the analyzer by pressing the following keys:

FREQUENCY, CF Step, 50 kHz (Man) SPAN, 20 kHz AMPLITUDE, More, Y Axis Units $(or\ Amptd\ Units)$, dBm AMPLITUDE, Ref Level, $-5\ dBm$ AMPLITUDE, Attenuation, 5 dB (Man) BW/Avg, 1 kHz (Man) BW/Avg, Video BW, 300 Hz (Man) Peak Search $(or\ Search)$, More Search Param $(or\ Search\ Criteria)$, Peak Excursn, 3 dB

10.On the analyzer, press the following keys:

Peak Search (or Search)

Marker → Mkr → CF Delta

- 11.On the analyzer, press: **FREQUENCY**, ↑.
- 12.If the resolution bandwidth is ≥ 1 kHz, press: **SPAN**, 4 kHz.
- 13.On the synthesized sweeper, set the RF on.
- 14.On the analyzer, press Peak Search (or Search).
- 15.On the synthesized sweeper, adjust the power level until the marker delta (Δ Mkr1) amplitude reads 0 dB \pm 0.05 dB.
- 16.On the analyzer, press **FREQUENCY**, \downarrow , \downarrow . The center frequency should now be lower than the signal generator frequency by the CF Step value.
- 17.Set the analyzer reference level to −15 dBm.
- 18.On the analyzer, press: **BW/Avg**, **Average**, **20**, and wait for "Vavg 20" to appear along the left side of the display.
- 19.On the analyzer, press **Peak Search** (or **Search**) and record the marker amplitude reading in Table 2-72 as the Lower Distortion Amplitude.
- 20.On the analyzer, press: **BW/Avg**, **Average Off**.
- 21.On the analyzer, press **FREQUENCY**, **Center Freq**, \uparrow , \uparrow . The center frequency should now be one CF Step value above the synthesized sweeper frequency.
- 22.Set the synthesized signal generator frequency to F2 as indicated in Table 2-71.
- 23.Set the synthesized sweep CW frequency to F1 as indicated in Table 2-71.
- 24.On the analyzer, press **BW/Avg**, **Average**, **20**, and wait for "Vavg 20" to appear along the left side of the display.
- 25.On the analyzer, press **Peak Search** (or **Search**) and record the marker amplitude reading in Table 2-72 as the Upper Distortion Amplitude.
- 26.On the analyzer, press BW/Avg, Average Off.
- 27.Of the Lower Distortion Amplitude and Upper Distortion Amplitudes recorded in Table 2-72, enter the most positive value as the Worst Distortion Amplitude in Table 2-72. For example, if the Upper Distortion Amplitude is -62 dBc and the Lower Distortion Amplitude is -63 dBc, enter -62 dBc as the Worst Distortion Amplitude.
- 28.Enter –17 dBm as the Mixer Level in Table 2-72 (–12 dBm input power –5 dB input attenuation).
- 29. Calculate the equivalent TOI by subtracting one half of the Worst

Distortion Amplitude (in dB) from the Mixer Level (in dBm). Enter the result in Table 2-72 as the Calculated TOI. For example, if the Worst Distortion Amplitude is -62 dBc and the Mixer Level is -17 dBm, the Calculated TOI would be:

TOI =
$$-17 \text{ dBm} - \left(-\frac{62 \text{ dB}}{2}\right) = -17 \text{ dBm} + 31 \text{ dB} = +14 \text{ dBm}$$

Table 2-72 Third Order Intermodulation Distortion Worksheet

TOI Test	Lower Distortion Amplitude	Upper Distortion Amplitude	Worst Distortion Amplitude	Mixer Level	Test Record Entry Calculated TOI
1					1)
Option 1DR					2)

- 30.If the analyzer is an E4402B and is equipped with Option 1DR, Narrow Resolution Bandwidth, perform step 31 through step 36. Otherwise, continue with step 37.
- 31.Set synthesized signal generator frequency to F1 as indicated in Table 2-71 for TOI Test 1.
- 32.Set synthesized sweeper CW frequency to F2 as indicated in Table 2-71 for TOI Test 1.
- 33.Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Press **System**, **Alignments**, **Auto Align**, **Off.** Set the analyzer center frequency to the F1 value for TOI Test Option 1DR in Table 2-71. Then, set the analyzer by pressing the following keys:

FREQUENCY, CF Step, 50 kHz (Man) SPAN, 20 kHz AMPLITUDE, More, Y Axis Units $(or\ Amptd\ Units)$, dBm AMPLITUDE, Ref Level, -5 dBm AMPLITUDE, Attenuation, 5 dB (Man) BW/Avg, 1 kHz (Man) BW/Avg, Video BW, 300 Hz (Man) Peak Search $(or\ Search)$, More, Search Param (or\ Search Criteria), Peak Excursn, 3 dB

34.On the analyzer, press the following keys:

 $\begin{array}{l} \textbf{Peak Search} \; (or \; \textbf{Search}) \\ \textbf{Marker} \rightarrow \\ \textbf{Mkr} \rightarrow \textbf{CF} \\ \end{array}$

35.Set the analyzer as follows:

SPAN, 500 Hz BW/Avg, Res BW, 30 Hz Video BW, 10 Hz

- 36.Repeat step 10 through step 29. This is the TOI test for Option 1DR.
- 37.On the analyzer, press System, Alignments, Auto Align, On.
- 38.Part 1: Third Order Intermodulation Distortion is complete. Continue with Part 2: Second Harmonic Distortion.

Part 2: Second Harmonic Distortion

1. Zero and calibrate the power meter and RF power sensor. Enter the power sensor 300 MHz calibration factor into the power meter.

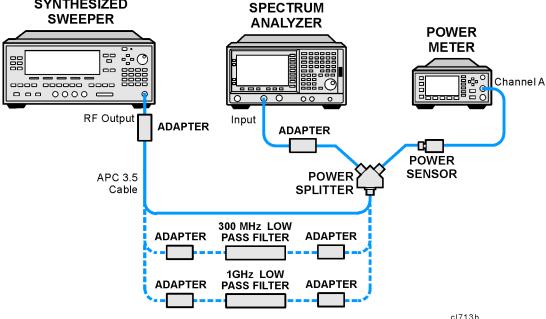
Measuring the 300 MHz Frequency Response Error

2. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the controls as follows:

FREQUENCY, 300 MHz SPAN, 10 MHz

3. Connect the equipment as shown in Figure 2-48, with the output of the synthesized sweeper connected to the power splitter input and the power splitter outputs connected to the analyzer and power sensor.

Figure 2-48 Second Harmonic Distortion Test Setup
SYNTHESIZED SPECTRUM



4. Preset the synthesized sweeper and set the controls as follows:

CW, 300 MHz POWER LEVEL, 0 dBm

5. On the analyzer, press Peak Search (or Search), Marker, Delta.

- 6. Record the power meter reading at 300 MHz in Table 2-73.
- 7. Set the synthesized sweeper CW to 600 MHz.
- 8. On the analyzer, press FREQUENCY, 600 MHz, then Peak Search (or Search).
- 9. Adjust the synthesized sweeper power level until the marker delta (Δ Mkr1) amplitude reads 0 dB \pm 0.10 dB.
- 10.Enter the power sensor 600 MHz calibration factor into the power meter.
- 11.Record the power meter reading at 600 MHz in Table 2-73.
- 12.Subtract the power meter reading at 600 MHz from the power meter reading at 300 MHz. Record this difference as the 300 MHz Frequency Response Error in Table 2-73. For example, if the power meter reading at 600 MHz is -6.45 dBm and the power meter reading at 300 MHz is -7.05 dBm, the 300 MHz Frequency Response Error would be -0.60 dB:

$$-0.60 \text{ dB} = -7.05 \text{ dBm} - (-6.45 \text{ dBm})$$

Table 2-73 Second Harmonic Distortion Worksheet

Description	Measurement
Power Meter Reading at 300 MHz	dBm
Power Meter Reading at 600 MHz	dBm
300 MHz Frequency Response Error (FRE)	dB
Power Meter Reading at 900 MHz	dBm
Power Meter Reading at 1800 MHz	dBm
900 MHz Frequency Response Error (FRE)	dB

Measuring 900 MHz Frequency Response Error

13.On the synthesized sweeper, press the following:

CW, 900 MHz POWER LEVEL, 0 dBm

- 14.On the analyzer, press FREQUENCY, Center Freq, 900 MHz.
- 15.Enter the power sensor 1 GHz calibration factor into the power meter.
- 16.On the analyzer, press

Marker, Off Peak Search (or Search). Marker, Delta

- 17.Record the power meter reading in Table 2-73 as the 900 MHz power meter reading.
- 18.On the synthesized sweeper, press CW, 1.8 GHz.
- 19.On the analyzer, press the following:

FREQUENCY, Center Freq, 1.8 GHz Peak Search (or Search) AMPLITUDE

- 20.On the analyzer, press Peak Search (or Search).
- 21.Adjust the synthesized sweeper power level until the marker delta $(\Delta \, \text{Mkr1})$ amplitude reads 0 dB ± 0.1 dB.
- 22.Enter the power sensor 2 GHz calibration factor into the power meter.
- 23.Record the power meter reading in Table 2-73 as the 1.8 GHz power meter reading.
- 24.On the analyzer, press Marker, Off.
- 25.Subtract the power meter reading at 1.8 GHz from the power meter reading at 900 MHz. Record this difference as the 900 MHz Frequency Response Error in Table 2-73. For example, if the power meter reading at 1.8 GHz is -6.35 dBm and the power meter reading at 900 MHz is -7.05 dBm, the 900 MHz Frequency Response Error would be -0.7 dB:

$$-0.70 \text{ dB} = -7.05 \text{ dBm} - (-6.35 \text{ dBm})$$

Measuring the 300 MHz Second Harmonic Distortion

- 1. Connect the equipment as shown in Figure 2-48 using the 300 MHz Low Pass Filter.
- 2. On the synthesized sweeper, press:

CW, 300 MHz POWER LEVEL, -10 dBm

- 3. Enter the power sensor 300 MHz calibration factor into the power meter.
- 4. On the analyzer, press the following:

FREQUENCY, Center Freq, 300 MHz SPAN, 100 kHz AMPLITUDE, Ref Level, -10 dBm AMPLITUDE, Attenuation, 10 dB (Man) BW/Avg, Res BW 1 kHz (Man) Video BW, 1 kHz (Man) Markers, Off

- 5. Adjust the synthesized sweeper power level until the power meter reading is $-10 \text{ dBm } \pm 0.2 \text{ dB}$.
- 6. On the analyzer, press the following:

Peak Search (or Search), Marker, Delta FREQUENCY, 600 MHz BW/Avg, 10

Wait for the "Vavg 10" to appear along the left side of the display.

- 7. On the analyzer, press **Peak Search** (or **Search**). The marker delta (Δ Mkr1) amplitude is the second harmonic suppression.
- 8. On the synthesized sweeper, press Marker, Off.
- 9. Calculate the 300 MHz Second Harmonic Intercept (SHI) using the second harmonic suppression value read in step 7 and the 300 MHz Frequency Response Error (FRE) from Table 2-73 as follows:

```
300 MHz SHI = -20 dBm - Second Harmonic Suppression + 300 MHz FRE
```

For example, if the second harmonic suppression is –59 dB, and the 300 MHz FRE is –0.60 dB, the SHI would be 38.4 dBm:

```
38.4 \, dBm = -20 \, dBm - (-59 \, dB) + (-0.60 \, dB)
```

10.Record the 300 MHz SHI as Entry 3 in the performance verification test record.

Measuring 900 MHz Second Harmonic Distortion

- 1. Replace the 300 MHz low pass filter with the 1 GHz low pass filter as shown in Figure 2-48.
- 2. On the synthesized sweeper, press the following:

```
CW, 900 MHz
POWER LEVEL, -10 dBm
```

- 3. Enter the power sensor 1 GHz calibration factor into the power meter.
- 4. On the analyzer, press FREQUENCY, Center Freq, 900 MHz.
- 5. On the analyzer, press Peak Search (or Search).
- 6. Adjust the synthesized sweeper power level until the power meter reading is $-10 \text{ dBm } \pm 0.1 \text{ dB}$.
- 7. On the analyzer, press the following:

Peak Search (or Search)
Marker, Delta
FREQUENCY, Center Freq, 1.8 GHz

8. On the analyzer, press the following:

AMPLITUDE, Ref Level, -20 dBm BW/Avg, Video BW, 30 Hz (Man)

- 9. On the analyzer, press **BW/Avg**, **Average**, **10 Hz**. Wait until "VAvg 10" is displayed along the left side of the display.
- 10.On the analyzer, press **Peak Search** (or **Search**). The marker delta (Δ Mkr1) amplitude reading is the second harmonic suppression.
- 11.Calculate the 900 MHz Second Harmonic Intercept (SHI) using the second harmonic suppression value read in step 10 and the 300 MHz Frequency Response Error (FRE) from Table 2-73 as follows:

```
900 MHz SHI = -20 dBm - Second Harmonic Suppression + 900 GHz FRE
```

For example, if the second harmonic suppression is –73 dB, and the 900 MHz FRE is 0.70 dB, the SHI would be 52.3 dBm:

$$52.3 \text{ dBm} = -20 \text{ dBm} - (-73 \text{ dB}) + (-0.70 \text{ dB})$$

12.Record the 900 MHz SHI as Entry 4 in the performance verification test record.

32. Spurious Responses: Agilent E4404B, E4405B, E4407B, and E4408B

This test is performed in two parts. Part 1 measures third order intermodulation distortion. Part 2 measures second harmonic distortion.

To test second harmonic distortion, a low pass filter is used to filter the source output, ensuring that harmonics read by the analyzer are internally generated and not coming from the source. To measure the distortion products, the power at the mixer is set 25 dB higher than specified.

A power meter, power sensor, and power splitter are used to characterize the frequency response of the analyzer so this uncertainty can be eliminated.

For example, if the specification states that with -30 dBm at the input mixer, the distortion products should be suppressed by >75 dBc, the equivalent second harmonic intercept (SHI) is >45dBm (-30 dBm + 75 dBc). Measuring with -15 dBm at the mixer and verifying the distortion products suppressed by >60 dBc also ensures the SHI is >45 dBm (-15 dBm + 60 dBc).

For third order intermodulation distortion, two signals are combined in a directional bridge or directional coupler to provide isolation. These two signals are applied to the analyzer input. The power level of the two signals is several dB higher than specified, so the distortion products should be suppressed by less than the amount specified. In this manner, the equivalent third order intercept (TOI) is measured.

For example, if the specification states that with two -30 dBm signals at the input mixer, the distortion products should be suppressed by >75 dBc, which yields a third order intercept of >7.5 dBm (-30 dBm + (75 dBc/2)). Measuring with -20 dBm at the mixer and verifying the distortion products are suppressed by >55 dBc, the equivalent TOI is also >7.5 dBm (-20 dBm + (55 dBc/2)).

There are no related adjustment procedures for this performance test.

Equipment Required

Synthesized sweeper (2 required)
Power meter, dual channel
Microwave power sensor
Microwave power splitter
Directional bridge
Directional coupler
300 MHz low pass filter
1 GHz low pass filter

32. Spurious Responses: Agilent E4404B, E4405B, E4407B, and E4408B

1.8 GHz low pass filter (2 required)
4.4 GHz low pass filter (2 required)
Cable, BNC, 120-cm (48-in)
Cable, APC 3.5, 91-cm (48-in) (2 required)
Adapter, Type-N (m) to APC 3.5 (f) (3 required)
Adapter, Type-N (m) to SMA (m)
Adapter, Type-N (m) to BNC (f)
Adapter, Type-N (m) to Type-N (m)
Adapter, SMA (f) to BNC (m)
Adapter, APC 3.5 (f) to APC 3.5 (f)

Procedure

This performance test consists of two parts:

Part 1: Third Order Intermodulation Distortion

Part 2: Second Harmonic Distortion

Perform Part 1 before Part 2.

Part 1: Third Order Intermodulation Distortion

- 1. Zero and calibrate the power meter and microwave power sensor in log mode (power reads out in dBm), as described in the power meter operation manual.
- 2. Connect the equipment as shown in Figure 2-49 using the 300 MHz low pass filter with the output of the directional bridge connected to the power sensor.

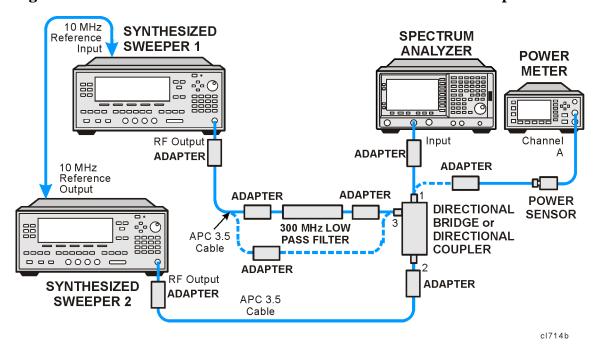


Figure 2-49 Third Order Intermodulation Distortion Test Setup

3. Perform step 4 through step 29 using the information and entries from Table 2-74. Then continue with step 31 through step 43.

Table 2-74 Test Equipment Settings for TOI

TOI Test	F1 (MHz)	F2 (MHz)	Low Pass Filter (MHz)	Bridge or Coupler	Presel Center
1	300.0	300.05	300	Bridge	No
Option 1DR	300.0	300.05	300	Bridge	No
2	5000.0	5000.05	None	Coupler	Yes
3	8000.0 ^a	8000.05 ^a	None	Coupler	Yes

- a. This frequency is not tested on the Agilent E4404B.
 - 4. Press **PRESET** on synthesized sweeper 1. Set the CW frequency to F1 as indicated in Table 2-74, and set the power level to 4 dBm.
 - 5. Press **PRESET** on synthesized sweeper 2. Set the CW frequency to F2 as indicated in Table 2-74, and set the controls as follows:

POWER LEVEL, -10 dBm RF Off

- 6. Enter the power sensor calibration factor for F1 into the power meter.
- 7. Adjust the power level of synthesized sweeper 1 until the power

meter reads -12 dBm ±0.1 dB.

8. Disconnect the power sensor from the directional bridge (or directional coupler). Connect the directional bridge (or directional coupler) directly to the analyzer input using an adapter (do not use a cable).

CAUTION

Support the directional bridge (or directional coupler) and low pass filter to minimize stress on the analyzer input connector.

9. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Press **System**, **Alignments**, **Auto Align**, **Off**. Set the analyzer center frequency to the F1 value for TOI Test 1 in Table 2-74. Then set the analyzer by pressing the following keys:

```
FREQUENCY, CF Step, 50 kHz (Man) SPAN, 20 kHz AMPLITUDE, More, Y Axis Units (or\ Amptd\ Units), dBm AMPLITUDE, Ref Level, -5 dBm AMPLITUDE, Attenuation, 5 dB (Man) BW/Avg, 1 kHz (Man) BW/Avg, Video BW, 300 Hz (Man) Peak Search (or\ Search), More Search Param, Peak Excursn, 3 dB
```

10.On the analyzer, press the following keys:

```
 \begin{array}{l} \textbf{Peak Search} \; (or \; \textbf{Search}) \\ \textbf{Marker} \rightarrow \\ \textbf{Mkr} \rightarrow \textbf{CF} \\ \textbf{Delta} \\ \end{array}
```

- 11.On the analyzer, Press **FREQUENCY**, ↑. The center frequency should now be equal to synthesized sweeper 2 frequency.
- 12.If the resolution bandwidth is ≥ 1 kHz, press **SPAN**, **4** kHz.
- 13.On the synthesized sweeper 2, set the RF On.
- 14.On the analyzer, press Peak Search (or Search).
- 15.Adjust the power level of synthesized sweeper 2 until the marker delta (Δ Mkr1) amplitude reads 0 dB \pm 0.05 dB.
- 16.On the analyzer, press **FREQUENCY**, \downarrow , \downarrow . The center frequency should now be lower than synthesized sweeper 1 by the CF Step value.
- 17.Set the analyzer reference level to −15 dBm.
- 18.On the analyzer, press **BW/Avg**, **Average**, **20**, and wait for "Vavg 20" to appear along the left side of the display.
- 19.On the analyzer, press **Peak Search** (or **Search**) and record the marker amplitude reading in Table 2-75 as the Lower Distortion Amplitude.

- 20.On the analyzer, press BW/Avg, Average Off.
- 21.On the analyzer, press **FREQUENCY**, **Center Freq**, \uparrow , \uparrow . The center frequency should now be one CF Step value above synthesized sweeper 2 frequency.
- 22.Set synthesized sweeper 1 CW to F2 as indicated in Table 2-74.
- 23.Set synthesized sweeper 2 CW to F1 as indicated in Table 2-74.
- 24.On the analyzer, press **BW/Avg**, **Average**, **20**, and wait for "Vavg 20" to appear along the left side of the display.
- 25.On the analyzer, press **Peak Search** (or **Search**) and record the marker amplitude reading in Table 2-75 as the Upper Distortion Amplitude.
- 26.On the analyzer, press BW/Avg, Average Off.
- 27.Of the Lower Distortion Amplitude and Upper Distortion Amplitudes recorded in Table 2-75, enter the most positive value as the Worst Distortion Amplitude in Table 2-75. For example, if the Upper Distortion Amplitude is -62 dBc and the Lower Distortion Amplitude is -63 dBc, enter -62 dBc as the Worst Distortion Amplitude.
- 28.Enter –17 dBm as the Mixer Level in Table 2-75 (–12 dBm input power 5 dB input attenuation).
- 29.Calculate the equivalent TOI by subtracting one half of the Worst Distortion Amplitude (in dB) from the Mixer Level (in dBm). Enter the result in Table 2-75 as the Calculated TOI. For example, if the Worst Distortion Amplitude is -62 dBc and the Mixer Level is -17 dBm, the Calculated TOI would be:

$$TOI = -17 \text{ dBm} - \left(-\frac{62 \text{ dB}}{2}\right) = -17 \text{ dBm} + 31 \text{ dB} = +14 \text{ dBm}$$

30.Record the Calculated TOI in the performance verification test record as specified in Table 2-75.

Table 2-75 Third Order Intermodulation Distortion Worksheet

TOI Test	Lower Distortion Amplitude	Upper Distortion Amplitude	Worst Distortion Amplitude	Mixer Level	Calculated TOI Test Record Entry
1					1)
Option 1DR					2)
2					3)
3					4)

- 32. Spurious Responses: Agilent E4404B, E4405B, E4407B, and E4408B
- 31.If the analyzer is an E4404B, E4405B or E4407B and is equipped with Option 1DR, Narrow Resolution Bandwidth, perform step 32 through step 36. Otherwise, continue with step 37.
- 32.Set synthesized sweeper 1 CW frequency to F1 as indicated in TOI Test 1 of Table 2-74.
- 33.Set synthesized sweeper 2 CW frequency to F2 as indicated in TOI Test 1 of Table 2-74.
- 34.Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Press **System**, **Alignments**, **Auto Align**, **Off.** Set the analyzer center frequency to the F1 value for TOI Test Option 1DR in Table 2-74. Then, set the analyzer by pressing the following keys:

FREQUENCY, CF Step, 50 kHz (Man) SPAN, 20 kHz AMPLITUDE, More, Y Axis Units $(or\ Amptd\ Units)$, dBm AMPLITUDE, Ref Level, -5 dBm AMPLITUDE, Attenuation, 5 dB (Man) BW/Avg, 1 kHz (Man) BW/Avg, Video BW, 300 Hz (Man) Peak Search $(or\ Search)$, More Search Param $(or\ Search\ Criteria)$, Peak Excursn, 3 dB

35.On the analyzer, press the following keys:

Peak Search (or Search)
Meas Tools
Mkr → CF
SPAN, 500 Hz
BW/Avg, Res BW, 30 Hz
BW/Avg, Video BW, 10 Hz

- 36. Repeat step 9 through step 26. This is the TOI test for Option 1DR.
- 37.See Figure 2-49. Replace the directional bridge with the directional coupler. The cable from synthesized sweeper 1 should be connected directly to the input of the directional coupler; no low pass filter is required when testing frequencies >3 GHz.
- 38. Connect the output of the directional coupler to the power sensor.
- 39.Repeat step 4 through step 29 using information and entries for TOI Test 2 in Table 2-74 and Table 2-75.
- 40. Connect the output of the directional bridge to the power sensor.
- 41. Repeat step 4 through step 29 using information and entries for TOI Test 3 in Table 2-74 and Table 2-75.
- 42.On the analyzer, press System, Alignments, Auto Align, All.
- 43.Part 1: Third Order Intermodulation Distortion is complete. Continue with Part 2: Second Harmonic Distortion.

Part 2: Second Harmonic Distortion

1. Zero and calibrate the power meter and microwave power sensor. Enter the power sensor 300 MHz calibration factor into the power meter.

Measuring the Noise Level at 6.2 GHz

- 2. Remove any cables or adapters from the analyzer Input.
- 3. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the controls as follows:

FREQUENCY, 6.2 GHz SPAN, 0 Hz AMPLITUDE, Ref Level, -40 dBm AMPLITUDE, Attenuation, 10 dB BW/Avg, Res BW 1 kHz Video BW, 30 Hz Sweep, Sweep time, 5 s

- 4. Wait until "VAvg 10" is displayed along the left side of the display.
- 5. Press **Peak Search** (or **Search**) and record the marker amplitude reading as the 6.2 GHz Noise Level in Table 2-76.

Measuring 300 MHz Frequency Response Error

1. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the controls as follows:

```
FREQUENCY, 300 MHz
SPAN, 10 MHz
```

2. Connect the equipment as shown in Figure 2-50, with the output of the synthesized sweeper connected to the power splitter input and the power splitter outputs connected to the analyzer and power sensor.

SYNTHESIZED SWEEPER SPECTRUM ANALYZER POWER METER Channel A ____ 0000 ___ RF Output Input **ADAPTER ADAPTER POWER SENSOR POWER** APC 3.5 Cable **SPLITTER ADAPTER** 2 4.4 GHz LOW PASS FILTERS **ADAPTER** 300 MHz LOW **ADAPTER** PASS FILTER 1.8 GHz LOW 1.8 GHz LOW **ADAPTER ADAPTER** PASS FILTER PASS FILTER 1 GHz LOW PASS FILTER **ADAPTER** s17103b

Figure 2-50 Second Harmonic Distortion Test Setup

3. Preset the synthesized sweeper and set the controls as follows:

CW, 300 MHz POWER LEVEL, 0 dBm

- 4. On the analyzer, press Peak Search (or Search), Marker, Delta.
- 5. Record the power meter reading at 300 MHz in Table 2-76.
- 6. Set the synthesized sweeper CW to 600 MHz.
- 7. On the analyzer, press FREQUENCY, 600 MHz, then Peak Search (or Search).
- 8. Adjust the synthesized sweeper power level until the marker delta (Δ Mkr1) amplitude reads 0 dB ± 0.10 dB.
- 9. Enter the power sensor 600 MHz calibration factor into the power meter.
- 10.Record the power meter reading at 600 MHz in Table 2-76.

11.Subtract the power meter reading at 600 MHz from the power meter reading at 300 MHz. Record this difference as the 300 MHz Frequency Response Error in Table 2-76. For example, if the power meter reading at 600 MHz is -6.45 dBm and the power meter reading at 300 MHz is -7.05 dBm, the 300 MHz Frequency Response Error would be -0.60 dB:

$$-0.60 \text{ dB} = -7.05 \text{ dBm} - (-6.45 \text{ dBm})$$

Measuring 900 MHz Frequency Response Error

12.On the synthesized sweeper, press the following:

CW, 900 MHz POWER LEVEL, 0 dBm

- 13.On the analyzer, press **FREQUENCY**, **900 MHz**.
- 14.Enter the power sensor 1 GHz calibration factor into the power meter.
- 15.On the analyzer, press

Marker, Off Peak Search (or Search). Marker, Delta

- 16.Record the power meter reading in Table 2-76 as the 900 MHz power meter reading.
- 17.On the synthesized sweeper, press CW, 1.8 GHz.
- 18.On the analyzer, press the following:

FREQUENCY, 1.8 GHz Peak Search (or Search) AMPLITUDE

- 19.On the analyzer, press Peak Search (or Search).
- 20.Adjust the synthesized sweeper power level until the marker delta (Δ Mkr1) amplitude reads 0 dB \pm 0.1 dB.
- 21.Enter the power sensor 2 GHz calibration factor into the power meter.
- 22.Record the power meter reading in Table 2-76 as the 1.8 GHz power meter reading.
- 23.On the analyzer, press Marker, Off.
- 24.Subtract the power meter reading at 1.8 GHz from the power meter reading at 900 MHz. Record this difference as the 900 MHz Frequency Response Error in Table 2-76. For example, if the power meter reading at 1.8 GHz is -6.35 dBm and the power meter reading

at 900 MHz is -7.05 dBm, the 900 MHz Frequency Response Error would be -0.7 dB:

$$-0.70 \text{ dB} = -7.05 \text{ dBm} - (-6.35 \text{ dBm})$$

Measuring 1.55 GHz Frequency Response Error

1. On the synthesized sweeper, press the following:

CW, 1.55 GHz POWER LEVEL, 0 dBm

- 2. On the analyzer, press FREQUENCY, 1.55 GHz.
- 3. Enter the power sensor 2 GHz calibration factor into the power meter.
- 4. On the analyzer, press the following:

Marker, Off Peak Search (or Search)

- 5. On the analyzer, press Peak Search (or Search), Marker, Delta.
- 6. Record the power meter reading in Table 2-76 as the 1.55 GHz power meter reading.
- 7. On the synthesized sweeper, press CW, 3.1 GHz.
- 8. On the analyzer, press FREQUENCY, 3.1 GHz.
- 9. On the analyzer, press the following:

Peak Search (or Search)
AMPLITUDE
Presel Center

- 10.On the analyzer, press Peak Search (or Search).
- 11.Adjust the synthesized sweeper power level until the marker delta (Δ Mkr1) amplitude reads 0 dB \pm 0.1 dB.
- 12.Enter the power sensor 3 GHz calibration factor into the power meter.
- 13.Record the power meter reading in Table 2-76 as the 3.1 GHz power meter reading.
- 14.On the analyzer, press Marker, Off.
- 15.Subtract the power meter reading at 3.1 GHz from the power meter reading at 1.55 GHz. Record this difference as the 1.55 GHz Frequency Response Error in Table 2-76. For example, if the power meter reading at 3.1 GHz is -6.05 dBm and the power meter reading at 1.55 GHz is -7.35 dBm, the 3.1 GHz Frequency Response Error

would be -1.2 dB:

$$-1.2 \text{ dB} = -7.35 \text{ dBm} - (-6.15 \text{ dBm})$$

Measuring 3.1 GHz Frequency Response Error

1. On the synthesized sweeper, press the following:

CW, 3.1 GHz POWER LEVEL, 0 dBm

- 2. On the analyzer, press **FREQUENCY**, **3.1 GHz**.
- 3. Enter the power sensor 3 GHz calibration factor into the power meter.
- 4. On the analyzer, press the following:

Marker, Off
Peak Search (or Search)
AMPLITUDE
Presel Center

- 5. On the analyzer, press Peak Search (or Search), Marker, Delta.
- 6. Record the power meter reading in Table 2-76 as the 3.1 GHz power meter reading.
- 7. On the synthesized sweeper, press CW, 6.2 GHz.
- 8. On the analyzer, press the following:

FREQUENCY, 6.2 GHz
Peak Search (or Search)
AMPLITUDE
Presel Center

- 9. On the analyzer, press Peak Search (or Search).
- 10.Adjust the synthesized sweeper power level until the marker delta (Δ Mkr1) amplitude reads 0 dB \pm 0.1 dB.
- 11.Enter the power sensor 6 GHz calibration factor into the power meter.
- 12.Record the power meter reading in Table 2-76 as the 6.2 GHz power meter reading.
- 13.On the analyzer, press Marker, Off.
- 14.Subtract the power meter reading at 6.2 GHz from the power meter reading at 3.1 GHz. Record this difference as the 3.1 GHz Frequency Response Error in Table 2-76. For example, if the power meter reading at 6.2 GHz is -6.05 dBm and the power meter reading at 3.1 GHz is -7.25 dBm, the 3.1 GHz Frequency Response Error would

be
$$-1.2$$
 dB:

-1.2 dB = -7.25 dBm - (-6.05 dBm)

Table 2-76 Second Harmonic Distortion Worksheet

Description	Measurement
6.2 GHz Noise Level	dBm
Power Meter Reading at 300 MHz	dBm
Power Meter Reading at 600 MHz	dBm
300 MHz Frequency Response Error (FRE)	dB
Power Meter Reading at 900 MHz	dBm
Power Meter Reading at 1.8 GHz	dBm
900 MHz Frequency Response Error (FRE)	dB
Power Meter Reading at 1.55 GHz	dBm
Power Meter Reading at 3.1 GHz	dBm
1.55 GHz Frequency Response Error (FRE)	dB
Power Meter Reading at 3.1 GHz	dBm
Power Meter Reading at 6.2 GHz	dBm
3.1 GHz Frequency Response Error (FRE)	dB

Measuring 300 MHz Second Harmonic Distortion

- 1. Connect the equipment as shown in Figure 2-50 using the 300 MHz Low Pass Filter.
- 2. On the synthesized sweeper, press the following:

CW, 300 MHz POWER LEVEL, -10 dBm

- 3. Enter the power sensor 300 MHz calibration factor into the power meter.
- 4. On the analyzer, press the following:

FREQUENCY, Center Freq, 300 MHz SPAN, 100 kHz AMPLITUDE, Ref Level, –10 dBm AMPLITUDE, Attenuation, 10 dB (Man) BW/Avg, Res BW 1 kHz (Man) Video BW, 1 kHz (Man) Markers, Off

5. Adjust the synthesized sweeper power level until the power meter

reading is -10 dBm ±0.2 dB.

6. On the analyzer, press the following:

Peak Search (or Search), Marker, Delta FREQUENCY, 600 MHz BW/Avg, 10

Wait for the "VAvg 10" to appear along the left side of the display.

- 7. On the analyzer, press **Peak Search** (or **Search**). The marker delta (Δ Mkr1) amplitude is the second harmonic suppression.
- 8. Calculate the 300 MHz Second Harmonic Intercept (SHI) using the second harmonic suppression value read in step 7 and the 300 MHz Frequency Response Error (FRE) from Table 2-76 as follows:

300 MHz SHI = -20 dBm - Second Harmonic Suppression + 300 MHz FRE

For example, if the second harmonic suppression is –59 dB, and the 300 MHz FRE is –0.60 dB, the SHI would be 38.4 dBm:

$$+38.4 \text{ dBm} = -20 \text{ dBm} - (-59 \text{ dB}) + (-0.60 \text{ dB})$$

9. Record the 300 MHz SHI as Entry 5 in the performance verification test record.

Measuring 900 MHz Second Harmonic Distortion

- 1. Replace the 300 MHz low pass filter with the 1 GHz low pass filter as shown in Figure 2-50.
- 2. On the synthesized sweeper, press the following:

```
CW, 900 MHz
POWER LEVEL, -10 dBm
```

- 3. Enter the power sensor 1 GHz calibration factor into the power meter.
- 4. On the analyzer, press FREQUENCY, Center Freq, 900 MHz.
- 5. On the analyzer, press Peak Search (or Search).
- 6. Adjust the synthesized sweeper power level until the power meter reading is $-10~dBm~\pm0.1~dB$.
- 7. On the analyzer, press the following:

Peak Search (or Search)
Marker, Delta
FREQUENCY, Center Freq, 1.8 GHz

8. On the analyzer, press the following:

32. Spurious Responses: Agilent E4404B, E4405B, E4407B, and E4408B

AMPLITUDE, Ref Level, -20 dBm BW/Avg, Video BW, 30 Hz (Man)

- 9. On the analyzer, press **BW/Avg**, **Average**, **10 Hz**. Wait until "VAvg 10" is displayed along the left side of the display.
- 10.On the analyzer, press **Peak Search** (or **Search**). The marker delta (Δ Mkr1) amplitude reading is the second harmonic suppression.
- 11.Calculate the 900 MHz Second Harmonic Intercept (SHI) using the second harmonic suppression value read in step 10 and the 300 MHz Frequency Response Error (FRE) from Table 2-76 as follows:
- 900 MHz SHI = -20 dBm Second Harmonic Suppression + 900 MHz FRE

For example, if the second harmonic suppression is -73 dB, and the 900 MHz FRE is 0.70 dB, the SHI would be 52.3 dBm:

$$52.3 \text{ dBm} = -20 \text{ dBm} - (-73 \text{ dB}) + (-0.70 \text{ dB})$$

12.Record the 900 MHz SHI as Entry 6 in the performance verification test record.

Measuring 1.55 GHz Second Harmonic Distortion

- 1. Replace the 1.GHz low pass filter with the two 1.8 GHz low pass filters as shown in Figure 2-50. Two filters are necessary to reduce the second harmonics from the source to less than -100 dBc.
- 2. On the synthesized sweeper, press the following:

CW, 1.55 GHz POWER LEVEL, 6 dBm

- 3. Enter the power sensor 2 GHz calibration factor into the power meter.
- 4. On the analyzer, press the following:

FREQUENCY, 1.55 GHz
AMPLITUDE, Ref Level, 0 dBm
AMPLITUDE, Attenuation, 10 dB (Man)
Peak Search (or Search).

- 5. Adjust the synthesized sweeper power level until the power meter reading is $0 \text{ dBm } \pm 0.1 \text{ dB}$.
- 6. On the analyzer, press the following:

Peak Search (or Search)
Marker, Delta
FREQUENCY, Center Freq, 3.1 GHz

- 7. See Figure 2-50. Remove the 1.8 GHz low pass filters and connect the synthesized sweeper output directly to the power splitter input.
- 8. On the analyzer, press the following:

Peak Search (or Search)
AMPLITUDE
Presel Center

- 9. Reinstall the filters between the synthesized sweeper and the power splitter.
- 10.On the analyzer, press the following:

AMPLITUDE, Ref Level, -40 dBm BW/Avg, Video BW, 30 Hz (Man)

- 11.On the analyzer, press **BW/Avg**, **Average**, **10 Hz**. Wait until "VAvg 10" is displayed along the left side of the display.
- 12.On the analyzer, press **Peak Search** (or **Search**). The marker delta (Δ Mkr1) amplitude reading is the second harmonic suppression.

- 13.Calculate the 1.55 GHz Second Harmonic Intercept (SHI) using the second harmonic suppression value read in step 12 and the 300 MHz Frequency Response Error (FRE) from Table 2-76 as follows:
- 1.55GHz SHI = -20 dBm Second Harmonic Suppression + 1.55 GHz FRE

For example, if the second harmonic suppression is –93 dB, and the 1.55 GHz FRE is –1.05 dB, the SHI would be 81.95 dBm:

```
81.95 \text{ dBm} = -10 \text{ dBm} - (-93 \text{ dB}) + (-1.05 \text{ dB})
```

14.Record the 1.55 GHz SHI as Entry 7 in the performance verification test record.

Measuring 3.1 GHz Second Harmonic Distortion

- 1. Replace the 1.8 GHz low pass filters with the two 4.4 GHz low pass filters as shown in Figure 2-50. Two filters are necessary to reduce the second harmonics from the source to less than -110 dBc.
- 2. On the synthesized sweeper, press the following:

```
CW, 3.1 GHz
POWER LEVEL, 6 dBm
```

- 3. Enter the power sensor 3 GHz calibration factor into the power meter.
- 4. On the analyzer, press the following:

```
FREQUENCY, 3.1 GHz AMPLITUDE, Ref Level, 0 dBm AMPLITUDE, Attenuation, 10 dB (Man)
```

5. On the analyzer, press the following:

```
Peak Search (or Search)
AMPLITUDE
Presel Center
```

- 6. Adjust the synthesized sweeper power level until the power meter reading is $0 \text{ dBm } \pm 0.1 \text{ dB}$.
- 7. On the analyzer, press the following:

```
Peak Search (or Search)
Marker
Delta
```

8. On the analyzer, press the following:

```
FREQUENCY, Center Freq, 6.2 GHz
```

9. See Figure 2-50. Remove the 4.4 GHz low pass filters and connect

the synthesized sweeper output directly to the power splitter input.

10.On the analyzer, press the following:

Peak Search (or Search)
AMPLITUDE
Presel Center

- 11.Reinstall the filters between the synthesized sweeper and the power splitter.
- 12.On the analyzer, press the following:

AMPLITUDE, Ref Level, -40 dBm BW/Avg, Video BW, 30 Hz (Man)

- 13.On the analyzer, press **BW/Avg**, **Average**, **10 Hz**. Wait until "VAvg 10" is displayed along the left side of the display.
- 14.On the analyzer, press **Peak Search** (or **Search**). The marker delta (Δ Mkr1) amplitude reading is the second harmonic suppression.
- 15.If the marker does not appear to be on a signal, do the following:
 - a. Press Marker, Select Marker (2)
 - b. Compare the marker 2 (Mkr2) and the 6.2 GHz Noise Level recorded in Table 2-76.
 - c. If the difference between marker 2 (Mkr2) and the 6.2 GHz Noise Level recorded in Table 2-76 is less than 2 dB, check the box on the performance verification test record that the 3.1 GHz SHI test was noise limited.
- 16.If the measurement is not noise limited, calculate the 3.1 GHz Second Harmonic Intercept (SHI) using the second harmonic suppression value read in step 14 and the 3.1 GHz Frequency Response Error (FRE) from Table 2-76 as follows:
- 3.1GHz SHI = -10 dBm Second Harmonic Suppression + 3.1 GHz FRE

For example, if the second harmonic suppression is -103 dB, and the 3.1 GHz FRE is -1.20 dB, the SHI would be 91.8 dBm:

$$91.8 \text{ dBm} = -10 \text{ dBm} - (-103 \text{ dB}) + (-1.20 \text{ dB})$$

17.Record the 3.1 GHz SHI as Entry 8 in the performance verification test record.

33. Gain Compression: Agilent E4401B, E4402B, E4403B, and E4411B

This test verifies the ability of the analyzer to measure relatively low-amplitude signals in the presence of higher-amplitude signals. Gain compression is measured by applying two signals, separated by a defined amount in frequency. The higher-amplitude signal is set to yield the specified total power at the input mixer (the power at the input mixer is defined as the input power level minus the input attenuation). The lower-amplitude signal is set at least 35 dB below the higher-amplitude signal, such that its power does not significantly add to the total power. The higher-amplitude signal is turned off and the lower-amplitude signal level is measured. This is the uncompressed amplitude.

The higher-amplitude signal is turned on and the amplitude of the lower-amplitude signal is again measured. This is the compressed amplitude. The difference between the uncompressed and compressed amplitude is the measured gain compression.

There are no related adjustment procedures for this performance test.

Equipment Required

Synthesized sweeper
Synthesized signal generator
Power meter, dual channel
RF power sensor
Directional bridge
Cable, BNC, 120-cm (48-in)
Cable, APC 3.5 (m) (2 required)
Adapter, Type-N (m) to Type-N (m)
Adapter, Type-N (m) to APC 3.5 (f) (3 required)
Adapter, Type-N (m) to SMA (m)

Additional Equipment for 75 Ω Input

Power sensor, 75 Ω Adapter, Type-N (m), to BNC (m), 75 Ω Adapter, mechanical, Type-N (m), 50 Ω to Type-N (f), 75 Ω

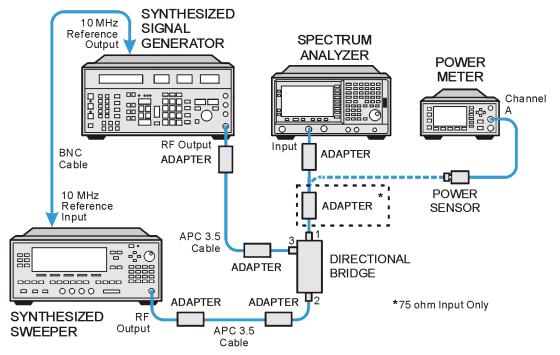
Procedure

- 1. Zero and calibrate the power meter and power sensor combination in log mode (power reads out in dBm) as described in the power meter operation manual.
- 2. Connect the equipment as shown in Figure 2-51, with port 1 of the

directional bridge connected to the power sensor.

75 Ω Input only: Use the 75 Ω power sensor with the mechanical adapter. The power measured at the output of the 50 Ω directional bridge by the 75 Ω power sensor is the equivalent power "seen" by the 75 Ω analyzer.

Figure 2-51 Gain Compression Test Setup



wl723a

CAUTION

Use only 75 Ω cables, connectors, or adapters on instruments with 75 Ω connectors, or damage to the connectors will occur.

3. Set the synthesized signal generator controls as follows:

FREQUENCY, 50 MHz AMPLITUDE, -100 dBm

4. On the synthesized sweeper press **INSTRUMENT PRESET**, then set the controls as follows:

CW, 53 MHz POWER LEVEL, -3 dBm

- 5. Enter the power sensor calibration factor for the synthesizer frequency into the power meter.
- 6. Adjust the synthesized sweeper power level setting until the power meter reading is the same as indicated in Table 2-77.

7. Record the actual synthesized sweeper power level setting in Table 2-77 for each frequency indicated.

Table 2-77 Source Frequency and Amplitude Settings

Synthesized Signal Generator		Synthesized Sweeper				
Frequency	Amplitude	CW Frequency	Desired Power Level	Actual Power Level		
(GHz)	(dBm)	(MHz)	(dBm)	(dBm)		
0.05	-40	53	0.0			
0.05 ^a	-40	50.004	0.0			
1.40	-40	1403	0.0			
2.50 ^b	-40 ^b	2503 ^b	0.0 ^b			

- a. Agilent E4401B and E4402B with Option 1DR only.
- b. Agilent E4402B and E4403B only.

Table 2-78 Analyzer Settings

Test Frequency	Analyzer					Test Record Entry		
(MHz)	Center Freq (GHz)	Span (kHz)	RBW (kHz)	VBW (kHz)	Ref Lvl (dBm)	Scale (dB)	Atten (dB)	
53	0.05	150	30	0.300	-10.0	10	0.0	1)
50.004 ^a	0.05 ^a	1.0 ^a	0.030 ^a	0.030 ^a	-10.0 ^a	10 ^a	0.0 ^a	2)
1403	1.40	150	30	0.300	-10.0	10	0.0	3)
2503 ^b	2.50 ^b	150 ^b	30 ^b	0.300 ^b	-10.0 ^b	10 ^b	0.0 ^b	4)

- a. Agilent E4401B and E4402B with Option 1DR only.
- b. Agilent E4402B and E4403B only.
 - 8. Repeat step 3 through step 7 for each of the settings listed in Table 2-77. The test at 50 MHz with a span of 1 kHz, is only for the E4401B and E4402B with Option 1DR.
 - 9. Disconnect the power sensor from the directional bridge and connect the directional bridge to the input of the analyzer using an adapter. Do not use a cable.

75 Ω Input only: Use a 75 Ω adapter, Type-N (m) to BNC (m) and a mechanical adapter, Type-N (m) 50 Ω to Type-N (f) 75 Ω

- 10.Set the synthesized sweeper amplitude Off.
- 11.Set the synthesized signal generator amplitude to -24 dBm.
- 12.Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Press **System**, **Alignments**, **Auto Align**, **Off**. Set the analyzer by pressing the following keys:

```
FREQUENCY, Center Freq, 50 MHz (or as indicated in Table 2-78)
SPAN, 150 kHz (or as indicated in Table 2-78)
AMPLITUDE, More, Y Axis Units (or Amptd Units), dBm
AMPLITUDE, Ref Level, -10 dBm, Attenuation 0 dB
AMPLITUDE, Scale/Div, 10 dB
BW/Avg, Res BW, 30 kHz (or as indicated in Table 2-78)
BW/Avg, Video BW, 300 Hz (or as indicated in Table 2-78)
```

13.On the synthesized sweeper, set the appropriate power level to the setting recorded in Table 2-77. Then set RF to Off.

75 Ω Input only: Adjust the power level for a -2.0 dBm reading.

- 14.On the analyzer, press Peak Search (or Search).
- 15.Adjust the amplitude of the synthesized signal generator to achieve a marker amplitude reading within 0.5 dB of the value indicated in Table 2-77. The marker amplitude is the uncompressed amplitude.
- 16.On the analyzer, press the following keys:

```
Peak Search (or Search)
Marker
Delta
```

- 17.On the synthesized sweeper, set RF to On. The amplitude should be the same as recorded in Table 2-77.
- 18.On the analyzer, press **Peak Search** (or **Search**). This is the compressed amplitude. The marker delta (Δ Mkr1) amplitude is the measured gain compression.
- 19.Record the measured gain compression in the performance test record as the Entry listed in Table 2-78.
- 20.Repeat step 6 through step 19 for each set of settings in Table 2-77 and Table 2-78.

34. Gain Compression: Agilent E4404B, E4405B, E4407B, and E4408B

This test verifies the ability of the analyzer to measure relatively low-amplitude signals in the presence of higher-amplitude signals. Gain compression is measured by applying two signals, separated by a defined amount in frequency. The higher-amplitude signal is set to yield the specified total power at the input mixer (the power at the input mixer is defined as the input power level minus the input attenuation). The lower-amplitude signal is set at least 35 dB below the higher-amplitude signal, such that its power does not significantly add to the total power. The higher-amplitude signal is turned off and the lower-amplitude signal level is measured. This is the uncompressed amplitude.

The higher-amplitude signal is turned on and the amplitude of the lower-amplitude signal is again measured. This is the compressed amplitude. The difference between the uncompressed and compressed amplitude is the measured gain compression.

There are no related adjustment procedures for this performance test.

Equipment Required

Synthesized sweeper (2 required)
Power meter, dual channel
Microwave power sensor
Directional bridge
Directional coupler
Cable, BNC, 120-cm (48-in)
Cable, APC 3.5 (m) (2 required)
Adapter, Type-N (m) to Type-N (m)
Adapter, Type-N (m) to APC 3.5 (f) (3 required)
Adapter, Type-N (m) to SMA (m)

Additional Equipment for Option BAB

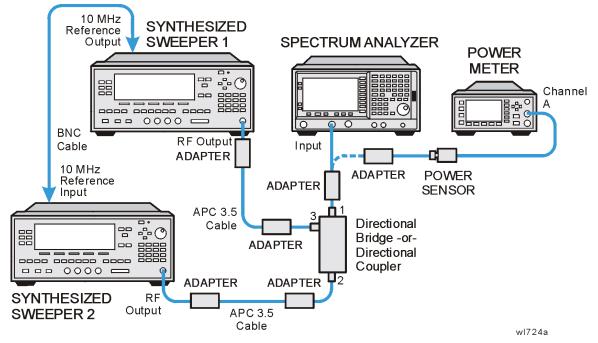
Adapter, Type-N (m), to APC 3.5 (f)

Procedure

- 1. Zero and calibrate the power meter and power sensor combination in log mode (power reads out in dBm) as described in the power meter operation manual.
- 2. Connect the equipment as shown in Figure 2-50, with the load port of the directional bridge connected to the power sensor. The directional bridge should be used for measurements of frequencies

less than or equal to 2.5 GHz. Use the directional coupler for higher frequency measurements.

Figure 2-52 Gain Compression Test Setup



3. On the synthesized sweeper 1 press **PRESET**, then set the controls as follows:

CW, 50 MHz POWER LEVEL, -100 dBm

4. On the synthesized sweeper 2 press **PRESET**, then set the controls as follows:

CW, 53 MHz POWER LEVEL, –3 dBm

- 5. Enter the power sensor calibration factor for the synthesized sweeper 2 frequency into the power meter.
- 6. Adjust the synthesized sweeper 2 power level setting until the power meter reading is the same as indicated in Table 2-80.
- 7. Record the actual synthesized sweeper 2 power level setting in

Table 2-80 for each frequency indicated.

Table 2-79 Source Frequency and Amplitude Settings

First Synthesized Sweeper		Second Synthesized Sweeper				
CW Frequency (MHz)	Power Level (dBm)	CW Frequency (MHz)	Desired Power Level (dBm)	Actual Power Level (dBm)		
50	-40	53	-0.0			
50 ^a	-40 ^a	50.004 ^a	-0.0 ^a			
1400	-40	1403	0.0			
2500	-40	2503	0.0			
4400	-40	4403	0.0			
7600 ^b	-40	7603	-3.0			
14000°	-40	14003	-5.0			

- a. Agilent E4404B, E4405B and E4407B with Option 1DR only.
- b. Agilent E4405B, E4407B and E4408B only.
- c. Agilent E4407B and E4408B only.

Table 2-80 Analyzer Settings

Test Frequency		Analyzer Settings						Test Record Entry
(MHz)	Center Freq (GHz)	Span (kHz)	RBW (kHz)	VBW (kHz)	Ref Lvl (dBm)	Scale (dB)	Atten (dB)	
53	0.05	150	30	0.300	-10.0	10	0.0	1)
50.004 ^a	0.05 ^a	1.0 ^a	0.030 ^a	0.030 ^a	-10.0 ^a	10 ^a	0.0 ^a	2)
1403	1.40	150	30	0.300	-10.0	10	0.0	3)
2503	2.50	150	30	0.300	-10.0	10	0.0	4)
4403	4.40	150	30	0.300	-10.0	10	0.0	5)
7603 ^b	7.60	150	30	0.300	-10.0	10	0.0	6)
14003 ^c	14.0	150	30	0.300	-10.0	10	0.0	7)

a. Agilent E4404B, E4405B and E4407B with Option 1DR only.

b. Agilent E4405B, E4407B and E4408B only.

- c. Agilent E4407B and E4408B only.
 - 8. Repeat step 3 through step 7 for each of the settings listed in Table 2-79. Use the directional bridge in place of the coupler for frequencies less than or equal to 2503 MHz. The test at 50 MHz with a span of 1 kHz is only for E4404B, E4405B or E4407B with Option 1DR.
 - 9. Disconnect the power sensor from the directional bridge and connect the directional bridge to the input of the analyzer using an adapter. Do not use a cable.
 - 10.Set the synthesized sweeper 2 power level to Off.
 - 11.Set the synthesized sweeper 1 power level to -24 dBm.
 - 12.Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Press **System**, **Alignments**, **Auto Align**, **Off**. Set the analyzer by pressing the following keys:

```
FREQUENCY, Center Freq, 50 MHz (or as indicated in Table 2-80)
SPAN, 150 kHz (or as indicated in Table 2-80)
AMPLITUDE, Ref Level, -10 dBm, Attenuation 0 dB
AMPLITUDE, Scale/Div, 10 dB
BW/Avg, Res BW, 30 kHz (or as indicated in Table 2-80)
BW/Avg, Video BW, 300 Hz (or as indicated in Table 2-80)
```

- 13.On the synthesized sweeper 2, set the appropriate power level to the setting recorded in Table 2-79. Then set RF to Off.
- 14.On the analyzer, press Peak Search (or Search).
- 15.Adjust the power level of the synthesized sweeper 1 to achieve a marker amplitude reading within 0.5 dB of the value indicated in Table 2-79. The marker amplitude is the uncompressed amplitude.
- 16.On the analyzer, press the following keys:

```
Peak Search (or Search)
Marker
Delta
```

- 17.On the synthesized sweeper 2, set RF to On. The amplitude should be the same as recorded in Table 2-79.
- 18.On the analyzer, press **Peak Search** (or **Search**). This is the compressed amplitude. The marker delta (Δ Mkr1) amplitude is the measured gain compression.
- 19.Record the measured gain compression in the performance test record as the Entries indicated in Table 2-80.
- 20.Repeat step 10 through step 19 for each set of settings in Table 2-79 and Table 2-80 for frequencies less than or equal to 2503 MHz.

- **34. Gain Compression: Agilent E4404B, E4405B, E4407B, and E4408B**
- 21.Replace the directional bridge with the directional coupler.
- 22.Repeat step 10 through step 19 for the remaining frequencies in Table 2-79.

35. Displayed Average Noise Level: Agilent E4401B and E4411B

This performance test measures the Displayed Average Noise Level (DANL) within the frequency range specified. The analyzer input is terminated in its characteristic impedance. If the analyzer is also equipped with a tracking generator (Option 1DN or 1DQ), the tracking generator is also terminated in its characteristic impedance and set for maximum leveled output power.

The test tunes the analyzer frequency across the band and uses the marker to locate the frequency with the highest response. It then reads the average noise in zero span using the minimum resolution bandwidth (RBW) specified for the analyzer. Analyzers having Option 1DN (Tracking Generator) installed are tested in a 1 kHz RBW. Analyzers having Option 1DR (Narrow Bandwidths) installed have a minimum RBW of either 100 Hz or 10 Hz. Even though analyzers having Option 1D5 (High Stability Frequency Reference) and firmware revision A.08.00 or later installed have a minimum RBW of 1 Hz, DANL for these analyzers is specified and tested with a 10 Hz RBW.

To reduce measurement uncertainty due to input attenuator switching and resolution bandwidth switching, a reference level offset is added. The 50 MHz alignment signal is used as the amplitude reference for determining the amount of offset required. The offset is removed at the end of the test by pressing instrument preset.

The related adjustment for this procedure is "Frequency Response."

Equipment Required

Termination, 50 Ω , Type-N (m) (2 required for Options 1DN or 1DQ)

Additional Equipment for 75 Ω Input

Termination, 75 Ω , Type-N (m) (2 required for Option 1DQ) Adapter, Type-N (f), to BNC (m), 75 Ω

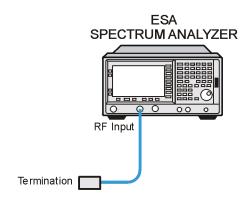
Procedure

CAUTION

Use only 75 Ω cables, connectors, or adapters on instruments with 75 Ω connectors, or damage to the connectors will occur.

1. Set up the analyzers as shown in Figure 2-53.

Figure 2-53 Displayed Average Noise Level Test Setup



wl767a

2. Press System, More, Show System. If there is an entry shown which reads 1DR: Narrow Resolution BW and the analyzer is an E4401B, then enter 10 Hz below as the Minimum RBW. If there is an entry shown which reads 1DR: Narrow Resolution BW and the analyzer is an E4411B, then enter 100 Hz below as the Minimum RBW. Otherwise, enter 1 kHz as the Minimum RBW (resolution bandwidth). Keep this value in mind as you continue to perform this procedure. Also, take note of whether or not Options 1DN or 1DQ (1.5 GHz Tracking Generator) and Option 1DS (RF Preamplifier) are installed.

Minimum RBW	$_{-}$ Hz
Option 1DN or 1DQ:	
Option 1DS:	

3. On the analyzer, press **Preset**. Press the **Factory Preset** softkey, if it is displayed. Then press the following keys:

Input/Output (or Input), Amptd Ref (On) FREQUENCY, Center Freq, 50 MHz SPAN, 2 kHz AMPLITUDE, –25 dBm ($50~\Omega~Input~only$) AMPLITUDE, 28.75 dBmV ($75~\Omega~Input~only$) AMPLITUDE, Attenuation, 10 dB BW/Avg, Res BW, 1 kHz BW/Avg, Video BW, 1 kHz Det/Demod, Detector, Sample

4. On the analyzer, press Single, Peak Search (or Search) and record the Ref Amptd reading below.

Ref Amptd	$_{-}$ dBm (50 Ω Input only)
Ref Amptd	dBmv (75 Ω Input only)

5. If the analyzer does not have Option 1DN or 1DQ (1.5 GHz Tracking

Generator) installed and the minimum RBW is 100 Hz or 10 Hz, continue with step 10.

- 6. If the analyzer has a minimum RBW of 1 kHz or has Option 1DN or 1DQ (1.5 GHz Tracking Generator) installed then continue with step 7.
- 7. On the analyzer, press the following keys:

AMPLITUDE, Attenuation, 0 dB SPAN, 20 kHz BW/Avg, Res BW, 1 kHz BW/Avg, Video BW, 30 Hz

8. On the analyzer, press **Single**, **Peak Search** (or **Search**) and record the amplitude reading below as Meas Amptd(1 kHz RBW).

Meas Amptd (1 kHz RBW)	$dBm (50 \Omega Input only)$
Meas Amptd (1 kHz RBW)	dBmv (75 Ω Input only)

9. Calculate the necessary reference level offset by subtracting the Meas Amptd in step 8 from the Ref Amptd in step 4. If the calculated Ref Lvl Offset is greater than 0.05 dB or less than -0.05 dB, record the Ref Lvl Offset value below. Otherwise, enter 0.

```
Ref Lvl Offset (1 kHz RBW) = Ref Amptd – Meas Amptd (1 kHz RBW)
```

```
Ref Lvl Offset (1 kHz RBW) dB
```

- 10.If the analyzer is not equipped with Option 1DR, continue with step 14.
- 11.On the analyzer, press the following keys:

AMPLITUDE, Attenuation, 0 dB SPAN, 500 Hz BW/Avg, Res BW, 10 Hz (E4401B) BW/Avg, Res BW, 100 Hz (E4411A) BW/Avg, Video BW, 1 Hz

12.On the analyzer, press Single, Peak Search (or Search) and record the amplitude reading below as Meas Amptd (100 Hz/10 Hz RBW).

```
Meas Ampt<br/>d(100~{\rm Hz}/10~{\rm Hz}~{\rm RBW}) ______ dBm (50~\Omega~Input~only) <br/> Meas Ampt<br/>d(100~{\rm Hz}/10~{\rm Hz}~{\rm RBW}) ______ dBmv (75~\Omega~Input~{\rm Mem})
```

13.Calculate the necessary reference level offset by subtracting the Meas Amptd in step 12 from the Ref Amptd in step 4. If the calculated Ref Lvl Offset is greater than 0.05 dB or less than -0.05 dB, record the Ref Lvl Offset value below. Otherwise, enter 0.

Ref Lvl Offset(100 Hz/10 Hz RBW) = Ref Amptd – Meas Amptd(100 Hz/10 Hz RBW)

Ref Lvl Offset (100 Hz/10 Hz RBW) dB

- 14.On the analyzer, press Input, Amptd Ref (Off). Then press AMPLITUDE, More, Ref LvI Offst, and enter the value recorded in step 9.
- 15.Connect the 50 Ω termination to the analyzer input as shown in Figure 2-53.
- 75 Ω Input only: Connect the 75 Ω termination to the analyzer Input 75 Ω using an adapter.
- 16.If the analyzer has Option 1DN, 50 Ω tracking generator, do the following:
 - a. On the analyzer, press BW/Avg, Res BW, 1 kHz.
 - b. Press Source, Amplitude, 0 dBm.
 - c. Connect a 50 Ω termination to the RF OUT 50 Ω .
- 17.If the analyzer has Option 1DQ (1.5 GHz, 75 Ω Tracking Generator) installed do the following:
 - a. On the analyzer, press Source, Amplitude, 42.75 dBmv.
 - b. Connect a 75 Ω termination to the RF OUT 75 Ω .

Measurement Sequence

The following option-specific DANL Measurement Sequence tables list the procedures to be performed and the parameters to be used in each procedure. Also listed in the tables are test record entry numbers for recording the results in the performance verification test record.

- 1. Perform all of the following steps (through step 7) that apply to your analyzer using the appropriate subsets in Table 2-81 Table 2-82, Table 2-83 or Table 2-84. Then record the display line amplitude setting as the indicated Test Record entry in the performance verification test record.
- 2. If the minimum RBW of the analyzer is 1 kHz, perform those procedures listed as Subset A in the appropriate table.
- 3. If the minimum RBW of the analyzer is 1 kHz and Option 1DS (RF Preamplifier) is installed, also perform those procedures listed in Subset B in the appropriate table.
- 4. If the minimum RBW of the analyzer is 100 Hz or 10 Hz and Option 1DN or 1DQ (1.5 GHz Tracking Generator) is installed, perform those procedures listed in Subset A in the appropriate table.
- 5. If the minimum RBW of the analyzer is 10 Hz and both Option 1DS (RF Preamplifier) and Option 1DN or 1DQ (1.5 GHz Tracking Generator) are installed, also perform those procedures listed in Subset B in the appropriate table.
- 6. If the minimum RBW of the analyzer is 100 Hz or 10 Hz, also

- perform those procedures listed in Subset C in the appropriate table.
- 7. If the minimum RBW of the analyzer is 10 Hz and Option 1DS (RF Preamplifier) is installed, also perform those procedures listed in Subset D in the appropriate table.
- 8. After performing all applicable DANL measurement procedures, continue with "Remove Reference Level Offset".

Table 2-81 DANL Measurement Sequence, E4401B 50 Ω Inputs

G 1 4		Pr	Procedure Parameters				
Subset	Procedure	Start Freq	Stop Freq	Test RBW	Preamp State	Record Entry	
A	Meas. DANL at 400 kHz	N/A	N/A	1 kHz	Off	1)	
	Measure DANL	1 MHz	10 MHz	1 kHz	Off	2)	
	Measure DANL	10 MHz	500 MHz	1 kHz	Off	3)	
	Measure DANL	500 MHz	1 GHz	1 kHz	Off	4)	
	Measure DANL	1 GHz	1.5 GHz	1 kHz	Off	5)	
В	Meas. DANL at 400 kHz	N/A	N/A	1 kHz	On	6)	
	Measure DANL	1 MHz	10 MHz	1 kHz	On	7)	
	Measure DANL	10 MHz	500 MHz	1 kHz	On	8)	
	Measure DANL	500 MHz	1 GHz	1 kHz	On	9)	
	Measure DANL	1 GHz	1.5 GHz	1 kHz	On	10)	
С	Meas. DANL at 400 kHz	N/A	N/A	10 Hz	Off	11)	
	Measure DANL	1 MHz	10 MHz	10 Hz	Off	12)	
	Measure DANL	10 MHz	500 MHz	10 Hz	Off	13)	
	Measure DANL	500 MHz	1 GHz	10 Hz	Off	14)	
	Measure DANL	1 GHz	1.5 GHz	10 Hz	Off	15)	
D	Meas. DANL at 400 kHz	N/A	N/A	10 Hz	On	16)	
	Measure DANL	1 MHz	10 MHz	10 Hz	On	17)	
	Measure DANL	10 MHz	500 MHz	10 Hz	On	18)	
	Measure DANL	500 MHz	1 GHz	10 Hz	On	19)	
	Measure DANL	1 GHz	1.5 GHz	10 Hz	On	20)	

Table 2-82 DANL Measurement Sequence, E4411B 50 Ω Inputs

Subset		Pı	Test			
Subset	Procedure	Start Freq	Stop Freq	Test RBW	Preamp State	Record Entry
A	Meas. DANL at 400 kHz	N/A	N/A	1 kHz	Off	1)
	Measure DANL	1 MHz	10 MHz	1 kHz	Off	2)

Table 2-82 DANL Measurement Sequence, E4411B 50 Ω Inputs

Subset		Pı	Test			
Subset	Procedure	Start Freq	Stop Freq	Test RBW	Preamp State	Record Entry
	Measure DANL	10 MHz	500 MHz	1 kHz	Off	3)
	Measure DANL	500 MHz	1 GHz	1 kHz	Off	4)
	Measure DANL	1 GHz	1.5 GHz	1 kHz	Off	5)
С	Meas. DANL at 400 kHz	N/A	N/A	100 Hz	Off	11)
	Measure DANL	1 MHz	10 MHz	100 Hz	Off	12)
	Measure DANL	10 MHz	500 MHz	100 Hz	Off	13)
	Measure DANL	500 MHz	1 GHz	100 Hz	Off	14)
	Measure DANL	1 GHz	1.5 GHz	100 Hz	Off	15)

Table 2-83 DANL Measurement Sequence, E4401B 75 Ω Inputs

		P	Test			
Subset	Procedure	Start Freq	Stop Freq	Test RBW	Preamp State	Record Entry
A	Measure DANL	1 MHz	10 MHz	1 kHz	Off	21)
	Measure DANL	10 MHz	500 MHz	1 kHz	Off	22)
	Measure DANL	500 MHz	1 GHz	1 kHz	Off	23)
	Measure DANL	1 GHz	1.5 GHz	1 kHz	Off	24)
В	Measure DANL	1 MHz	10 MHz	1 kHz	On	25)
	Measure DANL	10 MHz	500 MHz	1 kHz	On	26)
	Measure DANL	500 MHz	1 GHz	1 kHz	On	27)
	Measure DANL	1 GHz	1.5 GHz	1 kHz	On	28)
С	Measure DANL	1 MHz	10 MHz	10 Hz	Off	29)
	Measure DANL	10 MHz	500 MHz	10 Hz	Off	30)
	Measure DANL	500 MHz	1 GHz	10 Hz	Off	31)
	Measure DANL	1 GHz	1.5 GHz	10 Hz	Off	32)
D	Measure DANL	1 MHz	10 MHz	10 Hz	On	33)
	Measure DANL	10 MHz	500 MHz	10 Hz	On	34)
	Measure DANL	500 MHz	1 GHz	10 Hz	On	35)

Table 2-83 DANL Measurement Sequence, E4401B 75 Ω Inputs

		P	Test			
Subset	Procedure	Start Freq	Stop Freq	Test RBW	Preamp State	Record Entry
	Measure DANL	1 GHz	1.5 GHz	10 Hz	On	36)

Table 2-84 DANL Measurement Sequence, E4411B 75 Ω Inputs

		F	Test				
Subset	Procedure	Start Freq	Stop Freq	Test RBW	Preamp State	Record Entry	
A	Measure DANL	1 MHz	10 MHz	1 kHz	Off	21)	
	Measure DANL	10 MHz	500 MHz	1 kHz	Off	22)	
	Measure DANL	500 MHz	1 GHz	1 kHz	Off	23)	
	Measure DANL	1 GHz	1.5 GHz	1 kHz	Off	24)	
С	Measure DANL	1 MHz	10 MHz	100 Hz	Off	29)	
	Measure DANL	10 MHz	500 MHz	100 Hz	Off	30)	
	Measure DANL	500 MHz	1 GHz	100 Hz	Off	31)	
	Measure DANL	1 GHz	1.5 GHz	100 Hz	Off	32)	

Measuring Displayed Average Noise Level (DANL)

Use the following procedure for testing DANL over most frequency ranges. The start and stop frequencies and test RBW (1 kHz, 100 Hz or 10 Hz) are specified in the DANL Measurement Sequence Table (Table 2-81 Table 2-82, Table 2-83 or Table 2-84).

- 1. If the test RBW is 100 Hz or 10 Hz and the analyzer has Option 1DN (1.5 GHz Tracking Generator) installed, press **Source**, **Amplitude** (Off).
- 2. Set the analyzer as follows:

Auto Couple

FREQUENCY, Start Freq, (enter specified start frequency)

FREQUENCY, **Stop Freq**, (enter specified stop frequency)

AMPLITUDE, Ref Level, $-70 \text{ dBm } (50 \Omega Input only)$

Attenuation, 0 dB

AMPLITUDE, More, Y Axis Units (or Amptd Units)

dBmV, More, Ref Level, -21.24 dBmV (75 Ω Input only)

AMPLITUDE, More, Ref Lvl Offst, (enter Ref Lvl Offset (1 kHz) if test RBW = 1 kHz)

AMPLITUDE, More, Ref LvI Offst, (enter Ref LvI Offset (100 Hz / 10

```
Hz) if test RBW = 100 Hz or 10 Hz)

BW/Avg, Res BW, 1 MHz

BW/Avg, Video BW, 10 kHz

AMPLITUDE, More, Int Preamp (Off) (if preamp state = Off)

AMPLITUDE, More, Int Preamp (On) (if preamp state = On)

Sweep, Sweep (Cont)

Sweep, Sweep Time (Auto)
```

3. On the analyzer, press Single, View/Trace, Trace 1, Clear Write, BW/Avg, Average Type (Video), Average, 3, Enter, Single.

Wait until VAvg 3 is displayed to the left of the graticule (the analyzer will take three sweeps, then stop).

4. On the analyzer, press Peak Search (or Search). Then press:

```
BW/Avg, Average (Off)
Marker \rightarrow, Mkr \rightarrow CF
```

- 5. If the test RBW is 1 kHz or 100 Hz, press SPAN, 20 kHz. If the test RBW is 10 Hz, press SPAN, 500 Hz.
- 6. If the test RBW is 1 kHz, press **BW/Avg**, **Res BW**, **1 kHz**, **Video BW**, **30 Hz**.

If the test RBW is $10~\mathrm{Hz}$, press BW/Avg, Res BW, 100 Hz, Video BW, 1 Hz.

If the test RBW is 10 Hz, press BW/Avg, Res BW, 10 Hz, Video BW, 1 Hz.

- 7. On the analyzer, press **Single** and wait for the new sweep to finish.
- 8. Read the average of the trace data, ignoring any residual responses. On the analyzer, press **Display, Display Line** (On), and adjust the display line so that it is centered on the average trace noise, ignoring any residual responses (refer to the Residual Responses verification test for any suspect residuals).

Measuring Displayed Average Noise Level at 400 kHz Non-Option 1DP (50 Ω input only)

- 1. If the test RBW is 10 Hz and the analyzer has Option 1DN (1.5 GHz Tracking Generator) installed, press **Source**, **Amplitude** (Off).
- 2. Press **FREQUENCY**, **Center Freq**, **400 kHz**. Set the analyzer by pressing the following keys:

```
SPAN, 20 kHz (if test RBW = 1 \ kHz)
SPAN, 500 Hz (if test RBW = 10 \ Hz or 100 \ Hz)
AMPLITUDE, -70 dBm (50 \ \Omega \ Input \ only)
Attenuation, 0 dB
AMPLITUDE, More, Ref Lvl Offst, (enter Ref Lvl Offset (1 \ kHz) if test RBW = 1 \ kHz)
```

```
AMPLITUDE, More, Ref LvI Offst, (enter Ref LvI Offset (100 Hz/10 Hz) if test RBW = 10 Hz or 100 Hz)

AMPLITUDE, More, Int Preamp (Off) (if preamp state = Off)

AMPLITUDE, More, Int Preamp (On) (if preamp state = On)

BW/Avg, Res BW, 1 kHz (if test RBW = 1 kHz)

BW/Avg, Res BW, 100 Hz (if test RBW = 100 Hz)

BW/Avg, Video BW, 30 Hz (if test RBW = 1 kHz)

BW/Avg, Video BW, 1 Hz (if test RBW = 1 kHz)

BW/Avg, Video BW, 1 Hz (if test RBW = 100 Hz or 10 Hz)
```

- 3. On the analyzer, press **Single** and wait for a new sweep to complete.
- 4. On the analyzer, press **Display**, **Display Line** (On). Adjust the display line so that it is centered on the average trace noise, ignoring any residual responses (refer to the Residual Responses verification test for any suspect residuals).

Remove Reference Level Offset

- 1. Press AMPLITUDE, More, Ref LvI Offst, 0 dB.
- 2. On the analyzer, press **Preset**.
- 3. This performance test is now complete.

36. Displayed Average Noise Level: Agilent E4402B and E4403B

This performance test measures the Displayed Average Noise Level (DANL) within the frequency range specified. The analyzer input is terminated in its characteristic impedance. If the analyzer is also equipped with a tracking generator (Option 1DN or 1DQ), the tracking generator is also terminated in its characteristic impedance and set for maximum leveled output power.

The test tunes the analyzer frequency across the band and uses the marker to locate the frequency with the highest response. It then reads the average noise in zero span using the minimum resolution bandwidth (RBW) specified for the analyzer. Analyzers having Option 1DN (Tracking Generator) installed are tested in a 1 kHz RBW. Analyzers having Option 1DR (Narrow Bandwidths) installed have a minimum RBW of 100 Hz or 10 Hz. Even though analyzers having Option 1D5 (High Stability Frequency Reference) and firmware revision A.08.00 or later installed have a minimum RBW of 1 Hz, DANL for these analyzers is specified and tested with a 10 Hz RBW.

To reduce measurement uncertainty due to input attenuator switching and resolution bandwidth switching, a reference level offset is added. The 50 MHz alignment signal is used as the amplitude reference for determining the amount of offset required. The offset is removed at the end of the test by pressing instrument preset.

The related adjustment for this procedure is "Frequency Response."

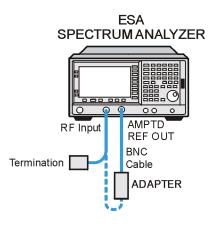
Equipment Required

Termination, 50 Ω, Type-N (m) (2 required for Option 1DN) Cable, BNC Adapter, Type-N (m) to BNC (f)

Procedure

1. Connect the AMPTD REF OUT to the 50 Ω Input using a BNC cable and adapter as shown in Figure 2-54.

Figure 2-54 Displayed Average Noise Level Test Setup



w1752a

2. Press System, More, Show System. If there is an entry shown which reads 1DR: Narrow Resolution BW, and the analyzer is an E4402B, then enter 10 Hz below as the minimum RBW. If there is an entry shown which reads 1DR:Narrow Resolution BW and the analyzer is an E4403B, then enter 100 Hz. Otherwise, enter 1 kHz as the minimum RBW (resolution bandwidth). Keep this value in mind as you continue to perform this procedure. Also, take note of whether or not Option 1DN (3.0 GHz Tracking Generator) and Option 1DS (RF Preamplifier) are installed.

Minimum RBW	_Hz
Option 1DN:	
Option 1DS:	

3. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Then press the following keys:

Input/Output (or Input), Amptd Ref Out (On) FREQUENCY, Center Freq, 50 MHz SPAN, 2 kHz AMPLITUDE, -20 dBm AMPLITUDE, Attenuation, 10 dB BW/Avg, Res BW, 1 kHz BW/Avg, Video BW, 1 kHz Det/Demod, Detector, Sample, Return

4. On the analyzer, press Single, Peak Search (or Search) and record the Ref Amptd reading below.

Ref	Amptd	dBm

5. If the analyzer does not have Option 1DN (3.0 GHz Tracking Generator) installed and the minimum RBW is 100 Hz or 10 Hz,

continue with step 11.

- 6. If the analyzer has a minimum RBW of 1 kHz or has Option 1DN (3.0 GHz Tracking Generator) installed then continue with step 7.
- 7. On the analyzer, press the following keys:

AMPLITUDE, Attenuation, 0 dB SPAN, 20 kHz BW/Avg, Res BW, 1 kHz BW/Avg, Video BW, 30 Hz

- 8. On the analyzer, press Single.
- 9. On the analyzer, press **Peak Search** (or **Search**) and record the amplitude reading below as Meas Amptd (1 kHz RBW).

Meas Amptd (1 kHz RBW) dBm

10.Calculate the necessary reference level offset by subtracting the Meas Amptd in step 9 from the Ref Amptd in step 4. If the calculated Ref Lvl Offset is greater than 0.05 dB or less than -0.05 dB, record the Ref Lvl Offset value below. Otherwise, enter 0.

Ref Lvl Offset(1 kHz RBW) = Ref Amptd – Meas Amptd(1 kHz RBW)

Ref Lvl Offset(1 kHz RBW)_____ dB

- 11.If the analyzer is not equipped with Option 1DR, continue with step 15.
- 12.On the analyzer, press the following keys:

AMPLITUDE, Attenuation, 0 dB SPAN, 500 Hz BW/Avg, Res BW, 10 Hz (E4401B) BW/Avg, Res BW, 100 Hz (E4403B) BW/Avg, Video BW, 1 Hz

13.On the analyzer, press Single, Peak Search (or Search) and record the amplitude reading below as Meas Amptd(100 Hz/10 Hz RBW).

Meas Amptd(100 Hz/10 Hz RBW) dB

14.Calculate the necessary reference level offset by subtracting the Meas Amptd in step 13 from the Ref Amptd in step 4. If the calculated Ref Lvl Offset is greater than 0.05 dB or less than -0.05 dB, record the Ref Lvl Offset value below. Otherwise, enter 0.

Ref Lvl Offset(100 Hz/10 Hz RBW) = Ref Amptd – Meas Amptd(100 Hz/10 Hz RBW)

Ref Lvl Offset(100 Hz/10 Hz RBW)_____ dB

- 15.On the analyzer, press Input, Amptd Ref Out (Off), then AMPLITUDE, More, Ref LvI Offst, and enter the value recorded in step 10.
- 16. Connect the 50 Ω termination to the analyzer input as shown in

Figure 2-54.

- 17.Disconnect the BNC cable and adapter from the AMPTD REF OUT and the 50 Ω Input.
- 18.If the analyzer has Option 1DN, 50 Ω tracking generator, do the following:
 - a. On the analyzer, press BW/Avg, Res BW, 1 kHz.
 - b. Press Source, Amplitude, 0 dBm.
 - c. Connect a 50 Ω termination to the RF OUT 50 Ω .

Measurement Sequence

The following DANL Measurement Sequence table lists the procedures to be performed and the parameters to be used in each procedure. Also listed in the table are test record entry numbers for recording the results in the performance verification test record.

- 1. Perform all of the following steps (through step 7) that apply to your analyzer using the appropriate subsets in Table 2-85 (for E4402B) or Table 2-86 (for E4403B). Then record the display line amplitude setting as the indicated Test Record entry in the performance verification test record.
- 2. If the minimum RBW of the analyzer is 1 kHz, perform those procedures listed as Subset A in Table 2-85 or Table 2-86.
- 3. If the minimum RBW of the analyzer is 1 kHz and Option 1DS (RF Preamplifier) is installed, also perform those procedures listed in Subset B in Table 2-85.
- 4. If the minimum RBW of the analyzer is 100 Hz or 10 Hz and Option 1DN (3.0 GHz Tracking Generator) is installed, perform those procedures listed in Subset A in Table 2-85 or Table 2-86.
- 5. If the minimum RBW of the analyzer is 10 Hz and both Option 1DS (RF Preamplifier) and Option 1DN (3.0 GHz Tracking Generator) are installed, also perform those procedures listed in Subset B in Table 2-85.
- 6. If the minimum RBW of the analyzer is 100 Hz or 10 Hz, perform those procedures listed in Subset C in Table 2-85 or Table 2-86.
- 7. If the minimum RBW of the analyzer is 10 Hz and Option 1DS (RF Preamplifier) is installed, also perform those procedures listed in

Subset D in Table 2-85.

Table 2-85 DANL Measurement Sequence, E4402B

		P	Test			
Subset	Procedure	Start Freq	Stop Freq	Test RBW	Preamp State	Record Entry ^a
A	Measure DANL	10 MHz	1 GHz	1 kHz	Off	1)
	Measure DANL	1 GHz	2 GHz	1 kHz	Off	2)
	Measure DANL	2 GHz	3 GHz	1 kHz	Off	3)
В	Measure DANL	10 MHz	1 GHz	1 kHz	On	4/13)
	Measure DANL	1 GHz	2 GHz	1 kHz	On	5/14)
	Measure DANL	2 GHz	3 GHz	1 kHz	On	6/15)
С	Measure DANL	10 MHz	1 GHz	10 Hz	Off	7)
	Measure DANL	1 GHz	2 GHz	10 Hz	Off	8)
	Measure DANL	2 GHz	3 GHz	10 Hz	Off	9)
D	Measure DANL	10 MHz	1 GHz	10 Hz	On	10/16)
	Measure DANL	1 GHz	2 GHz	10 Hz	On	11/17)
	Measure DANL	2 GHz	3 GHz	10 Hz	On	12/18)

a. There are two possible entries for measurements made with the preamplifier on, depending upon the ambient temperature. The first entry is for measurements made with an ambient temperature outside of the 20° to 30° C range, but within the 0° to 55° C range. The second entry is for measurements made with an ambient temperature within the 20° to 30° C range.

Table 2-86 DANL Measurement Sequence, E4403B

		P	Test			
Subset	Procedure	Start Freq	Stop Freq	Test RBW	Preamp State	Record Entry
A	Measure DANL	10 MHz	1 GHz	1 kHz	Off	1)
	Measure DANL	1 GHz	2 GHz	1 kHz	Off	2)
	Measure DANL	2 GHz	3 GHz	1 kHz	Off	3)
С	Measure DANL	10 MHz	1 GHz	100 Hz	Off	7)
	Measure DANL	1 GHz	2 GHz	100 Hz	Off	8)
	Measure DANL	2 GHz	3 GHz	100 Hz	Off	9)

8. After performing all applicable DANL measurement procedures,

continue with "Remove Reference Level Offset".

Measuring Displayed Average Noise Level (DANL)

Use the following procedure for testing DANL over most frequency ranges. The start and stop frequencies and test RBW (1 kHz, 100 Hz or 10 Hz) are specified in the DANL Measurement Sequence Table (Table 2-85 or Table 2-86).

- 1. If the test RBW is 100 Hz or 10 Hz and the analyzer has Option 1DN (1.5 GHz Tracking Generator) installed, press **Source**, **Amplitude** (Off).
- 2. Set the analyzer as follows:

```
Auto Couple FREQUENCY, Start Freq, (enter specified start frequency) FREQUENCY, Stop Freq, (enter specified stop frequency) AMPLITUDE, -70 dBm Attenuation, 0 dB AMPLITUDE, More, Ref Lvl Offst, (enter Ref Lvl Offset (1 \ kHz) if test RBW = 1 \ kHz) AMPLITUDE, More, Ref Lvl Offst, (enter Ref Lvl Offset (100 \ Hz/10 \ Hz) if test RBW = 100 \ Hz or 10 \ Hz) BW/Avg, Res BW, 1 MHz BW/Avg, Video BW, 10 kHz AMPLITUDE, More, Int Preamp (Off) (if preamp state = Off) AMPLITUDE, More, Int Preamp (On) (if preamp state = On) Sweep, Sweep (Cont)
```

- 3. On the analyzer, press Single, View/Trace, Trace 1, Clear Write, BW/Avg, Average Type (Video), Average, 3, Enter, Single
- 4. Wait until VAvg 3 is displayed to the left of the graticule (the analyzer will take three sweeps, then stop).
- 5. On the analyzer, press the following keys:

Sweep, Sweep Time (Auto)

```
BW/Avg, Average (Off)
Peak Search (or Search)
BW/Avg, Average (On)
Marker→, Mkr→CF
```

6. If the test RBW is 1 kHz, press SPAN, 20 kHz.

If the test RBW is 100 Hz or 10 Hz, press SPAN, 500 Hz.

7. If the test RBW is 1 kHz, press BW/Avg, Res BW, 1 kHz, Video BW, 30 Hz.

If the test RBW is 100 Hz, press BW/Avg, Res BW, 100 Hz, Video BW, 10 Hz.

If the test RBW is 10 Hz, press BW/Avg, Res BW, 10 Hz,

Video BW, 1 Hz.

- 8. On the analyzer, press **Single** and wait for the new sweep to finish.
- 9. Read the average of the trace data, ignoring any residual responses. On the analyzer, press **Display**, **Display Line** (On), and adjust the display line so that it is centered on the average trace noise, ignoring any residual responses (refer to the Residual Responses verification test for any suspect residuals).

Remove Reference Level Offset

- 1. Press AMPLITUDE, More, Ref LvI Offst, 0 dB.
- 2. On the analyzer, press **Preset**.
- 3. This performance test is now complete.

37. Displayed Average Noise Level: Agilent E4404B and E4405B

This performance test measures the displayed average noise level (DANL) within the frequency range specified. The analyzer input is terminated in its characteristic impedance. If the analyzer is also equipped with a tracking generator (Option 1DN), the tracking generator is also terminated in its characteristic impedance and set for maximum leveled output power.

The test tunes the analyzer frequency across the band and uses the marker to locate the frequency with the highest response. It then reads the average noise in zero span using the minimum resolution bandwidth (RBW) specified for the analyzer. Analyzers having Option 1DN (Tracking Generator) installed are tested in a 1 kHz RBW. Analyzers having Option 1DR (Narrow Bandwidths) installed have a minimum RBW of 100 Hz or 10 Hz. Even though analyzers having Option 1D5 (High Stability Frequency Reference) and firmware revision A.08.00 or later installed have a minimum RBW of 1 Hz, DANL for these analyzers is specified and tested with a 10 Hz RBW.

To reduce measurement uncertainty due to input attenuator switching and resolution bandwidth switching, a reference level offset is added. The 50 MHz alignment signal is used as the amplitude reference for determining the amount of offset required. The offset is removed at the end of the test by pressing instrument preset.

The related adjustment for this procedure is "Frequency Response."

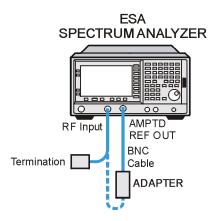
Equipment Required

Termination, 50 Ω , Type-N (m) (2 required for Option 1DN) Cable, BNC Adapter, Type-N (m) to BNC (f)

Procedure

1. Connect the AMPTD REF OUT to the 50 Ω Input using a BNC cable and adapter as shown in Figure 2-55.

Figure 2-55 Displayed Average Noise Level Test Setup



wl752a

2. Press System, More, Show System. If there is an entry shown which reads 1DR: Narrow Resolution BW, then enter 10 Hz below; otherwise enter 1 kHz as the minimum RBW (resolution bandwidth). Keep this value in mind as you continue to perform this procedure. Also, take note of whether or not Option 1DN (3.0 GHz Tracking Generator) and Option 1DS (RF Preamplifier) are installed.

Minimum RBW	Hz
Option 1DN:	
Option 1DS:	

3. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Then press the following keys:

Input/Output (or Input), Amptd Ref Out (On)
FREQUENCY, Center Freq, 50 MHz
SPAN, 2 kHz
AMPLITUDE, -20 dBm
AMPLITUDE, Attenuation, 10 dB
BW/Avg, Res BW, 1 kHz
BW/Avg, Video BW, 1 kHz
Det/Demod, Detector, Sample, Return

4. On the analyzer, press Single, Peak Search (or Search) and record the Ref Amptd reading below.

Ref Amptd dE

5. If the analyzer does not have Option 1DN (3.0 GHz Tracking Generator) installed and the minimum RBW is 10 Hz, continue with step 10.

37. Displayed Average Noise Level: Agilent E4404B and E4405B

- 6. If the analyzer has a minimum RBW of 1 kHz or has Option 1DN (3.0 GHz Tracking Generator) installed then continue with step 7.
- 7. On the analyzer, press the following keys:

AMPLITUDE, Attenuation, 0 dB SPAN, 20 kHz BW/Avg, Res BW, 1 kHz BW/Avg, Video BW, 30 Hz

8. On the analyzer, press **Single**, **Peak Search** (or **Search**) and record the amplitude reading below as Meas Amptd (1 kHz RBW).

Meas Amptd (1 kHz RBW)_____ dB

9. Calculate the necessary reference level offset by subtracting the Meas Amptd in step 8 from the Ref Amptd in step 4. If the calculated Ref Lvl Offset is greater than 0.05 dB or less than -0.05 dB, record the Ref Lvl Offset value below. Otherwise, enter 0.

Ref Lvl Offset (1 kHz RBW) = Ref Amptd – Meas Amptd (1 kHz RBW)

Ref Lvl Offset (1 kHz RBW)_____ dB

- 10.If the analyzer is not equipped with Option 1DR, continue with step 14.
- 11.On the analyzer, press the following keys:

AMPLITUDE, Attenuation, 0 dB SPAN, 500 Hz BW/Avg, Res BW, 10 Hz BW/Avg, Video BW, 1 Hz

12.On the analyzer, press Single, Peak Search (or Search) and record the amplitude reading below as Meas Amptd (10 Hz RBW).

Meas Amptd (10 Hz RBW)_____ dB

13.Calculate the necessary reference level offset by subtracting the Meas Amptd in step 12 from the Ref Amptd in step 4. If the calculated Ref Lvl Offset is greater than 0.05 dB or less than -0.05 dB, record the Ref Lvl Offset value below. Otherwise, enter 0.

Ref Lvl Offset (10 Hz RBW) = Ref Amptd – Meas Amptd (10 Hz RBW)

Ref Lvl Offset (10 Hz RBW) dB

- 14.On the analyzer, press Input, Amptd Ref Out (Off), then AMPLITUDE, More, Ref LvI Offst, and enter the value recorded in step 8.
- 15.Connect the 50 Ω termination to the analyzer input as shown in Figure 2-55.
- 16.Disconnect the BNC cable and adapter from the AMPTD REF OUT and the 50 Ω Input.

- 17.If the analyzer has Option 1DN, 50 Ω tracking generator, do the following:
 - a. On the analyzer, press BW/Avg, Res BW, 1 kHz.
 - b. Press Source, Amplitude, 0 dBm.
 - c. Connect a 50 Ω termination to the RF OUT 50 Ω .

Measurement Sequence

The following model-specific DANL Measurement Sequence tables list the procedures to be performed and the parameters to be used in each procedure. Also listed in the tables are test record entry numbers for recording the results in the performance verification test record.

- 1. Perform all of the following steps (through step 7) that apply to your analyzer using the appropriate subsets in Table 2-87 or Table 2-88. Then record the display line amplitude setting as the indicated Test Record entry in the performance verification test record.
- 2. If the minimum RBW of the analyzer is 1 kHz, perform those procedures listed as Subset A in Table 2-87 or Table 2-88.
- 3. If the minimum RBW of the analyzer is 1 kHz and Option 1DS (RF Preamplifier) is installed, also perform those procedures listed in Subset B in Table 2-87 or Table 2-88.
- 4. If the minimum RBW of the analyzer is 10 Hz and Option 1DN (3.0 GHz Tracking Generator) is installed, perform those procedures listed in Subset A in Table 2-87 or Table 2-88.
- 5. If the minimum RBW of the analyzer is 10 Hz and both Option 1DS (RF Preamplifier) and Option 1DN (3.0 GHz Tracking Generator) are installed, also perform those procedures listed in Subset B in Table 2-87 or Table 2-88.
- 6. If the minimum RBW of the analyzer is 10 Hz, also perform those procedures listed in Subset C in Table 2-87 or Table 2-88.
- 7. If the minimum RBW of the analyzer is 10 Hz and Option 1DS (RF Preamplifier) is installed, also perform those procedures listed in Subset D in Table 2-87 or Table 2-88.
- 8. After performing all applicable DANL measurement procedures, continue with Remove Reference Level Offset.

Table 2-87 DANL Measurement Sequence, E4404B

		P	Test			
Subset	Procedure	Start Freq	Stop Freq	Test RBW	Preamp State	Record Entry ^a
A	Measure DANL	10 MHz	1 GHz	1 kHz	Off	1)

Table 2-87 DANL Measurement Sequence, E4404B

		F	Test			
Subset	Procedure	Start Freq	Stop Freq	Test RBW	Preamp State	Record Entry ^a
	Measure DANL	1 GHz	2 GHz	1 kHz	Off	2)
	Measure DANL	2 GHz	3 GHz	1 kHz	Off	3)
	Measure DANL	3 GHz	6 GHz	1 kHz	Off	4)
	Measure DANL	6 GHz	6.7 GHz	1 kHz	Off	5)
В	Measure DANL	10 MHz	1 GHz	1 kHz	On	6/17)
	Measure DANL	1 GHz	2 GHz	1 kHz	On	7/18)
	Measure DANL	2 GHz	3 GHz	1 kHz	On	8/19)
С	Measure DANL	10 MHz	1 GHz	10 Hz	Off	9)
	Measure DANL	1 GHz	2 GHz	10 Hz	Off	10)
	Measure DANL	2 GHz	3 GHz	10 Hz	Off	11)
	Measure DANL	3 GHz	6 GHz	10 Hz	Off	12)
	Measure DANL	6 GHz	6.7 GHz	10 Hz	Off	13)
D	Measure DANL	10 MHz	1 GHz	10 Hz	On	14/20)
	Measure DANL	1 GHz	2 GHz	10 Hz	On	15/21)
	Measure DANL	2 GHz	3 GHz	10 Hz	On	16/22)

a. There are two possible entries for measurements made with the preamplifier on, depending upon the ambient temperature. The first entry is for measurements made with an ambient temperature outside of the 20° to 30° C range, but within the 0° to 55° C range. The second entry is for measurements made with an ambient temperature within the 20° to 30° C range.

Table 2-88 DANL Measurement Sequence, E4405B

	Procedure		Test			
Subset		Start Freq	Stop Freq	Test RBW	Preamp State	Record Entry ^a
A	Measure DANL	10 MHz	1 GHz	1 kHz	Off	1)
	Measure DANL	1 GHz	2 GHz	1 kHz	Off	2)
	Measure DANL	2 GHz	3 GHz	1 kHz	Off	3)
	Measure DANL	3 GHz	6 GHz	1 kHz	Off	4)
	Measure DANL	6 GHz	12 GHz	1 kHz	Off	5)

	Procedure		Test			
Subset		Start Freq	Stop Freq	Test RBW	Preamp State	Record Entry ^a
	Measure DANL	12 GHz	13.2 GHz	1 kHz	Off	6)
В	Measure DANL	10 MHz	1 GHz	1 kHz	On	7/19)
	Measure DANL	1 GHz	2 GHz	1 kHz	On	8/20)
	Measure DANL	2 GHz	3 GHz	1 kHz	On	9/21)
С	Measure DANL	10 MHz	1 GHz	10 Hz	Off	10)
	Measure DANL	1 GHz	2 GHz	10 Hz	Off	11)
	Measure DANL	2 GHz	3 GHz	10 Hz	Off	12)
	Measure DANL	3 GHz	6 GHz	10 Hz	Off	13)
	Measure DANL	6 GHz	12 GHz	10 Hz	Off	14)
	Measure DANL	12 GHz	13.2 GHz	10 Hz	Off	15)
D	Measure DANL	10 MHz	1 GHz	10 Hz	On	16/22)
	Measure DANL	1 GHz	2 GHz	10 Hz	On	17/23)
	Measure DANL	2 GHz	3 GHz	10 Hz	On	18/24)

a. There are two possible entries for measurements made with the preamplifier on, depending upon the ambient temperature. The first entry is for measurements made with an ambient temperature outside of the 20° to 30° C range, but within the 0° to 55° C range. The second entry is for measurements made with an ambient temperature within the 20° to 30° C range.

Measuring Displayed Average Noise Level (DANL)

Use the following procedure for testing DANL over most frequency ranges. The start and stop frequencies and test RBW (1 kHz or 10 Hz) are specified in the DANL Measurement Sequence Table (Table 2-87 or Table 2-88).

- 1. If the test RBW is 10 Hz and the analyzer has Option 1DN (1.5 GHz Tracking Generator) installed, press **Source**, **Amplitude** (Off).
- 2. Set the analyzer as follows:

Auto Couple
FREQUENCY, Start Freq, (enter specified start frequency)
FREQUENCY, Stop Freq, (enter specified stop frequency)
AMPLITUDE, -70 dBm
Attenuation 0 dB

AMPLITUDE, More, Ref Lvl Offst, $(enter\ Ref\ Lvl\ Offset\ (1\ kHz)\ if\ test$

37. Displayed Average Noise Level: Agilent E4404B and E4405B

```
RBW = 1 \ kHz)
AMPLITUDE, More, Ref Lvl Offst, (enter Ref Lvl Offset (10 Hz) if test RBW = 10 Hz)
BW/Avg, Res BW, 1 \ MHz
BW/Avg, Video BW, 10 \ kHz
AMPLITUDE, More, Int Preamp (Off) (if preamp state = Off)
AMPLITUDE, More, Int Preamp (On) (if preamp state = On)
Sweep, Sweep (Cont)
Sweep, Sweep Time (Auto)
```

- 3. If the analyzer is equipped with Option 1DN and the current stop frequency is >3 GHz, press **Source**, **Amplitude** (Off).
- 4. On the analyzer, press Single, View/Trace, Trace 1, Clear Write, BW/Avg, Average Type (Video), Average, 3, Enter, Single.

Wait until VAvg 3 is displayed to the left of the graticule (the analyzer will take three sweeps, then stop).

5. On the analyzer, press the following keys:

```
Peak Search (or Search)
BW/Avg Average (Off)
Marker→, Mkr→ CF
```

6. If the test RBW is 1 kHz, press SPAN, 20 kHz.

If the test RBW is 10 Hz, press SPAN, 500 Hz.

7. If the test RBW is 1 kHz, press BW/Avg, Res BW, 1 kHz, Video BW, 30 Hz.

If the test RBW is $10~\mathrm{Hz}$, press BW/Avg, Res BW, 10 Hz, Video BW, 1 Hz.

- 8. On the analyzer, press **Single** and wait for the new sweep to finish.
- 9. Read the average of the trace data, ignoring any residual responses. On the analyzer, press **Display**, **Display Line** (On), and adjust the display line so that it is centered on the average trace noise, ignoring any residual responses (refer to the Residual Responses verification test for any suspect residuals).

Remove Reference Level Offset

- 1. Press AMPLITUDE, More, Ref Lvl Offst, 0 dB.
- 2. On the analyzer, press **Preset**.
- 3. This performance test is now complete.

38. Displayed Average Noise Level: Agilent E4407B and E4408B

This performance test measures the displayed average noise level (DANL) within the frequency range specified. The analyzer input is terminated in its characteristic impedance. If the analyzer is also equipped with a tracking generator (Option 1DN), the tracking generator is also terminated in its characteristic impedance and set for maximum leveled output power.

The test tunes the analyzer frequency across the band and uses the marker to locate the frequency with the highest response. It then reads the average noise in zero span using the minimum resolution bandwidth (RBW) specified for the analyzer. Analyzers having Option 1DN (Tracking Generator) installed are tested in a 1 kHz RBW. Analyzers having Option 1DR (Narrow Bandwidths) installed have a minimum RBW of 100 Hz or 10 Hz. Even though analyzers having Option 1D5 (High Stability Frequency Reference) and firmware revision A.08.00 or later installed have a minimum RBW of 1 Hz, DANL for these analyzers is specified and tested with a 10 Hz RBW.

To reduce measurement uncertainty due to input attenuator switching and resolution bandwidth switching, a reference level offset is added. The 50 MHz alignment signal is used as the amplitude reference for determining the amount of offset required. The offset is removed at the end of the test by pressing instrument preset.

The related adjustment for this procedure is "Frequency Response."

Equipment Required

Termination, 50 Ω , Type-N (m) (2 required for Option 1DN) Cable, BNC Adapter, Type-N (m) to BNC (f)

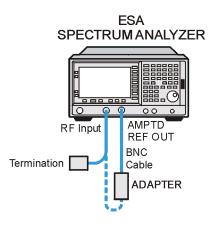
Additional Equipment for Option BAB

Adapter, APC 3.5 (f) to Type-N (f)

Procedure

1. Connect the AMPTD REF OUT to the 50 Ω Input using a BNC cable and adapter as shown in Figure 2-56.

Figure 2-56 Displayed Average Noise Level Test Setup



w1752a

2. Press System, More, Show System. If there is an entry shown which reads 1DR: Narrow Resolution BW and the analyzer is an E4407B, then enter 10 Hz below as the Minimum RBW. If there is an entry shown which reads 1DR: Narrow Resolution BW and the analyzer is an E4408B, then enter 100 Hz. Otherwise, enter 1 kHz as the minimum RBW (resolution bandwidth). Keep this value in mind as you continue to perform this procedure. Also, take note of whether or not Options 1DN (3.0 GHz Tracking Generator) and Option 1DS (RF Preamplifier) are installed.

Minimum RBW	_ Hz
Option 1DN:	
Option 1DS:	

3. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Then press the following keys:

Input/Output (or Input), Amptd Ref Out (On) FREQUENCY, Center Freq, 50 MHz SPAN, 2 kHz AMPLITUDE, -20 dBm AMPLITUDE, Attenuation, 10 dB BW/Avg, Res BW, 1 kHz BW/Avg, Video BW, 1 kHz Det/Demod, Detector, Sample, Return

- 4. On the analyzer, press Single.
- 5. On the analyzer, press **Peak Search** (or **Search**) and record the Ref Amptd reading below.

Ref Amptd _____ dBm

- 6. If the analyzer does not have Option 1DN (3.0 GHz Tracking Generator) installed and the minimum RBW is 100 Hz or 10 Hz, continue with step 12.
- 7. If the analyzer has a minimum RBW of 1 kHz or has Option 1DN (3.0 GHz Tracking Generator) installed then continue with step 8.
- 8. On the analyzer, press the following keys:

AMPLITUDE, Attenuation, 0 dB SPAN, 20 kHz BW/Avg, Res BW, 1 kHz BW/Avg, Video BW, 30 Hz

- 9. On the analyzer, press Single.
- 10.On the analyzer, press **Peak Search** (or **Search**) and record the amplitude reading below as Meas Amptd(1 kHz RBW).

Meas Amptd(1 kHz RBW) dB

11.Calculate the necessary reference level offset by subtracting the Meas Amptd in step 10 from the Ref Amptd in step 5. If the calculated Ref Lvl Offset is greater than 0.05 dB or less than -0.05 dB, record the Ref Lvl Offset value below. Otherwise, enter 0.

Ref Lvl Offset(1 kHz RBW) = Ref Amptd – Meas Amptd(1 kHz RBW)

Ref Lvl Offset(1 kHz RBW) dB

- 12.If the analyzer is not equipped with Option 1DR, continue with step 17.
- 13.On the analyzer, press the following keys:

AMPLITUDE, Attenuation, 0 dB SPAN, 500 Hz BW/Avg, Res BW, 10 Hz (E4407B) BW/Avg, Res BW, 100 Hz (E4408B) BW/Avg, Video BW, 1 Hz

- 14.On the analyzer, press Single.
- 15.On the analyzer, press Peak Search (or Search) and record the amplitude reading below as Meas Amptd(100 Hz/10 Hz RBW).

Meas Amptd(100 Hz/10 Hz RBW)_____ dB

16.Calculate the necessary reference level offset by subtracting the Meas Amptd in step 15 from the Ref Amptd in step 5. If the calculated Ref Lvl Offset is greater than 0.05 dB or less than -0.05 dB, record the Ref Lvl Offset value below. Otherwise, enter 0.

Ref Lvl Offset(100 Hz/10 Hz RBW) = Ref Amptd – Meas Amptd(100 Hz/10 Hz RBW)

Ref Lvl Offset(100 Hz/10 Hz RBW) dB

- 17.On the analyzer, press Input, Amptd Ref Out (Off), then AMPLITUDE, More, Ref LvI Offst, and enter the value recorded in step 10.
- 18.Connect the 50 Ω termination to the analyzer input as shown in Figure 2-56.
- 19.Disconnect the BNC cable and adapter from the AMPTD REF OUT and the 50 Ω Input.
- 20.If the analyzer is equipped with Option 1DN, 50 Ω tracking generator, do the following:
 - a. On the analyzer, press BW/Avg, Res BW, 1 kHz.
 - b. Press Source, Amplitude, 0 dBm.
 - c. Connect a 50 Ω termination to the RF OUT 50 Ω .

Measurement Sequence

The following model-specific DANL Measurement Sequence table lists the procedures to be performed and the parameters to be used in each procedure. Also listed in the table are test record entry numbers for recording the results in the performance verification test record.

- 1. Perform all of the following steps (through step 7) that apply to your analyzer using the appropriate subsets in Table 2-89 (E4407B) or Table 2-90 (E4408B). Then record the display line amplitude setting as the indicated Test Record entry in the performance verification test record.
- 2. If the minimum RBW of the analyzer is 1 kHz, perform those procedures listed as Subset A in Table 2-89 or Table 2-90.
- 3. If the minimum RBW of the analyzer is 1 kHz and Option 1DS (RF Preamplifier) is installed, also perform those procedures listed in Subset B in Table 2-89.
- 4. If the minimum RBW of the analyzer is 100 Hz or 10 Hz and Option 1DN (3.0 GHz Tracking Generator) is installed, perform those procedures listed in Subset A in Table 2-89 or Table 2-90.
- 5. If the minimum RBW of the analyzer is 10 Hz and both Option 1DS (RF Preamplifier) and Option 1DN (3.0 GHz Tracking Generator) are installed, also perform those procedures listed in Subset B in Table 2-89.
- 6. If the minimum RBW of the analyzer is 100 Hz or 10 Hz, also perform those procedures listed in Subset C in Table 2-89 or Table 2-90.
- 7. If the minimum RBW of the analyzer is 10 Hz and Option 1DS (RF Preamplifier) is installed, also perform those procedures listed in

Subset D in Table 2-89.

Table 2-89 DANL Measurement Sequence, E4407B

		Procedure Parameters				Test
Subset	Procedure	Start Freq	Stop Freq	Test RBW	Preamp State	Record Entry ^a
A	Measure DANL	10 MHz	1 GHz	1 kHz	Off	1)
	Measure DANL	1 GHz	2 GHz	1 kHz	Off	2)
	Measure DANL	2 GHz	3 GHz	1 kHz	Off	3)
	Measure DANL	3 GHz	6 GHz	1 kHz	Off	4)
	Measure DANL	6 GHz	12 GHz	1 kHz	Off	5)
	Measure DANL	12 GHz	22 GHz	1 kHz	Off	6)
	Measure DANL	22 GHz	26.5 GHz	1 kHz	Off	7)
В	Measure DANL	10 MHz	1 GHz	1 kHz	On	8/21)
	Measure DANL	1 GHz	2 GHz	1 kHz	On	9/22)
	Measure DANL	2 GHz	3 GHz	1 kHz	On	10/23)
С	Measure DANL	10 MHz	1 GHz	10 Hz	Off	11)
	Measure DANL	1 GHz	2 GHz	10 Hz	Off	12)
	Measure DANL	2 GHz	3 GHz	10 Hz	Off	13)
	Measure DANL	3 GHz	6 GHz	10 Hz	Off	14)
	Measure DANL	6 GHz	12 GHz	10 Hz	Off	15)
	Measure DANL	12 GHz	22 GHz	10 Hz	Off	16)
	Measure DANL	22 GHz	26.5 GHz	10 Hz	Off	17)
D	Measure DANL	10 MHz	1 GHz	10 Hz	On	18/24)
	Measure DANL	1 GHz	2 GHz	10 Hz	On	19/25)
	Measure DANL	2 GHz	3 GHz	10 Hz	On	20/26)

a. There are two possible entries for measurements made with the preamplifier on, depending upon the ambient temperature. The first entry is for measurements made with an ambient temperature outside of the 20° to 30° C range, but within the 0° to 55° C range. The second entry is for measurements made with an ambient temperature within the 20° to 30° C range.

Table 2-90 DANL Measurement Sequence, E4408B

		Procedure Parameters				Test
Subset	Procedure	Start Freq	Stop Freq	Test RBW	Preamp State	Record Entry
A	Measure DANL	10 MHz	1 GHz	1 kHz	Off	1)
	Measure DANL	1 GHz	2 GHz	1 kHz	Off	2)
	Measure DANL	2 GHz	3 GHz	1 kHz	Off	3)
	Measure DANL	3 GHz	6 GHz	1 kHz	Off	4)
	Measure DANL	6 GHz	12 GHz	1 kHz	Off	5)
	Measure DANL	12 GHz	22 GHz	1 kHz	Off	6)
	Measure DANL	22 GHz	26.5 GHz	1 kHz	Off	7)
С	Measure DANL	10 MHz	1 GHz	100 Hz	Off	11)
	Measure DANL	1 GHz	2 GHz	100 Hz	Off	12)
	Measure DANL	2 GHz	3 GHz	100 Hz	Off	13)
	Measure DANL	3 GHz	6 GHz	100 Hz	Off	14)
	Measure DANL	6 GHz	12 GHz	100 Hz	Off	15)
	Measure DANL	12 GHz	22 GHz	100 Hz	Off	16)
	Measure DANL	22 GHz	26.5 GHz	100 Hz	Off	17)

8. After performing all applicable DANL measurement procedures, continue with Remove Reference Level Offset.

Measuring Displayed Average Noise Level

Use the following procedure for testing DANL over most frequency ranges. The start and stop frequencies and test RBW (1 kHz, 100 Hz or 10 Hz) are specified in the DANL Measurement Sequence Table (Table 2-89 or Table 2-90).

- If the test RBW is 100 Hz or 10 Hz and the analyzer has Option 1DN (1.5 GHz Tracking Generator) installed, press Source, Amplitude (Off).
- 2. Set the analyzer as follows:

Auto Couple
FREQUENCY, Start Freq, (enter specified start frequency)
FREQUENCY, Stop Freq, (enter specified stop frequency)
AMPLITUDE, -70 dBm
Attenuation, 0 dB

AMPLITUDE, More, Ref Lvl Offst, (enter Ref Lvl Offset (1 kHz) if test

```
RBW = 1 \ kHz
```

AMPLITUDE, More, Ref Lvl Offst, (enter Ref Lvl Offset (100 Hz / 10 Hz) if test RBW = 10 Hz or 100 Hz)

BW/Avg, Res BW, 1 MHz

BW/Avg, Video BW, 10 kHz

AMPLITUDE, More, Int Preamp (Off) (if preamp state = Off)

AMPLITUDE, More, Int Preamp (On) (if preamp state = On)

Sweep, Sweep (Cont)

Sweep, Sweep Time (Auto)

- 3. If the analyzer is equipped with Option 1DN and the current stop frequency is >3 GHz, press **Source**, **Amplitude** (Off).
- 4. On the analyzer, press Single, View/Trace, Trace 1, Clear Write, BW/Avg, Average Type (Video), Average, 3, Enter, Single.

Wait until VAvg 3 is displayed to the left of the graticule (the analyzer will take three sweeps, then stop).

5. On the analyzer, press the following keys:

Peak Search (or Search)
BW/Avg, Average (Off)
Marker→, Mkr→ CF

6. If the test RBW is 1 kHz, press SPAN, 20 kHz.

If the test RBW is 100 Hz or 10 Hz, press **SPAN**, **500 Hz**.

7. If the test RBW is 1 kHz, press BW/Avg, Res BW, 1 kHz, Video BW, 30 Hz.

If the test RBW is 100 Hz, press BW/Avg, Res BW, 100 Hz, Video BW, 10 Hz.

If the test RBW is 10 Hz, press BW/Avg, Res BW, 10 Hz, Video BW. 1 Hz.

- 8. On the analyzer, press **Single** and wait for the new sweep to finish.
- 9. Read the average of the trace data, ignoring any residual responses. On the analyzer, press **Display**, **Display Line** (On), and adjust the display line so that it is centered on the average trace noise, ignoring any residual responses (refer to the Residual Responses verification test for any suspect residuals).

Remove Reference Level Offset

- 10.Press AMPLITUDE, More, Ref LvI Offst, 0 dB.
- 11.On the analyzer, press **Preset**.
- 12. This performance test is now complete.

39. Residual Responses

The analyzer input is terminated and the analyzer is swept from 150 kHz to 1 MHz. Then the analyzer is swept in incremental 10 MHz spans from 1 MHz to the upper frequency range. Any responses above the specification are noted.

There are no related adjustment procedures for this performance test.

Equipment Required

Termination, 50 Ω Type-N (m)

Additional Equipment for 75 Ω Input

Termination, 75 Ω , BNC (m) Adapter, Type-N (f) to BNC (m), 75 Ω

Additional Equipment for Option BAB

Adapter, Type-N (f) to APC 3.5 (f)

CAUTION

Use only 75 Ω cables, connectors, or adapters on instruments with 75 Ω input, or damage to the input connector will occur.

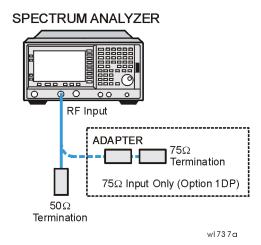
Procedure

150 kHz to 1 MHz

1. Connect the 50 Ω termination to the analyzer input as shown in Figure 2-57.

75 Ω Input: Use the adapter to connect the 75 Ω termination, and continue with step 4.

Figure 2-57 Residual Response Test Setup



2. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the analyzer by pressing the following keys:

FREQUENCY, Start Freq, 150 kHz FREQUENCY, Stop Freq, 1 MHz AMPLITUDE, -60 dBm AMPLITUDE, Attenuation, 0 dB BW/Avg, 3 kHz BW/Avg, Video BW, 1 kHz Display, Display Line On, -90 dBm

3. Press **Single** and wait for a new sweep to finish. Look for any residual responses at or above the display line.

If a residual is suspected, press **Single** again. A residual response will persist on successive sweeps, but a noise peak will not. Note the frequency and amplitude of any residual responses above the display line in Table 2-91.

4. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the analyzer by pressing the following keys:

FREQUENCY, Center Freq, 5.9 MHz FREQUENCY, CF Step, 9.9 MHz SPAN, 10 MHz AMPLITUDE, -60 dBm $(50~\Omega~Input~only)$ AMPLITUDE, -11.2 dBmV $(75~\Omega~Input~only)$ AMPLITUDE, Attenuation, 0 dB BW/Avg, 10 kHz BW/Avg, Video BW, 3 kHz Display, Display Line On, -90 dBm, $(50~\Omega~Input~only)$ Display, Display Line On, -36 dBmV $(75~\Omega~Input~only)$

5. Repeat step 6 and step 7 until the complete range of frequencies has

been checked for the model and frequency ranges below.

Agilent Model	Frequency Range
E4401B and E4411B	1 MHz to 1.5 GHz
E4402B and E4403B	1 MHz to 3.0 GHz
E4404B, E4405B, E4407B, and E4408B	1 MHz to 6.7 GHz

6. Press **Single** and wait for a new sweep to finish. Look for any residual responses at or above the display line.

If a residual is suspected, press **Single** again. A residual response will persist on successive sweeps, but a noise peak will not. Record the frequency and amplitude of any residual responses above the display line in Table 2-91.

7. Press FREQUENCY, Center Freq. ↑.

If there are any residuals at or near the frequency specification limits (1 MHz, 1.5 GHz, 3 GHz, or 6.7 GHz), it is recommended that a known frequency source be used as a frequency marker. This will ensure that testing is done at or below the specification limits.

Table 2-91 Residual Responses Worksheet

Frequency (MHz)	Amplitude (dBm or dBmV)

8. Record the highest residual from Table 2-91 as Test Record entry 1 in the performance verification test record. If no residuals are found, then record "N/A" in the performance verification test record.

40. Fast Time Domain Amplitude Accuracy: Agilent E4401B, E4402B, E4404B, E4405B, and E4407B (Option AYX)

The analyzer amplitude reference signal is used to compare the amplitude level of a normal sweep time (≥ 5 ms) to a fast sweep time (≤ 5 ms) using the marker functions. The difference should be less than the marker readout resolution specification for the fast sweep times.

Equipment Required

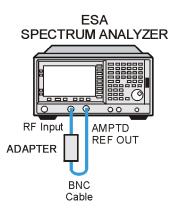
Cable, BNC, 122 cm (48 in) Adapter, Type-N (m) to BNC (f)

Procedure

Fast Sweep Time Amplitude Accuracy

1. Connect the equipment as shown in Figure 2-58.

Figure 2-58 Fast Time Domain Amplitude Accuracy Test Setup



wl760a

NOTE

No test setup is required for the Agilent E4401B.

- 2. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed.
- 3. Set the analyzer as follows:

FREQUENCY, 50 MHz
SPAN, Zero Span
Sweep 5 ms
Input/Output (or Input), Amptd Ref (On) (Agilent E4401B only)

40. Fast Time Domain Amplitude Accuracy: Agilent E4401B, E4402B, E4404B, E4405B, and E4407B (Option AYX)

Input/Output (or Input), Amptd Ref Out (On) (Agilent E4402B, E4404B, E4405B, E4407B only)
AMPLITUDE, Scale Type (Lin)
AMPLITUDE, More, Y-Axis Units (or Amptd Units), Volts
AMPLITUDE, Ref Level, 12.57 mV (Agilent E4401B, 50 W only)
AMPLITUDE, Ref Level, 15.05 mV (Agilent E4401B, 75 W only)
AMPLITUDE, Ref Level, 30.73 mV (Agilent E4402B, E4404B, E4405B, E4407B only)

4. On the analyzer, press:

Marker, More 1 of 2, Function Marker Noise, Single Marker, Delta Sweep, 1 ms Single

5. If the marker delta (Δ Mkr1) amplitude readout (the second line) is not expressed as a percentage, subtract 1 from the marker delta (Δ Mkr1) amplitude (ignore the "X") and multiply the result by 100 to obtain the amplitude error in percent:

Amplitude Error =
$$(\Delta Mkr1 - 1.0) \times 100$$

6. If the marker delta (Δ Mkr1) amplitude readout is expressed as a percentage, subtract 100% from the marker delta (Δ Mkr1) amplitude reading to obtain the amplitude error in percent:

Amplitude Error =
$$\Delta Mkr1 - 100\%$$

7. Record the Amplitude Error as Test Record entry 1 in the performance verification test record.

41. Tracking Generator Absolute Amplitude and Vernier Accuracy: Agilent E4401B and E4411B (Option 1DN or 1DQ)

A calibrated power sensor is connected to the tracking generator output to measure the power level at 50 MHz.

The power meter is set to relative mode so that future power level readings are in dB relative to the reference power level setting. The output power level setting is decreased in 1 dB steps and the power level is measured at each step. The difference between the ideal and actual power levels is calculated at each step.

Since a power sweep is accomplished by stepping through the vernier settings, the peak-to-peak variation of the vernier accuracy is equal to the power sweep accuracy.

The related adjustments for this performance test are "Tracking Generator ALC Calibration" and "Tracking Generator Frequency Slope."

Equipment Required

Power meter, compatible with power sensor RF power sensor, 50 Ω

Additional Equipment for Option 1DQ

Power sensor, 75 Ω Adapter, Type-N (f) to BNC (m), 75 Ω Adapter, Type-N (f), 75 Ω to Type-N (m), 50 Ω

Procedure

CAUTION

Use only 75 Ω cables, connectors, or adapters on instruments with 75 Ω connectors, or damage to the connectors will occur.

For Agilent E4411B analyzers, this test must be performed at 20 to 30° C.

1. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the analyzer by pressing the following keys:

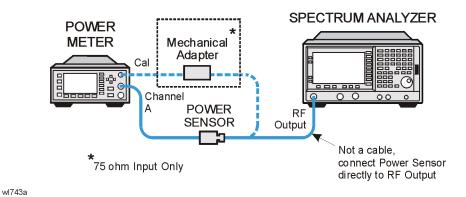
FREQUENCY, Center Freq, 50 MHz SPAN, Zero Span AMPLITUDE, 0 dBm $(Option\ 1DN)$ AMPLITUDE, 42.76 dBmV $(Option\ 1DQ)$ Source, Amplitude (On), 0 dBm $(Option\ 1DN)$

41. Tracking Generator Absolute Amplitude and Vernier Accuracy: Agilent E4401B and E4411B (Option 1DN or 1DQ)

Source, Amplitude (On), 42.76 dBmV $(Option\ 1DQ)$ Source, Attenuation, 0 dB Single

- 2. Zero and calibrate the power meter and power sensor in log mode (power reads out in dBm), as described in the power meter operation manual. Enter the 50 MHz Cal Factor of the power sensor into the power meter.
- 3. Connect the 50 Ω power sensor to the RF OUT as shown in Figure 2-59.

Figure 2-59 Absolute Amplitude, Vernier, and Power Sweep Accuracy Test Setup



Option 1DQ: Connect the 75 Ω power sensor to the RF OUT 75 Ω as shown in Figure 2-59.

4. Read the power level displayed on the power meter and record the result as Test Record entry 1 of the performance verification test record as the Absolute Amplitude Accuracy.

Absolute Amplitude Accuracy at 50 MHz = ____dB

Option 1DQ: Add 6 dB to the power level displayed on the power meter and record the result as Test Record entry 1 of the performance verification test record as the Absolute Amplitude Accuracy.

- 5. Set the power meter to dB relative mode as described in the power meter operation manual so that the readout is in power level relative to the power level at 50 MHz (press **Rel/Offset**, **Rel**).
- 6. Set the source amplitude to the settings indicated in Table 2-92.

Option 1DQ: Use the source amplitude settings for Option 1DQ analyzers.

- 7. Press **Single** on the analyzer. At each setting, record the power level displayed on the power meter as Measured Power Level in Table 2-92.
- 8. Calculate the Vernier Accuracy by subtracting the Source Vernier

41. Tracking Generator Absolute Amplitude and Vernier Accuracy: Agilent E4401B and E4411B (Option 1DN or 1DQ)

Setting from the Measured Power Level for each Source Amplitude Setting in Table 2-92.

Vernier Accuracy = Measured Power Level (dB) – Source Vernier Setting (dB)
9. Locate the most positive and most negative Vernier Accuracy Values for Source Vernier Settings of -1 dBm to -10 dBm recorded in Table 2-92. Record the Positive Vernier Accuracy as Test Record entry 2 and the Negative Vernier Accuracy as Test Record entry 3 in the performance verification test record.
Option 1DQ: For source amplitudes of 41.76 dBmV to $27.76 \ dBmV$.
Positive Vernier Accuracy dB
Negative Vernier Accuracy dB
10.Locate the most positive and most negative Vernier Accuracy values for all Source Amplitude Settings in Table 2-92 and record these values below:
Positive Power Sweep Accuracy dB
Negative Power Sweep Accuracy dB
11.Calculate the Power Sweep Accuracy by subtracting the Negative Power Sweep Accuracy recorded in the previous step from the Positive Power Sweep Accuracy recorded in the previous step. Record the Power Sweep Accuracy as Test Record entry 4 in the performance verification test record.
Power Sweep Accuracy = Positive Power Sweep Accuracy – Negative Power Sweep Accuracy

Power Sweep Accuracy _____ dB

41. Tracking Generator Absolute Amplitude and Vernier Accuracy: Agilent E4401B and E4411B (Option 1DN or 1DQ)

Table 2-92 Vernier Accuracy Worksheet

Source Amplitude Setting		Source Vernier Setting	Measured Power Level	Vernier Accuracy
Option 1DN (dBm)	Option 1DQ (dBmV)	(dB)	(dB)	(dB)
0 (Ref)	42.76 (Ref)	0 (Ref)	NA	NA
-1	41.76	-1		
-2	40.76	-2		
-3	39.76	-3		
-4	38.76	-4		
-5	37.76	-5		
-6	36.76	-6		
-7	35.76	-7		
-8	34.76	-8		
-9	33.76	-9		
-10	32.76	-10		
-11	31.76	-11		
-12	30.76	-12		
-13	29.76	-13		
-14	28.76	-14		
-15	27.76	-15		

41. Tracking Generator Absolute Amplitude and Vernier Accuracy: Agilent E4401B and E4411B (Option 1DN or 1DQ)

42. Tracking Generator Absolute Amplitude and Vernier Accuracy: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B (Option 1DN)

A calibrated power sensor is connected to the tracking generator output to measure the power level at 50 MHz.

The power meter is set to relative mode so that future power level readings are in dB relative to the reference power level setting. The output power level setting is decreased in 1 dB steps and the power level is measured at each step. The difference between the ideal and actual power levels is calculated at each step.

Since a power sweep is accomplished by stepping through the vernier settings, the peak-to-peak variation of the vernier accuracy is equal to the power sweep accuracy.

The related adjustment for this performance test is the front panel Align Now, TG (Ext Cable) under the System, Alignments menu.

Equipment Required

Power meter, compatible with power sensor Power sensor, 50 Ω

Procedure

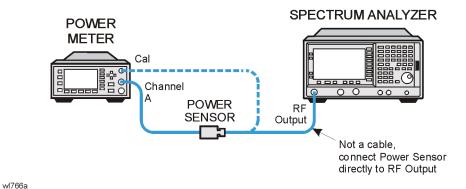
1. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the analyzer by pressing the following keys:

FREQUENCY, Center Freq, 50 MHz SPAN, Zero Span AMPLITUDE, 0 dBm System, Alignments, Auto Align, Off Source Amptd, Amplitude (On), –20 dBm Source Amptd, Attenuation (Man), 16 dB Single Sweep

- 2. Zero and calibrate the power meter and power sensor in log mode (power reads out in dBm), as described in the power meter operation manual. Enter the 50 MHz Cal Factor of the power sensor into the power meter.
- 3. Connect the 50 Ω power sensor to the RF output as shown in Figure 2-60.

Figure 2-60 Absolute Amplitude, Vernier, and Power Sweep Accuracy Test

Setup



4. Read the power level displayed on the power meter, add 20 dB, and record the result as Test Record entry 1 of the performance verification test record as the Absolute Amplitude Accuracy.

Absolute Amplitude Accuracy at 50 MHz = dB

- 5. Set the power meter to dB relative mode as described in the power meter operation manual so that the readout is in power level relative to the power level at 50 MHz (press **Rel/Offset**, **Rel**).
- 6. Press **Single** on the analyzer. At each setting, record the power level displayed on the power meter in Table 2-93.
- 7. Set the source amplitude to the settings indicated in Table 2-93.

Table 2-93 Vernier and Power Sweep Accuracy Worksheet

Source Amplitude Setting	Source Vernier Setting	Measured Power Level	Vernier Accuracy
(dBm)	(dBm)	(dB)	(dB)
-18	-2		2)
-19	-3		3)
-20 (Ref)	-4	N/A	N/A
-21	-5		4)
-22	-6		5)
-23	-7		6)
-24	-8		7)
-25	-9		8)
-26	-10		9)

8. Calculate the Vernier Accuracy by adding 4 dB to the Source Vernier

42. Tracking Generator Absolute Amplitude and Vernier Accuracy: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B (Option 1DN)

setting and subtracting the result from the Measured Power Level for each Source Amplitude Setting in Table 2-93.

Vernier Accuracy = Measured Power Level (dB) – (Source Vernier Setting (dB) + 4 dB)

- 9. Record the vernier accuracy values from Table 2-93 as test record entries (TR entries) 2 through 9 in the performance test record.
- 10.Copy the Absolute Vernier Accuracy values from Table 2-93 into columns 2 and 3 of Table 2-94 on page 342, as indicated by the TR entry numbers.
- 11.Calculate the Incremental Vernier Accuracy for each Source Vernier Setting by subtracting the Absolute Vernier Accuracy value in Column 3 of Table 2-94 from the Absolute Vernier Accuracy value in Column 2. Record the result in Column 4 of Table 2-94 and in the Performance Test Record as indicated by the TR entry number.

Example:

If the Absolute Vernier Accuracy for the -7 dB vernier setting is 0.23 dB (TR entry 6) and the Absolute Vernier Accuracy for the -8 dB vernier setting is 0.08 dB (TR entry 7), the Incremental Vernier Accuracy for the -8 dB vernier setting would be -0.15 dB (-0.15 = 0.08 - 0.23).

 Table 2-94
 Incremental Vernier Accuracy Worksheet

Column 1	Column 2	Column 3	Column 4
Source Vernier Setting (dB)	Absolute Vernier Accuracy (dB)	Absolute Vernier Accuracy (dB)	Incremental Vernier Accuracy (dB)
-2	2)	3)	10)
-3	3)	0.0	11)
-4	0.0 (Ref)	0.0 (Ref)	0.0 (Ref)
-5	4)	0.0	12)
-6	5)	4)	13)
-7	6)	5)	14)
-8	7)	6)	15)
-9	8)	7)	16)
-10	9)	8)	17)

12.Press System, Alignments, Auto Align, All.

43. Tracking Generator Level Flatness: Agilent E4401B and E4411B (Option 1DN or 1DQ)

This test verifies that analyzers with the tracking generator option (1DN or 1DQ) meet their tracking generator level flatness specification. A calibrated power sensor is connected to the tracking generator output to measure the power level at 50 MHz. The power meter is set for dB relative mode so that future power level readings are in dB, relative to the power level at 50 MHz.

Next, the tracking generator is stepped to several frequencies throughout its range, and the output power difference relative to the power level at 50 MHz is measured for each frequency recorded.

For frequencies below 100 kHz, a digital voltmeter and precision 50 Ω termination are used to measure the power of the tracking generator output. The DVM is set to read out in dBm using the MATH function with R value set to 50 Ω The following equation is used to calculate dBm:

$$dBm = 10 \log_{10}((E^2/R)/1mW)$$

The DVM readout is corrected by making the readings relative to the 100 kHz reading from the power sensor.

Option 1DN, 50 Ω tracking generators are tested from 9 kHz to 1500 MHz.

Option 1DQ, 75 Ω tracking generators are tested from 1 MHz to 1500 MHz.

The related adjustments for this procedure are "Tracking Generator ALC Calibration" and "Tracking Generator Frequency Slope."

Equipment Required

Power meter Power sensor, 50 Ω , 100 kHz to 1.5 GHz Digital multimeter Termination, 50 Ω Cable, BNC Adapter, Type-N tee, (m) (f) (f) Adapter, Type-N (m) to BNC (f) Adapter, BNC (f) to dual banana plug

Additional Equipment for Option 1DQ

Power sensor, 75 Ω , 1 MHz to 1.5 GHz Adapter, Type-N (f) to BNC (m), 75 Ω

CAUTION

Use only 75 Ω cables, connectors, or adapters on the 75 Ω input of an Option 1DQ or damage to the input connector will occur.

Procedure

Tracking Generator Level Flatness, Center Frequency ≥100 kHz

- 1. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed.
- 2. Set the analyzer by pressing the following keys:

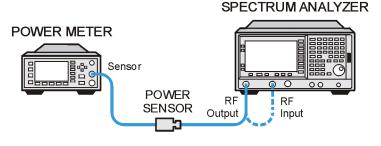
FREQUENCY, 50 MHz FREQUENCY, CF Step, 150 MHz SPAN, Zero Span Source, Amplitude On, 0 dBm $(Option\ 1DN)$ Source, Amplitude On, 42.76 dBmV $(Option\ 1DQ)$ Single

3. Zero and calibrate the power meter with the power sensor in log mode (power reads out in dBm), as described in the power meter operation manual.

Option 1DQ: Use a 75 Ω power sensor.

4. Connect the power sensor to the RF Out on the analyzer. See Figure 2-61.

Figure 2-61 Tracking Generator Level Flatness Test Setup, ≥100 kHz



wl712a

5. Set the power meter to relative mode, as described in the power meter operation manual. Power levels now read out in power level

relative to the power level at 50 MHz.

Perform the next four steps for each measurement value in Table 2-95.

1. Set the center frequency of the analyzer according to the values in Table 2-95. For 100 kHz, press **FREQUENCY**, **100 kHz**. The **step up key** $(\ensuremath{\Uparrow})$ may be used to tune to center frequencies above 100 MHz.

Option 1DQ: Start at 1 MHz by pressing FREQUENCY, 1 MHz.

- 2. Press **Single** on the analyzer.
- 3. Enter the appropriate power sensor Cal Factor into the power meter as indicated in Table 2-95.
- 4. Record the power level displayed on the power meter in the Level Flatness column in Table 2-95.

Table 2-95 Tracking Generator Level Flatness Worksheet, ≥100 kHz

Center Frequency	Level Flatness (dB)	Cal Factor (MHz)
100 kHz ^a		0.1
300 kHz ^a		0.3
500 kHz ^a		0.3
1 MHz		1
2 MHz		3
5 MHz		3
10 MHz		10
20 MHz		30
40 MHz		50
50 MHz	0 (Ref)	50
80 MHz		100
100 MHz		100
250 MHz		300
400 MHz		300
550 MHz		300
700 MHz		1000
850 MHz		1000

Table 2-95 Tracking Generator Level Flatness Worksheet, ≥100 kHz

Center Frequency	Level Flatness (dB)	Cal Factor (MHz)
1000 MHz		1000
1150 MHz		1000
1300 MHz		1000
1450 MHz		1000
1500 MHz		2000

- a. These frequencies do not apply to analyzers with Option 1DQ Tracking Generators (75 Ω RF Output).
- 5. Disconnect the power sensor from the RF Out on the analyzer.

Tracking Generator Level Flatness, Center Frequency ≤100 kHz

NOTE

Perform step 1 to step 7 for 50 Ω tracking generators only (*Option 1DN*).

1. Set up the digital multimeter as follows.

Parameter	Setting
AC/DC	AC Volts
Impedance & Units:	
Set to 50 Ω impedance	SMATH 10 ^a
Set to dBm	MATH 5 ^a
Set to Synchronous	SETACV 3 ^a
Sub-sampled mode	

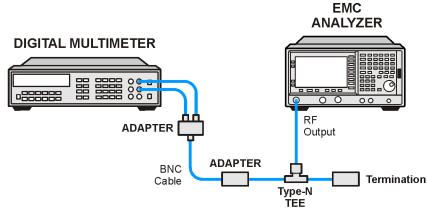
a. To set the Agilent 3458A multimeter functions from the front panel, press the blue shift key, then Recall State (T) key. Use the \uparrow (up) and \downarrow (down) arrows to select the appropriate function, then enter the value from the numeric keypad and press enter.

NOTE

Perform step 2 to step 7 for each measurement value in Table 2-97.

2. Refer to Figure 2-62 to set up the equipment.

Figure 2-62 Tracking Generator Level Flatness Test Setup, ≤100 kHz



wb939a

3. To set the analyzer center frequency to 9 kHz, press **FREQUENCY**, **9 kHz** (or as indicated in Table 2-96).

- 43. Tracking Generator Level Flatness: Agilent E4401B and E4411B (Option 1DN or 1DQ)
- 4. Press Single.
- 5. Record the DVM readout in Table 2-96.
- 6. Subtract the 100 kHz Level Flatness readout in Table 2-95 from the 100 kHz DVM Readout in Table 2-96 and record as the DVM Offset at 100 kHz.

DVM Offset at 100 kHz	dE
-----------------------	----

For example, if the Level Flatness reading from Table 2-95 is 0.7 dB and the DVM Readout from Table 2-96 is -0.53 dBm, the DVM offset would be -1.23 dB.

DVM Offset = DVM Readout – Level Flatness

7. Add the DVM Offset at 100 kHz from step 6, above, to each of the DVM Readouts in Table 2-96 and record as the Corrected Level Flatness in Column 3.

For example, if the DVM Readout from Table 2-96 is 0.22 dBm, and the DVM Offset is -1.23 dB, the Corrected Level Flatness would be -1.01 dB.

Corrected Level Flatness = DVM + DVM Offset

Table 2-96 Tracking Generator Level Flatness Worksheet, ≤100 kHz

Center Frequency	DVM Readout (dBm)	Corrected Level Flatness (dB)
9 kHz		
20 kHz		
40 kHz		
60 kHz		
80 kHz		
100 kHz		

- 8. For 50 Ω tracking generators only, locate the most positive Level Flatness reading in Table 2-95 and Table 2-96 for frequencies <1 MHz and enter this value as Test Record entry 1 of the performance verification test record.
- 9. For 50 Ω tracking generators only, locate the most negative Level Flatness reading in Table 2-95 and Table 2-96 for frequencies <1 MHz and enter this value as Test Record entry 2 of the

performance verification test record.

- 10.Locate the most positive Level Flatness reading in Table 2-95 and Table 2-96 for frequencies ≥1 MHz and ≤10 MHz and enter this value as Test Record entry 3 of the performance verification test record.
- 11.Locate the most negative Level Flatness reading in Table 2-95 and Table 2-96 for frequencies ≥1 MHz and ≤10 MHz and enter this value as Test Record entry 4 of the performance verification test record.
- 12.Locate the most positive Level Flatness reading in Table 2-95 for frequencies ≥10 MHz and ≤1.5 GHz and enter this value as Test Record entry 5 of the performance verification test record.
- 13.Locate the most negative Level Flatness reading in Table 2-95 for frequencies ≥10 MHz and ≤1.5 GHz and enter this value as Test Record entry 6 of the performance verification test record.

44. Tracking Generator Level Flatness: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B (Option 1DN)

This test verifies that analyzers with the tracking generator option 1DN meet their tracking generator level flatness specification. In this test, a calibrated power sensor is connected to the tracking generator output to measure the power level at 50 MHz. The power meter is set for dB Relative mode so that future power level readings are in dB, relative to the power level at 50 MHz.

Next, the tracking generator is stepped to several frequencies throughout its range, and the output power difference relative to the power level at 50 MHz is measured for each frequency recorded.

For frequencies below 100 kHz, a digital voltmeter and precision 50 Ω termination are used to measure the power of the tracking generator output. The DVM is set to read out in dBm using the MATH function with R value set to 50 Ω The following equation is used to calculate dBm:

$$dBm = 10 \log_{10}((E^2/R)/1mW)$$

The DVM readout is corrected by making the readings relative to the 100 kHz reading from the power sensor.

• Option 1DN, 50 Ω tracking generators are tested from 9 kHz to 3000 MHz.

The related adjustment for this performance test is the front panel Align Now, TG (Ext Cable) under the System, Alignments menu.

Equipment Required

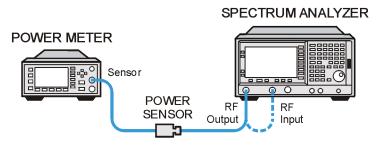
Power meter Power sensor, 50Ω Digital multimeter Termination, 50Ω Cable, BNC Cable, Type-N (m) (m) Adapter, Type-N tee, (m) (f) (f) Adapter, Type-N (m) to BNC (f) Adapter, BNC (f) to dual banana plug

Procedure

Tracking Generator Level Flatness, Center Frequency ≥100 kHz

- 1. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed.
- 2. Connect the Type-N cable between the RF Input and the tracking generator RF OUT, as shown in Figure 2-63. Do not connect the power sensor to the analyzer yet.

Figure 2-63 Tracking Generator Level Flatness Test Setup ≥100 kHz



wl712a

3. Set the analyzer by pressing the following keys:

FREQUENCY, 50 MHz
FREQUENCY, CF Step, 150 MHz
SPAN, Zero Span
System, Alignments, Auto Align, Off
Marker
Source, Amplitude (On),
Source, More, Tracking Peak (Wait for the Peaking message to disappear.)
Source, Amplitude, -20 dBm
Single

- 4. Disconnect the Type-N cable.
- 5. Zero and calibrate the power meter with the power sensor in log mode (power reads out in dBm), as described in the power meter operation manual.
- 6. Connect the 50 Ω power sensor to the RF OUT 50 Ω on the analyzer. See Figure 2-63.
- 7. Set the power meter to relative mode, as described in the power meter operation manual. Power levels now read out in power level relative to the power level at 50 MHz.

Perform the next four steps for each measurement value in Table 2-97.

8. Set the center frequency of the analyzer according to the values in

44. Tracking Generator Level Flatness: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B (Option 1DN)

Table 2-97. For 100 kHz, press **FREQUENCY**, **100 kHz**. The \uparrow (step up key) may be used to tune to most center frequencies above 100 MHz.

- 9. Press **Single** on the analyzer.
- 10.Enter the appropriate power sensor Cal Factor into the power meter as indicated in Table 2-97.
- 11.Record the power level displayed on the power meter in the Level Flatness column in Table 2-97.

Table 2-97 Tracking Generator Level Flatness Worksheet, ≥100 kHz

Center Frequency	Level Flatness (dB)	Cal Factor (MHz)
100 kHz		0.1
300 kHz		0.3
500 kHz		0.3
1 MHz		1
2 MHz		3
5 MHz		3
10 MHz		10
20 MHz		30
40 MHz		50
50 MHz	0 (Ref)	50
80 MHz		100
100 MHz		100
250 MHz		300
400 MHz		300
550 MHz		300
700 MHz		1000
850 MHz		1000
1000 MHz		1000
1150 MHz		1000
1300 MHz		1000
1450 MHz		1000
1600 MHz		2000
1750 MHz		2000

Table 2-97 Tracking Generator Level Flatness Worksheet, ≥100 kHz

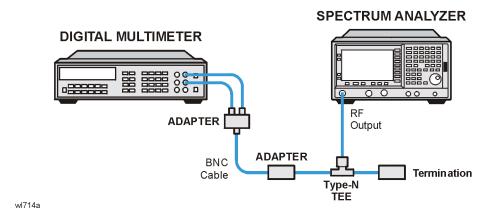
Center Frequency	Level Flatness (dB)	Cal Factor (MHz)
1900 MHz		2000
2050 MHz		2000
2200 MHz		2000
2350 MHz		2000
2500 MHz		3000
2650 MHz		3000
2800 MHz		3000
2950 MHz		3000
3000 MHz		3000

12. See Figure 2-63. Disconnect the power sensor from the RF Out 50 Ω on the analyzer.

Tracking Generator Level Flatness, Center Frequency ≤100 kHz

1. Refer to Figure 2-64 to set up the equipment.

Figure 2-64 Tracking Generator Level Flatness Test Setup, ≤100 kHz



Set up the digital multimeter as follows.

Parameter	Setting
AC/DC	AC Volts
Impedance & Units:	

44. Tracking Generator Level Flatness: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B (Option 1DN)

Parameter	Setting
Set to 50 Ω impedance	SMATH 10 ^a
Set to dBm	MATH 5 ^a
Set to Synchronous	SETACV 3ª
Sub-sampled mode	

- a. To set the Agilent 3458A multimeter functions from the front panel, press the blue shift key, then Recall State (T) key. Use the \uparrow (up) and \downarrow (down) arrows to select the appropriate function, then enter the value from the numeric keypad and press enter.
- 2. Set the analyzer resolution bandwidth to 10 kHz by pressing BW/Avg, Res BW, 10 kHz.

Repeat step 3 through step 7 for each Center Frequency value in Table 2-98.

- 3. Set the analyzer center frequency to 9 kHz, by pressing **FREQUENCY**, **9 kHz**.
- 4. Press Single.
- 5. Record the DVM readout in Table 2-98.
- 6. Subtract the 100 kHz Level Flatness readout in Table 2-97 from the 100 kHz DVM Readout in Table 2-98 and record as the DVM Offset at 100 kHz.

DVM Offset at 100 kHz	$\mathrm{d}\mathbf{F}$
-----------------------	------------------------

For example, if the Level Flatness reading from Table 2-97 is 0.7 dB and the DVM Readout from Table 2-98 is -0.53 dBm, the DVM offset would be -1.23 dB.

DVM Offset= DVM Readout – Level Flatness

7. Add the DVM Offset at 100 kHz from step 6, above, to each of the DVM Readouts in Table 2-98 and record as the Corrected Level Flatness in Column 3.

For example, if the DVM Readout from Table 2-98 is 0.22 dBm, and the DVM Offset is -1.23 dB, the Corrected Level Flatness would be -1.01 dB.

Corrected Level Flatness = DVM Readout + DVM Offset

8. Press System, Alignments, Auto Align, All.

Table 2-98 Tracking Generator Level Flatness Worksheet, 100 kHz

Center Frequency	DVM Readout (dBm)	Corrected Level Flatness (dB)
9 kHz		
20 kHz		
40 kHz		
60 kHz		
80 kHz		
100 kHz		

- 1. Locate the most positive Level Flatness reading in Table 2-97 and Table 2-98 for frequencies <1 MHz and enter this value as Test Record entry 1 of the performance verification test record.
- 2. Locate the most negative Level Flatness reading in Table 2-97 and Table 2-98 for frequencies <1 MHz and enter this value as Test Record entry 2 of the performance verification test record.
- 3. Locate the most positive Level Flatness reading in Table 2-97 and Table 2-98 for frequencies ≥1 MHz and ≤10 MHz and enter this value as Test Record entry 3 of the performance verification test record.
- 4. Locate the most negative Level Flatness reading in Table 2-97 and Table 2-98 for frequencies ≥1 MHz and ≤10 MHz and enter this value as Test Record entry 4 of the performance verification test record.
- 5. Locate the most positive Level Flatness reading in Table 2-97 for frequencies ≥10 MHz and ≤1.5 GHz and enter this value as Test Record entry 5 of the performance verification test record.
- 6. Locate the most negative Level Flatness reading in Table 2-97 for frequencies ≥10 MHz and ≤1.5 GHz and enter this value as Test Record entry 6 of the performance verification test record.
- 7. Locate the most positive Level Flatness reading in Table 2-97 for frequencies >1.5 GHz and enter this value as Test Record entry 7 of the performance verification test record.
- 8. Locate the most negative Level Flatness reading in Table 2-97 for frequencies >1.5 GHz and enter this value as Test Record entry 8 of the performance verification test record.

45. Tracking Generator Harmonic Spurious Outputs: Agilent E4401B and E4411B (Option 1DN or 1DQ)

The measurement for tracking generator harmonic spurious outputs determines the maximum level of tracking generator harmonics. The tracking generator output is connected to the input of a microwave analyzer, then tuned to several different frequencies as the amplitude of the second and third harmonics relative to the fundamental are measured at each frequency.

There are no related adjustment procedures for this performance test.

Equipment Required

Microwave analyzer Cable, Type-N, 62 cm (24 in) Cable, BNC to BNC, 23 cm (9 in) Adapter, Type-N (m) to BNC (f)

Additional Equipment Required for Option 1DQ

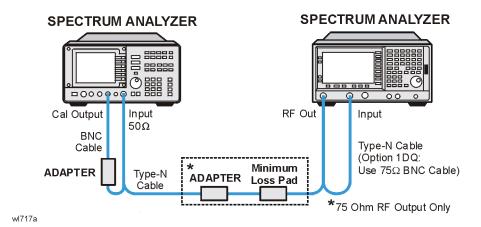
50 Ω to 75 Ω Minimum loss pad Adapter, Type-N (f) to BNC (m), 75 Ω

Procedure

CAUTION	Use only 75 Ω cables, connectors, or adapters on instruments with 75 Ω connectors or damage to the connectors will occur.
NOTE	The following steps are for an Agilent 8563E microwave analyzer, the steps may be different if you are using another microwave analyzer.

1. Connect the 10 MHz reference output from the microwave analyzer to the 10 MHz reference input of the analyzer as shown in Figure 2-65.

Figure 2-65 Harmonic Spurious Outputs Test Setup



2. Complete this step only if more than 24 hours have elapsed since performing a front-panel calibration of the microwave analyzer.

The microwave analyzer should be allowed to warm up for at least 5 minutes before proceeding.

Complete a front-panel calibration of the microwave analyzer by performing the following steps:

- a. Preset the microwave analyzer.
- b. Connect a BNC cable between CAL OUTPUT and 50 Ω Input.
- c. Press CAL, REALIGN LO & IF.
- d. Set FREQUENCY, 300 MHz.
- e. Set SPAN, 20 MHz.
- f. Set AMPLITUDE, -10 dBm.
- g. Press PEAK SEARCH.
- h. Press CAL, REF LVL ADJ and use the ↑ ↓ arrows to adjust the DAC value to a marker amplitude reading of -10 dBm. Press STORE REF LVL.
- i. Disconnect the BNC cable from between the CAL OUTPUT and 50 Ω Input.
- 3. Press **Preset** on the analyzer under test. Press the **Factory Preset** softkey, if it is displayed.
- 4. Set the analyzer by pressing the following keys:

FREQUENCY, 10 MHz SPAN, Zero Span BW/Avg, 10 kHz Source, Amplitude (On)

45. Tracking Generator Harmonic Spurious Outputs: Agilent E4401B and E4411B (Option 1DN or 1DQ)

Source, Amplitude (On), 0 dBm $(Option\ 1DN)$ Source, Amplitude (On), 42.76 dBmV $(Option\ 1DQ)$ Single

5. Set the microwave analyzer controls as follows:

FREQUENCY, 10 MHz FREQUENCY, CF STEP, 10 MHz SPAN, 10 kHz AMPLITUDE, 5 dBm $(Option\ 1DN)$ AMPLITUDE, 0 dBm $(Option\ 1DQ)$ BW, 1 kHz

6. Refer to Figure 2-65 to connect the Type-N cable from the spectrum analyzer RF OUT to the input of the microwave analyzer.

NOTE

The following steps are for an Agilent 8563E microwave analyzer, the steps may be different if you are using another microwave analyzer.

Perform step 7 and step 8 for each measurement value in Table 2-99.

- 7. Set the analyzer center frequency to the next frequency listed in Table 2-99. Similarly, set the microwave analyzer frequency and step size to match the analyzer center frequency. Press **Single** on the analyzer.
- 8. On the microwave analyzer:
 - a. Press MKR, SIG TRK (On). Wait for the signal to be displayed at center screen.
 - b. Press PEAK SEARCH, MKR, SIG TRK (Off), MARKER DELTA.
 - c. Press **FREQUENCY** and ↑ (step-up key) to tune to the second harmonic.
 - d. Press **PEAK SEARCH** and record the marker amplitude reading in Table 2-99 as the 2nd Harmonic Level for the appropriate Tracking Generator Output Frequency.
 - e. Perform this step only if the Tracking Generator Output Frequency is ≤500 MHz. Press **FREQUENCY** and ↑ (step-up key) to tune to the third harmonic. Press **PEAK SEARCH**.

Record the marker amplitude reading in Table 2-99 as the 3rd Harmonic Level for the appropriate Tracking Generator Output Frequency.

f. Press MKR, MARKERS (Off).

Table 2-99 Tracking Generator Harmonic Spurious Response Worksheet

1.5 GHz Tracking Generator Output Frequency	2nd Harmonic Level (dBc)	3rd Harmonic Level (dBc)
10 MHz		
100 MHz		
300 MHz		
750 MHz		N/A

750 MHz		N/A
9. From Table 2-99, enter Record entry 1 and coptest record.	r the 2nd Harmonic Lev by this value into the pe	
• Test Record entry 1 TG 2nd Harmonic S	: Spurious Output	dB
	quencies of 100 MHz to ord entry 2 and copy thi	750 MHz and record
• Test Record entry 2 TG 2nd Harmonic S	: Spurious Output	dB
11.From Table 2-99, enter Record entry 3 and coptest record.	r the 3rd Harmonic Lev by this value into the pe	
• Test Record entry 3 TG 3rd Harmonic S	: purious Output	dB
0.0	quencies of 100 MHz to ord entry 4 and copy thi	750 MHz and record
• Test Record entry 4	:	

TG 3rd Harmonic Spurious Output _____ dB

46. Tracking Generator Harmonic Spurious Outputs: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B (Option 1DN)

The measurement for tracking generator harmonic spurious outputs determines the maximum level of tracking generator harmonics. The tracking generator output is connected to the input of a microwave analyzer, then tuned to several different frequencies as the amplitude of the second and third harmonics (relative to the fundamental) are measured at each frequency.

There are no related adjustment procedures for this performance test.

Equipment Required

Microwave analyzer Cable, Type-N, 62 cm (24 in) Cable, BNC to BNC, 23 cm (9 in) Adapter, Type-N (m) to BNC (f)

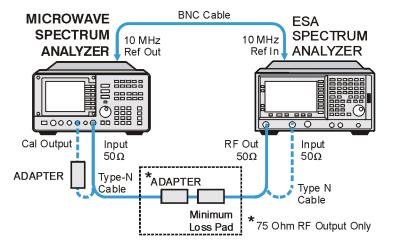
Procedure

NOTE

The following steps are for an Agilent 8563E microwave analyzer, the steps may be different if you are using another microwave analyzer.

1. Use the Type-N cable to connect the RF INPUT to the tracking generator RF OUT as shown in Figure 2-66. Do not connect the Type-N cable to the microwave analyzer yet. Connect the 10 MHz Reference from the output of the microwave analyzer to the 10 MHz Reference Input of the analyzer being tested.

Figure 2-66 Harmonic Spurious Outputs Test Setup



wl722a

NOTE

Complete this step only if more than 24 hours have elapsed since performing a front-panel calibration of the microwave analyzer.

The microwave analyzer should be allowed to warm up for at least 5 minutes before proceeding.

Complete a front-panel calibration of the microwave analyzer by performing the following steps:

- a. Preset the microwave analyzer.
- b. Connect a BNC cable between CAL OUTPUT and 50 Ω Input.
- c. Press CAL, REALIGN LO & IF.
- d. Set FREQUENCY, 300 MHz.
- e. Set SPAN, 20 MHz.
- f. Set AMPLITUDE, -10 dBm.
- g. Press PEAK SEARCH.
- h. Press CAL, REF LVL ADJ and use the $\uparrow \downarrow \downarrow$ arrows to adjust the DAC value to a marker amplitude reading of -10 dBm. Press STORE REF LVL.
- i. Disconnect the BNC cable from between the CAL OUTPUT and 50 Ω Input.
- 2. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed.
- 3. Set the analyzer under test by pressing the following keys:

FREQUENCY, 10 MHz SPAN, Zero Span

46. Tracking Generator Harmonic Spurious Outputs: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B (Option 1DN)

BW/Avg, 10 kHz
System, Alignments, Auto Align, Off
Marker
Source, Amplitude (On)
Source, Tracking Peak (Wait for the Peaking message to appear.)
Source, Amplitude (On), -2 dBm
Single

4. Set the microwave analyzer controls as follows:

FREQUENCY, 9 kHz FREQUENCY, CF STEP, 9 kHz SPAN, 10 kHz AMPLITUDE, 5 dBm BW, 1 kHz

5. Disconnect the Type-N cable from between the analyzer RF INPUT and the tracking generator RF OUT. Refer to Figure 2-66 to connect the Type-N cable from the analyzer RF OUT to the input of the microwave analyzer.

NOTE

The following steps are for an Agilent 8563E microwave analyzer, the steps may be different if you are using another microwave analyzer.

Perform step 6 and step 7 for each measurement value in Table 2-100.

- 6. Set the analyzer under test center frequency to the next frequency listed in Table 2-100. Similarly, set the microwave analyzer frequency and step size to match the analyzer under test center frequency. Press **Single** on the analyzer under test.
- 7. On the microwave analyzer:
 - a. Press **MKR**, **SIG TRK** (On). Wait for the signal to be displayed at center screen.
 - b. Press PEAK SEARCH, MKR, SIG TRK (Off), MARKER DELTA.
 - c. Press **FREQUENCY** and ↑ (step up key) to tune to the second harmonic.
 - d. Press **PEAK SEARCH** and record the marker amplitude reading in Table 2-100 as the 2nd Harmonic Level for the appropriate Tracking Generator Output Frequency.
 - e. Perform this step only if the Tracking Generator Output Frequency is ≤900 MHz. Press **FREQUENCY** and ↑ (step up key) to tune to the third harmonic. Press **PEAK SEARCH**.

Record the marker amplitude reading in Table 2-100 as the 3rd Harmonic Level for the appropriate Tracking Generator Output Frequency.

f. Press MKR, MARKERS (Off).

Table 2-100 Tracking Generator Harmonic Spurious Response Worksheet

1.5 GHz Tracking Generator Output Frequency	2nd Harmonic Level (dBc)	3rd Harmonic Level (dBc)
9 kHz		
25 kHz		
100 MHz		
300 MHz		
900 MHz		
1500 MHz		N/A

	1000 11112		11/11
8.	•	er the 2nd Harmonic Le	
	• Test Record entry 1 TG 2nd Harmonic S	: Spurious Output	dB
9.	tracking generator free	ate the most positive 2nd quencies of 9 kHz to 750 ntry 2 and copy this val on test record.	MHz and record this
	• Test Record entry 2 TG 2nd Harmonic S	: Spurious Output	dB
10		er the 3rd Harmonic Le by this value into the pe	
	• Test Record entry 3 TG 3rd Harmonic S	: purious Output	dB
11	tracking generator free	ate the most positive 3rd quencies of 25 kHz to 15 ord entry 4 and copy thi on test record.	500 MHz and record
	• Test Record entry 4 TG 3rd Harmonic S	: purious Output	dB

Chapter 2 363

12.Press System, Alignments, Auto Align, All.

47. Tracking Generator Non-Harmonic Spurious Outputs: Agilent E4401B and E4411B (Option 1DN or 1DQ)

This procedure determines the maximum level of the non-harmonic spurious outputs of the tracking generator. The tracking generator output is set to several different output frequencies. For each output frequency, several sweeps are taken on the microwave analyzer over different frequency spans and the highest displayed spurious response is measured in each span. Responses at the fundamental frequency of the tracking generator output or their harmonics are ignored. The amplitude of the highest spurious response is recorded.

There are no related adjustment procedures for this performance test.

Equipment Required

Microwave analyzer Cable, Type-N, 62 cm (24 in) Cable, BNC, 23 cm (9 in) Adapter, Type-N (m) to BNC (f)

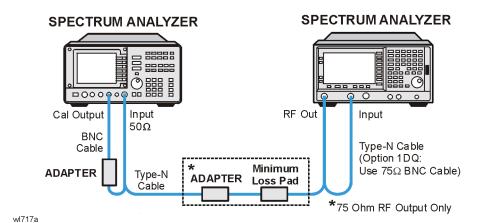
Additional Equipment for 75 Ω Input

Pad, minimum loss Adapter, Type-N (f) to BNC (m), 75 Ω

Procedure

1. Connect the equipment as shown in Figure 2-67.

Figure 2-67 Non-Harmonic Spurious Outputs Test Setup



NOTE

The following steps are for an Agilent 8563E microwave analyzer, the steps may be different if you are using another microwave analyzer.

1. Complete this step only if more than two hours have elapsed since performing a front-panel calibration of the microwave analyzer.

The microwave analyzer should be allowed to warm up for at least 30 minutes before proceeding.

Complete a front-panel calibration of the microwave analyzer by performing the following steps:

- a. Preset the microwave analyzer.
- b. Connect a BNC cable between CAL OUTPUT and 50 Ω Input.
- c. Press CAL, REALIGN LO & IF.
- d. Set FREQUENCY, 300 MHz.
- e. Set SPAN, 20 MHz.
- f. Set AMPLITUDE, -10 dBm.
- g. Press PEAK SEARCH.
- h. Press CAL, REF LVL ADJ and use the ↑ ↓ arrows to adjust the DAC value to a marker amplitude reading of -10 dBm. Press STORE REF LVL.
- i. Disconnect the BNC cable from between the CAL OUTPUT and 50 Ω Input.
- 2. Press **Preset** on the analyzer under test. Press the **Factory Preset** softkey, if it is displayed. Set the analyzer by pressing the following keys:

47. Tracking Generator Non-Harmonic Spurious Outputs: Agilent E4401B and E4411B (Option 1DN or 1DQ)

FREQUENCY, 50 MHz
SPAN, Zero Span
BW/Avg, 30 kHz
Marker
Source, Amplitude On, 0 dBm
Source, Amplitude On, 42.76 dBmV (75 Ω Option only)

- 3. Set the microwave analyzer by pressing the following keys:
 - SPAN, 100 kHz
 - AMPLITUDE, 5 dBm
 - AMPLITUDE, 0 dBm (75 Ω Option only)
 - AMPLITUDE, ATTEN, 20 dB
 - AMPLITUDE, LOG dB/DIV, 10 dB
- 4. Disconnect the Type-N cable from between the analyzer RF INPUT and the tracking generator RF OUT. Refer to Figure 2-67 to connect the Type-N cable from the analyzer RF OUT to the microwave analyzer 50 Ω Input.

Measuring Fundamental Amplitudes

Perform the following two steps for each fundamental frequency in Table 2-101.

- 1. Set the analyzer under test center frequency to the fundamental frequency listed in Table 2-101 and press **Single** to activate a single sweep. Set the microwave analyzer to the same frequency.
- 2. On the microwave analyzer, press **PEAK SEARCH**. Press **MKR** →, **MARKER** → **REF LVL**. Wait for another sweep to finish. Press **PEAK SEARCH**. Record the marker amplitude reading in Table 2-101 as the Fundamental Amplitude.

Table 2-101 Tracking Generator Fundamental Response Worksheet

Fundamental Frequency	Fundamental Amplitude (dBm)
10 MHz	
750 MHz	
1.5 GHz	

Measuring Non-Harmonic Responses

- 1. On the analyzer under test, set the center frequency to the initial value indicated in the first row of Table 2-101. Press **Single** on the analyzer to trigger a single sweep.
- 2. Set the microwave analyzer Start Freq, Stop Freq, and Res BW as indicated in the first row of Table 2-102.

47. Tracking Generator Non-Harmonic Spurious Outputs: Agilent E4401B and E4411B (Option 1DN or 1DQ)

75 Ω outputs only: Measure only at start frequencies of 1 MHz and greater.

- 3. Press **SGL SWP** on the microwave analyzer to activate a single sweep and wait for the sweep to finish. Press **PEAK SEARCH** to locate the largest spurious response.
- 4. Verify that the marked signal is not the fundamental or a harmonic of the fundamental by performing the following steps:

NOTE

The following steps are for an Agilent 8563E microwave analyzer, the steps may be different if you are using another microwave analyzer.

- a. Divide the marker frequency by the fundamental frequency (the analyzer center frequency setting). For example, if the marker frequency is 30.3 MHz and the fundamental frequency is 10 MHz, dividing 30.3 MHz by 10 MHz yields 3.03.
- b. Round the number calculated in step a to the nearest whole number. In the example above, 3.03 should be rounded to 3. Values less than 1 should be rounded up to 1.
- c. Multiply the fundamental frequency by the number calculated in step b. Following the example, multiplying 10 MHz by 3 yields 30 MHz.
- d. Calculate the difference between the marker frequency and the frequency calculated in step c above. Continuing the example, the difference would be 300 kHz.
- e. Due to span accuracy uncertainties in the microwave analyzer, the marker frequency might not equal the actual frequency. Given the marker frequency, check if the difference calculated in step d is within the appropriate tolerance:

For marker frequencies <5 MHz, tolerance = ± 200 kHz For marker frequencies <55 MHz, tolerance = ± 750 kHz For marker frequencies >55 MHz, tolerance = ± 10 MHz

- f. If the difference in step d is within the indicated tolerance, the signal in question is the fundamental signal (if the number in step b=1) or a harmonic of the fundamental (if the number in step b>1). This response should be ignored.
- 5. Verify that the marked signal is a true response and not a random noise peak by pressing **SINGLE** to trigger a new sweep and press **PEAK SEARCH**. A true response will remain at the same frequency and amplitude on successive sweeps but a noise peak will not.
 - If the marked signal is not the fundamental or a harmonic of the fundamental and is a true response, continue with step 7.
- 6. If the marked signal is either the fundamental or a harmonic of the fundamental or a noise peak, move the marker on the microwave

47. Tracking Generator Non-Harmonic Spurious Outputs: Agilent E4401B and E4411B (Option 1DN or 1DQ)

analyzer to the next highest signal by pressing **NEXT PEAK**. Repeat step 4 above.

Perform step 7 only if the marker signal is a true response and not a fundamental or harmonic of the fundamental. Otherwise, continue with step 8.

7. Calculate the difference between the amplitude of marked signal and the fundamental amplitude as listed in Table 2-101.

For example, if the fundamental amplitude for a fundamental frequency of 10 MHz is 1.2 dBm and the marker amplitude is -40.8 dBm, the difference is -42 dBc.

Record this difference as the non-harmonic response amplitude for the appropriate analyzer center frequency and microwave analyzer start and stop frequency settings in Table 2-102.

Non-harmonic Amplitude = Marker Amplitude - Fundamental Amplitude

- 8. If a true non-harmonic spurious response is not found, record "NOISE" as the Amplitude of Non-Harmonic Response in Table 2-102 for the appropriate analyzer center frequency and microwave analyzer start and stop frequency settings.
- 9. Repeat step 1 through step 8 for the remaining analyzer center frequency and microwave analyzer settings in Table 2-102.

Table 2-102 1.5 GHz Tracking Generator Non-Harmonic Spurious Response Worksheet

Analyzer Center Frequency	Microwave Analyzer Start Frequency	Microwave Analyzer Stop Frequency	Microwave Analyzer Resolution Bandwidth	Amplitude of Non-Harmonic Response (dBc)
10 MHz	9 kHz ^a	100 kHz ^a	300 Hz ^a	
10 MHz	100 kHz ^b	5 MHz	10 kHz	
10 MHz	5 MHz	55 MHz	100 kHz	
10 MHz	55 MHz	1240 MHz	1 MHz	
10 MHz	1240 MHz	1500 MHz	1 MHz	
750 MHz	9 kHz ^a	100 kHz ^a	300 Hz ^a	
750 MHz	100 kHz ^b	5 MHz	10 kHz	
750 MHz	5 MHz	55 MHz	100 kHz	
750 MHz	55 MHz	1240 MHz	1 MHz	
750 MHz	1240 MHz	1500 MHz	1 MHz	
1.5 GHz	9 kHz ^a	100 kHz ^a	300 Hz ^a	

Table 2-102 1.5 GHz Tracking Generator Non-Harmonic Spurious Response Worksheet

Analyzer Center Frequency	Microwave Analyzer Start Frequency	Microwave Analyzer Stop Frequency	Microwave Analyzer Resolution Bandwidth	Amplitude of Non-Harmonic Response (dBc)
1.5 GHz	100 kHz ^b	5 MHz	10 kHz	
1.5 GHz	5 MHz	55 MHz	100 kHz	
1.5 GHz	55 MHz	1240 MHz	1 MHz	
1.5 GHz	1240 MHz	1500 MHz	1 MHz	

a. 75 Ω RF Outputs: Omit this frequency range.

Determining the Highest Non-harmonic Spurious Response

1. In Table 2-102, locate the most positive non-harmonic response amplitude. Record this amplitude as the highest non-harmonic response amplitude in Test Record entry 1 of the performance verification test record.

b. 75 Ω RF Outputs: Set the start frequency to 1 MHz.

48. Tracking Generator Non-Harmonic Spurious Outputs: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B (Option 1DN)

This procedure determines the maximum level of the non-harmonic spurious outputs of the tracking generator. The tracking generator output is set to several different output frequencies. For each output frequency, several sweeps are taken on the microwave analyzer over different frequency spans and the highest displayed spurious response is measured in each span. Responses at the fundamental frequency of the tracking generator output or their harmonics are ignored. The amplitude of the highest spurious response is recorded.

There are no related adjustment procedures for this performance test.

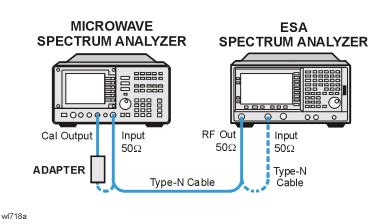
Equipment Required

Microwave analyzer Cable, Type-N, 62 cm (24 in) Cable, BNC, 23 cm (9 in) Adapter, Type-N (m) to BNC (f)

Procedure

1. Connect the equipment as shown in Figure 2-68.

Figure 2-68 Non-Harmonic Spurious Outputs Test Setup



NOTE

The following steps are for an Agilent 8563E microwave analyzer, the steps may be different if you are using another microwave analyzer.

- 48. Tracking Generator Non-Harmonic Spurious Outputs: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B (Option 1DN)
- 1. Complete this step only if more than two hours have elapsed since performing a front-panel calibration of the microwave analyzer.

The microwave analyzer should be allowed to warm up for at least 30 minutes before proceeding.

Complete a front-panel calibration of the microwave analyzer by performing the following steps:

- a. Preset the microwave analyzer.
- b. Connect a BNC cable between CAL OUTPUT and 50 Ω Input.
- c. Press CAL, REALIGN LO & IF.
- d. Set FREQUENCY, 300 MHz.
- e. Set SPAN, 20 MHz.
- f. Set AMPLITUDE, -10 dBm.
- g. Press PEAK SEARCH.
- h. Press CAL, REF LVL ADJ and use the ↑ ↓ arrows to adjust the DAC value to a marker amplitude reading of -10 dBm. Press STORE REF LVL.
- i. Disconnect the BNC cable from between the CAL OUTPUT and 50 Ω Input.
- 2. Use the Type-N cable to connect the RF Input to the RF OUT of the tracking generator as shown in Figure 2-68. Do not connect to the RF Input of the microwave analyzer yet.
- 3. Press **Preset** on the analyzer under test. Press the **Factory Preset** softkey, if it is displayed. Set the analyzer by pressing the following keys:

FREQUENCY, 50 MHz
SPAN, Zero Span
BW/Avg, 30 kHz
System, Alignments, Auto Align, Off
Marker
Source, Tracking Peak (wait for the Peaking message to appear)
Source, Amplitude On, -2 dBm
Single

- 4. Set the microwave analyzer by pressing the following keys:
 - SPAN, 100 kHz
 - AMPLITUDE, 5 dBm
 - AMPLITUDE, Attenuation, 20 dB
 - AMPLITUDE, LOG dB/DIV, 10 dB
- 5. Disconnect the Type-N cable from between the analyzer RF INPUT and the tracking generator RF OUT. Refer to Figure 2-68 to connect the Type-N cable from the analyzer RF OUT to the microwave

48. Tracking Generator Non-Harmonic Spurious Outputs: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B (Option 1DN)

analyzer 50Ω Input.

Measuring Fundamental Amplitudes

Perform the following two steps for each measurement value in Table 2-103.

- 6. Set the analyzer center frequency to the Fundamental Frequency listed in Table 2-103 and press **Single** to activate a single sweep. Set the microwave analyzer to the same frequency.
- On the microwave analyzer, press PEAK SEARCH. Press MARKER →, MKR → REF LVL. Wait for another sweep to finish. Press PEAK SEARCH. Record the marker amplitude reading in Table 2-103 as the fundamental amplitude.

Table 2-103 Tracking Generator Fundamental Response Worksheet

Fundamental Frequency	Fundamental Amplitude (dBm)
10 MHz	
1.5 GHz	
3.0 GHz	

Measuring Non-Harmonic Responses

- 8. On the analyzer, set the center frequency to the initial value indicated in the first row of Table 2-103. Press **Single** on the analyzer to trigger a single sweep.
- 9. Set the Start Freq, Stop Freq, and Res BW of the microwave analyzer as indicated in the first row of Table 2-104.
- 10.Press **SGL SWP** on the microwave analyzer to activate a single sweep and wait for the sweep to finish. Press **PEAK SEARCH** to locate the largest spurious response.
- 11. Verify that the marked signal is not the fundamental or a harmonic of the fundamental by performing the following steps:

NOTE

The following steps are for an Agilent 8563E microwave analyzer, the steps may be different if you are using another microwave analyzer.

- a. Divide the marker frequency by the fundamental frequency (the analyzer center frequency setting). For example, if the marker frequency is 30.3 MHz and the fundamental frequency is 10 MHz, dividing 30.3 MHz by 10 MHz yields 3.03.
- b. Round the number calculated in step a to the nearest whole number. In the example above, 3.03 should be rounded to 3. Values less than 1 should be rounded up to 1.

- 48. Tracking Generator Non-Harmonic Spurious Outputs: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B (Option 1DN)
 - c. Multiply the fundamental frequency by the number calculated in step b. Following the example, multiplying 10 MHz by 3 yields 30 MHz.
- d. Calculate the difference between the marker frequency and the frequency calculated in step c above. Continuing the example, the difference would be 300 kHz.
- e. Due to span accuracy uncertainties in the microwave analyzer, the marker frequency might not equal the actual frequency. Given the marker frequency, check if the difference calculated in step d is within the appropriate tolerance:

For marker frequencies <5 MHz, tolerance = ± 200 kHz For marker frequencies <55 MHz, tolerance = ± 750 kHz For marker frequencies >55 MHz, tolerance = ± 10 MHz

- f. If the difference in step d is within the indicated tolerance, the signal in question is the fundamental signal (if the number in step b = 1) or a harmonic of the fundamental (if the number in step b > 1). This response should be ignored.
- 12. Verify that the marked signal is a true response and not a random noise peak by pressing **SINGLE** to trigger a new sweep and press **PEAK SEARCH**. A true response will remain at the same frequency and amplitude on successive sweeps but a noise peak will not.
 - If the marked signal is not the fundamental or a harmonic of the fundamental and is a true response, continue with step 14.
- 13.If the marked signal is either the fundamental or a harmonic of the fundamental or a noise peak, move the marker on the microwave analyzer to the next highest signal by pressing **NEXT PEAK**. Repeat step 11 above.
 - Perform step 14 only if the marker signal is a true response and not a fundamental or harmonic of the fundamental. Otherwise, continue with step 15.
- 14.Calculate the difference between the amplitude of marked signal and the fundamental amplitude as listed in Table 2-103.

For example, if the fundamental amplitude for a fundamental frequency of 10 MHz is 1.2 dBm and the marker amplitude is -40.8 dBm, the difference is -42 dBc.

Record this difference as the non-harmonic response amplitude for the appropriate analyzer center frequency and microwave analyzer start and stop frequency settings in Table 2-104.

Non-harmonic Amplitude = Marker Amplitude – Fundamental Amplitude

15.If a true non-harmonic spurious response is not found, record "NOISE" as the non-harmonic response Amplitude in Table 2-104 for the appropriate analyzer center frequency and microwave analyzer

48. Tracking Generator Non-Harmonic Spurious Outputs: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B (Option 1DN)

start and stop frequency settings.

- 16.Repeat step 8 through step 15 for the remaining analyzer center frequency and microwave analyzer settings in Table 2-104.
- 17.Press System, Alignments, Auto Align, All

Table 2-104 3.0 GHz Tracking Generator Non-Harmonic Spurious Response Worksheet

Analyzer Center Frequency	Microwave Analyzer Start Frequency	Microwave Analyzer Stop Frequency	Microwave Analyzer Resolution Bandwidth	Amplitude of Non-Harmonic Response (dBc)
10 MHz	9 kHz	100 kHz	300 Hz	
10 MHz	100 kHz	5 MHz	10 kHz	
10 MHz	5 MHz	55 MHz	100 kHz	
10 MHz	55 MHz	1240 MHz	1 MHz	
10 MHz	1240 MHz	2000 MHz	1 MHz	
10 MHz	2000 MHz	3000 MHz	1 MHz	
1.5 GHz	9 kHz	100 kHz	300 Hz	
1.5 GHz	100 kHz	5 MHz	10 kHz	
1.5 GHz	5 MHz	55 MHz	100 kHz	
1.5 GHz	55 MHz	1240 MHz	1 MHz	
1.5 GHz	1240 MHz	2000 MHz	1 MHz	
1.5 GHz	2000 MHz	3000 MHz	1 MHz	
3.0 GHz	9 kHz	100 kHz	300 Hz	
3.0 GHz	100 kHz	5 MHz	10 kHz	
3.0 GHz	5 MHz	55 MHz	100 kHz	
3.0 GHz	55 MHz	1240 MHz	1 MHz	
3.0 GHz	1240 MHz	2000 MHz	1 MHz	
3.0 GHz	2000 MHz	3000 MHz	1 MHz	

Determining the Highest Non-harmonic Spurious Response

- 1. In Table 2-104, locate the most positive non-harmonic response amplitude for microwave analyzer stop frequency settings ≤2000 MHz. Record this amplitude as the highest non-harmonic response amplitude in Test Record entry 1 of the performance verification test record.
- 2. In Table 2-104, locate the most positive non-harmonic response

48. Tracking Generator Non-Harmonic Spurious Outputs: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B (Option 1DN)

amplitude for microwave analyzer start frequency settings ≥2000 MHz. Record this amplitude as the highest non-harmonic response amplitude in Test Record entry 2 of the performance verification test record.

49. Tracking Generator LO Feedthrough: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B(Option 1DN)

The tracking generator output is connected to the analyzer 50 W Input, and the tracking is adjusted at 50 MHz for a maximum signal level. The tracking generator output is then connected to the input of a microwave analyzer. The tracking generator is tuned to several different frequencies and the LO Feedthrough is measured at the frequency extremes of the LO.

The related adjustment for this procedure is "TG LO Leveling."

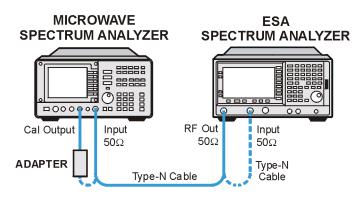
Equipment Required

Microwave analyzer Cable, Type-N, 62 cm (24 in) Cable, BNC, 23 cm (9 in) Adapter, Type-N (m) to BNC (f)

Procedure

1. Connect the equipment as shown in Figure 2-69.

Figure 2-69 LO Feedthrough Amplitude Test Setup



wl718a

NOTE

Note that the following steps are for an Agilent 8563E microwave analyzer, the steps may be different if you are using another microwave analyzer.

1. Press **PRESET** on the microwave analyzer.

The microwave analyzer should be allowed to warm up for at least

five minutes before proceeding.

Complete step 2 only if more than 24 hours have elapsed since performing a front-panel calibration of the microwave analyzer.

- 2. Perform a front-panel calibration of the microwave analyzer by performing the following steps:
 - a. Connect a BNC cable between CAL OUTPUT and 50 Ω Input.
 - b. Press CAL, REALIGN LO & IF.
 - c. Set FREQUENCY, 300 MHz.
 - d. Set SPAN, 20 MHz.
 - e. Set AMPLITUDE, -10 dBm.
 - f. Press PEAK SEARCH.
 - g. Press CAL, REF LVL ADJ and use the ↑ ↓ arrows to adjust the DAC value to a marker amplitude reading of −10 dBm. Press STORE REF LVL.
 - h. Disconnect the BNC cable from between the CAL OUTPUT and 50 Ω Input.
- 3. Press **Preset** on the analyzer under test. Press the **Factory Preset** softkey, if it is displayed.
- 4. Use the type-N cable to connect the RF Input to the tracking generator RF OUT on the analyzer under test as shown in Figure 2-69. Do not connect to the microwave analyzer RF Input yet.
- 5. Initialize the test equipment by pressing the following keys on the analyzer under test:

FREQUENCY, 50 MHz SPAN, Zero Span BW / Avg, 30 kHz System, Alignments, Auto Align, Off Marker

Source, Amplitude On, -5 dBm

Source, Tracking Peak ($Wait\ for\ the\ \texttt{PEAKING}\ \texttt{SIGNAL}\ message\ to\ disappear.$)

FREQUENCY, 9 kHz Source, Amplitude On, -2 dBm Single

6. On the microwave analyzer, press the following keys:

FREQUENCY, 3.921409 GHz SPAN, 100 kHz AMPLITUDE, 0 dBm BW, 1 kHz

7. Disconnect the type-N cable from between the analyzer RF INPUT

49. Tracking Generator LO Feedthrough: Agilent E4402B, E4403B, E4404B, E4405B, E4407B, and E4408B(Option 1DN)

and the Tracking Generator RF OUT. Refer to Figure 2-69 to connect the type-N cable from the analyzer RF OUT to the microwave analyzer 50 W Input.

8. On the microwave analyzer, press:

PEAK SEARCH MKR, SIG TRK (On)

Wait for the signal to be displayed at center screen, then press **SIG TRK** (Off).

- 9. On the microwave analyzer, press **AUX CTRL**, **INTERNAL MIXER**, **PRESEL AUTO PK** then wait for the PEAKING message to disappear.
- 10.Record the microwave analyzer marker amplitude in Table 2-105 as the LO Feedthrough Amplitude for the Microwave analyzer CENTER FREQUENCY at 3.921409 GHz.
- 11.Repeat step 8 through step 10 for the remaining Analyzer CENTER FREQUENCY and Microwave Analyzer CENTER FREQUENCY settings listed in Table 2-105. Press **Single** on the analyzer to activate a single sweep each time the center frequency is changed.
- 12.Press System, Alignments, Auto Align, All.
- 13.In Table 2-105, for analyzer center frequencies of 9 kHz to 1.5 GHz, locate the highest LO Feedthrough Amplitude then record this amplitude as Test Record entry 1 of the performance verification test record.
- 14.In Table 2-105, for the Analyzer Center Frequency of 3.0 GHz, record this LO Feedthrough Amplitude as Test Record entry 2 of the performance verification test record.

Table 2-105 Tracking Generator LO Feedthrough Amplitude Worksheet

Analyzer Center Frequency	Microwave Analyzer Center Frequency	LO Feedthrough Amplitude (dBm)
9 kHz	3.921409 GHz	
70 MHz	3.9914 GHz	
150 MHz	4.0714 GHz	
1.5 GHz	5.4214 GHz	
3.0 GHz	6.9214 GHz	

50. Gate Delay Accuracy and Gate Length Accuracy: Agilent E4401B, E4402B, E4404B, E4405B, and E4407B (Option 1D6)

The method used for measuring the gate length times is determined by the length of the gate. Shorter gate-length times are measured with an oscilloscope, and longer gate-length times are measured with a counter.

For shorter gate-length times, the output signal of a pulse generator is used to trigger the gate circuitry. To measure the gate delay, Δt markers are used. The oscilloscope pulse width measurement feature is used to measure the short gate-length.

For longer gate-length times, a universal counter is used to measure the time period from the rising edge of the gate output to its falling edge. Because the gate-length time is equivalent to the clock accuracy of the analyzer, the gate-length time is compared to the specification for clock accuracy.

There are no related adjustment procedures for this performance test.

Equipment Required

Universal counter
Function generator
Oscilloscope (This procedure is written for the Agilent 54820A.)
Cable, BNC, 120 cm (48 in) (four required)
Adapter, BNC tee (m) (f) (f) (two required)

Procedure

- 1. Connect the equipment as shown in Figure 2-70. Connect the GATE OUT to Channel 2.
- 2. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the analyzer by pressing the following keys:

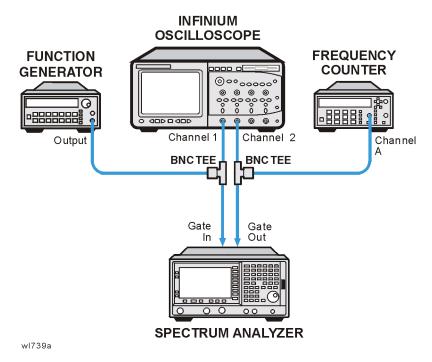
SPAN, Zero Span Sweep, Sweep Time, 100 s Sweep, Gate (On) Gate Setup, Edge Setup $(or\ Edge\ Gate)$ Gate Delay, 1 μs Gate Length, 1 μs

NOTE

The oscilloscope measurement is much more stable using slow sweep times on the analyzer. The response on the analyzer display will not be valid, but the Gate Delay and Gate Length accuracy are being measured externally with the universal counter and oscilloscope.

50. Gate Delay Accuracy and Gate Length Accuracy: Agilent E4401B, E4402B, E4404B, E4405B, and E4407B (Option 1D6)

Figure 2-70 Gate Delay and Gate Length Test Setup



3. Set up the function generator as follows:

Waveform	Square
Frequency	100 Hz
Amplitude	2.5 V
Offset	1.25 V

4. Press **Default Setup** on the oscilloscope and set the controls as follows:

Timebase	500 ns/div
Trigger	Edge
Trigger Source	2
Trigger Level	2.0 V
Channel 1	
V/Div	1 V
Coupling	DC
Offset	2.0 V
Channel 2	
V/Div	1 V
Coupling	DC

Offset 3.0 V

- 5. On the oscilloscope, adjust the horizontal position to place the area between the rising edges of channel 1 and channel 2 at the center of the display. The horizontal position at the bottom of the grid should be between -500 ns and -650 ns.
- 6. Set the oscilloscope timebase to 200 ns/div. The rising edges of channel 1 and channel 2 should still be displayed. If not, adjust the horizontal position so the rising edges of channel 1 and channel 2 are displayed.
- 7. Use the mouse connected to the oscilloscope and click on the mouse icon in the upper right-hand corner of the display.
- 8. Set the oscilloscope statistics on.

Click on Measure and verify that "Show Statistics" is checked.

9. Define the conditions for a delta time measurement on the oscilloscope.

Leave the oscilloscope in Auto Trigger "Free Run" mode until all connections and setups are completed on both the oscilloscope and the analyzer. This allows you to confirm that both channels on the oscilloscope are receiving a valid signal.

- a. Click on Measure, Customize, Measurement Definitions.
- b. Set Threshold Definition to "10%, 50%, 90%".
- c. Set Top-Base Definition to "Standard".
- d. Set From Edge # to 1, and set To Edge # to 2.
- e. Set both Direction selections to "Rising".
- f. Set both Threshold selections to "Middle Level".
- g. Click Close.
- 10.Activate the delta time measurement.
 - a. Click Measure, Time, Delta Time.
 - b. Set Source 1 to "Channel 1".
 - c. Set Source 2 to "Channel 2".
 - d. Click OK.
- 11. Wait a few seconds for the minimum and maximum values displayed at the bottom of the oscilloscope grid to stabilize.
- 12.Refer to the measurement statistics at the bottom of the oscilloscope grid.

Record the Δ Time (1)-(2) min value as Minimum Gate Delay in Table

50. Gate Delay Accuracy and Gate Length Accuracy: Agilent E4401B, E4402B, E4404B, E4405B, and E4407B (Option 1D6)

2-106.

Record the Δ Time (1)-(2) max value as the Maximum Gate Delay in Table 2-106.

- 13.Clear all current oscilloscope measurements. Click on Measure, Clear, and All Measurements.
- 14.Adjust the oscilloscope horizontal position to center the pulse on Channel 2 on the display. Switching the trigger source to channel 2 will help with the measurement.
- 15.Activate the pulse width measurement function for channel 2 of the oscilloscope.

Click on Measure, Time, and click on +width.

Set the Source to be channel 2 and click **OK**.

- 16.Record the +width (2) mean value in Table 2-106 as the 1 μs Gate Length.
- 17.On the analyzer, press

Sweep, Sweep Time 150 ms, Sweep Gate Setup (or Gate), Edge Setup (or Edge Gate) Gate Delay, 10ms Sweep, Gate Setup Edge Setup (or Edge Gate), Gate Length, 65 ms

18.Set the universal counter controls as follows:

Function Pos Width 1

Gate Time 0.1 s

Auto Trigger On

Channel 1

 Coupling
 DC

 Impedance
 1 MΩ

 X10 Atten
 Off

 100 kHz Filter
 Off

 Common 1
 On

19.Record the universal counter readout value as the 65ms Gate Length in Table 2-106.

Table 2-106 Gate Delay and Gate Length Accuracy Worksheet

Description	Value	Test Record Entry
Minimum Gate Delay		1)
Maximum Gate Delay		2)
1 μs Gate Length		3)
65 ms Gate Length		4)

51. Gate Mode Additional Amplitude Error: Agilent E4401B, E4402B, E4404B, E4405B, and E4407B (Option 1D6)

This procedure measures the additional amplitude error while gate mode is turned on. An amplitude reference is established while gate mode is off. Gate mode is then turned on with a function generator providing the gate trigger input. The amplitude with gate mode on is then measured using the marker delta function.

There are no related adjustment procedures for this performance test.

Equipment Required

Synthesized signal generator Function generator Cable, Type-N (f), 50Ω Cable, BNC, 120 cm

Additional Equipment for Option 1DP

Adapter, Type-N (f) to BNC (m), 75 Ω Minimum loss pad

Additional Equipment for Option BAB

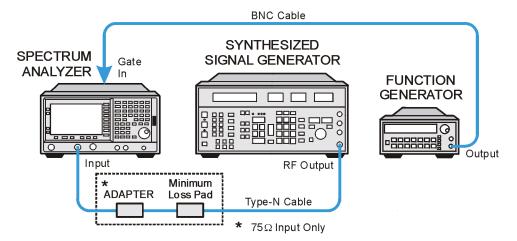
Adapter, Type-N (f) to APC 3.5 (f)

Procedure

- 1. Connect the equipment as shown in Figure 2-71.
- 2. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the analyzer by pressing the following keys:

FREQUENCY, 300 MHz SPAN, Zero Span AMPLITUDE, Ref Level, –20 dBm $(50~\Omega~Inputs~only)$ AMPLITUDE, Ref Level, –10 dBm $(75~\Omega~Inputs~only)$ AMPLITUDE, More, Y Axis Units (or Amptd Units), dBm Sweep, 20 ms

Figure 2-71 Gate Delay and Gate Length Accuracy Test Setup



wl757a

3. Set up the function generator as follows:

Waveform Square

Duty Cycle 50%

Frequency 100 Hz

Amplitude 2.5 V pk-pk

Offset 1.25V

4. On the synthesized signal generator, press **Blue Key**, **Special**, **0**, **0**. Set the signal generator as follows:

FREQUENCY 300 MHz

AMPLITUDE $-20 \text{ dBm } (50 \Omega \text{ Inputs only})$ AMPLITUDE $-10 \text{ dBm } (75 \Omega \text{ Inputs only})$

- 5. On the analyzer, press **Single** and wait for the sweep to finish. Press **Peak Search** (or **Search**).
- 6. On the analyzer, press Marker, Delta.
- 7. Set the analyzer as follows:

Trig, External (Pos) Sweep, Gate (On) Gate Setup, Edge Setup (or Edge Gate), Gate Delay, 1 $\mu\sigma$ Gate Length, 1 $\mu\sigma$ Sweep, Gate Setup (or Gate), Trig Type (Level) (or Gate Control (Level))

8. On the analyzer, press **Single** and wait for the sweep to finish. Press

51. Gate Mode Additional Amplitude Error: Agilent E4401B, E4402B, E4404B, E4405B, and E4407B (Option 1D6)

Peak Search (or Search).

9. Record the marker delta (Δ Mkr1) amplitude reading as Test Record entry 1 in the performance test record.

52. First LO OUTPUT Power Accuracy (Option AYZ only)

This test applies only to analyzers equipped with external mixing (Option AYZ).

This test verifies that analyzers with external mixing (Option AYZ) meet their specification for First LO (local oscillator) output level. The flatness of the First LO output determines the flatness of measurements made using external mixers. In this test, a calibrated power sensor is connected to the First LO output to measure the power level at frequencies between 2.9 GHz and 7.1 GHz.

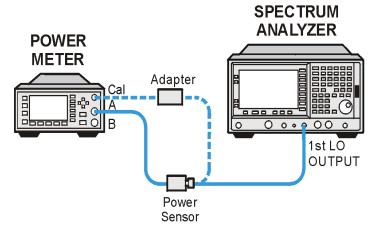
The analyzer is put into external mixing mode using a harmonic number of -10. The tuned frequency of the spectrum will therefore be 321.4 MHz (the frequency of the Second IF) below the Tenth harmonic of the First LO. A 321.4 MHz frequency offset is used so that the center frequency will be exactly 10 times the First LO frequency. Setting the center frequency step size to 2 GHz allows the LO frequency to be stepped in 200 MHz increments.

The related adjustment for this performance test is "LO Power Adjustment."

Equipment Required

Power meter Microwave power sensor Adapter, type-N (m) to SMA (f)

Figure 2-72 First LO Output Amplitude Accuracy Test Setup



wl75b

Procedure

- 1. Zero and calibrate the power sensor and power meter combination at 50 MHz. Set the power meter for dBm output.
- 2. Enter the 3 GHz calibration factor of the power sensor into the power meter.
- 3. Remove the termination from the First LO OUTPUT connector of the analyzer.
- 4. Connect the power sensor to the First LO OUTPUT connector of the analyzer as shown in Figure 2-72.
- 5. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the analyzer by pressing the following keys:

Input/Output, Input Mixer, Input Mixer (Ext)
Mixer Config, Harmonic, -10
SPAN, Zero Span
FREQUENCY, 30 GHz
CF Step, 2 GHz
Freq Offset, 321.4 MHz
System, Alignments, Auto Align, Off

- 6. Press **FREQUENCY**, on the analyzer.
- 7. Read the power displayed on the power meter and record it as Test Record entry 1 in the Performance Verification Test Record.
- 8. Press the ↑ key on the analyzer to select the next center frequency and First LO frequency.
- 9. Enter the appropriate power sensor calibration factor into the power meter as shown in Table 2-107.
- 10.Read the power displayed on the power meter and record it in the Performance Verification Test Record as indicated in the Test Record entry column of Table 2-107.
- 11.Repeat step 8 through step 10 for the remaining center frequency and First LO frequencies listed in Table 2-107.

Table 2-107 First LO Output Amplitude Accuracy Worksheet

First LO Frequency (GHz)	Center Frequency (GHz)	Calibration Factor Frequency (GHz)	Test Record Entry
2.9	29	3.0	1)
3.3	33	3.0	2)
3.7	37	4.0	3)
3.9	39	4.0	4)
4.1	41	4.0	5)
4.5	45	5.0	6)
4.9	49	5.0	7)
5.3	53	5.0	8)
5.7	57	6.0	9)
5.9	59	6.0	10)
6.1	61	6.0	11)
6.5	65	7.0	12)
6.9	69	7.0	13)
7.1	71	7.0	14)

Post-Test Instrument Restoration

- 12. Disconnect the power sensor from the 1st LO OUTPUT connector.
- 13. Replace the 50 Ω termination on the 1st LO OUTPUT connector.
- 14.Press **Preset** the analyzer.
- 15.Press System, Alignments, Auto Align, All.

53. IF INPUT Accuracy (Option AYZ only)

This test only applies to analyzers equipped with external mixing (Option AYZ).

This test measures the accuracy of the IF INPUT. A nominal $-30~dBm,\,321.4~MHz$ signal is applied to a power sensor and the power level is recorded. The actual frequency must be offset slightly to compensate for the IF centering error of the 1 kHz resolution bandwidth. This frequency offset is measured using the 321.4 MHz signal applied to the $50~\Omega$ Input connector. The signal is measured with frequency corrections on and off. The difference between these two measurements is the IF centering error. The 321.4 MHz signal is then offset by the IF centering error.

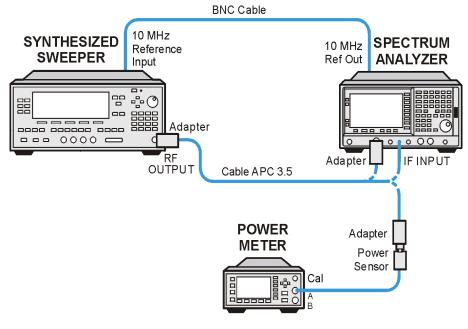
This signal is then applied to the IF INPUT of the analyzer which is set to external mixing mode in A band (26.5 GHz to 40 GHz). Amplitude corrections are set to 0 dB. The amplitude is measured by the analyzer and then recorded. The difference between the two measurements is the IF INPUT accuracy.

The related adjustment procedure for this performance test is "IF INPUT Correction."

Equipment Required

Synthesized sweeper
Power meter
Low-power power sensor
30 dB reference attenuator
Cable, APC 3.5
Cable, BNC
Adapter, type-N (m) to APC 3.5 (f) (not required for Option BAB)
Adapter, APC 3.5 (f) to APC 3.5 (f) (two required for Option BAB)
Adapter, type-N (f) to APC 3.5 (f)

Figure 2-73 IF INPUT Accuracy Test Setup



wl76b

Procedure

Determining the IF Centering Error

1. Preset the synthesized sweeper and set the controls as follows:

CW321.4 MHz POWER LEVEL–30 dBm RFOn

- 2. Connect the synthesized sweeper output to the analyzer 50 Ω Input connector. The analyzer provides the frequency reference for the synthesized sweeper.
- 3. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the analyzer by pressing the following keys:

System, Alignments, Auto Align, Off FREQUENCY, 321.4 MHz SPAN, 5 kHz AMPLITUDE, -30 dBm BW/Avg, Res BW, 1 kHz

- 4. On the analyzer, press **Single** and wait for the sweep to finish.
- 5. On the analyzer, press the following keys:

Peak Search (or Search)
Marker, Delta
System, Alignments, Freq Correct (Off).

- 6. On the analyzer, press **Single** and wait for the sweep to finish.
- 7. On the analyzer, press Peak Search (or Search).
- 8. Note the marker delta (Δ Mkr1) frequency.
- 9. Calculate the new synthesized sweeper CW frequency by adding the marker delta (Δ Mkr1) frequency to 321.4 MHz. Set the synthesized sweeper CW frequency to the new calculated frequency.

New CW Frequency = $321.4 \text{ MHz} + \Delta \text{Mkr1}$ Frequency

For example, if the marker delta (Δ Mkr1) frequency is 725 Hz, the new CW frequency would be 321.400725 MHz.

10.On the analyzer, press System, Alignments, Freq Correct (On).

Setting the Synthesized Sweeper Power Level

- 11.Zero and calibrate the low-power sensor and power meter in dBm mode using the 30 dB reference attenuator. Enter the 300 MHz calibration factor of the power sensor into the power meter.
- 12.Connect the equipment as shown in Figure 2-73, with the output of the synthesized sweeper connected to the power sensor using an adapter between the cable and the power sensor.
- 13. Adjust the synthesized sweeper power level for a power meter reading of $-30 \text{ dBm} \pm 0.1 \text{ dB}$.
- 14.Record the power meter reading as Input Power.

T ID	110
Input Power	dBm

Measuring the IF INPUT Accuracy

- 15.Connect the APC 3.5 cable from the RF OUTPUT of the synthesized sweeper to the IF INPUT of the analyzer.
- 16.Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the analyzer by pressing the following keys:

System, Alignments, Auto Align, Off
AMPLITUDE, More 1 of 2, Corrections, Corrections (Off)
AMPLITUDE, -30 dBm
Input/Output, Input Mixer, Input Mixer (Ext)
Ext Mix Band, 26.5-40 GHz
FREQUENCY, 30 GHz
SPAN, Zero Span
BW/Avg, Res BW, 1 kHz

17.Press **Peak Search** on the analyzer. Record the marker (Mkr1) amplitude reading as the Measured Power.

Measured Power _____dBm

18.Subtract the Input Power (step 14) from the Measured Power (step 17) and record the difference as the IF INPUT Accuracy.

IF INPUT Accuracy = Measured Power – Input Power

For example, if the Measured Power is -29.34 dBm and the Input Power is -30.08 dBm, the IF INPUT Accuracy would be 0.74 dB.

19.Record the IF INPUT Accuracy as Test Record entry 1 in the Performance Verification Test Record.

Post-Test Instrument Restoration

- 20.Disconnect the cable from the IF INPUT connector.
- 21.Preset the analyzer.
- 22.On the analyzer, press the following keys:

System, Alignments Auto Align, All

54. Comms Frequency Response (Option BAC or BAH)

This test measures the analyzer amplitude error as a function of frequency. The output of a source is fed through a power splitter to a power sensor and the analyzer. The source's power level is adjusted at 50 MHz to place the displayed signal at the analyzer center graticule line. The power meter is then set to measure dB relative to the power level at 50 MHz. At each new analyzer source frequency and center frequency, the source power level is adjusted to place the signal at the center horizontal graticule line. The power meter displays the inverse of the frequency response relative to 50 MHz.

For improved amplitude accuracy in the PCS and Cellular bands, a power splitter is characterized using a second power sensor (the "reference" sensor) connected to one power splitter output port. The other power splitter output port connects to the "buried" sensor; it is not removed from the power splitter. Once the characterization is done, the reference sensor is removed and replaced by the analyzer.

This procedure also tests frequency response with the optional preamplifier (Option 1DS) turned on if the analyzer is equipped with Option 1DS. When testing the preamplifier, it is necessary to re-characterize the power splitter/buried sensor combination.

The related adjustment for this performance test is "Frequency Response."

NOTE

There is no performance test record provided for recording the results of this test. Results of this test are required by test 59. Comms Absolute Power Accuracy (Options BAC or BAH), located in this chapter.

There are no related adjustment procedures for this performance test.

Equipment Required

Synthesized sweeper
Function generator
Power meter
RF Power sensor (2 required)
Microwave power sensor
Microwave power splitter
Adapter, APC 3.5 (f) to APC 3.5 (f)
Adapter, Type-N (m) to Type-N (m)
Adapter, Type-N (m) to BNC (f)
Fixed Attenuator, 20 dB
BNC Tee (BNC f,m,f)
Cable, BNC, 122-cm (48-in) (2 required)

Cable, Type-N, 183-cm (72-in) Cable, APC 3.5 Termination, 50 Ω, BNC (m)

Procedure

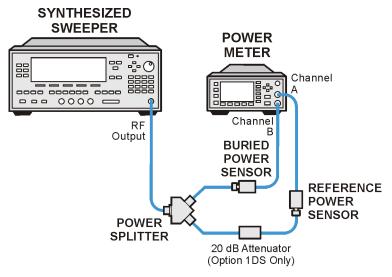
Part 1: Source/Splitter Characterization

NOTE

On analyzers equipped with the optional preamplifier, Option 1DS, this characterization will be performed twice. The first characterization, which will be performed on all analyzers, will be performed without the 20 dB fixed attenuator connected. The second characterization, which will be performed only on analyzers with Option 1DS, will be performed with the 20 dB fixed attenuator connected.

1. Connect the Agilent 8482A to Channel A of the power meter. This will be the "reference" sensor. Connect the other Agilent 8482A to Channel B of the power meter. This will be the "buried" sensor. Refer to Figure 2-74.

Figure 2-74 Source/Splitter Characterization Setup



wl723b

- 2. Zero and calibrate both power sensors.
- 3. On the power meter, set the Channel A calibration factor to the calibration factor of the reference sensor for 50 MHz.
- 4. On the power meter, set the Channel B calibration factor to 100%. Do not change this calibration factor during this test.
- 5. Connect the equipment as shown in Figure 2-74. Do not use the 20 dB fixed attenuator unless frequency response with the Preamp On

is being measured.

- 6. Set the source frequency to 50 MHz and amplitude to 0 dBm.
- 7. Adjust the source amplitude to obtain a Channel A power meter reading of -10 dBm ± 0.1 dB (if the preamp is not being tested), or a power meter reading of -20 dBm ± 0.1 dB (if the preamp is being tested).
- 8. Record the source amplitude setting, and both the Channel A and Channel B power meter readings in Table 2-108.
- 9. Tune the source to the next frequency in Table 2-108.
- 10.On the power meter, set the Channel A calibration factor to the calibration factor of the reference sensor for the current source frequency.
- 11.Adjust the source amplitude to obtain a Channel A power meter reading of -10 dBm ± 0.1 dB (if the preamp is not being tested), or a power meter reading of -20 dBm ± 0.1 dB (if the preamp is being tested).
- 12.Record the source amplitude setting, and both the Channel A and Channel B power meter readings in Table 2-108. If the preamp is being measured, enter these values in the "Preamp On" columns. Otherwise, enter these values in the "Preamp Off" columns.
- 13.Repeat step 9 through step 12 for frequencies up to 2000 MHz in Table 2-108.
- 14. For each entry in Table 2-108, calculate the splitter tracking error as follows:

Splitter Tracking Error = Channel A Power – Channel B Power

For example, if Channel A Power is –10.05 dBm and Channel B Power is –10.23 dBm, the Splitter Tracking Error is 0.18 dB.

NOTE

When calculating the splitter tracking error with the 20 dB fixed attenuator in place, the splitter tracking errors will be nominally 20 dB.

Table 2-108 Source/Splitter Characterization

Frequency	Power Meter Reading				Splitter Tracking Error		Source Power	
	Channel A		Channel B		Entor		Setting	
	Preamp Off	Preamp On	Preamp Off	Preamp On	Preamp Off	Preamp On	Preamp Off	Preamp On
50 MHz								
800 MHz								

Table 2-108 Source/Splitter Characterization

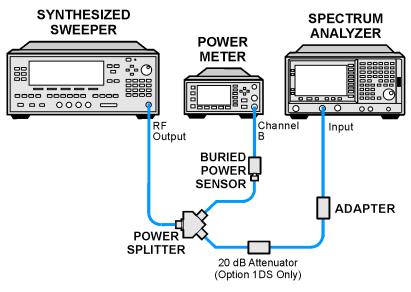
		Power Met	er Reading	ç				rce Power	
Frequency	Chan	nel A	Chan	nnel B		- 0-2	Setting		
	Preamp Off	Preamp On	Preamp Off	Preamp On	Preamp Off	Preamp On	Preamp Off	Preamp On	
810 MHz									
820 MHz									
830 MHz									
840 MHz									
850 MHz									
860 MHz									
880 MHz									
890 MHz									
900 MHz									
910 MHz									
920 MHz									
930 MHz									
940 MHz									
950 MHz									
960 MHz									
970 MHz									
980 MHz									
990 MHz									
1000 MHz									
1700 MHz									
1710 MHz									
1720 MHz									
1730 MHz									
1740 MHz									
1750 MHz									
1760 MHz									
1770 MHz									
1780 MHz									

Table 2-108 Source/Splitter Characterization

		Power Met	er Reading	f	Splitter '	Fracking ror		Power
Frequency	Chan	nel A	Chan	nel B			Setting	
	Preamp Off	Preamp On	Preamp Off	Preamp On	Preamp Off	Preamp On	Preamp Off	Preamp On
1790 MHz								
1800 MHz								
1810 MHz								
1820 MHz								
1830 MHz								
1840 MHz								
1850 MHz								
1860 MHz								
1870 MHz								
1880 MHz								
1890 MHz								
1900 MHz								
1910 MHz								
1920 MHz								
1930 MHz								
1940 MHz								
1950 MHz								
1960 MHz								
1970 MHz								
1980 MHz								
1990 MHz								
2000 MHz								

Part 2: Measuring Frequency Response, 800 MHz to 1000 MHz, 1700 MHz to 2000 MHz (0 dB, 5 dB, 10 dB, 25 dB, and 40 dB Attenuation)

Figure 2-75 Comms Frequency Response Test Setup



wl724b

1. This procedure will be performed several times with various combinations of input attenuation, resolution bandwidth, and preamp settings as described in Table 2-109. Make 6 copies of Table 2-110 (7 copies if the analyzer is equipped with the preamp, Option 1DS). Label each copy with the information listed in Table 2-109.

Table 2-109 Comms Frequency Response Measurement Conditions

Test	Measurement	Attenuation	Res BW	Preamp
1	1 0 01 1 D	40 dB	10 kHz	Off
2	cdmaOne Channel Power Accuracy	25 dB	10 kHz	Off
3		10 dB	10 kHz	Off
4	GSM Transmit Power	40 dB	300 kHz	Off
5	Accuracy	5 dB	300 kHz	Off
6	cdmaOne Receive Channel Power Accuracy	0 dB	10 kHz	Off
7	cdmaOne Receive Channel Power Accuracy (Preamp On)	0 dB	10 kHz	On

2. Remove the reference sensor (Channel A sensor) from the power

54. Comms Frequency Response (Option BAC or BAH)

splitter. Connect the power splitter to the analyzer 50 Ω Input using an adapter. Do not use a cable. If measuring with the preamp on, connect the 20 dB attenuator to the analyzer input. Refer to Figure 2-75.

- 3. Set the source frequency to 50 MHz.
- 4. Set the source POWER LEVEL to -6 dBm.
- 5. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Set the controls as follows:

```
FREQUENCY, Center Freq, 800 MHz
CF Step, 10 MHz
SPAN, 0 kHz
Input/Output (or Input), Coupling (AC) (ESA 6.7 GHz and 13.2 GHz only)
(Tests 1–6) AMPLITUDE, More, Int Preamp, (Off) (Option 1DS only)
(Test 7) AMPLITUDE, More, Int Preamp, (On) (Option 1DS only)
AMPLITUDE, More, Y-Axis Units (or Amptd Units), dBm
(Tests 1–6) AMPLITUDE, Ref Level, –10 dBm
(Test 7) AMPLITUDE, Ref Level, –30 dBm
Attenuation, x dB (Man) Where x is listed in Table 2-109.
Scale/Div, 1 dB
(Tests 1, 2, 3, 6, 7) BW/Avg, Res BW, 10 kHz (Man)
(Tests 4, 5) BW/Avg, Res BW, 300 kHz (Man)
Video BW, 10 kHz (Man)
```

- 6. Press Marker.
- 7. Adjust the source POWER LEVEL to obtain a marker amplitude reading of -12 dBm ±0.1 dB (Tests 1-6) or -32 dBm ±0.1 dB (Tests 7)
- 8. Record the current Channel B power reading in Table 2-110 as the current Channel B reading.
- 9. Trigger a sweep on the analyzer.
- 10.Perform a peak search on the analyzer. Manually press **Peak Search** (or Search).
- 11.Record the marker (Mkr1) amplitude reading in Table 2-110.
- 12.Set the source to the next frequency listed in Table 2-110.
- 13.Set the analyzer center frequency to the next frequency listed in Table 2-110 by pressing the FREQUENCY and up arrow keys to step the center frequency.
- 14.Adjust the source POWER LEVEL to obtain a marker amplitude reading of -12 dBm ± 0.1 dB (Tests 1-6) or -32 dBm ± 0.1 dB (Tests 7)
- 15.Record the current Channel B power reading in Table 2-110 as the current Channel B reading.
- 16. Trigger a sweep on the analyzer.

- 17. Perform a peak search on the analyzer. Manually press **Search**.
- 18.Record the marker (Mkr1) amplitude reading in Table 2-110 as marker (Mkr1) Amptd.
- 19.Repeat step 12 through step 18 for each frequency in Table 2-110.
- 20.Copy the splitter tracking errors from Table 2-108 into Table 2-110. For Tests 1–6, use the Preamp Off values. For Test 7, use the Preamp On values.
- 21.Calculate the Flatness Error for each frequency in Table 2-110 as follows:
- Flatness Error = Mkr1 Amptd Current Channel B Splitter Tracking Error For example, if marker (Mkr1) Amptd is –10.32 dBm, Current Channel B is –10.2 and Splitter Tracking Error is 0.18 dB, Flatness Error would be –0.30 dB.
 - 22.Record the Flatness Error for 50 MHz below as the 50 MHz Ref Amptd:
 - 50 MHz Ref Amptd: _____
 - 23.Calculate the Flatness Relative to 50 MHz for each frequency in Table 2-110 as follows:
- Flatness Relative to 50 MHz = Flatness Error 50 MHz Ref Amptd
 - For example, if Flatness Error is –30.0 dB, 50 MHz Ref Amptd is 0.15 dB and setup change error is –0.19 dB, Flatness Relative to 50 MHz would be –0.45 dB.
 - 24.Repeat step 2 through step 23 of Part 2 using the attenuation and resolution bandwidth settings as indicated in Table 2-109 for Tests 2-6.
 - 25.If the analyzer is equipped with the optional preamplifier, Option 1DS, perform Part 1, the Source/Splitter Characterization again for the Preamp On case.
 - 26.If the analyzer is equipped with the optional preamplifier, Option 1DS, perform step 2 through step 23, Part 2, using the attenuation and resolution bandwidth settings as indicated in Table 2-109 for Test 7.
 - 27.Proceed to Part 3: Test Results.

Table 2-110 Frequency Response Worksheet

Test:____ Atten:___ RBW:____ Preamp:____

Frequency	Current Channel B Reading	Marker (Mkr1) Amptd	Splitter Tracking Error	Flatness Error	Flatness Relative to 50 MHz
50 MHz					0 dB (Ref)
800 MHz					
810 MHz					
820 MHz					
830 MHz					
840 MHz					
850 MHz					
860 MHz					
870 MHz					
880 MHz					
890 MHz					
900 MHz					
910 MHz					
920 MHz					
930 MHz					
940 MHz					
950 MHz					
960 MHz					
970 MHz					
980 MHz					
990 MHz					
1000 MHz					
1700 MHz					
1710 MHz					
1720 MHz					
1730 MHz					

Table 2-110	Frequency	Response Work	sheet		
	Test:	Atten:	RRW:	Preamn:	

Frequency	Current Channel B Reading	Marker (Mkr1) Amptd	Splitter Tracking Error	Flatness Error	Flatness Relative to 50 MHz
1740 MHz					
1750 MHz					
1760 MHz					
1770 MHz					
1780 MHz					
1790 MHz					
1800 MHz					
1810 MHz					
1820 MHz					
1830 MHz					
1840 MHz					
1850 MHz					
1860 MHz					
1870 MHz					
1880 MHz					
1890 MHz					
1900 MHz					
1910 MHz					
1920 MHz					
1930 MHz					
1940 MHz					
1950 MHz					
1960 MHz					
1970 MHz					
1980 MHz					
1990 MHz					
2000 MHz					

Part 3: Test Results

- 1. Repeat the following steps using the Table 2-110 data for each set of test data for Tests 1–6 (Option 1DS, Tests 1–7):
 - a. Record the most positive number from the Flatness Relative to 50 MHz column for the 800 MHz to 1000 MHz range in Table 2-110 as the Maximum Response in the 800 MHz to 1000 MHz Cellular Band for the appropriate test number.
 - b. Record the most positive number from the Flatness Relative to 50 MHz column for the 1700 MHz to 2000 MHz range in Table 2-110 as the Maximum Response in the 1700 MHz to 2000 MHz PCS Band for the appropriate test number.
 - c. Record the most negative number from the Flatness Relative to 50 MHz column for the 800 MHz to 1000 MHz range in Table 2-110 as the Minimum Response in the 800 MHz to 1000 MHz Cellular Band for the appropriate test number.
 - d. Record the most negative number from the Flatness Relative to 50 MHz column for the 1700 MHz to 2000 MHz range in Table 2-110 as the Minimum Response in the 1700 MHz to 2000 MHz PCS Band for the appropriate test number.

Table 2-111 Absolute Frequency Response

Test		o 1000 MHz ar Band	1700 MHz to 2000 MHz PCS Band		
	Minimum Response (dB)	Maximum Response (dB)	Minimum Response (dB)	Maximum Response (dB)	
1					
2					
3					
4					
5					
6					
7					

- 2. Repeat the following using the data in Table 2-111 for Tests 1–6 (Option 1DS, Tests 1–7):
 - a. Subtract the Minimum Response for the 800 MHz to 1000 MHz
 Cellular Band from The Maximum Response for the 800 MHz to 1000 MHz Cellular Band and record the difference as the Peak-to-Peak Response in
 Table 2-112 for the appropriate test number.

- b. Subtract the Minimum Response for the 1700 MHz to 2000 MHz PCS Band from The Maximum Response for the 1700 MHz to 2000 MHz PCS Band and record the difference as the Peak-to-Peak Response in Table 2-113 for the appropriate test number.
- 3. The Comms Frequency Response test is completed

Table 2-112 Comms Frequency Response Test Results, Cellular Bands

Test	Measurement	Attenuation	Res BW	Preamp	Peak-to-Peak Response (dB)
1	cdmaOne Channel Power	40 dB	10 kHz	Off	
2	Accuracy	25 dB	10 kHz	Off	
3		10 dB	10 kHz	Off	
4	GSM Transmit Power	40 dB	300 kHz	Off	
5	Accuracy	5 dB	300 kHz	Off	
6	cdmaOne Receive Channel Power Accuracy	0 dB	10 kHz	Off	
7	cdmaOne Receive Channel Power Accuracy (Preamp On)	0 dB	10 kHz	On	

NOTE

There is no performance test record provided for recording the results of this test. Results of this test are required by test 59. Comms Absolute Power Accuracy (Options BAC or BAH), located in this chapter.

Table 2-113 Comms Frequency Response Test Results, PCS Bands

Test	Measurement	Attenuation	Res BW	Preamp	Peak-to-Peak Response (dB)
1	cdmaOne Channel Power	40 dB	10 kHz	Off	
2	Accuracy	25 dB	10 kHz	Off	
3		10 dB	10 kHz	Off	
4	GSM Transmit Power	40 dB	300 kHz	Off	
5	Accuracy	5 dB	300 kHz	Off	
6	cdmaOne Receive Channel Power Accuracy	0 dB	10 kHz	Off	
7	cdmaOne Receive Channel Power Accuracy (Preamp On)	0 dB	10 kHz	On	

58. GSM Phase and Frequency Error (Options BAH and B7E)

This test verifies the ability of a UUT (unit under test) to measure phase and frequency error in the GSM personality (Option BAH). ESA Series Spectrum Analyzers that use both Options BAH and B7E are used to measure and verify the performance of the phase and frequency error in the GSM personality.

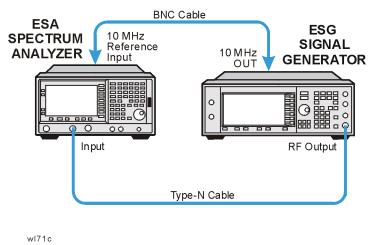
Phase and frequency error in the GSM personality is measured by generating a GSM forward link carrier with a single active time slot. Note that Option B7D is a required Option for B7E. This test is repeated at different frequencies and amplitude signal levels.

There are no related adjustment procedures for this performance test.

Equipment Required

Sythesized signal generator with GSM capabilities Cable, BNC, 120-cm (48-in.) Cable, Type N, 183-cm (73-in.)

Figure 2-76 GSM Phase and Frequency Test Setup



Procedure

Set the signal generator to generate a single forward link GSM modulated carrier with a single time slot by performing the following steps:

NOTE The signal generator provides the 10 MHz reference for the analyzer.

- 1. Set up the equipment as shown in Figure 2-76.
- 2. Preset the signal generator by pressing the **PRESET** hardkey.
- 3. To enter the GSM setup, press the following signal generator keys:

MODE, Real Time I/Q Baseband TDMA, GSM

- 4. Press the **Data Format Continuous/Framed** softkey and highlight **Framed** to select a single time slot.
- 5. Turn on the GSM setup screen by pressing the **GSM ON/OFF** softkey and highlighting **ON**.
- 6. Turn RF on by pressing the RF ON/OFF softkey.
- 7. Set the signal generator frequency to the first frequency listed in Column 1 of Table 2-114.
- 8. Set the signal generator amplitude to the first amplitude listed in Column 2 of Table 2-114.
- 9. Set the analyzer to measure GSM phase and frequency error by performing the following steps:
 - a. Preset the analyzer by pressing the **Preset** hardkey.
 - b. Enter the GSM personality by pressing the **Mode** hardkey followed by the **GSM** softkey.
 - c. Initiate the phase and frequency measurement by pressing the **Measure** hardkey followed by the **Phase and Frequency** softkey.
 - d. Use the first frequency listed in the Table 2-114 by pressing the **Frequency** hardkey, **Channel Freq** and entering the numeric value.
- 10. Press **Meas Setup**. If the Average Type softkey is present, press **Average Type** to highlight Mean.
- 11.Press Average Number, 10, Enter.
- 12.Press **Single**. The analyzer will make ten measurements and report the average values for peak and RMS phase errors and frequency error.
- 13.Enter the peak and RMS phase errors and the frequency error in the appropriate row of Table 2-114.

Table 2-114 GSM - Phase and Frequency Measurement Table

ESA/ESG Frequency (MHz)	ESG Amplitude (dBm)	Phase Error (deg)		Frequency Error (Hz)
(MIIIZ)	(dBiii)	Peak	RMS	
900	0			

Table 2-114 GSM - Phase and Frequency Measurement Table

ESA/ESG Frequency (MHz)	ESG Amplitude (dBm)	Phase Error (deg)		Frequency Error (Hz)
(MIIIZ)	(dDiii)	Peak RMS		
900	-30			
1800	0			
1800	-30			

- 14. Repeat step 7 through step 13 for each of the frequencies and amplitudes listed in Table 2-114.
- 15.Record the worst peak phase error from Column 3 as Entry 1 in the performance test record.
- 16.Record the worst RMS phase error from Column 4 as Entry 2 in the performance test record.
- 17.Record the worst frequency error from Column 5 as Entry 3 in the performance test record.

59. Comms Absolute Power Accuracy (Options BAC or BAH)

This test measures the absolute amplitude of the ESA Series Spectrum Analyzer at numerous input levels, attenuator settings, and log levels. The test also measures the amplitude accuracy with the Preamp On when Option 1DS is present. The measured performance, when added to the absolute frequency response over a 20 to 30 °C temperature range, yields the Comms Absolute Accuracy. The absolute frequency response is tested separately. Refer to the Frequency Response performance test.

The frequency response is not specified in the Cellular nor PCS bands; therefore, the Comms Frequency Response test must be completed first. The worksheet data will be used with the results of the Comms Amplitude Accuracy at 50 MHz to yield to the Comms absolute accuracy in the Cellular and PCS bands.

A sythesized signal generator and attenuators are used as the signal source to the analyzer. A power meter is used to measure the signal source (with the attenuators set to 0 dB). The value measured is recorded as the source amplitude. 15 dBm as well as 0 dBm are the source levels used.

The attenuators are used to adjust the signal levels applied to the analyzer from the initial signal amplitude. The amplitude measured by the analyzer is compared to the actual signal level and the amplitude error is then calculated.

This test is repeated at different frequencies and amplitude signal levels.

The related adjustment for this performance test is the "IF Amplitude Adjustment."

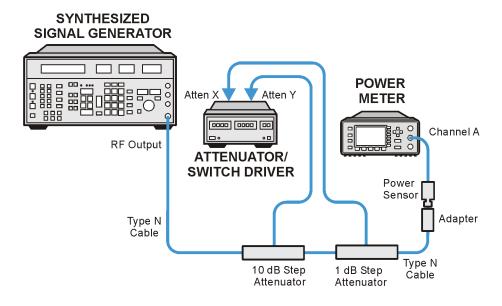
Equipment Required

Synthesized signal generator
10 dB step attenuator
1 dB step attenuator
Attenuator interconnection kit
Attenuator driver (if programmable step attenuators are used)
Power meter
Power sensor
Cable, Type-N, 62 cm (24 in.) (m) (2 required)
Cable, BNC
Adapter, Type-N (f) to Type-N (f)

Additional Equipment for Option BAB

Adapter, Type N (f) to APC 3.5 (f)

Figure 2-77 Measure Source Test Setup



eswcommspwraccy

Procedure

Part 1: cdmaOne Channel Power and GSM Transmit Power

Table 2-115, Table 2-116, Table 2-119, and Table 2-120 list the reference level, input attenuation, and nominal input level for the analyzer, and nominal attenuation for the calibrated 1 dB and 10 dB step attenuators for the amplitude accuracy measurements.

Table 2-115 cdmaOne Channel Power (Option BAC), Preamp Off, Input Level \geq -25 dBm

Nominal Input Level	Reference Level	Resolution Bandwidth	Internal Attenuator	1 dB Step Attenuator	10 dB Step Attenuator	Nominal Source Level
(dBm)	(dBm)	(kHz)	(dB)	(dB)	(dB)	(dBm)
15	15	10	40	0	0	15
15	30	10	40	0	0	15
-5	-5	10	25	0	20	15
-5	15	10	25	0	20	15
-25	-25	10	10	0	40	15

Table 2-115 cdmaOne Channel Power (Option BAC), Preamp Off, Input Level ≥-25 dBm

Nominal Input Level	Reference Level	Resolution Bandwidth	Internal Attenuator	1 dB Step Attenuator	10 dB Step Attenuator	Nominal Source Level
(dBm)	(dBm)	(kHz)	(dB)	(dB)	(dB)	(dBm)
-25	- 5	10	10	0	40	15

Table 2-116 GSM Transmit Power (Option BAH), Preamp Off, Input Level >-20 dBm

Nominal Input Level (dBm)	Reference Level (dBm)	Resolution Bandwidth (kHz)	Internal Attenuator (dB)	1 dB Step Attenuator	10 dB Step Attenuator	Nominal Source Level (dBm)
15	15	300	40	0	0	15
15	30	300	40	0	0	15

- 1. Press **Preset** on the analyzer. Press the **Factory Preset** softkey, if it is displayed. Wait for the preset routine to finish.
- 2. Perform a complete self-alignment and set Auto Align Off. Press System, Alignments, Align Now, All, and wait for the alignment routine to finish. Then, press Return, Auto Align, Off.
- 3. Zero and calibrate the power meter and power sensor connected to Channel A of the power meter.
- 4. Connect the equipment as shown in Figure 2-77.
- 5. Preset the synthesized signal generator. Press: Blue Key, Special, 0, 0 and set the signal generator as follows:

FREQUENCY, 50 MHz AMPLITUDE, 15 dBm

- 6. Set the 10 dB and 1 dB step attenuators to 0 dB.
- 7. Obtain the actual attenuation for the 0 dB setting of each attenuator at 50 MHz from the metrology data for the step attenuators. In some cases this value might be zero, by definition. Add the two actual attenuations to obtain the 0 dB reference attenuation.

 $RefAtten_{0dB} = 10 dB Actual_{0dB} + 1 dB Actual_{0dB}$

For example, if the actual attenuation for the 10 dB step attenuator at the 0 dB setting is 0.03 dB, then 10 dB Actual_{0dB} is 0.03 dB. If the actual attenuation for the 1 dB step attenuator at the 0 dB setting is

59. Comms Absolute Power Accuracy (Options BAC or BAH)

- 0.02~dB, then 1 dB Actual $_{0dB}$ is 0.02~dB. In this case RefAtten $_{0dB}$ is 0.05~dB.
- 8. Obtain the metrology data for the step attenuators at 50 MHz. Enter the actual attenuation values for each attenuator setting as indicated in Table 2-117, Table 2-118, Table 2-121, and Table 2-122.

Table 2-117 Amplitude Accuracy Worksheet, cdmaOne, Input Level \geq -25 dBm

1 dB Step Attenuator		10 dB Step Attenuator		Total Attenuation		Ref Level	Nominal Input	Meas Amptd	Amptd Accuracy
Setting	Actual	Setting	Actual	Setting	Actual	Level	Amptd	Amptu	
0 dB		0 dB		0 dB		15 dBm	15 dBm		
0 dB		0 dB		0 dB		30 dBm	15 dBm		
0 dB		20 dB		20 dB		–5 dBm	–5 dBm		
0 dB		20 dB		20 dB		15 dBm	–5 dBm		
0 dB		40 dB		40 dB		–25 dBm	–25 dBm		
0 dB		40 dB		40 dB		–5 dBm	–25 dBm		

Table 2-118 Amplitude Accuracy Worksheet, GSM, Input Level >-20 dBm

1 dB Step Attenuator		10 dB Step Attenuator		Total Attenuation		Ref Level	Nominal Input	Meas Amptd	Amptd Accuracy
Setting	Actual	Setting	Actual	Setting	Actual	Level	Amptd	Amptu	
0 dB		0 dB		0 dB		15 dBm	15 dBm		
0 dB		0 dB		0 dB		30 dBm	15 dBm		

9. Calculate the actual total attenuation by adding the actual attenuation for the 1 dB step attenuator to the actual attenuation for the 10 dB step attenuator for each total attenuation setting listed in Table 2-117, Table 2-118, Table 2-121, and Table 2-122.

NOTE	The external attenuators and cables are now part of the "source."
------	---

10.Adjust the signal generator amplitude for a power meter reading of 15 dBm ±0.2 dB. Record the power meter reading here:

$$Amptd_{15dBm} = \underline{\hspace{1cm}} dBm$$

11. Connect the equipment as indicated in Figure 2-78.

BNC Cable SYNTHESIZED SPECTRUM 10 MHz SIGNAL GENERATOR 10 MHz Ref Out **ANALYZER** Ref In Atten X Atten Y 0000 0000 00 RF Input RF Output ATTENUATOR/ **SWITCH DRIVER** Type N Type N Cable Cable 10 dB Step 1 dB Step Attenuator Attenuator

Figure 2-78 Amplitude Accuracy Test Setup

eswcommspwraccy

12.Set the analyzer as follows:

FREQUENCY, Center Freq, 50 MHz
SPAN, 0 kHz
BW/Avg, Res BW, 10 kHz
BW/Avg, Video BW, 10 kHz
AMPLITUDE, More, Y Axis Units (or Amptd Units), dBm
AMPLITUDE, Ref Level, 15 dBm
AMPLITUDE, Attenuation, 40 dB

- 13.Perform the following steps for each of the nominal amplitude values listed in Table 2-115 and Table 2-116:
 - a. Set the 1 dB step attenuator as indicated.
 - b. Set the 10 dB step attenuator as indicated.
 - c. Set the analyzer reference level as indicated.
 - d. Set the analyzer input attenuation as indicated.
 - e. Set the analyzer resolution bandwidth as indicated.
 - f. Press **Single** and wait for the sweep to finish.
 - g. Press **Peak Search** (or **Search**). The marker can still make a valid measurement even though the signal may be slightly above the reference level for the first nominal amplitude setting.
 - h. Record the marker (Mkr1) amplitude value as the Measured Amplitude in Table 2-117 and Table 2-118.
 - i. If the nominal amplitude is 15 dBm, calculate the amplitude accuracy as follows:
 - Amplitude Accuracy = Measured Amplitude Amptd_{15dBm}
 - j. If the amplitude is less than 15 dBm, calculate the amplitude accuracy as follows:

Amplitude Accuracy = Measured Amplitude – $(Amptd_{15dBm} - ActualTotalAtten + RefAtten_{0dB})$

- 14.Set the 10 dB and 1 dB step attenuators to 0 dB.
- 15.Disconnect the cable from the analyzer input connector and connect the cable to the adapter and power sensor as shown in Figure 2-77.
- 16.Adjust the signal generator AMPLITUDE for a power meter reading of $0 \text{ dbm} \pm 0.2 \text{ dB}$. Record the power meter reading here:

$$Amptd_{0dBm} = \underline{\hspace{1cm}} dBm$$

- 17. Connect the equipment as shown in Figure 2-78.
- 18.Perform the following steps for each of the "Nominal Input Amplitude" values listed in Table 2-119 and Table 2-120.
 - a. Set the 1 dB step attenuator as indicated.
 - b. Set the 10 dB step attenuator as indicated.
 - c. Set the analyzer reference level as indicated.
 - d. Set the analyzer input attenuation as indicated.
 - e. Set the analyzer resolution bandwidth as indicated.
 - f. Press **Single** and wait for the sweep to finish.
 - g. Press **Peak Search** (or **Search**). The marker can still make a valid measurement, even though the signal may be slightly above the reference level for the first nominal amplitude setting.
 - h. Record the marker (Mkr1) amplitude value as the Measured Amplitude in Table 2-121 and Table 2-122.
 - i. Calculate the amplitude accuracy as follows:

Amplitude Accuracy =

Measured Amplitude – (Amptd_{0dB} – ActualTotalAtten + RefAtten_{0dB})

Table 2-119 cdmaOne Channel Power (Option BAC), Preamp Off, Input level <-25 dBm

Nominal Input Amplitude (dBm)	Reference Level (dBm)	Resolution Bandwidth (kHz)	Input Attenuation (dB)	1 dB Step Attenuator (dB)	10 dB Step Attenuator (dB)	Nominal Source Level (dBm)
-45	-45	10	10	5	40	0
-45	-25	10	10	5	40	0
-55	-55	10	10	5	50	0
-55	-35	10	10	5	50	0
-70	-70	10	10	0	70	0
-70	-50	10	10	0	70	0

Table 2-120 GSM Transmit Power (Option BAH), Preamp Off, Input level \leq -20 dBm

Nominal Input Amplitude (dBm)	Reference Level (dBm)	Resolution Bandwidth (kHz)	Input Attenuation (dB)	1 dB Step Attenuator (dB)	10 dB Step Attenuator (dB)	Nominal Source Level (dBm)
-20	0	300	5	0	20	0
-20	-20	300	5	0	20	0
-30	-10	300	5	0	30	0
-30	-30	300	5	0	30	0
-40	-20	300	5	0	40	0
-40	-40	300	5	0	40	0
-50	-30	300	5	0	50	0
-50	-50	300	5	0	50	0
-60	-40	300	5	0	60	0
-60	-60	300	5	0	60	0

Table 2-121 Amplitude Accuracy Worksheet, cdmaOne, Input Level <-25 dBm

1 dB Step Attenuator		10 dB Step Attenuator		Total Attenuation		Ref	Nominal Input	Meas Amptd	Amptd Accuracy
Setting	Actual	Setting	Actual	Setting	Actual	Level	Amptd	Amptu	
5 dB		40 dB		45 dB		–45 dBm	–45 dBm		
5 dB		40 dB		45 dB		–25 dBm	–45 dBm		
5 dB		50 dB		55 dB		–55 dBm	–55 dBm		
5 dB		50 dB		55 dB		–35 dBm	–55 dBm		
0 dB		70 dB		70 dB		-70 dBm	-70 dBm		
0 dB		70 dB		70 dB		–50 dBm	-70 dBm		

Table 2-122 Amplitude Accuracy Worksheet, GSM, Input Level ≤-20 dBm

	1 dB Step Attenuator		10 dB Step Attenuator		Total Attenuation		Nominal Input	Meas Amptd	Amptd Accuracy
Setting	Actual	Setting	Actual	Setting	Actual	Level	Amptd	Amptu	
0 dB		20 dB		20 dB		0 dBm	–20 dBm		
0 dB		20 dB		20 dB		–20 dBm	–20 dBm		
0 dB		30 dB		30 dB		-10 dBm	–30 dBm		

Table 2-122 Amplitude Accuracy Worksheet, GSM, Input Level ≤-20 dBm

1 dB Step Attenuator		10 dB Step Attenuator		Total Attenuation		Ref Level	Nominal Input	Meas Amptd	Amptd Accuracy
Setting	Actual	Setting	Actual	Setting	Actual	Level	Amptd	Impu	
0 dB		30 dB		30 dB		-30 dBm	-30 dBm		
0 dB		40 dB		40 dB		–20 dBm	-40 dBm		
0 dB		40 dB		40 dB		-40 dBm	-40 dBm		
0 dB		50 dB		50 dB		-30 dBm	–50 dBm		
0 dB		50 dB		50 dB		-50 dBm	–50 dBm		
0 dB		60 dB		60 dB		-40 dBm	-60 dBm		
0 dB		60 dB		60 dB		-60 dBm	-60 dBm		

- 19.Table 2-117 and Table 2-121 have two Amplitude Accuracy entries for each nominal input amplitude setting. For each of the nominal input amplitude setting pairs in Table 2-117 and Table 2-121, record the worst of the two Amplitude Accuracy values in Table 2-123 and Table 2-124 as the 50 MHz Amplitude Accuracy for the same Nominal Input Amplitude setting.
- 20.Table 2-118 and Table 2-122 have two Amplitude Accuracy entries for each nominal input amplitude setting. For each of the nominal input amplitude setting pairs in Table 2-118 and Table 2-122, record the worst of the two Amplitude Accuracy values in Table 2-125 and Table 2-126 as the 50 MHz Amplitude Accuracy for the same Nominal Input Amplitude setting.
- 21.Copy into Table 2-123 and Table 2-124 the peak-to-peak frequency response error for the appropriate input attenuation setting from the Comms Frequency Response Performance Test for both the 800 MHz to 1 GHz Cellular Band, and the 1.7 GHz to 2 GHz PCS Band measured in a 10 kHz resolution bandwidth.
- 22.Copy into Table 2-125 and Table 2-126 the peak-to-peak frequency response error for the appropriate input attenuation setting from the Comms Frequency Response Performance Test for both the 800 MHz to 1 GHz Cellular Band, and the 1.7 GHz to 2 GHz PCS Band measured in a 300 kHz resolution bandwidth.
- 23.For each Nominal Input Amplitude setting listed in Table 2-123, add the values for the 50 MHz Amplitude Accuracy (Column 2), the peak-to-peak response (Column 4), and the uncertainty (Column 5). Record the sum as the cdmaOne Channel Power Accuracy (Column 6). Repeat this step for Table 2-124, Table 2-125, and Table 2-126.
- 24.Record the cdmaOne Channel Power and GSM Transmit Power Results in the test record as indicated by the test record entry

numbers in parenthesis.

25. Continue with Part 2.

Table 2-123 cdmaOne Channel Power Accuracy (Cellular Band)

Nominal Input Amplitude (dBm)	50 MHz Amplitude Accuracy (dB)	Input Attenuation (dB)	Peak to Peak Response (800 MHz to 1 GHz) (dB)	Uncertainty (dB)	cdmaOne Channel Power Accuracy (dB) Columns 2+4+5
15		40		0.19	1)
-5		25		0.19	2)
-25		10		0.19	3)
-45		10		0.19	4)
-55		10		0.19	5)
-70		10		0.19	6)

Table 2-124 cdmaOne Channel Power Accuracy (PCS Band)

Nominal Input Amplitude (dBm)	50 MHz Amplitude Accuracy (dB)	Input Attenuation (dB)	Peak to Peak Response (1.7 GHz to 2 GHz) (dB)	Uncertainty (dB)	cdmaOne Channel Power Accuracy (dB) Columns 2+4+5 (dB)
15		40		0.19	7)
-5		25		0.19	8)
-25		10		0.19	9)
-45		10		0.19	10)
-55		10		0.19	11)
-70		10		0.19	12)

Table 2-125 GSM Transmit Power Accuracy (Cellular Band)

Nominal Input Amplitude (dBm)	50 MHz Amplitude Accuracy (dB)	Input Attenuation (dB)	Peak to Peak Response (800 MHz to 1 GHz) (dB)	Uncertainty (dB)	GSM Channel Power Accuracy Columns 2+4+5 (dB)
15		40		0.19	13)
-20		5		0.19	14)
-30		5		0.19	15)
-40		5		0.19	16)
-50		5		0.19	17)
-60		5		0.19	18)

Table 2-126 GSM Transmit Power Accuracy (PCS Band)

Nominal Input Amplitude (dBm)	50 MHz Amplitude Accuracy (dB)	Input Attenuation (dB)	Peak to Peak Response (1.7 GHz to 2 GHz) (dB)	Uncertainty (dB)	GSM Channel Power Accuracy Columns 2+4+5 (dB)
15		40		0.19	19)
-20		5		0.19	20)
-30		5		0.19	21)
-40		5		0.19	22)
-50		5		0.19	23)
-60		5		0.19	24)

Part 2: cdmaOne Receive Channel Power (Preamp Off)

Table 2-127 lists the reference level, input attenuation, and nominal input level for the analyzer, and nominal attenuation for the calibrated 1 dB and 10 dB step attenuators for the amplitude accuracy measurements.

Table 2-127 cdmaOne Receive Channel Power, Preamp Off (Option BAC)

Nominal Input Amplitude (dBm)	Reference Level (dBm)	Resolution Bandwidth (kHz)	Input Attenuation (dB)	1 dB Step Attenuator (dB)	10 dB Step Attenuator (dB)	Source Nominal Level (dBm)
-40	-20	10	0	0	40	0
-40	-40	10	0	0	40	0
-60	-40	10	0	0	60	0
-60	-60	10	0	0	60	0
-70	-50	10	0	0	70	0
-70	-70	10	0	0	70	0
-80	-60	10	0	0	80	0
-80	-80	10	0	0	80	0
-85	-65	10	0	5	80	0
-85	-85	10	0	5	80	0

- 1. Set the 10 dB step attenuator to 40 dB and the 1 dB step attenuator to 0 dB.
- 2. Obtain the actual attenuation for the 0 dB setting of each attenuator at 50 MHz from the metrology data for the step attenuators. In some cases this value might be zero, by definition. Add the two actual attenuations to obtain the 0 dB reference attenuation.

$$RefAtten_{40dB} = 10 dB Actual_{40dB} + 1 dB Actual_{0dB}$$

For example, if the actual attenuation for the 10 dB step attenuator at the 0 dB setting is 40.03 dB, then 10 dB Actual $_{40dB}$ is 40.03 dB. If the actual attenuation for the 1 dB step attenuator at the 0 dB setting is 0.02 dB, then 1 dB Actual $_{0dB}$ is 0.02 dB. In this case RefAtten $_{40dB}$ is 40.05 dB.

- 3. Obtain the metrology data for the step attenuators at 50 MHz.
- 4. Calculate the actual total attenuation by adding the actual attenuation for the 1 dB step attenuator to the actual attenuation for the 10 dB step attenuator for each total attenuation setting listed in Table 2-128.

NOTE

The external attenuators and cables are now part of the "source."

Table 2-128 Amplitude Accuracy Worksheet

	1 dB Step Attenuator		10 dB Step Attenuator		Total Attenuation		Nominal Input	Meas Amptd	Amptd Accuracy
Setting	Actual	Setting	Actual	Setting	Actual	Level	Amptd	Impu	
0 dB		40 dB		40 dB		–20 dBm	–40 dBm		
0 dB		40 dB		40 dB		-40 dBm	–40 dBm		
0 dB		60 dB		60 dB		-40 dBm	-60 dBm		
0 dB		60 dB		60 dB		-60 dBm	–60 dBm		
0 dB		70 dB		70 dB		–50 dBm	-70 dBm		
0 dB		70 dB		70 dB		-70 dBm	-70 dBm		
0 dB		80 dB		80 dB		-60 dBm	-80 dBm		
0 dB		80 dB		80 dB		-80 dBm	-80 dBm		
0 dB		80 dB		80 dB		-65 dBm	–85 dBm		
5 dB		80 dB		85 dB		-85 dBm	-85 dBm		

5. Set the analyzer as follows:

FREQUENCY, Center Freq, 50 MHz
SPAN, 0 kHz
BW/Avg, Res BW, 10 kHz
BW/Avg, Video BW, 10 kHz
AMPLITUDE, More, Y-Axis Units (or Amptd Units), dBm
AMPLITUDE, Ref Level, -20 dBm
AMPLITUDE, Attenuation, 0 dB
AMPLITUDE, More, Int Preamp Off

- 6. Perform the following steps for each of the "Nominal Input Amplitude" values listed in Table 2-127.
 - a. Set the 1 dB step attenuator as indicated.
 - b. Set the 10 dB step attenuator as indicated.
 - c. Set the analyzer reference level as indicated.
 - d. Set the analyzer input attenuation as indicated.
 - e. Press **Single** and wait for the sweep to finish.
 - f. Press **Peak Search** (or **Search**). The marker can still make a valid measurement, even though the signal may be slightly above the reference level for the first nominal amplitude setting.
 - g. Record the marker (Mkr1) amplitude value as the Measured Amplitude in Table 2-128.

h. Calculate the amplitude accuracy as follows:

Amplitude Accuracy =

 $Measured\ Amplitude - (Amptd_{0dB} - ActualTotalAtten + RefAtten_{40dB}) + 40dB$

7. Table 2-128 has two Amplitude Accuracy entries for each nominal input amplitude setting. For each of the nominal input amplitude setting pairs in Table 2-128, record the worst of the two Amplitude Accuracy values in Table 2-129 and Table 2-130 as the 50 MHz Amplitude Accuracy for the same Nominal Input Amplitude setting.

Table 2-129 cdmaOne Receive Channel Power (Cellular Band) Preamp Off

Nominal Input Amplitude (dBm)	50 MHz Amplitude Accuracy (dB)	Input Attenuation (dB)	Peak to Peak Response (1.7 GHz to 2 GHz) (dB)	Uncertainty (dB)	cdmaOne Receive Channel Power Accuracy, Preamp Off Columns 2+4+5 (dB)
-40		0		0.24	25)
-60		0		0.24	26)
-70		0		0.24	27)
-80		0		0.24	28)
-85		0		0.24	29)

Table 2-130 cdmaOne Receive Channel Power (PCS Band) Preamp Off

Nominal Input Amplitude (dBm)	50 MHz Amplitude Accuracy (dB)	Input Attenuation (dB)	Peak to Peak Response (1.7 GHz to 2 GHz) (dB)	Uncertainty (dB)	cdmaOne Receive Channel Power Accuracy, Preamp Off Columns 2+4+5 (dB)
-40		0		0.24	30)
-60		0		0.24	31)
-70		0		0.24	32)
-80		0		0.24	33)
-85		0		0.24	34)

8. Copy into Table 2-129 and Table 2-130 the peak-to-peak frequency response error for the appropriate input attenuation setting from the Comms Frequency Response Performance Test for both the 800 MHz

59. Comms Absolute Power Accuracy (Options BAC or BAH)

- to 1 GHz Cellular Band, and the 1.7 GHz to 2 GHz PCS Band measured in a 10 kHz resolution bandwidth with the preamplifier off.
- 9. For each Nominal Input Amplitude setting listed in Table 2-129, add the values for the 50 MHz Amplitude Accuracy (Column 2), the peak-to-peak response (Column 4), and the uncertainty (Column 5). Record the sum as the cdmaOne Receive Channel Power Accuracy (Column 6). Repeat this step for Table 2-130.
- 10.Record the worst-case cdmaOne Receive Channel Power Accuracy Result from Table 2-129 (Cellular band) in the test record as test record entry number 21.
- 11.Record the worst-case cdmaOne Receive Channel Power Accuracy Result from Table 2-130 (PCS band) in the test record as test record entry number 22.
- 12.If the analyzer has Option 1DS (preamplifier) installed, continue with Part 3. If the analyzer does not have Option 1DS, this test procedure is completed.

Part 3: cdmaOne Receive Channel Power (Preamplifier On)

This procedure applies only to analyzers with Option 1DS (preamplifier) installed.

Table 2-131 lists the reference level, input attenuation, and nominal input level for the analyzer, and nominal attenuation for the calibrated 1 dB and 10 dB step attenuators for the amplitude accuracy measurements.

Table 2-131 cdmaOne Receive Channel Power Preamp On (Option BAC)

Nominal Input Amplitude (dBm)	Reference Level (dBm)	Resolution Bandwidth (kHz)	Input Attenuation (dB)	1 dB Step Attenuator (dB)	10 dB Step Attenuator (dB)	Source Nominal Level (dBm)
-40	-20	10	0	0	40	0
-40	-40	10	0	0	40	0
-60	-40	10	0	0	60	0
-60	-60	10	0	0	60	0
-70	-50	10	0	0	70	0
-70	-70	10	0	0	70	0
-80	-60	10	0	0	80	0
-80	-80	10	0	0	80	0
-90	-70	10	0	0	90	0
-90	-90	10	0	0	90	0
-100	-80	10	0	0	100	0
-100	-100	10	0	0	100	0

- 1. Set the 10 dB step attenuator to 40 dB and the 1 dB step attenuator to 0 dB.
- 2. Obtain the actual attenuation for the 0 dB setting of each attenuator at 50 MHz from the metrology data for the step attenuators. In some cases this value might be zero, by definition. Add the two actual attenuations to obtain the 0 dB reference attenuation.

$$RefAtten_{40dB} = 10 dB Actual_{40dB} + 1 dB Actual_{0dB}$$

For example, if the actual attenuation for the 10 dB step attenuator at the 0 dB setting is 40.03 dB, then 10 dB Actual $_{40dB}$ is 40.03 dB. If the actual attenuation for the 1 dB step attenuator at the 0 dB setting is 0.02 dB, then 1 dB Actual $_{0dB}$ is 0.02 dB. In this case RefAtten $_{40dB}$ is 40.05 dB.

3. Obtain the metrology data for the step attenuators at 50 MHz.

59. Comms Absolute Power Accuracy (Options BAC or BAH)

4. Calculate the actual total attenuation by adding the actual attenuation for the 1 dB step attenuator to the actual attenuation for the 10 dB step attenuator for each total attenuation setting listed in Table 2-132.

NOTE

The external attenuators and cables are now part of the "source."

Table 2-132 Amplitude Accuracy Worksheet

1 dB Atten	_	10 dB Atten	_	To Attent		Ref Level	Nominal Input	Meas Amptd	Amptd Accy
Setting	Actual	Setting	Actual	Setting	Actual		Amptd	Amptu	
0 dB		40 dB		40 dB		-20 dBm	-40 dBm		
0 dB		40 dB		40 dB		-40 dBm	-40 dBm		
0 dB		60 dB		60 dB		-40 dBm	-60 dBm		
0 dB		60 dB		60 dB		-60 dBm	-60 dBm		
0 dB		70 dB		70 dB		–50 dBm	-70 dBm		
0 dB		70 dB		70 dB		-70 dBm	-70 dBm		
0 dB		80 dB		80 dB		-60 dBm	-80 dBm		
0 dB		80 dB		80 dB		-80 dBm	-80 dBm		
0 dB		90 dB		90 dB		-70 dBm	-90 dBm		
0 dB		90 dB		90 dB		-90 dBm	-90 dBm		
0 dB		100 dB		100 dB		-80 dBm	-100 dBm		
0 dB		100 dB		100 dB		-100 dBm	-100 dBm		

5. Set the analyzer as follows:

FREQUENCY, Center Freq, 50 MHz SPAN, 0 kHz BW/Avg, Res BW, 10 kHz BW/Avg, Video BW, 10 kHz AMPLITUDE, More, Y-Axis Units (or Amptd Units), dBm AMPLITUDE, Ref Level, $-20\ dBm$ AMPLITUDE, Attenuation, 0 dB AMPLITUDE, More, Int Preamp On

- 6. Perform the following steps for each of the "Nominal Input Amplitude" values listed in Table 2-131.
 - a. Set the 1 dB step attenuator as indicated.
 - b. Set the 10 dB step attenuator as indicated.
 - c. Set the analyzer reference level as indicated.
 - d. Set the analyzer input attenuation as indicated.
 - e. Press Single and wait for the sweep to finish.

- f. Press **Peak Search** (or **Search**). The marker can still make a valid measurement, even though the signal may be slightly above the reference level for the first nominal amplitude setting.
- g. Record the marker (Mkr1) amplitude value as the Measured Amplitude in Table 2-132.
- h. Calculate the amplitude accuracy as follows:

Amplitude Accuracy =

Measured Amplitude – $(Amptd_{0dB} - ActualTotalAtten + RefAtten_{0dB}) + 40dB$

- 7. Table 2-132 has two Amplitude Accuracy entries for each nominal input amplitude setting. For each of the nominal input amplitude setting pairs in Table 2-132, record the worst of the two Amplitude Accuracy values in Table 2-133 and Table 2-134 as the 50 MHz Amplitude Accuracy for the same Nominal Input Amplitude setting.
- 8. Copy into Table 2-133 and Table 2-134 the peak-to-peak frequency response error for the appropriate input attenuation setting from the Comms Frequency Response Performance Test for both the 800 MHz to 1 GHz Cellular Band, and the 1.7 GHz to 2 GHz PCS Band measured in a 10 kHz resolution bandwidth with the preamplifier on.
- 9. For each Nominal Input Amplitude setting listed in Table 2-133, add the values for the 50 MHz Amplitude Accuracy (Column 2), the peak-to-peak response (Column 4), and the uncertainty (Column 5). Record the sum as the cdmaOne Receive Channel Power Accuracy, Preamp On (Column 6). Repeat this step for Table 2-134.
- 10.Record the cdmaOne Receive Channel Power Accuracy, Preamplifier On Results from Table 2-133 and Table 2-134 into the test record as indicated by the test record entry in parenthesis.
- 11. This test procedure is now complete.

Table 2-133 cdmaOne Receive Channel Power (Cellular Band) Preamp On

Nominal Input Amplitude (dBm)	50 MHz Amplitude Accuracy (dB)	Input Attenuation (dB)	Peak to Peak Response (1.7 GHz to 2 GHz) (dB)	Uncertainty (dB)	cdmaOne Receive Channel Power Accuracy, Preamp On Columns 2+4+5 (dB)
-40		0		0.24	35)
-60		0		0.24	36)
-70		0		0.24	37)
-80		0		0.24	38)

Table 2-133 cdmaOne Receive Channel Power (Cellular Band) Preamp On

Nominal Input Amplitude	50 MHz Amplitude Accuracy	Input Attenuation	Peak to Peak Response (1.7 GHz to 2 GHz)	Uncertainty	cdmaOne Receive Channel Power Accuracy, Preamp On
(dBm)	(dB)	(dB)	(dB)	(dB)	Columns 2+4+5 (dB)
-90		0		0.24	39)
-100		0		0.24	40)

Table 2-134 cdmaOne Receive Channel Power (PCS Band) Preamp On

Nominal Input Amplitude (dBm)	50 MHz Amplitude Accuracy (dB)	Input Attenuation (dB)	Peak to Peak Response (1.7 GHz to 2 GHz) (dB)	Uncertainty (dB)	cdmaOne Receive Channel Power Accuracy, Preamp On Columns 2+4+5 (dB)
-40		0		0.24	41)
-60		0		0.24	42)
-70		0		0.24	43)
-80		0		0.24	44)
-90		0		0.24	45)
-100		0		0.24	46)

Performance Verification Test Records

Agilent E4401B Performance Verification Test Record

Tests for the Agilent E4401B only are included in this test record, therefore not all test numbers are included.

Table 3-1 Agilent E4401B Performance Verification Test Record

Agilent Technologies			
Address:		Report No	
		Date	
Model E4401B			
Serial No		Ambient temperature _	° C
Options		Relative humidity	%
Firmware Revision		Power mains line freque (nominal)	ency Hz
Customer		Tested by	
Test Equipment Used:			
Description	Model No.	Trace No.	Cal Due Date
Synthesized Signal Generator			
Synthesized Sweeper			
Function Generator			
Power Meter, Dual-Channel			
RF Power Sensor #1			
RF Power Sensor #2 50 Ω Input (No Option 1DP)			
Low-Power Power Sensor			
75 Ω Power Sensor (Option 1DP only)			
Digital Multimeter			
Universal Counter			
Frequency Standard			
Power Splitter			

Table 3-1 Agilent E4401B Performance Verification Test Record

$50~\Omega$ Termination			
Minimum Loss Pad (Option 1DP only)			
1 dB Step Attenuator			
10 dB Step Attenuator			
Oscilloscope (Option 1D6 only)			
Microwave Spectrum Analyzer (Option 1DN or 1DQ only)			
Notes/comments:			

Table 3-2 Agilent E4401B Performance Verification Test Record

Agilent Technologies Model E4401B Serial No					
		Report No			
			Date		
Test Description Min		Minimum	Results Measured Maximum		Measurement Uncertainty
1.	10 MHz Reference Output Accuracy (Non-Option 1D5 only)				
	Settability	–5.0 Hz	(1)	5.0 Hz	±293.3 μHz
2.	10 MHz High-Stability Frequency Reference Output Accuracy (Option 1D5 only)				
	5 Minute Warm-Up Error	-0.1 ppm	(1)	0.1 ppm	±0.000072 ppm
	15 Minute Warm-Up Error	-0.01 ppm	(2)	0.01 ppm	±0.000070 ppm
3.	Frequency Readout and Marker Frequency Count Accuracy				
	Frequency Readout Accuracy				
	Center Freq Span				
	1490 MHz 20 MHz	1489.83 MHz	(1)	1490.17 MHz	±0 Hz

Chapter 3 429

Table 3-2 Agilent E4401B Performance Verification Test Record

Agil	ent Technologies				
Model E4401B Serial No Test Description Minimum		Report No			
		Date			
		Results Measured	Maximum	Measurement Uncertainty	
	1490 MHz 10 MHz	1489.91 MHz	(2)	1490.09 MHz	±0 Hz
	1490 MHz 1 MHz	1489.991 MHz	(3)	1490.009 MHz	±0 Hz
	Marker Count Accuracy				
	Center Freq Span				
	1490 MHz 10 MHz	1489.999999 MHz	(4)	1490.000001 MHz	±0 Hz
	1490 MHz 1 MHz	1489.999999 MHz	(5)	1490.000001 MHz	±0 Hz
5.	Frequency Span Accuracy				
	Span Start Freq				
	1500 MHz 0 Hz	1185 MHz	(1)	1215 MHz	±3.06 MHz
	100 MHz 10 MHz	79 MHz	(2)	81 MHz	±204 kHz
	100 kHz 10 MHz	79 kHz	(3)	81 kHz	±204 Hz
	100 MHz 800 MHz	79 MHz	(4)	81 MHz	±204 kHz
	100 kHz 800 MHz	79 kHz	(5)	81 kHz	±204 Hz
	100 MHz 1400 MHz	79 MHz	(6)	81 MHz	±204 kHz
	100 kHz 1499 MHz	79 kHz	(7)	81 kHz	±204 Hz
7.	Noise Sidebands				
	Offset from 1 GHz signal				
	10 kHz		(1)	-93 dBc/Hz	±2.44 dB
	20 kHz		(2)	-100 dBc/Hz	±2.44 dB
	30 kHz		(3)	-104 dBc/Hz	±2.44 dB
	100 kHz		(4)	-113 dBc/Hz	±2.44 dB
9.	System-Related Sidebands				

Table 3-2 Agilent E4401B Performance Verification Test Record

Agil	ent Technologies				
Model E4401B Serial No		Report No			
		Date			
Test	Description	Minimum	Results Measured Maxim		Measurement Uncertainty
	Offset from 500 MHz signal				
	30 kHz to 230 kHz		(1)	-65 dBc	±1.3 dB
	–30 kHz to –230 kHz		(2)	-65 dBc	±1.3 dB
10.	Residual FM				
	1 kHz Res BW, (Non-Option 1D5)		(1)	150 Hz	±21 Hz
	1 kHz Res BW, (Option 1D5)		(1)	100 Hz	±21 Hz
	10 Hz Res BW (Options 1DR and 1D5 only)		(2)	2 Hz	±0.27 Hz
11.	Sweep Time Accuracy				
	Sweep Time				
	5 ms	-1.0%	(1)	±1.0%	±0.16%
	20 ms	-1.0%	(2)	±1.0%	±0.16%
	100 ms	-1.0%	(3)	±1.0%	±0.16%
	1 s	-1.0%	(4)	±1.0%	±0.16%
	10 s	-1.0%	(5)	±1.0%	±0.16%
	1 ms (Option AYX only)	-1.0%	(6)	±1.0%	±0.16%
	500 μs (Option AYX only)	-1.0%	(7)	±1.0%	±0.16%
	100 μs (Option AYX only)	-1.0%	(8)	±1.0%	±0.16%
12.	Display Scale Fidelity				
	Cumulative Log Fidelity, Res BW ≥1 kHz				
	dB from Ref Level				
	-4	-0.30 dB	(1)	0.30 dB	±0.082 dB
	-8	-0.30 dB	(2)	0.30 dB	±0.078 dB

Chapter 3 431

Table 3-2 Agilent E4401B Performance Verification Test Record

Agilent Technologies				
Model E4401B Serial No		Report No.		
		Date		
Test Description Minimum		Results Measured	Maximum	Measurement Uncertainty
-12	-0.40 dB	(3)	0.40 dB	±0.075 dB
-16	-0.40 dB	(4)	0.40 dB	±0.073 dB
-20	-0.40 dB	(5)	0.40 dB	±0.078 dB
-24	-0.50 dB	(6)	0.50 dB	±0.074 dB
-28	-0.50 dB	(7)	0.50 dB	±0.073 dB
-32	-0.60 dB	(8)	0.60 dB	±0.077 dB
-36	-0.60 dB	(9)	0.60 dB	±0.075 dB
-40	-0.60 dB	(10)	0.60 dB	±0.081 dB
-44	-0.70 dB	(11)	0.70 dB	±0.077 dB
-48	-0.70 dB	(12)	0.70 dB	±0.076 dB
-52	-0.70dB	(13)	0.70 dB	±0.080 dB
-56	-0.70 dB	(14)	0.70 dB	±0.078 dB
-60	-0.70 dB	(15)	0.70 dB	±0.084 dB
-64	-0.80 dB	(16)	0.80 dB	±0.081 dB
-68	-0.80 dB	(17)	0.80 dB	±0.080 dB
-72	-0.80 dB	(18)	0.80 dB	±0.084 dB
-76	-0.80 dB	(19)	0.80 dB	±0.083 dB
-80	-0.80 dB	(20)	0.80 dB	±0.089 dB
-84	-1.15 dB	(21)	1.15 dB	±0.086 dB
Incremental Log Fidelity, Res BW ≥1 kHz				
dB from Ref Level				
-4	-0.4 dB	(22)	0.4 dB	±0.082 dB
-8	-0.4 dB	(23)	0.4 dB	±0.078 dB
-12	-0.4 dB	(24)	0.4 dB	±0.075 dB
-16	-0.4 dB	(25)	0.4 dB	±0.073 dB

Table 3-2 Agilent E4401B Performance Verification Test Record

Agilent Technologies				
Model E4401B		Report No		
Serial No		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
-20	-0.4 dB	(26)	0.4 dB	±0.078 dB
-24	-0.4 dB	(27)	0.4 dB	±0.074 dB
-28	-0.4 dB	(28)	0.4 dB	±0.073 dB
-32	-0.4 dB	(29)	0.4 dB	±0.077 dB
-36	-0.4 dB	(30)	0.4 dB	±0.075 dB
-40	-0.4 dB	(31)	0.4 dB	±0.081 dB
_44	-0.4 dB	(32)	0.4 dB	±0.077 dB
-48	-0.4 dB	(33)	0.4 dB	±0.076 dB
-52	-0.4 dB	(34)	0.4 dB	±0.080 dB
-56	-0.4 dB	(35)	0.4 dB	±0.078 dB
-60	-0.4 dB	(36)	0.4 dB	±0.084 dB
-64	-0.4 dB	(37)	0.4 dB	±0.081 dB
-68	-0.4 dB	(38)	0.4 dB	±0.080 dB
-72	-0.4 dB	(39)	0.4 dB	±0.084 dB
-76	-0.4 dB	(40)	0.4 dB	±0.083 dB
-80	-0.4 dB	(41)	0.4 dB	±0.089 dB
Cumulative Log Fidelity, Res BW ≤300 Hz (Option 1DR only) dB from Ref Level				
-4	-0.34 dB	(43)	0.34 dB	±0.082 dB
_8	-0.38 dB	(44)	0.38 dB	±0.078 dB
-12	-0.42 dB	(45)	0.42 dB	±0.075 dB
-16	-0.46 dB	(46)	0.46 dB	±0.073 dB
-20	-0.50 dB	(47)	0.50 dB	±0.078 dB

Table 3-2 Agilent E4401B Performance Verification Test Record

Agilent Technologies						
Mod	lel E4401B		Report No			
Seri	al No		Date			
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
	-24	-0.54 dB	(48)	0.54 dB	±0.074 dB	
	-28	-0.58 dB	(49)	0.58 dB	±0.073 dB	
	-32	-0.62 dB	(50)	0.62 dB	±0.077 dB	
	-36	-0.66 dB	(51)	0.66 dB	±0.075 dB	
	-40	-0.70 dB	(52)	0.70 dB	±0.081 dB	
	-44	-0.74 dB	(53)	0.74 dB	±0.077 dB	
	-48	-0.78 dB	(54)	0.78 dB	±0.076 dB	
	-52	-0.82 dB	(55)	0.82 dB	±0.080 dB	
	-56	-0.86 dB	(56)	0.86 dB	±0.078 dB	
	-60	-0.90 dB	(57)	0.90 dB	±0.084 dB	
	-64	-0.94 dB	(58)	0.94 dB	±0.081 dB	
	-68	-0.98 dB	(59)	0.98 dB	±0.080 dB	
	-72	-1.02 dB	(60)	1.02 dB	±0.084 dB	
	-76	-1.06 dB	(61)	1.06 dB	±0.083 dB	
	-80	-1.10 dB	(62)	1.10 dB	±0.089 dB	
	-84	-1.14 dB	(63)	1.14 dB	±0.086 dB	
	-88	-1.18 dB	(64)	1.18 dB	±0.085 dB	
	-92	-1.22 dB	(65)	1.22 dB	±0.100 dB	
	-96	-1.26 dB	(66)	1.26 dB	±0.099 dB	
	-98	-1.28 dB	(67)	1.28 dB	±0.098 dB	
	Incremental Log Fidelity, Res BW ≤300 Hz (Option 1DR only)					
	dB from Ref Level					
	_4	-0.4 dB	(68)	0.4 dB	±0.082 dB	
	-8	-0.4 dB	(69)	0.4 dB	±0.078 dB	

Table 3-2 Agilent E4401B Performance Verification Test Record

Agil	ent Technologies				
Mod	lel E4401B		Report No		
Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	-12	-0.4 dB	(70)	0.4 dB	±0.075 dB
	-16	-0.4 dB	(71)	0.4 dB	±0.073 dB
	-20	-0.4 dB	(72)	0.4 dB	±0.078 dB
	-24	-0.4 dB	(73)	0.4 dB	±0.074 dB
	-28	-0.4 dB	(74)	0.4 dB	±0.073 dB
	-32	-0.4 dB	(75)	0.4 dB	±0.077 dB
	-36	-0.4 dB	(76)	0.4 dB	±0.075 dB
	-40	-0.4 dB	(77)	0.4 dB	±0.081 dB
	-44	-0.4 dB	(78)	0.4 dB	±0.077 dB
	-48	-0.4 dB	(79)	0.4 dB	±0.076 dB
	-52	-0.4 dB	(80)	0.4 dB	±0.080 dB
	-56	-0.4 dB	(81)	0.4 dB	±0.078 dB
	-60	-0.4 dB	(82)	0.4 dB	±0.084 dB
	-64	-0.4 dB	(83)	0.4 dB	±0.081 dB
	-68	-0.4 dB	(84)	0.4 dB	±0.080 dB
	-72	-0.4 dB	(85)	0.4 dB	±0.084 dB
	-76	-0.4 dB	(86)	0.4 dB	±0.083 dB
	-80	-0.4 dB	(87)	0.4 dB	±0.089 dB
	Linear Fidelity, Res BW ≥1 kHz				
	dB from Ref Level				
	-4	-2.0%	(93)	2.0%	±0.064%
	-8	-2.0%	(94)	2.0%	±0.064%
	-12	-2.0%	(95)	2.0%	±0.064%
	-16	-2.0%	(96)	2.0%	±0.064%

Table 3-2 Agilent E4401B Performance Verification Test Record

Agilent Technologies				
Model E4401B		Report No		
Serial No		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
-20	-2.0%	(97)	2.0%	±0.063%
Linear Fidelity, Res BW ≤300 Hz (Option 1DR only)				
dB from Ref Level				
-4	-2.0%	(98)	2.0%	±0.064%
-8	-2.0%	(99)	2.0%	±0.064%
-12	-2.0%	(100)	2.0%	±0.064%
-16	-2.0%	(101)	2.0%	±0.064%
-20	-2.0%	(102)	2.0%	±0.063%
Zero Span, Res BW ≤300 Hz (Option 1DR only)				
dB from Ref Level				
-4	-0.36 dB	(103)	$0.36~\mathrm{dB}$	±0.082 dB
-8	-0.42 dB	(104)	$0.42~\mathrm{dB}$	±0.078 dB
-12	-0.48 dB	(105)	0.48 dB	±0.075 dB
-16	-0.54 dB	(106)	$0.54~\mathrm{dB}$	±0.073 dB
-20	-0.60 dB	(107)	0.60 dB	±0.078 dB
-24	-0.66 dB	(108)	0.66 dB	±0.074 dB
-28	-0.72 dB	(109)	$0.72~\mathrm{dB}$	±0.073 dB
-32	-0.78 dB	(110)	0.78 dB	±0.077 dB
-36	-0.84 dB	(111)	0.84 dB	±0.075 dB
-40	-0.90 dB	(112)	0.90 dB	±0.081 dB
-44	-0.96 dB	(113)	0.96 dB	±0.077 dB
-48	-1.02 dB	(114)	1.02 dB	±0.076 dB
-52	-1.08 dB	(115)	1.08 dB	±0.080 dB

Table 3-2 Agilent E4401B Performance Verification Test Record

Agil	ent Technologies				
Mod	lel E4401B		Report No		
Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	-56	-1.14 dB	(116)	1.14 dB	±0.078 dB
	-60	-1.20 dB	(117)	1.20 dB	±0.084 dB
	-64	-1.5 dB	(118)	1.5 dB	±0.081 dB
	-68	-1.5 dB	(119)	1.5 dB	±0.080 dB
	- 70	-1.5 dB	(120)	1.5 dB	±0.084 dB
13.	Input Attenuation Switching Uncertainty				
	Input Attenuation Setting				
	0 dB	-0.3 dB	(1)	0.3 dB	±0.101 dB
	5 dB	-0.3 dB	(2)	0.3 dB	±0.104 dB
	15 dB	-0.3 dB	(3)	0.3 dB	±0.102 dB
	20 dB	-0.3 dB	(4)	0.3 dB	±0.098 dB
	25 dB	-0.35 dB	(5)	0.35 dB	±0.098 dB
	30 dB	-0.40 dB	(6)	0.40 dB	±0.096 dB
	35 dB	-0.45 dB	(7)	0.45 dB	±0.099 dB
	40 dB	-0.50 dB	(8)	0.50 dB	±0.096 dB
	45 dB	-0.55 dB	(9)	0.55 dB	±0.099 dB
	50 dB	-0.60 dB	(10)	0.60 dB	±0.095 dB
	55 dB	-0.65 dB	(11)	0.65 dB	±0.099 dB
	60 dB	-0.70 dB	(12)	0.70 dB	±0.100 dB
14.	Reference Level Accuracy				
	Log, Res BW ≥1 kHz				
	Reference Level				
	$50 \Omega (dBm) 75 \Omega (dBmV)$				
	-15 33.75	-0.3 dB	(1)	0.3 dB	±0.091 dB

Table 3-2 Agilent E4401B Performance Verification Test Record

Agilent Technol	ogies				
Model E4401B			Report No.		
Serial No.			Date	_	
Test Description	1	Minimum	Results Measured	Maximum	Measurement Uncertainty
-5	43.75	-0.3 dB	(2)	0.3 dB	±0.100 dB
-35	13.75	-0.3 dB	(3)	0.3 dB	±0.092 dB
-45	3.75	-0.3 dB	(4)	0.3 dB	±0.094 dB
-55	-6.25	-0.5 dB	(5)	0.5 dB	±0.095 dB
-65	-16.25	-0.5 dB	(6)	0.5 dB	±0.097 dB
-75	-26.25	-0.7 dB	(7)	0.7 dB	±0.099 dB
Linear, Res I	BW ≤300 Hz				
Reference	Level				
$50~\Omega~(dBm)$	$75~\Omega~(dBmV)$				
-15	33.75	-0.3 dB	(8)	0.3 dB	±0.091 dB
-5	43.75	-0.3 dB	(9)	0.3 dB	±0.100 dB
-35	13.75	-0.3 dB	(10)	0.3 dB	±0.092 dB
-45	3.75	-0.3 dB	(11)	0.3 dB	±0.094 dB
-55	-6.25	-0.5 dB	(12)	0.5 dB	±0.095 dB
-65	-16.25	-0.5 dB	(13)	0.5 dB	±0.097 dB
-75	-26.25	-0.7 dB	(14)	0.7 dB	±0.099 dB
Log, Res BW (Option 1DR					
Reference	Level				
50 Ω (dBm)	$75~\Omega~(dBmV)$				
-15	33.75	-0.3 dB	(15)	0.3 dB	±0.091 dB
-5	43.75	-0.3 dB	(16)	0.3 dB	±0.100 dB
-35	13.75	-0.3 dB	(17)	0.3 dB	±0.092 dB
-45	3.75	-0.3 dB	(18)	0.3 dB	±0.094 dB
– 55	-6.25	-0.5 dB	(19)	0.5 dB	±0.095 dB
-65	-16.25	-0.5 dB	(20)	0.5 dB	±0.097 dB

Table 3-2 Agilent E4401B Performance Verification Test Record

Agil	ent Technolo	ogies				
Mod	lel E4401B			Report No		
Seri	al No			Date		
Test	Description	ı	Minimum	Results Measured	Maximum	Measurement Uncertainty
	-75	-26.25	-0.7 dB	(21)	0.7 dB	±0.099 dB
	Linear, Res E (Option 1DR					
	Reference	Level				
	$50~\Omega~(dBm)$	$75~\Omega~(dBmV)$				
	-15	33.75	-0.3 dB	(22)	0.3 dB	±0.091 dB
	-5	43.75	-0.3 dB	(23)	0.3 dB	±0.100 dB
	-35	13.75	-0.3 dB	(24)	0.3 dB	±0.092 dB
	-45	3.75	-0.3 dB	(25)	0.3 dB	±0.094 dB
	-55	-6.25	-0.5 dB	(26)	0.5 dB	±0.095 dB
	-65	-16.25	-0.5 dB	(27)	0.5 dB	±0.097 dB
	- 75	-26.25	-0.7 dB	(28)	0.7 dB	±0.099 dB
16.	Resolution Switching U					
	Resolution B	andwidth				
	3 kHz		-0.3 dB	(1)	0.3 dB	±0.048 dB
	9 kHz		-0.3 dB	(2)	0.3 dB	±0.048 dB
	10 kHz		-0.3 dB	(3)	0.3 dB	±0.048 dB
	30 kHz		-0.3 dB	(4)	0.3 dB	±0.048 dB
	100 kHz		-0.3 dB	(5)	0.3 dB	±0.048 dB
	$120~\mathrm{kHz}$		-0.3 dB	(6)	0.3 dB	±0.048 dB
	$300~\mathrm{kHz}$		-0.3 dB	(7)	0.3 dB	±0.048 dB
	1 MHz		-0.3 dB	(8)	0.3 dB	±0.048 dB
	3 MHz		-0.3 dB	(9)	0.3 dB	±0.048 dB
	5 MHz		-0.6 dB	(10)	0.6 dB	±0.076 dB
	300 Hz (Opti	ion 1DR only)	-0.3 dB	(11)	0.3 dB	±0.048 dB

Table 3-2 Agilent E4401B Performance Verification Test Record

Agil	ent Technologies					
Mod	lel E4401B		Report No			
Seri	al No		Date			
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
	200 Hz (Option 1DR only)	-0.3 dB	(12)	0.3 dB	±0.048 dB	
	100 Hz (Option 1DR only)	-0.3 dB	(13)	0.3 dB	±0.048 dB	
	30 Hz (Option 1DR only)	-0.3 dB	(14)	0.3 dB	±0.048 dB	
	10 Hz (Option 1DR only)	-0.3 dB	(15)	0.3 dB	±0.048 dB	
	3 Hz (Option 1DR and 1D5 only) Firmware Revision A.08.00 or later	-0.3 dB	(16)	0.3 dB	±0.048 dB	
	1Hz (Option 1DR and 1D5 only) Firmware Revision A.08.00 or later	-0.3 dB	(17)	0.3 dB	±0.048 dB	
17.	Absolute Amplitude Accuracy (Reference Settings)					
	Log, Preamp Off	-0.30 dB	(1)	0.30 dB	±0.09 dB	
	Lin, Preamp Off	-0.30 dB	(2)	0.30 dB	±0.09 dB	
	Log, Preamp On (Option 1DS only)	–0.37 dB	(3)	0.37 dB	±0.09 dB	
	Lin, Preamp On (Option 1DS only)	-0.37 dB	(4)	0.37 dB	±0.09 dB	
19.	Overall Absolute Amplitude Accuracy					
	0 dBm Reference Level					
	0 dBm input	-0.54 dB	(1)	0.54 dB	±0.234 dB	
	–10 dBm input	-0.54 dB	(2)	0.54 dB	±0.115 dB	
	–20 dBm input	-0.54 dB	(3)	0.54 dB	±0.110 dB	
	–30 dBm input	-0.54 dB	(4)	0.54 dB	±0.109 dB	
	–40 dBm input	-0.54 dB	(5)	0.54 dB	±0.109 dB	
	–50 dBm input	-0.54 dB	(6)	0.54 dB	±0.109 dB	
	–20 dBm Reference Level					

Table 3-2 Agilent E4401B Performance Verification Test Record

Agil	ent Technologies				
Mod	Model E4401B Serial No		Report No Date		
Seri					
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	–20 dBm input	-0.54 dB	(7)	0.54 dB	±0.109 dB
	–30 dBm input	-0.54 dB	(8)	0.54 dB	±0.109 dB
	–40 dBm input	-0.54 dB	(9)	0.54 dB	±0.109 dB
	–50 dBm input	-0.54 dB	(10)	0.54 dB	±0.109 dB
	–40 dBm Reference Level				
	–40 dBm input	-0.54 dB	(11)	0.54 dB	±0.087 dB
	–50 dBm input	-0.54 dB	(12)	0.54 dB	±0.087 dB
	–50 dBm Reference Level				
	–50 dBm input	-0.54 dB	(13)	0.54 dB	±0.087 dB
21.	Resolution Bandwidth Accuracy				
	Resolution Bandwidth				
	5 MHz	3.5 MHz	(1)	6.5 MHz	±110 kHz
	3 MHz	2.55 MHz	(2)	3.45 MHz	±66 kHz
	1 MHz	0.85 MHz	(3)	1.15 MHz	±22 kHz
	300 kHz	$255~\mathrm{kHz}$	(4)	345 kHz	±6.6 kHz
	100 kHz	85 kHz	(5)	115 kHz	±2.2 kHz
	30 kHz	25.5 kHz	(6)	34.5 kHz	±660 Hz
	10 kHz	8.5 kHz	(7)	11.5 kHz	±220 Hz
	3 kHz	$2.55~\mathrm{kHz}$	(8)	$3.45~\mathrm{kHz}$	±66 Hz
	1 kHz	850 Hz	(9)	1.15 kHz	±22 Hz
	120 kHz	96 kHz	(10)	144 kHz	±2.17 kHz
	9 kHz	7.2 kHz	(11)	10.8 kHz	±163 Hz
22.	Frequency Response				lepending upon the med and installed

Table 3-2 Agilent E4401B Performance Verification Test Record

Agilent Technologies					
Model E4401B		Report No			
Serial No		Date			
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
20 to 30° C					
50 Ω Input (Non-Option 1DP) (9 kHz to 1.5 GHz)					
Maximum Response		(1)	0.50 dB	±0.19 dB	
Minimum Response	-0.50 dB	(2)		±0.19 dB	
Peak-to-Peak Response		(3)	1.0 dB	±0.19 dB	
Option 1DP (75 Ω) Band 0 (1 MHz to 1.5 GHz)					
Maximum Response		(1)	0.50 dB	±0.11 dB	
Minimum Response	-0.50 dB	(2)		±0.11 dB	
Peak-to-Peak Response		(3)	1.0 dB	±0.11 dB	
0 to 55° C					
50 Ω Input (Non-Option 1DP) (9 kHz to 1.5 GHz)					
Maximum Response		(1)	1.0 dB	±0.19 dB	
Minimum Response	-1.0 dB	(2)		±0.19 dB	
Peak-to-Peak Response		(3)	2.0 dB	±0.19 dB	
Option 1DP (75 Ω)					
(1 MHz to 1.5 GHz)					
Maximum Response		(1)	1.0 dB	±0.11 dB	
Minimum Response	-1.0 dB	(2)		±0.11 dB	
Peak-to-Peak Response		(3)	2.0 dB	±0.11 dB	

Table 3-2 Agilent E4401B Performance Verification Test Record

Agi	lent Technologies					
Mo	del E4401B		Report No			
Ser	Serial No		Date			
Tes	t Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
25.	Frequency Response (Preamp On) (Option 1DS only)				lepending upon the med and installed	
	20 to 30° C					
	50 Ω Input (No Option 1DP) (100 kHz to 1.5 GHz)					
	Maximum Response		(1)	1.0 dB	±0.28 dB	
	Minimum Response	-1.0 dB	(2)		±0.28 dB	
	Peak-to-Peak Response		(3)	2.0 dB	±0.28 dB	
	Option 1DP (75 Ω) (1 MHz to 1.5 GHz)					
	Maximum Response		(1)	1.50 dB	±0.28 dB	
	Minimum Response	-1.50 dB	(2)		±0.28 dB	
	Peak-to-Peak Response		(3)	3.0 dB	±0.28 dB	
	0 to 55° C					
	50 Ω Input (No Option 1DP) (100 kHz to 1.5 GHz)					
	Maximum Response		(1)	1.5 dB	±0.28 dB	
	Minimum Response	-1.5 dB	(2)		±0.28 dB	
	Peak-to-Peak Response		(3)	3.0 dB	±0.28 dB	
	Option 1DP (75 Ω) (1 MHz to 1.5 GHz)					
	Maximum Response		(1)	2.0 dB	±0.28 dB	
	Minimum Response	-2.0 dB	(2)		±0.28 dB	

Table 3-2 Agilent E4401B Performance Verification Test Record

Agil	ent Technologies					
Mod	lel E4401B		Report No			
Seri	al No		Date			
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
	Peak-to-Peak Response		(3)	4.0 dB	±0.28 dB	
28.	Other Input-Related Spurious Responses					
	Input Frequency					
	542.8 MHz		(1)	-65 dBc	±0.889 dB	
	510.7 MHz		(2)	-65 dBc	±0.889 dB	
	1310.7 MHz		(3)	-45 dBc	±0.889 dB	
30.	Spurious Responses		ta in the appropriate ce and serial numbe			
	50 MHz TOI, 1 kHz RBW, 50 Ω (Serial Number less than US39440413)	10 dBm	(1)		±0.93 dB	
	50 MHz TOI, 1 kHz RBW, 50 Ω (Serial Number US39440413 or greater)	13.5 dBm	(1)		±0.93 dB	
	50 MHz TOI, 1 kHz RBW, 75 Ω	58.75 dBmV	(1)		±0.93 dB	
	50 MHz TOI, 30 Hz RBW, 50 Ω (Option 1DR only) (Serial Number less than US39440413)	10 dBm	(2)		±0.93 dB	
	50 MHz TOI, 30 Hz RBW, 50 Ω (Option 1DR only) (Serial Number US39440413 or greater)	13.5 dBm	(2)		±0.93 dB	
	50 MHz TOI, 30 Hz RBW, 75 Ω (Option 1DR only)	58.75 dBmV	(2)		±0.93 dB	
	$40~\mathrm{MHz}~\mathrm{SHI},50~\Omega$	35 dBm	(3)		±0.50 dB	
	$40~\mathrm{MHz}~\mathrm{SHI},75~\Omega$	83.75 dBmV	(3)		±0.50 dB	
33.	Gain Compression					
	Test Frequency					

Table 3-2 Agilent E4401B Performance Verification Test Record

Agil	ent Technologies				
Mod	lel E4401B		Report No		
Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	53 MHz		(1)	1.0 dB	±0.123 dB
	50.004 MHz (Option 1DR only)		(2)	1.0 dB	±0.123 dB
	1403 MHz		(3)	1.0 dB	±0.123 dB
35.	Displayed Average Noise Level		ta in the appropriate ce and serial numbe		
	50Ω , 1 kHz RBW, Preamp Off				
	400 kHz		(1)	-115 dBm	±1.23 dB
	1 MHz to 10 MHz		(2)	-115 dBm	±1.23 dB
	10 MHz to 500 MHz		(3)	-119 dBm	±1.23 dB
	500 MHz to 1 GHz		(4)	-117 dBm	±1.23 dB
	1 GHz to 1.5 GHz		(5)	-114 dBm	±1.23 dB
	50 Ω, 1 kHz RBW, Preamp On				
	400 kHz		(6)	-131 dBm	±1.23 dB
	1 MHz to 10 MHz		(7)	-131 dBm	±1.23 dB
	10 MHz to 500 MHz		(8)	-135 dBm	±1.23 dB
	500 MHz to 1 GHz		(9)	-133 dBm	±1.23 dB
	1 GHz to 1.5 GHz		(10)	-131 dBm	±1.23 dB
	50 Ω, 10 Hz RBW, Preamp Off				
	400 kHz		(11)	-134 dBm	±1.23 dB
	1 MHz to 10 MHz		(12)	-134 dBm	±1.23 dB
	10 MHz to 500 MHz		(13)	-138 dBm	±1.23 dB
	500 MHz to 1 GHz		(14)	-136 dBm	±1.23 dB
	1 GHz to 1.5 GHz		(15)	-133 dBm	±1.23 dB

Table 3-2 Agilent E4401B Performance Verification Test Record

Agilent Technologies				
Model E4401B		Report No Date		
Serial No				
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
50 Ω, 10 Hz RBW, Preamp On				
400 kHz		(16)	-150 dBm	±1.23 dB
1 MHz to 10 MHz		(17)	-150 dBm	±1.23 dB
10 MHz to 500 MHz		(18)	-154 dBm	±1.23 dB
500 MHz to 1 GHz		(19)	-152 dBm	±1.23 dB
1 GHz to 1.5 GHz		(20)	-150 dBm	±1.23 dB
75 Ω, 1 kHz RBW, Preamp Off				
1 MHz to 10 MHz		(21)	-64 dBmV	±1.23 dB
10 MHz to 500 MHz		(22)	-66 dBmV	±1.23 dB
500 MHz to 1 GHz		(23)	-60 dBmV	±1.23 dB
1 GHz to 1.5 GHz		(24)	–56 dBmV	±1.23 dB
75 Ω, 1 kHz RBW, Preamp On:				
1 MHz to 10 MHz		(25)	-80 dBmV	±1.23 dB
10 MHz to 500 MHz		(26)	–81 dBmV	±1.23 dB
500 MHz to 1 GHz		(27)	-81 dBmV	±1.23 dB
1 GHz to 1.5 GHz		(28)	-75 dBmV	±1.23 dB
75 Ω, 10 Hz RBW, Preamp Off				
1 MHz to 10 MHz		(29)	-83 dBmV	±1.23 dB
10 MHz to 500 MHz		(30)	-85 dBmV	±1.23 dB
500 MHz to 1 GHz		(31)	-79 dBmV	±1.23 dB
1 GHz to 1.5 GHz		(32)	-75 dBmV	±1.23 dB
75 Ω, 10 Hz RBW, Preamp On:				

Table 3-2 Agilent E4401B Performance Verification Test Record

Agi	lent Technologies				
Mod	del E4401B		Report No		
Ser	ial No		Date		
Test	t Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	1 MHz to 10 MHz		(33)	-99 dBmV	±1.23 dB
	10 MHz to 500 MHz		(34)	-100 dBmV	±1.23 dB
	500 MHz to 1 GHz		(35)	-100 dBmV	±1.23 dB
	1 GHz to 1.5 GHz		(36)	−94 dBmV	±1.23 dB
39.	Residual Responses	Note: Enter data in the appropriate section below depending upon the input impedance and serial number of the analyzer.			
	50 Ω, 150 kHz to 1.5 GHz		(1)	-90 dBm	±0.87 dB
	75 Ω, 1 MHz to 1.5 GHz		(1)	-36 dBmV	±0.87 dB
40.	Fast Time Domain Amplitude Accuracy (Option AYX only)				
	Amplitude Error	-0.3%	(1)	0.3%	±0.029%
41.	Tracking Generator Absolute Amplitude and Vernier Accuracy		ta in the appropriate ce and serial number		
	(Option 1DN or Option 1DQ only)				
	Absolute Amplitude Accuracy	-0.5 dB	(1)	0.5 dB	±0.096 dB
	Positive Vernier Accuracy		(2)	0.75 dB	±0.008 dB
	Negative Vernier Accuracy	-0.75 dB	(3)		±0.008 dB
	Power Sweep Accuracy		(4)	1.5 dB	±0.008 dB
	75 Ω (Option 1DQ)				
	Absolute Amplitude Accuracy	–1.5 dB	(1)	1.5 dB	±0.096 dB
	Positive Vernier Accuracy		(2)	0.9 dB	±0.008 dB
	Negative Vernier Accuracy	-0.9 dB	(3)		±0.008 dB

Table 3-2 Agilent E4401B Performance Verification Test Record

Agil	ent Technologies				
Mod	lel E4401B		Report No		
Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	Power Sweep Accuracy		(4)	1.8 dB	±0.008 dB
43.	Tracking Generator Level Flatness		ta in the appropriate ce of the analyzer.	e section below de	epending upon the
	(Option 1DN or Option 1DQ only)				
	Positive Level Flatness, <1 MHz		(1)	2.0 dB	±0.73 dB
	Negative Level Flatness, <1 MHz	-2.0 dB	(2)		±0.73 dB
	Positive Level Flatness, 1 MHz to 10 MHz		(3)	2.0 dB	±0.190 dB
	Negative Level Flatness, 1 MHz to 10 MHz	-2.0 dB	(4)		±0.190 dB
	Positive Level Flatness, >10 MHz		(5)	1.5 dB	±0.190 dB
	Negative Level Flatness, >10 MHz	-1.5 dB	(6)		±0.190 dB
	75 Ω (Option 1DQ)				
	Positive Level Flatness, 1 MHz to 10 MHz		(3)	2.5 dB	±0.190 dB
	Negative Level Flatness, 1 MHz to 10 MHz	-2.5 dB	(4)		±0.190 dB
	Positive Level Flatness, >10 MHz		(5)	2.0 dB	±0.190 dB
	Negative Level Flatness, >10 MHz	-2.0 dB	(6)		±0.190 dB
45.	Tracking Generator Harmonic Spurious Outputs (Option 1DN or Option 1DQ only)				
	2 nd Harmonic, <20 MHz		(1)	-20 dBc	±2.6 dB

Table 3-2 Agilent E4401B Performance Verification Test Record

Agilent Technologies					
Mod	lel E4401B		Report No		
Seri	Serial No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	2 nd Harmonic, ≥20 MHz		(2)	-25 dBc	±2.6 dB
	3 rd Harmonic, <20 MHz		(3)	-20 dBc	±2.6 dB
	3 rd Harmonic, ≥20 MHz		(4)	–25 dBc	±2.6 dB
47.	Tracking Generator Non-Harmonic Spurious Outputs (Option 1DN or Option 1DQ only)				
	Highest Non-Harmonic Spurious Output Amplitude		(1)	–35 dBc	±2.65 dB
50.	Gate Delay Accuracy and Gate Length Accuracy (Option 1D6 only)				
	Minimum Gate Delay	499.9 ns	(1)	1.5001 μs	$\pm 549~\mathrm{ps}$
	Maximum Gate Delay	499.9 ns	(2)	1.5001 μs	±549 ps
	1 μs Gate Length	499.9 ns	(3)	1.5001 μs	$\pm 520~\mathrm{ps}$
	65 ms Gate Length	64.993 ms	(4)	65.007 ms	±647 ns
51.	Gate Mode Additional Amplitude Error (Option 1D6 only)				
	Amplitude Error	-0.2 dB	(1)	0.2 dB	±0.023 dB

Agilent E4402B Performance Verification Test Record

Tests for the Agilent E4402B only are included in this test record, therefore not all test numbers are included.

Table 3-3 Agilent E4402B Performance Verification Test Record

Agilent Technologies			
Address:		Report No	
		Date	
Model E4402B			
Serial No		Ambient temperature	e° C
Options		Relative humidity	%
Firmware Revision		Power mains line free (nominal)	quency Hz
Customer		Tested by	
Test Equipment Used:			
Description	Model No.	Trace No.	Cal Due Date
Synthesized Signal Generator			
Wide Offset Phase Noise Signal Generator			
Synthesized Sweeper			
Function Generator			
Power Meter, Dual-Channel			
RF Power Sensor #1			
RF Power Sensor #2			
Low-Power Power Sensor			
Digital Multimeter			
Universal Counter			
Frequency Standard			
Power Splitter			
50 Ω Termination			
1 dB Step Attenuator			

Table 3-3 Agilent E4402B Performance Verification Test Record

10 dB Step Attenuator	 	
Oscilloscope (Option 1D6 only)	 	
Microwave Spectrum Analyzer (Option 1DN only)	 	
Notes/comments:	 	
	 ·	

Table 3-4 Agilent E4402B Performance Verification Test Record

Agil	Agilent Technologies					
Mod	el E4402B	Report No				
Seri	al No		Date			
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
1.	10 MHz Reference Output Accuracy (Non-Option 1D5 only)					
	Settability	-5.0 Hz	(1)	5.0 Hz	±293.3 μHz	
2.	10 MHz High-Stability Frequency Reference Output Accuracy (Option 1D5 only)					
	5 Minute Warm-Up Error	-0.1 ppm	(1)	0.1 ppm	±0.000072 ppm	
	15 Minute Warm-Up Error	-0.01 ppm	(2)	0.01 ppm	±0.000070 ppm	
3.	Frequency Readout and Marker Frequency Count Accuracy					
	Frequency Readout Accuracy					
	Center Freq Span					
	1500 MHz 20 MHz	1499.83 MHz	(1)	1500.17 MHz	±0 Hz	
	1500 MHz 10 MHz	1499.91 MHz	(2)	1500.09 MHz	±0 Hz	
	1500 MHz 1 MHz	1499.991 MHz	(3)	1500.009 MHz	±0 Hz	
	Marker Count Accuracy					

Table 3-4 Agilent E4402B Performance Verification Test Record

Agil	ent Technologies				
Mod	lel E4402B		Report No		
Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	Center Freq Span				
	1500 MHz 10 MHz	1499.999999 MHz	(4)	1500.000001 MHz	±0 Hz
	1500 MHz 1 MHz	1499.999999 MHz	(5)	1500.000001 MHz	±0 Hz
6.	Frequency Span Accuracy				
	Span Start Freq				
	3000 MHz 0 Hz	2370 MHz	(1)	2430 MHz	±6.12 MHz
	100 MHz 10 MHz	79 MHz	(2)	81 MHz	±204 kHz
	100 kHz 10 MHz	79 kHz	(3)	81 kHz	±204 Hz
	100 MHz 800 MHz	79 MHz	(4)	81 MHz	±204 kHz
	100 kHz 800 MHz	79 kHz	(5)	81 kHz	±204 Hz
	100 MHz 1400 MHz	79 MHz	(6)	81 MHz	±204 kHz
	100 kHz 1499 MHz	79 kHz	(7)	81 kHz	±204 Hz
7.	Noise Sidebands				
	Offset from 1 GHz signal				
	(Serial Prefix < US4510, SG4510 or MY4510)				
	10 kHz		(1)	-90 dBc/Hz	±2.44 dB
	20 kHz		(2)	-100 dBc/Hz	±2.44 dB
	30 kHz		(3)	-106 dBc/Hz	±2.44 dB
	(Serial Prefix \geq US4510, SG4510 or MY4510, Option 1DR)				
	10 kHz		(1)	-98 dBc/Hz	±2.44 dB
	20 kHz		(2)	-104 dBc/Hz	±2.44 dB
	30 kHz		(3)	–110 dBc/Hz	±2.44 dB

Table 3-4 Agilent E4402B Performance Verification Test Record

Agilent Technologies					
Mod	el E4402B		Report No.		
Seria	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	(Serial Prefix ≥ US4510, SG4510 or MY4510, Non-Option 1DR)				
	10 kHz		(1)	–90 dBc/Hz	±2.44 dB
	$20~\mathrm{kHz}$		(2)	–104 dBc/Hz	±2.44 dB
	$30~\mathrm{kHz}$		(3)	–110 dBc/Hz	±2.44 dB
8.	Noise Sidebands - Wide Offsets	Note: Enter data in the appropriate section below depending upon whether or not Option 120 (ACPR Dynamic Range Extension) is installed.			
	Non-Option 120				
	Offset from 1 GHz signal				
	$100~\mathrm{kHz}$		(1)	–118 dBc/Hz	±2.44 dB
	1 MHz		(2)	–125 dBc/Hz	±2.44 dB
	$5~\mathrm{MHz}$		(3)	–127 dBc/Hz	±2.44 dB
	10 MHz		(4)	–131 dBc/Hz	±2.44 dB
	Option 120				
	Offset from 1 GHz signal				
	$100~\mathrm{kHz}$		(1)	–118 dBc/Hz	±2.44 dB
	1 MHz		(2)	–133 dBc/Hz	±2.44 dB
	5 MHz		(3)	–135 dBc/Hz	±2.44 dB
	$10~\mathrm{MHz}$		(4)	–137 dBc/Hz	±2.44 dB
9.	System-Related Sidebands				
	Offset from 500 MHz signal				
	30 kHz to 230 kHz		(1)	-65 dBc	±1.30 dB
	–30 kHz to –230 kHz		(2)	-65 dBc	±1.30 dB
10.	Residual FM				

Table 3-4 Agilent E4402B Performance Verification Test Record

Agilent Technologies							
Mod	el E4402B		Report No				
Seri	al No		Date				
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty		
	1 kHz Res BW, (Non-Option 1D5)		(1)	150 Hz	±21 Hz		
	1 kHz Res BW, (Option 1D5)		(1)	100 Hz	±21 Hz		
	10 Hz Res BW (Options 1DR and 1D5 only)		(3)	2 Hz	±0.27 Hz		
11.	Sweep Time Accuracy						
	Sweep Time						
	5 ms	-1.0%	(1)	1.0%	±0.16%		
	20 ms	-1.0%	(2)	1.0%	±0.16%		
	100 ms	-1.0%	(3)	1.0%	±0.16%		
	1 s	-1.0%	(4)	1.0%	±0.16%		
	10 s	-1.0%	(5)	1.0%	±0.16%		
	$1 \mathrm{ms} (Option AYX or B7D \\ only)$	-1.0%	(6)	1.0%	±0.16%		
	500 µs (Option AYX or B7D only)	-1.0%	(7)	1.0%	±0.16%		
	100 µs (Option AYX or B7D only)	-1.0%	(8)	1.0%	±0.16%		
12.	Display Scale Fidelity						
	Cumulative Log Fidelity, Res BW ≥1 kHz						
	dB from Ref Level						
	-4	-0.30 dB	(1)	0.30 dB	±0.082 dB		
	-8	-0.30 dB	(2)	0.30 dB	±0.078 dB		
	-12	-0.40 dB	(3)	0.40 dB	±0.075 dB		
	-16	-0.40 dB	(4)	0.40 dB	±0.073 dB		
	-20	-0.40 dB	(5)	0.40 dB	±0.078 dB		

Table 3-4 Agilent E4402B Performance Verification Test Record

Agilent Technologies	
Model E4402B	Report No
Serial No	Date

Serial No.	Serial No Date				
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
-24	-0.50 dB	(6)	0.50 dB	±0.074 dB	
-28	-0.50 dB	(7)	0.50 dB	±0.073 dB	
-32	-0.60 dB	(8)	0.60 dB	±0.077 dB	
-36	-0.60 dB	(9)	0.60 dB	±0.075 dB	
-40	-0.60 dB	(10)	0.60 dB	±0.081 dB	
-44	-0.70 dB	(11)	0.70 dB	±0.077 dB	
-48	-0.70 dB	(12)	0.70 dB	±0.076 dB	
-52	-0.70dB	(13)	0.70 dB	±0.080 dB	
-56	-0.70 dB	(14)	0.70 dB	±0.078 dB	
-60	-0.70 dB	(15)	0.70 dB	±0.084 dB	
-64	-0.80 dB	(16)	0.80 dB	±0.081 dB	
-68	-0.80 dB	(17)	0.80 dB	±0.080 dB	
-72	-0.80 dB	(18)	0.80 dB	±0.084 dB	
-76	-0.80 dB	(19)	0.80 dB	±0.083 dB	
-80	-0.80 dB	(20)	0.80 dB	±0.089 dB	
-84	-1.15 dB	(21)	1.15 dB	±0.086 dB	
Incremental Log Fidelity, Res BW ≥1 kHz					
dB from Ref Level					
-4	-0.4 dB	(22)	0.4 dB	±0.082 dB	
-8	-0.4 dB	(23)	0.4 dB	±0.078 dB	
-12	-0.4 dB	(24)	0.4 dB	±0.075 dB	
-16	-0.4 dB	(25)	0.4 dB	±0.073 dB	
-20	-0.4 dB	(26)	0.4 dB	±0.078 dB	
-24	-0.4 dB	(27)	0.4 dB	±0.074 dB	
-28	-0.4 dB	(28)	0.4 dB	±0.073 dB	

Table 3-4 Agilent E4402B Performance Verification Test Record

Agilent Technologies			
Model E4402B	Report No		
Serial No	Date		
	,	· · · · · · · · · · · · · · · · · · ·	

Serial No		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
-32	-0.4 dB	(29)	0.4 dB	±0.077 dB
-36	-0.4 dB	(30)	0.4 dB	±0.075 dB
-40	-0.4 dB	(31)	0.4 dB	±0.081 dB
-44	-0.4 dB	(32)	0.4 dB	±0.077 dB
-48	-0.4 dB	(33)	0.4 dB	±0.076 dB
-52	-0.4 dB	(34)	0.4 dB	±0.080 dB
-56	-0.4 dB	(35)	0.4 dB	±0.078 dB
-60	-0.4 dB	(36)	0.4 dB	±0.084 dB
-64	-0.4 dB	(37)	0.4 dB	±0.081 dB
-68	-0.4 dB	(38)	0.4 dB	±0.080 dB
-72	-0.4 dB	(39)	0.4 dB	±0.084 dB
-76	-0.4 dB	(40)	0.4 dB	±0.083 dB
-80	-0.4 dB	(41)	0.4 dB	±0.089 dB
Cumulative Log Fidelity, Res BW ≤300 Hz (Option 1DR only)				
dB from Ref Level				
_4	-0.34 dB	(43)	0.34 dB	±0.082 dB
-8	-0.38 dB	(44)	0.38 dB	±0.078 dB
-12	-0.42 dB	(45)	0.42 dB	±0.075 dB
-16	-0.46 dB	(46)	0.46 dB	±0.073 dB
-20	-0.50 dB	(47)	0.50 dB	±0.078 dB
-24	-0.54 dB	(48)	0.54 dB	±0.074 dB
-28	-0.58 dB	(49)	0.58 dB	±0.073 dB
-32	-0.62 dB	(50)	0.62 dB	±0.077 dB
-36	-0.66 dB	(51)	0.66 dB	±0.075 dB

Table 3-4 Agilent E4402B Performance Verification Test Record

Agilent Technologies	
Model E4402B	Report No
Serial No	Date

Serial No	erial No Date			
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
-40	-0.70 dB	(52)	0.70 dB	±0.081 dB
-44	-0.74 dB	(53)	0.74 dB	±0.077 dB
-48	-0.78 dB	(54)	0.78 dB	±0.076 dB
-52	-0.82 dB	(55)	0.82 dB	±0.080 dB
-56	-0.86 dB	(56)	0.86 dB	±0.078 dB
-60	-0.90 dB	(57)	0.90 dB	±0.084 dB
-64	-0.94 dB	(58)	0.94 dB	±0.081 dB
-68	-0.98 dB	(59)	0.98 dB	±0.080 dB
-72	-1.02 dB	(60)	1.02 dB	±0.084 dB
-76	-1.06 dB	(61)	1.06 dB	±0.083 dB
-80	-1.10 dB	(62)	1.10 dB	±0.089 dB
-84	-1.14 dB	(63)	1.14 dB	±0.086 dB
-88	-1.18 dB	(64)	1.18 dB	±0.085 dB
-92	-1.22 dB	(65)	1.22 dB	±0.100 dB
-96	-1.26 dB	(66)	1.26 dB	±0.099 dB
-98	-1.28 dB	(67)	1.28 dB	±0.098 dB
Incremental Log Fidelity, Res BW ≤300 Hz (Option 1DR only)				
dB from Ref Level				
-4	-0.4 dB	(68)	0.4 dB	±0.082 dB
-8	-0.4 dB	(69)	0.4 dB	±0.078 dB
-12	-0.4 dB	(70)	0.4 dB	±0.075 dB
-16	-0.4 dB	(71)	0.4 dB	±0.073 dB
-20	-0.4 dB	(72)	0.4 dB	±0.078 dB
-24	-0.4 dB	(73)	0.4 dB	±0.074 dB

Table 3-4 Agilent E4402B Performance Verification Test Record

Agilent Technologies		
Model E4402B	Report No	
Serial No	Date	

Serial No.		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
-28	-0.4 dB	(74)	0.4 dB	±0.073 dB
-32	-0.4 dB	(75)	0.4 dB	±0.077 dB
-36	-0.4 dB	(76)	0.4 dB	±0.075 dB
-40	-0.4 dB	(77)	0.4 dB	±0.081 dB
-44	-0.4 dB	(78)	0.4 dB	±0.077 dB
-48	-0.4 dB	(79)	0.4 dB	±0.076 dB
-52	-0.4 dB	(80)	0.4 dB	±0.080 dB
-56	-0.4 dB	(81)	0.4 dB	±0.078 dB
-60	-0.4 dB	(82)	0.4 dB	±0.084 dB
-64	-0.4 dB	(83)	0.4 dB	±0.081 dB
-68	-0.4 dB	(84)	0.4 dB	±0.080 dB
-72	-0.4 dB	(85)	0.4 dB	±0.084 dB
-76	-0.4 dB	(86)	0.4 dB	±0.083 dB
-80	-0.4 dB	(87)	0.4 dB	±0.089 dB
Linear Fidelity, Res BW ≥1 kHz				
dB from Ref Level				
-4	-2.0%	(93)	2.0%	±0.064%
-8	-2.0%	(94)	2.0%	±0.064%
-12	-2.0%	(95)	2.0%	±0.064%
-16	-2.0%	(96)	2.0%	±0.064%
-20	-2.0%	(97)	2.0%	±0.063%
Linear Fidelity, Res BW ≤300 Hz (Option 1DR only)				
dB from Ref Level				
_4	-2.0%	(98)	2.0%	±0.064%

Table 3-4 Agilent E4402B Performance Verification Test Record

Agilent Technologies	
Model E4402B	Report No.
Serial No	Date

Seria	Serial No Date				
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	-8	-2.0%	(99)	2.0%	±0.064%
	-12	-2.0%	(100)	2.0%	±0.064%
	-16	-2.0%	(101)	2.0%	±0.064%
	-20	-2.0%	(102)	2.0%	±0.063%
	Zero Span, Res BW ≤300 Hz (Option 1DR only)				
	dB from Ref Level				
	-4	-0.36 dB	(103)	0.36 dB	±0.082 dB
	-8	-0.42 dB	(104)	0.42 dB	±0.078 dB
	-12	-0.48 dB	(105)	0.48 dB	±0.075 dB
	-16	-0.54 dB	(106)	0.54 dB	±0.073 dB
	-20	-0.60 dB	(107)	0.60 dB	±0.078 dB
	-24	-0.66 dB	(108)	0.66 dB	±0.074 dB
	-28	−0.72 dB	(109)	0.72 dB	±0.073 dB
	-32	-0.78 dB	(110)	0.78 dB	±0.077 dB
	-36	-0.84 dB	(111)	0.84 dB	±0.075 dB
	-40	-0.90 dB	(112)	0.90 dB	±0.081 dB
	-44	-0.96 dB	(113)	0.96 dB	±0.077 dB
	-48	-1.02 dB	(114)	1.02 dB	±0.076 dB
	-52	-1.08 dB	(115)	1.08 dB	±0.080 dB
	-56	-1.14 dB	(116)	1.14 dB	±0.078 dB
	-60	-1.20 dB	(117)	1.20 dB	±0.084 dB
	-64	-1.5 dB	(118)	1.5 dB	±0.081 dB
	-68	-1.5 dB	(119)	1.5 dB	±0.080 dB
	-70	-1.5 dB	(120)	1.5 dB	±0.084 dB

Table 3-4 Agilent E4402B Performance Verification Test Record

Agil	ent Technologies				
Mod	Model E4402B Report No				
Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
13.	Input Attenuation Switching Uncertainty				
	Input Attenuation Setting				
	0 dB	-0.3 dB	(1)	0.3 dB	±0.101 dB
	5 dB	-0.3 dB	(2)	0.3 dB	±0.104 dB
	15 dB	-0.3 dB	(3)	0.3 dB	±0.102 dB
	20 dB	-0.3 dB	(4)	0.3 dB	±0.098 dB
	25 dB	-0.35 dB	(5)	0.35 dB	±0.098 dB
	30 dB	-0.40 dB	(6)	0.40 dB	±0.096 dB
	35 dB	−0.45 dB	(7)	0.45 dB	±0.099 dB
	40 dB	-0.50 dB	(8)	$0.50~\mathrm{dB}$	±0.096 dB
	45 dB	−0.55 dB	(9)	$0.55~\mathrm{dB}$	±0.099 dB
	50 dB	-0.60 dB	(10)	0.60 dB	±0.095 dB
	55 dB	−0.65 dB	(11)	$0.65~\mathrm{dB}$	±0.099 dB
	60 dB	-0.70 dB	(12)	0.70 dB	±0.100 dB
	65 dB	−0.75 dB	(13)	$0.75~\mathrm{dB}$	±0.111 dB
15.	Reference Level Accuracy				
	Log, Res BW ≥1 kHz				
	Reference Level				
	-10 dBm	-0.3 dB	(1)	0.3 dB	±0.091 dB
	0 dBm	-0.3 dB	(2)	0.3 dB	±0.100 dB
	-30 dBm	-0.3 dB	(3)	0.3 dB	±0.092 dB
	–40 dBm	-0.3 dB	(4)	0.3 dB	±0.094 dB
	-50 dBm	-0.5 dB	(5)	0.5 dB	±0.095 dB
	-60 dBm	-0.5 dB	(6)	0.5 dB	±0.097 dB

Table 3-4 Agilent E4402B Performance Verification Test Record

Agilent Technologies	
Model E4402B	Report No
Serial No	Date

Serial No.		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
-70 dBm	-0.5 dB	(7)	0.5 dB	±0.099 dB
-80 dBm	-0.7 dB	(8)	0.7 dB	±0.101 dB
Linear, Res BW ≥1 kHz				
Reference Level				
-10 dBm	-0.3 dB	(9)	0.3 dB	±0.091 dB
0 dBm	-0.3 dB	(10)	0.3 dB	±0.100 dB
-30 dBm	-0.3 dB	(11)	0.3 dB	±0.092 dB
-40 dBm	-0.3 dB	(12)	0.3 dB	±0.094 dB
-50 dBm	-0.5 dB	(13)	0.5 dB	±0.095 dB
-60 dBm	-0.5 dB	(14)	0.5 dB	±0.097 dB
-70 dBm	-0.5 dB	(15)	0.5 dB	±0.099 dB
-80 dBm	-0.7 dB	(16)	0.7 dB	±0.101 dB
Log, Res BW ≤300 Hz (Option 1DR only)				
Reference Level				
-10 dBm	-0.3 dB	(17)	0.3 dB	±0.091 dB
0 dBm	-0.3 dB	(18)	0.3 dB	±0.100 dB
-30 dBm	-0.3 dB	(19)	0.3 dB	±0.092 dB
-40 dBm	-0.3 dB	(20)	0.3 dB	±0.094 dB
-50 dBm	-0.5 dB	(21)	0.5 dB	±0.095 dB
-60 dBm	-0.5 dB	(22)	0.5 dB	±0.097 dB
-70 dBm	-0.5 dB	(23)	0.5 dB	±0.099 dB
-80 dBm	-0.7 dB	(24)	0.7 dB	±0.101 dB
Linear, Res BW ≤300 Hz (Option 1DR only)				
Reference Level				

Table 3-4 Agilent E4402B Performance Verification Test Record

Agilent Technologies						
Mod	el E4402B		Report No.			
Serial No			Date			
Test Description Minimum		Results Measured	Maximum	Measurement Uncertainty		
	-10 dBm	-0.3 dB	(25)	0.3 dB	±0.091 dB	
	0 dBm	-0.3 dB	(26)	0.3 dB	±0.100 dB	
	–30 dBm	-0.3 dB	(27)	0.3 dB	±0.092 dB	
	-40 dBm	-0.3 dB	(28)	0.3 dB	±0.094 dB	
	–50 dBm	-0.5 dB	(29)	0.5 dB	±0.095 dB	
	-60 dBm	-0.5 dB	(30)	0.5 dB	±0.097 dB	
	–70 dBm	-0.5 dB	(31)	0.5 dB	±0.099 dB	
	-80 dBm	-0.7 dB	(32)	0.7 dB	±0.101 dB	
16.	Resolution Bandwidth Switching Uncertainty					
	Resolution Bandwidth					
	3 kHz	-0.3 dB	(1)	0.3 dB	±0.048 dB	
	9 kHz	-0.3 dB	(2)	0.3 dB	±0.048 dB	
	10 kHz	-0.3 dB	(3)	0.3 dB	±0.048 dB	
	30 kHz	-0.3 dB	(4)	0.3 dB	±0.048 dB	
	100 kHz	-0.3 dB	(5)	0.3 dB	±0.048 dB	
	120 kHz	-0.3 dB	(6)	0.3 dB	±0.048 dB	
	300 kHz	-0.3 dB	(7)	0.3 dB	±0.048 dB	
	1 MHz	-0.3 dB	(8)	0.3 dB	±0.048 dB	
	3 MHz	-0.3 dB	(9)	0.3 dB	±0.048 dB	
	5 MHz	-0.6 dB	(10)	0.6 dB	±0.076 dB	
	300 Hz (Option 1DR only)	-0.3 dB	(11)	0.3 dB	±0.048 dB	
	200 Hz (Option 1DR only)	-0.3 dB	(12)	0.3 dB	±0.048 dB	
	100 Hz (Option 1DR only)	-0.3 dB	(13)	0.3 dB	±0.048 dB	
	30 Hz (Option 1DR only)	-0.3 dB	(14)	0.3 dB	±0.048 dB	
	10 Hz (Option 1DR only)	-0.3 dB	(15)	0.3 dB	±0.048 dB	

Table 3-4 Agilent E4402B Performance Verification Test Record

Agilent Technologies				
Model E4402B	Report No.			
Serial No	Date			

Serial No			Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	3 Hz (Option 1DR and 1D5 only) Firmware Revision A.08.00 or later	-0.3 dB	(16)	0.3 dB	±0.048 dB
	1Hz (Option 1DR and 1D5 only) Firmware Revision A.08.00 or later	-0.3 dB	(17)	0.3 dB	±0.048 dB
18.	Absolute Amplitude Accuracy (Reference Settings)				
	Log, Preamp Off	-0.34 dB	(1)	0.34 dB	±0.09 dB
	Lin, Preamp Off	-0.34 dB	(2)	0.34 dB	±0.09 dB
	Log, Preamp On (Option 1DS only)	–0.37 dB	(3)	0.37 dB	±0.09 dB
	Lin, Preamp On (Option 1DS only)	-0.37 dB	(4)	0.37 dB	±0.09 dB
20.	Overall Absolute Amplitude Accuracy				
	0 dBm Reference Level				
	0 dBm input	−0.54 dB	(1)	0.54 dB	±0.234 dB
	–10 dBm input	−0.54 dB	(2)	0.54 dB	±0.115 dB
	–20 dBm input	−0.54 dB	(3)	0.54 dB	±0.110 dB
	–30 dBm input	-0.54 dB	(4)	0.54 dB	±0.109 dB
	–40 dBm input	-0.54 dB	(5)	0.54 dB	±0.109 dB
	–50 dBm input	-0.54 dB	(6)	0.54 dB	±0.109 dB
	–20 dBm Reference Level				
	–20 dBm input	−0.54 dB	(7)	0.54 dB	±0.109 dB
	–30 dBm input	−0.54 dB	(8)	0.54 dB	±0.109 dB
	–40 dBm input	−0.54 dB	(9)	0.54 dB	±0.109 dB
	–50 dBm input	-0.54 dB	(10)	0.54 dB	±0.109 dB

Table 3-4 Agilent E4402B Performance Verification Test Record

Agilent Technologies						
Model E4402B			Report No			
Seria	al No		Date			
Test Description		Minimum	Results Measured	Maximum	Measurement Uncertainty	
	–40 dBm Reference Level					
	–40 dBm input	-0.54 dB	(11)	$0.54~\mathrm{dB}$	±0.087 dB	
	–50 dBm input	-0.54 dB	(12)	0.54 dB	±0.087 dB	
	–50 dBm Reference Level					
	–50 dBm input	-0.54 dB	(13)	$0.54~\mathrm{dB}$	±0.087 dB	
21.	Resolution Bandwidth Accuracy					
	Resolution Bandwidth					
	5 MHz	$3.5~\mathrm{MHz}$	(1)	$6.5~\mathrm{MHz}$	$\pm 110~\mathrm{kHz}$	
	3 MHz	$2.55~\mathrm{MHz}$	(2)	$3.45~\mathrm{MHz}$	$\pm 66~\mathrm{kHz}$	
	1 MHz	0.85 MHz	(3)	$1.15~\mathrm{MHz}$	$\pm 22~\mathrm{kHz}$	
	$300~\mathrm{kHz}$	$255~\mathrm{kHz}$	(4)	$345~\mathrm{kHz}$	±6.6 kHz	
	$100~\mathrm{kHz}$	$85~\mathrm{kHz}$	(5)	$115~\mathrm{kHz}$	$\pm 2.2~\mathrm{kHz}$	
	$30~\mathrm{kHz}$	$25.5~\mathrm{kHz}$	(6)	$34.5~\mathrm{kHz}$	±660 Hz	
	10 kHz	$8.5~\mathrm{kHz}$	(7)	$11.5~\mathrm{kHz}$	±220 Hz	
	3 kHz	$2.55~\mathrm{kHz}$	(8)	$3.45~\mathrm{kHz}$	±66 Hz	
	1 kHz	850 Hz	(9)	$1.15~\mathrm{kHz}$	±22 Hz	
	$120~\mathrm{kHz}$	96 kHz	(10)	144 kHz	$\pm 2.17~\mathrm{kHz}$	
	9 kHz	$7.2~\mathrm{kHz}$	(11)	$10.8~\mathrm{kHz}$	±163 Hz	
23.	Frequency Response		ta in the appropriat mperature at which ns.			
	20 to $30^{\circ}\mathrm{C}$					
	Non-Option UKB Band 0 (9 kHz to 3.0 GHz)					
	Maximum Response		(1)	$0.46~\mathrm{dB}$	±0.19 dB	

Table 3-4 Agilent E4402B Performance Verification Test Record

Agilent Technologies	
Model E4402B	Report No
Serial No	Date

Test I	Dogovintion				
	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	Minimum Response	-0.46 dB	(2)		±0.19 dB
	Peak-to-Peak Response		(3)	0.92 dB	±0.19 dB
	Option UKB dc Coupled Band 0 (100 Hz to 3.0 GHz)				
	Maximum Response		(1)	0.50 dB	±0.19 dB
	Minimum Response	-0.50 dB	(2)		±0.19 dB
	Peak-to-Peak Response		(3)	1.0 dB	±0.19 dB
	Non-Option UKB Band 0A (800 MHz to 1.0 GHz) (serial number US39441006 or greater) Maximum Response Minimum Response Peak-to-Peak Response	-0.46 dB	(4) (5) (6)	0.46 dB 0.92 dB	±0.11 dB ±0.11 dB ±0.11 dB
	Non-Option UKB Band 0B (1.7 GHz to 2.0 GHz) (serial number US39441006 or greater)				
	Maximum Response		(7)	$0.46~\mathrm{dB}$	±0.11 dB
	Minimum Response	-0.46 dB	(8)		±0.11 dB
	Peak-to-Peak Response		(9)	$0.92~\mathrm{dB}$	±0.11 dB

Table 3-4 Agilent E4402B Performance Verification Test Record

Agilent Technologies							
Model E4402B				Report No.			
Serial No							
Test Description Minimum		Results Measured	Maximum	Measurement Uncertainty			
Option UKB ac Coupled Band 0 (100 kHz to 3.0 GHz)							
Maximum Response		(10)	0.50 dB	±0.11 dB			
Minimum Response	-0.50 dB	(11)		±0.11 dB			
Peak-to-Peak Response		(12)	1.0 dB	±0.11 dB			
Option UKB ac Coupled Band 0A (800 MHz to 1.0 GHz)							
Maximum Response		(13)	0.50 dB	±0.11 dB			
Minimum Response	-0.50 dB	(14)		±0.11 dB			
Peak-to-Peak Response		(15)	1.0 dB	±0.11 dB			
Option UKB ac Coupled Band 0B (1.7 GHz to 2.0 GHz)							
Maximum Response		(16)	0.50 dB	±0.11 dB			
Minimum Response	-0.50 dB	(17)		±0.11 dB			
Peak-to-Peak Response		(18)	1.0 dB	±0.11 dB			
0 to 55° C Non-Option UKB Band 0 (9 kHz to 3.0 GHz)							
Maximum Response		(1)	0.76 dB	±0.19 dB			
Minimum Response	-0.76 dB	(2)		±0.19 dB			

Table 3-4 Agilent E4402B Performance Verification Test Record

Agilent Technologies	
Model E4402B	Report No.
Serial No	Date

	Date	-	
Minimum	Results Measured	Maximum	Measurement Uncertainty
	(3)	1.52 dB	±0.19 dB
-1.0 dB	(1) (2) (3)	1.0 dB 2.0 dB	±0.19 dB ±0.19 dB ±0.19 dB
-0.76 dB	(4) (5) (6)	0.76 dB 1.52 dB	±0.11 dB ±0.11 dB ±0.11 dB
-0.76 dB	(7) (8) (9)	0.76 dB 1.52 dB	±0.11 dB ±0.11 dB ±0.11 dB
	-1.0 dB	Minimum Results Measured (3)	Minimum Measured Maximum

Table 3-4 Agilent E4402B Performance Verification Test Record

Agilent Technologies						
Model E4402B			Report No.			
Serial No			Date			
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
	Option UKB ac Coupled Band 0 (100 kHz to 3.0 GHz)					
	Maximum Response		(10)	1.0 dB	±0.11 dB	
	Minimum Response	-1.0 dB	(11)		±0.11 dB	
	Peak-to-Peak Response		(12)	2.0 dB	±0.11 dB	
	Option UKB ac Coupled Band 0A (800 MHz to 1.0 GHz)					
	Maximum Response		(13)	1.0 dB	±0.11 dB	
	Minimum Response	-1.0 dB	(14)		±0.11 dB	
	Peak-to-Peak Response		(15)	2.0 dB	±0.11 dB	
	Option UKB ac Coupled Band 0B (1.7 GHz to 2.0 GHz)					
	Maximum Response		(16)	1.0 dB	±0.11 dB	
	Minimum Response	-1.0 dB	(17)		±0.11 dB	
	Peak-to-Peak Response		(18)	2.0 dB	±0.11 dB	
26.	Frequency Response (Preamp On) (Option 1DS Only)		ta in the appropriat mperature at which ns.			
	20 to 30° C					
	Band 0 (1 MHz to 3.0 GHz)					
	Maximum Response		(1)	1.5 dB	±0.28 dB	

Table 3-4 Agilent E4402B Performance Verification Test Record

Agilent Technologies	
Model E4402B	Report No
Serial No	Date

Seriai No.		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
Minimum Response	-1.5 dB	(2)		±0.28 dB
Peak-to-Peak Response		(3)	3.0 dB	±0.28 dB
Band 0A (800 MHz to 1.0 GHz) (serial number US39441006 or greater)				
Maximum Response		(4)	1.5 dB	±0.28 dB
Minimum Response	-1.5 dB	(5)		±0.28 dB
Peak-to-Peak Response		(6)	3.0 dB	±0.28 dB
Band 0B (1.7 GHz to 2.0 GHz) (serial number US39441006 or greater) Maximum Response Minimum Response Peak-to-Peak Response	–1.5 dB	(7) (8) (9)	1.5 dB 3.0 dB	±0.28 dB ±0.28 dB ±0.28 dB
0 to 55° C				
Band 0 (1 MHz to 3.0 GHz)				
Maximum Response		(1)	2.0 dB	±0.28 dB
Minimum Response	-2.0 dB	(2)		±0.28 dB
Peak-to-Peak Response		(3)	4.0 dB	±0.28 dB

Table 3-4 Agilent E4402B Performance Verification Test Record

Agil	ent Technologies				
Mod	el E4402B	Report No			
Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	Band 0A (800 MHz to 1.0 GHz) (serial number US39441006 or greater)				
	Maximum Response		(4)	2.0 dB	±0.28 dB
	Minimum Response	-2.0 dB	(5)		±0.28 dB
	Peak-to-Peak Response		(6)	4.0 dB	±0.28 dB
	Band 0B (1.7 GHz to 2.0 GHz) (serial number US39441006 or greater)				
	Maximum Response		(7)	2.0 dB	±0.28 dB
	Minimum Response	-2.0	(8)		±0.28 dB
	Peak-to-Peak Response		(9)	4.0 dB	±0.28 dB
29.	Other Input-Related Spurious Responses				
	Input Frequency				
	$2042.8~\mathrm{MHz}$		(1)	-65 dBc	±.891 dB
	$2642.8~\mathrm{MHz}$		(2)	-65 dBc	±.891 dB
	$1820.8~\mathrm{MHz}$		(3)	-65 dBc	±.891 dB
	278.5 MHz		(4)	-65 dBc	±.891 dB
31.	Spurious Responses				
	300 MHz TOI, 1 kHz RBW	11 dBm	(1)		±0.93 dB
	300 MHz TOI, 30 Hz RBW (Option 1DR only)	11 dBm	(2)		±0.93 dB
	300 MHz SHI	35 dBm	(3)		±0.41 dB
	900 MHz SHI	45 dBm	(4)		±0.41 dB

Table 3-4 Agilent E4402B Performance Verification Test Record

Agil	ent Technologies				
Mod	el E4402B		Report No		
Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
33.	Gain Compression				
	Test Frequency				
	53 MHz		(1)	1.0 dB	±0.123 dB
	50.004 MHz (Option 1DR only)		(2)	1.0 dB	±0.123 dB
	1403 MHz		(3)	1.0 dB	±0.123 dB
	2503 MHz		(4)	1.0 dB	±0.123 dB
36.	Displayed Average Noise Level		sults with preamp o ent temperature wh		
	1 kHz RBW, Preamp Off				
	10 MHz to 1 GHz		(1)	–117 dBm	±1.23 dB
	1 GHz to 2 GHz		(2)	-116 dBm	±1.23 dB
	2 GHz to 3 GHz		(3)	-114 dBm	±1.23 dB
	1kHz RBW, Preamp On, 0 to 55° C				
	10 MHz to 1 GHz		(4)	-132 dBm	±1.23 dB
	1 GHz to 2 GHz		(5)	-132 dBm	±1.23 dB
	2 GHz to 3 GHz		(6)	-129 dBm	±1.23 dB
	10 Hz RBW, Preamp Off				
	10 MHz to 1 GHz		(7)	-136 dBm	±1.23 dB
	1 GHz to 2 GHz		(8)	–135 dBm	±1.23 dB
	2 GHz to 3 GHz		(9)	–133 dBm	±1.23 dB
	10 Hz RBW, Preamp On, 0 to 55° C				
	10 MHz to 1 GHz		(10)	–151 dBm	±1.23 dB
	1 GHz to 2 GHz		(11)	–151 dBm	±1.23 dB
	2 GHz to 3 GHz		(12)	-148 dBm	±1.23 dB

Table 3-4 Agilent E4402B Performance Verification Test Record

Agil	ent Technologies				
Mod	el E4402B	Report No			
Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	1kHz RBW, Preamp On, 20 to 30° C				
	10 MHz to 1 GHz		(13)	–133 dBm	±1.23 dB
	1 GHz to 2 GHz		(14)	-134 dBm	±1.23 dB
	2 GHz to 3 GHz		(15)	-132 dBm	±1.23 dB
	10 Hz RBW, Preamp On, 20 to 30° C				
	10 MHz to 1 GHz		(16)	-152 dBm	±1.23 dB
	1 GHz to 2 GHz		(17)	–152 dBm	±1.23 dB
	2 GHz to 3 GHz		(18)	–151 dBm	±1.23 dB
39.	Residual Responses				
	150 kHz to 3.0 GHz		(1)	-90 dBm	±0.87 dB
40.	Fast Time Domain Amplitude Accuracy (Option AYX only)				
	Amplitude Error	-0.3%	(1)	0.3%	±0.029%
42.	Tracking Generator Absolute Amplitude and Vernier Accuracy (Option 1DN only)				
	Absolute Amplitude Accuracy	−0.75 dB	(1)	0.75 dB	±0.096 dB
	Absolute Vernier Accuracy				
	-2 dB	-0.5 dB	(2)	0.5 dB	±0.008 dB
	-3 dB	-0.5 dB	(3)	0.5 dB	±0.008 dB
	-5 dB	-0.5 dB	(4)	0.5 dB	±0.008 dB
	-6 dB	-0.5 dB	(5)	0.5 dB	±0.008 dB
	-7 dB	-0.5 dB	(6)	0.5 dB	±0.008 dB

Table 3-4 Agilent E4402B Performance Verification Test Record

Agilent Technologies	
Model E4402B	Report No
Serial No	Date

Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	-8 dB	-0.5 dB	(7)	0.5 dB	±0.008 dB
	–9 dB	-0.5 dB	(8)	0.5 dB	±0.008 dB
	-10 dB	-0.5 dB	(9)	0.5 dB	±0.008 dB
	Incremental Vernier Accuracy				
	−2 dB	-0.2 dB	(10)	0.2 dB	±0.008 dB
	–3 dB	-0.2 dB	(11)	0.2 dB	±0.008 dB
	–5 dB	-0.2 dB	(12)	0.2 dB	±0.008 dB
	-6 dB	-0.2 dB	(13)	0.2 dB	±0.008 dB
	-7 dB	-0.2 dB	(14)	0.2 dB	±0.008 dB
	-8 dB	-0.2 dB	(15)	0.2 dB	±0.008 dB
	−9 dB	-0.2 dB	(16)	0.2 dB	±0.008 dB
	-10 dB	-0.2 dB	(17)	0.2 dB	±0.008 dB
44.	Tracking Generator Level Flatness (Option 1DN only)				
	Positive Level Flatness, <1 MHz		(1)	3.0 dB	±0.284 dB
	Negative Level Flatness, <1 MHz	-3.0 dB	(2)		±0.284 dB
	Positive Level Flatness, 1 MHz to 10 MHz		(3)	3.0 dB	±0.142 dB
	Negative Level Flatness, 1 MHz to 10 MHz	-3.0 dB	(4)		±0.142 dB
	Positive Level Flatness, >10 MHz to 1.5 GHz		(5)	2.0 dB	±0.142 dB
	Negative Level Flatness, >10 MHz to 1.5 GHz	-2.0 dB	(6)		±0.142 dB

Table 3-4 Agilent E4402B Performance Verification Test Record

Agil	ent Technologies					
Mod	el E4402B		Report No			
Seri	al No		Date			
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
	Positive Level Flatness, >1.5 GHz		(7)	2.0 dB	±0.142 dB	
	Negative Level Flatness, >1.5 GHz	-2.0 dB	(8)		±0.142 dB	
46.	Tracking Generator Harmonic Spurious Outputs (Option 1DN only)					
	2 nd Harmonic, <20 kHz		(1)	-15 dBc	±2.6 dB	
	2 nd Harmonic, ≥20 kHz		(2)	–25 dBc	±2.6 dB	
	3 rd Harmonic, <20 kHz		(3)	-15 dBc	±2.6 dB	
	3 rd Harmonic, ≥20 kHz		(4)	–25 dBc	±2.6 dB	
48.	Tracking Generator Non-Harmonic Spurious Outputs (Option 1DN only)					
	Highest Non-Harmonic Spurious Output Amplitude, 9 kHz to 2 GHz		(1)	–27 dBc	±2.63 dB	
	Highest Non-Harmonic Spurious Output Amplitude, 2 GHz to 3 GHz		(2)	–23 dBc	±3.14 dB	
49.	Tracking Generator L.O. Feedthrough (Option 1DN only)					
	9 kHz to 2.9 GHz		(1)	-16 dBm	±2.58 dB	
	2.9 GHz to 3.0 GHz		(2)	-16 dBm	±3.03 dB	

Table 3-4 Agilent E4402B Performance Verification Test Record

Agilent Technologies					
Mod	el E4402B		Report No		
Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
50.	Gate Delay Accuracy and Gate Length Accuracy (Option 1D6 only)				
	Minimum Gate Delay	499.9 ns	(1)	1.5001 μs	±549 ps
	Maximum Gate Delay	499.9 ns	(2)	1.5001 μs	±549 ps
	1 μs Gate Length	499.9 ns	(3)	1.5001 μs	±520 ps
	65 ms Gate Length	64.993 ms	(4)	65.007 ms	±647 ns
51.	Gate Mode Additional Amplitude Error (Option 1D6 only)				
	Amplitude Error	-0.2 dB	(1)	0.2 dB	±0.023 dB
58.	GSM Phase and Frequency Error (Option BAH and B7E)				
	Peak Phase Error	-2.1 Deg	(1)	2.1 Deg	±0.52 Deg
	RMS Phase Error	-1.1 Deg	(2)	1.1 Deg	±0.000063 Deg
	Frequency Error	-10 Hz	(3)	10 Hz	±0.006 Hz
59.	Comms Absolute Power Accuracy (Options BAC or BAH)				
	$20 ext{ to } 30^{\circ} ext{ C}$				
	cdmaOne Channel Power Accuracy (Option BAC only)				
	Cellular Band Input Amplitude				
	15 dBm	-0.90 dB	(1)	0.90 dB	±0.173 dB
	−5 dBm	-0.90 dB	(2)	0.90 dB	±0.161 dB

 $-0.86~\mathrm{dB}$

 $(3)_{-}$

 $-25~\mathrm{dBm}$

Chapter 3 475

 $0.86~\mathrm{dB}$

±0.161 dB

Table 3-4 Agilent E4402B Performance Verification Test Record

Agilent Technologies	
Model E4402B	Report No
Serial No	Date

Serial No.		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
-45 dBm	-0.70 dB	(4)	0.70 dB	±0.152 dB
-55 dBm	-0.78 dB	(5)	0.78 dB	±0.152 dB
-70 dBm	-0.90 dB	(6)	0.90 dB	±0.161 dB
PCS Band Input Amplitude				
15 dBm	-0.74 dB ^a	(7)	$0.74~\mathrm{dB^b}$	±0.173 dB
−5 dBm	-0.74 dB ^a	(8)	$0.74~\mathrm{dB^b}$	±0.161 dB
-25 dBm	-0.69 dB ^a	(9)	$0.69~\mathrm{dB^b}$	±0.161 dB
-45 dBm	-0.70 dB ^a	(10)	0.70 dB ^b	±0.152 dB
-55 dBm	-0.78 dB ^a	(11)	$0.78~\mathrm{dB^b}$	±0.152 dB
-70 dBm	-0.90 dB ^a	(12)	0.90 dB ^b	±0.161 dB
GSM Transmit Power Accuracy (Option BAH only)				
GSM Band Input Amplitude				
15 dBm	-0.99 dB	(13)	0.99 dB	±0.173 dB
-20 dBm	-0.99 dB	(14)	0.99 dB	±0.161 dB
-30 dBm	-0.92 dB	(15)	0.92 dB	±0.156 dB
-40 dBm	-0.97 dB	(16)	0.97 dB	±0.161 dB
-50 dBm	-1.16 dB	(17)	1.16 dB	±0.152 dB
-60 dBm	-1.29 dB	(18)	1.29 dB	±0.161 dB
DCS and PCS Bands Input Amplitude				
15 dBm	-0.83 dB ^a	(19)	0.83 dB ^b	±0.173 dB
-20 dBm	-0.83 dB ^a	(20)	0.83 dB ^b	±0.161 dB

Table 3-4 Agilent E4402B Performance Verification Test Record

Agilent Technologies	
Model E4402B	Report No.
Serial No	Date

Serial No		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
-30 dBm	-0.75 dB ^a	(21)	$0.75~\mathrm{dB^b}$	±0.156 dB
-40 dBm	-0.80 dB ^a	(22)	$0.80~\mathrm{dB^b}$	±0.161 dB
-50 dBm	-0.99 dB ^a	(23)	$0.99~\mathrm{dB^b}$	±0.152 dB
-60 dBm	-1.12 dB ^a	(24)	$1.12~\mathrm{dB^b}$	±0.161 dB
cdmaOne Receive Channel Power, Preamp Off (Option BAC only) Cellular Band Input Amplitude				
-40 dBm	-1.58 dB	(25)	1.58 dB	±0.161 dB
-60 dBm	-1.58 dB	(26)	1.58 dB	±0.161 dB
-70 dBm	-1.58 dB	(27)	1.58 dB	±0.161 dB
-80 dBm	-1.58 dB	(28)	1.58 dB	±0.161 dB
-85 dBm	-1.58 dB	(29)	1.58 dB	±0.152 dB
PCS Band Input Amplitude				
-40 dBm	-1.52 dB ^a	(30)	$1.52~\mathrm{dB^b}$	±0.161 dB
-60 dBm	-1.52 dB ^a	(31)	$1.52~\mathrm{dB^b}$	±0.161 dB
-70 dBm	-1.52 dB ^a	(32)	$1.52~\mathrm{dB^b}$	±0.161 dB
-80 dBm	-1.52 dB ^a	(33)	$1.52~\mathrm{dB^b}$	±0.161 dB
-85 dBm	-1.52 dB ^a	(34)	$1.52~\mathrm{dB^b}$	±0.152 dB
cdmaOne Receive Channel Power, Preamp On (Option BAC only)				
Cellular Band Input Amplitude				

Agilent E4402B Performance Verification Test Record Table 3-4

Agilent Technologies				
Model E4402B		Report No		
Serial No Date				
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
-40 dBm	-1.77 dB	(35)	1.77 dB	±0.161 dB
-60 dBm	–1.77 dB	(36)	1.77 dB	±0.161 dB
-70 dBm	–1.77 dB	(37)	1.77 dB	±0.161 dB
-80 dBm	−1.77 dB	(38)	1.77 dB	±0.161 dB
-90 dBm	-3.00 dB	(39)	3.00 dB	±0.161 dB
-100 dBm	-3.00 dB	(40)	3.00 dB	±0.161 dB
PCS Band Input Amplitude				
-40 dBm	-1.86 dB	(41)	$1.86~\mathrm{dB^b}$	±0.161 dB
-60 dBm	-1.86 dB	(42)	1.86 dB ^b	±0.161 dB
-70 dBm	-1.86 dB	(43)	$1.86~\mathrm{dB^b}$	±0.161 dB
-80 dBm	-1.86 dB	(44)	$1.86~\mathrm{dB^b}$	±0.161 dB
-90 dBm	-3.09 dB	(45)	$3.09~\mathrm{dB^b}$	±0.161 dB
-100 dBm	-3.09 dB	(46)	$3.09~\mathrm{dB^b}$	±0.161 dB

a. Subtract $0.10~\mathrm{dB}$ if the analyzer has Option UKB installed. b. Add $0.10~\mathrm{dB}$ if the analyzer has Option UKB installed.

Agilent E4403B Performance Verification Test Record

Tests for the Agilent E4403B only are included in this test record, therefore not all test numbers are included.

Table 3-5 Agilent E4403B Performance Verification Test Record

Agilent Technologies				
Address:		Report No		
		Date		
Model E4403B				
Serial No		Ambient temperatur	e° C	
Options		Relative humidity	%	
Firmware Revision		Power mains line frequency Hz (nominal)		
Customer		Tested by		
Test Equipment Used:				
Description	Model No.	Trace No.	Cal Due Date	
Synthesized Signal Generator				
Synthesized Sweeper				
Function Generator				
Power Meter, Dual-Channel				
RF Power Sensor #1				
RF Power Sensor #2				
Low-Power Power Sensor				
Digital Multimeter				
Universal Counter				
Frequency Standard				
Power Splitter				
$50~\Omega$ Termination				
1 dB Step Attenuator				
10 dB Step Attenuator				

Table 3-5 Agilent E4403B Performance Verification Test Record

Microwave Spectrum Analyzer (Option 1DN only)	 	
Notes/comments:	 	

Table 3-6 Agilent E4403B Performance Verification Test Record

		_				
Agil	ent Technologi	ies				
Mod	lel E4403B			Report No		
Seri	al No			Date		
Test	Description		Minimum Results Maximum Measurement Uncertainty			
1.	10 MHz Refer Output Accur					
	Settability		-5.0 Hz	(1)	5.0 Hz	±293.3 μHz
3.	Frequency Ro Marker Frequency Count Accura	uency				
	Frequency Rea Accuracy	idout				
	Center Freq	Span				
	1500 MHz	$20~\mathrm{MHz}$	1499.83 MHz	(1)	1500.17 MHz	±0 Hz
	1500 MHz	10 MHz	1499.91 MHz	(2)	1500.09 MHz	±0 Hz
	1500 MHz	1 MHz	1499.991 MHz	(3)	1500.009 MHz	±0 Hz
	Marker Count	•				
	Center Freq	Span				
	1500 MHz	10 MHz	1499.999999 MHz	(4)	1500.000001 MHz	±0 Hz
	1500 MHz	1 MHz	1499.999999 MHz	(5)	1500.000001 MHz	±0 Hz

Table 3-6 Agilent E4403B Performance Verification Test Record

Agil	ent Technologies				
Mod	el E4403B		Report No		
Seria	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
6.	Frequency Span Accuracy				
	Span Start Freq				
	3000 MHz 0 Hz	2370 MHz	(1)	2430 MHz	±6.12 MHz
	100 MHz 10 MHz	79 MHz	(2)	81 MHz	±204 kHz
	100 kHz 10 MHz	79 kHz	(3)	81 kHz	±204 Hz
	100 MHz 800 MHz	79 MHz	(4)	81 MHz	±204 kHz
	100 kHz 800 MHz	79 kHz	(5)	81 kHz	±204 Hz
	100 MHz 1400 MHz	79 MHz	(6)	81 MHz	±204 kHz
	100 kHz 1499 MHz	79 kHz	(7)	81 kHz	±204 Hz
7.	Noise Sidebands				
	Offset from 1 GHz signal				
	$10~\mathrm{kHz}$		(1)	–90 dBc/Hz	±2.44 dB
	$20~\mathrm{kHz}$		(2)	-100 dBc/Hz	±2.44 dB
	$30~\mathrm{kHz}$		(3)	-106 dBc/Hz	±2.44 dB
9.	System-Related Sidebands				
	Offset from 500 MHz signal				
	30 kHz to 230 kHz		(1)	-65 dBc	±1.30 dB
	–30 kHz to –230 kHz		(2)	–65 dBc	±1.30 dB
10.	Residual FM				
	1 kHz Res BW		(1)	150 Hz	±21 Hz
11.	Sweep Time Accuracy				
	Sweep Time				

(1)___

-1.0%

5 ms

Chapter 3 481

1.0%

±0.16%

Table 3-6 Agilent E4403B Performance Verification Test Record

Agil	ent Technologies					
Mod	el E4403B		Report No			
Seri	al No		Date			
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
	20 ms	-1.0%	(2)	1.0%	±0.16%	
	100 ms	-1.0%	(3)	1.0%	±0.16%	
	1 s	-1.0%	(4)	1.0%	±0.16%	
	10 s	-1.0%	(5)	1.0%	±0.16%	
12.	Display Scale Fidelity					
	Cumulative Log Fidelity, Res BW ≥1 kHz					
	dB from Ref Level					
	-4	-0.34 dB	(1)	0.34 dB	±0.082 dB	
	-8	-0.38 dB	(2)	0.38 dB	±0.078 dB	
	-12	-0.42 dB	(3)	0.42 dB	±0.075 dB	
	-16	-0.46 dB	(4)	0.46 dB	±0.073 dB	
	-20	-0.50 dB	(5)	0.50 dB	±0.078 dB	
	-24	-0.54 dB	(6)	0.54 dB	±0.074 dB	
	-28	-0.58 dB	(7)	$0.58~\mathrm{dB}$	±0.073 dB	
	-32	-0.62 dB	(8)	$0.62~\mathrm{dB}$	±0.077 dB	
	-36	-0.66 dB	(9)	0.66 dB	±0.075 dB	
	-40	-0.70 dB	(10)	0.70 dB	±0.081 dB	
	-44	−0.74 dB	(11)	0.74 dB	±0.077 dB	
	-48	-0.78 dB	(12)	0.78 dB	±0.076 dB	
	-52	-0.82 dB	(13)	0.82 dB	±0.080 dB	
	-56	-0.86 dB	(14)	0.86 dB	±0.078 dB	
	-60	-0.90 dB	(15)	0.90 dB	±0.084 dB	
	-64	−0.94 dB	(16)	0.94 dB	±0.081 dB	
	-68	-0.98 dB	(17)	0.98 dB	±0.080 dB	
	-72	-1.02 dB	(18)	1.02 dB	±0.084 dB	

Table 3-6 Agilent E4403B Performance Verification Test Record

Agilent Technologies	
Model E4403B	Report No
Serial No	Date

Serial No.		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
-76	-1.06 dB	(19)	1.06 dB	±0.083 dB
-80	-1.10 dB	(20)	1.10 dB	±0.089 dB
-84	-1.14 dB	(21)	1.14 dB	±0.086 dB
Incremental Log Fidelity, Res BW ≥1 kHz				
dB from Ref Level				
-4	-0.4 dB	(22)	0.4 dB	±0.082 dB
-8	-0.4 dB	(23)	0.4 dB	±0.078 dB
-12	-0.4 dB	(24)	0.4 dB	±0.075 dB
-16	-0.4 dB	(25)	0.4 dB	±0.073 dB
-20	-0.4 dB	(26)	0.4 dB	±0.078 dB
-24	-0.4 dB	(27)	0.4 dB	±0.074 dB
-28	-0.4 dB	(28)	0.4 dB	±0.073 dB
-32	-0.4 dB	(29)	0.4 dB	±0.077 dB
-36	-0.4 dB	(30)	0.4 dB	±0.075 dB
-40	-0.4 dB	(31)	0.4 dB	±0.081 dB
-44	-0.4 dB	(32)	0.4 dB	±0.077 dB
-48	-0.4 dB	(33)	0.4 dB	±0.076 dB
-52	-0.4 dB	(34)	0.4 dB	±0.080 dB
-56	-0.4 dB	(35)	0.4 dB	±0.078 dB
-60	-0.4 dB	(36)	0.4 dB	±0.084 dB
-64	-0.4 dB	(37)	0.4 dB	±0.081 dB
-68	-0.4 dB	(38)	0.4 dB	±0.080 dB
-72	-0.4 dB	(39)	0.4 dB	±0.084 dB
-76	-0.4 dB	(40)	0.4 dB	±0.083 dB
-80	-0.4 dB	(41)	0.4 dB	±0.089 dB

Table 3-6 Agilent E4403B Performance Verification Test Record

Agil	ent Technologies				
Mod	el E4403B		Report No		
Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	Cumulative Log Fidelity, Res BW ≤300 Hz (Option 1DR only)				
	dB from Ref Level				
	_4	-0.34 dB	(43)	0.34 dB	±0.082 dB
	-8	-0.38 dB	(44)	0.38 dB	±0.078 dB
	-12	-0.42 dB	(45)	0.42 dB	±0.075 dB
	-16	-0.46 dB	(46)	0.46 dB	±0.073 dB
	-20	-0.50 dB	(47)	0.50 dB	±0.078 dB
	-24	−0.54 dB	(48)	0.54 dB	±0.074 dB
	-28	-0.58 dB	(49)	0.58 dB	±0.073 dB
	-32	-0.62 dB	(50)	0.62 dB	±0.077 dB
	-36	-0.66 dB	(51)	0.66 dB	±0.075 dB
	-40	-0.70 dB	(52)	0.70 dB	±0.081 dB
	-44	-0.74 dB	(53)	0.74 dB	±0.077 dB
	-48	-0.78 dB	(54)	0.78 dB	±0.076 dB
	-52	-0.82 dB	(55)	0.82 dB	±0.080 dB
	-56	-0.86 dB	(56)	0.86 dB	±0.078 dB
	-60	-0.90 dB	(57)	0.90 dB	±0.084 dB
	-64	-0.94 dB	(58)	0.94 dB	±0.081 dB
	-68	-0.98 dB	(59)	0.98 dB	±0.080 dB
	-72	-1.02 dB	(60)	1.02 dB	±0.084 dB
	-76	-1.06 dB	(61)	1.06 dB	±0.083 dB
	-80	-1.10 dB	(62)	1.10 dB	±0.089 dB
	-84	−1.14 dB	(63)	1.14 dB	±0.086 dB

-1.18 dB

-88

484 Chapter 3

 $(64)_{__}$

 $1.18~\mathrm{dB}$

 $\pm 0.085~\mathrm{dB}$

Table 3-6 Agilent E4403B Performance Verification Test Record

Agilent Technologies	
Model E4403B	Report No
Serial No	Date

Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	-92	-1.22 dB	(65)	1.22 dB	±0.100 dB
	-96	-1.26 dB	(66)	1.26 dB	±0.099 dB
	-98	-1.28 dB	(67)	1.28 dB	±0.098 dB
	Incremental Log Fidelity, Res BW ≤300 Hz (Option 1DR only)				
	dB from Ref Level				
	-4	-0.4 dB	(68)	0.4 dB	±0.082 dB
	-8	-0.4 dB	(69)	0.4 dB	±0.078 dB
	-12	-0.4 dB	(70)	0.4 dB	±0.075 dB
	-16	-0.4 dB	(71)	0.4 dB	±0.073 dB
	-20	-0.4 dB	(72)	0.4 dB	±0.078 dB
	-24	-0.4 dB	(73)	0.4 dB	±0.074 dB
	-28	-0.4 dB	(74)	0.4 dB	±0.073 dB
	-32	-0.4 dB	(75)	0.4 dB	±0.077 dB
	-36	-0.4 dB	(76)	0.4 dB	±0.075 dB
	-40	-0.4 dB	(77)	0.4 dB	±0.081 dB
	-44	-0.4 dB	(78)	0.4 dB	±0.077 dB
	-48	-0.4 dB	(79)	0.4 dB	±0.076 dB
	-52	-0.4 dB	(80)	0.4 dB	±0.080 dB
	-56	-0.4 dB	(81)	0.4 dB	±0.078 dB
	-60	-0.4 dB	(82)	0.4 dB	±0.084 dB
	-64	-0.4 dB	(83)	0.4 dB	±0.081 dB
	-68	-0.4 dB	(84)	0.4 dB	±0.080 dB
	-72	-0.4 dB	(85)	0.4 dB	±0.084 dB
	-76	-0.4 dB	(86)	0.4 dB	±0.083 dB

Table 3-6 Agilent E4403B Performance Verification Test Record

Agilent Technologies			
Model E4403B	Report No		
Serial No	Date		
	-		

Serial No.	Date			
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
-80	-0.4 dB	(87)	0.4 dB	±0.089 dB
Linear Fidelity, Res BW ≥1 kHz				
dB from Ref Level				
-4	-2.0%	(93)	2.0%	±0.064%
-8	-2.0%	(94)	2.0%	±0.064%
-12	-2.0%	(95)	2.0%	±0.064%
-16	-2.0%	(96)	2.0%	±0.064%
-20	-2.0%	(97)	2.0%	±0.063%
Linear Fidelity, Res BW ≤300 Hz (Option 1DR only)				
dB from Ref Level				
-4	-2.0%	(98)	2.0%	±0.064%
-8	-2.0%	(99)	2.0%	±0.064%
-12	-2.0%	(100)	2.0%	±0.064%
-16	-2.0%	(101)	2.0%	±0.064%
-20	-2.0%	(102)	2.0%	±0.063%
Zero Span, Res BW ≤300 Hz (Option 1DR only)				
dB from Ref Level				
-4	-0.36 dB	(103)	0.36 dB	±0.082 dB
-8	$-0.42~\mathrm{dB}$	(104)	0.42 dB	±0.078 dB
-12	-0.48 dB	(105)	0.48 dB	±0.075 dB
-16	-0.54 dB	(106)	0.54 dB	±0.073 dB
-20	-0.60 dB	(107)	0.60 dB	±0.078 dB
-24	-0.66 dB	(108)	0.66 dB	±0.074 dB

Table 3-6 Agilent E4403B Performance Verification Test Record

Agilent Technologies	
Model E4403B	Report No
Serial No	Date

Seri	Serial No Date				
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	-28	-0.72 dB	(109)	0.72 dB	±0.073 dB
	-32	-0.78 dB	(110)	0.78 dB	±0.077 dB
	-36	-0.84 dB	(111)	0.84 dB	±0.075 dB
	-40	-0.90 dB	(112)	0.90 dB	±0.081 dB
	-44	-0.96 dB	(113)	0.96 dB	±0.077 dB
	-48	-1.02 dB	(114)	1.02 dB	±0.076 dB
	-52	-1.08 dB	(115)	1.08 dB	±0.080 dB
	-56	-1.14 dB	(116)	1.14 dB	±0.078 dB
	-60	-1.20 dB	(117)	1.20 dB	±0.084 dB
	-64	−1.5 dB	(118)	1.5 dB	±0.081 dB
	-68	-1.5 dB	(119)	1.5 dB	±0.080 dB
	-70	-1.5 dB	(120)	1.5 dB	±0.084 dB
13.	Input Attenuation Switching Uncertainty				
	Input Attenuation Setting				
	0 dB	-0.3 dB	(1)	0.3 dB	±0.101 dB
	5 dB	-0.3 dB	(2)	0.3 dB	±0.104 dB
	15 dB	-0.3 dB	(3)	0.3 dB	±0.102 dB
	20 dB	-0.3 dB	(4)	0.3 dB	±0.098 dB
	25 dB	−0.35 dB	(5)	0.35 dB	±0.098 dB
	30 dB	-0.40 dB	(6)	0.40 dB	±0.096 dB
	35 dB	−0.45 dB	(7)	0.45 dB	±0.099 dB
	40 dB	-0.50 dB	(8)	0.50 dB	±0.096 dB
	45 dB	−0.55 dB	(9)	0.55 dB	±0.099 dB
	50 dB	-0.60 dB	(10)	0.60 dB	±0.095 dB
	55 dB	-0.65 dB	(11)	0.65 dB	±0.099 dB

Table 3-6 Agilent E4403B Performance Verification Test Record

Agil	ent Technologies				
Mod	el E4403B		Report No		
Serial No			Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	60 dB	-0.70 dB	(12)	0.70 dB	±0.100 dB
	65 dB	−0.75 dB	(13)	0.75 dB	±0.111 dB
15.	Reference Level Accuracy				
	Log Reference Level				
	–10 dBm	-0.3 dB	(1)	0.3 dB	±0.091 dB
	0 dBm	-0.3 dB	(2)	0.3 dB	±0.100 dB
	-30 dBm	-0.3 dB	(3)	0.3 dB	±0.092 dB
	-40 dBm	-0.3 dB	(4)	0.3 dB	±0.094 dB
	–50 dBm	-0.5 dB	(5)	0.5 dB	±0.095 dB
	-60 dBm	-0.5 dB	(6)	0.5 dB	±0.097 dB
	–70 dBm	-0.5 dB	(7)	0.5 dB	±0.099 dB
	-80 dBm	-0.7 dB	(8)	0.7 dB	±0.101 dB
	Linear				
	Reference Level				
	-10 dBm	-0.3 dB	(9)	0.3 dB	±0.091 dB
	0 dBm	-0.3 dB	(10)	0.3 dB	±0.100 dB
	-30 dBm	-0.3 dB	(11)	0.3 dB	±0.092 dB
	-40 dBm	-0.3 dB	(12)	0.3 dB	±0.094 dB
	-50 dBm	-0.5 dB	(13)	0.5 dB	$\pm 0.095~\mathrm{dB}$
	-60 dBm	-0.5 dB	(14)	0.5 dB	$\pm 0.097~\mathrm{dB}$
	-70 dBm	-0.5 dB	(15)	0.5 dB	$\pm 0.099~\mathrm{dB}$
	-80 dBm	-0.7 dB	(16)	0.7 dB	±0.101 dB
16.	Resolution Bandwidth				

Table 3-6 Agilent E4403B Performance Verification Test Record

Agilent Technologies	
Model E4403B	Report No
Serial No	Date

Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	Resolution Bandwidth				
	3 kHz	-0.3 dB	(1)	0.3 dB	±0.048 dB
	9 kHz	-0.3 dB	(2)	0.3 dB	±0.048 dB
	$10~\mathrm{kHz}$	-0.3 dB	(3)	0.3 dB	±0.048 dB
	$30~\mathrm{kHz}$	-0.3 dB	(4)	0.3 dB	±0.048 dB
	100 kHz	-0.3 dB	(5)	0.3 dB	±0.048 dB
	120 kHz	-0.3 dB	(6)	0.3 dB	±0.048 dB
	300 kHz	-0.3 dB	(7)	0.3 dB	±0.048 dB
	1 MHz	-0.3 dB	(8)	0.3 dB	±0.048 dB
	3 MHz	-0.3 dB	(9)	0.3 dB	±0.048 dB
	5 MHz	-0.6 dB	(10)	0.6 dB	±0.076 dB
	300 Hz (Option 1DR only)	-3.0 dB	(11)	0.3 dB	±0.048 dB
	200 Hz (Option 1DR only)	-3.0 dB	(12)	0.3 dB	±0.048 dB
	100 Hz (Option 1DR only)	-3.0 dB	(13)	0.3 dB	±0.048 dB
18.	Absolute Amplitude Accuracy (Reference Settings)				
	Log, Preamp Off	-0.4 dB	(1)	0.4 dB	±0.09 dB
	Lin, Preamp Off	-0.4 dB	(2)	0.4 dB	±0.09 dB
20.	Overall Absolute Amplitude Accuracy				
	0 dBm Reference Level				
	0 dBm input	-0.6 dB	(1)	0.6 dB	±0.234 dB
	–10 dBm input	-0.6 dB	(2)	0.6 dB	±0.115 dB
	–20 dBm input	-0.6 dB	(3)	0.6 dB	±0.110 dB
	–30 dBm input	-0.6 dB	(4)	0.6 dB	±0.109 dB

Table 3-6 Agilent E4403B Performance Verification Test Record

Agil	ent Technologies				
Mod	el E4403B		Report No		
Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	–40 dBm input	-0.6 dB	(5)	0.6 dB	±0.109 dB
	–50 dBm input	-0.6 dB	(6)	0.6 dB	±0.109 dB
	–20 dBm Reference Level				
	–20 dBm input	-0.6 dB	(7)	0.6 dB	±0.109 dB
	–30 dBm input	-0.6 dB	(8)	0.6 dB	±0.109 dB
	–40 dBm input	-0.6 dB	(9)	0.6 dB	±0.109 dB
	–50 dBm input	-0.6 dB	(10)	0.6 dB	±0.109 dB
	–40 dBm Reference Level				
	–40 dBm input	-0.6 dB	(11)	0.6 dB	±0.087 dB
	–50 dBm input	-0.6 dB	(12)	0.6 dB	±0.087 dB
	–50 dBm Reference Level				
	–50 dBm input	-0.6 dB	(13)	0.6 dB	±0.087 dB
21.	Resolution Bandwidth Accuracy				
	Resolution Bandwidth				
	5 MHz	3.5 MHz	(1)	6.5 MHz	±110 kHz
	3 MHz	2.55 MHz	(2)	3.45 MHz	±66 kHz
	1 MHz	0.85 MHz	(3)	1.15 MHz	±22 kHz
	300 kHz	255 kHz	(4)	345 kHz	±6.6 kHz
	100 kHz	85 kHz	(5)	115 kHz	±2.2 kHz
	$30~\mathrm{kHz}$	25.5 kHz	(6)	34.5 kHz	±660 Hz
	10 kHz	8.5 kHz	(7)	11.5 kHz	±220 Hz
	$3~\mathrm{kHz}$	2.55 kHz	(8)	$3.45~\mathrm{kHz}$	±66 Hz
	1 kHz	850 Hz	(9)	1.15 kHz	±22 Hz
	120 kHz	96 kHz	(10)	144 kHz	±2.17 kHz
	9 kHz	7.2 kHz	(11)	10.8 kHz	±163 Hz

Table 3-6 Agilent E4403B Performance Verification Test Record

Agilent Technologies					
Mod	el E4403B		Report No		
Seria	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
23.	Frequency Response		ta in the appropriat mperature at which		
	20 to 30° C				
	Maximum Response		(1)	0.5 dB	±0.19 dB
	Minimum Response	−0.5 dB	(2)		±0.19 dB
	Peak-to-Peak Response		(3)	1.0 dB	±0.19 dB
	0 to 55° C				
	Maximum Response		(1)	1.0 dB	±0.19 dB
	Minimum Response	-1.0 dB	(2)		±0.19 dB
	Peak-to-Peak Response		(3)	2.0 dB	±0.19 dB
29.	Other Input-Related Spurious Responses				
	Input Frequency				
	$2042.8~\mathrm{MHz}$		(1)	-65 dBc	±0.891 dB
	$2642.8~\mathrm{MHz}$		(2)	-65 dBc	±0.891 dB
	$1820.8~\mathrm{MHz}$		(3)	-65 dBc	±0.891 dB
	$278.5~\mathrm{MHz}$		(4)	-65 dBc	±0.891 dB
31.	Spurious Responses	Note: Entry 2 o	loes not apply to the	Agilent E4403F	3.
	$300~\mathrm{MHz}~\mathrm{TOI}$	7.5 dBm	(1)		±0.93 dB
	$300~\mathrm{MHz}~\mathrm{SHI}$	30 dBm	(3)		±0.41 dB
	$900~\mathrm{MHz}~\mathrm{SHI}$	40 dBm	(4)		±0.41 dB
33.	Gain Compression	Note: Entry 2 o	loes not apply to the	e Agilent E4403F	3.
	Test Frequency				
	$53~\mathrm{MHz}$		(1)	1.0 dB	±0.123 dB
	$1403~\mathrm{MHz}$		(3)	1.0 dB	±0.123 dB
	$2503~\mathrm{MHz}$		(4)	1.0 dB	±0.123 dB

Table 3-6 Agilent E4403B Performance Verification Test Record

Agil	ent Technologies				
Mod	el E4403B		Report No		
Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
36.	Displayed Average Noise Level				
	1 kHz RBW				
	10 MHz to 1 GHz		(1)	–117 dBm	±1.23 dB
	1 GHz to 2 GHz		(2)	–116 dBm	±1.23 dB
	2 GHz to 3 GHz		(3)	–114 dBm	±1.23 dB
	100 Hz RBW				
	10 MHz to 1 GHz		(7)	–125 dBm	±1.23 dB
	1 GHz to 2 GHz		(8)	–124 dBm	±1.23 dB
	2 GHz to 3 GHz		(9)	–122 dBm	±1.23 dB
39.	Residual Responses				
	150 kHz to 3.0 GHz		(1)	-90 dBm	±0.87 dB
42.	Tracking Generator Absolute Amplitude and Vernier Accuracy (Option 1DN only)				
	Absolute Amplitude Accuracy	-0.75 dB	(1)	$0.75~\mathrm{dB}$	±0.096 dB
	Absolute Vernier Accuracy				
	-2 dB	-0.5 dB	(2)	0.5 dB	±0.008 dB
	-3 dB	-0.5 dB	(3)	0.5 dB	±0.008 dB
	-5 dB	-0.5 dB	(4)	0.5 dB	±0.008 dB
	-6 dB	-0.5 dB	(5)	0.5 dB	±0.008 dB
	-7 dB	-0.5 dB	(6)	0.5 dB	±0.008 dB
	-8 dB	-0.5 dB	(7)	0.5 dB	±0.008 dB
	-9 dB	-0.5 dB	(8)	0.5 dB	±0.008 dB
	_10 dB	_0.5 dB	(9)	0.5 dB	±0.008 dB

Table 3-6 Agilent E4403B Performance Verification Test Record

Agilent Technologies	
Model E4403B	Report No
Serial No	Date

Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	Incremental Vernier Accuracy				
	−2 dB	-0.2 dB	(10)	0.2 dB	±0.008 dB
	-3 dB	-0.2 dB	(11)	0.2 dB	±0.008 dB
	-5 dB	-0.2 dB	(12)	0.2 dB	±0.008 dB
	-6 dB	-0.2 dB	(13)	0.2 dB	±0.008 dB
	-7 dB	-0.2 dB	(14)	0.2 dB	±0.008 dB
	-8 dB	-0.2 dB	(15)	0.2 dB	±0.008 dB
	-9 dB	-0.2 dB	(16)	0.2 dB	±0.008 dB
	-10 dB	-0.2 dB	(17)	0.2 dB	±0.008 dB
44.	Tracking Generator Level Flatness (Option 1DN only)				
	Positive Level Flatness, <1 MHz		(1)	3.0 dB	±0.284 dB
	Negative Level Flatness, <1 MHz	-3.0 dB	(2)		±0.284 dB
	Positive Level Flatness, 1 MHz to 10 MHz		(3)	3.0 dB	±0.142 dB
	Negative Level Flatness, 1 MHz to 10 MHz	-3.0 dB	(4)		±0.142 dB
	Positive Level Flatness, >10 MHz to 1.5 GHz		(5)	2.0 dB	±0.142 dB
	Negative Level Flatness, >10 MHz to 1.5 GHz	-2.0 dB	(6)		±0.142 dB
	Positive Level Flatness, >1.5 GHz		(7)	2.0 dB	±0.142 dB
	Negative Level Flatness, >1.5 GHz	-2.0 dB	(8)		±0.142 dB

Table 3-6 Agilent E4403B Performance Verification Test Record

Agilent Technologies					
Mod	el E4403B	Report No			
Seria	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
46.	Tracking Generator Harmonic Spurious Outputs (Option 1DN only)				
	2 nd Harmonic, <20 kHz		(1)	–15 dBc	±2.6 dB
	2 nd Harmonic, ≥20 kHz		(2)	–25 dBc	±2.6 dB
	3 rd Harmonic, <20 kHz		(3)	–15 dBc	±2.6 dB
	3 rd Harmonic, ≥20 kHz		(4)	–25 dBc	±2.6 dB
48.	Tracking Generator Non-Harmonic Spurious Outputs (Option 1DN only)				
	Highest Non-Harmonic Spurious Output Amplitude, 9 kHz to 2 GHz		(1)	–27 dBc	±2.63 dB
	Highest Non-Harmonic Spurious Output Amplitude, 2 GHz to 3 GHz		(2)	–23 dBc	±3.14 dB
49.	Tracking Generator L.O. Feedthrough (Option 1DN only)				
	9 kHz to 2.9 GHz		(1)	–16 dBm	±2.58 dB
	2.9 GHz to 3.0 GHz		(2)	-16 dBm	±3.08 dB

Agilent E4404B Performance Verification Test Record

Tests for the Agilent E4404B only are included in this test record, therefore not all test numbers are included.

Table 3-7 Agilent E4404B Performance Verification Test Record

Agilent Technologies				
Address:		Report No		
		Date		
Model E4404B				
Serial No		Ambient temperature	e° C	
Options		Relative humidity	%	
Firmware Revision		Power mains line free (nominal)	quency Hz	
Customer		Tested by		
Test Equipment Used:				
Description	Model No.	Trace No.	Cal Due Date	
Synthesized Signal Generator				
Wide Offset Phase Noise Signal Generator				
Synthesized Sweeper #1				
Synthesized Sweeper #2				
Function Generator				
Power Meter, Dual-Channel				
RF Power Sensor #1				
RF Power Sensor #2				
Microwave Power Sensor				
Low-Power Power Sensor				
Digital Multimeter				
Universal Counter				
Frequency Standard				

Table 3-7 Agilent E4404B Performance Verification Test Record

Power Splitter	 	
50 Ω Termination	 	
1 dB Step Attenuator	 	
10 dB Step Attenuator	 	
Oscilloscope (Option 1D6 only)	 	
Microwave Spectrum Analyzer (Option 1DN only)	 	
Notes/comments:	 	

Table 3-8 Agilent E4404B Performance Verification Test Record

Agilent Technologies						
Mod	el E4404B			Report No		
Seria	al No			Date		
Test Description			Minimum	Results Measured	Maximum	Measurement Uncertainty
1.	10 MHz Refer Accuracy (Non-Option 1L					
	Settability		$-5.0~\mathrm{Hz}$	(1)	5.0 Hz	$\pm 293.3~\mu Hz$
2.	10 MHz High- Frequency Re Output Accur (Option 1D5 on	eference acy				
	5 Minute War	m-Up Error	-0.1 ppm	(1)	0.1 ppm	$\pm 0.000072~\mathrm{ppm}$
	15 Minute War	m-Up Error	-0.01 ppm	(2)	0.01 ppm	$\pm 0.000070~\mathrm{ppm}$
4.	Frequency Re Marker Frequ Count Accura	iency				
	Frequency Read Accuracy	dout				
	Center Freq	Span				
	$1500~\mathrm{MHz}$	$20~\mathrm{MHz}$	1499.83 MHz	(1)	1500.17 MHz	±0 Hz
	$1500~\mathrm{MHz}$	10 MHz	1499.91 MHz	(2)	1500.09 MHz	±0 Hz

Table 3-8 Agilent E4404B Performance Verification Test Record

Agilent Technologies	
Model E4404B	Report No
Serial No	Date

	ai 110:		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	1500 MHz 1 MHz	1499.991 MHz	(3)	1500.009 MHz	±0 Hz
	4000 MHz 20 MHz	3999.83 MHz	(4)	4000.17 MHz	±0 Hz
	4000 MHz 10 MHz	3999.91 MHz	(5)	4000.09 MHz	±0 Hz
	4000 MHz 1 MHz	3999.991 MHz	(6)	4000.009 MHz	±0 Hz
	Marker Count Accuracy				
	Center Freq Span				
	1500 MHz 20 MHz	1499.999999 MHz	(16)	1500.000001 MHz	±0 Hz
	1500 MHz 1 MHz	1499.999999 MHz	(17)	1500.000001 MHz	±0 Hz
	4000 MHz 20 MHz	3999.999999 MHz	(18)	4000.000001 MHz	±0 Hz
	4000 MHz 1 MHz	3999.999999 MHz	(19)	4000.000001 MHz	±0 Hz
6.	Frequency Span Accuracy				
	Span Start Freq				
	3000 MHz 0 Hz	2370 MHz	(1)	2430 MHz	±6.12 MHz
	100 MHz 10 MHz	79 MHz	(2)	81 MHz	±204 kHz
	100 kHz 10 MHz	79 kHz	(3)	81 kHz	±204 Hz
	100 MHz 800 MHz	79 MHz	(4)	81 MHz	±204 kHz
	100 kHz 800 MHz	79 kHz	(5)	81 kHz	±204 Hz
	100 MHz 1400 MHz	79 MHz	(6)	81 MHz	±204 kHz
	100 kHz 1499 MHz	79 kHz	(7)	81 kHz	±204 Hz

Table 3-8 Agilent E4404B Performance Verification Test Record

Agile	Agilent Technologies					
Mod	el E4404B		Report No			
Seria	al No		Date			
Test Description Minimum		Results Measured	Maximum	Measurement Uncertainty		
7.	Noise Sidebands					
	Offset from 1 GHz signal					
	$(Serial\ Prefix < US4510,\ SG4510\ or\ MY4510)$					
	$10~\mathrm{kHz}$		(1)	–90 dBc/Hz	±2.44 dB	
	$20~\mathrm{kHz}$		(2)	-100 dBc/Hz	±2.44 dB	
	$30~\mathrm{kHz}$		(3)	$-106~\mathrm{dBc/Hz}$	±2.44 dB	
	(Serial Prefix \geq US4510, SG4510 or MY4510, Option 1DR)					
	$10~\mathrm{kHz}$		(1)	–98 dBc/Hz	±2.44 dB	
	$20~\mathrm{kHz}$		(2)	$-104~\mathrm{dBc/Hz}$	±2.44 dB	
	$30~\mathrm{kHz}$		(3)	-110 dBc/Hz	±2.44 dB	
	(Serial Prefix \geq US4510, SG4510 or MY4510, Non-Option 1DR)					
	$10~\mathrm{kHz}$		(1)	–90 dBc/Hz	±2.44 dB	
	$20~\mathrm{kHz}$		(2)	$-104~\mathrm{dBc/Hz}$	±2.44 dB	
	$30~\mathrm{kHz}$		(3)	-110 dBc/Hz	±2.44 dB	
8.	Noise Sidebands - Wide Offsets		ta in the appropriat Option 120 (ACPR			
	Non-Option 120					
	Offset from 1 GHz signal					
	$100~\mathrm{kHz}$		(1)	-118 dBc/Hz	±2.44 dB	
	1 MHz		(2)	-125 dBc/Hz	±2.44 dB	
	$5~\mathrm{MHz}$		(3)	-127 dBc/Hz	±2.44 dB	
	$10~\mathrm{MHz}$		(4)	–131 dBc/Hz	±2.44 dB	

Table 3-8 **Agilent E4404B Performance Verification Test Record**

Agilent Technologies					
Mod	el E4404B		Report No.		
Seri	al No		Date		
Test Description Minimum		Results Measured	Maximum	Measurement Uncertainty	
	Option 120				
	Offset from 1 GHz signal				
	100 kHz		(1)	-118 dBc/Hz	±2.44 dB
	1 MHz		(2)	-133 dBc/Hz	±2.44 dB
	5 MHz		(3)	-135 dBc/Hz	±2.44 dB
	10 MHz		(4)	-137 dBc/Hz	±2.44 dB
9.	System-Related Sidebands				
	Offset from 500 MHz signal				
	30 kHz to 230 kHz		(1)	-65 dBc	±1.30 dB
	–30 kHz to –230 kHz		(2)	-65 dBc	±1.30 dB
10.	Residual FM				
	1 kHz Res BW, (Non-Option 1D5)		(1)	150 Hz	±21 Hz
	1 kHz Res BW, (Option 1D5)		(1)	100 Hz	±21 Hz
	10 Hz Res BW (Options 1DR and 1D5 only)		(2)	2 Hz	±0.27 Hz
11.	Sweep Time Accuracy				
	Sweep Time				
	5 ms	-1.0%	(1)	1.0%	±0.16%
	20 ms	-1.0%	(2)	1.0%	±0.16%
	100 ms	-1.0%	(3)	1.0%	±0.16%
	1 s	-1.0%	(4)	1.0%	±0.16%
	10 s	-1.0%	(5)	1.0%	±0.16%

 $(5)_{-}$

Chapter 3 499

Table 3-8 Agilent E4404B Performance Verification Test Record

Agilent Technologies						
Mod	el E4404B		Report No			
Seri	al No		Date			
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
	$1 \operatorname{ms} (Option AYX or B7D \\ only)$	-1.0%	(6)	1.0%	±0.16%	
	500 μs (Option AYX or B7D only)	-1.0%	(7)	1.0%	$\pm 0.16\%$	
	100 μs (Option AYX or B7D only)	-1.0%	(8)	1.0%	±0.16%	
12.	Display Scale Fidelity					
	Cumulative Log Fidelity, Res BW ≥1 kHz					
	dB from Ref Level					
	-4	-0.30 dB	(1)	0.30 dB	±0.082 dB	
	-8	-0.30 dB	(2)	0.30 dB	±0.078 dB	
	-12	-0.40 dB	(3)	0.40 dB	±0.075 dB	
	-16	-0.40 dB	(4)	0.40 dB	±0.073 dB	
	-20	-0.40 dB	(5)	0.40 dB	±0.078 dB	
	-24	-0.50 dB	(6)	0.50 dB	±0.074 dB	
	-28	-0.50 dB	(7)	0.50 dB	±0.073 dB	
	-32	-0.60 dB	(8)	0.60 dB	±0.077 dB	
	-36	-0.60 dB	(9)	0.60 dB	±0.075 dB	
	-40	-0.60 dB	(10)	0.60 dB	±0.081 dB	
	-44	-0.70 dB	(11)	0.70 dB	±0.077 dB	
	-48	-0.70 dB	(12)	0.70 dB	$\pm 0.076~\mathrm{dB}$	
	-52	-0.70dB	(13)	0.70 dB	±0.080 dB	
	-56	-0.70 dB	(14)	0.70 dB	±0.078 dB	
	-60	-0.70 dB	(15)	0.70 dB	±0.084 dB	
	-64	-0.80 dB	(16)	0.80 dB	±0.081 dB	

(17)_

-0.80 dB

-68

500 Chapter 3

 $0.80~\mathrm{dB}$

±0.080 dB

Table 3-8 Agilent E4404B Performance Verification Test Record

Agilent Technologies	
Model E4404B	Report No
Serial No	Date

Serial No		Date			
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
-72	-0.80 dB	(18)	0.80 dB	±0.084 dB	
-76	-0.80 dB	(19)	0.80 dB	±0.083 dB	
-80	-0.80 dB	(20)	0.80 dB	±0.089 dB	
-84	-1.15 dB	(21)	1.15 dB	±0.086 dB	
Incremental Log Fidelity, Res BW ≥1 kHz					
dB from Ref Level					
-4	-0.4 dB	(22)	0.4 dB	±0.082 dB	
-8	-0.4 dB	(23)	0.4 dB	±0.078 dB	
-12	-0.4 dB	(24)	0.4 dB	±0.075 dB	
-16	-0.4 dB	(25)	0.4 dB	±0.073 dB	
-20	-0.4 dB	(26)	0.4 dB	±0.078 dB	
-24	-0.4 dB	(27)	0.4 dB	±0.074 dB	
-28	-0.4 dB	(28)	0.4 dB	±0.073 dB	
-32	-0.4 dB	(29)	0.4 dB	±0.077 dB	
-36	-0.4 dB	(30)	0.4 dB	±0.075 dB	
-40	-0.4 dB	(31)	0.4 dB	±0.081 dB	
-44	-0.4 dB	(32)	0.4 dB	±0.077 dB	
-48	-0.4 dB	(33)	0.4 dB	±0.076 dB	
-52	-0.4 dB	(34)	0.4 dB	±0.080 dB	
-56	-0.4 dB	(35)	0.4 dB	±0.078 dB	
-60	-0.4 dB	(36)	0.4 dB	±0.084 dB	
-64	-0.4 dB	(37)	0.4 dB	±0.081 dB	
-68	-0.4 dB	(38)	0.4 dB	±0.080 dB	
-72	-0.4 dB	(39)	0.4 dB	±0.084 dB	
-76	-0.4 dB	(40)	0.4 dB	±0.083 dB	

Table 3-8 Agilent E4404B Performance Verification Test Record

	Dogulta	Maggunomant
Serial No.	Date	
Model E4404B	Report No	
Agilent Technologies		

Serial No		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
-80	-0.4 dB	(41)	0.4 dB	±0.089 dB
Cumulative Log Fidelity, Res BW ≤300 Hz (Option 1DR only)				
dB from Ref Level				
_4	-0.34 dB	(43)	0.34 dB	±0.082 dB
-8	-0.38 dB	(44)	0.38 dB	±0.078 dB
-12	-0.42 dB	(45)	0.42 dB	±0.075 dB
-16	-0.46 dB	(46)	0.46 dB	±0.073 dB
-20	-0.50 dB	(47)	0.50 dB	±0.078 dB
-24	-0.54 dB	(48)	0.54 dB	±0.074 dB
-28	-0.58 dB	(49)	0.58 dB	±0.073 dB
-32	-0.62 dB	(50)	0.62 dB	±0.077 dB
-36	-0.66 dB	(51)	0.66 dB	±0.075 dB
-40	-0.70 dB	(52)	0.70 dB	±0.081 dB
-44	-0.74 dB	(53)	0.74 dB	±0.077 dB
-48	-0.78 dB	(54)	0.78 dB	±0.076 dB
-52	-0.82 dB	(55)	0.82 dB	±0.080 dB
-56	-0.86 dB	(56)	0.86 dB	±0.078 dB
-60	-0.90 dB	(57)	0.90 dB	±0.084 dB
-64	-0.94 dB	(58)	0.94 dB	±0.081 dB
-68	-0.98 dB	(59)	0.98 dB	±0.080 dB
-72	-1.02 dB	(60)	1.02 dB	±0.084 dB
-76	-1.06 dB	(61)	1.06 dB	±0.083 dB
-80	-1.10 dB	(62)	1.10 dB	±0.089 dB
-84	-1.14 dB	(63)	1.14 dB	±0.086 dB

Table 3-8 Agilent E4404B Performance Verification Test Record

Agilent Technologies	
Model E4404B	Report No
Serial No	Date

Serial N	0		Date		
Test Des	cription	Minimum	Results Measured	Maximum	Measurement Uncertainty
-88	3	-1.18 dB	(64)	1.18 dB	±0.085 dB
-92	2	-1.22 dB	(65)	1.22 dB	±0.100 dB
-96	3	-1.26 dB	(66)	1.26 dB	±0.099 dB
-98	3	-1.28 dB	(67)	1.28 dB	±0.098 dB
Res	remental Log Fidelity, s BW ≤300 Hz otion 1DR only)				
dB	from Ref Level				
-4		-0.4 dB	(68)	0.4 dB	±0.082 dB
-8		-0.4 dB	(69)	0.4 dB	$\pm 0.078~\mathrm{dB}$
-12	2	-0.4 dB	(70)	0.4 dB	$\pm 0.075~\mathrm{dB}$
-16	3	-0.4 dB	(71)	0.4 dB	$\pm 0.073~\mathrm{dB}$
-20)	-0.4 dB	(72)	0.4 dB	±0.078 dB
-24	1	-0.4 dB	(73)	0.4 dB	±0.074 dB
-28	3	-0.4 dB	(74)	0.4 dB	±0.073 dB
-32	2	-0.4 dB	(75)	0.4 dB	±0.077 dB
-36	3	-0.4 dB	(76)	0.4 dB	$\pm 0.075~\mathrm{dB}$
-40)	-0.4 dB	(77)	0.4 dB	±0.081 dB
-44	1	-0.4 dB	(78)	0.4 dB	±0.077 dB
-48	3	-0.4 dB	(79)	0.4 dB	±0.076 dB
-52	2	-0.4 dB	(80)	0.4 dB	±0.080 dB
-56	3	-0.4 dB	(81)	0.4 dB	±0.078 dB
-60)	-0.4 dB	(82)	0.4 dB	±0.084 dB
-64	1	-0.4 dB	(83)	0.4 dB	±0.081 dB
-68	3	-0.4 dB	(84)	0.4 dB	±0.080 dB
-72	2	-0.4 dB	(85)	0.4 dB	±0.084 dB

Table 3-8 Agilent E4404B Performance Verification Test Record

Agilent Technologies		
Model E4404B	Report No	
Serial No	Date	
	Rosults	Magguramant

Serial No.		Date			
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
-76	-0.4 dB	(86)	0.4 dB	±0.083 dB	
-80	-0.4 dB	(87)	0.4 dB	±0.089 dB	
Linear Fidelity, Res BW ≥1 kHz					
dB from Ref Level					
-4	-2.0%	(93)	2.0%	±0.064%	
-8	-2.0%	(94)	2.0%	±0.064%	
-12	-2.0%	(95)	2.0%	±0.064%	
-16	-2.0%	(96)	2.0%	±0.064%	
-20	-2.0%	(97)	2.0%	±0.063%	
Linear Fidelity, Res BW ≤300 Hz (Option 1DR only)					
dB from Ref Level					
-4	-2.0%	(98)	2.0%	±0.064%	
-8	-2.0%	(99)	2.0%	±0.064%	
-12	-2.0%	(100)	2.0%	±0.064%	
-16	-2.0%	(101)	2.0%	±0.064%	
-20	-2.0%	(102)	2.0%	±0.063%	
Zero Span, Res BW ≤300 Hz (Option 1DR only)					
dB from Ref Level					
-4	-0.36 dB	(103)	0.36 dB	±0.082 dB	
-8	-0.42 dB	(104)	0.42 dB	±0.078 dB	
-12	-0.48 dB	(105)	0.48 dB	±0.075 dB	
-16	-0.54 dB	(106)	0.54 dB	±0.073 dB	
-20	-0.60 dB	(107)	0.60 dB	±0.078 dB	

Table 3-8 Agilent E4404B Performance Verification Test Record

Agilent Technologies	
Model E4404B	Report No
Serial No	Date

Serial No Date			Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	-24	-0.66 dB	(108)	0.66 dB	±0.074 dB
	-28	-0.72 dB	(109)	0.72 dB	±0.073 dB
	-32	-0.78 dB	(110)	0.78 dB	±0.077 dB
	-36	-0.84 dB	(111)	0.84 dB	±0.075 dB
	-40	-0.90 dB	(112)	0.90 dB	±0.081 dB
	-44	-0.96 dB	(113)	0.96 dB	±0.077 dB
	-48	-1.02 dB	(114)	1.02 dB	±0.076 dB
	-52	-1.08 dB	(115)	1.08 dB	±0.080 dB
	-56	-1.14 dB	(116)	1.14 dB	±0.078 dB
	-60	-1.20 dB	(117)	1.20 dB	±0.084 dB
	-64	-1.5 dB	(118)	1.5 dB	±0.081 dB
	-68	-1.5 dB	(119)	1.5 dB	±0.080 dB
	-70	-1.5 dB	(120)	1.5 dB	±0.084 dB
13.	Input Attenuation Switching Uncertainty				
	Input Attenuation Setting				
	0 dB	-0.3 dB	(1)	0.3 dB	±0.101 dB
	5 dB	-0.3 dB	(2)	0.3 dB	±0.104 dB
	15 dB	-0.3 dB	(3)	0.3 dB	±0.102 dB
	20 dB	-0.3 dB	(4)	0.3 dB	±0.098 dB
	25 dB	-0.35 dB	(5)	0.35 dB	±0.098 dB
	30 dB	-0.40 dB	(6)	0.40 dB	±0.096 dB
	35 dB	-0.45 dB	(7)	0.45 dB	±0.099 dB
	40 dB	-0.50 dB	(8)	0.50 dB	±0.096 dB
	45 dB	-0.55 dB	(9)	0.55 dB	±0.099 dB
	50 dB	-0.60 dB	(10)	0.60 dB	±0.095 dB

Table 3-8 Agilent E4404B Performance Verification Test Record

Agilent Technologies						
Mod	el E4404B		Report No			
Seri	al No		Date			
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
	55 dB	-0.65 dB	(11)	0.65 dB	±0.099 dB	
	60 dB	-0.70 dB	(12)	0.70 dB	±0.100 dB	
	65 dB	−0.75 dB	(13)	0.75 dB	±0.111 dB	
15.	Reference Level Accuracy					
	Log, Res BW ≥1 kHz					
	Reference Level					
	-10 dBm	-0.3 dB	(1)	0.3 dB	±0.091 dB	
	0 dBm	-0.3 dB	(2)	0.3 dB	±0.100 dB	
	-30 dBm	-0.3 dB	(3)	0.3 dB	±0.092 dB	
	-40 dBm	-0.3 dB	(4)	0.3 dB	±0.094 dB	
	–50 dBm	-0.5 dB	(5)	0.5 dB	±0.095 dB	
	-60 dBm	-0.5 dB	(6)	0.5 dB	±0.097 dB	
	-70 dBm	-0.5 dB	(7)	0.5 dB	±0.099 dB	
	-80 dBm	-0.7 dB	(8)	0.7 dB	±0.101 dB	
	Linear, Res BW ≥1 kHz					
	Reference Level					
	-10 dBm	-0.3 dB	(9)	0.3 dB	±0.091 dB	
	0 dBm	-0.3 dB	(10)	0.3 dB	±0.100 dB	
	-30 dBm	-0.3 dB	(11)	0.3 dB	±0.092 dB	
	-40 dBm	-0.3 dB	(12)	0.3 dB	±0.094 dB	
	-50 dBm	-0.5 dB	(13)	0.5 dB	±0.095 dB	
	-60 dBm	-0.5 dB	(14)	0.5 dB	±0.097 dB	
	-70 dBm	-0.5 dB	(15)	0.5 dB	±0.099 dB	
	_80 dBm	_0 7 dB	(16)	0 7 dB	+0 101 dB	

Table 3-8 Agilent E4404B Performance Verification Test Record

Agilent Technologies	
Model E4404B	Report No.
Serial No.	Date

Serial No Date					
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	Log, Res BW ≤300 Hz (Option 1DR only)				
	Reference Level				
	-10 dBm	-0.3 dB	(17)	0.3 dB	±0.091 dB
	0 dBm	-0.3 dB	(18)	0.3 dB	±0.100 dB
	-30 dBm	-0.3 dB	(19)	0.3 dB	±0.092 dB
	-40 dBm	-0.3 dB	(20)	0.3 dB	±0.094 dB
	–50 dBm	-0.5 dB	(21)	0.5 dB	±0.095 dB
	-60 dBm	-0.5 dB	(22)	0.5 dB	±0.097 dB
	–70 dBm	-0.5 dB	(23)	0.5 dB	±0.099 dB
	-80 dBm	-0.7 dB	(24)	0.7 dB	±0.101 dB
	Linear, Res BW \leq 300 Hz (Option 1DR only)				
	Reference Level				
	-10 dBm	-0.3 dB	(25)	0.3 dB	±0.091 dB
	0 dBm	-0.3 dB	(26)	0.3 dB	±0.100 dB
	–30 dBm	-0.3 dB	(27)	0.3 dB	±0.092 dB
	-40 dBm	-0.3 dB	(28)	0.3 dB	±0.094 dB
	–50 dBm	-0.5 dB	(29)	0.5 dB	±0.095 dB
	-60 dBm	-0.5 dB	(30)	0.5 dB	±0.097 dB
	-70 dBm	-0.5 dB	(31)	0.5 dB	±0.099 dB
	-80 dBm	-0.7 dB	(32)	0.7 dB	±0.101 dB
16.	Resolution Bandwidth Switching Uncertainty				
	Resolution Bandwidth				
	3 kHz	-0.3 dB	(1)	0.3 dB	±0.048 dB
	9 kHz	-0.3 dB	(2)	0.3 dB	±0.048 dB

Agilent E4404B Performance Verification Test Record Table 3-8

Agilent Technologies					
Mod	el E4404B		Report No		
Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	10 kHz	-0.3 dB	(3)	0.3 dB	±0.048 dB
	30 kHz	-0.3 dB	(4)	0.3 dB	±0.048 dB
	100 kHz	-0.3 dB	(5)	0.3 dB	±0.048 dB
	120 kHz	-0.3 dB	(6)	0.3 dB	±0.048 dB
	300 kHz	-0.3 dB	(7)	0.3 dB	±0.048 dB
	1 MHz	-0.3 dB	(8)	0.3 dB	±0.048 dB
	3 MHz	-0.3 dB	(9)	0.3 dB	±0.048 dB
	5 MHz	-0.6 dB	(10)	0.6 dB	±0.076 dB
	300 Hz (Option 1DR only)	-0.3 dB	(11)	0.3 dB	±0.048 dB
	200 Hz (Option 1DR only)	-0.3 dB	(12)	0.3 dB	±0.048 dB
	100 Hz (Option 1DR only)	-0.3 dB	(13)	0.3 dB	±0.048 dB
	30 Hz (Option 1DR only)	-0.3 dB	(14)	0.3 dB	±0.048 dB
	10 Hz (Option 1DR only)	-0.3 dB	(15)	0.3 dB	±0.048 dB
	3 Hz (Option 1DR and 1D5 only) Firmware Revision A.08.00 or later	-0.3 dB	(16)	0.3 dB	±0.048 dB
	1Hz (Option 1DR and 1D5 only) Firmware Revision A.08.00 or later	-0.3 dB	(17)	0.3 dB	±0.048 dB
18.	Absolute Amplitude Accuracy (Reference Settings)				
	Log, Preamp Off	-0.34 dB	(1)	0.34 dB	±0.09 dB
	Lin, Preamp Off	-0.34 dB	(2)	0.34 dB	±0.09 dB
	Log, Preamp On (Option 1DS only)	-0.37 dB	(3)	0.37 dB	±0.09 dB
	Lin, Preamp On	-0.37 dB	(4)	0.37 dB	±0.09 dB

(Option 1DS only)

Overall Absolute Amplitude Accuracy

20.

508 **Chapter 3**

Table 3-8 Agilent E4404B Performance Verification Test Record

Agilent Technologies	
Model E4404B	Report No
Serial No	Date

Seri	al No	Date			
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	0 dBm Reference Level				
	0 dBm input	−0.54 dB	(1)	0.54 dB	±0.234 dB
	–10 dBm input	-0.54 dB	(2)	0.54 dB	±0.115 dB
	–20 dBm input	-0.54 dB	(3)	0.54 dB	±0.110 dB
	–30 dBm input	-0.54 dB	(4)	0.54 dB	±0.109 dB
	–40 dBm input	−0.54 dB	(5)	0.54 dB	±0.109 dB
	–50 dBm input	−0.54 dB	(6)	0.54 dB	±0.109 dB
	–20 dBm Reference Level				
	–20 dBm input	-0.54 dB	(7)	0.54 dB	±0.109 dB
	–30 dBm input	-0.54 dB	(8)	0.54 dB	±0.109 dB
	–40 dBm input	−0.54 dB	(9)	0.54 dB	±0.109 dB
	–50 dBm input	-0.54 dB	(10)	0.54 dB	±0.109 dB
	–40 dBm Reference Level				
	–40 dBm input	-0.54 dB	(11)	0.54 dB	±0.087 dB
	–50 dBm input	-0.54 dB	(12)	0.54 dB	±0.087 dB
	–50 dBm Reference Level				
	–50 dBm input	-0.54 dB	(13)	0.54 dB	±0.087 dB
21.	Resolution Bandwidth Accuracy				
	Resolution Bandwidth				
	5 MHz	3.5 MHz	(1)	6.5 MHz	±110 kHz
	3 MHz	2.55 MHz	(2)	3.45 MHz	±66 kHz
	1 MHz	0.85 MHz	(3)	1.15 MHz	±22 kHz
	$300~\mathrm{kHz}$	255 kHz	(4)	345 kHz	±6.6 kHz
	100 kHz	85 kHz	(5)	115 kHz	±2.2 kHz
	30 kHz	25.5 kHz	(6)	34.5 kHz	±660 Hz

Table 3-8 Agilent E4404B Performance Verification Test Record

Agil	ent Technologies					
Mod	el E4404B		Report No			
Seri	al No		Date	-		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
	10 kHz	8.5 kHz	(7)	11.5 kHz	±220 Hz	
	3 kHz	$2.55~\mathrm{kHz}$	(8)	3.45 kHz	±66 Hz	
	1 kHz	850 Hz	(9)	1.15 kHz	±22 Hz	
	120 kHz	96 kHz	(10)	144 kHz	±2.17 kHz	
	9 kHz	7.2 kHz	(11)	10.8 kHz	±163 Hz	
24.	Frequency Response	the ambient to	Note: Enter data in the appropriate section below depending upon the ambient temperature at which the test was performed and installed options.			
	20 to 30° C					
	Non-Option UKB dc Coupled Band 0 (9 kHz to 3.0 GHz)					
	Maximum Response		(1)	0.46 dB	±0.19 dB	
	Minimum Response	-0.46 dB	(2)		±0.19 dB	
	Peak-to-Peak Response		(3)	0.92 dB	±0.19 dB	
	Option UKB dc Coupled Band 0 (100 Hz to 3.0 GHz)					
	Maximum Response		(1)	0.50 dB	±0.19 dB	
	Minimum Response	-0.50 dB	(2)		±0.19 dB	
	Peak-to-Peak Response		(3)	1.0 dB	±0.19 dB	
	dc Coupled Band 1 (3.0 GHz to 6.7 GHz)					
	Maximum Response		(4)	1.5 dB	±0.39 dB	
	Minimum Response	-1.5 dB	(5)		±0.39 dB	

Table 3-8 Agilent E4404B Performance Verification Test Record

Agilent Technologies	
Model E4404B	Report No.
Serial No	Date

Serial No	Date			
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
Peak-to-Peak Response		(6)	2.6 dB	±0.39 dB
ac Coupled Band 0 (100 kHz to 3.0 GHz)				
Maximum Response		(10)	0.5 dB	±0.11 dB
Minimum Response	−0.5 dB	(11)		±0.11 dB
Peak-to-Peak Response		(12)	1.0 dB	±0.11 dB
ac Coupled Band 0A (800 MHz to 1.0 GHz) (serial number US39440498 or greater)				
Maximum Response		(13)	0.5 dB	±0.11 dB
Minimum Response	-0.5 dB	(14)		±0.11 dB
Peak-to-Peak Response		(15)	1.0 dB	±0.11 dB
ac Coupled Band 0B (1.7 GHz to 2.0 GHz) (serial number US39440498 or greater)				
Maximum Response		(16)	0.5 dB	±0.11 dB
Minimum Response	-0.5 dB	(17)		±0.11 dB
Peak-to-Peak Response		(18)	1.0 dB	±0.11 dB
ac Coupled Band 1 (3.0 GHz to 6.7 GHz)				

Table 3-8 Agilent E4404B Performance Verification Test Record

Agilent Technologies						
Mod	el E4404B		Report No	Report No		
Seria	al No		Date			
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
	Maximum Response		(19)	1.5 dB	±0.39 dB	
	Minimum Response	-1.5 dB	(20)		±0.39 dB	
	Peak-to-Peak Response		(21)	2.6 dB	±0.39 dB	
	0 to 55° C Non-Option UKB dc Coupled Band 0 (9 kHz to 3.0 GHz) Maximum Response Minimum Response Peak-to-Peak Response	−0.76 dB	(1) (2) (3)	0.76 dB 1.52 dB	±0.19 dB ±0.19 dB ±0.19 dB	
	Option UKB dc Coupled Band 0 (100 Hz to 3.0 GHz)					
	Maximum Response		(1)	1.0 dB	±0.19 dB	
	Minimum Response	−1.0 dB	(2)		±0.19 dB	
	Peak-to-Peak Response		(3)	2.0 dB	±0.19 dB	
	dc Coupled Band 1 (3.0 GHz to 6.7 GHz) Maximum Response		(4)	2.5 dB	±0.39 dB	
	waximum nesponse	1	(4 <i>)</i>	⊿.ն նք	±0.59 ad	

 $-2.5~\mathrm{dB}$

Minimum Response

Peak-to-Peak Response

512 Chapter 3

 $3.0~\mathrm{dB}$

 $\pm 0.39~\mathrm{dB}$

 $\pm 0.39~\mathrm{dB}$

(5)_____

(6)____

Table 3-8 Agilent E4404B Performance Verification Test Record

Agilent Technologies	
Model E4404B	Report No
Serial No	Date

Serial No		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
ac Coupled Band 0 (100 kHz to 3.0 GHz)				
Maximum Response		(10)	1.0 dB	±0.11 dB
Minimum Response	-1.0 dB	(11)		±0.11 dB
Peak-to-Peak Response		(12)	2.0 dB	±0.11 dB
ac Coupled Band 0A (800 MHz to 1.0 GHz) (serial number US39440498 or greater)				
Maximum Response		(13)	1.0 dB	±0.11 dB
Minimum Response	-1.0 dB	(14)		±0.11 dB
Peak-to-Peak Response		(15)	2.0 dB	±0.11 dB
ac Coupled Band 0B (1.7 GHz to 2.0 GHz) (serial number US39440498 or greater)				
Maximum Response		(16)	1.0 dB	±0.11 dB
Minimum Response	-1.0 dB	(17)		±0.11 dB
Peak-to-Peak Response		(18)	2.0 dB	±0.11 dB
ac Coupled Band 1 (3.0 GHz to 6.7 GHz)				
Maximum Response		(19)	2.5 dB	±0.39 dB
Minimum Response	-2.5 dB	(20)		±0.39 dB

Table 3-8 Agilent E4404B Performance Verification Test Record

E4404B No scription Peak-to-Peak Response requency Response reamp On) ption 1DS Only) to 30° C and 0 MHz to 3.0 GHz) Maximum Response		emperature at wh		
Peak-to-Peak Response Requency Response Reamp On) Petion 1DS Only) Reamp On Only Response R	Note: Enter da	Results Measured (21) ata in the appropremperature at who	Maximum 3.0 dB	Uncertainty ±0.39 dB depending upon
Peak-to-Peak Response requency Response reamp On) ption 1DS Only) to 30° C and 0 MHz to 3.0 GHz)	Note: Enter da	Measured (21) ata in the appropremperature at whi	3.0 dB	Uncertainty ±0.39 dB depending upon
requency Response reamp On) ption 1DS Only) to 30° C and 0 MHz to 3.0 GHz)	the ambient to	ata in the appropremerature at wh	riate section below	depending upon
reamp On) ption 1DS Only) to 30° C and 0 MHz to 3.0 GHz)	the ambient to	emperature at wh		
and 0 MHz to 3.0 GHz)				
MHz to 3.0 GHz)				
Maximum Response				
		(1)	1.5 dB	±0.28 dB
Minimum Response	-1.5 dB	(2)		±0.28 dB
Peak-to-Peak Response		(3)	3.0 dB	±0.28 dB
and 0A 00 MHz to 1.0 GHz) erial number S39440498 or greater)				
Maximum Response		(4)	1.5 dB	±0.28 dB
Minimum Response	-1.5 dB	(5)		±0.28 dB
Peak-to-Peak Response		(6)	3.0 dB	±0.28 dB
and 0B 7 GHz to 2.0 GHz) erial number 539440498 or greater)				
Maximum Response		(7)	1.5 dB	±0.28 dB
Minimum Response	-1.5 dB	(8)		±0.28 dB
		(9)	3.0 dB	±0.28 dB
N N P	Maximum Response Minimum Response Meak-to-Peak Response and 0B GHz to 2.0 GHz) rial number 39440498 or greater) Maximum Response	Maximum Response Minimum Response Ind OB GHz to 2.0 GHz) GHz to greater) Maximum Response Minimum Response Ind OB Maximum Response	Maximum Response (4) Minimum Response -1.5 dB (5) Meak-to-Peak Response (6) Maximum Response (7) Maximum Response -1.5 dB (8)	Maximum Response (4)

Table 3-8 Agilent E4404B Performance Verification Test Record

Agilent Technologies	
Model E4404B	Report No.
Serial No	Date

Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	0 to 55° C				
	Band 0 (1 MHz to 3.0 GHz)				
	Maximum Response		(1)	2.0 dB	±0.28 dB
	Minimum Response	-2.0 dB	(2)		±0.28 dB
	Peak-to-Peak Response		(3)	4.0 dB	±0.28 dB
	Band 0A (800 MHz to 1.0 GHz) (serial number US39440498 or greater)				
	Maximum Response		(4)	2.0 dB	±0.28 dB
	Minimum Response	-2.0 dB	(5)		±0.28 dB
	Peak-to-Peak Response		(6)	4.0 dB	±0.28 dB
	Band 0B (1.7 GHz to 2.0 GHz) (serial number US39440498 or greater)				
	Maximum Response		(7)	2.0 dB	±0.28 dB
	Minimum Response	-2.0 dB	(8)		±0.28 dB
	Peak-to-Peak Response		(9)	4.0 dB	±0.28 dB
29.	Other Input-Related Spurious Responses				
	Center Freq Input Freq				
	2.0 GHz 2042.8 MHz		(1)	-65 dBc	±.891 dB
	2.0 GHz 2642.8 MHz		(2)	-65 dBc	±.891 dB
	2.0 GHz 1820.8 MHz		(3)	-65 dBc	±.891 dB
	2.0 GHz 278.5 MHz		(4)	-65 dBc	±.891 dB

Table 3-8 Agilent E4404B Performance Verification Test Record

Agilent Technologies						
Model E4404B			Report No			
Seri	al No		Date			
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
	2.0 GHz 5600.0 MHz		(5)	-80 dBc	±.891 dB	
	2.0 GHz 6242.8 MHz		(6)	-80 dBc	±.891 dB	
	4.0 GHz 4042.8 MHz		(7)	-65 dBc	±.891 dB	
	4.0 GHz 4642.8 MHz		(8)	-65 dBc	±.891 dB	
	4.0 GHz 3742.9 MHz		(9)	-65 dBc	±.891 dB	
	4.0 GHz 2242.8 MHz		(10)	-80 dBc	±.891 dB	
32.	Spurious Responses					
	300 MHz TOI, 1 kHz RBW	12.5 dBm	(1)		±0.93 dB	
	300 MHz TOI, 30 Hz RBW (Option 1DR only)	12.5 dBm	(2)		±0.93 dB	
	5 GHz TOI	11 dBm	(3)		±0.93 dB	
	300 MHz SHI	35 dBm	(5)		±0.41 dB	
	900 MHz SHI	45 dBm	(6)		±0.41 dB	
	1.55 GHz SHI	75 dBm	(7)		±0.41 dB	
	3.1 GHz SHI	90 dBm	(8)		±0.41 dB	
34.	Gain Compression					
	Test Frequency					
	53 MHz		(1)	1.0 dB	±0.123 dB	
	50.004 MHz (Option 1DR only)		(2)	1.0 dB	±0.123 dB	
	1403 MHz		(3)	1.0 dB	±0.123 dB	
	2503 MHz		(4)	1.0 dB	±0.123 dB	
	4403 MHz		(5)	1.0 dB	±0.123 dB	
37.	Displayed Average Noise Level		sults with preamp o ent temperature wh			
	1 kHz RBW, Preamp Off					

Table 3-8 Agilent E4404B Performance Verification Test Record

Agilent Technologies	
Model E4404B	Report No
Serial No	Date

Serial No.		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
10 MHz to 1 GHz		(1)	-116 dBm	±1.23 dB
1 GHz to 2 GHz		(2)	-116 dBm	±1.23 dB
2 GHz to 3 GHz		(3)	-112 dBm	±1.23 dB
3 GHz to 6 GHz		(4)	-112 dBm	±1.23 dB
6 GHz to 6.7 GHz		(5)	-111 dBm	±1.23 dB
1kHz RBW, Preamp On, 0 to 55° C				
10 MHz to 1 GHz		(6)	–131 dBm	±1.23 dB
1 GHz to 2 GHz		(7)	–131 dBm	±1.23 dB
2 GHz to 3 GHz		(8)	-127 dBm	±1.23 dB
10 Hz RBW, Preamp Off				
10 MHz to 1 GHz		(9)	–135 dBm	±1.23 dB
1 GHz to 2 GHz		(10)	–135 dBm	±1.23 dB
2 GHz to 3 GHz		(11)	–131 dBm	±1.23 dB
3 GHz to 6 GHz		(12)	–131 dBm	±1.23 dB
6 GHz to 6.7 GHz		(13)	-130 dBm	±1.23 dB
$10~Hz$ RBW, Preamp On, $0~to~55^{\circ}~\mathrm{C}$				
10 MHz to 1 GHz		(14)	-150 dBm	±1.23 dB
1 GHz to 2 GHz		(15)	-150 dBm	±1.23 dB
2 GHz to 3 GHz		(16)	-146 dBm	±1.23 dB
1 kHz RBW, Preamp On, 20 to 30° C				
10 MHz to 1 GHz		(17)	-132 dBm	±1.23 dB
1 GHz to 2 GHz		(18)	-132 dBm	±1.23 dB
2 GHz to 3 GHz		(19)	-130 dBm	±1.23 dB

Table 3-8 Agilent E4404B Performance Verification Test Record

Agilent Technologies						
Mod	el E4404B		Report No.			
Serial No			Date			
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
	10 Hz RBW, Preamp On, 20 to 30° C					
	10 MHz to 1 GHz		(20)	–151 dBm	±1.23 dB	
	1 GHz to 2 GHz		(21)	–151 dBm	±1.23 dB	
	$2~\mathrm{GHz}$ to $3~\mathrm{GHz}$		(22)	-149 dBm	±1.23 dB	
39.	Residual Responses					
	150 kHz to 6.7 GHz		(1)	-90 dBm	±0.87 dB	
40.	Fast Time Domain Amplitude Accuracy (Option AYX only)					
	Amplitude Error	-0.3%	(1)	0.3%	±0.029%	
42.	Tracking Generator Absolute Amplitude and Vernier Accuracy Option 1DN only)					
	Absolute Amplitude Accuracy	−0.75 dB	(1)	0.75 dB	±0.096 dB	
	Absolute Vernier Accuracy					
	−2 dB	-0.5 dB	(2)	0.5 dB	±0.008 dB	
	-3 dB	-0.5 dB	(3)	0.5 dB	±0.008 dB	
	−5 dB	-0.5 dB	(4)	0.5 dB	±0.008 dB	
	-6 dB	-0.5 dB	(5)	0.5 dB	±0.008 dB	
	-7 dB	-0.5 dB	(6)	0.5 dB	±0.008 dB	
	-8 dB	-0.5 dB	(7)	0.5 dB	±0.008 dB	
	–9 dB	-0.5 dB	(8)	0.5 dB	±0.008 dB	
	-10 dB	−0.5 dB	(9)	0.5 dB	±0.008 dB	
	Incremental Vernier Accuracy					

Table 3-8 Agilent E4404B Performance Verification Test Record

Agilent Technologies	
Model E4404B	Report No.
Serial No	Date

	ai 110:		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	-2 dB	-0.2 dB	(10)	0.2 dB	±0.008 dB
	-3 dB	−0.2 dB	(11)	0.2 dB	±0.008 dB
	−5 dB	-0.2 dB	(12)	0.2 dB	±0.008 dB
	-6 dB	−0.2 dB	(13)	0.2 dB	±0.008 dB
	−7 dB	−0.2 dB	(14)	0.2 dB	±0.008 dB
	-8 dB	-0.2 dB	(15)	0.2 dB	±0.008 dB
	-9 dB	-0.2 dB	(16)	0.2 dB	±0.008 dB
	-10 dB	-0.2 dB	(17)	0.2 dB	±0.008 dB
44.	Tracking Generator Level Flatness Option 1DN only)				
	Positive Level Flatness, <1 MHz		(1)	3.0 dB	±0.284 dB
	Negative Level Flatness, <1 MHz	-3.0 dB	(2)		±0.284 dB
	Positive Level Flatness, 1 MHz to 10 MHz		(3)	3.0 dB	±0.142 dB
	Negative Level Flatness, 1 MHz to 10 MHz	-3.0 dB	(4)		±0.142 dB
	Positive Level Flatness, >10 MHz to 1.5 GHz		(5)	2.0 dB	±0.142 dB
	Negative Level Flatness, >10 MHz to 1.5 GHz	-2.0 dB	(6)		±0.142 dB
	Positive Level Flatness, >1.5 GHz		(7)	2.0 dB	±0.142 dB
	Negative Level Flatness, >1.5 GHz	-2.0 dB	(8)		±0.142 dB

Table 3-8 Agilent E4404B Performance Verification Test Record

Agil	ent Technologies					
Mod	el E4404B		Report No Date			
Seri	al No					
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
46.	Tracking Generator Harmonic Spurious Outputs (Option 1DN only)					
	2 nd Harmonic, <20 kHz		(1)	-15 dBc	±2.6 dB	
	2 nd Harmonic, ≥ 20 kHz		(2)	–25 dBc	±2.6 dB	
	3 rd Harmonic, <20 kHz		(3)	-15 dBc	±2.6 dB	
	3 rd Harmonic, ≥ 20 kHz		(4)	–25 dBc	±2.6 dB	
48.	Tracking Generator Non-Harmonic Spurious Outputs (Option 1DN only)					
	Highest Non-Harmonic Spurious Output Amplitude, 9 kHz to 2 GHz		(1)	–27 dBc	±2.63 dB	
	Highest Non-Harmonic Spurious Output Amplitude, 2 GHz to 3 GHz		(2)	–23 dBc	±3.14 dB	
49.	Tracking Generator L.O. Feedthrough (Option 1DN only)					
	9 kHz to 2.9 GHz		(1)	-16 dBm	±2.58 dB	
	2.9 GHz to 3.0 GHz		(2)	-16 dBm	±3.03 dB	
50.	Gate Delay Accuracy and Gate Length Accuracy (Option 1D6 only)					
	Minimum Gate Delay	499.9 ns	(1)	1.5001 μs	±549 ps	
	Maximum Gate Delay	499.9 ns	(2)	1.5001 μs	±549 ps	
	1 us Gate Length	1999ns	(3)	1 5001 us	+520 ng	

Table 3-8 Agilent E4404B Performance Verification Test Record

Agil	Agilent Technologies					
Mod	el E4404B		Report No.			
Seri	al No		Date			
Test Description		Minimum	Results Measured	Maximum	Measurement Uncertainty	
	65 ms Gate Length	64.993 ms	(4)	65.007 ms	±647 ns	
51.	Gate Mode Additional Amplitude Error (Option 1D6 only)					
	Amplitude Error	−0.2 dB	(1)	0.2 dB	±0.023 dB	
58.	GSM Phase and Frequency Error (Option BAH and B7E)					
	Peak Phase Error	-2.1 Deg	(1)	2.1 Deg	0.52 Deg	
	RMS Phase Error	-1.1 Deg	(2)	1.1 Deg	0.000063 Deg	
	Frequency Error	-10 Hz	(3)	10 Hz	±0.006 Hz	
59.	Comms Absolute Power Accuracy (Options BAC or BAH)					
	$20 ext{ to } 30^{\circ} ext{ C}$					
	cdmaOne Channel Power Accuracy (Option BAC only)					
	Cellular Band Input Amplitude					
	15 dBm	-0.82 dB	(1)	0.82 dB	±0.173 dB	
	−5 dBm	-0.82 dB	(2)	0.82 dB	±0.161 dB	
	−25 dBm	-0.78 dB	(3)	0.78 dB	±0.161 dB	
	-45 dBm	-0.69 dB	(4)	0.69 dB	±0.152 dB	
	-55 dBm	−0.77 dB	(5)	0.77 dB	±0.152 dB	
	-70 dBm	-0.89 dB	(6)	0.89 dB	±0.161 dB	
	PCS Band Input Amplitude					
	15 dBm	-0.78 dB	(7)	0.78 dB	±0.173 dB	
	−5 dBm	-0.78 dB	(8)	0.78 dB	±0.161 dB	

Table 3-8 Agilent E4404B Performance Verification Test Record

Agilent Technologies	
Model E4404B	Report No
Serial No	Date

Serial No		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
-25 dBm	-0.74 dB	(9)	0.74 dB	±0.161 dB
-45 dBm	-0.71 dB	(10)	0.71 dB	±0.152 dB
-55 dBm	-0.79 dB	(11)	0.79 dB	±0.152 dB
-70 dBm	-0.91 dB	(12)	0.91 dB	±0.161 dB
GSM Transmit Power Accuracy (Option BAH only) GSM Band Input Amplitude				
15 dBm	-0.81 dB	(13)	0.81 dB	±0.173 dB
-20 dBm	-0.81 dB	(14)	0.81 dB	±0.161 dB
-30 dBm	-0.74 dB	(15)	0.74 dB	±0.156 dB
-40 dBm	-0.79 dB	(16)	0.79 dB	±0.161 dB
-50 dBm	-0.95 dB	(17)	0.95 dB	±0.152 dB
-60 dBm	-1.09 dB	(18)	1.09 dB	±0.161 dB
DCS and PCS Bands Input Amplitude				
15 dBm	−0.77 dB	(19)	0.77 dB	±0.173 dB
-20 dBm	-0.77 dB	(20)	0.77 dB	±0.161 dB
-30 dBm	-0.70 dB	(21)	0.70 dB	±0.156 dB
-40 dBm	−0.75 dB	(22)	0.75 dB	±0.161 dB
-50 dBm	-0.91 dB	(23)	0.91 dB	±0.152 dB
-60 dBm	-1.05 dB	(24)	1.05 dB	±0.161 dB
cdmaOne Receive Channel Power, Preamp Off (Option BAC only)				
Cellular Band Input Amplitude				

Table 3-8 Agilent E4404B Performance Verification Test Record

Agilent Technologies	
Model E4404B	Report No
Serial No	Date

Serial No		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
-40 dBm	-1.46 dB	(25)	1.46 dB	±0.161 dB
-60 dBm	-1.46 dB	(26)	1.46 dB	±0.161 dB
-70 dBm	-1.46 dB	(27)	1.46 dB	±0.161 dB
-80 dBm	-1.46 dB	(28)	1.46 dB	±0.161 dB
-85 dBm	-1.46 dB	(29)	1.46 dB	±0.152 dB
PCS Band Input Amplitude				
-40 dBm	-1.35 dB	(30)	1.35 dB	±0.161 dB
-60 dBm	-1.35 dB	(31)	1.35 dB	±0.161 dB
-70 dBm	-1.35 dB	(32)	1.35 dB	±0.161 dB
-80 dBm	-1.35 dB	(33)	1.35 dB	±0.161 dB
-85 dBm	-1.35 dB	(34)	1.35 dB	±0.152 dB
cdmaOne Receive Channel Power, Preamp On (Option BAC only) Cellular Band				
Input Amplitude				
-40 dBm	-1.88 dB	(35)	1.88 dB	±0.161 dB
-60 dBm	-1.88 dB	(36)	1.88 dB	±0.161 dB
-70 dBm	-1.88 dB	(37)	1.88 dB	±0.161 dB
-80 dBm	-1.88 dB	(38)	1.88 dB	±0.161 dB
-90 dBm	-2.95 dB	(39)	2.95 dB	±0.161 dB
-100 dBm	-2.95 dB	(40)	2.95 dB	±0.161 dB
PCS Band Input Amplitude				
-40 dBm	-1.88 dB	(41)	1.88 dB	±0.161 dB
-60 dBm	-1.88 dB	(42)	1.88 dB	±0.161 dB

Table 3-8 Agilent E4404B Performance Verification Test Record

Agilent Technologies						
Model E4404B			Report No			
Serial No Date						
Test Description Minimum		Results Measured	Maximum	Measurement Uncertainty		
	-70 dBm	-1.88 dB	(43)	1.88 dB	±0.161 dB	
	-80 dBm	-1.88 dB	(44)	1.88 dB	±0.161 dB	
	-90 dBm	−2.95 dB	(45)	2.95 dB	±0.161 dB	
	-100 dBm	-2.95 dB	(46)	2.95 dB	±0.161 dB	

Agilent E4405B Performance Verification Test Record

Tests for the Agilent E4405B only are included in this test record, therefore not all test numbers are included.

Table 3-9 Agilent E4405B Performance Verification Test Record

Agilent Technologies			
Address:		Report No	
		Date	
Model E4405B			
Serial No		Ambient temperature	e° C
Options		Relative humidity	%
Firmware Revision	-	Power mains line free (nominal)	quency Hz
Customer		Tested by	
Test Equipment Used:			
Description	Model No.	Trace No.	Cal Due Date
Synthesized Signal Generator			
Wide Offset Phase Noise Signal Generator			
Synthesized Sweeper #1			
Synthesized Sweeper #2			
Function Generator			
Power Meter, Dual-Channel			
RF Power Sensor #1			
RF Power Sensor #2			
Microwave Power Sensor			
Low-Power Power Sensor			
Digital Multimeter			
Universal Counter			
Frequency Standard			

Table 3-9 Agilent E4405B Performance Verification Test Record

Power Splitter	 	
$50~\Omega$ Termination	 	
1 dB Step Attenuator	 	
10 dB Step Attenuator	 	
Oscilloscope (Option 1D6 only)	 	
Microwave Spectrum Analyzer (Option 1DN only)	 	
Notes/comments:	 	

Table 3-10 Agilent E4405B Performance Verification Test Record

Agilent Technologies						
Mod	el E4405B		Report No			
Seria	al No		Date			
Test Description		Minimum	Results Measured	Maximum	Measurement Uncertainty	
1.	10 MHz Reference Output Accuracy (Non-Option 1D5 only)					
	Settability	-5.0 Hz	(1)	5.0 Hz	±293.3 μHz	
2.	10 MHz High-Stability Frequency Reference Accuracy (Option 1D5 only) 5 Minute Warm-Up Error 15 Minute Warm-Up Error	-0.1 ppm -0.01 ppm	(1)(2)	0.1 ppm 0.01 ppm	±0.000072 ppm ±0.000070 ppm	
4.			ord Entries 10 throu			
	Frequency Readout Accuracy					
	Center Freq Span					
	1500 MHz 20 MHz	1499.83 MHz	(1)	1500.17 MHz	±0 Hz	
	1500 MHz 10 MHz	1499.91 MHz	(2)	$1500.09~\mathrm{MHz}$	±0 Hz	

Table 3-10 Agilent E4405B Performance Verification Test Record

Agil	Agilent Technologies						
Mod	Model E4405B			Report No.			
Seri	al No			Date			
Test	Description		Minimum	Results Measured	Maximum	Measurement Uncertainty	
	1500 MHz	1 MHz	1499.991 MHz	(3)	1500.009 MHz	±0 Hz	
	4000 MHz	$20~\mathrm{MHz}$	3999.83 MHz	(4)	4000.17 MHz	±0 Hz	
	4000 MHz	$10~\mathrm{MHz}$	3999.91 MHz	(5)	4000.09 MHz	±0 Hz	
	4000 MHz	1 MHz	3999.991 MHz	(6)	4000.009 MHz	±0 Hz	
	9000 MHz	$20~\mathrm{MHz}$	8999.83 MHz	(7)	9000.17 MHz	±0 Hz	
	9000 MHz	$10~\mathrm{MHz}$	8999.91 MHz	(8)	9000.09 MHz	±0 Hz	
	9000 MHz	1 MHz	8999.991 MHz	(9)	9000.009 MHz	±0 Hz	
	Marker Count Accuracy		Note: Enter results in the appropriate section below based upon the firmware revision of the analyzer.				
	Firmware Revision Prior to A.03.00						
	Center Freq	Span					
	1500 MHz	20 MHz	1499.999998 MHz	(16)	1500.000002 MHz	±0 Hz	
	1500 MHz	1 MHz	1499.999998 MHz	(17)	1500.000002 MHz	±0 Hz	
	4000 MHz	20 MHz	3999.999998 MHz	(18)	4000.000002 MHz	±0 Hz	
	4000 MHz	1 MHz	3999.999998 MHz	(19)	4000.000002 MHz	±0 Hz	
	9000 MHz	20 MHz	8999.999997 MHz	(20)	9000.000003 MHz	±0 Hz	
	9000 MHz	1 MHz	8999.999997 MHz	(21)	9000.000003 MHz	±0 Hz	
	Marker Count	Accuracy					
	Firmware Rev A.03.00 or late						

Table 3-10 Agilent E4405B Performance Verification Test Record

Agilent Technologies					
Mod	el E4405B		Report No		
Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	Center Freq Span				
	1500 MHz 20 MHz	1499.999999 MHz	(16)	1500.000001 MHz	±0 Hz
	1500 MHz 1 MHz	1499.999999 MHz	(17)	1500.000001 MHz	±0 Hz
	4000 MHz 20 MHz	3999.999999 MHz	(18)	4000.000001 MHz	±0 Hz
	4000 MHz 1 MHz	3999.999999 MHz	(19)	4000.000001 MHz	±0 Hz
	9000 MHz 20 MHz	8999.999999 MHz	(20)	9000.000001 MHz	±0 Hz
	9000 MHz 1 MHz	8999.999999 MHz	(21)	9000.000001 MHz	±0 Hz
6.	Frequency Span Accuracy				
	Span Start Freq				
	3000 MHz 0 Hz	2370 MHz	(1)	2430 MHz	±6.12 MHz
	100 MHz 10 MHz	79 MHz	(2)	81 MHz	±204 kHz
	100 kHz 10 MHz	79 kHz	(3)	81 kHz	±204 Hz
	100 MHz 800 MHz	79 MHz	(4)	81 MHz	±204 kHz
	100 kHz 800 MHz	79 kHz	(5)	81 kHz	±204 Hz
	100 MHz 1400 MHz	79 MHz	(6)	81 MHz	±204 kHz
	100 kHz 1499 MHz	79 kHz	(7)	81 kHz	±204 Hz
7.	Noise Sidebands				
	Offset from 1 GHz signal				
	(Serial Prefix < US4510, SG4510 or MY4510)				
	10 kHz		(1)	_90 dBc/Hz	+2 44 dB

Table 3-10 Agilent E4405B Performance Verification Test Record

Agilent Technologies						
Mod	el E4405B		Report No.			
Seri	al No	Date				
Test Description Minimum		Minimum	Results Measured	Maximum	Measurement Uncertainty	
	20 kHz		(2)	-100 dBc/Hz	±2.44 dB	
	$30~\mathrm{kHz}$		(3)	-106 dBc/Hz	±2.44 dB	
	(Serial Prefix ≥ US4510, SG4510 or MY4510, Option 1DR)					
	10 kHz		(1)	-98 dBc/Hz	±2.44 dB	
	$20~\mathrm{kHz}$		(2)	-104 dBc/Hz	±2.44 dB	
	$30~\mathrm{kHz}$		(3)	-110 dBc/Hz	±2.44 dB	
	(Serial Prefix ≥ US4510, SG4510 or MY4510, Non-Option 1DR)					
	10 kHz		(1)	-90 dBc/Hz	±2.44 dB	
	20 kHz		(2)	-104 dBc/Hz	±2.44 dB	
	$30~\mathrm{kHz}$		(3)	-110 dBc/Hz	±2.44 dB	
8.	Noise Sidebands - Wide Offsets		ata in the appropriate Option 120 (ACPR			
	Non-Option 120					
	Offset from 1 GHz signal					
	100 kHz		(1)	-118 dBc/Hz	±2.44 dB	
	1 MHz		(2)	-125 dBc/Hz	±2.44 dB	
	5 MHz		(3)	-127 dBc/Hz	±2.44 dB	
	10 MHz		(4)	-131 dBc/Hz	±2.44 dB	
	Option 120					
	Offset from 1 GHz signal					
	100 kHz		(1)	-118 dBc/Hz	±2.44 dB	
	1 MHz		(2)	-133 dBc/Hz	±2.44 dB	
	$5~\mathrm{MHz}$		(3)	-135 dBc/Hz	±2.44 dB	

Table 3-10 Agilent E4405B Performance Verification Test Record

Agil	ent Technologies					
Mod	el E4405B		Report No Date			
Seri	al No					
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
	10 MHz		(4)	-137 dBc/Hz	±2.44 dB	
9.	System-Related Sidebands					
	Offset from 500 MHz signal					
	30 kHz to 230 kHz		(1)	-65 dBc	±1.30 dB	
	–30 kHz to –230 kHz		(2)	-65 dBc	±1.30 dB	
10.	Residual FM					
	1 kHz Res BW (Non-Option 1D5)		(1)	150 Hz	±21 Hz	
	1 kHz Res BW (Option 1D5)		(1)	100 Hz	±21 Hz	
	10 Hz Res BW (Options 1DR and 1D5 only)		(2)	2 Hz	±0.27 Hz	
11.	Sweep Time Accuracy					
	Sweep Time					
	5 ms	-1.0%	(1)	1.0%	±0.16%	
	20 ms	-1.0%	(2)	1.0%	±0.16%	
	100 ms	-1.0%	(3)	1.0%	±0.16%	
	1 s	-1.0%	(4)	1.0%	±0.16%	
	10 s	-1.0%	(5)	1.0%	±0.16%	
	$1 \operatorname{ms} (Option AYX or B7D \ only)$	-1.0%	(6)	1.0%	±0.16%	
	500 µs (Option AYX or B7D only)	-1.0%	(7)	1.0%	±0.16%	
	100 µs (Option AYX or B7D only)	-1.0%	(8)	1.0%	±0.16%	
12.	Display Scale Fidelity					

Table 3-10 Agilent E4405B Performance Verification Test Record

Agilent Technologies	
Model E4405B	Report No.
Serial No	Date

Serial No	Date			
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
Cumulative Log Fidelity, Res BW ≥1 kHz				
dB from Ref Level				
-4	-0.30 dB	(1)	0.30 dB	±0.082 dB
-8	-0.30 dB	(2)	0.30 dB	±0.078 dB
-12	-0.40 dB	(3)	0.40 dB	±0.075 dB
-16	-0.40 dB	(4)	0.40 dB	±0.073 dB
-20	-0.40 dB	(5)	0.40 dB	±0.078 dB
-24	-0.50 dB	(6)	0.50 dB	±0.074 dB
-28	-0.50 dB	(7)	0.50 dB	±0.073 dB
-32	-0.60 dB	(8)	0.60 dB	±0.077 dB
-36	-0.60 dB	(9)	0.60 dB	±0.075 dB
-40	-0.60 dB	(10)	0.60 dB	±0.081 dB
_44	-0.70 dB	(11)	0.70 dB	±0.077 dB
-48	-0.70 dB	(12)	0.70 dB	±0.076 dB
-52	-0.70dB	(13)	0.70 dB	±0.080 dB
-56	-0.70 dB	(14)	0.70 dB	±0.078 dB
-60	-0.70 dB	(15)	0.70 dB	±0.084 dB
-64	-0.80 dB	(16)	0.80 dB	±0.081 dB
-68	-0.80 dB	(17)	0.80 dB	±0.080 dB
-72	-0.80 dB	(18)	0.80 dB	±0.084 dB
-76	-0.80 dB	(19)	0.80 dB	±0.083 dB
-80	-0.80 dB	(20)	0.80 dB	±0.089 dB
-84	-1.15 dB	(21)	1.15 dB	±0.086 dB

Table 3-10 Agilent E4405B Performance Verification Test Record

Agilent Technologies						
Model E4405B	Report No					
Serial No	Date					
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty		

Serial No		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
Incremental Log Fidelity, Res BW ≥1 kHz				
dB from Ref Level				
-4	-0.4 dB	(22)	0.4 dB	±0.082 dB
-8	-0.4 dB	(23)	0.4 dB	±0.078 dB
-12	-0.4 dB	(24)	0.4 dB	±0.075 dB
-16	-0.4 dB	(25)	0.4 dB	±0.073 dB
-20	-0.4 dB	(26)	0.4 dB	±0.078 dB
-24	-0.4 dB	(27)	0.4 dB	±0.074 dB
-28	-0.4 dB	(28)	0.4 dB	±0.073 dB
-32	-0.4 dB	(29)	0.4 dB	±0.077 dB
-36	-0.4 dB	(30)	0.4 dB	±0.075 dB
-40	-0.4 dB	(31)	0.4 dB	±0.081 dB
-44	-0.4 dB	(32)	0.4 dB	±0.077 dB
-48	-0.4 dB	(33)	0.4 dB	±0.076 dB
-52	-0.4 dB	(34)	0.4 dB	±0.080 dB
-56	-0.4 dB	(35)	0.4 dB	±0.078 dB
-60	-0.4 dB	(36)	0.4 dB	±0.084 dB
-64	-0.4 dB	(37)	0.4 dB	±0.081 dB
-68	-0.4 dB	(38)	0.4 dB	±0.080 dB
-72	-0.4 dB	(39)	0.4 dB	±0.084 dB
-76	-0.4 dB	(40)	0.4 dB	±0.083 dB
-80	-0.4 dB	(41)	0.4 dB	±0.089 dB
Cumulative Log Fidelity, Res BW ≤300 Hz (Option 1DR only)				
dB from Ref Level				

Table 3-10 Agilent E4405B Performance Verification Test Record

Agilent Technologies	
Model E4405B	Report No
Serial No	Date

Serial No.	Date			
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
-4	-0.34 dB	(43)	0.34 dB	±0.082 dB
-8	-0.38 dB	(44)	0.38 dB	±0.078 dB
-12	-0.42 dB	(45)	0.42 dB	±0.075 dB
-16	-0.46 dB	(46)	0.46 dB	±0.073 dB
-20	-0.50 dB	(47)	0.50 dB	±0.078 dB
-24	-0.54 dB	(48)	0.54 dB	±0.074 dB
-28	-0.58 dB	(49)	0.58 dB	±0.073 dB
-32	-0.62 dB	(50)	0.62 dB	±0.077 dB
-36	-0.66 dB	(51)	0.66 dB	±0.075 dB
-40	-0.70 dB	(52)	0.70 dB	±0.081 dB
-44	-0.74 dB	(53)	0.74 dB	±0.077 dB
-48	-0.78 dB	(54)	0.78 dB	±0.076 dB
-52	-0.82 dB	(55)	0.82 dB	±0.080 dB
-56	-0.86 dB	(56)	0.86 dB	±0.078 dB
-60	-0.90 dB	(57)	0.90 dB	±0.084 dB
-64	-0.94 dB	(58)	0.94 dB	±0.081 dB
-68	-0.98 dB	(59)	0.98 dB	±0.080 dB
-72	-1.02 dB	(60)	1.02 dB	±0.084 dB
-76	-1.06 dB	(61)	1.06 dB	±0.083 dB
-80	-1.10 dB	(62)	1.10 dB	±0.089 dB
-84	-1.14 dB	(63)	1.14 dB	±0.086 dB
-88	-1.18 dB	(64)	1.18 dB	±0.085 dB
-92	-1.22 dB	(65)	1.22 dB	±0.100 dB
-96	-1.26 dB	(66)	1.26 dB	±0.099 dB
-98	-1.28 dB	(67)	1.28 dB	±0.098 dB

Table 3-10 Agilent E4405B Performance Verification Test Record

Agilent Technologies						
Mod	el E4405B		Report No.			
Seri	al No		Date			
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
	Incremental Log Fidelity, Res BW ≤300 Hz (Option 1DR only)					
	dB from Ref Level					
	_4	-0.4 dB	(68)	0.4 dB	±0.082 dB	
	-8	-0.4 dB	(69)	0.4 dB	±0.078 dB	
	-12	-0.4 dB	(70)	0.4 dB	±0.075 dB	
	-16	-0.4 dB	(71)	0.4 dB	±0.073 dB	
	-20	-0.4 dB	(72)	0.4 dB	±0.078 dB	
	-24	-0.4 dB	(73)	0.4 dB	±0.074 dB	
	-28	-0.4 dB	(74)	0.4 dB	±0.073 dB	
	-32	-0.4 dB	(75)	0.4 dB	±0.077 dB	
	-36	-0.4 dB	(76)	0.4 dB	±0.075 dB	
	-40	-0.4 dB	(77)	0.4 dB	±0.081 dB	
	-44	-0.4 dB	(78)	0.4 dB	±0.077 dB	
	-48	-0.4 dB	(79)	0.4 dB	±0.076 dB	
	-52	-0.4 dB	(80)	0.4 dB	±0.080 dB	
	-56	-0.4 dB	(81)	0.4 dB	±0.078 dB	
	-60	-0.4 dB	(82)	0.4 dB	±0.084 dB	
	-64	-0.4 dB	(83)	0.4 dB	±0.081 dB	
	-68	-0.4 dB	(84)	0.4 dB	±0.080 dB	
	-72	-0.4 dB	(85)	0.4 dB	±0.084 dB	
	-76	-0.4 dB	(86)	0.4 dB	±0.083 dB	

 $-0.4~\mathrm{dB}$

-80

Linear Fidelity, Res BW ≥1 kHz dB from Ref Level

534 Chapter 3

0.4 dB

±0.089 dB

(87)____

Table 3-10 Agilent E4405B Performance Verification Test Record

Agilent Technologies	
Model E4405B	Report No
Serial No	Date

Seriai No.		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
-4	-2.0%	(93)	2.0%	±0.064%
-8	-2.0%	(94)	2.0%	±0.064%
-12	-2.0%	(95)	2.0%	±0.064%
-16	-2.0%	(96)	2.0%	±0.064%
-20	-2.0%	(97)	2.0%	±0.063%
Linear Fidelity, Res BW ≤300 Hz (Option 1DR only)				
dB from Ref Level				
-4	-2.0%	(98)	2.0%	±0.064%
-8	-2.0%	(99)	2.0%	±0.064%
-12	-2.0%	(100)	2.0%	±0.064%
-16	-2.0%	(101)	2.0%	±0.064%
-20	-2.0%	(102)	2.0%	±0.063%
Zero Span, Res BW ≤300 Hz (Option 1DR only)				
dB from Ref Level				
-4	-0.36 dB	(103)	0.36 dB	±0.082 dB
-8	-0.42 dB	(104)	0.42 dB	±0.078 dB
-12	-0.48 dB	(105)	0.48 dB	±0.075 dB
-16	-0.54 dB	(106)	0.54 dB	±0.073 dB
-20	-0.60 dB	(107)	0.60 dB	±0.078 dB
-24	-0.66 dB	(108)	0.66 dB	±0.074 dB
-28	-0.72 dB	(109)	0.72 dB	±0.073 dB
-32	-0.78 dB	(110)	0.78 dB	±0.077 dB
-36	-0.84 dB	(111)	0.84 dB	±0.075 dB

Table 3-10 Agilent E4405B Performance Verification Test Record

Agilent Technologies						
Mod	el E4405B		Report No.			
Seri	al No		Date			
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
	-40	-0.90 dB	(112)	0.90 dB	±0.081 dB	
	-44	-0.96 dB	(113)	0.96 dB	±0.077 dB	
	-48	-1.02 dB	(114)	1.02 dB	±0.076 dB	
	-52	-1.08 dB	(115)	1.08 dB	±0.080 dB	
	-56	-1.14 dB	(116)	1.14 dB	±0.078 dB	
	-60	-1.20 dB	(117)	1.20 dB	±0.084 dB	
	-64	-1.5 dB	(118)	1.5 dB	±0.081 dB	
	-68	−1.5 dB	(119)	1.5 dB	±0.080 dB	
	- 70	-1.5 dB	(120)	1.5 dB	±0.084 dB	
13.	Input Attenuation Switching Uncertainty					
	Input Attenuation Setting					
	0 dB	-0.3 dB	(1)	0.3 dB	±0.101 dB	
	5 dB	-0.3 dB	(2)	0.3 dB	±0.104 dB	
	15 dB	-0.3 dB	(3)	0.3 dB	±0.102 dB	
	20 dB	-0.3 dB	(4)	0.3 dB	±0.098 dB	
	25 dB	−0.35 dB	(5)	$0.35~\mathrm{dB}$	±0.098 dB	
	30 dB	-0.40 dB	(6)	0.40 dB	±0.096 dB	
	35 dB	−0.45 dB	(7)	0.45 dB	±0.099 dB	
	40 dB	-0.50 dB	(8)	$0.50~\mathrm{dB}$	±0.096 dB	
	45 dB	−0.55 dB	(9)	$0.55~\mathrm{dB}$	±0.099 dB	
	50 dB	-0.60 dB	(10)	0.60 dB	±0.095 dB	
	55 dB	−0.65 dB	(11)	0.65 dB	±0.099 dB	
	60 dB	-0.70 dB	(12)	0.70 dB	±0.100 dB	
	65 dB	−0.75 dB	(13)	0.75 dB	±0.111 dB	

Table 3-10 Agilent E4405B Performance Verification Test Record

Agilent Technologies	
Model E4405B	Report No.
Serial No	Date

Serial No Date					
Test Description		Minimum	Results Measured	Maximum	Measurement Uncertainty
15.	Reference Level Accuracy				
	Log, Res BW ≥1 kHz				
	Reference Level				
	-10 dBm	-0.3 dB	(1)	0.3 dB	±0.091 dB
	0 dBm	-0.3 dB	(2)	0.3 dB	±0.100 dB
	-30 dBm	-0.3 dB	(3)	0.3 dB	±0.092 dB
	-40 dBm	-0.3 dB	(4)	0.3 dB	±0.094 dB
	-50 dBm	-0.5 dB	(5)	0.5 dB	±0.095 dB
	-60 dBm	-0.5 dB	(6)	0.5 dB	±0.097 dB
	-70 dBm	-0.5 dB	(7)	0.5 dB	±0.099 dB
	-80 dBm	-0.7 dB	(8)	0.7 dB	±0.101 dB
	Linear, Res BW ≥1 kHz				
	Reference Level				
	-10 dBm	-0.3 dB	(9)	0.3 dB	±0.091 dB
	0 dBm	-0.3 dB	(10)	0.3 dB	±0.100 dB
	-30 dBm	-0.3 dB	(11)	0.3 dB	±0.092 dB
	-40 dBm	-0.3 dB	(12)	0.3 dB	±0.094 dB
	-50 dBm	-0.5 dB	(13)	0.5 dB	±0.095 dB
	-60 dBm	-0.5 dB	(14)	0.5 dB	±0.097 dB
	-70 dBm	-0.5 dB	(15)	0.5 dB	±0.099 dB
	-80 dBm	-0.7 dB	(16)	0.7 dB	±0.101 dB
	Log, Res BW ≤300 Hz (Option 1DR only)				
	Reference Level				
	-10 dBm	-0.3 dB	(17)	0.3 dB	±0.091 dB

Table 3-10 Agilent E4405B Performance Verification Test Record

Agilent Technologies						
Model E4405B			Report No			
Serial No			Date			
Test Description Minimum		Results Measured	Maximum	Measurement Uncertainty		
	0 dBm	-0.3 dB	(18)	0.3 dB	±0.100 dB	
	-30 dBm	-0.3 dB	(19)	0.3 dB	±0.092 dB	
	-40 dBm	-0.3 dB	(20)	0.3 dB	±0.094 dB	
	–50 dBm	−0.5 dB	(21)	0.5 dB	±0.095 dB	
	-60 dBm	-0.5 dB	(22)	0.5 dB	±0.097 dB	
	-70 dBm	-0.5 dB	(23)	0.5 dB	±0.099 dB	
	-80 dBm	−0.7 dB	(24)	0.7 dB	±0.101 dB	
	Linear, Res BW \leq 300 Hz (Option 1DR only)					
	Reference Level					
	-10 dBm	−0.3 dB	(25)	0.3 dB	±0.091 dB	
	0 dBm	-0.3 dB	(26)	0.3 dB	±0.100 dB	
	-30 dBm	-0.3 dB	(27)	0.3 dB	±0.092 dB	
	-40 dBm	−0.3 dB	(28)	0.3 dB	±0.094 dB	
	-50 dBm	−0.5 dB	(29)	0.5 dB	±0.095 dB	
	-60 dBm	−0.5 dB	(30)	0.5 dB	±0.097 dB	
	-70 dBm	−0.5 dB	(31)	0.5 dB	±0.099 dB	
	-80 dBm	-0.7 dB	(32)	0.7 dB	±0.101 dB	
16.	Resolution Bandwidth Switching Uncertainty					
	Resolution Bandwidth					
	3 kHz	-0.3 dB	(1)	0.3 dB	±0.048 dB	
	9 kHz	-0.3 dB	(2)	0.3 dB	±0.048 dB	
	10 kHz	-0.3 dB	(3)	0.3 dB	±0.048 dB	
	30 kHz	-0.3 dB	(4)	0.3 dB	±0.048 dB	

-0.3 dB

100 kHz

538 Chapter 3

0.3 dB

±0.048 dB

Table 3-10 Agilent E4405B Performance Verification Test Record

Agilent Technologies	
Model E4405B	Report No.
Serial No	Date

Serial No Date					
Test Description		Minimum	Results Measured	Maximum	Measurement Uncertainty
	120 kHz	-0.3 dB	(6)	0.3 dB	±0.048 dB
	300 kHz	-0.3 dB	(7)	0.3 dB	±0.048 dB
	1 MHz	-0.3 dB	(8)	0.3 dB	±0.048 dB
	3 MHz	-0.3 dB	(9)	0.3 dB	±0.048 dB
	5 MHz	-0.6 dB	(10)	0.6 dB	±0.076 dB
	300 Hz (Option 1DR only)	-0.3 dB	(11)	0.3 dB	±0.048 dB
	200 Hz (Option 1DR only)	-0.3 dB	(12)	0.3 dB	±0.048 dB
	100 Hz (Option 1DR only)	-0.3 dB	(13)	0.3 dB	±0.048 dB
	30 Hz (Option 1DR only)	-0.3 dB	(14)	0.3 dB	±0.048 dB
	10 Hz (Option 1DR only)	-0.3 dB	(15)	0.3 dB	±0.048 dB
	3 Hz (Option 1DR and 1D5 only) Firmware Revision A.08.00 or later	-0.3 dB	(16)	0.3 dB	±0.048 dB
	1Hz (Option 1DR and 1D5 only) Firmware Revision A.08.00 or later	-0.3 dB	(17)	0.3 dB	±0.048 dB
18.	Absolute Amplitude Accuracy (Reference Settings)				
	Log, Preamp Off	-0.34 dB	(1)	0.34 dB	±0.09 dB
	Lin, Preamp Off	-0.34 dB	(2)	0.34 dB	±0.09 dB
	Log, Preamp On (Option 1DS only)	-0.37 dB	(3)	0.37 dB	±0.09 dB
	Lin, Preamp On (Option 1DS only)	-0.37 dB	(4)	0.37 dB	±0.09 dB
20.	Overall Absolute Amplitude Accuracy				
	0 dBm Reference Level				
	0 dBm input	-0.54 dB	(1)	0.54 dB	±0.234 dB

Table 3-10 Agilent E4405B Performance Verification Test Record

Agilent Technologies						
Model E4405B			Report No			
Serial No			Date			
Test Description Minimum		Results Measured	Maximum	Measurement Uncertainty		
	–10 dBm input	-0.54 dB	(2)	0.54 dB	±0.115 dB	
	–20 dBm input	−0.54 dB	(3)	0.54 dB	±0.110 dB	
	–30 dBm input	-0.54 dB	(4)	0.54 dB	±0.109 dB	
	–40 dBm input	-0.54 dB	(5)	0.54 dB	±0.109 dB	
	–50 dBm input	-0.54 dB	(6)	0.54 dB	±0.109 dB	
	–20 dBm Reference Level					
	–20 dBm input	-0.54 dB	(7)	0.54 dB	±0.109 dB	
	–30 dBm input	-0.54 dB	(8)	0.54 dB	±0.109 dB	
	–40 dBm input	-0.54 dB	(9)	0.54 dB	±0.109 dB	
	–50 dBm input	-0.54 dB	(10)	0.54 dB	±0.109 dB	
	–40 dBm Reference Level					
	–40 dBm input	-0.54 dB	(11)	0.54 dB	±0.087 dB	
	–50 dBm input	-0.54 dB	(12)	0.54 dB	±0.087 dB	
	–50 dBm Reference Level					
	–50 dBm input	-0.54 dB	(13)	0.54 dB	±0.087 dB	
21.	Resolution Bandwidth Accuracy					
	Resolution Bandwidth					
	5 MHz	3.5 MHz	(1)	6.5 MHz	±110 kHz	
	3 MHz	2.55 MHz	(2)	3.45 MHz	±66 kHz	
	1 MHz	0.85 MHz	(3)	1.15 MHz	±22 kHz	
	300 kHz	255 kHz	(4)	345 kHz	±6.6 kHz	
	100 kHz	85 kHz	(5)	115 kHz	±2.2 kHz	
	30 kHz	25.5 kHz	(6)	34.5 kHz	±660 Hz	
	10 kHz	8.5 kHz	(7)	11.5 kHz	±220 Hz	
	3 kHz	$2.55~\mathrm{kHz}$	(8)	$3.45~\mathrm{kHz}$	±66 Hz	

Table 3-10 Agilent E4405B Performance Verification Test Record

Agilent Technologies					
Mod	el E4405B		Report No		
Seria	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	1 kHz	850 Hz	(9)	1.15 kHz	±22 Hz
	120 kHz	96 kHz	(10)	144 kHz	$\pm 2.17~\mathrm{kHz}$
	9 kHz	7.2 kHz	(11)	10.8 kHz	±163 Hz
24.	Frequency Response		ta in the appropriat mperature at which as.		
	20 to $30^{\circ}\mathrm{C}$				
	Non-Option UKB dc Coupled Band 0 (9 kHz to 3.0 GHz)				
	Maximum Response		(1)	0.46 dB	±0.19 dB
	Minimum Response	-0.46 dB	(2)		±0.19 dB
	Peak-to-Peak Response		(3)	0.92 dB	±0.19 dB
	Option UKB dc Coupled Band 0 (100 Hz to 3.0 GHz)				
	Maximum Response		(1)	0.50 dB	±0.19 dB
	Minimum Response	-0.50 dB	(2)		±0.19 dB
	Peak-to-Peak Response		(3)	1.0 dB	±0.19 dB
	dc Coupled Band 1 (3.0 GHz to 6.7 GHz)				
	Maximum Response		(4)	1.5 dB	±0.39 dB
	Minimum Response	-1.5 dB	(5)		±0.39 dB
	Peak-to-Peak Response		(6)	2.6 dB	±0.39 dB

Table 3-10 Agilent E4405B Performance Verification Test Record

Agil	ent Technologies					
Mod	lel E4405B		Report No			
Seri	al No		Date			
Test Description Minimum			Results Measured	Maximum	Measurement Uncertainty	
	dc Coupled Band 2 (6.7 GHz to 13.2 GHz)					
	Maximum Response		(7)	2.0 dB	±0.40 dB	
	Minimum Response	−2.0 dB	(8)		±0.40 dB	
	Peak-to-Peak Response		(9)	3.6 dB	±0.40 dB	
	ac Coupled Band 0 (100 kHz to 3.0 GHz) Maximum Response Minimum Response Peak-to-Peak Response	-0.5 dB	(10) (11) (12)	0.5 dB 1.0 dB	±0.11 dB ±0.11 dB ±0.11 dB	
	ac Coupled Band 0A (800 MHz to 1.0 GHz) (serial number US39440327 or greater) Maximum Response Minimum Response Peak-to-Peak Response	-0.5 dB	(13) (14) (15)	0.5 dB 1.0 dB	±0.11 dB ±0.11 dB ±0.11 dB	
	ac Coupled Band 0B (1.7 GHz to 2.0 GHz) (serial number US39440327 or greater) Maximum Response		(16)	0.5 dB	±0.11 dB	

Table 3-10 Agilent E4405B Performance Verification Test Record

Agilent Technologies	
Model E4405B	Report No
Serial No	Date

Seriai No.		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
Minimum Response	-0.5 dB	(17)		±0.11 dB
Peak-to-Peak Response		(18)	1.0 dB	±0.11 dB
ac Coupled Band 1 (3.0 GHz to 6.7 GHz)				
Maximum Response		(19)	1.5 dB	±0.39 dB
Minimum Response	-1.5 dB	(20)		±0.39 dB
Peak-to-Peak Response		(21)	2.6 dB	±0.39 dB
ac Coupled Band 2 (6.7 GHz to 13.2 GHz) Maximum Response Minimum Response Peak-to-Peak Response	–2.0 dB	(22) (23) (24)	2.0 dB 3.6 dB	±0.40 dB ±0.40 dB ±0.40 dB
0 to 55° C Non-Option UKB dc Coupled Band 0 (9 kHz to 3.0 GHz)				
Maximum Response		(1)	0.76 dB	±0.19 dB
Minimum Response	-0.76 dB	(2)		±0.19 dB
Peak-to-Peak Response		(3)	1.52 dB	±0.19 dB

Table 3-10 Agilent E4405B Performance Verification Test Record

Agilent Technologies						
Mode	el E4405B		Report No			
Seria	al No		Date			
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
	Option UKB dc Coupled Band 0 (100 Hz to 3.0 GHz)					
	Maximum Response		(1)	1.0 dB	±0.19 dB	
	Minimum Response	-1.0 dB	(2)		±0.19 dB	
	Peak-to-Peak Response		(3)	2.0 dB	±0.19 dB	
	dc Coupled Band 1 (3.0 GHz to 6.7 GHz)					
	Maximum Response		(4)	2.5 dB	±0.39 dB	
	Minimum Response	-2.5 dB	(5)		±0.39 dB	
	Peak-to-Peak Response		(6)	3.0 dB	±0.39 dB	
	dc Coupled Band 2 (6.7 GHz to 13.2 GHz)				10.40 ID	
	Maximum Response	0.0.10	(7)	3.0 dB	±0.40 dB	
	Minimum Response	−3.0 dB	(8)		±0.40 dB	
	Peak-to-Peak Response		(9)	4.0 dB	±0.40 dB	
	ac Coupled Band 0 (100 kHz to 3.0 GHz)					
	Maximum Response		(10)	1.0 dB	±0.11 dB	
	Minimum Response	-1.0 dB	(11)		±0.11 dB	
	Peak-to-Peak Response		(12)	2.0 dB	±0.11 dB	

Table 3-10 Agilent E4405B Performance Verification Test Record

Agilent Technologies	
Model E4405B	Report No
Serial No	Date

Serial No		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
ac Coupled Band 0A (800 MHz to 1.0 GHz) (serial number US39440327 or greater)				
Maximum Response		(13)	1.0 dB	±0.11 dB
Minimum Response	-1.0 dB	(14)		±0.11 dB
Peak-to-Peak Response		(15)	2.0 dB	±0.11 dB
ac Coupled Band 0B (1.7 GHz to 2.0 GHz) (serial number US39440327 or greater)				
Maximum Response		(16)	1.0 dB	±0.11 dB
Minimum Response	-1.0 dB	(17)		±0.11 dB
Peak-to-Peak Response		(18)	2.0 dB	±0.11 dB
ac Coupled Band 1 (3.0 GHz to 6.7 GHz)				
Maximum Response		(19)	2.5 dB	±0.39 dB
Minimum Response	-2.5 dB	(20)		±0.39 dB
Peak-to-Peak Response		(21)	3.0 dB	±0.39 dB
ac Coupled Band 2 (6.7 GHz to 13.2 GHz)				
Maximum Response		(22)	3.0 dB	±0.40 dB
Minimum Response	-3.0 dB	(23)		±0.40 dB

Table 3-10 Agilent E4405B Performance Verification Test Record

Agilent Technologies					
Model E4405B			Report No		
Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	Peak-to-Peak Response		(24)	4.0 dB	±0.40 dB
27.	Frequency Response (Preamp On) (Option 1DS Only)		ta in the appropriate mperature at which as.		
	20 to 30° C				
	Band 0 (1 MHz to 3.0 GHz)				
	Maximum Response		(1)	1.5 dB	±0.28 dB
	Minimum Response	-1.5 dB	(2)		±0.28 dB
	Peak-to-Peak Response		(3)	3.0 dB	±0.28 dB
	Band 0A (800 MHz to 1.0 GHz) (serial number US39440327 or greater) Maximum Response Minimum Response Peak-to-Peak Response Band 0B (1.7 GHz to 2.0 GHz)	−1.5 dB	(4) (5) (6)	1.5 dB 3.0 dB	±0.28 dB ±0.28 dB ±0.28 dB
	(serial number US39440327 or greater) Maximum Response Minimum Response Peak-to-Peak Response	−1.5 dB	(7) (8) (9)	1.5 dB 3.0 dB	±0.28 dB ±0.28 dB ±0.28 dB

Table 3-10 Agilent E4405B Performance Verification Test Record

Agilent Technologies	
Model E4405B	Report No.
Serial No.	Date

Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	0 to 55° C				
	Band 0 (1 MHz to 3.0 GHz)				
	Maximum Response		(1)	2.0 dB	±0.28 dB
	Minimum Response	-2.0 dB	(2)		±0.28 dB
	Peak-to-Peak Response		(3)	4.0 dB	±0.28 dB
	Band 0A (800 MHz to 1.0 GHz) (serial number US39440327 or greater)				
	Maximum Response		(4)	2.0 dB	±0.28 dB
	Minimum Response	-2.0 dB	(5)		±0.28 dB
	Peak-to-Peak Response		(6)	4.0 dB	±0.28 dB
	Band 0B (1.7 GHz to 2.0 GHz) (serial number US39440327 or greater)				
	Maximum Response		(7)	2.0 dB	±0.28 dB
	Minimum Response	-2.0 dB	(8)		±0.28 dB
	Peak-to-Peak Response		(9)	4.0 dB	±0.28 dB
29.	Other Input-Related Spurious Responses				
	Center Freq Input Freq				
	2.0 GHz 2042.8 MHz		(1)	-65 dBc	±.891 dB
	2.0 GHz 2642.8 MHz		(2)	-65 dBc	±.891 dB
	2.0 GHz 1820.8 MHz		(3)	-65 dBc	±.891 dB
	2.0 GHz 278.5 MHz		(4)	-65 dBc	±.891 dB

Table 3-10 Agilent E4405B Performance Verification Test Record

Agilent Technologies					
Mod	el E4405B		Report No		
Serial No			Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	2.0 GHz 5600.0 MHz		(5)	-80 dBc	±.891 dB
	$2.0~\mathrm{GHz}~~6242.8~\mathrm{MHz}$		(6)	-80 dBc	±.891 dB
	4.0 GHz 4042.8 MHz		(7)	-65 dBc	±.891 dB
	4.0 GHz 4642.8 MHz		(8)	-65 dBc	±.891 dB
	4.0 GHz 3742.9 MHz		(9)	–65 dBc	±.891 dB
	4.0 GHz 2242.8 MHz		(10)	-80 dBc	±.891 dB
	9.0 GHz 9042.8 MHz		(11)	-65 dBc	±.891 dB
	9.0 GHz 9642.8 MHz		(12)	–65 dBc	±.891 dB
	9.0 GHz 9342.8 MHz		(13)	-65 dBc	±.891 dB
	9.0 GHz 4982.1 MHz		(14)	-80 dBc	±.891 dB
32.	Spurious Responses				
	300 MHz TOI, 1 kHz RBW	12.5 dBm	(1)		±0.93 dB
	300 MHz TOI, 30 Hz RBW (Option 1DR only)	12.5 dBm	(2)		±0.93 dB
	5 GHz TOI	11 dBm	(3)		±0.93 dB
	8 GHz TOI	7.5 dBm	(4)		±0.93 dB
	$300~\mathrm{MHz}~\mathrm{SHI}$	35 dBm	(5)		±0.41 dB
	$900~\mathrm{MHz}~\mathrm{SHI}$	45 dBm	(6)		±0.41 dB
	1.55 GHz SHI	75 dBm	(7)		±0.41 dB
	3.1 GHz SHI	90 dBm	(8)		±0.41 dB
34.	Gain Compression				
	Test Frequency				
	53 MHz		(1)	1.0 dB	±0.123 dB
	50.004 MHz (Option 1DR only)		(2)	1.0 dB	±0.123 dB

Table 3-10 Agilent E4405B Performance Verification Test Record

Agilent Technologies					
Mod	el E4405B		Report No		
Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	1403 MHz		(3)	1.0 dB	±0.123 dB
	2503 MHz		(4)	1.0 dB	±0.123 dB
	4403 MHz		(5)	1.0 dB	±0.123 dB
	7603 MHz		(6)	1.0 dB	±0.123 dB
37.	Displayed Average Noise Level		sults with preamp o ent temperature wh		
	1 kHz RBW, Preamp Off				
	10 MHz to 1 GHz		(1)	-116 dBm	±1.23 dB
	1 GHz to 2 GHz		(2)	-116 dBm	±1.23 dB
	2 GHz to 3 GHz		(3)	-112 dBm	±1.23 dB
	3 GHz to 6 GHz		(4)	-112 dBm	±1.23 dB
	6 GHz to 12 GHz		(5)	–111 dBm	±1.23 dB
	12 GHz to 13.2 GHz		(6)	-107 dBm	±1.23 dB
	1 kHz RBW, Preamp On, 0 to 55° C				
	10 MHz to 1 GHz		(7)	–131 dBm	±1.23 dB
	1 GHz to 2 GHz		(8)	–131 dBm	±1.23 dB
	2 GHz to 3 GHz		(9)	-127 dBm	±1.23 dB
	10 Hz RBW, Preamp Off				
	10 MHz to 1 GHz		(10)	–135 dBm	±1.23 dB
	1 GHz to 2 GHz		(11)	-135 dBm	±1.23 dB
	2 GHz to 3 GHz		(12)	–131 dBm	±1.23 dB
	3 GHz to 6 GHz		(13)	–131 dBm	±1.23 dB
	6 GHz to 12 GHz		(14)	-130 dBm	±1.23 dB
	12 GHz to 13.2 GHz		(15)	-120 dBm	±1.23 dB

Table 3-10 Agilent E4405B Performance Verification Test Record

Agil	ent Technologies					
Mod	el E4405B		Report No			
Seri	al No		Date	-		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
	10 Hz RBW, Preamp On, 0 to 55° C					
	10 MHz to 1 GHz		(16)	-150 dBm	±1.23 dB	
	1 GHz to 2 GHz		(17)	-150 dBm	±1.23 dB	
	2 GHz to 3 GHz		(18)	-146 dBm	±1.23 dB	
	1 kHz RBW, Preamp On, 20 to 30° C					
	10 MHz to 1 GHz		(19)	-132 dBm	±1.23 dB	
	1 GHz to 2 GHz		(20)	-132 dBm	±1.23 dB	
	2 GHz to 3 GHz		(21)	-130 dBm	±1.23 dB	
	10 Hz RBW, Preamp On, 20 to 30° C					
	10 MHz to 1 GHz		(22)	-151 dBm	±1.23 dB	
	1 GHz to 2 GHz		(23)	-151 dBm	±1.23 dB	
	2 GHz to 3 GHz		(24)	-149 dBm	±1.23 dB	
39.	Residual Responses					
	150 kHz to 6.7 GHz		(1)	-90 dBm	±0.87 dB	
40.	Fast Time Domain Amplitude Accuracy (Option AYX only)					
	Amplitude Error	-0.3%	(1)	0.3%	±0.029%	
42.	Tracking Generator Absolute Amplitude and Vernier Accuracy (Option 1DN only)					
	Absolute Amplitude Accuracy	-0.75 dB	(1)	0.75 dB	±0.096 dB	
	Absolute Vernier Accuracy					

Table 3-10 Agilent E4405B Performance Verification Test Record

Agilent Technologies	
Model E4405B	Report No
Serial No	Date

Serial No.			Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	−2 dB	-0.5 dB	(2)	0.5 dB	±0.008 dB
	−3 dB	-0.5 dB	(3)	0.5 dB	±0.008 dB
	–5 dB	−0.5 dB	(4)	0.5 dB	±0.008 dB
	-6 dB	-0.5 dB	(5)	0.5 dB	±0.008 dB
	-7 dB	-0.5 dB	(6)	0.5 dB	±0.008 dB
	-8 dB	-0.5 dB	(7)	0.5 dB	±0.008 dB
	–9 dB	−0.5 dB	(8)	0.5 dB	±0.008 dB
	-10 dB	−0.5 dB	(9)	0.5 dB	±0.008 dB
	Incremental Vernier Accuracy				
	−2 dB	-0.2 dB	(10)	0.2 dB	±0.008 dB
	−3 dB	-0.2 dB	(11)	0.2 dB	±0.008 dB
	−5 dB	-0.2 dB	(12)	0.2 dB	±0.008 dB
	-6 dB	-0.2 dB	(13)	0.2 dB	±0.008 dB
	−7 dB	-0.2 dB	(14)	0.2 dB	±0.008 dB
	-8 dB	-0.2 dB	(15)	0.2 dB	±0.008 dB
	–9 dB	-0.2 dB	(16)	0.2 dB	±0.008 dB
	-10 dB	−0.2 dB	(17)	0.2 dB	±0.008 dB
44.	Tracking Generator Level Flatness (Option 1DN only)				
	Positive Level Flatness, <1 MHz		(1)	3.0 dB	±0.284 dB
	Negative Level Flatness, <1 MHz	-3.0 dB	(2)		±0.284 dB
	Positive Level Flatness, 1 MHz to 10 MHz		(3)	3.0 dB	±0.142 dB

Table 3-10 Agilent E4405B Performance Verification Test Record

Agilent Technologies						
Model E4405B			Report No			
Seri	al No		Date	-		
Test Description Minim		Minimum	Results Measured	Maximum	Measurement Uncertainty	
	Negative Level Flatness, 1 MHz to 10 MHz	-3.0 dB	(4)		±0.142 dB	
	Positive Level Flatness, >10 MHz to 1.5 GHz		(5)	2.0 dB	±0.142 dB	
	Negative Level Flatness, >10 MHz to 1.5 GHz	-2.0 dB	(6)		±0.142 dB	
	Positive Level Flatness, >1.5 GHz		(7)	2.0 dB	±0.142 dB	
	Negative Level Flatness, >1.5 GHz	-2.0 dB	(8)		±0.142 dB	
46.	Tracking Generator Harmonic Spurious Outputs (Option 1DN only)					
	2 nd Harmonic, <20 kHz		(1)	-15 dBc	±2.6 dB	
	2 nd Harmonic, ≥ 20 kHz		(2)	-25 dBc	±2.6 dB	
	3 rd Harmonic, <20 kHz		(3)	-15 dBc	±2.6 dB	
	3 rd Harmonic, ≥ 20 kHz		(4)	–25 dBc	±2.6 dB	
48.	Tracking Generator Non-Harmonic Spurious Outputs (Option 1DN only)					
	Highest Non-Harmonic Spurious Output Amplitude, 9 kHz to 2 GHz		(1)	–27 dBc	±2.63 dB	
	Highest Non-Harmonic Spurious Output Amplitude, 2 GHz to 3 GHz		(2)	-23 dBc	±3.14 dB	
49.	Tracking Generator L.O. Feedthrough (Option 1DN only)					

Table 3-10 Agilent E4405B Performance Verification Test Record

Agilent Technologies					
Mod	el E4405B		Report No		
Serial No			Date		
Test	Description	Minimum	Maximiim		Measurement Uncertainty
	9 kHz to 2.9 GHz		(1)	-16 dBm	±2.58 dB
	$2.9~\mathrm{GHz}$ to $3.0~\mathrm{GHz}$		(2)	-16 dBm	±3.03 dB
50.	Gate Delay Accuracy and Gate Length Accuracy (Option 1D6 only)				
	Minimum Gate Delay	499.9 ns	(1)	1.5001µs	$\pm 549~\mathrm{ps}$
	Maximum Gate Delay	499.9 ns	(2)	1.5001µs	$\pm 549~\mathrm{ps}$
	1 μs Gate Length	499.9 ns	(3)	1.5001µs	$\pm 520~\mathrm{ps}$
	65 ms Gate Length	64.993 ms	(4)	65.007 ms	±647 ns
51.	Gate Mode Additional Amplitude Error (Option 1D6 only)				
	Amplitude Error	-0.2 dB	(1)	0.2 dB	±0.023 dB
58.	GSM Phase and Frequency Error (Option BAH and B7E)				
	Peak Phase Error	-2.1 Deg	(1)	2.1 Deg	0.52 Deg
	RMS Phase Error	-1.1 Deg	(2)	1.1 Deg	0.000063 Deg
	Frequency Error	–10 Hz	(3)	10 Hz	±0.006 Hz
59.	Comms Absolute Power Accuracy (Options BAC or BAH)				
	$20 ext{ to } 30^{\circ} ext{ C}$				
	cdmaOne Channel Power Accuracy (Option BAC only)				
	Cellular Band Input Amplitude				
	15 dBm	-0.82 dB	(1)	0.82 dB	±0.173 dB

Table 3-10 Agilent E4405B Performance Verification Test Record

Agilent Technologies	
Model E4405B	Report No.
Serial No	Date

Serial No		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
−5 dBm	-0.82 dB	(2)	0.82 dB	±0.161 dB
-25 dBm	-0.78 dB	(3)	0.78 dB	±0.161 dB
-45 dBm	-0.69 dB	(4)	0.69 dB	±0.152 dB
-55 dBm	−0.77 dB	(5)	0.77 dB	±0.152 dB
-70 dBm	-0.89 dB	(6)	0.89 dB	±0.161 dB
PCS Band Input Amplitude				
15 dBm	-0.78 dB	(7)	0.78 dB	±0.173 dB
−5 dBm	-0.78 dB	(8)	0.78 dB	±0.161 dB
-25 dBm	-0.74 dB	(9)	0.74 dB	±0.161 dB
-45 dBm	-0.71 dB	(10)	0.71 dB	±0.152 dB
-55 dBm	-0.79 dB	(11)	0.79 dB	±0.152 dB
-70 dBm	-0.91 dB	(12)	0.91 dB	±0.161 dB
GSM Transmit Power Accuracy (Option BAH only)				
GSM Band Input Amplitude				
15 dBm	-0.81 dB	(13)	0.81 dB	±0.173 dB
-20 dBm	-0.81 dB	(14)	0.81 dB	±0.161 dB
-30 dBm	-0.74 dB	(15)	0.74 dB	±0.156 dB
-40 dBm	-0.79 dB	(16)	0.79 dB	±0.161 dB
-50 dBm	−0.95 dB	(17)	0.95 dB	±0.152 dB
-60 dBm	-1.09 dB	(18)	1.09 dB	±0.161 dB
DCS and PCS Bands Input Amplitude				
15 dBm	-0.77 dB	(19)	0.77 dB	±0.173 dB

Table 3-10 Agilent E4405B Performance Verification Test Record

Agilent Technologies	
Model E4405B	Report No
Serial No	Date

Serial No.		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
-20 dBm	-0.77 dB	(20)	0.77 dB	±0.161 dB
-30 dBm	-0.70 dB	(21)	0.70 dB	±0.156 dB
-40 dBm	-0.75 dB	(22)	0.75 dB	±0.161 dB
-50 dBm	-0.91 dB	(23)	0.91 dB	±0.152 dB
-60 dBm	-1.05 dB	(24)	1.05 dB	±0.161 dB
cdmaOne Receive Channel Power, Preamp Off (Option BAC only) Cellular Band Input Amplitude				
-40 dBm	-1.46 dB	(25)	1.46 dB	±0.161 dB
-60 dBm	-1.46 dB	(26)	1.46 dB	±0.161 dB
-70 dBm	-1.46 dB	(27)	1.46 dB	±0.161 dB
-80 dBm	-1.46 dB	(28)	1.46 dB	±0.161 dB
-85 dBm	-1.46 dB	(29)	1.46 dB	±0.152 dB
PCS Band Input Amplitude	1.10 dB		1.10 ub	20.102 dD
-40 dBm	-1.35 dB	(30)	1.35 dB	±0.161 dB
-60 dBm	-1.35 dB	(31)	1.35 dB	±0.161 dB
-70 dBm	-1.35 dB	(32)	1.35 dB	±0.161 dB
-80 dBm	-1.35 dB	(33)	1.35 dB	±0.161 dB
-85 dBm	-1.35 dB	(34)	1.35 dB	±0.152 dB
cdmaOne Receive Channel Power, Preamp On (Option BAC only)				
Cellular Band Input Amplitude				

Table 3-10 Agilent E4405B Performance Verification Test Record

Agilent Technologies					
Model E4405B		Report No			
Serial No.	Date				
Test Description Minimum		Results Measured	Maximum	Measurement Uncertainty	
-40 dBm	-1.88 dB	(35)	1.88 dB	±0.161 dB	
-60 dBm	-1.88 dB	(36)	1.88 dB	±0.161 dB	
-70 dBm	-1.88 dB	(37)	1.88 dB	±0.161 dB	
-80 dBm	-1.88 dB	(38)	1.88 dB	±0.161 dB	
-90 dBm	-2.95 dB	(39)	2.95 dB	±0.161 dB	
-100 dBm	−2.95 dB	(40)	2.95 dB	±0.161 dB	
PCS Band Input Amplitude					
-40 dBm	-1.88 dB	(41)	1.88 dB	±0.161 dB	
-60 dBm	-1.88 dB	(42)	1.88 dB	±0.161 dB	
-70 dBm	-1.88 dB	(43)	1.88 dB	±0.161 dB	
-80 dBm	-1.88 dB	(44)	1.88 dB	±0.161 dB	
-90 dBm	-2.95 dB	(45)	2.95 dB	±0.161 dB	

(46)_

-2.95 dB

-100 dBm

556 Chapter 3

 $2.95~\mathrm{dB}$

 $\pm 0.161~\mathrm{dB}$

Agilent E4407B Performance Verification Test Record

Tests for the Agilent E4407B only are included in this test record, therefore not all test numbers are included.

Table 3-11 E4407B Performance Verification Test Record

Agilent Technologies			
Address:		Report No	
		Date	
Model E4407B			
Serial No		Ambient temperature	·° C
Options		Relative humidity	%
Firmware Revision		Power mains line freq (nominal)	uency Hz
Customer		Tested by	
Test Equipment Used:			
Description	Model No.	Trace No.	Cal Due Date
Synthesized Signal Generator			
Wide Offset Phase Noise Generator			
Synthesized Sweeper #1			
Synthesized Sweeper #2			
Function Generator			
Power Meter, Dual-Channel			
RF Power Sensor #1			
RF Power Sensor #2			
Microwave Power Sensor			
Low-Power Power Sensor			
Digital Multimeter			
Universal Counter			
Frequency Standard			

Table 3-11 E4407B Performance Verification Test Record

Power Splitter	 	
50 Ω Termination	 	
1 dB Step Attenuator	 	
10 dB Step Attenuator	 	
Oscilloscope (Option 1D6 only)	 	
Microwave Spectrum Analyzer (Option 1DN only)	 	
Notes/comments:	 	

Table 3-12 Agilent E4407B Performance Verification Test Record

Agil	ent Technologies				
Mod	el E4407B	Report No			
Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
1.	10 MHz Reference Output Accuracy (Non-Option 1D5 only)				
	Settability	-5.0 Hz	(1)	5.0 Hz	±293.3 μHz
2.	10 MHz High-Stability Frequency Reference Output Accuracy (Option 1D5 only)	0.1	(1)	0.1	10.000079
	5 Minute Warm-Up Error 15 Minute Warm-Up Error	-0.1 ppm -0.01 ppm	(1)(2)	0.1 ppm 0.01 ppm	±0.000072 ppm ±0.000070 ppm
4.	Frequency Readout and Marker Frequency Count Accuracy				
	Frequency Readout Accuracy				
	Center Freq Span				
	1500 MHz 20 MHz	1499.83 MHz	(1)	1500.17 MHz	±0 Hz
	1500 MHz 10 MHz	1499.91 MHz	(2)	1500.09 MHz	±0 Hz

Table 3-12 Agilent E4407B Performance Verification Test Record

Agil	Agilent Technologies						
Mod	el E4407B			Report No			
Seri	al No						
Test	Description		Minimum	Results Measured	Maximum	Measurement Uncertainty	
	1500 MHz	1 MHz	1499.991 MHz	(3)	1500.009 MHz	±0 Hz	
	4000 MHz	$20~\mathrm{MHz}$	3999.83 MHz	(4)	4000.17 MHz	±0 Hz	
	4000 MHz	$10~\mathrm{MHz}$	3999.91 MHz	(5)	4000.09 MHz	±0 Hz	
	4000 MHz	1 MHz	3999.991 MHz	(6)	4000.009 MHz	±0 Hz	
	$9000~\mathrm{MHz}$	$20~\mathrm{MHz}$	8999.83 MHz	(7)	9000.17 MHz	±0 Hz	
	$9000~\mathrm{MHz}$	$10~\mathrm{MHz}$	8999.91 MHz	(8)	9000.09 MHz	±0 Hz	
	$9000~\mathrm{MHz}$	1 MHz	8999.991 MHz	(9)	9000.009 MHz	±0 Hz	
	16000 MHz	$20~\mathrm{MHz}$	15999.83 MHz	(10)	16000.17 MHz	±0 Hz	
	16000 MHz	$10~\mathrm{MHz}$	15999.91 MHz	(11)	16000.09 MHz	±0 Hz	
	16000 MHz	1 MHz	15999.991 MHz	(12)	16000.009 MHz	±0 Hz	
	21000 MHz	$20~\mathrm{MHz}$	20999.83 MHz	(13)	21000.17 MHz	±0 Hz	
	21000 MHz	$10~\mathrm{MHz}$	20999.91 MHz	(14)	21000.09 MHz	±0 Hz	
	21000 MHz	1 MHz	20999.991 MHz	(15)	21000.009 MHz	±0 Hz	
	Marker Count	Accuracy		sults in the appropri	iate section belov	v based upon the	
	Firmware Rev to A.03.00	ision Prior					
	Center Freq	Span					
	$1500~\mathrm{MHz}$	$20~\mathrm{MHz}$	1499.999998	(16)	1500.000002	±0 Hz	

MHz

Chapter 3 559

MHz

Table 3-12 Agilent E4407B Performance Verification Test Record

Agilent Technologies				
Model E4407B		Report No		
Serial No		Date		

Serial No.		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
1500 MHz 1 MHz	1499.999998 MHz	(17)	1500.000002 MHz	±0 Hz
4000 MHz 20 MHz	3999.999998 MHz	(18)	4000.000002 MHz	±0 Hz
4000 MHz 1 MHz	3999.999998 MHz	(19)	4000.000002 MHz	±0 Hz
9000 MHz 20 MHz	8999.999997 MHz	(20)	9000.000003 MHz	±0 Hz
9000 MHz 1 MHz	8999.999997 MHz	(21)	9000.000003 MHz	±0 Hz
16000 MHz 20 MHz	15999.999995 MHz	(22)	16000.000005 MHz	±0 Hz
16000 MHz 1 MHz	20999.999995 MHz	(23)	21000.000005 MHz	±0 Hz
21000 MHz 20 MHz	20999.999995 MHz	(24)	21000.000005 MHz	±0 Hz
21000 MHz 1 MHz	20999.999995 MHz	(25)	21000.000005 MHz	±0 Hz
Firmware Revision A.03.00 or later				
Center Freq Span				
1500 MHz 20 MHz	1499.999999 MHz	(16)	1500.000001 MHz	±0 Hz
1500 MHz 1 MHz	1499.999999 MHz	(17)	1500.000001 MHz	±0 Hz
4000 MHz 20 MHz	3999.999999 MHz	(18)	4000.000001 MHz	±0 Hz
4000 MHz 1 MHz	3999.999999 MHz	(19)	4000.000001 MHz	±0 Hz
9000 MHz 20 MHz	8999.999999 MHz	(20)	9000.000001 MHz	±0 Hz

Table 3-12 Agilent E4407B Performance Verification Test Record

Agil	ent Technologi	ies					
Mod	el E4407B			Report No			
Seri	al No			Date			
Test	Description		Minimum	Results Measured	Maximum	Measurement Uncertainty	
	9000 MHz	1 MHz	8999.999999 MHz	(21)	9000.000001 MHz	±0 Hz	
	16000 MHz	$20~\mathrm{MHz}$	15999.999999 MHz	(22)	16000.000001 MHz	±0 Hz	
	16000 MHz	1 MHz	20999.999999 MHz	(23)	21000.000001 MHz	±0 Hz	
	21000 MHz	$20~\mathrm{MHz}$	20999.999999 MHz	(24)	21000.000001 MHz	±0 Hz	
	$21000~\mathrm{MHz}$	1 MHz	20999.999999 MHz	(25)	21000.000001 MHz	±0 Hz	
6.	Frequency Sp Accuracy	pan					
	Span	Start Freq					
	$3000~\mathrm{MHz}$	$0~\mathrm{Hz}$	2370 MHz	(1)	2430 MHz	±6.12 MHz	
	100 MHz	$10~\mathrm{MHz}$	79 MHz	(2)	81 MHz	±204 kHz	
	$100~\mathrm{kHz}$	$10~\mathrm{MHz}$	79 kHz	(3)	81 kHz	±204 Hz	
	$100~\mathrm{MHz}$	$800~\mathrm{MHz}$	79 MHz	(4)	81 MHz	±204 kHz	
	$100~\mathrm{kHz}$	$800~\mathrm{MHz}$	79 kHz	(5)	81 kHz	±204 Hz	
	100 MHz	1400 MHz	79 MHz	(6)	81 MHz	±204 kHz	
	$100~\mathrm{kHz}$	1499 MHz	79 kHz	(7)	81 kHz	±204 Hz	
7.	Noise Sideba	nds					
	Offset from 1	GHz signal					
	(Serial Prefix SG4510 or N						
	$10~\mathrm{kHz}$			(1)	-90 dBc/Hz	±2.44 dB	
	$20~\mathrm{kHz}$			(2)	-100 dBc/Hz	±2.44 dB	
	$30~\mathrm{kHz}$			(3)	-106 dBc/Hz	±2.44 dB	

Table 3-12 Agilent E4407B Performance Verification Test Record

Agilent Technologies						
Mod	el E4407B		Report No			
Seria	al No		Date			
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
	(Serial Prefix ≥ US4510, SG4510 or MY4510, Option 1DR)					
	$10~\mathrm{kHz}$		(1)	–98 dBc/Hz	$\pm 2.44~\mathrm{dB}$	
	$20~\mathrm{kHz}$		(2)	–104 dBc/Hz	±2.44 dB	
	$30~\mathrm{kHz}$		(3)	–110 dBc/Hz	±2.44 dB	
	$(Serial\ Prefix \geq US4510,\ SG4510\ or\ MY4510,\ Non-Option\ 1DR)$					
	10 kHz		(1)	-90 dBc/Hz	±2.44 dB	
	$20~\mathrm{kHz}$		(2)	-104 dBc/Hz	±2.44 dB	
	$30~\mathrm{kHz}$		(3)	–110 dBc/Hz	±2.44 dB	
8.	Noise Sidebands - Wide Offsets	Note: Enter data in the appropriate section below depending upon whether or not Option 120 (ACPR Dynamic Range Extension) is installed.				
	Non-Option 120					
	Offset from 1 GHz signal					
	100 kHz		(1)	–118 dBc/Hz	±2.44 dB	
	1 MHz		(2)	–125 dBc/Hz	±2.44 dB	
	$5~\mathrm{MHz}$		(3)	–127 dBc/Hz	±2.44 dB	
	$10~\mathrm{MHz}$		(4)	–131 dBc/Hz	±2.44 dB	
	Option 120					
	Offset from 1 GHz signal					
	100 kHz		(1)	–118 dBc/Hz	±2.44 dB	
	1 MHz		(2)	–133 dBc/Hz	±2.44 dB	
	$5~\mathrm{MHz}$		(3)	–135 dBc/Hz	±2.44 dB	
	$10~\mathrm{MHz}$		(4)	–137 dBc/Hz	±2.44 dB	

Table 3-12 Agilent E4407B Performance Verification Test Record

Agil	ent Technologies						
Model E4407B			Report No				
Seri	al No		Date				
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty		
9.	System-Related Sidebands						
	Offset from 500 MHz signal						
	30 kHz to 230 kHz		(1)	-65 dBc	±1.30 dB		
	–30 kHz to –230 kHz		(2)	-65 dBc	±1.30 dB		
10.	Residual FM						
	1 kHz Res BW, (Non-Option 1D5)		(1)	150 Hz	±21 Hz		
	1 kHz Res BW, (Option 1D5)		(1)	100 Hz	±21 Hz		
	10 Hz Res BW (Options 1DR and 1D5 only)		(2)	2 Hz	±0.27 Hz		
11.	Sweep Time Accuracy						
	Sweep Time						
	5 ms	-1.0%	(1)	±1.0%	±0.16%		
	20 ms	-1.0%	(2)	±1.0%	±0.16%		
	100 ms	-1.0%	(3)	±1.0%	±0.16%		
	1 s	-1.0%	(4)	±1.0%	±0.16%		
	10 s	-1.0%	(5)	±1.0%	±0.16%		
	$1 \mathrm{ms} (Option AYX or B7D \\ only)$	-1.0%	(6)	±1.0%	±0.16%		
	500 µs (Option AYX or B7D only)	-1.0%	(7)	±1.0%	±0.16%		
	100 µs (Option AYX or B7D only)	-1.0%	(8)	±1.0%	±0.16%		
12.	Display Scale Fidelity						

Table 3-12 Agilent E4407B Performance Verification Test Record

Agilent Technologies	
Model E4407B	Report No
Serial No.	Date

Serial No		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
Cumulative Log Fidelity, Res BW ≥1 kHz				
dB from Ref Level				
-4	-0.30 dB	(1)	0.30 dB	±0.082 dB
-8	-0.30 dB	(2)	0.30 dB	±0.078 dB
-12	-0.40 dB	(3)	0.40 dB	±0.075 dB
-16	-0.40 dB	(4)	0.40 dB	±0.073 dB
-20	-0.40 dB	(5)	0.40 dB	±0.078 dB
-24	-0.50 dB	(6)	0.50 dB	±0.074 dB
-28	-0.50 dB	(7)	0.50 dB	±0.073 dB
-32	-0.60 dB	(8)	0.60 dB	±0.077 dB
-36	-0.60 dB	(9)	0.60 dB	±0.075 dB
-40	-0.60 dB	(10)	0.60 dB	±0.081 dB
-44	-0.70 dB	(11)	0.70 dB	±0.077 dB
-48	-0.70 dB	(12)	0.70 dB	±0.076 dB
-52	-0.70dB	(13)	0.70 dB	±0.080 dB
-56	-0.70 dB	(14)	0.70 dB	±0.078 dB
-60	-0.70 dB	(15)	0.70 dB	±0.084 dB
-64	-0.80 dB	(16)	0.80 dB	±0.081 dB
-68	-0.80 dB	(17)	0.80 dB	±0.080 dB
-72	-0.80 dB	(18)	0.80 dB	±0.084 dB
-76	-0.80 dB	(19)	0.80 dB	±0.083 dB
-80	-0.80 dB	(20)	0.80 dB	±0.089 dB
-84	-1.15 dB	(21)	1.15 dB	±0.086 dB

Table 3-12 Agilent E4407B Performance Verification Test Record

Agilent Technologies	
Model E4407B	Report No
Serial No	Date

Serial No		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
Incremental Log Fidelity, Res BW ≥1 kHz				
dB from Ref Level				
_4	-0.4 dB	(22)	0.4 dB	±0.082 dB
-8	-0.4 dB	(23)	0.4 dB	±0.078 dB
-12	-0.4 dB	(24)	0.4 dB	±0.075 dB
-16	-0.4 dB	(25)	0.4 dB	±0.073 dB
-20	-0.4 dB	(26)	0.4 dB	±0.078 dB
-24	-0.4 dB	(27)	0.4 dB	±0.074 dB
-28	-0.4 dB	(28)	0.4 dB	±0.073 dB
-32	-0.4 dB	(29)	0.4 dB	±0.077 dB
-36	-0.4 dB	(30)	0.4 dB	±0.075 dB
-40	-0.4 dB	(31)	0.4 dB	±0.081 dB
-44	-0.4 dB	(32)	0.4 dB	±0.077 dB
-48	-0.4 dB	(33)	0.4 dB	±0.076 dB
-52	-0.4 dB	(34)	0.4 dB	±0.080 dB
-56	-0.4 dB	(35)	0.4 dB	±0.078 dB
-60	-0.4 dB	(36)	0.4 dB	±0.084 dB
-64	-0.4 dB	(37)	0.4 dB	±0.081 dB
-68	-0.4 dB	(38)	0.4 dB	±0.080 dB
-72	-0.4 dB	(39)	0.4 dB	±0.084 dB
–76	-0.4 dB	(40)	0.4 dB	±0.083 dB
-80	-0.4 dB	(41)	0.4 dB	±0.089 dB
Cumulative Log Fidelity, Res BW ≤300 Hz (Option 1DR only)				
dB from Ref Level				

Table 3-12 Agilent E4407B Performance Verification Test Record

Agilent Technologies	
Model E4407B	Report No
Serial No.	Date

Serial No Date				
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
-4	-0.34 dB	(43)	0.34 dB	±0.082 dB
-8	-0.38 dB	(44)	0.38 dB	±0.078 dB
-12	-0.42 dB	(45)	0.42 dB	±0.075 dB
-16	-0.46 dB	(46)	0.46 dB	±0.073 dB
-20	-0.50 dB	(47)	0.50 dB	±0.078 dB
-24	-0.54 dB	(48)	0.54 dB	±0.074 dB
-28	-0.58 dB	(49)	0.58 dB	±0.073 dB
-32	-0.62 dB	(50)	0.62 dB	±0.077 dB
-36	-0.66 dB	(51)	0.66 dB	±0.075 dB
-40	-0.70 dB	(52)	0.70 dB	±0.081 dB
-44	-0.74 dB	(53)	0.74 dB	±0.077 dB
-48	-0.78 dB	(54)	0.78 dB	±0.076 dB
-52	-0.82 dB	(55)	0.82 dB	±0.080 dB
-56	-0.86 dB	(56)	0.86 dB	±0.078 dB
-60	-0.90 dB	(57)	0.90 dB	±0.084 dB
-64	-0.94 dB	(58)	0.94 dB	±0.081 dB
-68	-0.98 dB	(59)	0.98 dB	±0.080 dB
-72	-1.02 dB	(60)	1.02 dB	±0.084 dB
-76	-1.06 dB	(61)	1.06 dB	±0.083 dB
-80	-1.10 dB	(62)	1.10 dB	±0.089 dB
-84	-1.14 dB	(63)	1.14 dB	±0.086 dB
-88	-1.18 dB	(64)	1.18 dB	±0.085 dB
-92	-1.22 dB	(65)	1.22 dB	±0.100 dB
-96	-1.26 dB	(66)	1.26 dB	±0.099 dB
-98	-1.28 dB	(67)	1.28 dB	±0.098 dB

Table 3-12 Agilent E4407B Performance Verification Test Record

Agilent Technologies	
Model E4407B	Report No
Serial No.	Date

Serial No		Date	_	
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
Incremental Log Fidelity, Res BW ≤300 Hz (Option 1DR only)				
dB from Ref Level				
-4	-0.4 dB	(68)	0.4 dB	±0.082 dB
-8	-0.4 dB	(69)	0.4 dB	±0.078 dB
-12	-0.4 dB	(70)	0.4 dB	±0.075 dB
-16	-0.4 dB	(71)	0.4 dB	±0.073 dB
-20	-0.4 dB	(72)	0.4 dB	±0.078 dB
-24	-0.4 dB	(73)	0.4 dB	±0.074 dB
-28	-0.4 dB	(74)	0.4 dB	±0.073 dB
-32	-0.4 dB	(75)	0.4 dB	±0.077 dB
-36	-0.4 dB	(76)	0.4 dB	±0.075 dB
-40	-0.4 dB	(77)	0.4 dB	±0.081 dB
-44	-0.4 dB	(78)	0.4 dB	±0.077 dB
-48	-0.4 dB	(79)	0.4 dB	±0.076 dB
-52	-0.4 dB	(80)	0.4 dB	±0.080 dB
-56	-0.4 dB	(81)	0.4 dB	±0.078 dB
-60	-0.4 dB	(82)	0.4 dB	±0.084 dB
-64	-0.4 dB	(83)	0.4 dB	±0.081 dB
-68	-0.4 dB	(84)	0.4 dB	±0.080 dB
-72	-0.4 dB	(85)	0.4 dB	±0.084 dB
-76	-0.4 dB	(86)	0.4 dB	±0.083 dB
-80	-0.4 dB	(87)	0.4 dB	±0.089 dB
Linear Fidelity, Res BW ≥1 kHz				
dB from Ref Level				

Table 3-12 Agilent E4407B Performance Verification Test Record

Agilent Technologies	
Model E4407B	Report No
Serial No.	Date

Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
-4	-2.0%	(93)	2.0%	±0.064%
-8	-2.0%	(94)	2.0%	±0.064%
-12	-2.0%	(95)	2.0%	±0.064%
-16	-2.0%	(96)	2.0%	±0.064%
-20	-2.0%	(97)	2.0%	±0.063%
Linear Fidelity, Res BW ≤300 Hz (Option 1DR only)				
dB from Ref Level		(5.5)		
-4	-2.0%	(98)	2.0%	±0.064%
-8	-2.0%	(99)	2.0%	±0.064%
-12	-2.0%	(100)	2.0%	±0.064%
-16	-2.0%	(101)	2.0%	±0.064%
-20	-2.0%	(102)	2.0%	±0.063%
Zero Span, Res BW ≤300 Hz (Option 1DR only)				
dB from Ref Level				
-4	-0.36 dB	(103)	0.36 dB	±0.082 dB
-8	-0.42 dB	(104)	0.42 dB	±0.078 dB
-12	-0.48 dB	(105)	0.48 dB	±0.075 dB
-16	-0.54 dB	(106)	0.54 dB	±0.073 dB
-20	-0.60 dB	(107)	0.60 dB	±0.078 dB
-24	-0.66 dB	(108)	0.66 dB	±0.074 dB
-28	-0.72 dB	(109)	0.72 dB	±0.073 dB
-32	-0.78 dB	(110)	0.78 dB	±0.077 dB
-36	-0.84 dB	(111)	0.84 dB	±0.075 dB

Table 3-12 Agilent E4407B Performance Verification Test Record

Agilent Technologies	
Model E4407B	Report No
Serial No	Date

Serial No.			Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	-40	-0.90 dB	(112)	0.90 dB	±0.081 dB
	-44	-0.96 dB	(113)	0.96 dB	±0.077 dB
	-48	-1.02 dB	(114)	1.02 dB	±0.076 dB
	-52	-1.08 dB	(115)	1.08 dB	±0.080 dB
	-56	-1.14 dB	(116)	1.14 dB	±0.078 dB
	-60	-1.20 dB	(117)	1.20 dB	±0.084 dB
	-64	-1.5 dB	(118)	1.5 dB	±0.081 dB
	-68	–1.5 dB	(119)	1.5 dB	±0.080 dB
	-70	-1.5 dB	(120)	1.5 dB	±0.084 dB
13.	Input Attenuation Switching Uncertainty				
	Input Attenuation Setting				
	0 dB	-0.3 dB	(1)	0.3 dB	±0.101 dB
	5 dB	-0.3 dB	(2)	0.3 dB	±0.104 dB
	15 dB	-0.3 dB	(3)	0.3 dB	±0.102 dB
	20 dB	-0.3 dB	(4)	0.3 dB	±0.098 dB
	25 dB	-0.35 dB	(5)	0.35 dB	±0.098 dB
	30 dB	-0.40 dB	(6)	0.40 dB	±0.096 dB
	35 dB	−0.45 dB	(7)	0.45 dB	±0.099 dB
	40 dB	-0.50 dB	(8)	0.50 dB	±0.096 dB
	45 dB	-0.55 dB	(9)	0.55 dB	±0.099 dB
	50 dB	-0.60 dB	(10)	0.60 dB	±0.095 dB
	55 dB	-0.65 dB	(11)	0.65 dB	±0.099 dB
	60 dB	-0.70 dB	(12)	0.70 dB	±0.100 dB
	65 dB	−0.75 dB	(13)	0.75 dB	±0.111 dB

	Table 3-12 Agile	ent E4407B Pe	rformance Verif	ication Test R	ecord	
Agil	ent Technologies					
Model E4407B Report No						
Seri	al No		Date			
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
15.	Reference Level Accuracy					
	Log, Res BW ≥1 kHz					
	Reference Level					
	-10 dBm	-0.3 dB	(1)	0.3 dB	±0.091 dB	
	0 dBm	-0.3 dB	(2)	0.3 dB	±0.100 dB	
	-30 dBm	-0.3 dB	(3)	0.3 dB	±0.092 dB	
	-40 dBm	-0.3 dB	(4)	0.3 dB	±0.094 dB	
	-50 dBm	-0.5 dB	(5)	0.5 dB	±0.095 dB	
	-60 dBm	-0.5 dB	(6)	0.5 dB	±0.097 dB	
	-70 dBm	-0.5 dB	(7)	0.5 dB	±0.099 dB	
	-80 dBm	-0.7 dB	(8)	0.7 dB	±0.101 dB	
	Linear, Res BW ≥1 kHz					
	Reference Level					
	-10 dBm	-0.3 dB	(9)	0.3 dB	±0.091 dB	

(10)_____

(11)_____

(12)_____

(13)_____

(14)_____

(15)_____

(16)_____

 $(17)_{-}$

 $-0.3~\mathrm{dB}$

 $-0.3 \mathrm{dB}$

 $-0.3 \mathrm{dB}$

 $-0.5~\mathrm{dB}$

 $-0.5~\mathrm{dB}$

 $-0.5~\mathrm{dB}$

 $-0.7~\mathrm{dB}$

 $-0.3~\mathrm{dB}$

0 dBm

-30 dBm

-40 dBm

-50 dBm

-60 dBm

 $-70~\mathrm{dBm}$

-80 dBm

-10 dBm

Log, Res BW ≤300 Hz (Option 1DR only) Reference Level

> 570 **Chapter 3**

0.3 dB

0.3 dB

0.3 dB

 $0.5~\mathrm{dB}$

 $0.5 \mathrm{dB}$

 $0.5~\mathrm{dB}$

 $0.7~\mathrm{dB}$

0.3 dB

 $\pm 0.100~\mathrm{dB}$

 $\pm 0.092~dB$

 $\pm 0.094~\mathrm{dB}$

 $\pm 0.095~dB$

 $\pm 0.097~\mathrm{dB}$

 $\pm 0.099~\mathrm{dB}$

 $\pm 0.101~dB$

 $\pm 0.091~dB$

Table 3-12 Agilent E4407B Performance Verification Test Record

Agilent Technologies	
Model E4407B	Report No
Serial No.	Date

Seri	Serial No Date				
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	0 dBm	-0.3 dB	(18)	0.3 dB	±0.100 dB
	-30 dBm	-0.3 dB	(19)	0.3 dB	±0.092 dB
	-40 dBm	-0.3 dB	(20)	0.3 dB	±0.094 dB
	–50 dBm	-0.5 dB	(21)	0.5 dB	±0.095 dB
	-60 dBm	-0.5 dB	(22)	0.5 dB	±0.097 dB
	-70 dBm	-0.5 dB	(23)	0.5 dB	±0.099 dB
	-80 dBm	-0.7 dB	(24)	0.7 dB	±0.101 dB
	Linear, Res BW \leq 300 Hz (Option 1DR only)				
	Reference Level				
	-10 dBm	-0.3 dB	(25)	0.3 dB	±0.091 dB
	0 dBm	-0.3 dB	(26)	0.3 dB	±0.100 dB
	-30 dBm	-0.3 dB	(27)	0.3 dB	±0.092 dB
	-40 dBm	-0.3 dB	(28)	0.3 dB	±0.094 dB
	–50 dBm	-0.5 dB	(29)	0.5 dB	±0.095 dB
	-60 dBm	-0.5 dB	(30)	0.5 dB	±0.097 dB
	-70 dBm	-0.5 dB	(31)	0.5 dB	±0.099 dB
	-80 dBm	-0.7 dB	(32)	0.7 dB	±0.101 dB
16.	Resolution Bandwidth Switching Uncertainty				
	Resolution Bandwidth				
	3 kHz	-0.3 dB	(1)	0.3 dB	±0.048 dB
	9 kHz	-0.3 dB	(2)	0.3 dB	±0.048 dB
	10 kHz	-0.3 dB	(3)	0.3 dB	±0.048 dB
	30 kHz	-0.3 dB	(4)	0.3 dB	±0.048 dB
	100 kHz	-0.3 dB	(5)	0.3 dB	±0.048 dB

Table 3-12 Agilent E4407B Performance Verification Test Record

Agil	ent Technologies				
Mod	el E4407B		Report No		
Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	120 kHz	-0.3 dB	(6)	0.3 dB	±0.048 dB

Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	120 kHz	-0.3 dB	(6)	0.3 dB	±0.048 dB
	300 kHz	-0.3 dB	(7)	0.3 dB	±0.048 dB
	1 MHz	-0.3 dB	(8)	0.3 dB	±0.048 dB
	3 MHz	-0.3 dB	(9)	0.3 dB	±0.048 dB
	5 MHz	-0.6 dB	(10)	0.6 dB	±0.076 dB
	300 Hz (Option 1DR only)	-0.3 dB	(11)	0.3 dB	±0.048 dB
	200 Hz (Option 1DR only)	-0.3 dB	(12)	0.3 dB	±0.048 dB
	100 Hz (Option 1DR only)	-0.3 dB	(13)	0.3 dB	±0.048 dB
	30 Hz (Option 1DR only)	-0.3 dB	(14)	0.3 dB	±0.048 dB
	10 Hz (Option 1DR only)	-0.3 dB	(15)	0.3 dB	±0.048 dB
	3 Hz (Option 1DR and 1D5 only) Firmware Revision A.08.00 or later	-0.3 dB	(16)	0.3 dB	±0.048 dB
	1Hz (Option 1DR and 1D5 only) Firmware Revision A.08.00 or later	-0.3 dB	(17)	0.3 dB	±0.048 dB
18.	Absolute Amplitude Accuracy (Reference Settings)				
	Log, Preamp Off	-0.34 dB	(1)	0.34 dB	±0.09 dB
	Lin, Preamp Off	-0.34 dB	(2)	0.34 dB	±0.09 dB
	Log, Preamp On (Option 1DS only)	-0.37 dB	(3)	0.37 dB	±0.09 dB
	Lin, Preamp On (Option 1DS only)	-0.37 dB	(4)	0.37 dB	±0.09 dB
20.	Overall Absolute Amplitude Accuracy				
	0 dBm Reference Level				
	0 dBm input	-0.54 dB	(1)	0.54 dB	±0.234 dB

Table 3-12 Agilent E4407B Performance Verification Test Record

Agilent Technologies	
Model E4407B	Report No
Serial No.	Date

Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	–10 dBm input	-0.54 dB	(2)	0.54 dB	±0.115 dB
	–20 dBm input	-0.54 dB	(3)	0.54 dB	±0.110 dB
	–30 dBm input	-0.54 dB	(4)	0.54 dB	±0.109 dB
	–40 dBm input	-0.54 dB	(5)	0.54 dB	±0.109 dB
	–50 dBm input	-0.54 dB	(6)	0.54 dB	±0.109 dB
	–20 dBm Reference Level				
	–20 dBm input	-0.54 dB	(7)	0.54 dB	±0.109 dB
	–30 dBm input	-0.54 dB	(8)	0.54 dB	±0.109 dB
	–40 dBm input	-0.54 dB	(9)	0.54 dB	±0.109 dB
	–50 dBm input	-0.54 dB	(10)	0.54 dB	±0.109 dB
	–40 dBm Reference Level				
	–40 dBm input	-0.54 dB	(11)	0.54 dB	±0.087 dB
	–50 dBm input	-0.54 dB	(12)	0.54 dB	±0.087 dB
	–50 dBm Reference Level				
	–50 dBm input	-0.54 dB	(13)	0.54 dB	±0.087 dB
21.	Resolution Bandwidth Accuracy				
	Resolution Bandwidth				
	5 MHz	3.5 MHz	(1)	6.5 MHz	±110 kHz
	3 MHz	2.55 MHz	(2)	3.45 MHz	±66 kHz
	1 MHz	0.85 MHz	(3)	1.15 MHz	±22 kHz
	300 kHz	255 kHz	(4)	345 kHz	±6.6 kHz
	100 kHz	85 kHz	(5)	115 kHz	±2.2 kHz
	30 kHz	25.5 kHz	(6)	34.5 kHz	±660 Hz
	10 kHz	8.5 kHz	(7)	11.5 kHz	±220 Hz
	3 kHz	$2.55~\mathrm{kHz}$	(8)	3.45 kHz	±66 Hz

Table 3-12 Agilent E4407B Performance Verification Test Record

Agil	ent Technologies					
Model E4407B			Report No.			
Serial No			Date			
Test Description Minimum			Results Measured	Maximum	Measurement Uncertainty	
	1 kHz	850 Hz	(9)	1.15 kHz	±22 Hz	
	120 kHz	96 kHz	(10)	144 kHz	±2.17 kHz	
	9 kHz	7.2 kHz	(11)	10.8 kHz	±163 Hz	
24.	Frequency Response	Note: Enter data in the appropriate section below depending upon the ambient temperature at which the test was performed and installed options.				
	20 to 30° C					
	Non-Option UKB dc Coupled Band 0 (9 kHz to 3.0 GHz)					
	Maximum Response		(1)	0.46 dB	±0.19 dB	
	Minimum Response	-0.46 dB	(2)		±0.19 dB	
	Peak-to-Peak Response		(3)	0.92 dB	±0.19 dB	
	Option UKB dc Coupled Band 0 (100 Hz to 3.0 GHz					
	Maximum Response		(1)	0.5 dB	±0.19 dB	
	Minimum Response	-0.5 dB	(2)		±0.19 dB	
	Peak-to-Peak Response		(3)	1.0 dB	±0.19 dB	
	Non-Option UKB dc Coupled Band 0A (800 MHz to 1.0 GHz) (serial number US39440871 or greater)					
	Maximum Response		(4)	0.46 dB	±0.11 dB	
	Minimum Response	-0.46 dB	(5)		±0.11 dB	

Table 3-12 Agilent E4407B Performance Verification Test Record

Agilent Technologies	
Model E4407B	Report No
Serial No	Date

Serial No		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
Peak-to-Peak Response		(6)	0.92 dB	±0.11 dB
Non-Option UKB dc Coupled Band 0B (1.7 GHz to 2.0 GHz) (serial number US39440871 or greater)				
Maximum Response		(7)	0.46 dB	±0.11 dB
Minimum Response	-0.46 dB	(8)		±0.11 dB
Peak-to-Peak Response		(9)	0.92 dB	±0.11 dB
dc Coupled Band 1 (3.0 GHz to 6.7 GHz) Maximum Response Minimum Response Peak-to-Peak Response	-1.5 dB	(10) (11) (12)	1.5 dB 2.6 dB	±0.39 dB ±0.39 dB ±0.39 dB
dc Coupled Band 2 (6.7 GHz to 13.2 GHz)				
Maximum Response		(13)	2.0 dB	±0.40 dB
Minimum Response	-2.0 dB	(14)		±0.40 dB
Peak-to-Peak Response		(15)	3.6 dB	±0.40 dB
dc Coupled Band 3 (13.2 GHz to 26.5 GHz) Maximum Response		(16)	2.0 dB	±0.59 dB
waximum nesponse		(10)	2.0 uD	±0.00 UD

Table 3-12 Agilent E4407B Performance Verification Test Record

Agilent Technologies				
Model E4407B		Report No		
Serial No		Date		

Serial No		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
Minimum Response	-2.0 dB	(17)		±0.59 dB
Peak-to-Peak Response		(18)	3.6 dB	±0.59 dB
Option UKB ac Coupled Band 0 (10 MHz to 3.0 GHz) Maximum Response		(19)	0.5 dB	±0.11 dB
Minimum Response	-0.5 dB	(20)		±0.11 dB
Peak-to-Peak Response		(21)	1.0 dB	±0.11 dB
Option UKB ac Coupled Band 0A (800 MHz to 1.0 GHz) (serial number US39440871 or greater) Maximum Response Minimum Response Peak-to-Peak Response	-0.5 dB	(22) (23) (24)	0.5 dB 1.0 dB	±0.11 dB ±0.11 dB ±0.11 dB
Option UKB ac Coupled Band 0B (1.7 GHz to 2.0 GHz) (serial number US39440871 or greater)				
Maximum Response		(25)	0.5 dB	±0.11 dB
Minimum Response	-0.5 dB	(26)		±0.11 dB
Peak-to-Peak Response		(27)	1.0 dB	±0.11 dB

Table 3-12 Agilent E4407B Performance Verification Test Record

Agilent Technologies	
Model E4407B	Report No
Serial No	Date

Serial No.	Date			
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
ac Coupled Band 1 (3.0 GHz to 6.7 GHz)				
Maximum Response		(28)	1.5 dB	±0.39 dB
Minimum Response	-1.5 dB	(29)		±0.39 dB
Peak-to-Peak Response		(30)	2.6 dB	±0.39 dB
ac Coupled Band 2 (6.7 GHz to 13.2 GHz)				
Maximum Response		(31)	2.0 dB	±0.40 dB
Minimum Response	-2.0 dB	(32)		±0.40 dB
Peak-to-Peak Response		(33)	3.6 dB	±0.40 dB
ac Coupled Band 3 (13.2 GHz to 26.5 GHz)				
Maximum Response		(34)	2.0 dB	±0.59 dB
Minimum Response	-2.0 dB	(35)		±0.59 dB
Peak-to-Peak Response		(36)	3.6 dB	±0.59 dB
0 to 55° C				
Non-Option UKB dc Coupled Band 0 (9 kHz to 3.0 GHz)				
Maximum Response		(1)	0.76 dB	±0.19 dB
Minimum Response	-0.76 dB	(2)		±0.19 dB
Peak-to-Peak Response		(3)	1.52 dB	±0.19 dB

Table 3-12 Agilent E4407B Performance Verification Test Record

Agilent Technologies				
Model E4407B		Report No		
Serial No		Date	_	
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
Option UKB dc Coupled Band 0 (100 Hz to 3.0 GHz)				
Maximum Response		(1)	1.0 dB	±0.19 dB
Minimum Response	-1.0 dB	(2)		±0.19 dB
Peak-to-Peak Response		(3)	2.0 dB	±0.19 dB
Non-Option UKB dc Coupled Band 0A (800 MHz to 1.0 GHz) (serial number US39440871 or greater) Maximum Response Minimum Response Peak-to-Peak Response	-0.76 dB	(4) (5) (6)	0.76 dB 1.52 dB	±0.11 dB ±0.11 dB ±0.11 dB
Non-Option UKB dc Coupled Band 0B (1.7 GHz to 2.0 GHz) (serial number US39440871 or greater)		(7)	0.7C ID	10.11 JD
Maximum Response	0.70 AD	(7)	0.76 dB	±0.11 dB
Minimum Response	-0.76 dB	(8)	1 50 JD	±0.11 dB
Peak-to-Peak Response		(9)	1.52 dB	±0.11 dB
dc Coupled				

(3.0 GHz to 6.7 GHz)

Table 3-12 Agilent E4407B Performance Verification Test Record

Agilent Technologies	
Model E4407B	Report No
Serial No	Date

Serial No.		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
Maximum Response		(10)	2.5 dB	±0.39 dB
Minimum Response	-2.5 dB	(11)		±0.39 dB
Peak-to-Peak Response		(12)	3.0 dB	±0.39 dB
dc Coupled Band 2 (6.7 GHz to 13.2 GHz)				
Maximum Response		(13)	3.0 dB	±0.40 dB
Minimum Response	-3.0 dB	(14)		±0.40 dB
Peak-to-Peak Response		(15)	4.0 dB	±0.40 dB
dc Coupled Band 3 (13.2 GHz to 26.5 GHz)				
Maximum Response		(16)	3.0 dB	±0.59 dB
Minimum Response	-3.0 dB	(17)		±0.59 dB
Peak-to-Peak Response		(18)	4.0 dB	±0.59 dB
Option UKB ac Coupled Band 0 (10 MHz to 3.0 GHz)				
Maximum Response		(19)	1.0 dB	±0.11 dB
Minimum Response	-1.0 dB	(20)		±0.11 dB
Peak-to-Peak Response		(21)	2.0 dB	±0.11 dB
Minimum Response		(20)		±0.11 dB

	Table 3-12 Agilent E4407B Performance Verification Test Record				
Agil	Agilent Technologies				
Mod	lel E4407B		Report No		
Serial No Date					
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	Option UKB ac Coupled Band 0A (800 MHz to 1.0 GHz) (serial number US39440871 or greater) Maximum Response Minimum Response Peak-to-Peak Response	-1.0 dB	(22) (23) (24)	1.0 dB 2.0 dB	±0.11 dB ±0.11 dB ±0.11 dB
	Option UKB ac Coupled Band 0B (1.7 GHz to 2.0 GHz) (serial number US39440871 or greater)				
	Maximum Response		(25)	1.0 dB	±0.11 dB
	Minimum Response	-1.0 dB	(26)		±0.11 dB
	Peak-to-Peak Response		(27)	2.0 dB	±0.11 dB

(28)_____

(29)_____

(30)

 $(31)_{-}$

 $-2.5~\mathrm{dB}$

ac Coupled Band 1

ac Coupled Band 2

(3.0 GHz to 6.7 GHz)

Maximum Response

Minimum Response

(6.7 GHz to 13.2 GHz)

Maximum Response

Peak-to-Peak Response

580 Chapter 3

 $2.5 \mathrm{dB}$

3.0 dB

3.0 dB

±0.39 dB

 $\pm 0.39~\mathrm{dB}$

±0.39 dB

±0.40 dB

Table 3-12 Agilent E4407B Performance Verification Test Record

Agil	ent Technologies				
Mod	el E4407B		Report No		
Serial No.		Date			
Test Description		Minimum	Results Measured	Maximum	Measurement Uncertainty
	Minimum Response	-3.0 dB	(32)		±0.40 dB
	Peak-to-Peak Response		(33)	4.0 dB	±0.40 dB
	ac Coupled Band 3 (13.2 GHz to 26.5 GHz)				
	Maximum Response		(34)	3.0 dB	$\pm 0.59~\mathrm{dB}$
	Minimum Response	-3.0 dB	(35)		$\pm 0.59~\mathrm{dB}$
	Peak-to-Peak Response		(36)	4.0 dB	$\pm 0.59~\mathrm{dB}$
27.	Frequency Response (Preamp On) (Option 1DS Only)	Note: Enter data in the appropriate section below depending upon the ambient temperature at which the test was performed and installed options.			
	20 to 30° C				
	Non-Option UKB dc Coupled Band 0 (1 MHz to 3.0 GHz)				
	Maximum Response		(1)	1.5 dB	±0.28 dB
	Minimum Response	-1.5 dB	(2)		±0.28 dB
	Peak-to-Peak Response		(3)	3.0 dB	±0.28 dB
	Non-Option UKB dc Coupled Band 0A (800 MHz to 1.0 GHz) (serial number US39440871 or greater)				
	Maximum Response		(4)	1.5 dB	±0.28 dB
	Minimum Response	-1.5 dB	(5)		±0.28 dB
	Peak-to-Peak Response		(6)	3.0 dB	±0.28 dB

Table 3-12 Agilent E4407B Performance Verification Test Record

9					
Agilent Technologies					
Model E4407B		Report No			
Serial No		Date			
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
Non-Option UKB dc Coupled Band 0B (1.7 GHz to 2.0 GHz) (serial number US39440871 or greater)					
Maximum Response		(7)	1.5 dB	±0.28 dB	
Minimum Response	−1.5 dB	(8)		±0.28 dB	
Peak-to-Peak Response		(9)	3.0 dB	±0.28 dB	
Option UKB ac Coupled Band 0 (10 MHz to 3.0 GHz)					
Maximum Response		(10)	1.5 dB	±0.28 dB	
Minimum Response	−1.5 dB	(11)		±0.28 dB	
Peak-to-Peak Response		(12)	3.0 dB	±0.28 dB	
Option UKB ac Coupled Band 0A (800 MHz to 1.0 GHz) (serial number US39440871 or greater) Maximum Response		(13)	1.5 dB	±0.28 dB	

 $3.0~\mathrm{dB}$

 $\pm 0.28~dB$

 $\pm 0.28~\mathrm{dB}$

(14)_____

(15)_____

-1.5 dB

Minimum Response

Peak-to-Peak Response

Table 3-12 Agilent E4407B Performance Verification Test Record

Agilent Technologies	
Model E4407B	Report No
Serial No.	Date

Serial No	Date			
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
Option UKB ac Coupled Band 0B (1.7 GHz to 2.0 GHz) (serial number US39440871 or greater)				
Maximum Response		(16)	1.5 dB	±0.28 dB
Minimum Response	-1.5 dB	(17)		±0.28 dB
Peak-to-Peak Response		(18)	3.0 dB	±0.28 dB
0 to 55° C				
Non-Option UKB dc Coupled Band 0 (1 MHz to 3.0 GHz)				
Maximum Response		(1)	2.0 dB	±0.28 dB
Minimum Response	-2.0 dB	(2)		±0.28 dB
Peak-to-Peak Response		(3)	4.0 dB	±0.28 dB
Non-Option UKB dc Coupled Band 0A (800 MHz to 1.0 GHz) (serial number US39440871 or greater)				
Maximum Response		(4)	2.0 dB	±0.28 dB
Minimum Response	-2.0 dB	(5)		±0.28 dB
Peak-to-Peak Response		(6)	4.0 dB	±0.28 dB

	Table 3-12 Agile	ent E4407B Pe	erformance Verif	fication Test F	Record
Agi	Agilent Technologies				
Model E4407B			Report No		
Seri	ial No		Date		
Test Description Minimum		Minimum	Results Measured Maximum Uncertaint		
	Non-Option UKB dc Coupled Band 0B (1.7 GHz to 2.0 GHz) (serial number US39440871 or greater) Maximum Response Minimum Response Peak-to-Peak Response	-2.0 dB	(7) (8) (9)	2.0 dB 4.0 dB	±0.28 dB ±0.28 dB ±0.28 dB
	Option UKB ac Coupled				

(10)_____

(11)_____

(12)____

(13)_____

(14)_____

(15)____

-2.0 dB

 $-2.0~\mathrm{dB}$

 $2.0~\mathrm{dB}$

4.0 dB

2.0 dB

4.0 dB

 $\pm 0.28~\mathrm{dB}$

 $\pm 0.28~\mathrm{dB}$

 $\pm 0.28~\mathrm{dB}$

 $\pm 0.28~\mathrm{dB}$

±0.28 dB

 $\pm 0.28~\mathrm{dB}$

Band 0

Option UKB ac Coupled Band 0A

(serial number

(10 MHz to 3.0 GHz)

Maximum Response

Minimum Response

(800 MHz to 1.0 GHz)

US39440871 or greater)

Maximum Response

Minimum Response

Peak-to-Peak Response

Peak-to-Peak Response

Table 3-12 Agilent E4407B Performance Verification Test Record

Agilent Technologies						
Mod	lel E4407B	Report No				
Seri	al No		Date			
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
	Option UKB ac Coupled Band 0B (1.7 GHz to 2.0 GHz) (serial number US39440871 or greater)					
	Maximum Response		(16)	2.0 dB	±0.28 dB	
	Minimum Response	-2.0 dB	(17)		±0.28 dB	
	Peak-to-Peak Response		(18)	4.0 dB	±0.28 dB	
29.	Other Input-Related Spurious Responses					
	Center Freq Input Freq					
	2.0 GHz 2042.8 MHz		(1)	-65 dBc	±.891 dB	
	2.0 GHz 2642.8 MHz		(2)	-65 dBc	±.891 dB	
	2.0 GHz 1820.8 MHz		(3)	-65 dBc	±.891 dB	
	2.0 GHz 278.5 MHz		(4)	-65 dBc	±.891 dB	
	2.0 GHz 5600.0 MHz		(5)	-80 dBc	±.891 dB	
	2.0 GHz 6242.8 MHz		(6)	-80 dBc	±.891 dB	
	4.0 GHz 4042.8 MHz		(7)	-65 dBc	±.891 dB	
	4.0 GHz 4642.8 MHz		(8)	-65 dBc	±.891 dB	
	4.0 GHz 3742.9 MHz		(9)	-65 dBc	±.891 dB	
	4.0 GHz 2242.8 MHz		(10)	-80 dBc	±.891 dB	
	9.0 GHz 9042.8 MHz		(11)	-65 dBc	±.891 dB	

9.0 GHz 9642.8 MHz

9.0 GHz 9342.8 MHz

9.0 GHz 4982.1 MHz

 $15.0~{\rm GHz}~15042.8~{\rm MHz}$

 $15.0~{\rm GHz}~15642.8~{\rm MHz}$

Chapter 3 585

 $-65~\mathrm{dBc}$

 $-65~\mathrm{dBc}$

 $-80~\mathrm{dBc}$

 $-65~\mathrm{dBc}$

 $-65~\mathrm{dBc}$

 $\pm .891~\mathrm{dB}$

 $\pm .891~\mathrm{dB}$

 $\pm .891~\mathrm{dB}$

 $\pm .891~\mathrm{dB}$

 $\pm .891~\mathrm{dB}$

(12)_____

(13)_____

(14)

(15)_____

 $(16)_{--}$

Table 3-12 Agilent E4407B Performance Verification Test Record

Agil	ent Technologies				
Mod	el E4407B		Report No		
Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	15.0 GHz 18830.35 MHz		(17)	-65 dBc	±.891 dB
	15.0 GHz 4151.75 MHz		(18)	-80 dBc	±.891 dB
	21.0 GHz 21042.8 MHz		(19)	-65 dBc	±.971 dB
	21.0 GHz 21642.8 MHz		(20)	-65 dBc	±.971 dB
	21.0 GHz 21342.8 MHz		(21)	-65 dBc	±.971 dB
	$21.0~{ m GHz}~5008.95~{ m MHz}$		(22)	-80 dBc	±.971 dB
32.	Spurious Responses				
	300 MHz TOI, 1 kHz RBW	12.5 dBm	(1)		±0.93 dB
	300 MHz TOI, 30 Hz RBW (Option 1DR only)	12.5 dBm	(2)		±0.93 dB
	5 GHz TOI	11 dBm	(3)		±0.93 dB
	8 GHz TOI	7.5 dBm	(4)		±0.93 dB
	$300~\mathrm{MHz}~\mathrm{SHI}$	35 dBm	(5)		±0.41 dB
	$900~\mathrm{MHz}~\mathrm{SHI}$	45 dBm	(6)		±0.41 dB
	$1.55~\mathrm{GHz}~\mathrm{SHI}$	75 dBm	(7)		±0.41 dB
	3.1 GHz SHI	90 dBm	(8)		±0.41 dB
34.	Gain Compression				
	Test Frequency				
	53 MHz		(1)	1.0 dB	±0.123 dB
	50.004 MHz (Option 1DR only)		(2)	1.0 dB	±0.123 dB
	1403 MHz		(3)	1.0 dB	±0.123 dB
	2503 MHz		(4)	1.0 dB	±0.123 dB
	4403 MHz		(5)	1.0 dB	±0.123 dB

(6)_

7603 MHz

586 Chapter 3

1.0 dB

±0.123 dB

Table 3-12 Agilent E4407B Performance Verification Test Record

Agilent Technologies					
Mod	el E4407B		Report No.		
Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	14003 MHz		(7)	1.0 dB	±0.123 dB
38.	Displayed Average Noise Level		sults with preamp or ent temperature who		
	1 kHz RBW, Preamp Off				
	$10~\mathrm{MHz}$ to $1~\mathrm{GHz}$		(1)	-116 dBm	±1.23 dB
	1 GHz to 2 GHz		(2)	-116 dBm	±1.23 dB
	2 GHz to 3 GHz		(3)	-112 dBm	±1.23 dB
	3 GHz to 6 GHz		(4)	-112 dBm	±1.23 dB
	$6~\mathrm{GHz}$ to $12~\mathrm{GHz}$		(5)	–111 dBm	±1.23 dB
	12 GHz to 22 GHz		(6)	-107 dBm	±1.23 dB
	$22~\mathrm{GHz}$ to $26.5~\mathrm{GHz}$		(7)	-106 dBm	±1.23 dB
	1kHz RBW, Preamp On, 0 to 55° C				
	$10~\mathrm{MHz}$ to $1~\mathrm{GHz}$		(8)	–131 dBm	±1.23 dB
	1 GHz to 2 GHz		(9)	–131 dBm	±1.23 dB
	$2~\mathrm{GHz}$ to $3~\mathrm{GHz}$		(10)	-133 dBm	±1.23 dB
	10 Hz RBW, Preamp Off				
	$10~\mathrm{MHz}$ to $1~\mathrm{GHz}$		(11)	-135 dBm	±1.23 dB
	1 GHz to 2 GHz		(12)	-135 dBm	±1.23 dB
	$2~\mathrm{GHz}$ to $3~\mathrm{GHz}$		(13)	–131 dBm	±1.23 dB
	3 GHz to 6 GHz		(14)	–131 dBm	±1.23 dB
	$6~\mathrm{GHz}$ to $12~\mathrm{GHz}$		(15)	-130 dBm	±1.23 dB
	$12~\mathrm{GHz}$ to $22~\mathrm{GHz}$		(16)	-126 dBm	±1.23 dB
	$22~\mathrm{GHz}$ to $26.5~\mathrm{GHz}$		(17)	-125 dBm	±1.23 dB
	$10~\mathrm{Hz}$ RBW, Preamp On, $0~\mathrm{to}~55^{\circ}~\mathrm{C}$				

Table 3-12 Agilent E4407B Performance Verification Test Record

	idole o 12 inglic	rightent E 110 th 1 citorinance verification 1 cot tectora				
Agil	ent Technologies					
Model E4407B		Report No				
Serial No			Date			
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
	10 MHz to 1 GHz		(18)	–150 dBm	±1.23 dB	

1 GHz to 2 GHz (19)_____ -150 dBm $\pm 1.23~\mathrm{dB}$ 2 GHz to 3 GHz (20)-146 dBm ±1.23 dB 1kHz RBW, Preamp On, 20 to 30° C 10 MHz to 1 GHz (21) -132 dBm ±1.23 dB 1 GHz to 2 GHz (22)-132 dBm ±1.23 dB 2 GHz to 3 GHz $(23)_{\underline{}}$ -130 dBm ±1.23 dB 10 Hz RBW, Preamp On, 20 to 30° C 10 MHz to 1 GHz -151 dBm $(24)_{----}$ ±1.23 dB (25)_____ 1 GHz to 2 GHz -151 dBm ±1.23 dB 2 GHz to 3 GHz (26)-149 dBm ±1.23 dB 39. **Residual Responses** 150 kHz to 6.7 GHz-90 dBm $\pm 0.87~\mathrm{dB}$ (1)____ **40. Fast Time Domain Amplitude Accuracy** (Option AYX only) -0.3%0.3% **Amplitude Error** $\pm 0.029\%$ (1) **Tracking Generator 42.** Absolute Amplitude and Vernier Accuracy (Option 1DN only) Absolute Amplitude $-0.75~\mathrm{dB}$ (1)____ 0.75 dB±0.096 dB Accuracy Absolute Vernier Accuracy -2 dB $-0.5~\mathrm{dB}$ $(2)_{----}$ $0.5~\mathrm{dB}$ $\pm 0.008~dB$ $-0.5~\mathrm{dB}$ -3 dB $(3)_{\underline{}}$ 0.5 dB $\pm 0.008 \text{ dB}$

Table 3-12 Agilent E4407B Performance Verification Test Record

Agilent Technologies			
Model E4407B	Report No		
Serial No	Date		

Seriai No.			Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	−5 dB	-0.5 dB	(4)	0.5 dB	±0.008 dB
	-6 dB	-0.5 dB	(5)	0.5 dB	±0.008 dB
	-7 dB	-0.5 dB	(6)	0.5 dB	±0.008 dB
	-8 dB	-0.5 dB	(7)	0.5 dB	±0.008 dB
	−9 dB	-0.5 dB	(8)	0.5 dB	±0.008 dB
	-10 dB	-0.5 dB	(9)	0.5 dB	±0.008 dB
	Incremental Vernier Accuracy				
	−2 dB	-0.2 dB	(10)	0.2 dB	±0.008 dB
	−3 dB	-0.2 dB	(11)	0.2 dB	±0.008 dB
	−5 dB	-0.2 dB	(12)	0.2 dB	±0.008 dB
	-6 dB	-0.2 dB	(13)	0.2 dB	±0.008 dB
	−7 dB	-0.2 dB	(14)	0.2 dB	±0.008 dB
	-8 dB	-0.2 dB	(15)	0.2 dB	±0.008 dB
	-9 dB	-0.2 dB	(16)	0.2 dB	±0.008 dB
	-10 dB	-0.2 dB	(17)	0.2 dB	±0.008 dB
43.	Tracking Generator Output Level Flatness (Option 1DN only)				
	Positive Level Flatness, <1 MHz		(1)	3.0 dB	±0.284 dB
	Negative Level Flatness, <1 MHz	-3.0 dB	(2)		±0.284 dB
	Positive Level Flatness, 1 MHz to 10 MHz		(3)	3.0 dB	±0.142 dB
	Negative Level Flatness, 1 MHz to 10 MHz	−3.0 dB	(4)		±0.142 dB

Table 3-12 Agilent E4407B Performance Verification Test Record

Agil	Agilent Technologies					
Mod	el E4407B		Report No Date			
Seri	al No					
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
	Positive Level Flatness, >10 MHz to 1.5 GHz		(5)	2.0 dB	±0.142 dB	
	Negative Level Flatness, >10 MHz to 1.5 GHz	–2.0 dB	(6)		±0.142 dB	
	Positive Level Flatness, >1.5 GHz		(7)	2.0 dB	±0.142 dB	
	Negative Level Flatness, >1.5 GHz	-2.0 dB	(8)		±0.142 dB	
46.	Tracking Generator Harmonic Spurious Outputs (Option 1DN only)					
	2 nd Harmonic, <20 kHz		(1)	-15 dBc	±2.6 dB	
	2 nd Harmonic, ≥20 kHz		(2)	-25 dBc	±2.6 dB	
	3 rd Harmonic, <20 kHz		(3)	-15 dBc	±2.6 dB	
	3 rd Harmonic, ≥20 kHz		(4)	–25 dBc	±2.6 dB	
48.	Tracking Generator Non-Harmonic Spurious Outputs (Option 1DN only)					
	Highest Non-Harmonic Spurious Output Amplitude, 9 kHz to 2 GHz		(1)	–27 dBc	±2.63 dB	
	Highest Non-Harmonic Spurious Output Amplitude, 2 GHz to 3 GHz		(2)	–23 dBc	±3.14 dB	
49.	Tracking Generator L.O. Feedthrough (Option 1DN only)					
	9 kHz to 2.9 GHz		(1)	-16 dBm	±2.58 dB	

 $(2)_{-}$

 $2.9~\mathrm{GHz}$ to $3.0~\mathrm{GHz}$

590 Chapter 3

 $-16~\mathrm{dBm}$

 $\pm 3.03~\mathrm{dB}$

Table 3-12 Agilent E4407B Performance Verification Test Record

Agilent Technologies					
Mod	el E4407B		Report No		
Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
50.	Gate Delay and Gate Length Accuracy (Option 1D6 only)				
	Minimum Gate Delay	499.9 ns	(1)	1.5001µs	±549 ps
	Maximum Gate Delay	499.9 ns	(2)	1.5001µs	±549 ps
	1 μs Gate Length	499.9 ns	(3)	1.5001µs	±520 ps
	65 ms Gate Length	64.993ms	(4)	65.007ms	±647 ns
51.	Gate Mode Additional Amplitude Error (Option 1D6 only)				
	Amplitude Error	-0.2 dB	(1)	0.2 dB	±0.023 dB
52.	First LO Output Power Accuracy (Option AYZ only) 20 to 30° C	Note: Enter data in the appropriate section based upon the ambient temperature at which the test was performed.			pon the ambient
	First LO Frequency				
	$2.9~\mathrm{GHz}$	15.5 dBm	(1)	17.0 dBm	±0.16 dB
	$3.3~\mathrm{GHz}$	15.5 dBm	(2)	17.0 dBm	±0.16 dB
	$3.7~\mathrm{GHz}$	15.5 dBm	(3)	17.0 dBm	±0.16 dB
	$3.9~\mathrm{GHz}$	15.5 dBm	(4)	17.0 dBm	±0.16 dB
	4.1 GHz	15.5 dBm	(5)	17.0 dBm	±0.16 dB
	4.5 GHz	15.5 dBm	(6)	17.0 dBm	±0.16 dB
	4.9 GHz	15.5 dBm	(7)	17.0 dBm	±0.16 dB
	$5.3~\mathrm{GHz}$	15.5 dBm	(8)	17.0 dBm	±0.16 dB
	$5.7~\mathrm{GHz}$	15.5 dBm	(9)	17.0 dBm	±0.16 dB
	$5.9~\mathrm{GHz}$	15.5 dBm	(10)	17.0 dBm	±0.16 dB
	$6.1~\mathrm{GHz}$	15.5 dBm	(11)	17.0 dBm	±0.16 dB
	$6.5~\mathrm{GHz}$	13.0 dBm	(12)	17.5 dBm	±0.16 dB

Agilent E4407B Performance Verification Test Record Table 3-12

Agilent Technologies					
el E4407B		Report No			
al No		Date			
Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
6.9 GHz	13.0 dBm	(13)	17.5 dBm	±0.16 dB	
7.1 GHz	13.0 dBm	(14)	17.5 dBm	±0.16 dB	
0 to 55° C First LO Frequency					
$2.9~\mathrm{GHz}$	15.0 dBm	(1)	17.5 dBm	±0.16 dB	
$3.3~\mathrm{GHz}$	15.0 dBm	(2)	17.5 dBm	±0.16 dB	
3.7 GHz	15.0 dBm	(3)	17.5 dBm	±0.16 dB	
$3.9~\mathrm{GHz}$	15.0 dBm	(4)	17.5 dBm	±0.16 dB	
4.1 GHz	15.0 dBm	(5)	17.5 dBm	±0.16 dB	
4.5 GHz	15.0 dBm	(6)	17.5 dBm	±0.16 dB	
4.9 GHz	15.0 dBm	(7)	17.5 dBm	±0.16 dB	
$5.3~\mathrm{GHz}$	15.0 dBm	(8)	17.5 dBm	±0.16 dB	
5.7 GHz	15.0 dBm	(9)	17.5 dBm	±0.16 dB	
$5.9~\mathrm{GHz}$	15.0 dBm	(10)	17.5 dBm	±0.16 dB	
6.1 GHz	15.0 dBm	(11)	17.5 dBm	±0.16 dB	
$6.5~\mathrm{GHz}$	13.0 dBm	(12)	17.5 dBm	±0.16 dB	
$6.9~\mathrm{GHz}$	13.0 dBm	(13)	17.5 dBm	±0.16 dB	
7.1 GHz	13.0 dBm	(14)	17.5 dBm	±0.16 dB	
IF Input Accuracy (Option AYZ only)	Note: Enter data in the appropriate section below depending upon the ambient temperature at which the test was performed.				
$20 ext{ to } 30^{\circ} ext{ C}$					
IF Input Accuracy	-1.0 dB	(1)	1.0 dBm	±0.102 dB	
0 to 50° C					
IF Input Accuracy	-1.5 dB	(1)	1.5 dBm	±0.102 dB	
	el E4407B al No Description 6.9 GHz 7.1 GHz 0 to 55° C First LO Frequency 2.9 GHz 3.3 GHz 3.7 GHz 3.9 GHz 4.1 GHz 4.5 GHz 4.9 GHz 5.3 GHz 5.7 GHz 5.9 GHz 6.1 GHz 6.5 GHz 6.9 GHz 7.1 GHz IF Input Accuracy (Option AYZ only) 20 to 30° C IF Input Accuracy 0 to 50° C	Description Minimum	Report No. Date	Report No. Date	

Table 3-12 Agilent E4407B Performance Verification Test Record

Agilent Technologies						
Model E4407B			Report No			
Seri	al No		Date			
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
58.	GSM Phase and Frequency Error (Option BAH and B7E)					
	Peak Phase Error	-2.1 Deg	(1)	2.1 Deg	0.52 Deg	
	RMS Phase Error	-1.1 Deg	(2)	1.1 Deg	0.000063 Deg	
	Frequency Error	-10 Hz	(3)	10 Hz	±0.006 Hz	
59.	Comms Absolute Power Accuracy (Options BAC or BAH)					
	20 to 30° C					
	cdmaOne Channel Power Accuracy (Option BAC only)					
	Cellular Band Input Amplitude					
	15 dBm	-0.95 dB	(1)	0.95 dB	±0.173 dB	
	−5 dBm	-0.95 dB	(2)	0.95 dB	±0.161 dB	
	−25 dBm	-0.84 dB	(3)	0.84 dB	±0.161 dB	
	-45 dBm	-0.87 dB	(4)	0.87 dB	±0.152 dB	
	-55 dBm	−0.95 dB	(5)	0.95 dB	±0.152 dB	
	-70 dBm	-1.07 dB	(6)	1.07 dB	±0.161 dB	
	PCS Band Input Amplitude					
	15 dBm	-0.93 dB	(7)	0.93 dB	±0.173 dB	
	−5 dBm	-0.93 dB	(8)	0.93 dB	±0.161 dB	
	-25 dBm	-0.78 dB	(9)	0.78 dB	±0.161 dB	
	-45 dBm	-0.77 dB	(10)	0.77 dB	±0.152 dB	
	-55 dBm	-0.85 dB	(11)	0.85 dB	±0.152 dB	
	-70 dBm	-0.97 dB	(12)	0.97 dB	±0.161 dB	

Table 3-12 Agilent E4407B Performance Verification Test Record

		,			
Agil	ent Technologies				
Model E4407B		Report No			
Seri	al No		Date	_	
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	GSM Transmit Power				

Serial No.		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
GSM Transmit Power Accuracy (Option BAH only)				
GSM Band Input Amplitude				
15 dBm	-0.94 dB	(13)	0.94 dB	±0.173 dB
-20 dBm	-0.94 dB	(14)	0.94 dB	±0.161 dB
-30 dBm	-0.80 dB	(15)	0.80 dB	±0.156 dB
-40 dBm	-0.83 dB	(16)	0.83 dB	±0.161 dB
-50 dBm	-0.99 dB	(17)	0.99 dB	±0.152 dB
-60 dBm	-1.13 dB	(18)	1.13 dB	±0.161 dB
DCS and PCS Bands Input Amplitude				
15 dBm	-0.92 dB	(19)	0.92 dB	±0.173 dB
-20 dBm	-0.92 dB	(20)	0.92 dB	±0.161 dB
-30 dBm	-0.74 dB	(21)	0.74 dB	±0.156 dB
-40 dBm	-0.79 dB	(22)	0.79 dB	±0.161 dB
-50 dBm	-0.95 dB	(23)	0.95 dB	±0.152 dB
-60 dBm	-1.09 dB	(24)	1.09 dB	±0.161 dB
cdmaOne Receive Channel Power, Preamp Off (Option BAC only)				
Cellular Band Input Amplitude				
-40 dBm	-1.56 dB	(25)	1.56 dB	±0.161 dB
-60 dBm	-1.56 dB	(26)	1.56 dB	±0.161 dB
-70 dBm	-1.56 dB	(27)	1.56 dB	±0.161 dB
-80 dBm	-1.56 dB	(28)	1.56 dB	±0.161 dB

Table 3-12 Agilent E4407B Performance Verification Test Record

Agilent Technologies	
Model E4407B	Report No
Serial No	Date

Seriai No.		Date			
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
-85 dBm	-1.56 dB	(29)	1.56 dB	±0.152 dB	
PCS Band Input Amplitude					
-40 dBm	-1.45 dB	(30)	1.45 dB	±0.161 dB	
-60 dBm	-1.45 dB	(31)	1.45 dB	±0.161 dB	
-70 dBm	-1.45 dB	(32)	1.45 dB	±0.161 dB	
-80 dBm	-1.45 dB	(33)	1.45 dB	±0.161 dB	
-85 dBm	-1.45 dB	(34)	1.45 dB	±0.152 dB	
cdmaOne Receive Channel Power, Preamp On (Option BAC only)					
Cellular Band Input Amplitude					
-40 dBm	-2.15 dB	(35)	2.15 dB	±0.161 dB	
-60 dBm	-2.15 dB	(36)	2.15 dB	±0.161 dB	
-70 dBm	-2.15 dB	(37)	2.15 dB	±0.161 dB	
-80 dBm	-2.15 dB	(38)	2.15 dB	±0.161 dB	
-90 dBm	-2.95 dB	(39)	2.95 dB	±0.161 dB	
-100 dBm	-2.95 dB	(40)	2.95 dB	±0.161 dB	
PCS Band Input Amplitude					
-40 dBm	-2.15 dB	(41)	2.15 dB	±0.161 dB	
-60 dBm	-2.15 dB	(42)	2.15 dB	±0.161 dB	
-70 dBm	-2.15 dB	(43)	2.15 dB	±0.161 dB	
-80 dBm	-2.15 dB	(44)	2.15 dB	±0.161 dB	
-90 dBm	-2.95 dB	(45)	2.95 dB	±0.161 dB	
-100 dBm	-2.95 dB	(46)	2.95 dB	±0.161 dB	

Agilent E4408B Performance Verification Test Record

Tests for the Agilent E4408B only are included in this test record, therefore not all test numbers are included.

Table 3-13 Agilent E4408B Performance Verification Test Record

Agilent Technologies				
Address:		Report No		
		Date		
Model E4408B				
Serial No		Ambient temperature	e° C	
Options		Relative humidity	%	
Firmware Revision		Power mains line frequency Hz (nominal)		
Customer		Tested by		
Test Equipment Used:				
Description	Model No.	Trace No.	Cal Due Date	
Synthesized Signal Generator				
Synthesized Sweeper #1		·		
Synthesized Sweeper #2				
Function Generator				
Power Meter, Dual-Channel				
RF Power Sensor #1				
RF Power Sensor #2				
Microwave Power Sensor				
Low-Power Power Sensor				
Digital Multimeter				
Universal Counter				
Frequency Standard				
Power Splitter				
$50~\Omega$ Termination				

Table 3-13 Agilent E4408B Performance Verification Test Record

1 dB Step Attenuator	 	
10 dB Step Attenuator	 	
Microwave Spectrum Analyzer (Option 1DN only)	 	
Notes/comments:	 	
	 	·

Table 3-14 Agilent E4408B Performance Verification Test Record

Agilent Technologies						
Mod	el E4408B			Report No		
Seri	al No			Date		
Test	Description		Minimum	Results Measured	Maximum	Measurement Uncertainty
1.	10 MHz Refer Output Accur					
	Settability		-5.0 Hz	(1)	5.0 Hz	±293.3 μHz
4.	Frequency R Marker Freq Count Accur	uency				
	Frequency Rea Accuracy	adout				
	Center Freq	Span				
	1500 MHz	$20~\mathrm{MHz}$	1499.83 MHz	(1)	1500.17 MHz	±0 Hz
	1500 MHz	$10~\mathrm{MHz}$	1499.91 MHz	(2)	1500.09 MHz	±0 Hz
	1500 MHz	1 MHz	1499.991 MHz	(3)	1500.009 MHz	±0 Hz
	4000 MHz	$20~\mathrm{MHz}$	3999.83 MHz	(4)	4000.17 MHz	±0 Hz
	4000 MHz	$10~\mathrm{MHz}$	3999.91 MHz	(5)	4000.09 MHz	±0 Hz
	4000 MHz	1 MHz	3999.991 MHz	(6)	4000.009 MHz	±0 Hz
	9000 MHz	$20~\mathrm{MHz}$	8999.83 MHz	(7)	9000.17 MHz	±0 Hz
	9000 MHz	$10~\mathrm{MHz}$	8999.91 MHz	(8)	9000.09 MHz	±0 Hz
	9000 MHz	1 MHz	8999.991 MHz	(9)	9000.009 MHz	±0 Hz

Table 3-14 Agilent E4408B Performance Verification Test Record

Agil	ent Technolog	ies				
Mod	el E4408B			Report No		
Seri	al No			Date		
Test	Description		Minimum	Results Measured	Maximum	Measurement Uncertainty
	16000 MHz	20 MHz	15999.83 MHz	(10)	16000.17 MHz	±0 Hz
	16000 MHz	10 MHz	15999.91 MHz	(11)	16000.09 MHz	±0 Hz
	16000 MHz	1 MHz	15999.991 MHz	(12)	16000.009 MHz	±0 Hz
	21000 MHz	$20~\mathrm{MHz}$	20999.83 MHz	(13)	21000.17 MHz	±0 Hz
	21000 MHz	$10~\mathrm{MHz}$	20999.91 MHz	(14)	21000.09 MHz	±0 Hz
	21000 MHz	1 MHz	20999.991 MHz	(15)	21000.009 MHz	±0 Hz
	Marker Count	Accuracy		sults in the appropri	ate section below	based upon the
	Firmware Revito A.03.00	ision Prior				
	Center Freq	Span				
	1500 MHz	20 MHz	1499.999998 MHz	(16)	1500.000002 MHz	±0 Hz
	1500 MHz	1 MHz	1499.999998 MHz	(17)	1500.000002 MHz	±0 Hz
	4000 MHz	20 MHz	3999.999998 MHz	(18)	4000.000002 MHz	±0 Hz
	4000 MHz	1 MHz	3999.999998 MHz	(19)	4000.000002 MHz	±0 Hz
	9000 MHz	$20~\mathrm{MHz}$	8999.999997 MHz	(20)	9000.000003 MHz	±0 Hz
	9000 MHz	1 MHz	8999.999997 MHz	(21)	9000.000003 MHz	±0 Hz
	16000 MHz	$20~\mathrm{MHz}$	15999.999995 MHz	(22)	16000.000005 MHz	±0 Hz

Table 3-14 Agilent E4408B Performance Verification Test Record

Agilent Technologies	
Model E4408B	Report No
Serial No	Date

seri	ai No			Date		
Test	Description		Minimum	Results Measured	Maximum	Measurement Uncertainty
	16000 MHz	1 MHz	20999.999995 MHz	(23)	21000.000005 MHz	±0 Hz
	21000 MHz	$20~\mathrm{MHz}$	20999.999995 MHz	(24)	21000.000005 MHz	±0 Hz
	21000 MHz	1 MHz	20999.999995 MHz	(25)	21000.000005 MHz	±0 Hz
	Firmware Revi A.03.00 or late					
	Center Freq	Span				
	1500 MHz	$20~\mathrm{MHz}$	1499.999999 MHz	(16)	1500.000001 MHz	±0 Hz
	1500 MHz	1 MHz	1499.999999 MHz	(17)	1500.000001 MHz	±0 Hz
	4000 MHz	20 MHz	3999.999999 MHz	(18)	4000.000001 MHz	±0 Hz
	4000 MHz	1 MHz	3999.999999 MHz	(19)	4000.000001 MHz	±0 Hz
	9000 MHz	$20~\mathrm{MHz}$	8999.999999 MHz	(20)	9000.000001 MHz	±0 Hz
	9000 MHz	1 MHz	8999.999999 MHz	(21)	9000.000001 MHz	±0 Hz
	16000 MHz	$20~\mathrm{MHz}$	15999.999999 MHz	(22)	16000.000001 MHz	±0 Hz
	16000 MHz	1 MHz	20999.999999 MHz	(23)	21000.000001 MHz	±0 Hz
	21000 MHz	$20~\mathrm{MHz}$	20999.999999 MHz	(24)	21000.000001 MHz	±0 Hz
	21000 MHz	1 MHz	20999.999999 MHz	(25)	21000.000001 MHz	±0 Hz
6.	Frequency Sp Accuracy	pan				

Table 3-14 Agilent E4408B Performance Verification Test Record

Agil	ent Technologies				
Mod	el E4408B		Report No		
Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	Span Start Freq				
	3000 MHz 0 Hz	2370 MHz	(1)	2430 MHz	±6.12 MHz
	100 MHz 10 MHz	79 MHz	(2)	81 MHz	±204 kHz
	100 kHz 10 MHz	79 kHz	(3)	81 kHz	±204 Hz
	100 MHz 800 MHz	79 MHz	(4)	81 MHz	±204 kHz
	100 kHz 800 MHz	79 kHz	(5)	81 kHz	±204 Hz
	100 MHz 1400 MHz	79 MHz	(6)	81 MHz	±204 kHz
	100 kHz 1499 MHz	79 kHz	(7)	81 kHz	±204 Hz
7.	Noise Sidebands				
	Offset from 1 GHz signal				
	10 kHz		(1)	–90 dBc/Hz	±2.44 dB
	20 kHz		(2)	-100 dBc/Hz	±2.44 dB
	30 kHz		(3)	-106 dBc/Hz	±2.44 dB
9.	System-Related Sidebands				
	Offset from 500 MHz signal				
	30 kHz to 230 kHz		(1)	–65 dBc	±1.30 dB
	–30 kHz to –230 kHz		(2)	–65 dBc	±1.30 dB
10.	Residual FM				
	1 kHz Res BW		(1)	150 Hz	±21 Hz
11.	Sweep Time Accuracy				
	Sweep Time				
	5 ms	-1.0%	(1)	±1.0%	±0.16%
	20 ms	-1.0%	(2)	±1.0%	±0.16%
	100 ms	-1.0%	(3)	±1.0%	±0.16%

Table 3-14 Agilent E4408B Performance Verification Test Record

Agilent Technologies				
Model E4408B	Report No			
Serial No.		Date		
Test Description	Minimum	Results	Maximum	Measurement
Test Description	Minimum	Measured	Maximum	Uncertainty

SCIT	Date				
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	1 s	-1.0%	(4)	±1.0%	±0.16%
	10 s	-1.0%	(5)	±1.0%	±0.16%
12.	Display Scale Fidelity				
	Cumulative Log Fidelity, Res BW ≥1 kHz				
	dB from Ref Level				
	_4	-0.34 dB	(1)	0.34 dB	±0.082 dB
	-8	-0.38 dB	(2)	0.38 dB	±0.078 dB
	-12	-0.42 dB	(3)	0.42 dB	±0.075 dB
	-16	-0.46 dB	(4)	0.46 dB	±0.073 dB
	-20	-0.50 dB	(5)	0.50 dB	±0.078 dB
	-24	-0.54 dB	(6)	0.54 dB	±0.074 dB
	-28	-0.58 dB	(7)	0.58 dB	±0.073 dB
	-32	-0.62 dB	(8)	0.62 dB	±0.077 dB
	-36	-0.66 dB	(9)	0.66 dB	±0.075 dB
	-40	-0.70 dB	(10)	0.70 dB	±0.081 dB
	-44	-0.74 dB	(11)	0.74 dB	±0.077 dB
	-48	-0.78 dB	(12)	0.78 dB	±0.076 dB
	-52	-0.82 dB	(13)	0.82 dB	±0.080 dB
	-56	-0.86 dB	(14)	0.86 dB	±0.078 dB
	-60	-0.90 dB	(15)	0.90 dB	±0.084 dB
	-64	-0.94 dB	(16)	0.94 dB	±0.081 dB
	-68	-0.98 dB	(17)	0.98 dB	±0.080 dB
	-72	-1.02 dB	(18)	1.02 dB	±0.084 dB
	-76	-1.06 dB	(19)	1.06 dB	±0.083 dB
	-80	-1.10 dB	(20)	1.10 dB	±0.089 dB

Table 3-14 Agilent E4408B Performance Verification Test Record

Agilent Technologies	
Model E4408B	Report No.
Serial No	Date

Seriai No.		Date			
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
-84	-1.14 dB	(21)	1.14 dB	±0.086 dB	
Incremental Log Fidelity, Res BW ≥1 kHz					
dB from Ref Level					
-4	-0.4 dB	(22)	0.4 dB	±0.082 dB	
-8	-0.4 dB	(23)	0.4 dB	±0.078 dB	
-12	-0.4 dB	(24)	0.4 dB	±0.075 dB	
-16	-0.4 dB	(25)	0.4 dB	±0.073 dB	
-20	-0.4 dB	(26)	0.4 dB	±0.078 dB	
-24	-0.4 dB	(27)	0.4 dB	±0.074 dB	
-28	-0.4 dB	(28)	0.4 dB	±0.073 dB	
-32	-0.4 dB	(29)	0.4 dB	±0.077 dB	
-36	-0.4 dB	(30)	0.4 dB	±0.075 dB	
-40	-0.4 dB	(31)	0.4 dB	±0.081 dB	
-44	-0.4 dB	(32)	0.4 dB	±0.077 dB	
-48	-0.4 dB	(33)	0.4 dB	±0.076 dB	
-52	-0.4 dB	(34)	0.4 dB	±0.080 dB	
-56	-0.4 dB	(35)	0.4 dB	±0.078 dB	
-60	-0.4 dB	(36)	0.4 dB	±0.084 dB	
-64	-0.4 dB	(37)	0.4 dB	±0.081 dB	
-68	-0.4 dB	(38)	0.4 dB	±0.080 dB	
-72	-0.4 dB	(39)	0.4 dB	±0.084 dB	
-76	-0.4 dB	(40)	0.4 dB	±0.083 dB	
-80	-0.4 dB	(41)	0.4 dB	±0.089 dB	

Table 3-14 Agilent E4408B Performance Verification Test Record

Agilent Technologies	
Model E4408B	Report No
Serial No	Date

Serial No Date				
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
Cumulative Log Fidelity, Res BW ≤300 Hz (Option 1DR only)				
dB from Ref Level				
-4	-0.34 dB	(43)	0.34 dB	±0.082 dB
-8	-0.38 dB	(44)	0.38 dB	±0.078 dB
-12	-0.42 dB	(45)	0.42 dB	±0.075 dB
-16	-0.46 dB	(46)	0.46 dB	±0.073 dB
-20	-0.50 dB	(47)	0.50 dB	±0.078 dB
-24	-0.54 dB	(48)	0.54 dB	±0.074 dB
-28	-0.58 dB	(49)	0.58 dB	±0.073 dB
-32	-0.62 dB	(50)	0.62 dB	±0.077 dB
-36	-0.66 dB	(51)	0.66 dB	±0.075 dB
-40	-0.70 dB	(52)	0.70 dB	±0.081 dB
-44	-0.74 dB	(53)	0.74 dB	±0.077 dB
-48	-0.78 dB	(54)	0.78 dB	±0.076 dB
-52	-0.82 dB	(55)	0.82 dB	±0.080 dB
-56	-0.86 dB	(56)	0.86 dB	±0.078 dB
-60	-0.90 dB	(57)	0.90 dB	±0.084 dB
-64	-0.94 dB	(58)	0.94 dB	±0.081 dB
-68	-0.98 dB	(59)	0.98 dB	±0.080 dB
-72	-1.02 dB	(60)	1.02 dB	±0.084 dB
-76	-1.06 dB	(61)	1.06 dB	±0.083 dB
-80	-1.10 dB	(62)	1.10 dB	±0.089 dB
-84	-1.14 dB	(63)	1.14 dB	±0.086 dB
-88	-1.18 dB	(64)	1.18 dB	±0.085 dB

Table 3-14 Agilent E4408B Performance Verification Test Record

Agilent Technologies	
Model E4408B	Report No
Serial No	Date

Serial No Date				
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
-92	-1.22 dB	(65)	1.22 dB	±0.100 dB
-96	-1.26 dB	(66)	1.26 dB	±0.099 dB
-98	-1.28 dB	(67)	1.28 dB	±0.098 dB
Incremental Log Fidelity, Res BW ≤300 Hz (Option 1DR only)				
dB from Ref Level				
-4	-0.4 dB	(68)	0.4 dB	±0.082 dB
-8	-0.4 dB	(69)	0.4 dB	±0.078 dB
-12	-0.4 dB	(70)	0.4 dB	±0.075 dB
-16	-0.4 dB	(71)	0.4 dB	±0.073 dB
-20	-0.4 dB	(72)	0.4 dB	±0.078 dB
-24	-0.4 dB	(73)	0.4 dB	±0.074 dB
-28	-0.4 dB	(74)	0.4 dB	±0.073 dB
-32	-0.4 dB	(75)	0.4 dB	±0.077 dB
-36	-0.4 dB	(76)	0.4 dB	±0.075 dB
-40	-0.4 dB	(77)	0.4 dB	±0.081 dB
_44	-0.4 dB	(78)	0.4 dB	±0.077 dB
-48	-0.4 dB	(79)	0.4 dB	±0.076 dB
-52	-0.4 dB	(80)	0.4 dB	±0.080 dB
-56	-0.4 dB	(81)	0.4 dB	±0.078 dB
-60	-0.4 dB	(82)	0.4 dB	±0.084 dB
-64	-0.4 dB	(83)	0.4 dB	±0.081 dB
-68	-0.4 dB	(84)	0.4 dB	±0.080 dB
-72	-0.4 dB	(85)	0.4 dB	±0.084 dB
-76	-0.4 dB	(86)	0.4 dB	±0.083 dB

Table 3-14 Agilent E4408B Performance Verification Test Record

Agilent Technologies	
Model E4408B	Report No
Serial No	Date

Serial No.		Date			
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	-80	-0.4 dB	(87)	0.4 dB	±0.089 dB
	Linear Fidelity, Res BW ≥1 kHz				
	dB from Ref Level				
	-4	-2.0%	(93)	2.0%	±0.064%
	-8	-2.0%	(94)	2.0%	±0.064%
	-12	-2.0%	(95)	2.0%	±0.064%
	-16	-2.0%	(96)	2.0%	±0.064%
	-20	-2.0%	(97)	2.0%	±0.063%
	Linear Fidelity, Res BW ≤300 Hz (Option 1DR only)				
	dB from Ref Level				
	-4	-2.0%	(98)	2.0%	±0.064%
	-8	-2.0%	(99)	2.0%	±0.064%
	-12	-2.0%	(100)	2.0%	±0.064%
	-16	-2.0%	(101)	2.0%	±0.064%
	-20	-2.0%	(102)	2.0%	±0.063%
	Zero Span, Res BW ≤300 Hz (Option 1DR only)				
	dB from Ref Level				
	-4	-0.36 dB	(103)	0.36 dB	±0.082 dB
	-8	−0.42 dB	(104)	0.42 dB	±0.078 dB
	-12	-0.48 dB	(105)	0.48 dB	±0.075 dB
	-16	-0.54 dB	(106)	0.54 dB	±0.073 dB
	-20	-0.60 dB	(107)	0.60 dB	±0.078 dB
	-24	-0.66 dB	(108)	0.66 dB	±0.074 dB

	Table 3-14 Agilent E4408B Performance Verification Test Record				
Agil	ent Technologies				
Mod	el E4408B		Report No		
Seri	Serial No Date				
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	-28	-0.72 dB	(109)	0.72 dB	±0.073 dB
	-32	-0.78 dB	(110)	0.78 dB	±0.077 dB
	-36	-0.84 dB	(111)	0.84 dB	±0.075 dB
	-40	-0.90 dB	(112)	0.90 dB	±0.081 dB
	-44	-0.96 dB	(113)	0.96 dB	±0.077 dB
	-48	-1.02 dB	(114)	1.02 dB	±0.076 dB
	-52	-1.08 dB	(115)	1.08 dB	±0.080 dB
	-56	-1.14 dB	(116)	1.14 dB	±0.078 dB
	-60	-1.20 dB	(117)	1.20 dB	±0.084 dB
	-64	-1.5 dB	(118)	1.5 dB	±0.081 dB
	-68	-1.5 dB	(119)	1.5 dB	±0.080 dB
	-70	-1.5 dB	(120)	1.5 dB	±0.084 dB
13.	Input Attenuation Switching Uncertainty				

		-48	-1.02 dB	(114)	1.02 dB	±0.076 dB
		-52	-1.08 dB	(115)	1.08 dB	±0.080 dB
		-56	-1.14 dB	(116)	1.14 dB	±0.078 dB
		-60	-1.20 dB	(117)	1.20 dB	±0.084 dB
		-64	−1.5 dB	(118)	1.5 dB	±0.081 dB
		-68	−1.5 dB	(119)	1.5 dB	±0.080 dB
		-70	−1.5 dB	(120)	1.5 dB	±0.084 dB
1	3.	Input Attenuation Switching Uncertainty				
		Input Attenuation Setting				
		0 dB	-0.3 dB	(1)	0.3 dB	±0.101 dB
		5 dB	-0.3 dB	(2)	0.3 dB	±0.104 dB
		15 dB	-0.3 dB	(3)	0.3 dB	±0.102 dB
		20 dB	-0.3 dB	(4)	0.3 dB	±0.098 dB
		25 dB	−0.35 dB	(5)	0.35 dB	±0.098 dB
		30 dB	-0.40 dB	(6)	0.40 dB	±0.096 dB
		35 dB	−0.45 dB	(7)	0.45 dB	±0.099 dB
		40 dB	-0.50 dB	(8)	0.50 dB	±0.096 dB
		45 dB	-0.55 dB	(9)	0.55 dB	±0.099 dB
		50 dB	-0.60 dB	(10)	0.60 dB	±0.095 dB
		55 dB	-0.65 dB	(11)	0.65 dB	±0.099 dB
					·	

	Table 3-14 Agilent E4408B Performance Verification Test Record					
Agil	Agilent Technologies					
Model E4408B Report No						
Seri	Serial No Date					
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
	60 dB	-0.70 dB	(12)	0.70 dB	±0.100 dB	
	65 dB	-0.75 dB	(13)	0.75 dB	±0.111 dB	
15.	Reference Level Accuracy					
	Log					
	Reference Level					
	-10 dBm	-0.3 dB	(1)	0.3 dB	±0.091 dB	
	0 dBm	-0.3 dB	(2)	0.3 dB	±0.100 dB	
	-30 dBm	-0.3 dB	(3)	0.3 dB	±0.092 dB	
	-40 dBm	-0.3 dB	(4)	0.3 dB	±0.094 dB	
	-50 dBm	−0.5 dB	(5)	$0.5~\mathrm{dB}$	±0.095 dB	

(6)____

(7)_____

(9)_____

(10)

(11)_____

(12)_____

(13)_____

(14)_____

(15)_____

(16)_____

(8)____

 $0.5 \mathrm{dB}$

 $0.5 \mathrm{dB}$

0.7 dB

0.3 dB

0.3 dB

0.3 dB

0.3 dB

 $0.5~\mathrm{dB}$

0.5 dB

 $0.5~\mathrm{dB}$

 $0.7 \mathrm{dB}$

 $\pm 0.097~\mathrm{dB}$

 $\pm 0.099~\mathrm{dB}$

 $\pm 0.101~dB$

 $\pm 0.091~dB$

 $\pm 0.100~dB$

 $\pm 0.092~dB$

 $\pm 0.094~dB$

 $\pm 0.095~\mathrm{dB}$

 $\pm 0.097~\mathrm{dB}$

 $\pm 0.099~dB$

 $\pm 0.101~\mathrm{dB}$

-0.5 dB

 $-0.5~\mathrm{dB}$

-0.7 dB

-0.3 dB

-0.3 dB

 $-0.3~\mathrm{dB}$

-0.3 dB

 $-0.5~\mathrm{dB}$

 $-0.5~\mathrm{dB}$

 $-0.5~\mathrm{dB}$

-0.7 dB

-60 dBm

 $-70~\mathrm{dBm}$

-80 dBm

-10 dBm

0 dBm

-30 dBm

-40 dBm

-50 dBm

-60 dBm

 $-70~\mathrm{dBm}$

-80 dBm

Resolution Bandwidth Switching Uncertainty

16.

Reference Level

Linear

	Table 3-14 Agilent E4408B Performance Verification Test Record				
Agil	ent Technologies				
Mod	el E4408B		Report No		
Serial No Date					
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	Resolution Bandwidth				
	3 kHz	-0.3 dB	(1)	0.3 dB	±0.048 dB
	9 kHz	-0.3 dB	(2)	0.3 dB	±0.048 dB
	10 kHz	-0.3 dB	(3)	0.3 dB	±0.048 dB
	$30~\mathrm{kHz}$	-0.3 dB	(4)	0.3 dB	±0.048 dB
	100 kHz	-0.3 dB	(5)	0.3 dB	±0.048 dB
	120 kHz	-0.3 dB	(6)	0.3 dB	±0.048 dB
	300 kHz	-0.3 dB	(7)	0.3 dB	±0.048 dB
	1 MHz	-0.3 dB	(8)	0.3 dB	±0.048 dB
	3 MHz	-0.3 dB	(9)	0.3 dB	±0.048 dB
	5 MHz	-0.6 dB	(10)	0.6 dB	±0.076 dB
	300 Hz (Option 1DR only)	-3.0 dB	(11)	0.3 dB	±0.048 dB
	200 Hz (Option 1DR only)	-3.0 dB	(12)	0.3 dB	±0.048 dB

(13)____

(1)____

 $(2)_{__}$

(1)_____

(2)____

(3)____

 $(4)_{___}$

-3.0 dB

-0.4 dB

-0.4 dB

-0.6 dB

-0.6 dB

-0.6 dB

-0.6 dB

0.3 dB

0.4 dB

0.4 dB

 $0.6 \mathrm{dB}$

 $0.6 \mathrm{dB}$

 $0.6~\mathrm{dB}$

0.6 dB

±0.048 dB

±0.09 dB

±0.09 dB

 $\pm 0.234~\mathrm{dB}$

 $\pm 0.115~\mathrm{dB}$

±0.110 dB

±0.109 dB

100 Hz (Option 1DR only)

Absolute Amplitude Accuracy (Reference

Log, Preamp Off

Lin, Preamp Off

Overall Absolute Amplitude Accuracy 0 dBm Reference Level

0 dBm input

−10 dBm input

-20 dBm input

-30 dBm input

Settings)

18.

20.

Table 3-14 Agilent E4408B Performance Verification Test Record

Agilent Technologies	
Model E4408B	Report No
Serial No.	Date

Seria	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	–40 dBm input	-0.6 dB	(5)	0.6 dB	±0.109 dB
	–50 dBm input	-0.6 dB	(6)	0.6 dB	±0.109 dB
	–20 dBm Reference Level				
	–20 dBm input	-0.6 dB	(7)	0.6 dB	±0.109 dB
	–30 dBm input	-0.6 dB	(8)	0.6 dB	±0.109 dB
	–40 dBm input	-0.6 dB	(9)	0.6 dB	±0.109 dB
	–50 dBm input	-0.6 dB	(10)	0.6 dB	±0.109 dB
	–40 dBm Reference Level				
	–40 dBm input	-0.6 dB	(11)	0.6 dB	±0.087 dB
	–50 dBm input	-0.6 dB	(12)	0.6 dB	±0.087 dB
	–50 dBm Reference Level				
	–50 dBm input	-0.6 dB	(13)	0.6 dB	±0.087 dB
21.	Resolution Bandwidth Accuracy				
	Resolution Bandwidth				
	5 MHz	$3.5~\mathrm{MHz}$	(1)	6.5 MHz	±110 kHz
	3 MHz	$2.55~\mathrm{MHz}$	(2)	$3.45~\mathrm{MHz}$	±66 kHz
	1 MHz	$0.85~\mathrm{MHz}$	(3)	$1.15~\mathrm{MHz}$	±22 kHz
	$300~\mathrm{kHz}$	$255~\mathrm{kHz}$	(4)	$345~\mathrm{kHz}$	±6.6 kHz
	100 kHz	$85~\mathrm{kHz}$	(5)	$115~\mathrm{kHz}$	±2.2 kHz
	30 kHz	$25.5~\mathrm{kHz}$	(6)	$34.5~\mathrm{kHz}$	±660 Hz
	10 kHz	$8.5~\mathrm{kHz}$	(7)	$11.5~\mathrm{kHz}$	±220 Hz
	3 kHz	$2.55~\mathrm{kHz}$	(8)	$3.45~\mathrm{kHz}$	±66 Hz
	1 kHz	850 Hz	(9)	$1.15~\mathrm{kHz}$	±22 Hz
	120 kHz	96 kHz	(10)	144 kHz	±2.17 kHz
	9 kHz	$7.2~\mathrm{kHz}$	(11)	10.8 kHz	±163 Hz

Table 3-14 Agilent E4408B Performance Verification Test Record

Agilent Technologies					
Model E4408B Serial No			Report No Date		
24.	Frequency Response	Note: Enter data in the appropriate section below depending upon the ambient temperature at which the test was performed and installed options.			
	20 to 30° C				
	Band 0 (9 kHz to 3.0 GHz)				
	Maximum Response		(1)	0.50 dB	±0.19 dB
	Minimum Response	-0.50 dB	(2)		±0.19 dB
	Peak-to-Peak Response		(3)	1.0 dB	±0.19 dB
	Band 1 (3.0 GHz to 6.7 GHz)				
	Maximum Response		(10)	1.5 dB	±0.39 dB
	Minimum Response	-1.5 dB	(11)		±0.39 dB
	Peak-to-Peak Response		(12)	2.6 dB	±0.39 dB
	Band 2 (6.7 GHz to 13.2 GHz)				
	Maximum Response		(13)	2.0 dB	±0.40 dB
	Minimum Response	-2.0 dB	(14)		±0.40 dB
	Peak-to-Peak Response		(15)	3.6 dB	±0.40 dB
	Band 3 (13.2 GHz to 26.5 GHz)				
	Maximum Response		(16)	2.0 dB	±0.59 dB
	Minimum Response	-2.0 dB	(17)		±0.59 dB
	Peak-to-Peak Response		(18)	3.6 dB	±0.59 dB

Table 3-14 Agilent E4408B Performance Verification Test Record

Agilent Technologies				
Model E4408B	Report No			
Serial No.	Date			

Serial No		Date			
Test Description		Minimum	Results Measured	Maximum	Measurement Uncertainty
	0 to 55° C				
	Band 0 (9 kHz to 3.0 GHz				
	Maximum Response		(1)	1.0 dB	±0.19 dB
	Minimum Response	-1.0 dB	(2)		±0.19 dB
	Peak-to-Peak Response		(3)	2.0 dB	±0.19 dB
	Band 1 (3.0 GHz to 6.7 GHz)				
	Maximum Response		(10)	2.5 dB	±0.39 dB
	Minimum Response	-2.5 dB	(11)		±0.39 dB
	Peak-to-Peak Response		(12)	3.0 dB	±0.39 dB
	Band 2 (6.7 GHz to 13.2 GHz) Maximum Response		(13)	3.0 dB	±0.40 dB
	Minimum Response	-3.0 dB	(14)	9.0 ub	±0.40 dB
	Peak-to-Peak Response	3.0 už	(15)	4.0 dB	±0.40 dB
	Band 3 (13.2 GHz to 26.5 GHz)				
	Maximum Response		(16)	3.0 dB	±0.59 dB
	Minimum Response	-3.0 dB	(17)		±0.59 dB
	Peak-to-Peak Response		(18)	4.0 dB	±0.59 dB
29.	Other Input-Related Spurious Responses				
	Center Freq Input Freq				
	.	L	J	l	l

Table 3-14 Agilent E4408B Performance Verification Test Record

Agilent Technologies				
Model E4408B	Report No	Report No		
Serial No	Date	Date		
	Rosults	Massurament		

Seri	al No	Date			
Test Description		Minimum	Results Measured	Maximum	Measurement Uncertainty
	2.0 GHz 2042.8 MHz		(1)	-65 dBc	±.891 dB
	2.0 GHz 2642.8 MHz		(2)	-65 dBc	±.891 dB
	2.0 GHz 1820.8 MHz		(3)	-65 dBc	±.891 dB
	2.0 GHz 278.5 MHz		(4)	-65 dBc	±.891 dB
	2.0 GHz 5600.0 MHz		(5)	-80 dBc	±.891 dB
	2.0 GHz 6242.8 MHz		(6)	-80 dBc	±.891 dB
	4.0 GHz 4042.8 MHz		(7)	-65 dBc	±.891 dB
	4.0 GHz 4642.8 MHz		(8)	-65 dBc	±.891 dB
	4.0 GHz 3742.9 MHz		(9)	-65 dBc	±.891 dB
	4.0 GHz 2242.8 MHz		(10)	-80 dBc	±.891 dB
	9.0 GHz 9042.8 MHz		(11)	-65 dBc	±.891 dB
	9.0 GHz 9642.8 MHz		(12)	-65 dBc	±.891 dB
	9.0 GHz 9342.8 MHz		(13)	-65 dBc	±.891 dB
	9.0 GHz 4982.1 MHz		(14)	-80 dBc	±.891 dB
	15.0 GHz 15042.8 MHz		(15)	-65 dBc	±.891 dB
	15.0 GHz 15642.8 MHz		(16)	-65 dBc	±.891 dB
	15.0 GHz 18830.35 MHz		(17)	-65 dBc	±.891 dB
	15.0 GHz 4151.75 MHz		(18)	-80 dBc	±.891 dB
	21.0 GHz 21042.8 MHz		(19)	-65 dBc	±.971 dB
	21.0 GHz 21642.8 MHz		(20)	-65 dBc	±.971 dB
	21.0 GHz 21342.8 MHz		(21)	-65 dBc	±.971 dB
	21.0 GHz 5008.95 MHz		(22)	-80 dBc	±.971 dB
32.	Spurious Responses	Note: Test Record Entry 2 does not apply to the Agilent E4408B.			
	300 MHz TOI	7.5 dBm	(1)		±0.93 dB
	5 GHz TOI	7.5 dBm	(3)		±0.93 dB

Table 3-14 Agilent E4408B Performance Verification Test Record

Agilent Technologies						
Mod	el E4408B		Report No			
Seri	al No		Date			
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty	
	8 GHz TOI	5 dBm	(4)		±0.93 dB	
	300 MHz SHI	30 dBm	(5)		±0.41 dB	
	900 MHz SHI	40 dBm	(6)		±0.41 dB	
	1.55 GHz SHI	70 dBm	(7)		±0.41 dB	
	3.1 GHz SHI	85 dBm	(8)		±0.41 dB	
34.	Gain Compression	Note: Test Reco	ord Entry 2 does not	apply to the Agil	ent E4408B.	
	Test Frequency					
	53 MHz		(1)	1.0 dB	±0.123 dB	
	1403 MHz		(3)	1.0 dB	±0.123 dB	
	2503 MHz		(4)	1.0 dB	±0.123 dB	
	4403 MHz		(5)	1.0 dB	±0.123 dB	
	7603 MHz		(6)	1.0 dB	±0.123 dB	
	14003 MHz		(7)	1.0 dB	±0.123 dB	
38.	Displayed Average Noise Level					
	1 kHz RBW					
	10 MHz to 1 GHz		(1)	-116 dBm	±1.23 dB	
	1 GHz to 2 GHz		(2)	–115 dBm	±1.23 dB	
	$2~\mathrm{GHz}$ to $3~\mathrm{GHz}$		(3)	–112 dBm	±1.23 dB	
	3 GHz to 6 GHz		(4)	–112 dBm	±1.23 dB	
	6 GHz to 12 GHz		(5)	-110 dBm	±1.23 dB	
	12 GHz to 22 GHz		(6)	-107 dBm	±1.23 dB	
	22 GHz to 26.5 GHz		(7)	-101 dBm	±1.23 dB	
	100 Hz RBW					
	10 MHz to 1 GHz		(11)	-124 dBm	±1.23 dB	
	1 CHz to 2 CHz		(19)	_193 dBm	+1 93 dB	

Table 3-14 Agilent E4408B Performance Verification Test Record

	9				
Agilent Technologies					
Mod	el E4408B		Report No		
Seri	al No	Date			
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	2 GHz to 3 GHz		(13)	-120 dBm	±1.23 dB
	3 GHz to 6 GHz		(14)	-120 dBm	±1.23 dB
	6 GHz to 12 GHz		(15)	-118 dBm	±1.23 dB
	12 GHz to 22 GHz		(16)	–115 dBm	±1.23 dB
	22 GHz to 26.5 GHz		(17)	-109 dBm	±1.23 dB
39.	Residual Responses				
	150 kHz to 6.7 GHz		(1)	–90 dBm	±0.87 dB
42.	Tracking Generator Absolute Amplitude and Vernier Accuracy (Option 1DN only)				
	Absolute Amplitude Accuracy	-0.75 dB	(1)	0.75 dB	±0.096 dB
	Absolute Vernier Accuracy				
	−2 dB	-0.5 dB	(2)	0.5 dB	±0.008 dB
	−3 dB	-0.5 dB	(3)	0.5 dB	±0.008 dB
	–5 dB	-0.5 dB	(4)	0.5 dB	±0.008 dB
	-6 dB	-0.5 dB	(5)	0.5 dB	±0.008 dB
	−7 dB	-0.5 dB	(6)	0.5 dB	±0.008 dB
	-8 dB	-0.5 dB	(7)	0.5 dB	±0.008 dB
	-9 dB	-0.5 dB	(8)	0.5 dB	±0.008 dB
	-10 dB	-0.5 dB	(9)	0.5 dB	±0.008 dB
	Incremental Vernier Accuracy				
	−2 dB	-0.2 dB	(10)	0.2 dB	±0.008 dB
	-3 dB	-0.2 dB	(11)	0.2 dB	±0.008 dB

(12)_

-0.2 dB

-5 dB

Chapter 3

0.2 dB

 $\pm 0.008~\mathrm{dB}$

Table 3-14 Agilent E4408B Performance Verification Test Record

Agilent Technologies						
Mod	el E4408B		Report No			
Seri	al No		Date			
Test Description Minimum		Results Measured	Maximum	Measurement Uncertainty		
	-6 dB	-0.2 dB	(13)	0.2 dB	±0.008 dB	
	-7 dB	-0.2 dB	(14)	0.2 dB	±0.008 dB	
	-8 dB	-0.2 dB	(15)	0.2 dB	±0.008 dB	
	-9 dB	-0.2 dB	(16)	0.2 dB	±0.008 dB	
	-10 dB	-0.2 dB	(17)	0.2 dB	±0.008 dB	
44.	Tracking Generator Level Flatness (Option 1DN only)					
	Positive Level Flatness, <1 MHz		(1)	3.0 dB	±0.284 dB	
	Negative Level Flatness, <1 MHz	-3.0 dB	(2)		±0.284 dB	
	Positive Level Flatness, 1 MHz to 10 MHz		(3)	3.0 dB	±0.142 dB	
	Negative Level Flatness, 1 MHz to 10 MHz	-3.0 dB	(4)		±0.142 dB	
	Positive Level Flatness, >10 MHz to 1.5 GHz		(5)	2.0 dB	±0.142 dB	
	Negative Level Flatness, >10 MHz to 1.5 GHz	-2.0 dB	(6)		±0.142 dB	
	Positive Level Flatness, >1.5 GHz		(7)	2.0 dB	±0.142 dB	
	Negative Level Flatness, >1.5 GHz	-2.0 dB	(8)		±0.142 dB	
46.	Tracking Generator Harmonic Spurious Outputs (Option 1DN only)					
	2 nd Harmonic, <20 kHz		(1)	–15 dBc	±2.6 dB	
	2 nd Harmonic, ≥20 kHz		(2)	–25 dBc	±2.6 dB	

Table 3-14 Agilent E4408B Performance Verification Test Record

Agilent Technologies					
Mod	el E4408B		Report No		
Seri	al No		Date	-	
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	3 rd Harmonic, <20 kHz		(3)	-15 dBc	±2.6 dB
	3 rd Harmonic, ≥20 kHz		(4)	-25 dBc	±2.6 dB
48.	Tracking Generator Non-Harmonic Spurious Outputs (Option 1DN only) Highest Non-Harmonic Spurious Output Amplitude, 9 kHz to 2 GHz Highest Non-Harmonic Spurious Output		(2)	–27 dBc	±2.63 dB ±3.14 dB
	Amplitude, 2 GHz to 3 GHz				
49.	Tracking Generator L.O. Feedthrough (Option 1DN only)				
	9 kHz to 2.9 GHz		(1)	-16 dBm	±2.58 dB
	2.9 GHz to 3.0 GHz		(2)	-16 dBm	±3.03 dB

Agilent E4411B Performance Verification Test Record

Tests for the Agilent E4411B only are included in this test record, therefore not all test numbers are included.

Table 3-15 Agilent E4411B Performance Verification Test Record

Agilent Technologies				
Address:		Report No		
		Date		
Model E4411B				
Serial No		Ambient temperature	° C	
Options		Relative humidity	%	
Firmware Revision		Power mains line frequency Hz (nominal)		
Customer		Tested by		
Test Equipment Used:				
Description	Model No.	Trace No.	Cal Due Date	
Synthesized Signal Generator				
Synthesized Sweeper				
Function Generator				
Power Meter, Dual-Channel				
RF Power Sensor #1				
RF Power Sensor #2 $50~\Omega~Input~(No~Option~1DP)$		·		
Low-Power Power Sensor				
75 Ω Power Sensor (Option 1DP only)	·			
Digital Multimeter				
Universal Counter				
Frequency Standard				
Power Splitter				

Table 3-15 Agilent E4411B Performance Verification Test Record

50Ω Termination	 	
Minimum Loss Pad (Option 1DP only)	 	
1 dB Step Attenuator	 	
10 dB Step Attenuator	 	
Microwave Spectrum Analyzer (Option 1DN or 1DQ only)	 	
Notes/comments:	 	

Table 3-16 Agilent E4411B Performance Verification Test Record

Agilent Technologies						
Mod	el E4411B			Report No		
Seri	al No			Date		
Test	Description		Minimum	Results Measured	Maximum	Measurement Uncertainty
1.	10 MHz Refer Output Accur					
	Settability		–5.0 Hz	(1)	5.0 Hz	±293.3 μHz
3.	Frequency Ro Marker Freq Count Accura	uency				
	Frequency Rea Accuracy	adout				
	Center Freq	Span				
	1490 MHz	20 MHz	1489.83 MHz	(1)	1490.17 MHz	±0 Hz
	$1490~\mathrm{MHz}$	$10~\mathrm{MHz}$	1489.91 MHz	(2)	1490.09 MHz	±0 Hz
	1490 MHz	1 MHz	1489.991 MHz	(3)	1490.009 MHz	±0 Hz
	Marker Count	Accuracy				
	Center Freq	Span				
	$1490~\mathrm{MHz}$	10 MHz	1489.999998 MHz	(4)	1490.000002 MHz	±0 Hz

Table 3-16 Agilent E4411B Performance Verification Test Record

Agilent Technologies					
Mod	el E4411B		Report No		
Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	1490 MHz 1 MHz	1489.999998 MHz	(5)	1490.000002 MHz	±0 Hz
5.	Frequency Span Accuracy				
	Span Start Freq				
	1500 MHz 0 Hz	1185 MHz	(1)	1215 MHz	±3.06 MHz
	100 MHz 10 MHz	79 MHz	(2)	81 MHz	±204 kHz
	100 kHz 10 MHz	79 kHz	(3)	81 kHz	±204 Hz
	100 MHz 800 MHz	79 MHz	(4)	81 MHz	±204 kHz
	100 kHz 800 MHz	79 kHz	(5)	81 kHz	±204 Hz
	100 MHz 1400 MHz	79 MHz	(6)	81 MHz	±204 kHz
	100 kHz 1499 MHz	79 kHz	(7)	81 kHz	±204 Hz
7.	Noise Sidebands				
	Offset from 1 GHz signal				
	10 kHz		(1)	–93 dBc/Hz	±2.44 dB
	20 kHz		(2)	-100 dBc/Hz	±2.44 dB
	30 kHz		(3)	-104 dBc/Hz	±2.44 dB
	100 kHz		(4)	–113 dBc/Hz	±2.44 dB
9.	System-Related Sidebands				
	Offset from 500 MHz signal				
	30 kHz to 230 kHz		(1)	-65 dBc	±1.30 dB
	–30 kHz to –230 kHz		(2)	-65 dBc	±1.30 dB
10.	Residual FM				
	1 kHz Res BW		(1)	150 Hz	±21 Hz
11	Swoon Time Accuracy				

Table 3-16 Agilent E4411B Performance Verification Test Record

Agilent Technologies					
Mod	el E4411B		Report No		
Seri	al No	Date			
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	Sweep Time				
	5 ms	-1.0%	(1)	1.0%	±0.16%
	20 ms	-1.0%	(2)	1.0%	±0.16%
	100 ms	-1.0%	(3)	1.0%	±0.16%
	1 s	-1.0%	(4)	1.0%	±0.16%
	10 s	-1.0%	(5)	1.0%	±0.16%
12.	Display Scale Fidelity				
	Cumulative Log Fidelity, Res BW ≥1 kHz				
	dB from Ref Level				
	_4	-0.34 dB	(1)	0.34 dB	±0.082 dB
	-8	-0.38 dB	(2)	$0.38~\mathrm{dB}$	±0.078 dB
	-12	−0.42 dB	(3)	$0.42~\mathrm{dB}$	±0.075 dB
	-16	-0.46 dB	(4)	$0.46~\mathrm{dB}$	±0.073 dB
	-20	-0.50 dB	(5)	$0.50~\mathrm{dB}$	±0.078 dB
	-24	-0.54 dB	(6)	$0.54~\mathrm{dB}$	±0.074 dB
	-28	-0.58 dB	(7)	$0.58~\mathrm{dB}$	±0.073 dB
	-32	-0.62 dB	(8)	$0.62~\mathrm{dB}$	±0.077 dB
	-36	-0.66 dB	(9)	0.66 dB	±0.075 dB
	-40	-0.70 dB	(10)	$0.70~\mathrm{dB}$	±0.081 dB
	-44	-0.74 dB	(11)	$0.74~\mathrm{dB}$	±0.077 dB
	-48	-0.78 dB	(12)	$0.78~\mathrm{dB}$	±0.076 dB
	-52	-0.82 dB	(13)	$0.82~\mathrm{dB}$	±0.080 dB
	-56	-0.86 dB	(14)	0.86 dB	±0.078 dB
	-60	-0.90 dB	(15)	0.90 dB	±0.084 dB
	64	0 04 4B	(16)	0 04 JD	±0.001.4D

Table 3-16 Agilent E4411B Performance Verification Test Record

Agilent Technologies	
Model E4411B	Report No
Serial No	Date

Seriar No.	Date			
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
-68	-0.98 dB	(17)	0.98 dB	±0.080 dB
-72	-1.02 dB	(18)	1.02 dB	±0.084 dB
-76	-1.06 dB	(19)	1.06 dB	±0.083 dB
-80	-1.10 dB	(20)	1.10 dB	±0.089 dB
-84	-1.14 dB	(21)	1.14 dB	±0.086 dB
Incremental Log Fide Res BW ≥1 kHz	lity,			
dB from Ref Level				
-4	-0.4 dB	(22)	0.4 dB	±0.082 dB
-8	-0.4 dB	(23)	0.4 dB	±0.078 dB
-12	-0.4 dB	(24)	0.4 dB	±0.075 dB
-16	-0.4 dB	(25)	0.4 dB	±0.073 dB
-20	-0.4 dB	(26)	0.4 dB	±0.078 dB
-24	-0.4 dB	(27)	0.4 dB	±0.074 dB
-28	-0.4 dB	(28)	0.4 dB	±0.073 dB
-32	-0.4 dB	(29)	0.4 dB	±0.077 dB
-36	-0.4 dB	(30)	0.4 dB	±0.075 dB
-40	-0.4 dB	(31)	0.4 dB	±0.081 dB
-44	-0.4 dB	(32)	0.4 dB	±0.077 dB
-48	-0.4 dB	(33)	0.4 dB	±0.076 dB
-52	-0.4 dB	(34)	0.4 dB	±0.080 dB
-56	-0.4 dB	(35)	0.4 dB	±0.078 dB
-60	-0.4 dB	(36)	0.4 dB	±0.084 dB
-64	-0.4 dB	(37)	0.4 dB	±0.081 dB
-68	-0.4 dB	(38)	0.4 dB	±0.080 dB
-72	-0.4 dB	(39)	0.4 dB	±0.084 dB

Table 3-16 Agilent E4411B Performance Verification Test Record

Agilent Technologies		
Model E4411B	Report No	
Serial No	Date	
	Results	Massurament

Serial No Date				
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
-76	-0.4 dB	(40)	0.4 dB	±0.083 dB
-80	-0.4 dB	(41)	0.4 dB	±0.089 dB
Cumulative Log Fidelity, Res BW ≤300 Hz (Option 1DR only)				
dB from Ref Level				
-4	-0.34 dB	(43)	0.34 dB	±0.082 dB
-8	-0.38 dB	(44)	0.38 dB	±0.078 dB
-12	-0.42 dB	(45)	0.42 dB	±0.075 dB
-16	-0.46 dB	(46)	0.46 dB	±0.073 dB
-20	-0.50 dB	(47)	0.50 dB	±0.078 dB
-24	-0.54 dB	(48)	0.54 dB	±0.074 dB
-28	-0.58 dB	(49)	0.58 dB	±0.073 dB
-32	-0.62 dB	(50)	0.62 dB	±0.077 dB
-36	-0.66 dB	(51)	0.66 dB	±0.075 dB
-40	-0.70 dB	(52)	0.70 dB	±0.081 dB
-44	-0.74 dB	(53)	0.74 dB	±0.077 dB
-48	-0.78 dB	(54)	0.78 dB	±0.076 dB
-52	-0.82 dB	(55)	0.82 dB	±0.080 dB
-56	-0.86 dB	(56)	0.86 dB	±0.078 dB
-60	-0.90 dB	(57)	0.90 dB	±0.084 dB
-64	-0.94 dB	(58)	0.94 dB	±0.081 dB
-68	-0.98 dB	(59)	0.98 dB	±0.080 dB
-72	-1.02 dB	(60)	1.02 dB	±0.084 dB
-76	-1.06 dB	(61)	1.06 dB	±0.083 dB
-80	-1.10 dB	(62)	1.10 dB	±0.089 dB

Table 3-16 Agilent E4411B Performance Verification Test Record

Agilent Technologies	
Model E4411B	Report No.
Serial No	Date

Serial No		Date		
Test Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
-84	-1.14 dB	(63)	1.14 dB	±0.086 dB
-88	-1.18 dB	(64)	1.18 dB	±0.085 dB
-92	-1.22 dB	(65)	1.22 dB	±0.100 dB
-96	-1.26 dB	(66)	1.26 dB	±0.099 dB
-98	-1.28 dB	(67)	1.28 dB	±0.098 dB
Incremental Log Fidelity, Res BW ≤300 Hz (Option 1DR only) dB from Ref Level				
-4	-0.4 dB	(68)	0.4 dB	±0.082 dB
-8	-0.4 dB	(69)	0.4 dB	±0.078 dB
-12	-0.4 dB	(70)	0.4 dB	±0.075 dB
-16	-0.4 dB	(71)	0.4 dB	±0.073 dB
-20	-0.4 dB	(72)	0.4 dB	±0.078 dB
-24	-0.4 dB	(73)	0.4 dB	±0.074 dB
-28	-0.4 dB	(74)	0.4 dB	±0.073 dB
-32	-0.4 dB	(75)	0.4 dB	±0.077 dB
-36	-0.4 dB	(76)	0.4 dB	±0.075 dB
-40	-0.4 dB	(77)	0.4 dB	±0.081 dB
-44	-0.4 dB	(78)	0.4 dB	±0.077 dB
-48	-0.4 dB	(79)	0.4 dB	±0.076 dB
-52	-0.4 dB	(80)	0.4 dB	±0.080 dB
-56	-0.4 dB	(81)	0.4 dB	±0.078 dB
-60	-0.4 dB	(82)	0.4 dB	±0.084 dB
-64	-0.4 dB	(83)	0.4 dB	±0.081 dB
-68	-0.4 dB	(84)	0.4 dB	±0.080 dB

Table 3-16 Agilent E4411B Performance Verification Test Record

	8 1				
Agil	ent Technologies				
Mod	el E4411B		Report No		
Seria	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	-72	-0.4 dB	(85)	0.4 dB	±0.084 dB

Serial No.			Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	-72	-0.4 dB	(85)	0.4 dB	±0.084 dB
	-76	-0.4 dB	(86)	0.4 dB	±0.083 dB
	-80	-0.4 dB	(87)	0.4 dB	±0.089 dB
	Linear Fidelity, Res BW ≥1 kHz				
	dB from Ref Level				
	_4	-2.0%	(93)	2.0%	±0.064%
	-8	-2.0%	(94)	2.0%	±0.064%
	-12	-2.0%	(95)	2.0%	±0.064%
	-16	-2.0%	(96)	2.0%	±0.064%
	-20	-2.0%	(97)	2.0%	±0.063%
	Linear Fidelity, Res BW ≤300 Hz (Option 1DR only)				
	dB from Ref Level				
	-4	-2.0%	(98)	2.0%	±0.064%
	-8	-2.0%	(99)	2.0%	±0.064%
	-12	-2.0%	(100)	2.0%	±0.064%
	-16	-2.0%	(101)	2.0%	±0.064%
	-20	-2.0%	(102)	2.0%	±0.063%
	Zero Span, Res BW ≤300 Hz (Option 1DR only)				
	dB from Ref Level				
	_4	-0.36 dB	(103)	0.36 dB	±0.082 dB
	-8	−0.42 dB	(104)	0.42 dB	±0.078 dB
	-12	-0.48 dB	(105)	0.48 dB	±0.075 dB
	-16	-0.54 dB	(106)	0.54 dB	±0.073 dB

Table 3-16 Agilent E4411B Performance Verification Test Record

Agilent Technologies	
Model E4411B	Report No
Serial No	Date

Serial No Date					
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	-20	-0.60 dB	(107)	0.60 dB	±0.078 dB
	-24	-0.66 dB	(108)	0.66 dB	±0.074 dB
	-28	-0.72 dB	(109)	0.72 dB	±0.073 dB
	-32	-0.78 dB	(110)	0.78 dB	±0.077 dB
	-36	-0.84 dB	(111)	0.84 dB	±0.075 dB
	-40	-0.90 dB	(112)	0.90 dB	±0.081 dB
	-44	-0.96 dB	(113)	0.96 dB	±0.077 dB
	-48	-1.02 dB	(114)	1.02 dB	±0.076 dB
	-52	-1.08 dB	(115)	1.08 dB	±0.080 dB
	-56	-1.14 dB	(116)	1.14 dB	±0.078 dB
	-60	-1.20 dB	(117)	1.20 dB	±0.084 dB
	-64	-1.5 dB	(118)	1.5 dB	±0.081 dB
	-68	-1.5 dB	(119)	1.5 dB	±0.080 dB
	-70	-1.5 dB	(120)	1.5 dB	±0.084 dB
13.	Input Attenuation Switching Uncertainty				
	Input Attenuation Setting				
	0 dB	-0.3 dB	(1)	0.3 dB	±0.101 dB
	5 dB	-0.3 dB	(2)	0.3 dB	±0.104 dB
	15 dB	-0.3 dB	(3)	0.3 dB	±0.102 dB
	20 dB	-0.3 dB	(4)	0.3 dB	±0.098 dB
	25 dB	-0.35 dB	(5)	0.35 dB	±0.098 dB
	30 dB	-0.40 dB	(6)	0.40 dB	±0.096 dB
	35 dB	−0.45 dB	(7)	0.45 dB	±0.099 dB
	40 dB	-0.50 dB	(8)	0.50 dB	±0.096 dB
	45 dB	-0.55 dB	(9)	0.55 dB	±0.099 dB

Table 3-16 Agilent E4411B Performance Verification Test Record

Agil	ent Technolo	gies				
Mod	el E4411B			Report No		
Seri	al No	<u>_</u>		Date		
Test	Description		Minimum	Results Measured	Maximum	Measurement Uncertainty
	50 dB		-0.60 dB	(10)	0.60 dB	±0.095 dB
	55 dB		−0.65 dB	(11)	$0.65~\mathrm{dB}$	±0.099 dB
	60 dB		-0.70 dB	(12)	$0.70~\mathrm{dB}$	±0.100 dB
14.	Reference I Accuracy	Level				
	Log					
	Reference	Level				
	50 Ω (dBm) 7	$75 \Omega (dBmV)$				
	-15	33.75	-0.3 dB	(1)	0.3 dB	±0.091 dB
	-5	43.75	-0.3 dB	(2)	0.3 dB	±0.100 dB
	-35	13.75	-0.3 dB	(3)	0.3 dB	±0.092 dB
	-45	3.75	-0.3 dB	(4)	0.3 dB	±0.094 dB
	-55	-6.25	-0.5 dB	(5)	$0.5~\mathrm{dB}$	±0.095 dB
	-65	-16.25	-0.5 dB	(6)	$0.5~\mathrm{dB}$	±0.097 dB
	-75	-26.25	-0.7 dB	(7)	0.7 dB	±0.099 dB
	Linear					
	Reference	Level				
	$50\Omega (dBm)$	$75\Omega \ (dBmV)$				
	-15	33.75	-0.3 dB	(8)	0.3 dB	±0.091 dB
	-5	43.75	-0.3 dB	(9)	0.3 dB	±0.100 dB
	-35	13.75	-0.3 dB	(10)	0.3 dB	±0.092 dB
	-45	3.75	-0.3 dB	(11)	0.3 dB	±0.094 dB
	-55	-6.25	-0.5 dB	(12)	0.5 dB	±0.095 dB
	-65	-16.25	-0.5 dB	(13)	0.5 dB	±0.097 dB
	_75	_26 25	_0.7 dB	(14)	0.7 dB	+0 099 dB

Table 3-16 Agilent E4411B Performance Verification Test Record

Agilent Technologies	
Model E4411B	Report No.
Serial No	Date

Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
16.	Resolution Bandwidth Switching Uncertainty				
	Resolution Bandwidth				
	3 kHz	-0.3 dB	(1)	0.3 dB	±0.048 dB
	9 kHz	-0.3 dB	(2)	0.3 dB	±0.048 dB
	$10~\mathrm{kHz}$	-0.3 dB	(3)	0.3 dB	±0.048 dB
	$30~\mathrm{kHz}$	-0.3 dB	(4)	0.3 dB	±0.048 dB
	100 kHz	-0.3 dB	(5)	0.3 dB	±0.048 dB
	120 kHz	-0.3 dB	(6)	0.3 dB	±0.048 dB
	300 kHz	-0.3 dB	(7)	0.3 dB	±0.048 dB
	1 MHz	-0.3 dB	(8)	0.3 dB	±0.048 dB
	3 MHz	-0.3 dB	(9)	0.3 dB	±0.048 dB
	5 MHz	-0.6 dB	(10)	0.6 dB	±0.076 dB
	300 Hz (Option 1DR only)	-3.0 dB	(11)	0.3 dB	±0.048 dB
	200 Hz (Option 1DR only)	-3.0 dB	(12)	0.3 dB	±0.048 dB
	100 Hz (Option 1DR only)	-3.0 dB	(13)	0.3 dB	±0.048 dB
17.	Absolute Amplitude Accuracy (Reference Settings)				
	Log, Preamp Off	-0.4 dB	(1)	0.4 dB	±0.09 dB
	Lin, Preamp Off	-0.4 dB	(2)	0.4 dB	±0.09 dB
19.	Overall Absolute Amplitude Accuracy				
	0 dBm Reference Level				
	0 dBm input	-0.6 dB	(1)	0.6 dB	±0.234 dB
	–10 dBm input	-0.6 dB	(2)	0.6 dB	±0.115 dB
	–20 dBm input	-0.6 dB	(3)	0.6 dB	±0.110 dB

Table 3-16 Agilent E4411B Performance Verification Test Record

Agil	ent Technologies				
Mod	el E4411B		Report No		
Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	–30 dBm input	-0.6 dB	(4)	0.6 dB	±0.109 dB
	–40 dBm input	-0.6 dB	(5)	0.6 dB	±0.109 dB
	–50 dBm input	-0.6 dB	(6)	0.6 dB	±0.109 dB
	–20 dBm Reference Level				
	–20 dBm input	-0.6 dB	(7)	0.6 dB	±0.109 dB
	–30 dBm input	-0.6 dB	(8)	0.6 dB	±0.109 dB
	–40 dBm input	-0.6 dB	(9)	0.6 dB	±0.109 dB
	–50 dBm input	-0.6 dB	(10)	0.6 dB	±0.109 dB
	–40 dBm Reference Level				
	–40 dBm input	-0.6 dB	(11)	0.6 dB	±0.087 dB
	–50 dBm input	-0.6 dB	(12)	0.6 dB	±0.087 dB
	–50 dBm Reference Level				
	–50 dBm input	-0.6 dB	(13)	0.6 dB	±0.087 dB
21.	Resolution Bandwidth Accuracy				
	Resolution Bandwidth				
	5 MHz	3.5 MHz	(1)	$6.5~\mathrm{MHz}$	±110 kHz
	3 MHz	2.55 MHz	(2)	$3.45~\mathrm{MHz}$	±66 kHz
	1 MHz	0.85 MHz	(3)	1.15 MHz	±22 kHz
	$300~\mathrm{kHz}$	255 kHz	(4)	$345~\mathrm{kHz}$	±6.6 kHz
	100 kHz	85 kHz	(5)	115 kHz	±2.2 kHz
	30 kHz	$25.5~\mathrm{kHz}$	(6)	$34.5~\mathrm{kHz}$	±660 Hz
	10 kHz	8.5 kHz	(7)	11.5 kHz	±220 Hz
	3 kHz	$2.55~\mathrm{kHz}$	(8)	$3.45~\mathrm{kHz}$	±66 Hz
	1 kHz	850 Hz	(9)	1.15 kHz	±22 Hz
	120 kHz	96 kHz	(10)	144 kHz	±2.17 kHz

Table 3-16 Agilent E4411B Performance Verification Test Record

Agil	ent Technologies				
Mod	lel E4411B		Report No		
Seri	al No		Date		
Test	Description	Minimum	Results Measured	Maximum	Measurement Uncertainty
	9 kHz	7.2 kHz	(11)	10.8 kHz	±163 Hz
22.	Frequency Response		ata in the appropriate at which ans.		
	20 to 30° C				
	50 Ω Input (No Option 1DP) (9 kHz to 1.5 GHz)				
	Maximum Response		(1)	0.50 dB	±0.19 dB
	Minimum Response	-0.50 dB	(2)		±0.19 dB
	Peak-to-Peak Response		(3)	1.0 dB	±0.19 dB
	Option 1DP (75 Ω) (1 MHz to 1.5 GHz)				
	Maximum Response		(1)	0.50 dB	±0.11 dB
	Minimum Response	-0.50 dB	(2)		±0.11 dB
	Peak-to-Peak Response		(3)	1.0 dB	±0.11 dB
	0 to 55° C				
	50 Ω Input (No Option 1DP) (9 kHz to 1.5 GHz)				
	Maximum Response		(1)	1.0 dB	±0.19 dB
	Minimum Response	-1.0 dB	(2)		±0.19 dB
	Peak-to-Peak Response		(3)	2.0 dB	±0.19 dB
	Option 1DP (75 Ω) (1 MHz to 1.5 GHz)				
	Maximum Response		(1)	1.0 dB	±0.11 dB

Table 3-16 Agilent E4411B Performance Verification Test Record

Agilent Technologies					
Model E4411B			Report No		
Serial No		Date			
Test Description		Minimum	Results Measured	Maximum	Measurement Uncertainty
	Minimum Response	-1.0 dB	(2)		±0.11 dB
	Peak-to-Peak Response		(3)	2.0 dB	±0.11 dB
28.	Other Input-Related Spurious Responses				
	Input Frequency				
	$542.8~\mathrm{MHz}$		(1)	-65 dBc	±.889 dB
	$510.7~\mathrm{MHz}$		(2)	-65 dBc	±.889 dB
	$1310.7~\mathrm{MHz}$		(3)	-45 dBc	±.889 dB
30.	Spurious Responses	Note: Enter the results in the appropriate lines below based upon the input impedance of the analyzer. Test Record Entry 2 does not apply to Agilent E4411B.			
	$50~\mathrm{MHz}$ TOI, $50~\Omega$	7.5 dBm	(1)		±0.93 dB
	$50~\mathrm{MHz}~\mathrm{TOI},~75~\Omega$	56.25 dBmV	(1)		±0.93 dB
	$40~\mathrm{MHz}~\mathrm{SHI},50~\Omega$	35 dBm	(3)		±.050 dB
	$40~\mathrm{MHz}~\mathrm{SHI},75~\Omega$	83.75 dBmV	(3)		±.050 dB
33.	Gain Compression	Note: Test Record Entry 2 does not apply to Agilent E4411B.			
	Test Frequency				
	53 MHz		(1)	1.0 dB	±0.123 dB
	1403 MHz		(3)	1.0 dB	±0.123 dB
35.	Displayed Average Noise Level	Note: Enter data in the appropriate section below depending upon the input impedance and serial number of the analyzer.			
	$50~\Omega, 1~\mathrm{kHz}~\mathrm{RBW}$				
	$400~\mathrm{kHz}$		(1)	–115 dBm	±1.23 dB
	$1~\mathrm{MHz}~\mathrm{to}~10~\mathrm{MHz}$		(2)	–115 dBm	±1.23 dB
	$10~\mathrm{MHz}$ to $500~\mathrm{MHz}$		(3)	–119 dBm	±1.23 dB
	$500~\mathrm{MHz}$ to $1~\mathrm{GHz}$		(4)	–117 dBm	±1.23 dB
	$1~\mathrm{GHz}$ to $1.5~\mathrm{GHz}$		(5)	–113 dBm	±1.23 dB

Table 3-16 Agilent E4411B Performance Verification Test Record

Agilent Technologies					
Model E4411B			Report No		
Serial No		Date			
Test Description		Minimum	Results Measured	Maximum	Measurement Uncertainty
	50 Ω, 100 Hz RBW				
	$400~\mathrm{kHz}$		(11)	–123 dBm	±1.23 dB
	1 MHz to 10 MHz		(12)	–123 dBm	±1.23 dB
	$10~\mathrm{MHz}$ to $500~\mathrm{MHz}$		(13)	-127 dBm	±1.23 dB
	$500~\mathrm{MHz}$ to $1~\mathrm{GHz}$		(14)	–125 dBm	±1.23 dB
	$1~\mathrm{GHz}$ to $1.5~\mathrm{GHz}$		(15)	–121 dBm	±1.23 dB
	75 Ω, 1 kHz RBW				
	1 MHz to 10 MHz		(21)	–63 dBmV	±1.23 dB
	$10~\mathrm{MHz}$ to $500~\mathrm{MHz}$		(22)	–65 dBmV	±1.23 dB
	$500~\mathrm{MHz}$ to $1~\mathrm{GHz}$		(23)	-60 dBmV	±1.23 dB
	1 GHz to 1.5 GHz		(24)	–53 dBmV	±1.23 dB
	75 Ω, 100 Hz RBW				
	1 MHz to 10 MHz		(29)	−72 dBmV	±1.23 dB
	$10~\mathrm{MHz}$ to $500~\mathrm{MHz}$		(30)	−74 dBmV	±1.23 dB
	500 MHz to 1 GHz		(31)	-68 dBmV	±1.23 dB
	1 GHz to 1.5 GHz		(32)	–61 dBmV	±1.23 dB
39.	Residual Responses	Note: Enter data in the appropriate section below depending upon the input impedance and serial number of the analyzer.			
	$50~\Omega$ 150 kHz to 1.5 GHz		(1)	-90 dBm	±0.87 dB
	75 Ω, 1 MHz to 1.5 GHz		(1)	–36 dBmV	±0.87 dB
41.	Tracking Generator Absolute Amplitude and Vernier Accuracy	Note: Enter data in the appropriate section below depending upon the input impedance and serial number of the analyzer.			
	$50~\Omega~(Option~1DN)$				
	Absolute Amplitude Accuracy	-0.5 dB	(1)	0.5 dB	±0.096 dB
	Positivo Vornior Acqueses		(2)	0.75 dB	+0 008 dB

Table 3-16 Agilent E4411B Performance Verification Test Record

Agilent Technologies					
Model E4411B			Report No.		
Serial No.		Date			
Test Description		Minimum	Results Measured	Maximum	Measurement Uncertainty
	Negative Vernier Accuracy	-0.75 dB	(3)		±0.008 dB
	Power Sweep Accuracy		(4)	1.5 dB	±0.008 dB
	$75~\Omega~(Option~1DQ)$				
	Absolute Amplitude Accuracy	–1.5 dB	(1)	1.5 dB	±0.096 dB
	Positive Vernier Accuracy		(2)	0.9 dB	±0.008 dB
	Negative Vernier Accuracy	-0.9 dB	(3)		±0.008 dB
	Power Sweep Accuracy		(4)	1.8 dB	±0.008 dB
43.	Tracking Generator Level Flatness	Note: Enter data in the appropriate section below depending upon the input impedance and serial number of the analyzer.			
	50Ω (Option 1DN)				
	Positive Level Flatness, <1 MHz		(1)	2.0 dB	±0.73 dB
	Negative Level Flatness, <1 MHz	–2.0 dB	(2)		±0.73 dB
	Positive Level Flatness, 1 MHz to 10 MHz		(3)	2.0 dB	±0.19 dB
	Negative Level Flatness, 1 MHz to 10 MHz	-2.0 dB	(4)		±0.19 dB
	Positive Level Flatness, >10 MHz		(5)	1.5 dB	±0.19 dB
	Negative Level Flatness, >10 MHz	-1.5 dB	(6)		±0.19 dB
	75 Ω (Option 1DQ)				
	Positive Level Flatness, 1 MHz to 10 MHz		(3)	2.5 dB	±0.19 dB
	Negative Level Flatness, 1 MHz to 10 MHz	-2.5 dB	(4)		±0.19 dB

Table 3-16 Agilent E4411B Performance Verification Test Record

Agilent Technologies					
Model E4411B		Report No			
Seri	al No		Date		
Test Description		Minimum	Results Measured	Maximum	Measurement Uncertainty
	Positive Level Flatness, >10 MHz		(5)	2.0 dB	±0.19 dB
	Negative Level Flatness, >10 MHz	-2.0 dB	(6)		±0.19 dB
45.	Tracking Generator Harmonic Spurious Outputs (Option 1DN or Option 1DQ only)				
	2 nd Harmonic, <20 MHz		(1)	–20 dBc	±2.6 dB
	2 nd Harmonic, ≥20 MHz		(2)	–25 dBc	±2.6 dB
	3 rd Harmonic, <20 MHz		(3)	–20 dBc	±2.6 dB
	3 rd Harmonic, ≥20 MHz		(4)	-25 dBc	±2.6 dB
47.	Tracking Generator Non-Harmonic Spurious Outputs (Option 1DN or Option 1DQ only) Highest Non-Harmonic Spurious Output		(1)	–35 dBc	±2.64 dB

Amplitude

Performance Verification Test Records **Agilent E4411B Performance Verification Test Record**

4 If You Have a Problem

This chapter includes information on how to check for a problem with your Agilent ESA Series Spectrum Analyzer, and how to return it for service. It also includes descriptions of the types of built-in messages.

What You'll Find in This Chapter

This chapter includes information on how to check for a problem with your Agilent ESA Series Spectrum Analyzer, and how to return it for service. It also includes descriptions of all of the analyzer built-in messages.

Your analyzer is built to provide dependable service. However, if you experience a problem, desire additional information, or wish to order parts, options, or accessories, Agilent Technologies' worldwide sales and service organization is ready to provide the support you need.

In general, a problem can be caused by a hardware failure, a software error, or a user error. Follow these general steps to determine the cause and to resolve the problem.

- 1. Perform the quick checks listed in "Check the Basics" in this chapter. It is possible that a quick check may eliminate your problem altogether.
- 2. If the problem is a hardware problem, you have several options:
 - Repair it yourself; see the "Service Options" section in this chapter.
 - Return the analyzer to Agilent Technologies for repair; if the analyzer is still under warranty or is covered by an Agilent Technologies maintenance contract, it will be repaired under the terms of the warranty or plan (the warranty is at the front of this manual).
 - If the analyzer is no longer under warranty or is not covered by an Agilent Technologies maintenance plan, Agilent Technologies will notify you of the cost of the repair after examining the instrument. See "How to Call Agilent Technologies" and "How to Return Your Analyzer for Service" for more information.

WARNING

No operator serviceable parts inside the analyzer. Refer servicing to qualified personnel. To prevent electrical shock do not remove covers.

Before You Call Agilent Technologies

Check the Basics

A problem can often be resolved by repeating the procedure you were following when the problem occurred. Before calling Agilent Technologies or returning the analyzer for service, please make the following checks:

fo]	llowing checks:
	Check the line fuse.
	Is there power at the receptacle?
	Is the analyzer turned on? Make sure the fan is running, which indicates that the power supply is on.
	If the display is dark or dim, press the upper Viewing Angle key in the upper-left corner of the front panel. If the display is too bright, adjust the lower Viewing Angle key in the upper-left corner of the front panel.
	If other equipment, cables, and connectors are being used with your Agilent ESA Series Spectrum Analyzer, make sure they are connected properly and operating correctly.
	Review the procedure for the measurement being performed when the problem appeared. Are all the settings correct?
	If the analyzer is not functioning as expected, return the analyzer to a known state by pressing the Preset key.
	Some analyzer settings are not affected by a Preset. If you wish to reset the analyzer configuration to the state it was in when it was originally sent from the factory, press System, Power On/Preset, Factory Preset (if it is displayed).
	Is the measurement being performed, and the results that are expected, within the specifications and capabilities of the analyzer? Refer to the "Specifications and Characteristics" chapters in the Specifications Guide.
	In order to meet specifications, the analyzer must be aligned. Either Auto Align All must be selected (press System, Alignments, Auto Align, All), or the analyzer must be manually aligned at least once per hour, or whenever the temperature changes more than 3° C. When Auto Align, All is selected, AA appears on the left edge of the display.
	If the necessary test equipment is available, perform the tests listed in Chapter 1, "Calibrating," for your instrument. Record all results on the appropriate form in Chapter 3, "Performance Verification Test Records," which follows the performance verification tests

Chapter 4 637

chapter.

☐ If the equipment to perform the performance verification tests is not available, you may still be able to perform the functional checks in the *Agilent ESA Series Spectrum Analyzers User's Guide*.

Read the Warranty

The warranty for your analyzer is at the front of this manual. Please read it and become familiar with its terms.

If your analyzer is covered by a separate maintenance agreement, please be familiar with its terms.

Service Options

Agilent Technologies offers several optional maintenance plans to service your analyzer after the warranty has expired. Call your Agilent Technologies sales and service office for full details.

If you want to service the analyzer yourself after the warranty expires, you can purchase the service documentation that provides all of the necessary test and maintenance information.

You can order the service documentation, Option 0BV (component level information including parts lists, component location diagrams and schematic diagrams) and Option 0BW (assembly level troubleshooting and adjustment procedures), through your Agilent Technologies sales and service office. Service documentation is described under "Component Level Service Documentation (Option 0BV)" and "Service Documentation and Adjustment Software (Option 0BW)" in Chapter 6 of the user's guide.

How to Call Agilent Technologies

Agilent Technologies has sales and service offices around the world to provide you with complete support for your analyzer. To obtain servicing information or to order replacement parts, contact the nearest Agilent Technologies sales and service office listed in Table 4-1. In any correspondence or telephone conversations, refer to your analyzer by its product number, full serial number, and firmware revision. (Press System, More 1 of 3, Show System, and the product number, serial number, and firmware revision information will be displayed on your analyzer screen.) A serial number label is also attached to the rear panel of the analyzer.

Table 4-1 Agilent Technologies Sales and Service Offices

	UNITED STATES	
Instrument Support Center Agilent Technologies, Inc. (800) 403-0801		
I	EUROPEAN FIELD OPERATIO	NS
Headquarters Agilent Technologies S.A. 150, Route du Nant-d'Avril 1217 Meyrin 2/ Geneva Switzerland (41 22) 780.8111	France Agilent Technologies France 1 Avenue Du Canada Zone D'Activite De Courtaboeuf F-91947 Les Ulis Cedex France (33 1) 69 82 60 60	Germany Agilent Technologies GmbH Agilent Technologies Strasse 61352 Bad Homburg v.d.H Germany (49 6172) 16-0
Great Britain Agilent Technologies Ltd. Eskdale Road, Winnersh Triangle Wokingham, Berkshire RG41 5DZ England (44 118) 9696622		
]	INTERCON FIELD OPERATION	NS
Headquarters Agilent Technologies, Inc. 3495 Deer Creek Rd. Palo Alto, CA 94304-1316 USA (415) 857-5027	Australia Agilent Technologies Australia Ltd. 31-41 Joseph Street Blackburn, Victoria 3130 (61 3) 895-2895	Canada Agilent Technologies (Canada) Ltd. 17500 South Service Road Trans-Canada Highway Kirkland, Quebec H9J 2X8 Canada (514) 697-4232
Agilent Technologies Japan, Ltd. Measurement Assistance Center 9-1, Takakura-Cho, Hachioji-Shi, Tokyo 192-8510, Japan TEL (81) -426-56-7832 FAX (81) -426-56-7840	Singapore Agilent Technologies Singapore (Pte.) Ltd. 150 Beach Road #29-00 Gateway West Singapore 0718 (65) 291-9088	Taiwan Agilent Technologies Taiwan 8th Floor, H-P Building 337 Fu Hsing North Road Taipei, Taiwan (886 2) 712-0404
China China Agilent Technologies, Inc. 38 Bei San Huan X1 Road Shuang Yu Shu Hai Dian District Beijing, China (86 1) 256-6888		

Chapter 4 639

How to Return Your Analyzer for Service

Service Tag

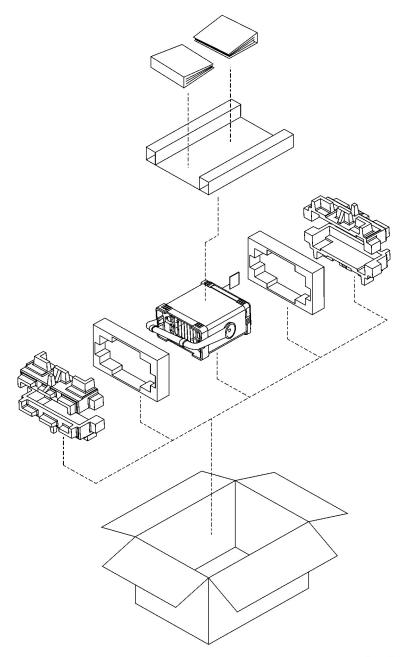
If you are returning your analyzer to Agilent Technologies for servicing, fill in and attach a blue service tag. Several service tags are supplied at the rear of this chapter. Please be as specific as possible about the nature of the problem. If you have recorded any error messages that appeared on the display, or have completed a Performance Test Record, or have any other specific data on the performance of your analyzer, please send a copy of this information with your return.

Original Packaging

Before shipping, pack the unit in the original factory packaging materials if they are available. If the original materials were not retained, see "Other Packaging".

NOTE	Ensure that the instrument handle is in the rear-facing position in order to reduce the possibility of damage during shipping. Refer to Figure 4-1.
NOTE	Install the transportation disk into the floppy drive to reduce the possibility of damage during shipping. If the original transportation disk is not available, a blank floppy may be substituted.

Figure 4-1



formt122

Chapter 4 641

Other Packaging

CAUTION

Analyzer damage can result from using packaging materials other than those specified. Never use styrene pellets in any shape as packaging materials. They do not adequately cushion the equipment or prevent it from shifting in the carton. They cause equipment damage by generating static electricity and by lodging in the analyzer louvers, blocking airflow.

You can repackage the instrument with commercially available materials, as follows:

- 1. Attach a completed service tag to the instrument.
- 2. Install the transportation disk or a blank floppy disk into the disk drive.
- 3. If you have a front-panel cover, install it on the instrument. If you do not have a front panel cover, make sure the instrument handle is in the forward-facing position to protect the control panel.
- 4. Wrap the instrument in antistatic plastic to reduce the possibility of damage caused by electrostatic discharge.
- 5. Use a strong shipping container. A double-walled, corrugated cardboard carton with 159 kg (350 lb) bursting strength is adequate. The carton must be both large enough and strong enough to accommodate the analyzer. Allow at least 3 to 4 inches on all sides of the analyzer for packing material.
- 6. Surround the equipment with three to four inches of packing material and prevent the equipment from moving in the carton. If packing foam is not available, the best alternative is S.D.-240 Air Cap™ from Sealed Air Corporation (Hayward, California, 94545). Air Cap looks like a plastic sheet filled with 1-1/4 inch air bubbles. Use the pink-colored Air Cap to reduce static electricity. Wrapping the equipment several times in this material should both protect the equipment and prevent it from moving in the carton.
- 7. Seal the shipping container securely with strong nylon adhesive tape.
- 8. Mark the shipping container "FRAGILE, HANDLE WITH CARE" to assure careful handling.
- 9. Retain copies of all shipping papers.

This information is subject to change without notice. © Keysight Technologies, 2014-2015
Published in USA, January 2015
E4401-90493
www.keysight.com